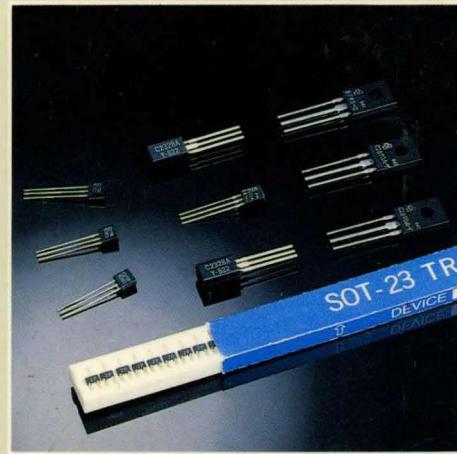


Transistor Data Book (Vol. 1)



1988

- Small Signal TR

PRINTED IN KOREA

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SAMSUNG SEMICONDUCTOR DATA BOOK LIST

- I. Semiconductor Product Guide**
- II. Transistor Data Book**
 - Vol. 1: Small Signal TR
 - Vol. 2: Bipolar Power TR
 - Vol. 3: TR Pellet
- III. Linear IC Data Book**
 - Vol. 1: Audio/Video
 - Vol. 2: Telecom/Industrial/Data Converter IC
- IV. MOS Product Data Book**
- V. High Performance CMOS Logic Data Book**
- VI. MOS Memory Data Book**
- VII. SFET Data Book**
- VIII. MPR Data Book**
- IX. CPL Data Book**
- X. Dot Matrix Data Book**

TRANSISTOR DATA BOOK

VOLUME 1

KSA Series
KSB Series
KSC Series
KSD Series
KSK Series
KSR Series
2N Series
BC Series
MM Series
MPS Series
SS Series

VOLUME 2

KSA Series
KSB Series
KSC Series
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BU Series
MJE Series
TIP Series

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Quality and Reliability

1

Function Guide

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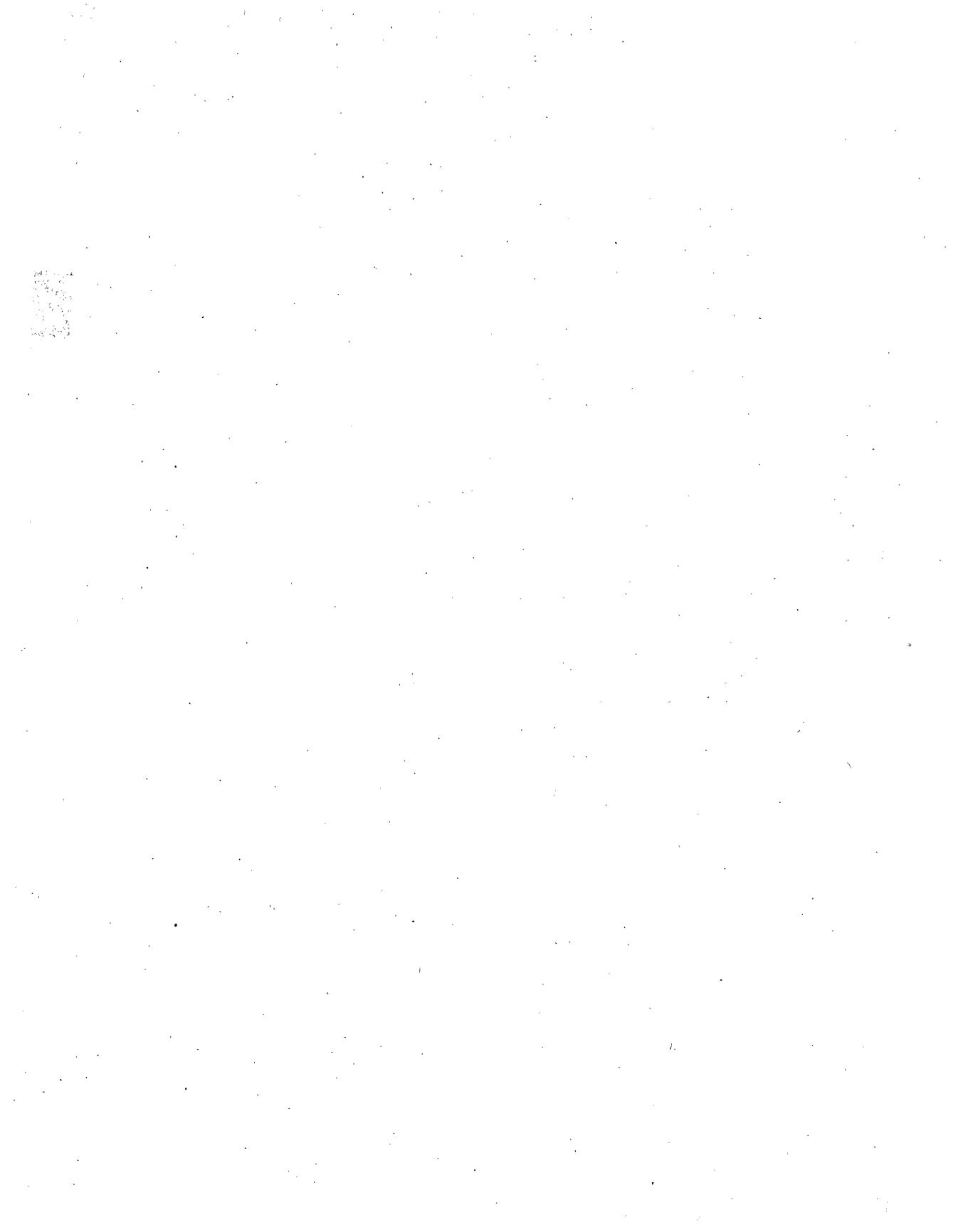
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Package Dimensions

4

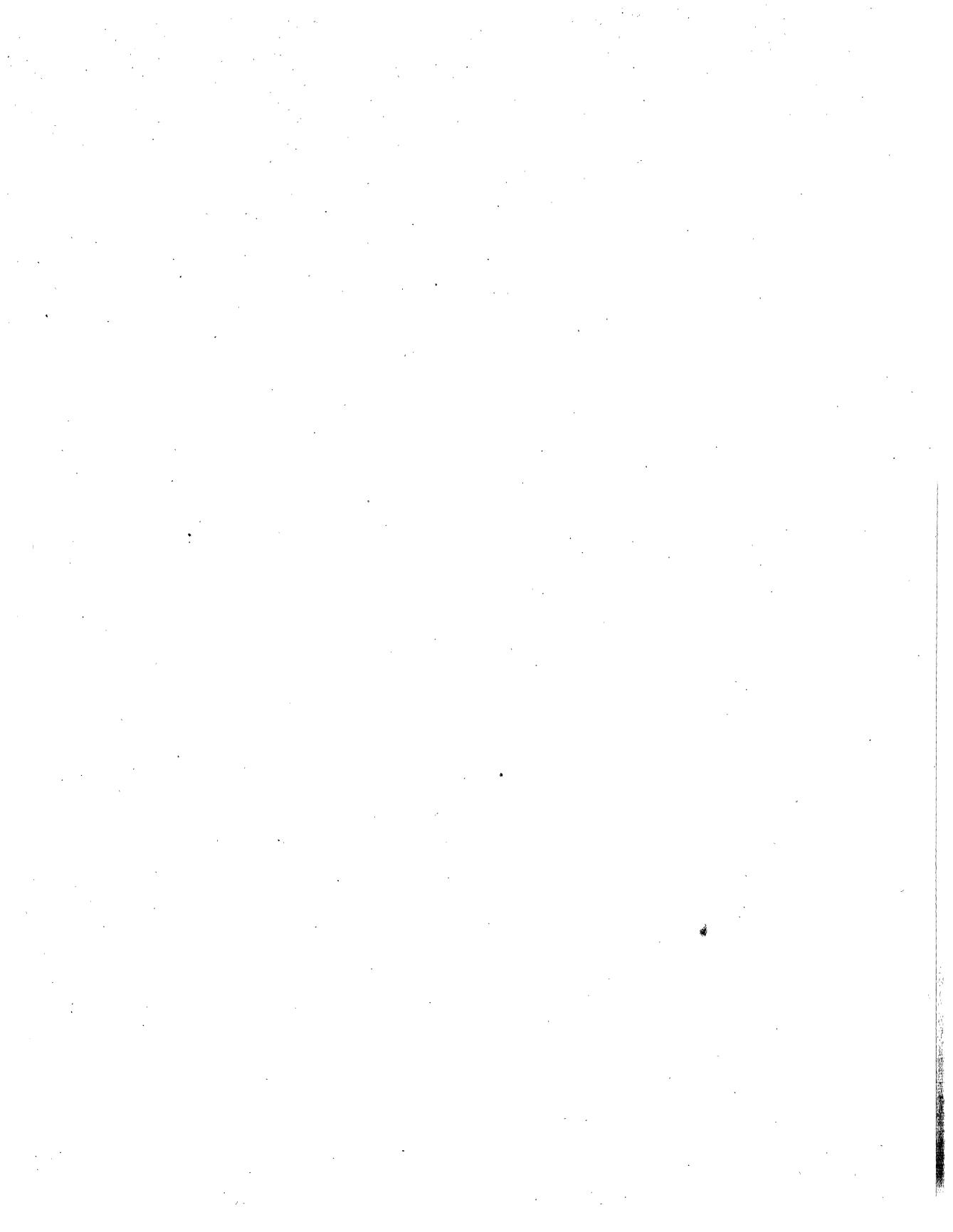
**Samsung Sales Offices and
Manufacturer's Representatives**

5



QUALITY and RELIABILITY 1





QUALITY ASSURANCE and RELIABILITY PROGRAM

1. Introduction

Samsung utilizes rigorous qualification and reliability programs to monitor the integrity of its devices. All industry standard (and various non-standard) stresses are run. Testing is done not only to collect data, but also to detect trends and product anomalies, with rectification to take place immediately (if necessary). This protects the customer from receiving discrepant material. Careful attention is given to any manufacturing changes, both through Engineering Change Notices and appropriate reliability stressing.

Items such as particular tests, frequency, sample sizes, acceptance criteria, and methods of stressing are detailed later in this chapter.

2. Policy

Samsung is committed to supplying high-quality semiconductors to its consumers. All product released for general sales has been fully tested and qualified. By meeting or exceeding normal industry standards for reliability, Samsung can confidently supply products to the world that will meet customer applications and reliability standards. Of course special programs can be run for customers who have particular requirements which are considered non-standard. The quality organization must approve any product before it is officially qualified and distributed. To do this most effectively, fully-functional devices must pass two critical stages prior to sales. Step 1 is product evaluation; step 2 is product qualification. Details are listed below.

3. Scope

Pass/Fail criteria are established by the quality assurance organization. All products have specifications which apply to them regarding reliability stressing, periodical monitoring, and final lot disposition.

The quality department is responsible for investigating mass-produced product for discrepancies, and enforcing corrective actions. All outgoing product goes through "QA-gating", where tests particularly critical to the product are accomplished. Only when quality assurance approves a device, either through qualification or gating acceptance, is it released. Fundamental "no-rework" policies ensure only highly reliable material leaves the factory. Testing is done to MIL-STD 883 and MIL-STD 750 standards, with sampling done in accordance with MIL-STD 19500E and MIL-STD 105D. Samsung also has internal specifications where its requirements exceed those of MIL-STDs.

4. Qualification Procedures

Procedures to qualify devices are listed below. There are both general and product-specific requirements. Procedures are detailed for new products, die-only qualifications, and package-only qualifications. The latter two are for products and/or packages already qualified, but where there is room for further product optimization.

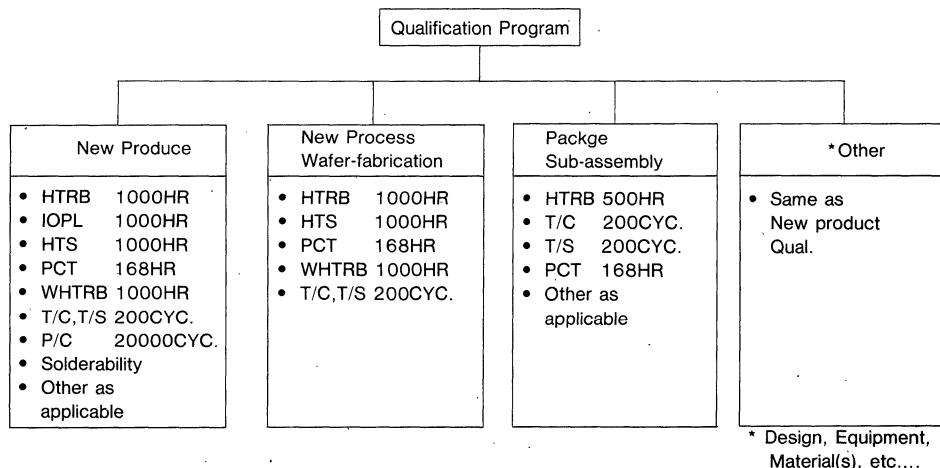


Fig. 1. Qualification Programs.



QUALITY ASSURANCE and RELIABILITY PROGRAM

4.1 New product qualification test items

No.	Test Item	Test Condition	Sample Size	LTPD	ACC. No	Reference Method	Note
1	High Temperature Reverse Bias (HTRB)	$T_a=T_j(\max)$ $V_{CB}=0.8 \times V_{CBO}$ 1000HRS	45	10	1		48HR for PRT
2	High Temperature Storage (HTS)	$T_a=T_j(\max)$ 1000HRS	45	10	1		
3	Operating Life (OPL)	$T_a=25^\circ C$ $P_c=P_c(\max)$ 1000HRS	45	10	1	MIL-STD-750 1026.3	For Small-Signal Device
4	Intermittent OPL (IOPL)	$T_a=25^\circ C$ $P_c=P_c(\max)$ 2min/2min On/Off 1000HRS	45	10	1	MIL-STD-750 1036.3	
5	Power Cycle (P/C)	$\Delta T_j=125^\circ C$ 45Sec/90Sec On/Off 20000CYC.	45	10	1		For PWR TR,
6	Pressure Cooker Test (PCT)	$T_a=121^\circ C \pm 2^\circ C$ $RH=100\%$ 15PSIG 168HRS	45	10	1		48HR for PRT
7	Wet High Temperature Reverse Bias (WHTRB)	$T_a=85^\circ C$, $RH=85\%$ $V_{CB}=0.8 \times V_{CBO}$ 1000HRS	45	10	1		
8	Thermal Shock (T/S)	$-65^\circ C \leftrightarrow 150^\circ C$ (Liquid) 5min,<10Sec, 5min 200 Cycles	45	10	1	MIL-STD-883 1011	
9	Temperature Cycle (T/C)	$-65^\circ C \leftrightarrow 25^\circ C \leftrightarrow 15^\circ C$ 10min, 5min, 10min 200 Cycles	45	10	1	MIL-STD-883 1011	
10	Solder Heat Resistance (S/H)	$T_a=245^\circ C \pm 5^\circ C$ $t=10 \pm 1\text{ Sec}$ (once with flux)	10	N/A	0	MIL-STD-750 2031	
11	Solderability	$T_a=260^\circ C \pm 5^\circ C$ $t=5 \pm 0.5 \text{ sec}$ Reject is >10% uncovered surface	10	N/A	0	MIL-STD-883 2003	
12	Salt Atmosphere	$T_a=35^\circ C$, 5% NaCl 24HRS	10	N/A	0	MIL-STD-883 1009A	
13	Mechanical Shock	1500G, 05ms 3 Times Each direction of X,Y and Z Axis	10	N/A	0	MIL-STD-750 2016	For Hermetic
14	Vibration	20G, 3Axis $f=100$ to 2000 cps for 4min, 4 cycles	10	N/A	0	MIL-STD-883 2007	For Hermetic
15	Constant Acceleration	2000G X,Y,Z Axis 1 min for each Axis	10	N/A	0	MIL-STD-883 2001	For Hermetic
16	ESD (Human Body Model)	$R=1.5k\Omega$ $C=100pF$ 5 Discharge $V \geq \pm 1000V$	5	N/A	0	MIL-STD-883 3015	



QUALITY ASSURANCE and RELIABILITY PROGRAM

4.2 New process, wafer fabrication qualification

No	Test Item	Test Condition	Sample Size	LTPD	ACC No
1	High Temperature Reverse Bias (HTRB)	$T_a=T_j(\max)$ $V_{CB}=0.8 \times V_{CBO}$ 1000HRS	45	10	1
2	High Temperature Storage (HTS)	$T_a=T_j(\max)$ 1000HRS	45	10	1
3	Pressure Cooker Test (PCT)	$T_a=121^\circ C \pm 2^\circ C$ RH=100% 15 PSIG 168HRS	45	10	1
4	Wet High Temperature Reverse Bias (WHTRB)	$T_a=85^\circ C$, RH=85% $V_{CB}=0.8 \times V_{CBO}$ 1000HRS	45	10	1
5	Thermal Shock (T/S)	$-65^\circ C = 150^\circ C$ (Liquid) 5min,<10sec, 5min 200 cycles	45	10	1
6	Temperature Cycle (T/C)	$-65^\circ C = 25^\circ C = 150^\circ C$ 10min, 5min, 10min 200 Cycles	45	10	1

4.3 Package Sub-Assembly Qualification

No	Test Item	Test Condition	Sample Size	LTPD	ACC No	Notes
1	High Temperature Reverse Bias (HTRB)	$T_a=T_j(\max)$ $V_{CB}=V_{CBO} \times 0.8$ 500HRS	45	10	1	
2	Temperature Cycle (T/C)	$-65^\circ C = 25^\circ C = 150^\circ C$ 10min, 5min, 10min 200 CYCLES	45	10	1	
3	Pressure Cooker Test (PCT)	$T_a=121^\circ C \pm 2^\circ C$ RH=100%, 15PSIG 168HRS	45	10	1	
4	Thermal Shock (T/S)	$-65^\circ C = 150^\circ C$ (Liquid) 5min,<10sec, 5min 200 CYCLES	45	10	1	
5	Solder Heat Resistance (S/H)	$260^\circ C \pm 5^\circ C$ 10 ± 1 sec Once without Flux	10	N/A	0	
6	Vibration (Variable-Frequency)	100~2000~100Hz 20G, 5min, 5Times, X,Y,Z	10	N/A	0	
7	Mechanial Shock (M/S)	1500G, 0.5ms 3 Times, X,Y,Z	10	N/A	0	
8	Constant Acceleration	20000G X,Y,Z Axis 1 min for each Axis	10	N/A	0	

Note) • N/A: not available



SAMSUNG SEMICONDUCTOR

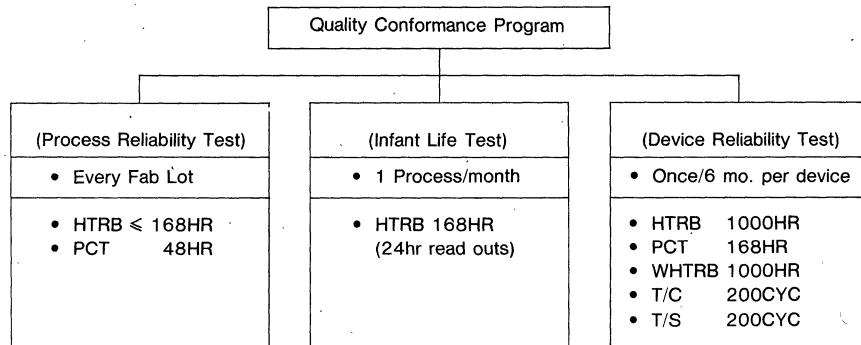
QUALITY ASSURANCE and RELIABILITY PROGRAM

5. Product Reliability (Quality Conformance) Monitors

Samsung implements periodic testing to monitor the ongoing reliability of its products. A subset of stresses used for qualification are run; they are seen as most critical for basic device reliability. Formally this is known as the Device Reliability Test System, or simply as DRT.

Lot-by-lot infant mortality reliability testing is also accomplished at Samsung. The purpose of this is to verify process integrity in a full QA step. Formally this is known as Process Reliability Testing, or more simply as PRT. Normally a short term accelerated lifetest and package reliability test are done, although exceptions are made in the case of special devices.

Although Samsung scrupulously utilizes statistical controls throughout its production process, DRT and PRT serve as confirmation that indeed the customer does receive only high-grade units. The tables on the following give details of DRT and PRT processing.



Note: Test descriptions given on following pages.

Fig. 2. Quality Conformance Program

(PRT/DRT Product Stress Methodologies)

1. PRT (Process Reliability Test)

Frequency: Every outgoing lot

No.	Test Item	Test Condition	Sample Size	LTPD	Accept. No.	Note
1	High Temperature Reverse Bias (HTRB)	$T_a = T_j(\max)$ $V_{CB} = V_{CEO} \times 0.8$ 168HR max	45	10	1	
2	Pressure Cooker Test (PCT)	$T_a = 121^\circ C \pm 2^\circ C$ 100% RH, 15PSIG 48HR	45	10	1	

2. ILT (Infant Life Test) Frequency: 1 Process/month

No.	Test Item	Test Condition	Sample Size	Note
1	High Temperature Reverse Bias (HTRB)	$T_a = T_j(\max)$ $V_{CB} = V_{CEO} \times 0.8$ 168HR	300	for Discrete



QUALITY ASSURANCE and RELIABILITY PROGRAM

3. DRT (Device Reliability Test)

No.	Test Item	Test Condition	Sample Size	LTPD*	Accept. No.	Note
1	High Temperature Reverse Bias (HTRB)	$T_a = T_j(\max)$ $V_{CB} = V_{CBO} \times 0.8$ 1000HRS	45	5 10	0 1	
2	Pressure Cooker Test (PCT)	$T_a = 121^\circ C \pm 2^\circ C$ RH=100%, 15PSIG 168HRS	45	5 10	0 1	
3	Wet High Temperature Reverse Bias (WHTRB)	$T_a = 85^\circ C$, RH=85% $V_{CB} = 0.8 \times V_{CBO}$ 1000HRS	45	5 10	0 1	
4	Temperature Cycle (T/C)	$-65^\circ C \leftrightarrow 25^\circ C \leftrightarrow 150^\circ C$ 10min, 5min, 10min 200 Cycles	45	5 10	0 1	
5	Thermal Shock (T/S)	$-65^\circ C \leftrightarrow 150^\circ C$ (Liquid) 5min,<10sec, 5min 200 Cycles	45	5 10	0 1	

* LTPD 5: S Grade Units LTPD 10: A,B Grade Units.

6. Reliability Tests

The test run by the quality department are accelerated tests, serving to model "real world" applications through boosted temperatures, voltages, and/or humidities. Accelerated conditions are used to derive device knowledge through means quicker than that of typical application situations. These accelerated conditions are then used to assess differing failure rate mechanisms that correlate directly with ambient conditions. Following are summaries of various stresses (and their conditions) run by Samsung on discrete and integrated devices.

High Temperature Reverse Bias (80% max. BV_{CBO}, 150°C, static)

For this test, device integrity is checked through stressing of the main blocking junction at an elevated temperature and voltage. Overall product stability is investigated through leakage current monitoring; low leakage indicates good integrity.

Intermittent Operating Life (P_{MAX}, 25°C, 2 min on/2 min off)

This test is normally applied to scrutinize die bond thermal fatigue. A stressed device undergoes an "on" cycle, where there is thermal heating due to power dissipation, and an "off" cycle, where there is thermal cooling due to lack of inputted power. Die attach (between die and package) and bond attach (between wire and die) are the critical areas of concern.

Wet High Temperature Reverse Bias (80% max. BV_{CBO}, 85°C, 85% R.H., static) or (V_{CC}=V_{CC}(typ), 85°C, 85% R.H., static)

Wet High Temperature Reverse Bias Test is used to accelerate failure mechanisms by applying static bias on alternate pins at high temperature and humidity ambient (85°C/85°C R.H.). This test checks for resistance to moisture penetration by using an electrolytic principle to accelerate corrosive mechanisms.

Pressure Cooker Test (Unbiased, 121°C, 15 PSIG, 100% R.H.)

The Pressure Cooker Test checks for resistance to moisture penetration. A highly pressurized vessel is used to force water (thereby promoting corrosion) into packaged devices located within the vessel.

High Temperature Storage (Unbiased, 150°C)

High Temperature Storage is utilized to test for both package and die weaknesses. For example, sensitivities to ionic contamination and bond integrity are closely scrutinized.



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Temperature Cycling (Unbiased, -65°C to +150°C, air)

This stress uses a chamber with alternating temperatures of -65°C and +150°C (air ambient) to thermally cycle devices within it. No bias is applied. The cycling checks for mechanical integrity of the packaged device, in particular bond wires and die attach, along with metal/polysilicon microcracks.

Thermal Shock (Unbiased, -65°C to +150°C, liquid)

This stress uses a chamber with alternating temperatures of -65°C to +150°C (liquid ambient) to thermally cycle devices within it. No bias is applied. The cycling is very rapid, and primarily checks for die/package compatibility.

Resistance to Solder Heat (Unbiased, 260°C, 10 sec)

Solder Heat Resistance is performed to establish that devices can withstand the thermal effects of solder dip, soldering iron, or solder wave operations.

Mechanical Shock (Unbiased, 1500g, Pulse=0.5msec)

This test determines the suitability of a device to be used in equipment where mechanical "shocks" may occur. Such shocks result from sudden or abrupt changes produced by rough (non-standard) handling, transportation, or field operations.

Variable Frequency Vibration (Unbiased, Range=100 to 2000 Hz)

Variable Frequency Vibration is done to model the effects of differential vibration in the specified range. Die attach and bonding integrity are particularly stressed, testing the mechanical soundness of device packaging.

Constant Acceleration (Unbiased, 10kg to 20kg)

This is an accelerated test designed to indicate types or modes of structural and mechanical weaknesses not necessarily detectable in Mechanical Shock and Variable Frequency Vibration stressing.

7. Failure criteria

Parameter	Symbol	Unit	SCOPE	Min.	Max.
Collector Cut-off Current	I _{CBO}	μA	COMMON	—	USLX2
Emitter Cut-off Current	I _{CEO}	μA	COMMON	—	USLX2
H _{FE} Variation Ratio	H _{FE}	—	H _{FE} (min)<500	I.V.X0.8	I.V.X1.2
		—	H _{FE} (min)≥500	I.V.X0.7	I.V.X1.3
		—	H _{FE} (min)≥1000	I.V.X0.6	I.V.X1.4
Collector-Emitter Saturation Voltage	V _{CE(sat)}	mV	COMMON	LSL	USL
Base-Emitter Saturation Voltage	V _{BE(sat)}	mV	COMMON	LSL	USL
Thermal, Resistance	ΔV _{BE}	mV	Power	LSL	USL
Noise	N _F , N _V	dB	Low Noise	—	USLX1.5

Note 1) USL: Upper Specification Limit 2) LSL: Lower Specification Limit 3) I.V.: Initial Value

8. Relative Stress Comparisons

Many stresses are run at Samsung on many different devices. Through both theoretical and actual results, it was clearly determined which stresses were most effective. Also established were the stresses which weren't fully effective.

Comparisons have been made on the basis of defects able to be determined, efficiency in detection, and cost. For the reader's benefit, Samsung provides the results of its conclusions on the following pages.

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Comparison of Reliability Test Methods

Test Method	Defect	Effectiveness	Cost	Remarks
Internal Visual Inspection	Lead Structure Metallization Oxide Film Foreign Particles Die Bond Wire Bond Contamination Corroded Substrate	Good	Slightly Inexpensive to Moderate	This method of screening must be performed for high reliability devices. Cost is affected by the degree of visual inspection
Infrared ray	Design(thermal)	Very Good	Expensive	For use in design evaluation only
Radiography	Die Bond Lead Structure(Gold) Foreign Particles Manufacturing (Gross Error) Seal Package Contamination	Extremely Good Good Good Good Good Good Good	Moderate	Advantage to using this screening method lies in the ability to test die frame/header bonding, and to be able to perform inspection after sealing. However, some materials being transparent to X-rays (for example, Al and Si) are not able to be analyzed. The use of the complex test system results in cost six times that of visual inspection.
High Temperature Storage	Electrical stability Metallization Bulk Silicon Corrosion	Good	Very Inexpensive	This is a highly desirable screening method
Temperature Cycling	Package Seal Die Bond Wire Bond Cracked Substrate Thermal Mismatching	Good	Very Inexpensive	This screening method is one of the most effective for use
Thermal Shock	Package Seal Die Bond Wire Bond Cracked Substrate Thermal Mismatching	Good	Inexpensive	While this screening method is similar to temperature cycling, it enables high stress levels as well. It is probably equal to the temperature cycling method.
Constant Acceleration	Lead Structure Die Bond Wire Bond Cracked Substrate	Good	Moderate	Doubt exists as to the effectiveness of screening aluminum wires with stress levels in the range of 0~20,000 G
Shock (Without Monitoring)	Lead Structure	Fairly Poor	Moderate	Drop shock testing is thought to be inferior to constant acceleration methods. However, the pneupactor shock test is more effective. Shock test is a destructive test method.
Shock (With Monitoring)	Particles Intermittent Short Intermittent Open	Fairly Poor Fairly Good Fairly Good	Expensive	Visual inspection or radiography is more desirable for detection of particles



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Comparison of Reliability Test Methods (continued)

Test Method	Defect	Effectiveness	Cost	Remarks
Vibration Fatigue	Lead Structure Package Die Bond Wire Bond Cracked Substrage	Fairly Poor	Expensive	This test is destructive and without merit.
Variable Frequency Vibration (Without Monitoring)	Package Die Bond Wire Bond Substrate	Fairly Poor	Expensive	
Variable Frequency Vibration (Without Monitoring)	Foreign Particles Lead Structure Intermittent Open	Fairly Good Good Good	Very Expensive	The effectiveness of the method for detecting particles depends on the type of particle
Random Vibration (Without Monitoring)	Package Die Bond Wire Bond Substrate	Good	Expensive	This screening method is more effective than variable frequency vibration(without monitoring), when used with equipment intended for space vehicle operation, although it is more expensive.
Random Vibration (With Monitoring)	Foreign Particle Lead Structure Intermittent Open	Fairly Good Good Good	Very Expensive	This is one of the most expensive screening methods
Vibrational Noise	Foreign Particles	Good	Expensive	
Radioisotope Leak Test	Package Seal	Good	Moderate	This screening method is effective for detecting leakage in the range 10E6~10E12 atm. ml/sec
Helium Leak Test	Package Seal	Good	Moderate	This screening method is effective for detecting leak in the range 10E6~10E12 atm. ml/sec
Gross Leak Test	Package Seal	Good	Inexpensive	Effectiveness is dependent upon volume. Testing is possible for detecting leaks above 10E-3 atm. ml/sec.
High Voltage Test	Oxide Film	Good	Inexpensive	Effectiveness Depends on structure
Insulation Resistance	Lead Structure Metallization Contamination	Fairly Good	Inexpensive	
Intermittent Operation	Metallization Bulk Silicon Oxide Film Inversion/Channeling Design Parameter Drift Contamination	Good	Expensive	Probably about the same as AC operating life



QUALITY ASSURANCE and RELIABILITY PROGRAM

Test Method	Defect	Effectiveness	Cost	Remarks
AC Operation	Metalization Bulk Silicon Oxide Film Inversion/Channeling Design Parameter Drift Contamination	Very Good	Expensive	
DC Operation	Basically the Same as Intermittent Operation	Good	Expensive	The AC operation life method is more effective for any failure mechanism
High Temperature AC Operation	Same as AC Operation Life Test	Extremely Good	Very Expensive	Failures are accelerated by temperature. This is probably the most expensive and one of the most effective screening methods.
High Temperature Reverse Bias	Inversion /Channeling	Fairly Poor	Expensive	

9. Reliability Test Results

Extensive test results have been compiled through long term reliability monitoring (DRT) of devices. Current and historical data is entered into Samsung's Reliability Network, SRN. Thus, past performance of a device or its family, assembly evaluation results, manufacturing change reliability results, etcetera, can all be seen via computer through SRN.

Results included in this manual are representative of products stressed, and contain data from the past year. Data is summarized from both die and package tests, on five critical stresses. Failure rates for long term life testing are in FITs, which are calculated using Arrhenius' Equation. (Arrhenius' Equation is summarized in the Appendix section). Samsung's failure rates are well below 50 FITs, which is acknowledged by customers and competitors alike as among the industry's elite.

9.1 Long Term Life Test Results

Family	Test Item	Steady State Operation Life			High Temperature Storage Life		
		Test Condition		T _a = T _j (max.) V _{CB} = V _{CBO} × 0.8 1000 HRS	T _a = 125°C, 150°C 1000 HRS		
Application	Number of Samples	Number of Failures	Failure Rate (FIT)	Number of Samples	Number of Failures	Failure Rate (FIT)	
TR	Small Signal	1228	4	8	430	2	14
	Power	1056	16	33	708	1	6

Note 1) FIT: Failure in time or failure unit; represents the number of failures expected per 10⁹ (one billion) device hours (at 55°C).

2) TR: Transistor



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9.2 Environmental Test Results

Test Item	High Temp/High Humidity			Pressure Cooker			Thermal Shock			
	Application	Number of Samples	Number of Failures	Failure Rate (% 1Khrs)	Number of Samples	Number of Failures	Failure Rate (% 168HRS)	85°C, 85% R.H., V _{cbo} × 0.8		
Family								Number of Samples	Number of Failures	Failure Rate (% 200CYC)
TR	Small Signal	880	2	0.23	1020	12	1.2	1263	0	0
	Power	346	1	0.29	404	6	1.5	576	1	0.17

10. Product Outgoing Quality Levels

The quality of Samsung products reaching customers has improved steadily over the years. Nearly on order of magnitude reduction in outgoing product PPM levels has been achieved from 1983-7. Results can be seen below.

Average Outgoing Quality, or AOQ, is measured by the Quality Assurance Department. Prior to release, product is sampled according to MIL-STD 105D. Both electrical and visual/mechanical inspections occur. If inspection standards are met, product is approved for sales. Depending on the nature of the failure(s), rejected samples can cause an entire lot to be 100% tested and/or inspected, re-worked to screen out defective devices, or scrapped.

Electrical testing is typically done to product specification limits, guardbanded by a fixed percentage. Visual/mechanical inspection is performed to check for key package, marking, and lead parameters. (More extensive details are provided in Chapter 3, Assembly process control)

Although Samsung's AOQ levels are acceptable, efforts are constantly underway to reduce the figures (thereby increasing outgoing quality).

Enhanced focus on statistical process control in the manufacturing operation should help Samsung achieve it's goal of 50 PPM in 1988.

Samsung Product Electrical AOQ levels

(in PPM)

Product Family	1983	1984	1985	1986	1987
Small-Signal Transistor	526	509	308	150	45
Power Transistor	968	1289	578	664	101

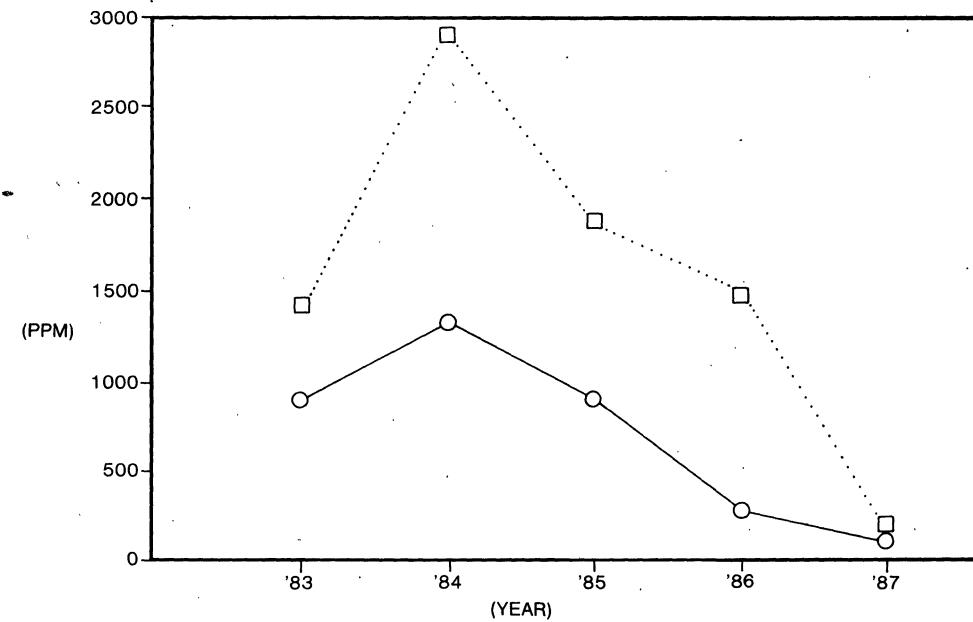
Samsung Product Visual/Mechanical AOQ Levels

(in PPM)

Product Family	1983	1984	1985	1986	1987
Small-Signal Transistor	362	816	596	129	57
Power Transistor	452	1589	1297	796	140



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Note: Total=Electrical + Visual/Mechanical
S/S TR=Small Signal Transistor
PWR TR=Power Transistor

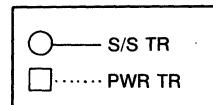
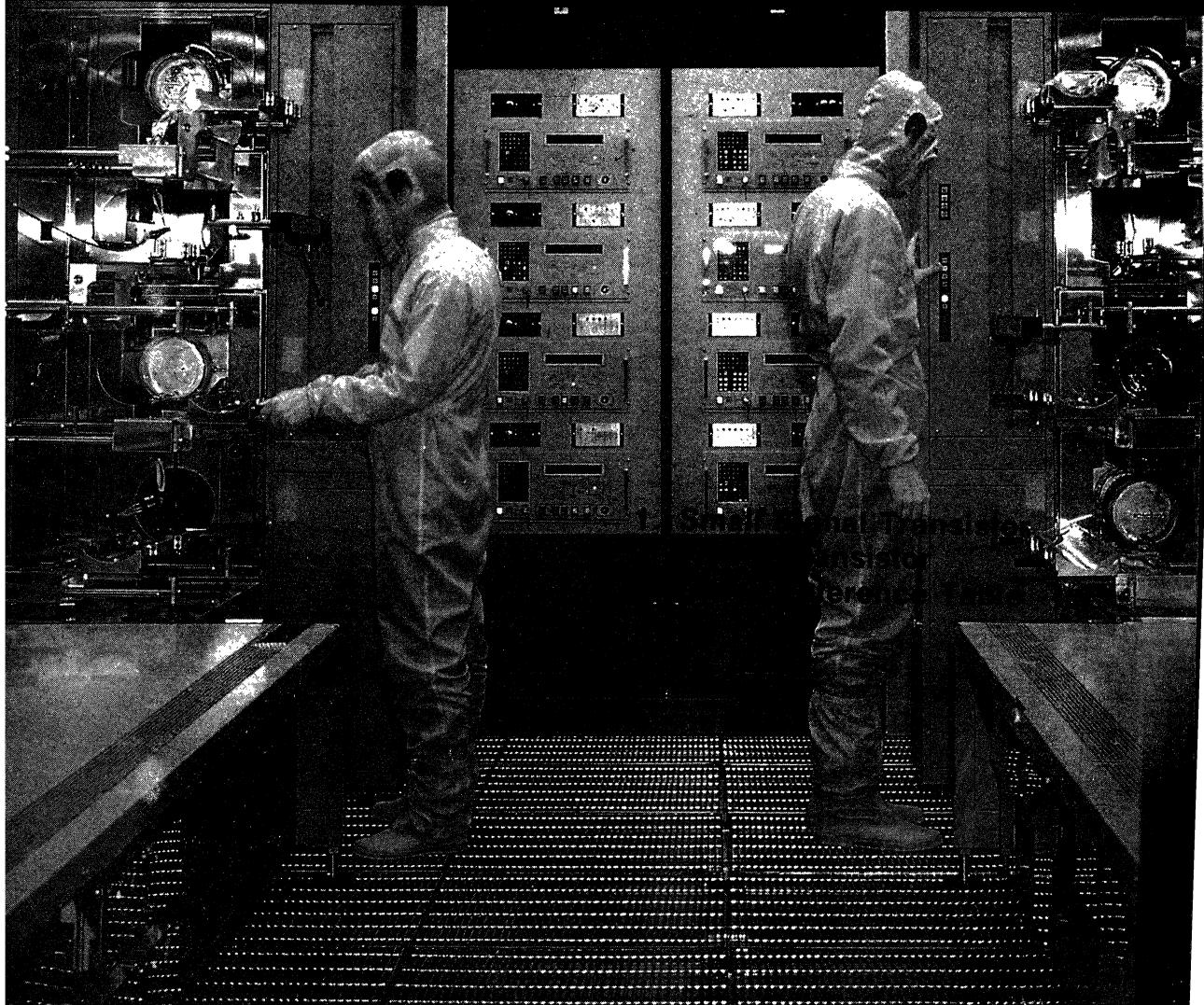


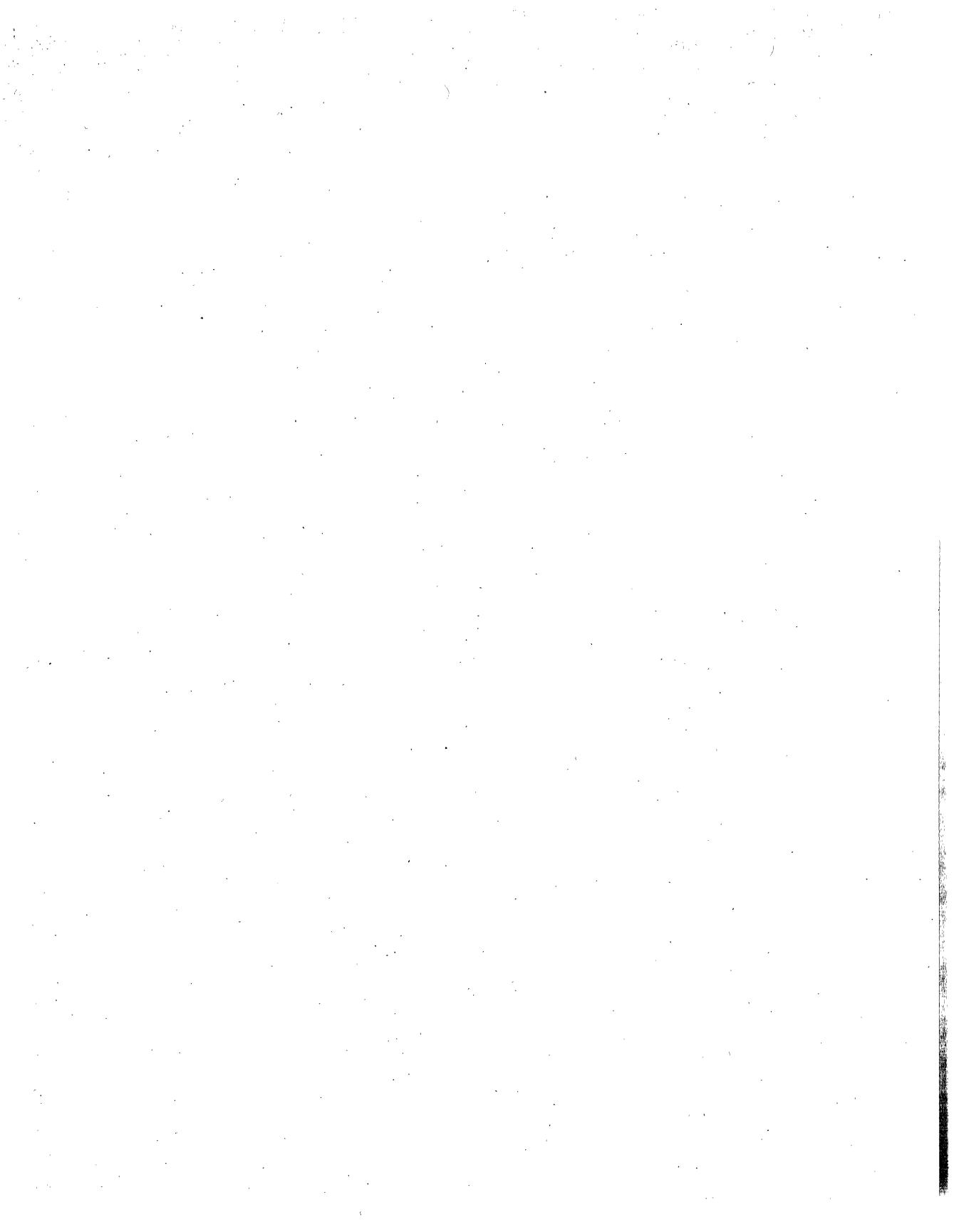
Fig. 3. Total AOQ Levels



NOTES

FUNCTION GUIDE 2





1. SMALL SIGNAL TRANSISTORS

1.1 General Purpose Transistors

1.1.1 SOT-23 Type Transistors

Device and Polarity (Marking)		V _{CEO} (V)	I _C (A)	Condition		h_{FE}		Condition		V _{CE} (sat), V _{BE} (sat) (V)		Condition		f_T (MHz)	
				V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)	V _{CE} (sat) MAX	V _{BE} (sat) MAX	V _{CE} (V)	I _C (mA)	MIN	TYP
MMBTA06(1G) MMBTA05(1H) KSC1623(C1X)	MMBTA56(2G)	80	0.5	1	100	50		100	10	0.25			2	10	100
	MMBTA55(2H)	60	0.5	1	100	50		100	10	0.25			2	10	100
	MMBT2907A(2F)	60	0.6	10	150	100	300	500	50	1.6	2.6		20	50	200
	KSA812(D1X)	50	0.1	6	1	90	600	100	10	0.3	1		6	10	250
	BCW69(H1)	45	0.1	5	2	120	260	10	0.5	0.3					
	BCW70(H2)	45	0.1	5	2	215	500	10	0.5	0.3					
BCW71(K1)		45	0.1	5	2	110	220	50	2.5				5	10	300
BCW72(K2)		45	0.1	5	2	200	450	50	2.5				5	10	300
BCX70G(AG)		45	0.1	5	2	120	220	50	1.25	0.55	1.05		5	10	125
BCX70H(AH)		45	0.1	5	2	180	310	50	1.25	0.55	1.05		5	10	125
BCX70J(AJ)		45	0.1	5	2	250	460	50	1.25	0.55	1.05		5	10	125
BCX70K(AK)	BCX71G(BG)	45	0.1	5	2	380	630	50	1.25	0.55	1.05		5	10	125
	BCX71H(BH)	45	0.1	5	2	120	220	50	1.25	0.55	1.05				
	BCX71J(BJ)	45	0.1	5	2	180	310	50	1.25	0.55	1.05				
	BCX71K(BK)	45	0.1	5	2	250	460	50	1.25	0.55	1.05				
	MMBA811C5(C5)	45	0.05	3	0.5	135	270	20	2	0.3			6	1	75
	MMBA811C6(C6)	45	0.05	3	0.5	200	400	20	2	0.3			6	1	75
	MMBA811C7(C7)	45	0.05	3	0.5	300	600	20	2	0.3			6	1	75
	MMBA811C8(C8)	45	0.05	3	0.5	450	900	20	2	0.3			6	1	75
MMBC1623L3(L3)	MMBA812M3(M3)	40	0.1	6	1	60	120	30	3	0.5					
MMBC1623L4(L4)	MMBA812M4(M4)	40	0.1	6	1	90	180	30	3	0.5					
MMBC1623L5(L5)	MMBA812M5(M5)	40	0.1	6	1	135	270	30	3	0.5					
MMBC1623L6(L6)	MMBA812M6(M6)	40	0.1	6	1	200	400	30	3	0.5					
MMBC1623L7(L7)	MMBA812M7(M7)	40	0.1	6	1	300	600	30	3	0.5					
MMBT2222A(1P)		40	0.6	10	150	100	300	500	50	1.6	2.6		20	20	300
MMBT3903(1Y)	MMBT2907(2B)	40	0.6	10	150	100	300	500	50	1.6	2.6		20	50	200
MMBT3904(1A)		40	0.2	1	10	50	150	50	5	0.3	0.95		20	10	250
MMBT4401(2X)	MMBT3906(2A)	40	0.2	1	10	100	300	50	5	0.3	0.95		20	10	300
MMBT4403(2T)		40	0.6	1	150	100	300	500	50	0.75	1.2		10	10	250
MMBT420(1C)	MMBT70(2C)	40	0.1	10	5	40	400	10	1	0.25			10	5	125
MMBC1622D6(D6)		35	0.1	3	0.5	200	400	100	10	0.3			6	1	100
MMBC1622D7(D7)		35	0.1	3	0.5	300	600	100	10	0.3			6	1	100
MMBC1622D8(D8)		35	0.1	3	0.5	450	900	100	10	0.3			6	1	100
BCW60A(AA)	BCW61A(BA)	32	0.1	5	2	120	220	50	1.25	0.55	1.05		5	10	125
BCW60B(AB)	BCW61B(BB)	32	0.1	5	2	180	310	50	1.25	0.55	1.05		5	10	125
BCW60C(AC)	BCW61C(BC)	32	0.1	5	2	250	460	50	1.25	0.55	1.05		5	10	125
BCW60D(AD)	BCW61D(BD)	32	0.1	5	2	380	630	50	1.25	0.55	1.05		5	10	125
MMBT2222(1B)		30	0.6	10	150	100	300	500	50	1.6	2.6		20	20	200
KSC2859(E1X)	KSA1182(F1X)	30	0.5	1	100	70	240	100	10	0.25			6	20	200
MMBT4123(5B)	MMBT4125(ZD)	30	0.2	1	2	50	150	50	5	0.3	0.95		20	10	250
KSC3265(K1X)	KSA1298(J1X)	25	0.8	1	100	100	320	500	20	0.4			5	10	120
MMBC1009F1(F1)		25	0.05	3	0.5	30	60	10	1	0.3			6	1	150



SOT-23 Type Transistors (Continued)

Device and Polarity (Marking)		V _{CEO} (V)	I _C (A)	Condition		h _{FE}		Condition		V _{CE} (sat), V _{BE} (sat) (V)		Condition		f _T (MHz)			
				V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)	V _{CE} (sat) MAX	V _{BE} (sat) MAX	V _{CE} (V)	I _C (mA)	MIN	TYP		
MMBC1009F2(F2)	MMBT4126(C3)	25	0.05	3	0.5	40	80	10	1	0.3		6	1	150			
MMBC1009F3(F3)		25	0.05	3	0.5	60	120	10	1	0.3		6	1	150			
MMBC1009F4(F4)		25	0.05	3	0.5	90	180	10	1	0.3		6	1	150			
MMBC1009F5(F5)		25	0.05	3	0.5	135	270	10	1	0.3		6	1	150			
MMBT4124(ZC)		25	0.2	1	2	120	360	50	5	0.3	0.95	20	10	300			
		BCW29(C1)	20	0.1	5	2	120	260	10	0.5	0.3						
		BCW30(C2)	20	0.1	5	2	215	500	10	0.5	0.3						
BCW31(D1)		20	0.1	5	2	110	220	10	0.5	0.3							
BCW32(D2)		20	0.1	5	2	200	450	10	0.5	0.3							
BCW33(D3)		20	0.1	5	2	420	800	10	0.5	0.3							

1.1.2 TO-92S Type Transistors

Device and Polarity		V _{CEO} (V)	I _C (A)	Condition		h _{FE}		Condition		V _{CE} (sat), V _{BE} (sat) (V)		Condition		f _T (MHz)			
				V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)	V _{CE} (sat) TYP	V _{CE} (sat) MAX	V _{BE} (sat) TYP	V _{BE} (sat) MAX	V _{CE} (V)	I _C (mA)	MIN	TYP
KSC2710	KSA1150	20	0.5	1	100	40	400	500	50	0.3	0.4	1	1.3	6	10	160	110
	KSA1378	25	0.3	1	50	70	400	300	30	0.35	0.6						
	KSB810	25	0.7	1	100	70	400	700	70	0.25	0.4	0.95	1.2	6	10		
	KSB811	25	1	0	100	70	400	1000	100	0.5	0.5		1.2	6	10		
	KSC3488	20	0.5	1	100	40	400	500	50	0.18	0.4					50	170
	KSD1020	25	0.3	1	50	70	400	300	30	0.14	0.4						
	KSD1021	25	0.7	1	100	70	400	700	70	0.2	0.4	0.95	1.2	6	10		
		30	1	1	100	70	400	1000	100	0.5	0.5		1.2	6	10		

1.1.3 TO-92 Type Transistors

Device and Polarity		V _{CEO} (V)	I _C (A)	Condition		h _{FE}		Condition		V _{CE} (sat), V _{BE} (sat) (V)		Condition		f _T (MHz)			
				V _{CE} (V)	I _C (mA)	MIN	MAX	I _C (mA)	I _B (mA)	V _{CE} (sat) MAX	V _{BE} (sat) MAX	V _{CE} (V)	I _C (mA)	MIN	TYP		
MPSA06	MPSA56	80	0.5	1	100	50		100	10	0.25			2	10	100	50	150
	MPS8099	80	0.5	5	1	100	300	100	10	0.3			6	10	50		
KSC2003	KSA954	80	0.3	1	50	90	400	300	30	0.6		1.2				100	100
	KSD1616A	60	1	2	100	135	400	1000	50	0.3		1.2	2	100	70		
KSC1008	KSA708	60	0.7	2	50	40	240	500	50	0.7		1.1	10	50	20	200	
	MPS2907A	60	0.6	10	150	100	300	500	50	1.6		2.6	20	50			
MPS8098	MPS8598	60	0.5	5	1	100	300	100	10	0.3			5	10	150	2	100
	MPSA55	60	0.5	1	100	50		100	10	0.25			2	10	100		
KSC2002	KSA953	60	0.3	1	50	90	400	300	30	0.6		1.2	6	10	50	100	100
	KSC853	60	0.2	1	50	40	400	150	15	0.5		1.2					
KSD1616	KSB1116	50	1	2	100	135	600	1000	50	0.3		1.2	2	100	70	100	100
	KSC1072	45	0.7	2	50	40	240	500	50	0.7		1.1					
KSC815	KSA707	45	0.2	1	0.05	40	240	150	15	0.5		1.2				100	270
	KSA539	45	0.2	1	0.05	40	240	150	15	0.5		1.2					
SS9014	SS9015	45	0.1	5	1	60	1000	100	5	0.3		1	5	10	150	270	270



TO-92 Type Transistors (continued)

Device and Polarity		V _{CEO} (V)	I _C (A)	Condition		h _{FE}	Condition		V _{CE} (sat), V _{BE} (sat) (V)		Condition		f _T (MHz)			
NPN	PNP			V _{CE} (V)	I _C (mA)		MIN	MAX	I _C (mA)	I _B (mA)	V _{CE} (sat) MAX	V _{BE} (sat) MAX	V _{CE} (V)	I _C (mA)	MIN	TYP
MPS6602		40	1	1	500	50	1000	100	0.6		0.6		10	50	100	
2N4401	2N4403	40	0.6	1	150	100	300	500	50	0.75	1.2	10	20	200		
MPS2222A	MPS2907	40	0.6	10	150	100	300	500	50	1.6	2.6	20	20	300		
2N4400	2N4402	40	0.6	1	150	50	150	500	50	0.75	1.2	10	20	200		
2N3903	2N3905	40	0.2	1	10	50	150	50	5	0.3	0.95	20	10	250		
2N3904	2N3906	40	0.2	1	10	100	300	50	5	0.3	0.95	20	10	300		
MPS6513	MPS6517	40	0.1	10	2	90	180	50	5	0.5		10	5	125		
MPSA10		40	0.1	10	5	40	400					10	5	125		
MPSA20	MPSA70	40	0.1	10	5	40	400					6	10	300		
KSC1330		40	0.1	6	1	70	400	30	3	0.5		6	10	130		
KSD471A		30	1	1	100	70	400	1000	100	0.5	1.2	5	50	100		
MPS3705	MPS3703	30	0.6	5	50	30	150	50	5	0.25						
MPS3704		30	0.6	2	50	100	300	100	5		2.6	2	50	100		
MPS2222		30	0.6	10	150	100	300	500	50	1.6		20	20	250		
KSC921		30	0.1	10	2	40	240	10	1	0.6		10	1	100	250	
KSC839		30	0.1	12	2	40	400	10	1	0.4		10	1	80	200	
SS9011		30	0.03	5	1	28	198	10	1	0.3						
SS8050	SS8550	25	1.5		100	85	300	800	80	0.5	1.2	10	50	100	190	
	KS8564A	25	1		100	70	400	1000	100	0.5	1.2	10	10	100	110	
MPS6601	MPS6651	25	1		500	50		1000	100	0.6		10	50	100		
	MPS3702	25	0.6		50	60	300	50	50	0.25		5	10	100		
MPS6560	MPS6562	25	0.5		500	50	200	500	50	0.5						
KSD227	KSA642	25	0.3		50	70	400	300	30	0.6						
	MPS5172	25	0.1		10	100	500	10	1	0.25		2			120	
KSC184	KSA542	25	0.05		1	40	400	20	2	0.3		6	1	100		
		20	0.6		50	30	600	100	5	1		2	50	100		
KSD261	KSA643	20	0.5		100	40	400	500	50	0.4	1.3	1				
SS9013	SS9012	20	0.5		50	64	202	500	50	0.6	1.2	1				

1.1.4 TO-92L Type Transistors

Device and Polarity		V _{CEO} (V)	I _C (A)	Condition		h _{FE}	Condition		V _{CE} (sat), V _{BE} (sat) (V)		Condition		f _T (MHz)			
NPN	PNP			V _{CE} (V)	I _C (mA)		MIN	MAX	I _C (mA)	I _B (mA)	V _{CE} (sat) MAX	V _{BE} (sat) MAX	V _{CE} (V)	I _C (mA)	MIN	TYP
KSC2328A	KSA928A	30	2	2	500	100	320	1500	30	2		2	500		120	
KSC2331	KSA931	60	0.7	2	50	40	240	500	50	0.7	1.2	10	50		100	
KSC2500		10	2	1	500	140	600	2000	50	0.5		1	500		150	

1.2 Low Noise Transistors

1.2.1 SOT-23 Type Transistors

Device and Polarity (Marking)		MAX	Condition Frequency	V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		V _{CE(sat)} (V) MAX
NPN	PNP					V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	
MMBT6428(1K)	MMBT5086(2P)	4	Audio	50	0.2	5	0.1	250	650	100	5	0.6
MMBT6429(1L)		4	Audio	45	0.2	5	0.1	500	1250	100	5	0.6
MMBT2484(1U)		3	Audio	60	0.05	5	1	250		1	0.1	0.35
MMBT5088(1Q)		3	Audio	50	0.05	5	0.1	150	500	10	1	0.3
MMBT5087(2Q)		3	Audio	30	0.05	5	0.1	300	900	10	1	0.5
MMBT5089(1R)		2	Audio	50	0.05	5	0.1	250	800	10	1	0.3
		2	Audio	25	0.05	5	0.1	400	1200	10	1	0.5

1.2.2 TO-92S Type Transistors

Device and Polarity(Marking)		NF(dB)	V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		V _{CE(sat)} (V) MAX	Condition		f _T (MHz) TYP		
NPN	PNP				Condition Frequency	(V)	(A)	V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)	MAX		
KSA1175		6	Audio	50	0.15	6	1	40	700	100	10	0.3	6	10		180
KSC2785		4	Audio	50	0.15	6	1	40	700	100	10	0.3	6	10		300

Audio = 10Hz to 15.7KHz

1.2.3 TO-92 Type Transistors

Device and Polarity		NF(dB)	Condition Frequency	V _{CEO} (V)	I _c (A)	Condition		h _{FE}		Condition		Saturation Voltage(V)		
NPN	PNP					Condition Frequency	(V)	(A)	V _{CE} (V)	I _c (mA)	MIN	MAX	I _c (mA)	I _B (mA)
2N6428	KSA733	6	Audio	50	0.2	5	0.1	250	650	100	5		0.6	
2N4123		6	Audio	30	0.2	1	2	50	150	50	5		0.3	
2N4124		5	Audio	30	0.2	1	2	50	150	50	5		0.4	
KSC945		5	Audio	25	0.2	1	2	120	360	50	5		0.3	
2N5088		4	Audio	50	0.15	6	1	40	700	100	10		0.3	
		2N4126	4	Audio	25	0.2	1	2	120	360	50	5		0.4
		MPS4249	3	Audio	60	0.1	5	0.1	100	300	10	0.5		0.25
		2N5086	3	Audio	50	0.05	5	0.1	150	500	10	1		0.3
		2N5088	3	Audio	30	0.05	5	0.1	300	900	10	1		0.5
		MPS6522	3	Audio	25	0.1	10	2	200	400	50	5		0.5
MPS6520	MPS6523	3	Audio	25	0.1	10	2	200	400	50	5		0.5	
MPS6521		3	Audio	25	0.1	10	2	300	600	50	5		0.5	
		MPS4250A	3	Audio	25	0.1	10	2	300	600	50	5		0.5
		2N5087	2	Audio	60	5	0.1	250	700	10	0.5		0.25	
2N5089	2N5210	2	Audio	50	0.05	5	0.1	250	800	10	1		0.3	
2N6428A		2	Audio	25	0.05	5	0.1	400	1200	10	1		0.5	
*4		50	0.2	5	0.1	250	650	100	5		0.6			
2N5209		*2	Audio	50	0.05	5	0.1	200	600	10	1		0.7	
MPS8097	KSA640	*2	Audio	40	0.2	5	0.1	250	700	10	0.5		0.25	
KSC1222		**40	Audio	45	0.05	3	0.5	120	1000	20	2		0.3	
KSC900		**30	Audio	25	0.05	3	0.5	120	1000	20	2		0.2	

Audio=10Hz to 15.7KHz

*=MAX, **=Noise Level



1-3. RF/VHF/UHF Amplifier Transistors

1-3-1. SOT-23 Type Transistors

Device NPN	Condition		f _T		C _{OB} (pF)	V _{CEO} (V)	G _{PE} (dB)	Condition		h _{FE}		N _F (dB)	I _{AGC} (mA)	Condition Gain Reduction (dB)
	V _{CE} (V)	I _C (mA)	MIN	TYP				V _{CE} (V)	I _C (mA)	MIN	MAX			
KSC2734(H8Z)	10	10	1400	3500	1.5	12	\$10	10	5	20	200	*8	800	
KSC3120(H9Z)	10	2	1500	2400	#0.9	15	\$12	10	5	40	200			
KSC2759(H6X)	10	5	1250	2000	1.3	14	&10	10	5	40	180			
MMBR5179	6	5	900	2000	@1	12	15	1	3	25	250	4.5	200	
KSC2757(H3X)	10	5	800	1100	1.5	15	10	5	5	60	240			
KSC2758(H4Z)	10	3	750	1000	0.8	25	14	10	3	60	240	4.5	900	11
MMBT10(3E)	10	4	650		@0.7	25	10	4	60					30
KSC2756(H2X)	10	5	500	850	#0.5	20	\$15	10	5	60	240	*6.5	200	
MMBT24(3A)	10	8	400	620	@0.36	30	\$19	10	8	30				
KSC2755(H1X)	10	3	400	600	#0.5	30	20	10	3	60	240	3	200	12
KSC2223(H5X)	6	1	400	600	*1	20		6	1	40	180	*3	100	
KSC3125(A1Z)	10	10	250	600	1.6	25		10	10	20	200			
KSC2715(B1X)	10	1	100		3.2	30	27	12	2	40	240			

1.3.2 TO-92S Type Transistors

Device (NPN)	Condition		f _T (MHz)		C _{OB} (pF)	V _{CEO} (V)	G _{PE} (dB)	Condition		h _{FE}		N _F (dB)	I _{AGC} (mA)	Condition f _T (MHz)
	V _{CE} (V)	I _C (mA)	MIN	TYP				V _{CE} (V)	I _C (mA)	MIN	TYP			
KSC2669	10	1	100	250	3.2	30		12	2	40		240		
KSC2786	6	1	400	600	*1.2	20	18	6	1	40		240	5	100
KSC2787	6	1	150	300	2.5	30		6	1	40		240		

1-3-2 TO-92 Type Transistors

Device NPN	Condition		f _T		C _{OB} (pF)	V _{CEO} (V)	G _{PE} (dB)	Condition		h _{FE}		N _F (dB)	I _{AGC} (mA)	Condition Gain Reduction (dB)
	V _{CE} (V)	I _C (mA)	MIN	TYP				V _{CE} (V)	I _C (mA)	MIN	TYP			
MPS5179	6	5	900	2000	@1	12	15	1	3	25	250	4.5	200	
KSC1730	10	5	800	1100	1.5	15		10	5	40	240			
MPSH17	10	5	800		@0.9	15	*24	10	5	25	250	6	200	
KSC1070***	10	3	750	1000	0.8	25	14	10	3	40	200	4	900	11
SS9018	5	5	700	1100	1.7	15		5	1	28	198			
MPSH11	10	4	650		@0.7	25		10	4	60				
MPSH10	10	4	650		@0.7	25		10	4	60				
KSC1395	10	5	600	1100	1.5	15		10	5	40	240			
MPSH24	10	8	400	620	@0.36	30	\$19	10	8	30				
KSC1393	10	3	400	700	#0.5	30	20	10	2	40	240	3	200	12
KSC1394	10	3	400	700	#0.5	30	20	10	2	40	240	3.5	200	
MPSH20	10	4	400	620	@0.65	30	\$18	10	4	25				
SS9016	5	1	400	620	1.6	20		5	1	28	198	5	100	
KSC1187	10	3	400	700	*#0.6	20	20	10	2	40	240			
KSC1188	10	3	400	700	1	20	20	10	2	40	240			
KSC1674	6	1	400	600	*1.5	20	18	6	1	40	240	5	100	
KSC388	12.5	12.5	300		2	25	28	12	12.5	20	200			
KSC1675	6	1	150	300	2.5	20		6	1	40	240			
KSC838	10	1	100	250	3.2	30		12	2	40	240			

*=TYP, #=Cre, @=Ccb, \$=Gce, &=Gcb, *** = DISK TYPE TRANSISTOR

1-4. High Voltage Transistors

1-4-1. SOT-23 Type Transistors

Device and polarity(Marking)		V _{CEO} (V)	I _C (A)	Condition		h _{FE}	Condition		Saturation Voltage(V)		Condition		f _T (MHz) MIN	TYP		
NPN	PNP			V _{CE} (V)	I _C (mA)		MIN	MAX	I _C (mA)	I _B (mA)	V _{CE} MAX	V _{BE} MAX	V _{CE} (V)	I _C (mA)		
MMBT42(1D)	MMBT42(2D)	300	0.5	10	30	40			20	2	0.5	0.9	20	10	50	
MMBT43(1E)	MMBT43(2E)	200	0.5	10	30	40			20	2	0.5	0.9	20	10	50	
MMBT5550(1F)	MMBT5401(2L)	150	0.5	5	10	60	240		50	5	0.5	1	10	10	100	
		140	0.6	5	10	60	250		50	5	0.25	1.2	10	10	100	

1-4-2. TO-92S Type Transistors

Device and polarity(Marking)		V _{CEO} (V)	I _C (A)	Condition		h _{FE}	Condition		V _{CE(sat)} , V _{BE(sat)} (V)		Condition		f _T (MHz) MIN	TYP			
NPN	PNP			V _{CE} (V)	I _C (mA)		MIN	MAX	I _C (mA)	I _B (mA)	V _{CE(sat)} MAX	V _{BE(sat)} MAX	V _{CE} (V)	I _C (mA)			
KSA1174		120	0.05	6	1	200	800	10	1	0.09	0.3			6	1	50	100
KSC2874		120	0.05	6	1	200	1200	10	1	0.07	0.3			6	1	50	110

1-4-3. TO-92 Type Transistors

Device and polarity(Marking)		V _{CEO} (V)	I _C (A)	Condition		h _{FE}	Condition		Saturation Voltage(V)		Condition		f _T (MHz) MIN	TYP			
NPN	PNP			V _{CE} (V)	I _C (mA)		MIN	MAX	I _C (mA)	I _B (mA)	V _{CE} MAX	V _{BE} MAX	V _{CE} (V)	I _C (mA)			
MPSA44		400	0.3	10	10	50	200	10	1	0.5	0.75						
2N6517	2N6520	350	0.5	10	30	30	200	30	3	0.5	0.9	20	10	40			
MPSA45		350	0.3	10	10	50	200	10	1	0.5	0.75						
MPSA42	MPSA92	300	0.5	10	30	40		20	2	0.5	0.9	20	10	50			
2N6516	2N6519	300	0.5	10	30	45	270	30	3	0.5	0.9	20	10	40			
KSC1506		300	0.1	10	10	40	240	50	5	2		30	10	40	80		
2N6515	2N6518	250	0.5	10	30	50	300	30	3	0.5	0.9	20	10	40			
MPSA43		200	0.5	10	30	40		20	2	0.5	0.9	20	10	50			
2N5551		160	0.6	5	10	80	250	50	6	0.2	1	10	10	100		50	
KSA709		150	0.7	2	50	40	240	200	20	0.4	1	10	50				
2N5401		150	0.6	5	10	60	240	50	5	0.5	1	10	10	100			
KSC1009		140	0.7	2	50	40	240	200	20	0.2	0.86	10	50	30	50		
2N5550	2N5400	140	0.6	5	10	60	250	50	5	0.25	1.2	10	10	100			
MPSL01		120	0.6	5	10	40	180	50	5	0.5	1	10	10	100			
KSC1845	KSA992	120	0.15	5	10	50	300	50	5	0.3	1.4	10	10	60			
	MPSL51	100	0.6	5	50	40	250	50	5	0.3	1.2	10	10	60			

1-4-4. TO-92L Type Transistors

Device and polarity(Marking)		V _{CEO} (V)	I _C (A)	Condition		h _{FE}	Condition		Saturation Voltage(V)		Condition		f _T (MHz) MIN	TYP			
NPN	PNP			V _{CE} (V)	I _C (mA)		MIN	MAX	I _C (mA)	I _B (mA)	V _{CE(sat)} MAX	V _{BE(sat)} MAX	V _{CE} (V)	I _C (mA)			
KSC2340		350	0.1	10	20	30	150	10	1	0.5	10	20	50				
KSC2330		300	0.1	10	20	40	240	10	1	0.5		30	10		50		
KSC2383	KSA1013	160	1	5	200	60	320	500	50	1.5		5	200	15	50		
KSC2310	KSA910	150	0.05	5	10	40	240	10	1	0.8		30	10		100		
KSC2316	KSA916	120	0.8	5	100	80	240	500	50	1		5	100		120		

1-5. Darlington Transistors

1-5-1. SOT-23 Type Transistors.

Device and polarity(Marking)		V _{CES}	I _c	Condition		h _{FE}	Condition V _{CE(sat)} V _{BE(sat)} (V)				Condition		f _{T(MHz)}
				V _{CE}	I _c		I _c	I _b	V _{CE(sat)}	V _{BE(sat)}	MAX	MIN	
NPN	PNP	(V)	(A)	(V)	(mA)		(mA)	(mA)	MAX	MIN	MIN	TYP	
MMBT6427(1V) MMBTA13(1M) MMBTA14(1N)	MMBT63(2U) MMBTA64(2V)	*40	0.5	5	100	20K	200K	500	0.5	1.5	2	5 5 5 10 10	10 10 10 125 125
		30	0.3	5	100	10K		100	0.1	1.5			
		30	0.3	5	100	10K		100	0.1	1.5			
		30	0.5	5	100	10K		100	0.1	1.5	5		
		30	0.5	5	100	10K		100	0.1	1.5	5		

*: V_{CEO}

1-5-2. TO-92 Type Transistors.

Device and Polarity		V _{CES}	I _c	Condition		h _{FE}	Condition V _{CE(sat)} V _{BE(sat)} (V)				Condition		f _{T(MHz)}	
				V _{CE}	I _c		I _c	I _b	V _{CE(sat)}	V _{BE(sat)}	MAX	MIN		
NPN	PNP	(V)	(A)	(V)	(mA)		(mA)	(mA)	MAX	MIN	MIN	TYP		
MPSA27 MPSA26 2N6427	MPSA77 MPSA76	60	0.5	5	100	10K	200K	100	0.1	1.5			5 5 5 10 10	10 10 10 125 125
		60	0.5	5	100	10K		100	0.1	1.5				
		50	0.5	5	100	10K		100	0.1	1.5				
		50	0.5	5	100	10K		100	0.1	1.5				
		*40	0.5	5	100	20K		500	0.5	1.5	2			
MPSA25 MPSA14 MPSA13 MPSA12	MPSA75 MPSA64 MPSA63 MPSA62	40	0.5	5	100	10K	200K	100	0.1	1.5				
		40	0.5	5	100	10K		100	0.1	1.5				
		30	0.5	5	100	10K		100	0.1	1.5				
		30	0.5	5	100	20K		100	0.1	1.5				
		20	0.5	5	10	20K		10	0.01	1				

*: V_{CEO}

1-6. Digital Transistors

1-6-1. SOT-23 Type Transistors

Device and Polarity		R1	R2	V _{CEO}	I _c	Condition		h _{FE}	Condition V(sat)(V)				Condition		f _{T(MHz)}
						V _{CE}	I _c		I _c	I _b	V _{CE(sat)}	V _{BE(sat)}	MAX	MIN	
NPN	PNP	KΩ	KΩ	(V)	(mA)			(mA)	(mA)	MAX	MIN	TYP			
KSR1101	KSR2101	4.7	4.7	50	100	5	10	20	10	0.5	0.1	0.3	10	5	250/200
KSR1102	KSR2102	10	10	50	100	5	4	30	10	0.5	0.1	0.3	10	5	250/200
KSR1103	KSR2103	22	22	50	100	5	5	56	10	0.5	0.1	0.3	10	5	250/200
KSR1104	KSR2104	47	47	50	100	5	5	68	10	0.5	0.1	0.3	10	5	250/200
KSR1105	KSR2105	4.7	10	50	100	5	5	30	10	0.5	0.1	0.3	10	5	250/200
KSR1106	KSR2106	10	47	50	100	5	5	68	10	0.5	0.1	0.3	10	5	250/200
KSR1107	KSR2107	22	47	50	100	5	5	68	10	0.5	0.1	0.3	10	5	250/200
KSR1108	KSR2108	47	22	50	100	5	5	56	10	0.5	0.1	0.3	10	5	250/200
KSR1109	KSR2109	4.7	40	100	5	5	100	600	10	1	0.1	0.3	10	5	250/200
KSR1110	KSR2110	10	40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1111	KSR2111	22	40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1112	KSR2112	47	40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1113	KSR2113	2.2	47	50	100	5	5	68	10	0.5	0.1	0.3	10	5	250/200
KSR1114	KSR2114	4.7	47	50	100	5	5	68	10	0.5	0.1	0.3	10	5	250/200

1-6-2. TO-92S Type Transistors

Device and Polarity		R1	R2	V _{CEO}	I _c	Condition		h _{FE}	Condition		V _{CE(sat)(V)}	Condition		f _T (MHz)		
						V _{CEO}	I _c		I _c	I _b		V _{CE(sat)}	TYP	MAX		
NPN	PNP	KΩ	KΩ	(V)	(mA)	(V)	(mA)	MIN	MAX	(V)	(mA)	(V)	(mA)	(V)	TYP	
KSR1201	KSR2201	4.7	4.7	50	100	5	10	20	-	10	0.5	0.1	0.3	10	5	250/200
KSR1202	KSR2202	10	10	50	100	5	4	30	-	10	0.5	0.1	0.3	10	5	250/200
KSR1203	KSR2203	22	22	50	100	5	5	56	-	10	0.5	0.1	0.3	10	5	250/200
KSR1204	KSR2204	47	47	50	100	5	5	68	-	10	0.5	0.1	0.3	10	5	250/200
KSR1205	KSR2205	4.7	10	50	100	5	5	30	-	10	0.5	0.1	0.3	10	5	250/200
KSR1206	KSR2206	10	47	50	100	5	5	68	-	10	0.5	0.1	0.3	10	5	250/200
KSR1207	KSR2207	22	47	50	100	5	5	68	-	10	0.5	0.1	0.3	10	5	250/200
KSR1208	KSR2208	47	22	50	100	5	5	56	-	10	0.5	0.1	0.3	10	5	250/200
KSR1209	KSR2209	4.7		40	100	5	5	100	600	10	1	0.1	0.3	10	5	250/200
KSR1210	KSR2210	10		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1211	KSR2211	22		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1212	KSR2212	47		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1213	KSR2213	2.2	47	50	100	5	5	68	-	10	0.5	0.1	0.3	10	5	250/200
KSR1214	KSR2214	4.7	47	50	100	5	5	68	-	10	0.5	0.1	0.3	10	5	250/200

1-6-3. TO-92 Type Transistors

Device and Polarity		R1	R2	V _{CEO}	I _c	Condition		h _{FE}	Condition		V(sat)(V)	Condition		f _T (MHz)		
						V _{CE}	I _c		I _c	I _b		V _{CE(sat)}	TYP	MAX		
NPN	PNP	KΩ	KΩ	(V)	(mA)	(V)	(mA)	MIN	MAX	(V)	(mA)	(V)	(mA)	(V)	TYP	
KSR1001	KSR2001	4.7	4.7	50	100	5	10	20	-	10	0.5	0.1	0.3	10	5	250/200
KSR1002	KSR2002	10	10	50	100	5	5	30	-	10	0.5	0.1	0.3	10	5	250/200
KSR1003	KSR2003	22	22	50	100	5	5	56	-	10	0.5	0.1	0.3	10	5	250/200
KSR1004	KSR2004	47	47	50	100	5	5	68	-	10	0.5	0.1	0.3	10	5	250/200
KSR1005	KSR2005	4.7	10	50	100	5	5	30	-	10	0.5	0.1	0.3	10	5	250/200
KSR1006	KSR2006	10	47	50	100	5	5	68	-	10	0.5	0.1	0.3	10	5	250/200
KSR1007	KSR2007	22	47	50	100	5	5	68	-	10	0.5	0.1	0.3	10	5	250/200
KSR1008	KSR2008	47	22	50	100	5	5	56	-	10	0.5	0.1	0.3	10	5	250/200
KSR1009	KSR2009	4.7		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1010	KSR2010	10		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1011	KSR2011	22		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1012	KSR2012	47		40	100	5	1	100	600	10	1	0.1	0.3	10	5	250/200
KSR1013	KSR2013	2.2	47	50	100	5	5	68	-	10	0.5	0.1	0.3	10	5	250/200
KSR1014	KSR2014	4.7	47	50	100	5	5	68	-	10	0.5	0.1	0.3	10	5	250/200



1.7 JUNCTION FETS

1.7.1 SOT-23 Type J-FET.

DEVICE	V _{GDO} (V)	I _G (mA)	P _D (mW)	I _{DS} (mA)			V _{DS} (V)	g _m (mS)			V _{GS(OFF)}			(V)	
				MIN	MAX	MIN		MIN	TYP	MAX	V _{DS} (V)	V _{DS} (V)	I _D (μA)	MIN	MAX
KSK123	20	2	200	0.13	0.47	4.5	0.9	1.6		4.5					
KSK211	18	10	200	1	10	10		9		10	10	1	0.4	4	2

1.7.2 TO-92S Type J-FET

DEVICE	V _{GDO} (V)	I _G (mA)	P _D (mW)	I _{DS} (mA)			V _{DS} (V)	g _m (mS)			V _{GS(OFF)}			(V)	
				MIN	MAX	MIN		MIN	TYP	MAX	V _{DS} (V)	V _{DS} (V)	I _D (μA)	MIN	MAX
KSK65	12	2	20	0.04	0.8	4.5	0.3	0.5		4.5					
KSK161	18	10	200	1	10	10		9		10	10	1	0.4	4	2

1.7.3 TO-92 Type J-FET

DEVICE	V _{GDO} (V)	I _G (mA)	P _D (mW)	I _{DS} (mA)			V _{DS} (V)	g _m (mS)			V _{GS(OFF)}			(V)	
				MIN	MAX	MIN		MIN	TYP	MAX	V _{DS} (V)	V _{DS} (V)	I _D (μA)	MIN	MAX
KSK30	50	10	100	0.3	6.5	10	1.2			10	10	0.1	0.4	5	
KSK117	50	10	300	0.6	14	10	4	15		10	10	0.1	0.2	1.5	



2. POWER TRANSISTORS

2.1. General Purpose Transistors

2.1.1 TO-126 Type Transistors

I _C (A)	V _{CEO} (V)	Device Type		h _{FE}				V _{CE(SAT)} (V)				f _T (MHz)				P _c (W)
		NPN	PNP	V _{CE} (V)	I _C (A)	MIN	MAX	I _C (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _C (A)	MIN	TYP	
0.1	180	KSC2682	KSA1142	5	0.01	100	320	0.05	0.005	0.16	0.5	10	0.02		180	8
0.2	300	KSC2688		10	0.01	40	250	0.05	0.005		1.5	30	0.01	50	80	10
0.5	300	MJE340	MJE350	10	0.05	30	240									20
1.2	120	KSC2690	KSA1220	5	0.3	60	320	1	0.2	0.4	0.7	5	0.2		175	20
	160	KSC2690A	KSA1220A	5	0.3	60	320	1	0.2	0.4	0.7	5	0.2		11	20
3	30	KSD882	KS8772	2	1	60	400	2	0.2	0.3	0.5	5	0.1		80	10
	40	MJE180	MJE170	1	0.1	50	250	3	0.6		1.7	10	0.1	50		12.5
	45	KSD794	KS8744	5	0.5	60	320	1.5	0.15	0.5	2	5	0.1		45	10
	60	KSD794A	KS8744A	5	0.5	60		1.5		0.5	2	5	0.1		45	10
	MJE181	MJE171		1	0.1	50	250	3	0.6	1.7	10	0.1	50		12.5	
5	80	MJE182	MJE172	1	0.1	50	250	3	0.6		1.7	10	0.1	50		12.5
	25	MJE200	MJE210	1	2	45	180	2	0.2		0.75	10	0.1	65		15
	60	KSD1691	KS87151	1	2	100	400	2	0.2	0.1	0.3					20

2.1.2 TO-202 Type Transistors

I _C (A)	V _{CEO} (V)	Device Type		h _{FE}				V _{CE(SAT)} (V)				f _T (MHz)				P _c (W)
		NPN	PNP	V _{CE} (V)	I _C (A)	MIN	MAX	I _C (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _C (A)	MIN	TYP	
0.2	250	KSC1520		10	0.01	40	240	0.05	0.005		2	30	0.01	40	80	10
	300	KSC1520A		10	0.01	40	240	0.05	0.005		2	30	0.01	40	80	10
2	30	KSC1096	KSA634	5	1	40	240	1.5	0.15	0.3	0.7					10
	45	KSC1098	KSA636	5	0.5	40	240	1	0.1	0.15	0.7					10

2.1.3 TO-220 Type Transistors

I _c (A)	V _{CEO} (V)	Device Type		h _{FE}				V _{CE(SAT)} (V)				f _T (MHz)				P _c (W)
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _b (A)	TYP	MAX	V _{CE} (V)	I _c (A)	MIN	TYP	
0.2	300	KSC1507		10	0.01	40	240	0.05	0.005		2	30	0.01	40	80	15
1	40	TIP29	TIP30	4	1	15	75	1	0.125		0.7	10	0.2	3		30
	60	TIP29A	TIP30A	4	1	15	75	1	0.125		0.7	10	0.2	3		30
	80	TIP29B	TIP30B	4	1	15	75	1	0.125		0.7	10	0.2	3		30
	100	TIP29C	TIP30C	4	1	15	75	1	0.125		0.7	10	0.2	3		30
	250	TIP47		10	0.3	30	150	1	0.2		0.1	10	0.2	10		40
	300	TIP48		10	0.3	30	150	1	0.2		0.1	10	0.2	10		40
	350	TIP49		10	0.3	30	150	1	0.2		0.1	10	0.2	10		40
	400	TIP50		10	0.3	30	150	1	0.2		0.1	10	0.2	10		40
1.5	150	KSC2073	KSA940	10	0.5	40	140	0.5	0.05		1.5	10	0.5	4		25
2	150	KSD401	KSB546	10	0.4	40	240					10	0.4		5	25
3	30	KSC1173	KSA473	2	0.5	70	240	2	0.2	0.3	0.8	2	0.5		100	10
	40	TIP31	TIP32	4	3	10	50	3	0.375		1.2	10	0.5	3		40
	55	KSD288	KSA614	5	0.5	40	240	1	0.1	0.15	0.5					25
	60	TIP31A	TIP32A	4	3	10	50	3	0.375		1.2	10	0.5	3		40
		KSD880	KSB834	5	0.5	60	200	3	0.3	0.5		5	0.5		9	30
		KSC1983		4	0.5	500		2	0.05		1	12	0.2		15	30
	80	TIP31B	TIP32B	4	3	10	50	3	0.375		1.2	10	0.5	3		40
	100	TIP31C	TIP32C	4	3	10	50	3	0.375		1.2	10	0.5	3		40
4	60	KSC2233		5	1	30	150	4	0.4		1	5	0.5		10	40
	80	KSD526	KSB596	.5	0.5	40	240	3	0.3	1.0	1.7	5	0.5	3		30
5	60	KSD73		10	1	70	240	5	0.5		2	10	0.3		20	30
	70	KSD362		5	5	20	140	5	0.5		1	5	0.5		10	40
	100	KSC2517		5	2	40	200	3	0.3		0.6					30
6	40	TIP41	TIP42	4	3	15	75	6	0.6		1.5	10	0.5	3		65
	60	TIP41A	TIP42A	4	3	15	75	6	0.6		1.5	10	0.5	3		65
	80	TIP41B	TIP42B	4	3	15	75	6	0.6		1.5	10	0.5	3		65
	100	TIP41C	TIP42C	4	3	15	75	6	0.6		1.5	10	0.5	3		65
	120	KSD363		5	1	40	240	1	0.1		1	5	0.5		10	40
7	60	KSD568	KSB707	1	3	40	200	5	0.5		0.5					40
	80	KSD569	KSB708	1	3	40	200	5	0.5		0.5					40
	100	KSC2334	KSA1010	5	3	40	200	5	0.5		0.6					40
	150	BU407						5	0.5		1	10	0.5	10		60
		BU407H						5	0.8		1	10	0.5	10		
	200	BU406						5	0.5		1	10	5	10		
		BU406H						5	0.8		1	10	5	10		60
		BU408						6	1.2		1	10	5	10		
10	60	MJE 3055T	MJE 2955T	4	4	20	100	4	0.4		1.1	10	0.5	2		75



2-2. Darlington Transistors

2.2.1 TO-126 Type Transistors

I _c (A)	V _{CEO} (V)	Device Type		h _{FE}			V _{CE(SAT)} (V)				f _T (MHz)			P _c (W)		
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _c (A)	MIN	TYP	
1.5	60	KSD985	KS8794	2	1	2K	3K	1A	0.001		1.5					10
	80	KSD986	KS8795	2	1	2K	3K	1A	0.001		1.5					10
3	60	KSD1693	KS81150	2	1.5	2K	20K	1.5	0.0015	0.9	1.2					15
	100	KSD1692	KS81149	2	1.5	2K	20K	1.5	0.0015	0.9	1.2					15
4	60	MJE800	MJE700	3	1.5	0.75K		1.5	0.03		2.5					40
		MJE801	MJE701	3	2	0.75K		2	0.04		2.8					
	80	MJE802	MJE702	3	1.5	0.75K		1.5	0.03		2.5					40
		MJE803	MJE703	3	2	0.75K		2	0.04		2.8					

2.2.2 TO-220 Type Transistors

I _c (A)	V _{CEO} (V)			h _{FE}			V _{CE(SAT)} (V)				f _T			P _c (W)		
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	V _{CE} (A)	I _c (A)	TYP	MAX	V _{CE} (V)	I _c (A)	MIN	TYP	
2	60	TIP110	TIP115	4	2	0.5K		2	0.008		2.5					50
	80	TIP111	TIP116	4	2	0.5K		2	0.008		2.5					50
	100	TIP112	TIP117	4	2	0.5K		2	0.008		2.5					50
5	60	TIP120	TIP125	3	3	1K		3	0.012		2					65
	80	TIP121	TIP126	3	3	1K		3	0.012		2					65
	100	TIP122	TIP127	3	3	1K		3	0.012		2					65
		KSD560	KS8601	2	3	2K	15K	3	0.003		1.5					30
8	60	TIP100	TIP105	4	3	1K	20K	3	0.006		2					80
	80	TIP101	TIP106	4	3	1K	20K	3	0.006		2					80
	100	TIP102	TIP107	4	3	1K	20K	3	0.006		2					80
	150	BU807						5	0.05		1.5					60
	200	BU806						5	0.05		1.5					60
10	60	TIP140T	TIP145T	4	5	1K		5	0.01		2					80
	80	TIP141T	TIP146T	4	5	1K		5	0.01		2					80
	100	TIP142T	TIP147T	4	5	1K		5	0.01		2					80



2.2.3 TO-3P & TO-3P(F) Type Transistors

I _c	V _{CEO}	h _{FE}				V _{CE(SAT)}				f _T				P _c	PKG		
		NPN	PNP	V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	V _{CE} (V)	I _c (A)	MIN	TYP		
10	60	TIP140F	TIP145F	4	5	1K		5	0.01		2					60	TO-3P(F)
		TIP140	TIP145	4	5	1K		5	0.01		2					125	TO-3P
80		TIP141F	TIP142F	4	5	1K		5	0.01		2					60	TO-3P(F)
		TIP141	TIP142	4	5	1K		5	0.01		2					125	TO-3P
100		TIP142F	TIP142F	4	5	1K		5	0.01		2					60	TO-3P(F)
		TIP142	TIP147	4	5	1K		5	0.01		2					125	TO-3P

2-3. Switching Transistors

V _{CEO} (V)	I _c (A)	Device (NPN)	h _{FE}				V _{CE(SAT)} (V)				Switching Time			P _c (W)	Package	Structure
			V _{CE} (V)	I _c (A)	MIN	MAX	I _c (A)	I _B (A)	TYP	MAX	t _{on} MAX (μS)	t _{sig} MAX (μS)	t _f MAX (μS)			
400	0.5	KSC2752	5	0.05	20	80	0.3	0.06		1	1	2.5	1	10	TO-126	
	2	KSC2333	5	0.1	20	80	0.5	0.1		1	1	2.5	1	15	TO-220	
	5	KSC2518	5	0.5	20	80	2	0.4		1	1	2.5	0.7	40	TO-220	
	7	KSC2335	5	1	20	80	3	0.6		1	1	2.5	1	40	TO-220	
	10	KSC2749	5	1	15	80	6	1.2		1	1	2.5	0.7	100	TO-3P	
	15	KSC2751	5	2	15	80	10	2	0.3	1	1	2.5	0.7	120	TO-3P	
500	3	KSC5020	5	0.3	15	50	1.5	0.3		1	0.5	3	0.3	40	TO-220	MBIT
	4	KSC5022	5	0.3	15	50	1.5	0.3		1	0.5	3	0.3	60	TO-3P	MBIT
	5	KSC5021	5	0.6	15	50	3	0.6		1	0.5	3	0.3	50	TO-220	MBIT
	7	KSC5023	5	0.6	15	50	3	0.6		1	0.5	3	0.3	80	TO-3P	MBIT
	10	KSC5024	5	0.8	15	50	4	0.8		1	0.5	3	0.3	90	TO-3P	MBIT
	15	KSC5025	5	1.2	15	50	6	1.2		1	0.5	3	0.3	100	TO-3P	MBIT
800	1.5	*KSC5026	5	0.1	10	40	0.75	0.15		2	0.5	3	0.3	40	TO-220	MBIT
	3	KSC5027	5	0.2	10	40	1.5	0.3		2	0.5	3	0.3	50	TO-220	MBIT
	*KSC5028	5	0.2	10	40	1.5	0.3		2	0.5	3	0.3	80	TO-3P	MBIT	
	4.5	*KSC5029	5	0.3	10	40	2	0.4		2	0.5	3	0.3	90	TO-3P	MBIT
	6	*KSC5030	5	0.4	10	40	3	0.6		2	0.5	3	0.3	100	TO-3P	MBIT
	8	*KSC5031	5	0.6	10	40	4	0.8		2	0.5	3	0.3	140	TO-3P	MBIT

*: Under Development.



2-4. Horizontal Deflection Output Transistors

2.4.1 TO-3P Type Transistors

V _{CEO} (V)	V _{CEO} (V)	I _c (A)	Device (NPN)	h _{FE}				V _{CE(SAT)} (V)				Switching Time			P _c (W)	Comment	
				V _{ce} (V)	I _c (A)	MIN	MAX	I _c (A)	I _b (A)	TYP	MAX	t _{on} MAX (μS)	t _{stg} MAX (μS)	t _f MAX (μS)			
1500	800	2.5	KSD5000	5	0.5	8		2	0.6		8				0.4	80	Built in Damper Diode
		3.5	KSD5001	5	0.5	8		2.5	0.8		8				0.4	80	Built in Damper Diode
		5	KSD5002	5	1	8		4	0.8		5				0.4	120	Built in Damper Diode
		6	KSD5003	5	1	8		5	1		5				0.4	120	Built in Damper Diode
		2.5	KSD5004	5	0.5	8		2	0.6		8				0.4	80	
		3.5	KSD5005	5	0.5	8		2.5	0.8		8				0.4	80	
		5	KSD5006	5	1	8		4	0.8		5				0.4	120	
		6	KSD5007	5	1	8		5	1		5				0.4	120	

2.4.2 TO-3P(F) Type Transistors

V _{CEO} (V)	V _{CEO} (V)	I _c (A)	Device (NPN)	h _{FE}				V _{CE(SAT)} (V)				Switching Time			P _c (W)	Comment	
				V _{ce} (V)	I _c (A)	MIN	MAX	I _c (A)	I _b (A)	TYP	MAX	t _{on} MAX (μS)	t _{stg} MAX (μS)	t _f MAX (μS)			
1500	800	2.5	KSD5010	5	0.5	8		2	0.6		8				0.4	50	Built in Damper Diode
		3.5	KSD5011	5	0.5	8		2.5	0.8		8				0.4	50	Built in Damper Diode
		5	KSD5012	5	1	8		4	0.8		5				0.4	60	Built in Damper Diode
		6	KSD5013	5	1	8		5	1		5				0.4	60	Built in Damper Diode
		2.5	KSD5014	5	0.5	8		2	0.6		8				0.4	50	
		3.5	KSD5015	5	0.5	8		2.5	0.8		8				0.4	50	
		5	KSD5016	5	1	8		4	0.8		5				0.4	60	
		6	KSD5017	5	1	8		5	1		5				0.4	60	



3. QUICK REFERENCE TABLE (APPLICATION)

3.1 Audio Equipment

Application \ Package	SOT-23	TO-92	TO-92L	TO-126	TO-220
FM	RM AMP Mix, Conv Local Osc IF	KSC2223 KSC2223 KSC2223 KSC2715	KSC1674 KSC1674 KSC1674,KSC1675 KSC838,KSC1675		
AM	RF, Conv Osc	KSC1623 KSC2715	KSC945,KSC815 KSC1675,KSC945 KSC838 KSC1675,KSC945 KSC838		
Diff Amp	10W 20W 25W 30W 35W 40W 50W 60W 80W 100W 150W	KSA812,KSC1623 KSA812,KSC1623 KSA812,KSC1623 KSA812,KSC1623 KSA812,KSC1623 KSA992,KSC1845 KSA992,KSC1845 KSA991,KSC1845 KSA992,KSC1845 KSA992,KSC1845 KSA992,KSC1845	KSA733,KSC945 KSA733,KSC945 KSA733,KSC945 KSA733,KSC945 KSA733,KSC945 KSA992,KSC1845 KSA992,KSC1845 KSA991,KSC1845 KSA992,KSC1845 KSA992,KSC1845 KSA992,KSC1845		
Pre Driver	20W 25W 30W 35W 40W 50W 60W 80W 100W 150W 20W		KSA954,KSC2003 KSA954,KSC2003	KSA910,KSC2310 KSA910,KSC2310 KSA910,KSC2310 KSA910,KSC2310 KSA910,KSC2310 KSA910,KSC2310 KSA910,KSC2310 KSA910,KSC2310 KSA1142,KSC2682 KSA1142,KSC2682 KSA1142,KSC2682	
Driver	3W 5W 10W 20W 25W 30W 40W 50W 60W 80W		KSA642,KSD227 KSA642,KSD227 KSA954,KSC2003 KSA954,KSC2003 KSA954,KSC2003 KSA954,KSC2003	KSA916,KSC2316 KSA916,KSC2316	KSA1220,KSC2690 KSA1220,KSC2690 KSA1220A,KSC2690A
Output	3W 5W 10W 20W 25W 30W 35W		KSA928A,KSC2328A	KSB772,KSD882 KSB744,KSD794	KSB834,KSD880 KSA614,KSD288 KSB596,KSD526 TIP41C,TIP42C TIP41C,TIP42C



3.2 Video Equipment

Application		Package	Color TV	B/W TV
Tuner	VHF	RF SOT-23	KSC2755	KSC2755
		TO-92		KSC1393
	MIX	SOT-23	KSC2756	KSC2756
		TO-92	KSC1393,MPSH24	KSC1394,MPSH24
	UHF	SOT-23	KSC2757,KSC2759,MMBR5179	KSC2757,KSC2759,MMBR5179
		TO-92	KSC1730,MPS5179,MPSH10	KSC1730,MPS5179,MPSH10
		RF DISK	KSC1070	KSC1070
		SOT-23	KSC2758	KSC2758
		MIX DISK	KSC1070	KSC1070
	UHF	SOT-23	KSC2758	KSC2758
		SOT-23	KSC2757,KSC2759,MMBR5179	KSC2757,KSC2759,MMBR5179
		TO-92	KSC1730,MPS5179,MPSH10	KSC1730,MPS5179,MPSH10
Video Chroma	Output	TO-92	KSA643,KSA733	KSA733,KSC945
		TO-92L	KSC2330,KSC2340	KSC2330,KSC2340
		TO-202	KSC1520A	KSC1520A
		TO-126	KSC2688	
		TO-220	KSC1257	KSC1507
Vertical Deflection	OSC	TO-92		KSC945,KSA733
	Driver	TO-92		KSA642,KSA643,KSD227,KSD261
		TO-92L	KSC2310,KSA910	
	Output	TO-220	KSB546,KSD401,KSA940,KSC2073	KSD880,KSD288,KSA614,KSB834
		TO-126	KSA1220A,KSC2690A	KSA1220A,KSC2690A,KSB772,KSD882
		TO-202		KSC1096,KSA634
		TO-92L		KSC2328,KSA928A
Sound	Output	TO-126	KSA1220A,KSC2690A	
		TO-220	KSB546,KSD401,KSA940,KSC2073	
		TO-202		
		TO-92L	KSC2383,KSA1013	KSC2328A,KSA928A
		TO-92		KSD261,KSB564,KSB1116,KSA643,KSD471,KSD1616
AGC		TO-92	KSC945,KSA733	KSC945,KSA733
Sync Separator		TO-92	KSC945,KSA733	KSC945,KSA733
Horizontal Deflection	OSC	TO-92	KSC945,KSA733	KSC945,KSA733
	Driver	TO-92		
		TO-92L	KSC2330,KSC2316,KSA916	
	Output	TO-3P	KSD5000,KSD5001,KSD5002,KSD5003	KSD5004,KSD5005,KSD5006,KSD5007
		TO-220		KSD362,KSD73
Series Regulator	Error Amp	TO-92		KSA733,KSC945
		TO-92L	KSC2310,KSA910	
	Driver	TO-92		KSA733,KSC945
		TO-92L	KSC2310,KSA910	
	Output	TO-220	KSD560	KSD288,KSD880,KSB834,KSA614
		TO-126		KSB772,KSD882
		TO-202		KSC1096,KSA634
Switching	Driver	TO-92	KSD471A,KSB564A,KSD261,KSA643	KSD471A,KSB564A,KSD261,KSA643
Regulator	Output	TO-3P	KSD5007	KSD5007



SOT-23 TYPE

I_C V_{CEO}	20mA	30mA	50mA	0.1A	0.2A	0.3A	0.5A	0.6A	0.8A	10mA
12V			MMBR5179							
14V			KSC2734 KSC2759							
15V			KSC3120 KSC2757							
20V	KSC2223	KSC2756		BCW29-33						(2mA) KSK123
25V	KSC2758		KSC3125 MMBT5089 MMBC1009F1-5	MMBTH10	MMBTA4124 MMBTA4126				KSA1298 KSC3265	
30V	KSC2755		KSC2715 MMBT5088	MMBTH24	MMBTA4123 MMBTA4125	MMBTA13 MMBTA14	KSA1182 KSC2859 MMBTA63 MMBTA64	MMBT2222		
32V				BCW60A-D BCW61A-D						
35V				MMBC1622D6-8						
40V				MMBA812M3-7 MMBC1623L3-7 MMBT420 MMBT470 KSR1109-12 KSR2109-12	MMBT3903 MMBT3904 MMBT3906		MMBT6427	MMBT2222A MMBT2907 MMBT4401 MMBT4403		
45V			MMBA811C5-8	BCW69-72 BCW70G-K BCW71G-K	MMBT6429					
50V			MMBT5086 MMBT5087	KSA812 KSC1623 KSR1101-8 KSR2101-8 KSR1113/4 KSR2113/4	MMBT6428					
60V			MMBT2484				MMBTA05 MMBTA55	MMBT2907A		
80V							MMBTA06 MMBTA56			
140V								MMBT5550		
150V							MMBT5401			
200V							MMBTA43 MMBTA93			
300V							MMBTA42 MMBTA92			



TO-92S, TO-92 & TO-92L TYPE (V_{CEO}: 12V~60V)

V _{CEO} I _c	12V	15V	20V	25V	30V	35V	40V	45V	50V	60V
20mA	KSK65 (2mA)	KSC1395	KSK161(10mA) KSK211(10mA) KSC1674 KSC2786	KSC1070	KSC1393 KSC1394				KSK117 (10mA) KSK30 (10mA)	
25mA			SS9016							
30mA			KSC1187 KSC1188		SS9011 KSC838 KSC2669					
50mA	MPS5179	KSC1730 SS9018		KSA542 KSC184 KSC2787 KSC388 KSC900 2N5089	2N5088 KSC1675			KSA640 KSC1222	2N5086 2N5087 2N5209 2N5210	
0.1A		MPSH17		MPS5172 MPS6520 MPS6521 MPS6522 MPS6523 MPSH10 MPSH11	KSC839 KSC921 MPSH20 MPSH24		KSC1330 MPS6513 MPS6517 MPSA10 MPSA20 MPSA70 KSR1009-12 KSR2009-12 KSR1209-12 KSR2209-12	SS9014 SS9015	KSR1201-8 KSR1213/4 KSR2201-8 KSR2213/4 KSR1001-8 KSR2001-8 KSR1013/4 KSR2013/4	
0.15A							MPS4250		KSA1175 KSC2785 KSA733 KSC945	MPS4250A MPS4249
0.2A				2N4124 2N4126	2N4123 2N4125		2N3903 2N3904 2N3905 2N3906 MPS8097	KSA539 KSC815	2N6428 2N6428A	KSA545 KSC853
0.3A				KSC3488 KSA1378 KSA642 KSD227						KSA953 KSC2002
0.5A			MPSA12 MPSA62 KSA643 KSD261 SS9012 SS9013 KSA1150 KSC2710	MPS6560 MPS6562	MPSA13 MPSA14 MPSA63 MPSA64		2N6427 MPSA25 MPSA75		MPSA26 MPSA76	MPS8098 MPS8598 MPSA05 MPSA55 MPSA27 MPSA77
0.6A			MPS3706	MPS3702	MPS2222 MPS3703 MPS3704 MPS3705		2N4400 2N4401 2N4402 2N4403 MPS2222A MPS2907			MPS2907A
0.7A				KSB810 KSB811				KSA707 KSC1072		KSA708 KSC1008 KSA931 KSC2331



TO-92S, TO-92 & TO-92L TYPE (Continued)

$\frac{V_{CEO}}{I_c}$	12V	15V	20V	25V	30V	35V	40V	45V	50V	60V
0.8A										
1A				KSB564A KSB811 MPS6601 MPS6651	KSD1021 KSD471A		MPS6602		KSB1116 KSD1616	KSB116A KSD1616A
1.5A				SS8050 SS8550						
2A	(10V) KSC2500				KSA928A KSC2328A					

TO-92S, TO-92 & TO-92L Type (V_{CEO} : 80V~400V)

$\frac{V_{CEO}}{I_c}$	80V	100V	120V	140V	150V	160V	200V	250V	300V	350V	400V
20mA											
25mA											
30mA											
50mA			KSA992 KSC1845 KSA1174 KSC2874		KSA910 KSC2310						
0.1mA									KSC1506 KSC2330	KSC2340	
0.15A			MPSL01								
0.2A											
0.3A	KSA954 KSC2003								MPSA45	MPSA44	
0.5A	MPS8099 MPS8599 MPSA06 MPSA56						MPSA43 MPSA93	2N6515 2N6518	2N6519 MPSA92 2N6516 MPSA42	2N6517 2N6520	
0.6A		MPSL51	2N5400	2N5550	2N5401	2N5551					



TO-92S, TO-92 & TO-92L Type (continued)

$\frac{V_{CEO}}{I_c}$	80V	100V	120V	140V	150V	160V	200V	250V	300V	350V	400V
0.7A				KSC1009	KSA709						
0.8A			KSA916 KSC2316								
1A						KSA1013 KSC2383					
1.5A											
2A											

TO-126 & TO-202 TYPE (V_{CEO} : 25V~400V)

$\frac{V_{CEO}}{I_c}$	25V	30V	40V	45V	60V	80V	100V	120V	160V	180V	250V	300V	400V
0.1A										KSC2682 KSA1142			
0.2A										KSC1520 KSC2688 KSC1520A			
0.5A										MJE340 MJE350	KSC2752		
1.2A								KSC2690 KSA1220	KSC2690A KSA1220A				
1.5A					KSD985 KSB794	KSD986 KSB795							
2A		KSC1096 KSA634		KSC1098 KSA636									
3A	KSD682 KSB772	MJE170 MJE180	KSD794 KSB744	KSD794A KSB744A	MJE172 MJE182	KSD1692 KSB1149							
4A				MJE700 MJE701 MJE800 MJE801	MJE702 MJE703 MJE802 MJE803								
5A	MJE200 MJE210			KSD1691 KSB1151									



TO-220 TYPE

I_c V_{CEO}	30V	40V	55V	60V	70V	80V	100V	120V	150V	200V	250V	300V	350V	400V	500V	800V
0.2												KSC1507				
1	TIP29 TIP30		TIP29A TIP30A		TIP29B TIP30B	TIP29C TIP30C				TIP47	TIP48	TIP49	TIP50			
1.5									KSC2073 KSA940							*KSC5026
2A			TIP110 TIP115		TIP111 TIP116	TIP112 TIP117		KSD401 KSB546				KSC2333				
3A	KSC1173 KSA473	TIP31	KSD288 KSA614	TIP31A TIP32A KSD880 KSB884 KSC1983		TIP31B TIP32B	TIP31C TIP32C							KSC5020	*KSC5027	
4A				KSC2233		KSD526 KSB596										
5A				KSD73 TIP120 TIP125	KSD362	TIP121 TIP126	KSC2517 TIP122 TIP127 KSB601 KSD560						KSC2518	*KSC5021		
6	TIP41 TIP42		TIP41A TIP42A		TIP41B TIP42B	TIP41C TIP42C	KSD363					KSC2335				
7				KSD568 KSB707		KSD569 KSB708	KSC2334 KSA1010		BU407 BU407H	BU406 BU406H BU408						
8				TIP100 TIP105		TIP101 TIP106	TIP102 TIP107		BU807	BU806						
10				MJE3055T MJE2955T TIP140T TIP145T		TIP141T TIP146T	TIP142T TIP147T									

TO-3P & TO-3P(F) TYPE

I_c V_{CEO}	2.5A	3A	3.5A	4A	4.5A	5A	6A	7A	8A	10A	15A
400										KSC2749	KSC2751
500				*KSC5022				*KSC5023		*KSC5024	*KSC5025
800	KSD5000 KSD5004 KSD5010 KSD5014	*KSC5028	KSD5000 KSD5005 KSD5011 KSD5012		*KSC5029	KSD5002 KSD5006 KSD5012 KSD5018	*KSC5030 KSD5003 KSD5007 KSD5013 KSD5017		*KSC5031		

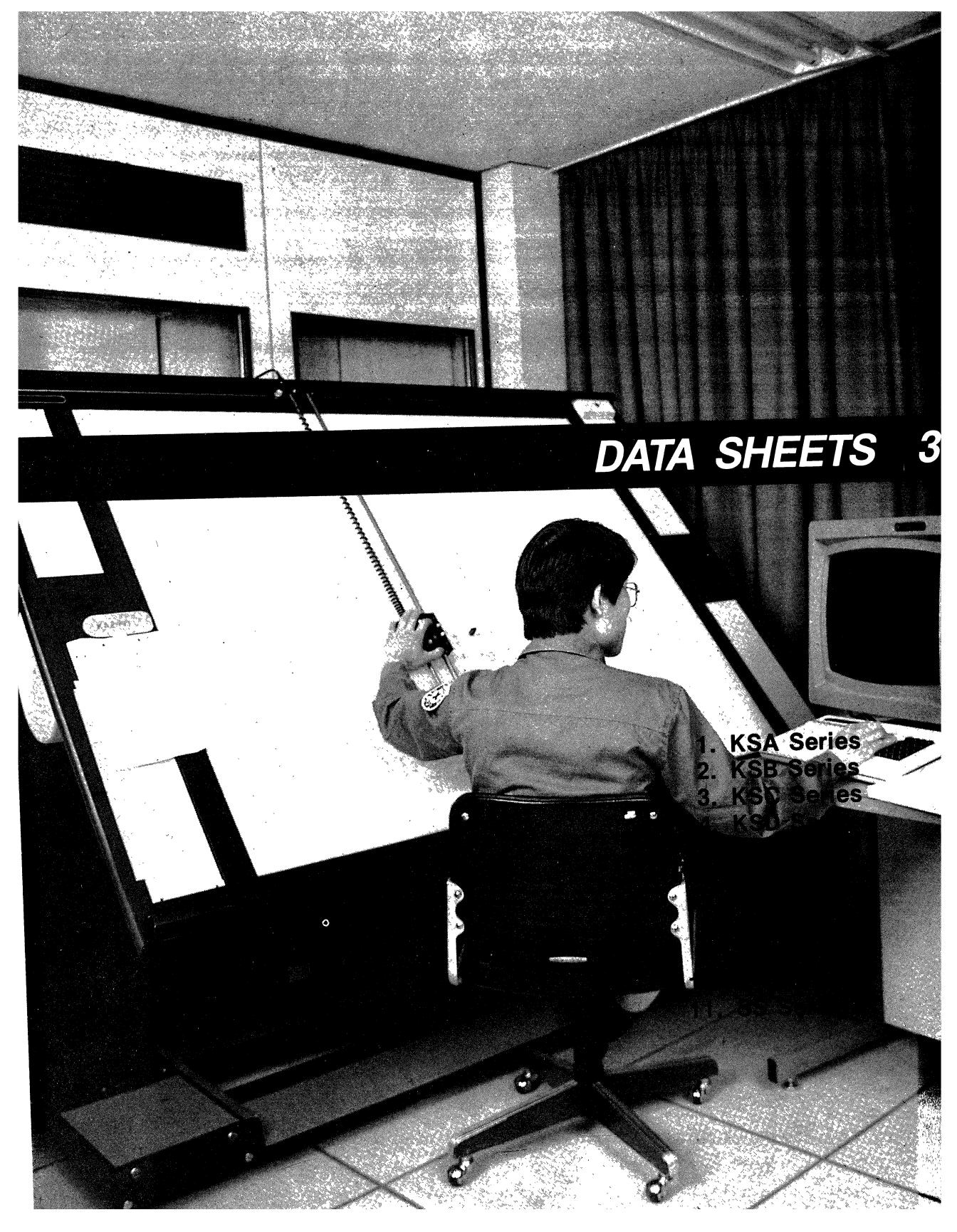
* Under Development

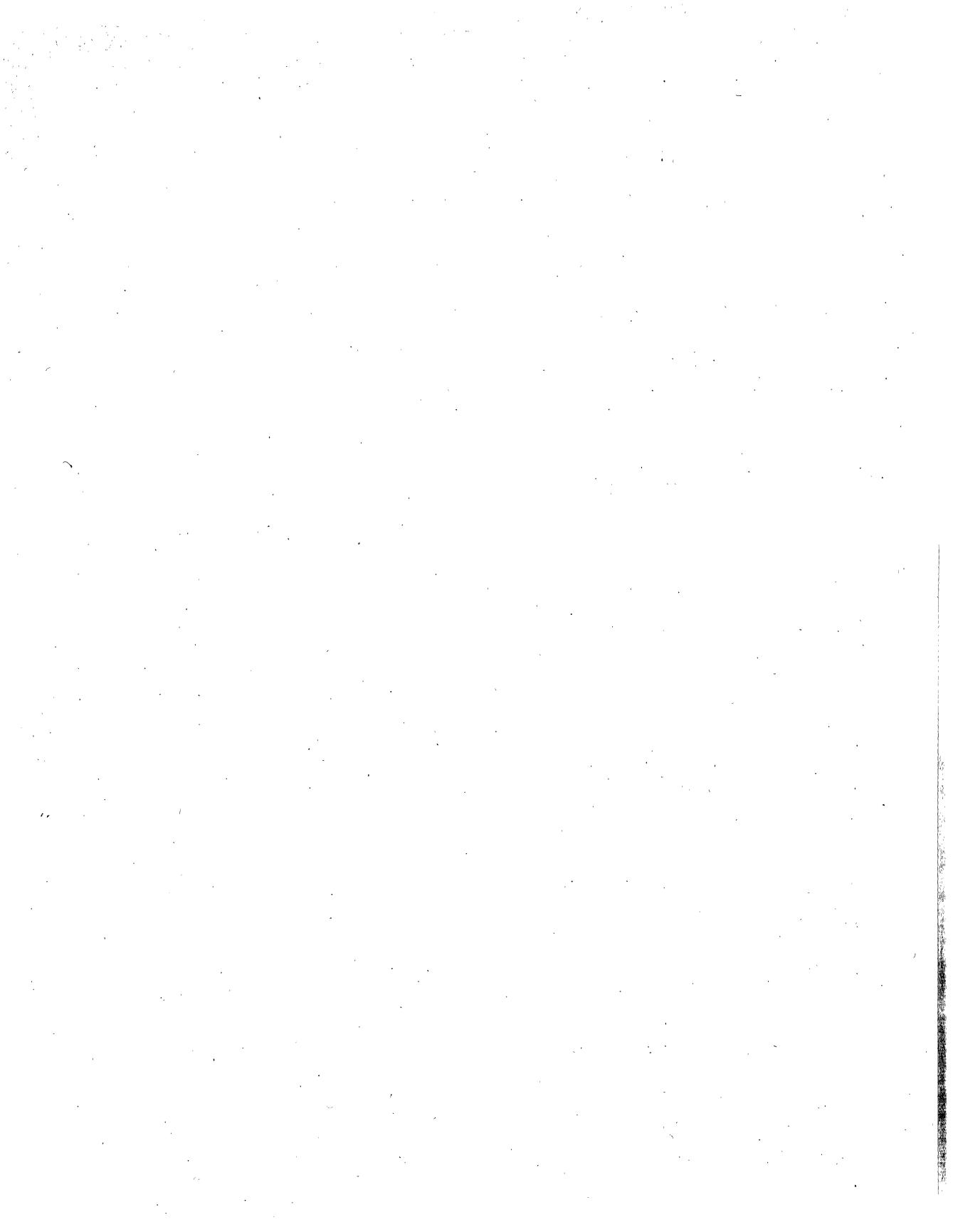


NOTES

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DATA SHEETS 3

- 
- A black and white photograph showing a man from behind, working on a large industrial machine. He is wearing a dark shirt and glasses. The machine has a prominent vertical metal frame and a horizontal beam. In the background, there is a computer monitor on a desk and some vertical blinds covering a window.
1. KSA Series
 2. KSB Series
 3. KSD Series
 4. KSD

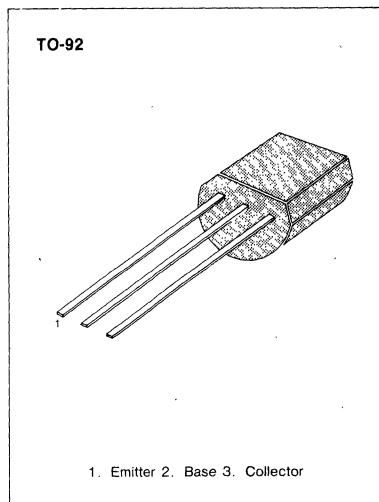


LOW FREQUENCY AMPLIFIER

- Complement to KSC815
- Collector-Base Voltage $V_{CBO} = -60V$
- Collector Dissipation $P_c = 400mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 60	V
Collector-Emitter Voltage	V_{CEO}	- 45	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current	I_C	- 200	mA
Collector Dissipation	P_c	400	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	- 55 ~ 150	$^\circ C$



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

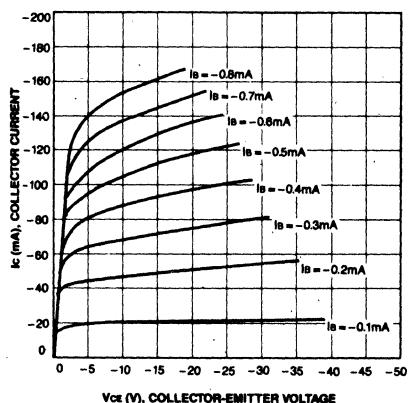
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	- 60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	- 45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	- 5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -45V, I_E = 0$			- 100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3V, I_C = 0$			- 100	nA
DC Current Gain	h_{FE}	$V_{CE} = -1V, I_C = -50mA$	40		240	
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$V_{CE} = -1V, I_C = -10mA$	- 0.60	- 0.65	- 0.90	V
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = -150mA, I_B = -15mA$		- 0.25	- 0.5	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = -150mA, I_B = -15mA$		- 0.9	- 1.2	V

 h_{FE} CLASSIFICATION

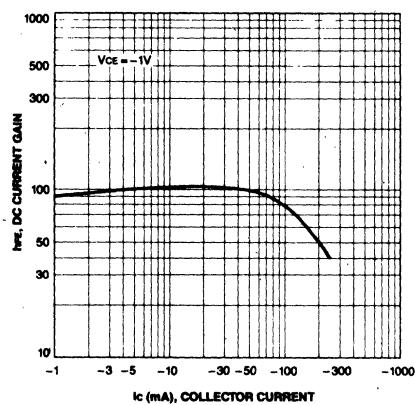
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



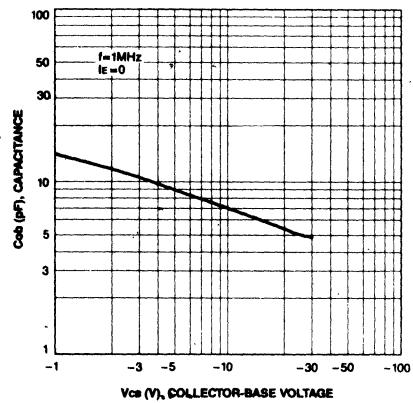
STATIC CHARACTERISTIC



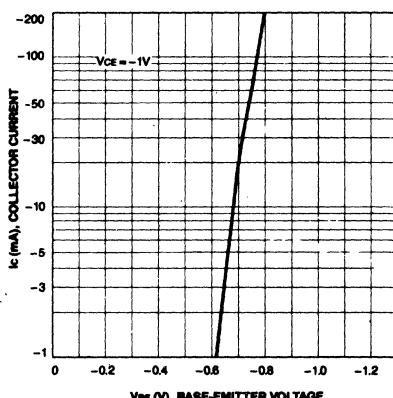
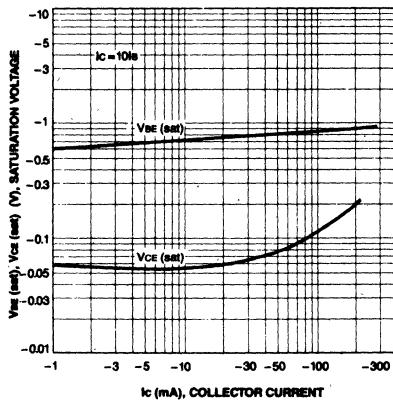
DC CURRENT GAIN



COLLECTOR OUTPUT CAPACITANCE



BASE-EMITTER ON VOLTAGE

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

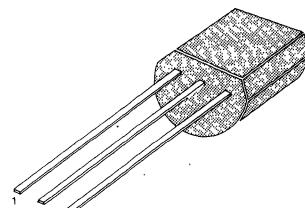
LOW FREQUENCY AMPLIFIER

- Collector-Base Voltage $V_{CBO} = -30V$
- Low Collector-Emitter Saturation Voltage $V_{CE}(\text{sat}) = -0.15V$ (TYP)
- Complement to KSC184

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

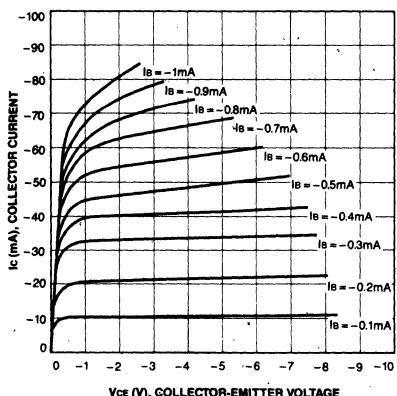
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_E = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -25V, I_E = 0$			-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3V, I_C = 0$			-100	nA
DC Current Gain	h_{FE}	$V_{CE} = -6V, I_C = -1\text{mA}$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -20\text{mA}, I_B = -2\text{mA}$		-0.15	-0.3	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -6V, I_C = -1\text{mA}$		-0.65	-1.0	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_C = -1\text{mA}$			100	MHz
Output Capacitance	C_{ob}	$V_{CB} = -6V, I_E = 0$			2.5	pF
		$f = 1\text{MHz}$				

 h_{FE} CLASSIFICATION

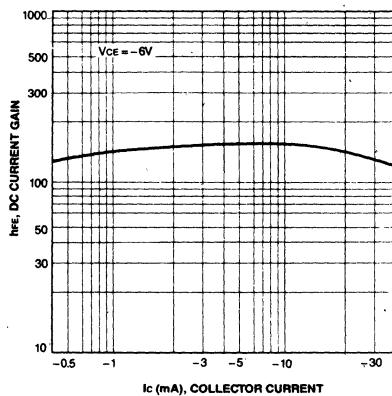
Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400



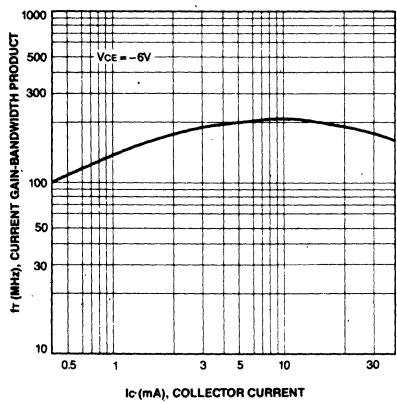
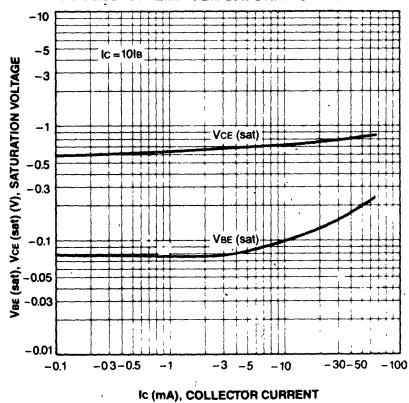
STATIC CHARACTERISTIC



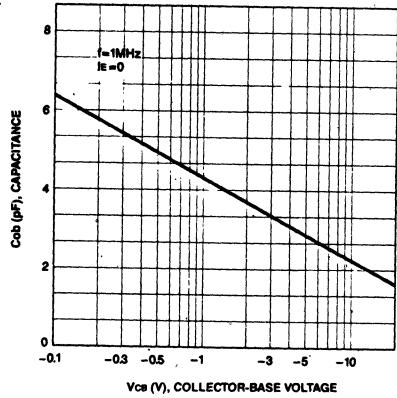
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



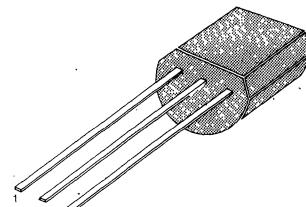
LOW FREQUENCY AMPLIFIER

- Complement to KSC853
- Collector-Base Voltage $V_{CBO} = -70V$
- Collector Dissipation $P_C = 400mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 70	V
Collector-Emitter Voltage	V_{CEO}	- 60	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current	I_C	- 200	mA
Collector Dissipation	P_C	400	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1 Emitter 2. Base 3 Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

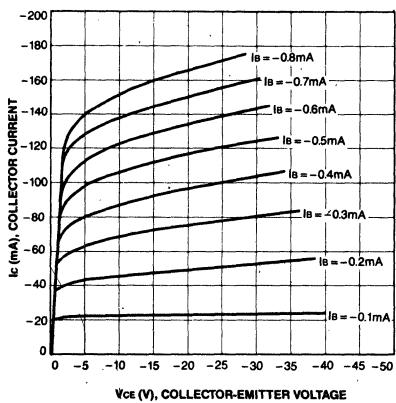
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	- 70			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	- 60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	- 5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -45V, I_E = 0$			- 100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3V, I_C = 0$			- 100	nA
DC Current Gain	h_{FE}	$V_{CE} = -1V, I_C = -50mA$	40		400	
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$V_{CE} = -1V, I_C = -10mA$	- 0.60	- 0.65	- 0.90	V
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = -150mA, I_B = -15mA$		- 0.25	- 0.5	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = -150mA, I_E = -15mA$		- 0.9	- 1.2	V

 h_{FE} CLASSIFICATION

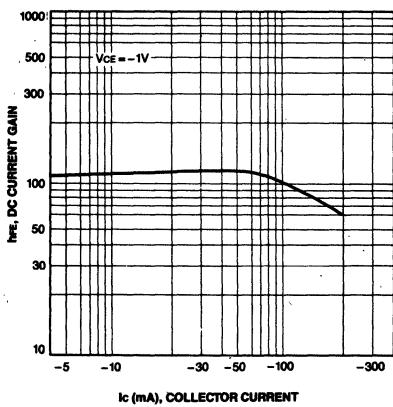
Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400



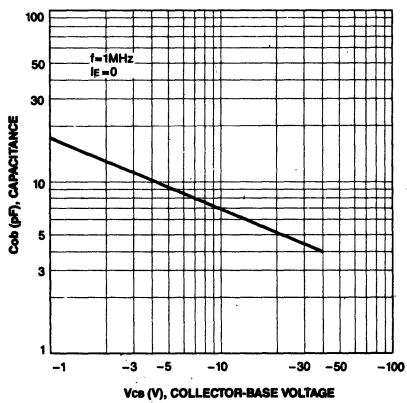
STATIC CHARACTERISTIC



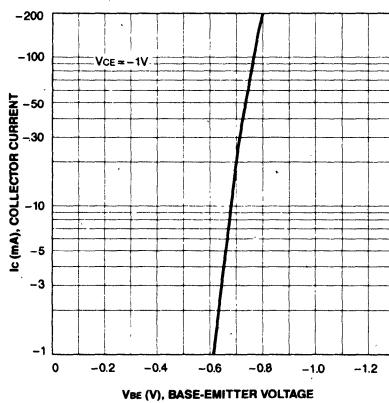
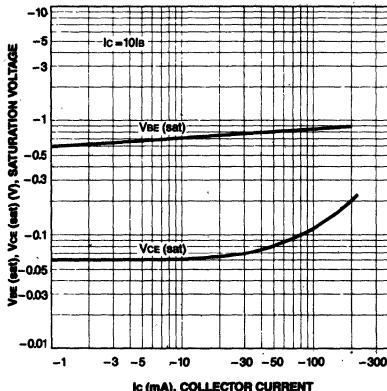
DC CURRENT GAIN



COLLECTOR OUTPUT CAPACITANCE



BASE-EMITTER ON VOLTAGE

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

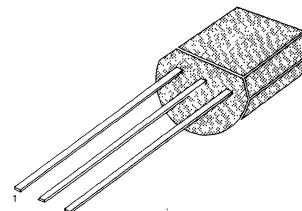
LOW FREQUENCY LOW NOISE AMPLIFIER

- Complement to KSC1222
- Collector-Base Voltage $V_{CBO} = -50V$
- Low Noise Level $NL = 40mV$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-45	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

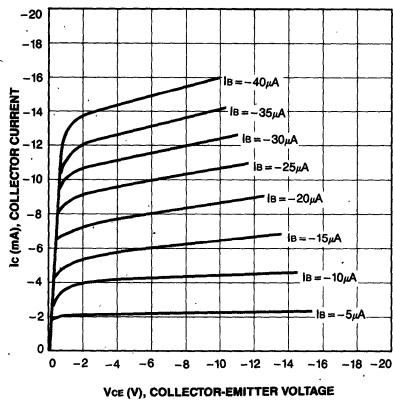
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			-0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3V, I_C = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -3V, I_C = -0.5mA$	120		1000	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -20mA, I_B = -2mA$		-0.2	-0.3	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$V_{CE} = -3V, I_C = -0.5mA$		-0.63	-0.70	V
Collector Gain-Bandwidth Product	f_T	$V_{CE} = -3V, I_C = -1mA$		100		MHz
Output Capacitance	C_{OB}	$V_{CB} = -6V, I_E = 0, f = 1MHz$		3.0		pF
Noise Level	NL	$V_{CC} = -20V, I_C = -0.1mA$ $R_S = 25K\Omega, f = 1KHz$ $A_V = 80dB$		27	40	mV

 h_{FE} CLASSIFICATION

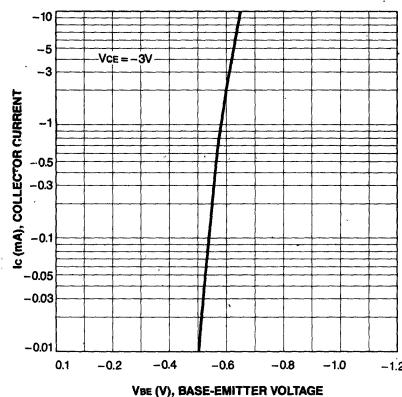
Classification	Y	G	L	V
h_{FE}	120-240	200-400	350-700	600-1000



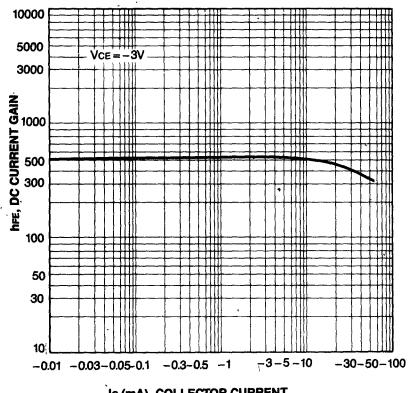
STATIC CHARACTERISTIC



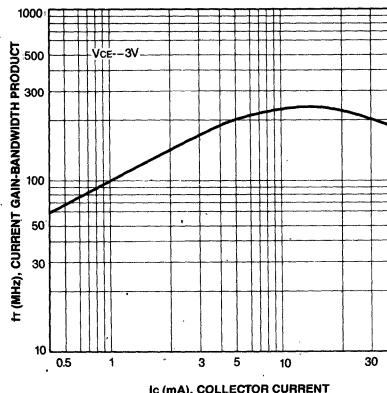
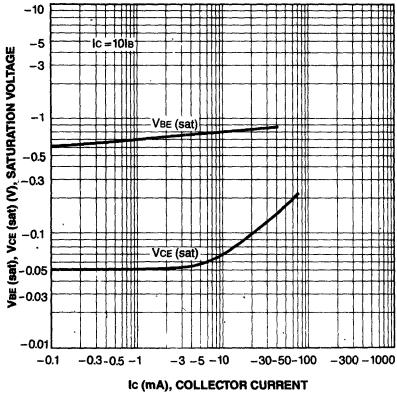
BASE-EMITTER ON VOLTAGE



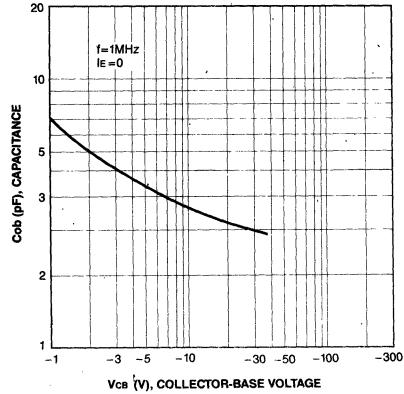
DC CURRENT GAIN



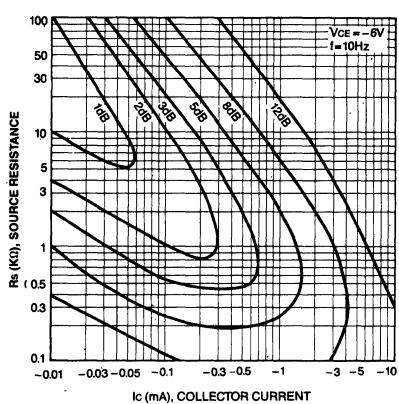
CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

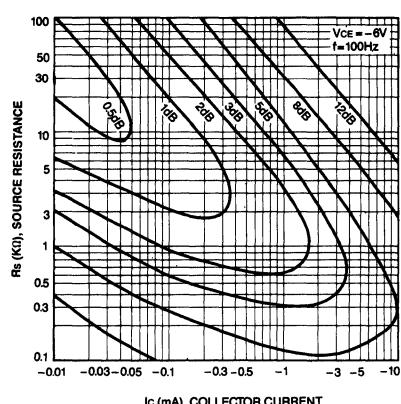
COLLECTOR OUTPUT CAPACITANCE



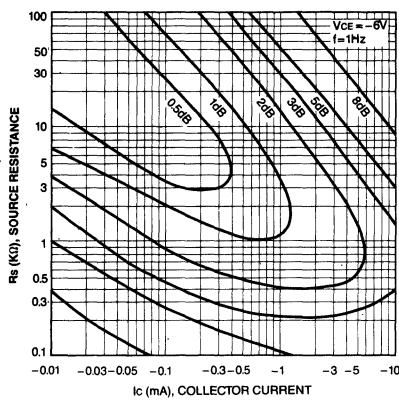
NOISE FIGURE



NOISE FIGURE



NOISE FIGURE



LOW FREQUENCY POWER AMPLIFIER

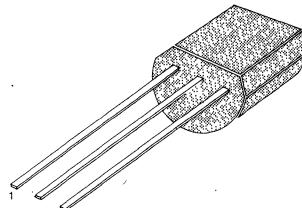
- Complement to KSD227
- Collector Dissipation $P_C = 400\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current (DC)	I_C (DC)	-300	mA
Collector Current (pulse)	I_C (pulse)*	-500	mA
Collector Dissipation	P_C	400	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

* PW ≤ 10ms, duty cycle ≤ 50%

TO-92



1 Emitter 2 Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -25\text{V}, I_E = 0$			-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3\text{V}, I_C = 0$			-100	nA
DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}, I_C = -50\text{mA}^*$	70		400	nA
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -300\text{mA}, I_B = -30\text{mA}^*$		-0.35	-0.6	V

* Pulse Test: PW ≤ 350μs, duty cycle ≤ 2%

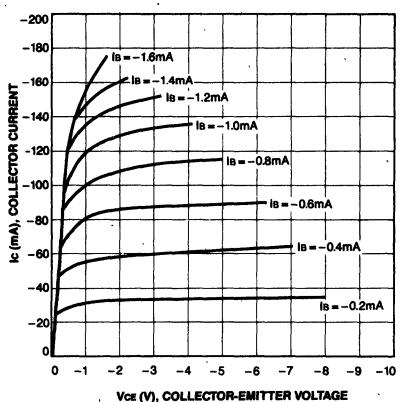
 h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

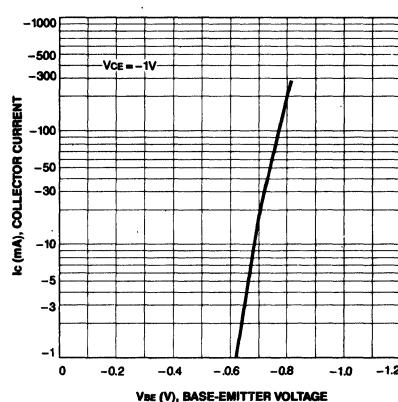


SAMSUNG SEMICONDUCTOR

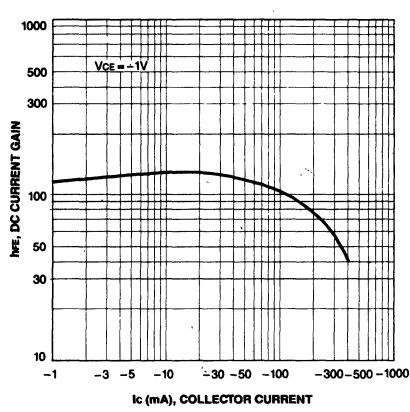
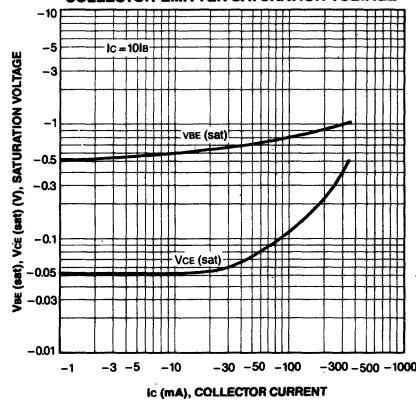
STATIC CHARACTERISTIC



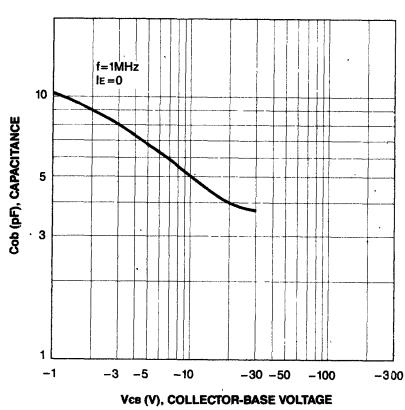
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



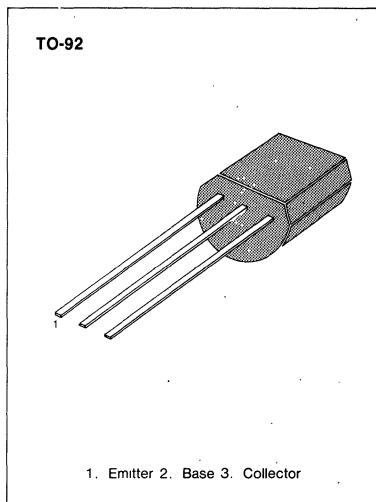
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSD261
- Collector Dissipation $P_c = 500\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-20	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current (DC)	I_c (DC)	-500	mA
Collector Current (pulse)*	I_c (pulse)*	-700	mA
Collector Dissipation	P_c	500	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* PW ≤ 10mS, duty Cycle ≤ 50%.

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = -100\mu\text{A}, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = -10\text{mA}, I_B = 0$	-20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -25\text{V}, I_E = 0$			-200	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3\text{V}, I_C = 0$			-200	nA
DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}, I_c = -100\text{mA}^*$	40		400	nA
Collector-Emitter Saturation Voltage	V_{CE} (sat)	$I_c = -500\text{mA}, I_B = -50\text{mA}^*$		-0.3	-0.4	V
Base-Emitter Saturation Voltage	V_{BE} (sat)	$I_c = -500\text{mA}, I_B = -50\text{mA}^*$		-1.0	-1.3	V

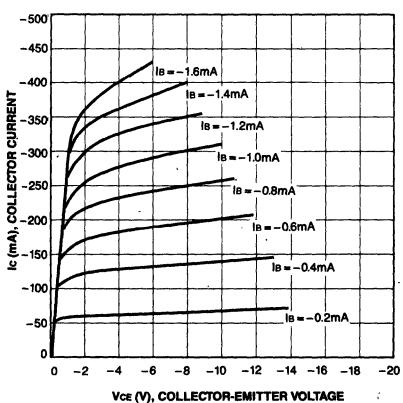
* Pulse Test: PW = 350 μs , duty cycle = 2%

 h_{FE} CLASSIFICATION

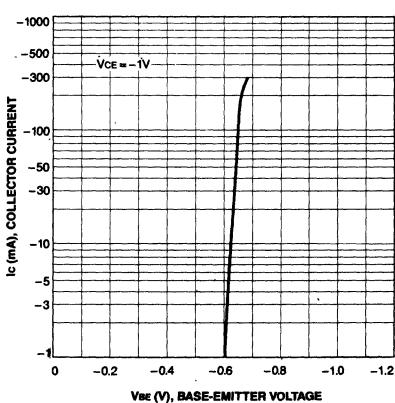
Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400



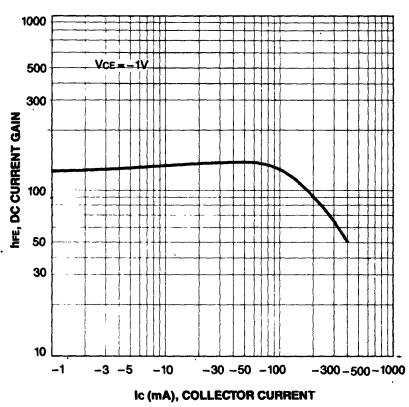
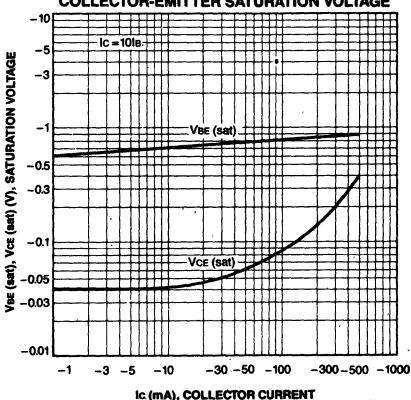
STATIC CHARACTERISTIC



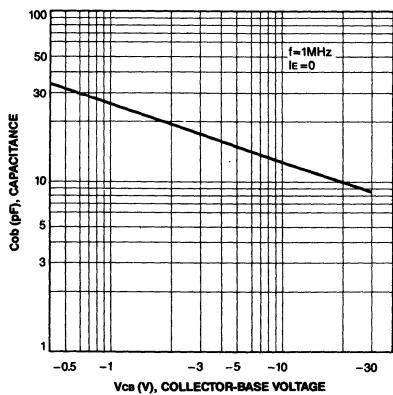
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



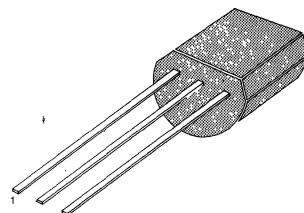
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSC1072
- Collector-Base Voltage $V_{CBO} = -60V$
- Collector Dissipation $P_c = 800mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 60	V
Collector-Emitter Voltage	V_{CEO}	- 45	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current	I_C	- 700	mA
Collector Dissipation	P_c	800	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

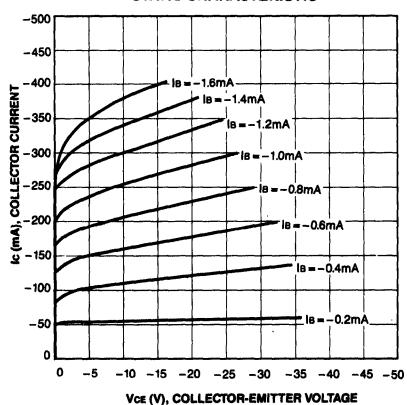
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	- 60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	- 45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	- 5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -40V, I_E = 0$			- 0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3V, I_C = 0$			- 0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -2V, I_C = -50mA^*$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -500mA, I_B = -50mA^*$		- 0.3	- 0.7	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -500mA, I_E = -50mA^*$	- 0.7	- 0.9	- 1.1	V
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		13		pF

* Pulse Test: PW $\leq 350\mu s$, duty cycle $\leq 2\%$ h_{FE} CLASSIFICATION

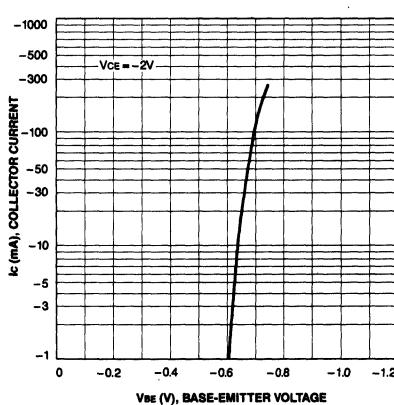
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



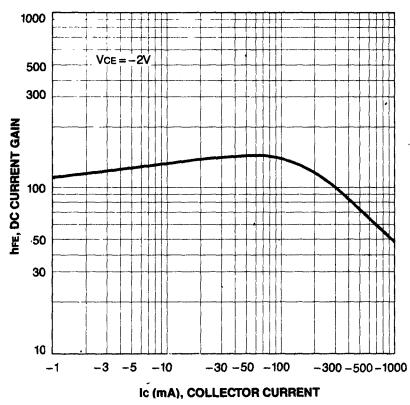
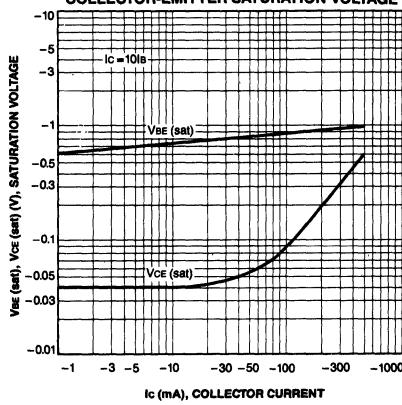
STATIC CHARACTERISTIC



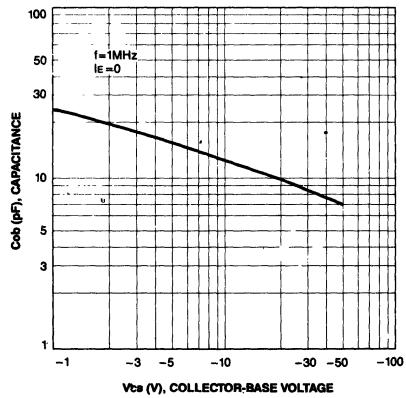
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE

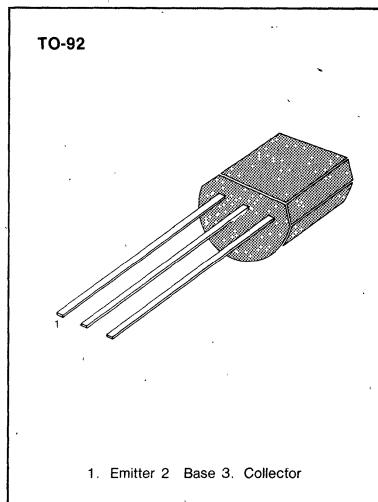


LOW FREQUENCY AMPLIFIER**MEDIUM SPEED SWITCHING**

- Complement to KSC1008
- Collector-Base Voltage $V_{CBO} = -80V$
- Collector Dissipation $P_c = 800mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 80	V
Collector-Emitter Voltage	V_{CEO}	- 60	V
Emitter-Base Voltage	V_{EBO}	- 8	V
Collector Current	I_c	- 700	mA
Collector Dissipation	P_c	800	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	- 55 ~ 150	$^\circ C$

**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)**

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = -100\mu A, I_E = 0$	- 80			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = -10mA, I_B = 0$	- 60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	- 8			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60V, I_E = 0$			- 0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			- 0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -2V, I_c = -50mA^*$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_c = -500mA, I_B = 50mA^*$		- 0.3	- 0.7	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_c = -500mA, I_C = -50mA$		- 0.9	1.1	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_c = -50mA$		50		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		13		pF

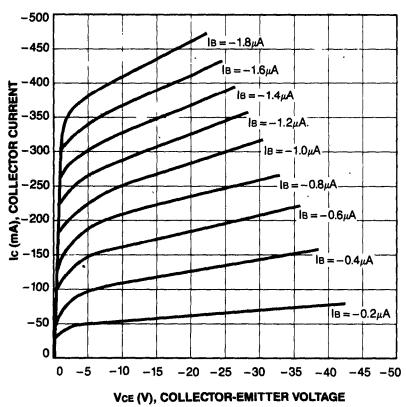
* Pulse Test: $PW \leq 350\mu s$, duty cycle $\leq 2\%$

 h_{FE} CLASSIFICATION

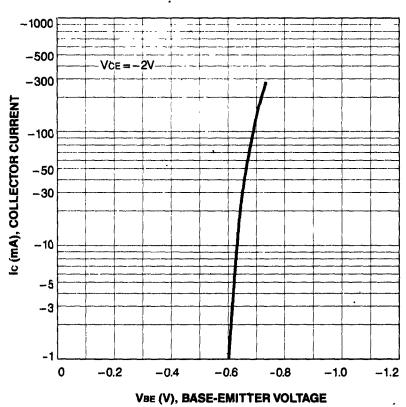
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



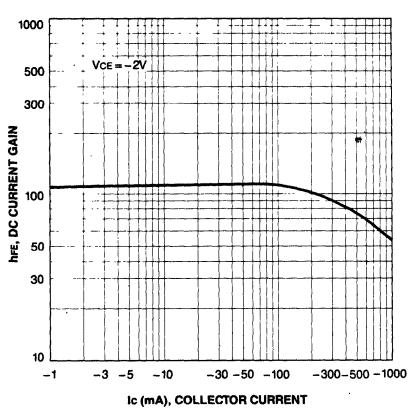
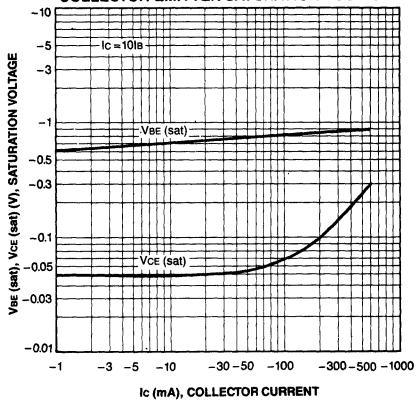
STATIC CHARACTERISTIC



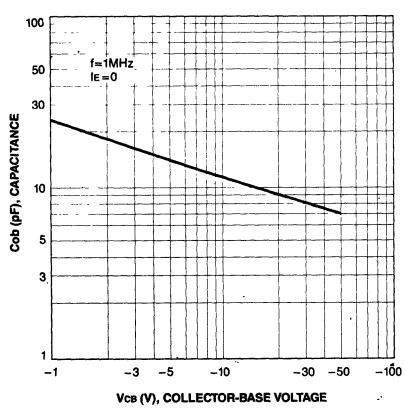
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



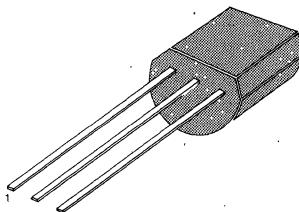
HIGH VOLTAGE AMPLIFIER

- Collector-Base Voltage $V_{CBO} = -160V$
- Collector Dissipation $P_C = 800mW$
- Complement to KSC1009

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 160	V
Collector-Emitter Voltage	V_{CEO}	- 150	V
Emitter-Base Voltage	V_{EBO}	- 8	V
Collector Current	I_C	- 700	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	- 160			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_E = 0$	- 150			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	- 8			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -100V, I_E = 0$			- 0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			- 0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -2V, I_C = -50mA^*$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -200mA, I_B = -20mA^*$		- 0.3	- 0.4	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -200mA, I_B = 20mA^*$		- 0.9	- 1.0	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -50mA$	50		10	MHz
Output Capacitance	C_{OB}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$				pF

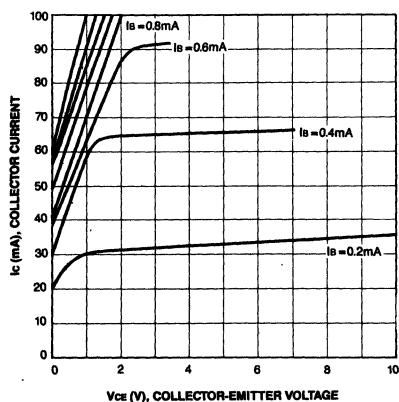
* pulse measured $PW \leq 350\mu s$, duty cycle $\leq 2\%$ **h_{FE} CLASSIFICATION**

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

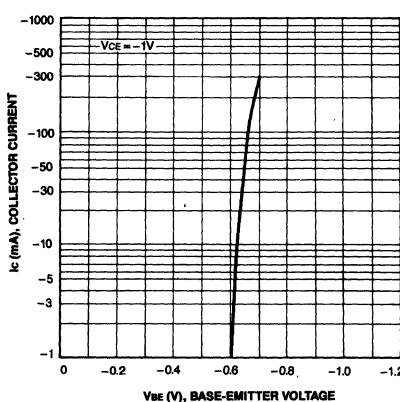


SAMSUNG SEMICONDUCTOR

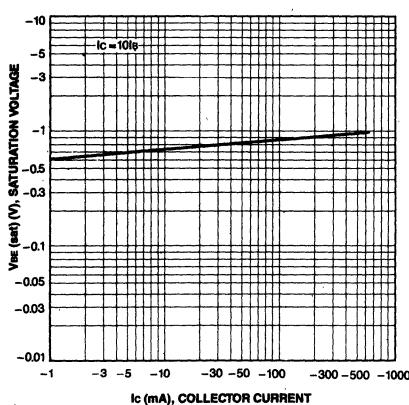
STATIC CHARACTERISTIC



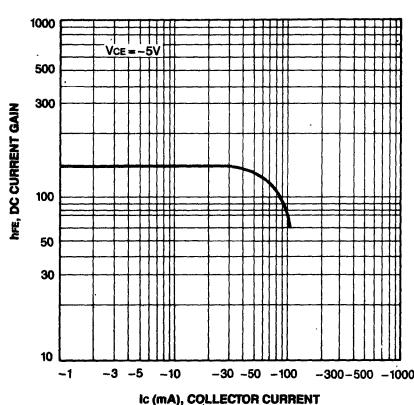
BASE-EMITTER ON VOLTAGE



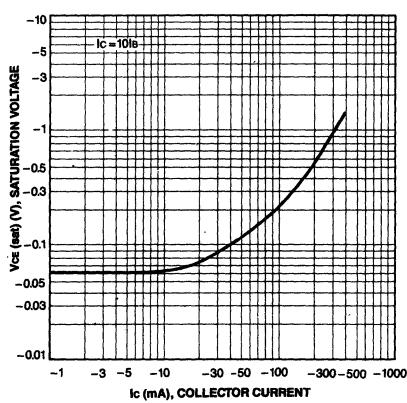
BASE-EMITTER SATURATION VOLTAGE



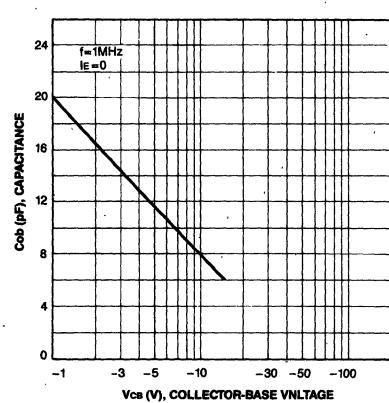
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR OUTPUT CAPACITANCE



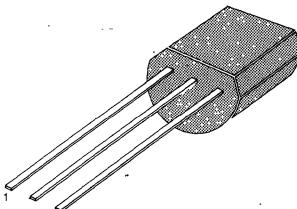
LOW FREQUENCY AMPLIFIER

- Complement to KSC945
- Collector-Base Voltage $V_{CBO} = -60V$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-150	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

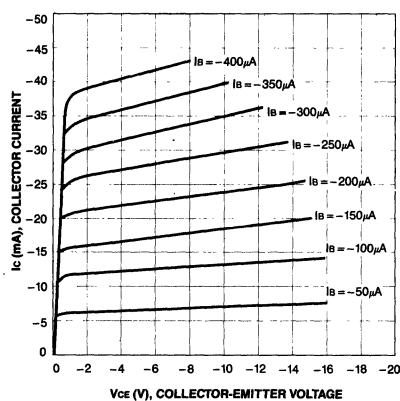
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-50			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60V, I_E = 0$			-0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -6V, I_C = -1mA$	40	700		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -100mA, I_B = -10mA$		-0.18	-0.3	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = -6V, I_C = -1mA$	-0.50	-0.62	-0.80	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_C = -10mA$	50	180		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		2.8		pF
Noise Figure	NF	$V_{CE} = -6V, I_C = -0.3mA$ $f = 100Hz, R_S = 10K\Omega$		6.0	20	dB

 h_{FE} CLASSIFICATION

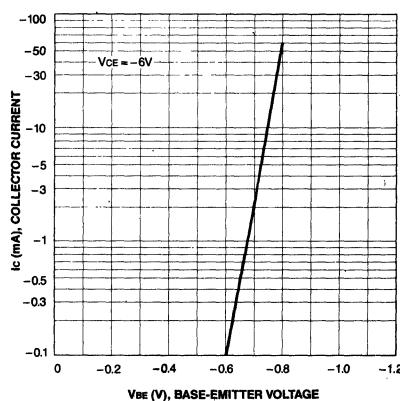
Classification	R	O	Y	G	L
h_{FE}	40-80	70-140	120-240	200-400	350-700



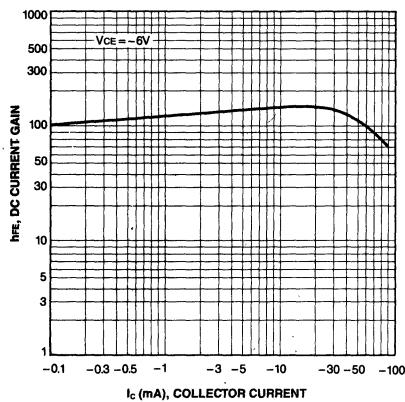
STATIC CHARACTERISTIC



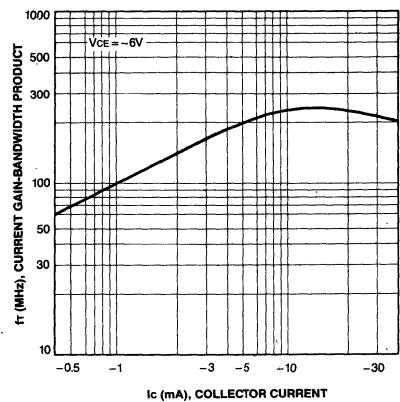
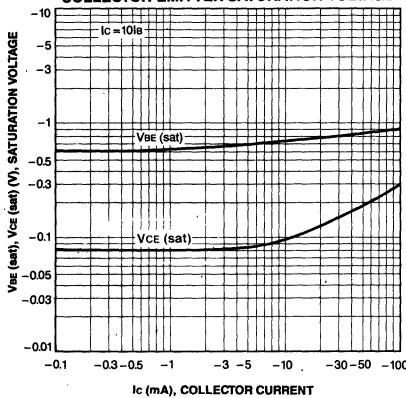
BASE-EMITTER ON VOLTAGE



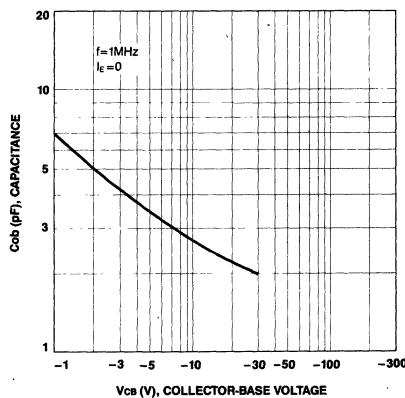
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



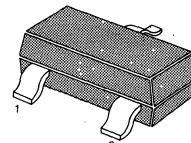
LOW FREQUENCY AMPLIFIER

- Complement to KSC1623
- Collector-Base Voltage $V_{CBO} = -60V$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_c	-100	mA
Collector Dissipation	P_c	150	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

SOT-23



1. Base 2. Emitter 3. Collector

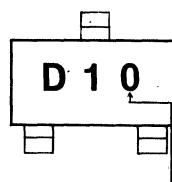
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = -60V, I_E = 0$			-0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -6V, I_C = -1mA$	90	200	600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -100mA, I_B = -10mA$		-0.18	-0.3	V
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C = -1mA, V_{CE} = -6V$	-0.55	-0.62	-0.65	V
Current Gain-Bandwidth Product	f_T	$I_C = -10mA, V_{CE} = -6V$		180		MHz
Output Capacitance	C _{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		4.5		pF

 h_{FE} CLASSIFICATION

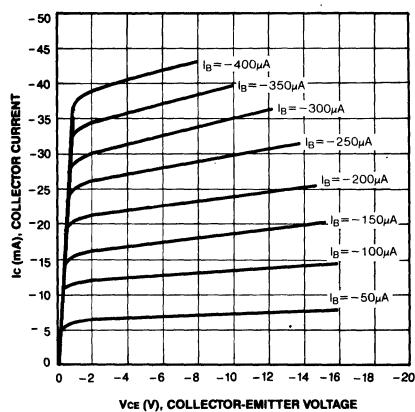
Marking

Classification	O	Y	G	L
h_{FE}	90-180	135-270	200-400	300-600

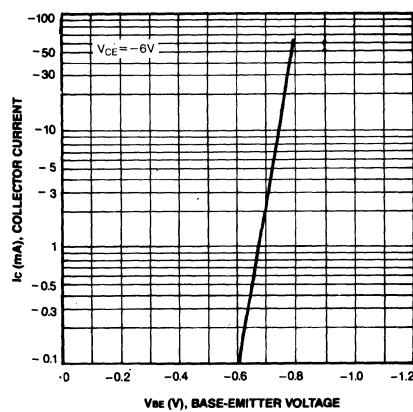
 h_{FE} grade

SAMSUNG SEMICONDUCTOR

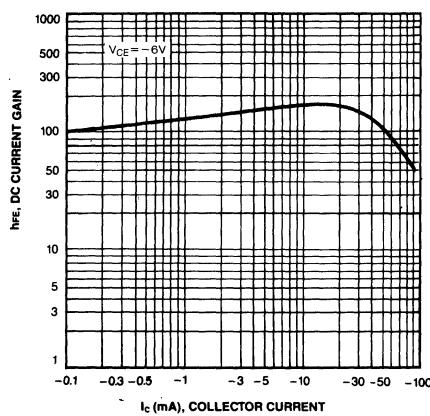
STATIC CHARACTERISTIC



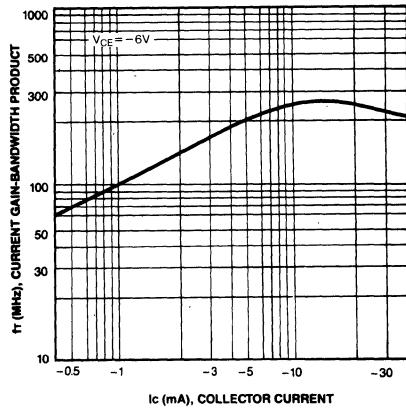
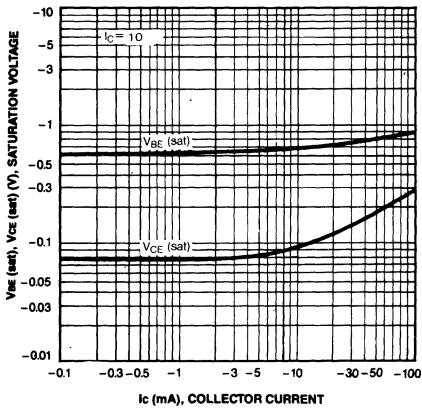
BASE-EMITTER ON VOLTAGE



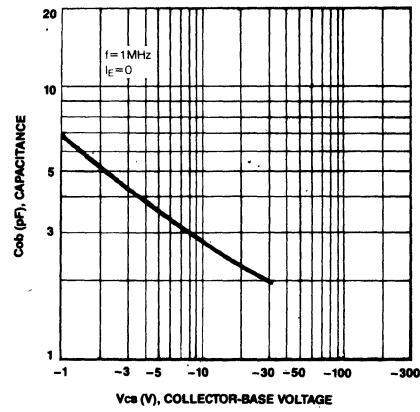
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE

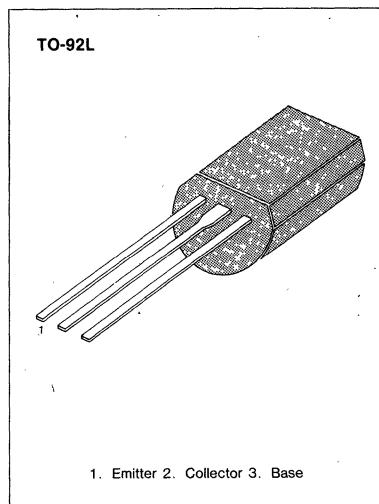


DRIVER STAGE AUDIO AMPLIFIER HIGH VOLTAGE SWITCHING APPLICATIONS

- Complement to KSC2310
- Collector-Emitter Voltage $V_{CEO} = -150V$
- Output Capacitance: $C_{ob}=5\text{pF}$ (MAX)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 150	V
Collector-Emitter Voltage	V_{CEO}	- 150	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current	I_C	- 50	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ\text{C}$



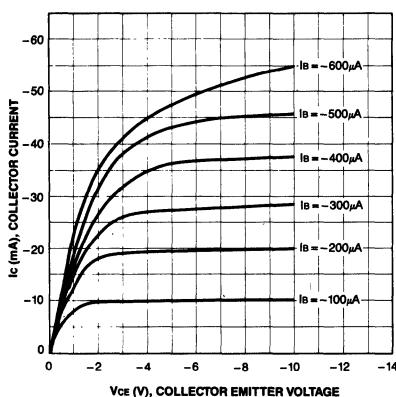
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	- 150			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -5\text{mA}, I_B = 0$	- 150			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_E = 0$	- 5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -150V, I_E = 0$			- 100	nA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -10\text{mA}$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -10\text{mA}, I_B = -1\text{mA}$			- 0.8	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -30V, I_C = -10\text{mA}$		100		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0, f = 1\text{MHz}$			5.0	pF

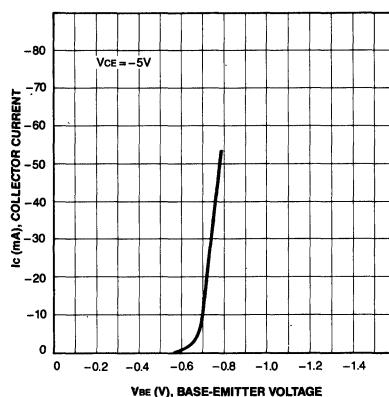
h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

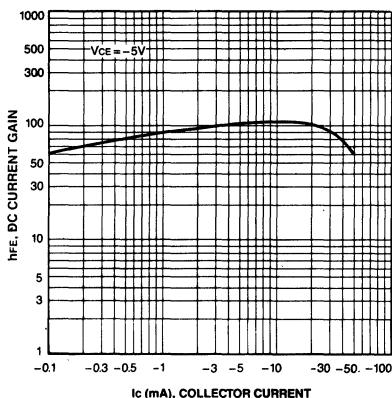
STATIC CHARACTERISTIC



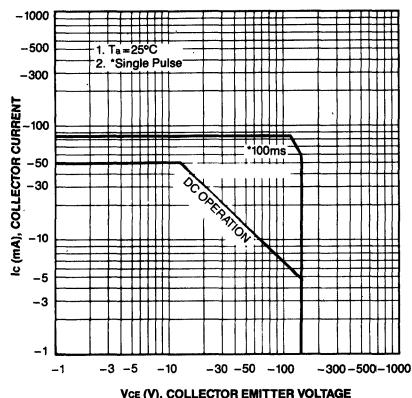
BASE-EMITTER ON VOLTAGE



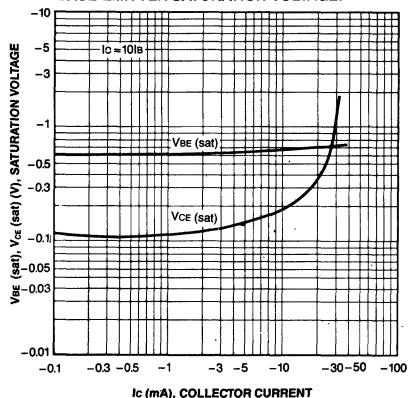
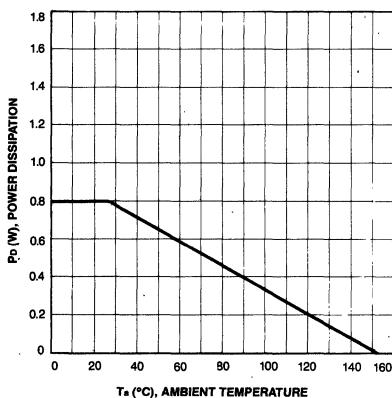
DC CURRENT GAIN



SAFE OPERATING AREA



POWER DERATING

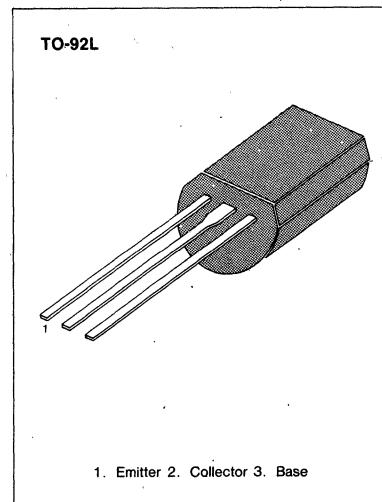


AUDIO POWER AMPLIFIER

- Driver Stage Amplifier
- Complement to KSC2316

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 120	V
Collector-Emitter Voltage	V_{CEO}	- 120	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current	I_C	- 800	mA
Collector Dissipation	P_C	900	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)**

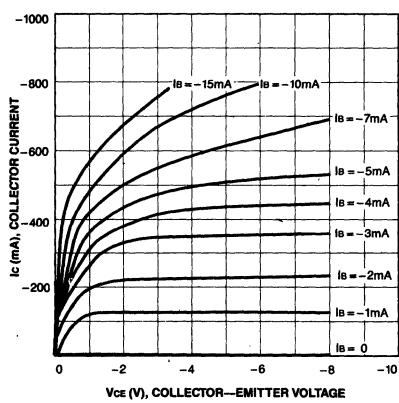
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -1\text{mA}, I_E = 0$	- 120			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	- 120			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -1\text{mA}, I_C = 0$	- 5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -120\text{V}, I_E = 0$			- 0.1	μA
DC Current Gain	h_{FE1}	$V_{CE} = -5\text{V}, I_C = -10\text{mA}$	60			
Collector-Emitter Saturation Voltage	h_{FE2}	$V_{CE} = -5\text{V}, I_C = -100\text{mA}$	80		240	
Current-Gain Bandwidth Product	$V_{CE} (\text{sat})$	$I_C = -500\text{mA}, I_B = -50\text{mA}$		120	- 1	V
Output Capacitance	f_T	$V_{CE} = -5\text{V}, I_C = -100\text{mA}$			40	MHz
	Cob	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1\text{MHz}$				pF

 h_{FE} CLASSIFICATION

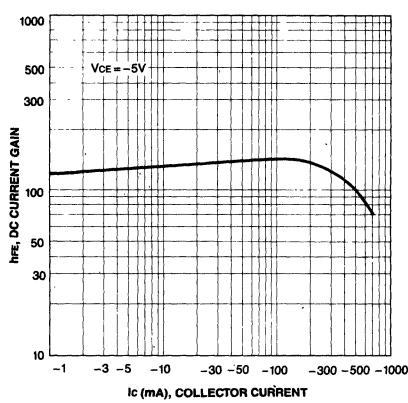
Classification	O	Y
$h_{FE(2)}$	80-160	120-240



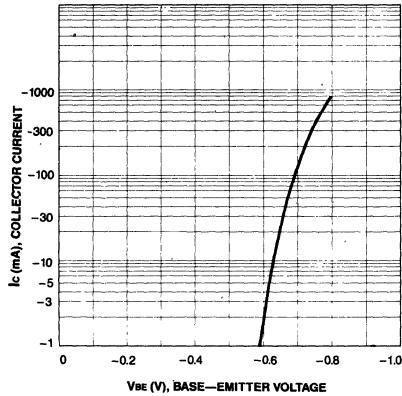
STATIC CHARACTERISTIC



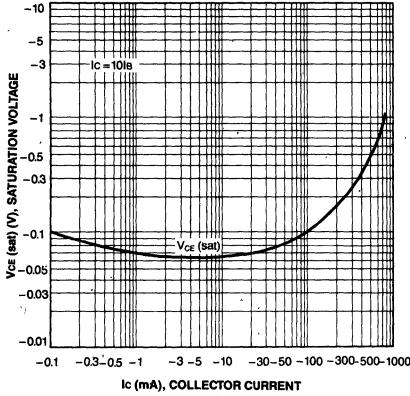
DC CURRENT GAIN



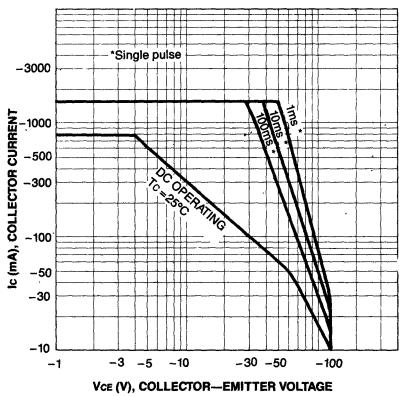
BASE-EMITTER ON VOLTAGE



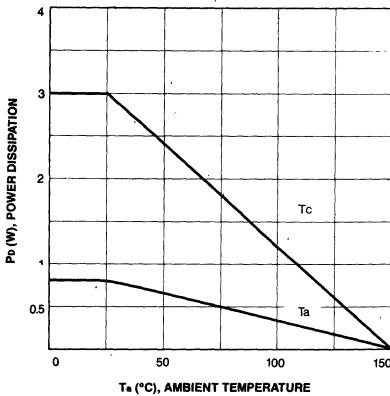
COLLECTOR-EMITTER SATURATION VOLTAGE



SAFE OPERATING AREA



POWER DERATING

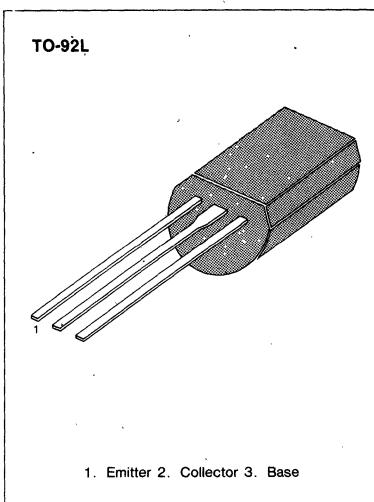


AUDIO POWER AMPLIFIER

- Complement of KSC2328A
- Collector Dissipation $P_c = 1$ Watt
- 3 Watt Output Application

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-30	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-2	A
Collector Dissipation	P_c	1	W
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)**

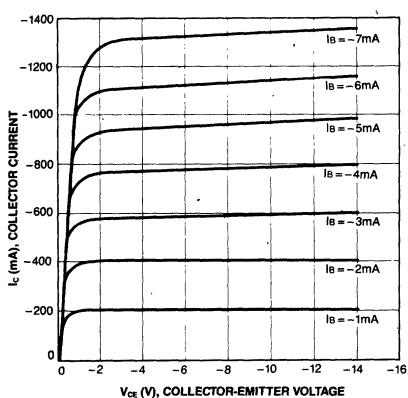
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	-30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -1\text{mA}, I_C = 0$	-5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30\text{V}, I_E = 0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -5\text{V}, I_C = 0$			-100	nA
DC Current Gain	h_{FE}	$V_{CE} = -2\text{V}, I_C = -500\text{mA}$	100		320	
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$V_{CE} = -2\text{V}, I_C = -500\text{mA}$			-1.0	V
Collector-Emitter Saturation Voltage	$V_{CE (\text{sat})}$	$I_C = -1.5\text{A}, I_B = -0.03\text{A}$			-2.0	V
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0,$ $f = 1\text{MHz}$		48		pF
Current Gain Bandwidth Product	f_T	$V_{CE} = -2\text{V}, I_C = -500\text{mA}$			120	MHz

 h_{FE} CLASSIFICATION

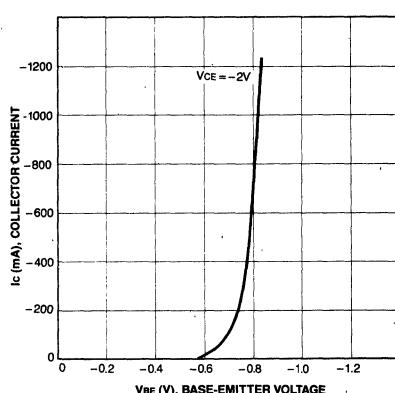
Classification	O	Y
h_{FE}	100-200	160-320



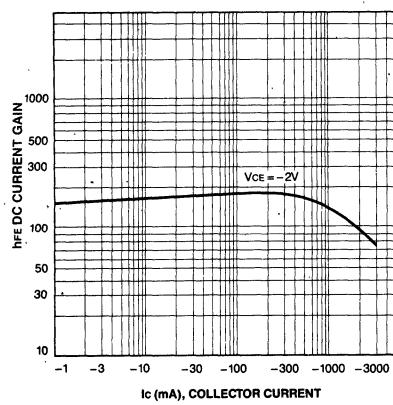
STATIC CHARACTERISTIC



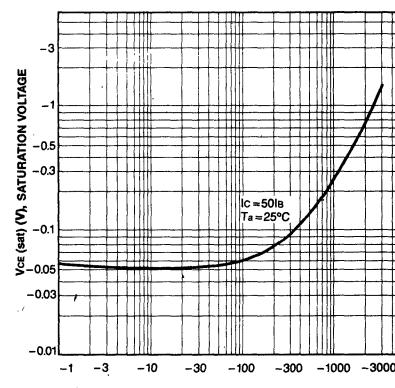
BASE-EMITTER ON VOLTAGE



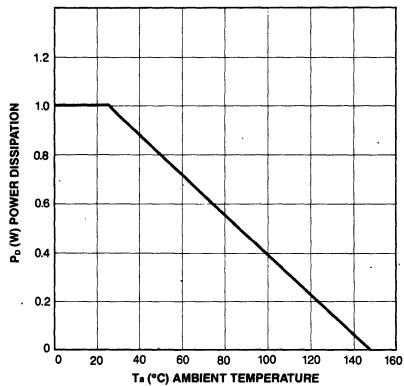
DC CURRENT GAIN



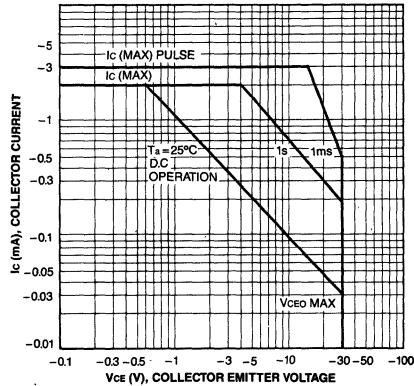
COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



SAFE OPERATING AREA

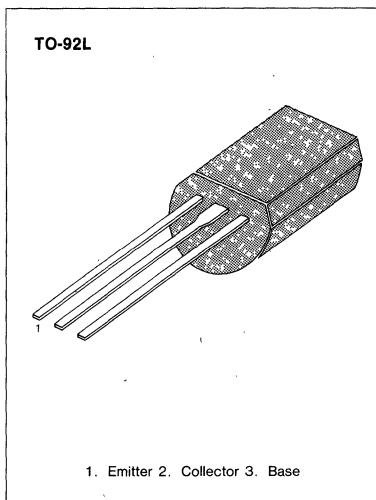


**LOW FREQUENCY AMPLIFIER
MEDIUM SPEED SWITCHING**

- Complement to KSC2331
- Collector-Base Voltage $V_{CBO} = -80V$
- Collector Dissipation $P_c = 1W$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 80	V
Collector-Emitter Voltage	V_{CEO}	- 60	V
Emitter-Base Voltage	V_{EBO}	- 8	V
Collector Current	I_c	- 700	mA
Collector Dissipation	P_c	1	W
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	- 55 ~ +150	$^\circ C$


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

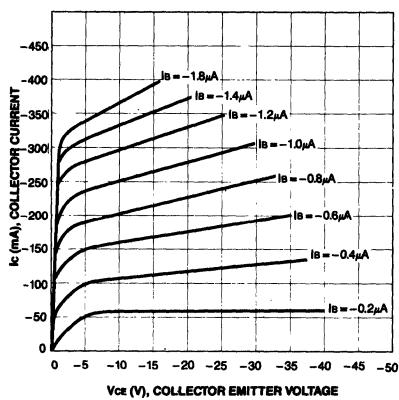
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = -100\mu A, I_e = 0$	- 80			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = -10mA, I_b = 0$	- 60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_e = -100\mu A, I_c = 0$	- 8			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60V, I_e = 0$			- 0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_c = 0$			- 0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -2V, I_c = -50mA^*$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_c = -500mA, I_b = -50mA^*$		- 0.3	- 0.7	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_c = -500mA, I_b = -50mA^*$		- 0.9	- 1.2	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_c = -50mA$		100		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_e = 0$ $f = 1MHz$		13		pF

* Pulse Test $PW \leq 350\mu s$, duty cycle $\leq 2\%$

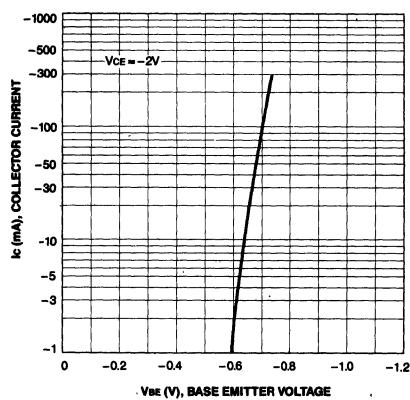
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

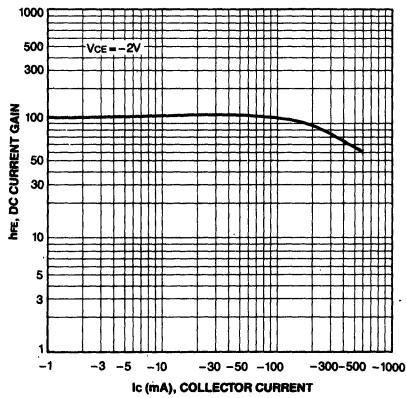
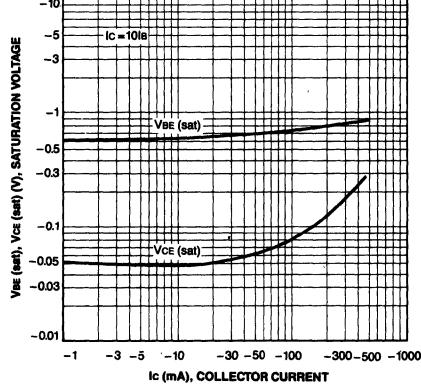
STATIC CHARACTERISTIC



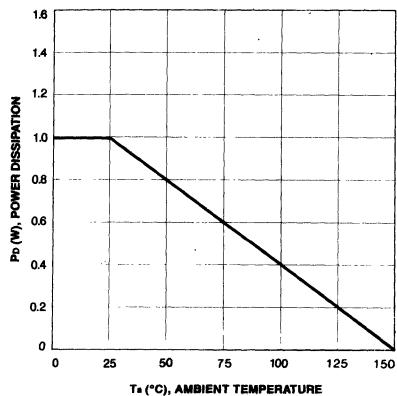
BASE-EMITTER ON VOLTAGE



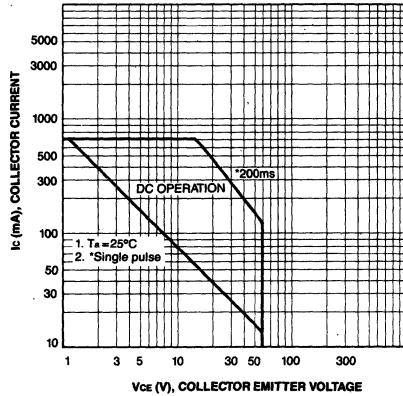
DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

POWER DERATING



SAFE OPERATING AREA



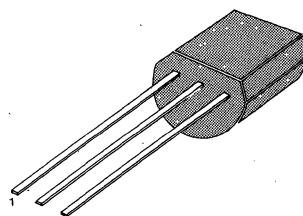
**GENERAL PURPOSE APPLICATIONS
HIGH TOTAL POWER DISIPATION
($\text{PT}=600 \text{ mW}$)**

High h_{FE} and Low $V_{CE(\text{sat})}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-700	mA
Base Current	I_B	-150	mA
Collector Dissipation	P_c	600	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

TO-92



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
*Base Emitter Voltage	V_{BE}	$V_{CE}=-6\text{V}$, $I_C=-10\text{mA}$	-600	-640	-700	mV
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30\text{V}$, $I_E=0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-5\text{V}$, $I_C=0$			-100	nA
*DC Current Gain	h_{FE1}	$V_{CE}=-1\text{V}$, $I_C=-100\text{mA}$	90	200	400	
	h_{FE2}	$V_{CE}=-1\text{V}$, $I_C=-700\text{mA}$	50	100		
*Collector Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-700\text{mA}$, $I_E=-70\text{mA}$		-0.25	-0.6	V
*Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C=-700\text{mA}$, $I_E=-70\text{mA}$		-0.95	-1.2	V
Output Capacitance	C_{ob}	$V_{CB}=-6\text{V}$, $I_E=0$, $f=1\text{MHz}$		17	40	pF
Current Gain Bandwidth Product	f_T	$V_{CE}=-6\text{V}$, $I_E=10\text{mA}$	50	160		MHz

* Pulse test: PW $\leq 350\mu\text{s}$, duty cycle $\leq 2\%$ Pulsed

h_{FE1} CLASSIFICATION

Classification	R	O	Y
h_{FE1}	90-180	135-270	200-400



SAMSUNG SEMICONDUCTOR

AUDIO FREQUENCY AMPLIFIER

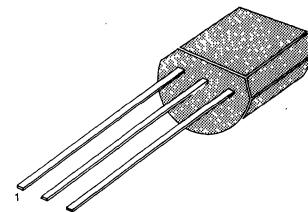
- Complement to KSC2002/KSC2003

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : KSA953 : KSA954	V_{CBO}	-60 -80	V
Collector-Emitter Voltage : KSA953 : KSA954	V_{CEO}	-60 -80	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current (DC)	I_c	-300	mA
* Collector Current (Pulse)	I_c	-500	mA
Collector Dissipation	P_c	600	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55~150	°C

* PW≤10ms, Duty Cycle ≤50%

TO-92



1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

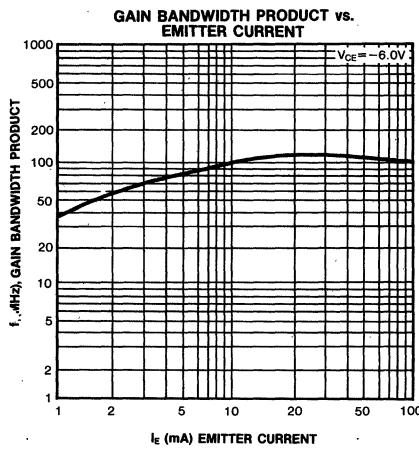
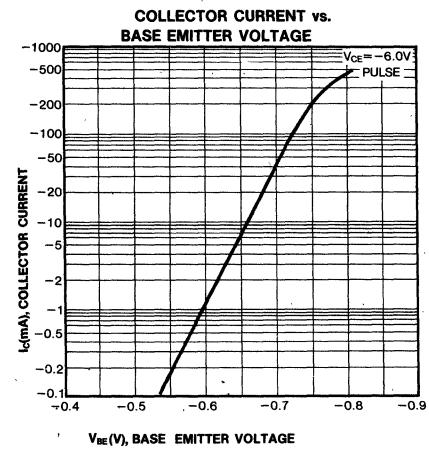
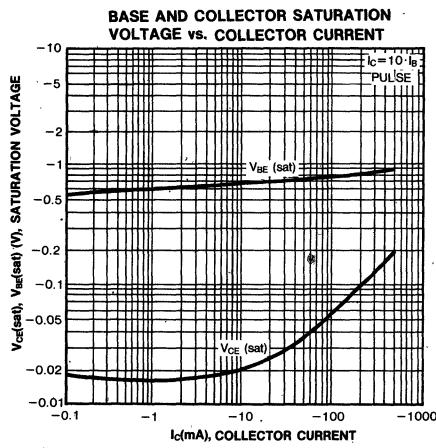
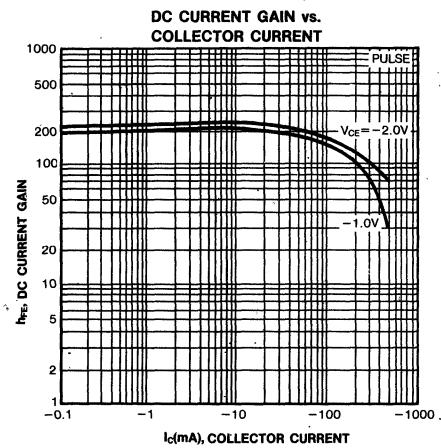
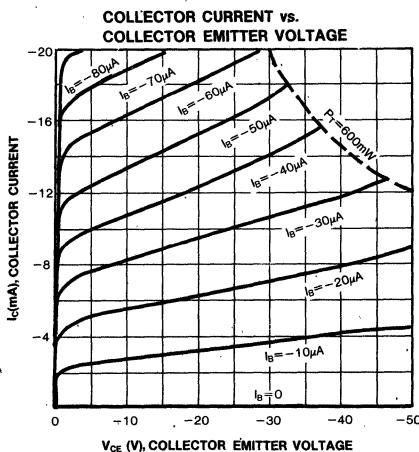
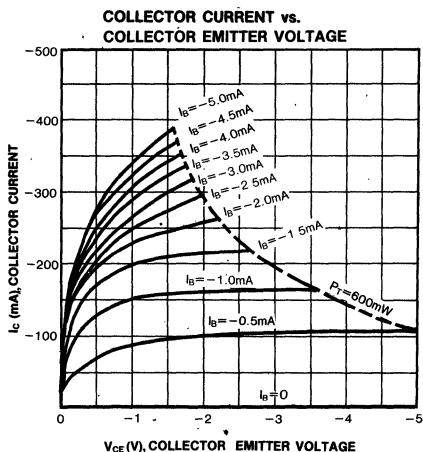
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current : KSA953 : KSA954	I_{CBO}	$V_{CB}=-60V, I_E=0$ $V_{CB}=-80V, I_E=0$			-100 -100 -100	nA nA nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-5V, I_c=0$			-100	nA
* DC Current Gain	h_{FE1}	$V_{CE}=-1V, I_c=-50\text{mA}$	90	200	400	
	h_{FE2}	$V_{CE}=-2V, I_c=-300\text{mA}$	30	80		
* Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=-6V, I_c=-10\text{mA}$	-600	-660	-700	mV
* Base Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=-300\text{mA}, I_E=-30\text{mA}$		-0.85	-1.2	V
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=-300\text{mA}, I_E=-30\text{mA}$		-0.15	-0.6	V
Output Capacitance	C_{ob}	$V_{CB}=-6V, I_E=0, f=1\text{MHz}$		13	25	pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-6V, I_E=10\text{mA}$	50	100		MHz

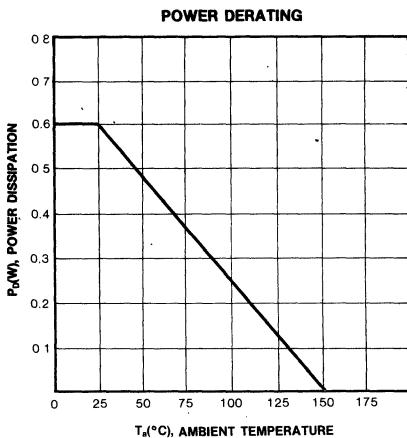
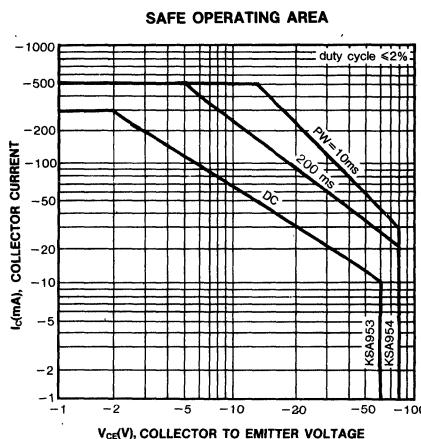
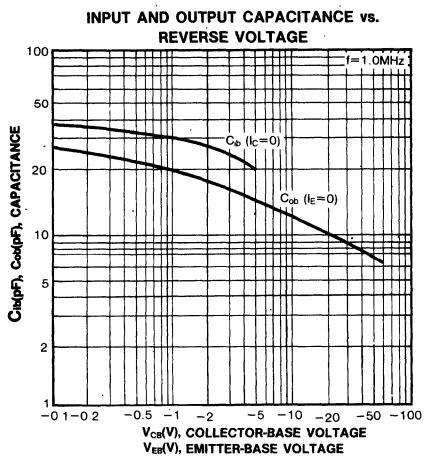
* Pulse Test: PW≤350μs, Duty Cycle≤2% Pulsed

 $h_{FE}(1)$ CLASSIFICATION

Classification	O	Y	G
h_{FE1}	90-180	135-270	200-400







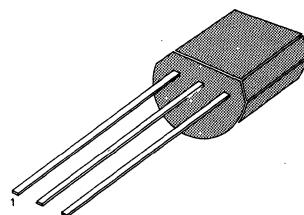
AUDIO FREQUENCY LOW NOISE AMPLIFIER

- Complement to KSC1845

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-120	V
Collector-Emitter Voltage	V_{CEO}	-120	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-50	mA
Base Current	I_B	-10	mA
Collector Dissipation	P_C	500	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 - 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Collector 3. Base

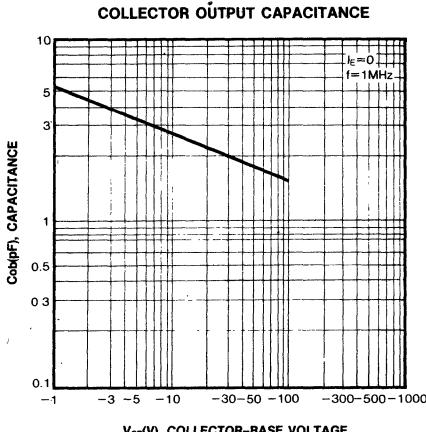
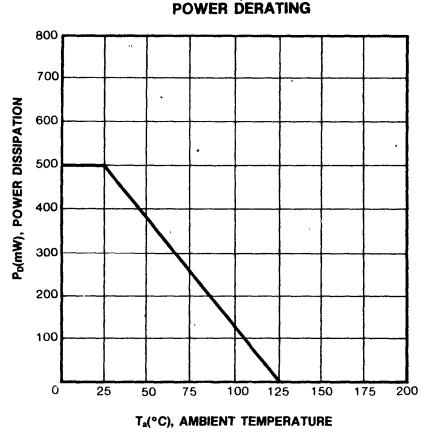
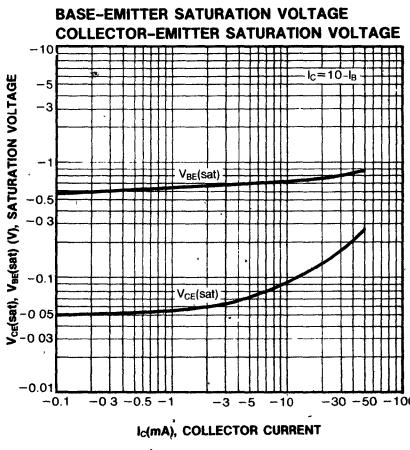
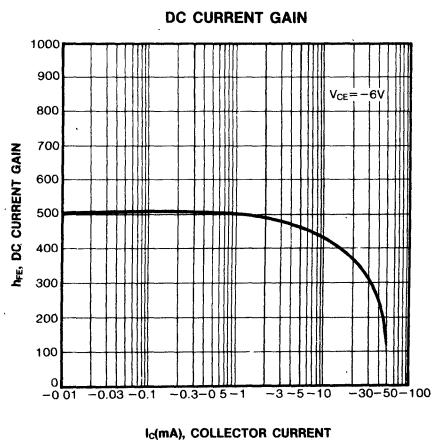
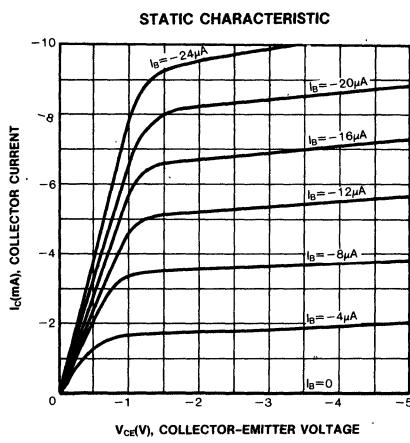
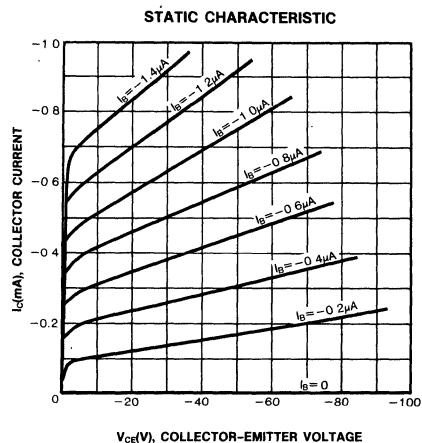
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

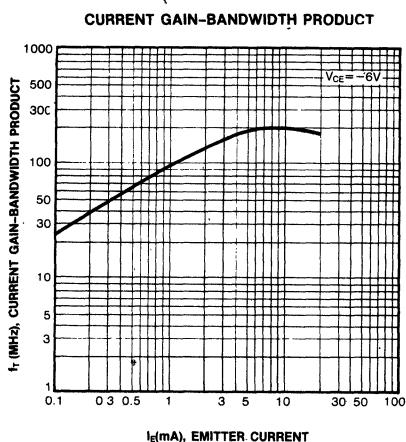
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=-120\text{V}$, $I_E=0$			-50	nA
Collector Cutoff Current	I_{CEO}	$V_{CE}=-100\text{V}$, $R_{BE}=\infty$			-1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-5\text{V}$, $I_C=0$			-50	nA
DC Current Gain	h_{FE1}	$V_{CE}=-6\text{V}$, $I_C=-0.1\text{mA}$	150	500		
	h_{FE2}	$V_{CE}=-6\text{V}$, $I_C=-1\text{mA}$	200	500	800	
Base Emitter On Voltage	V_{BE} (on)	$V_{CE}=-6\text{V}$, $I_C=-1\text{mA}$	-0.55	-0.61	-0.65	V
Collector Emitter Saturation Voltage	V_{CE} (sat)	$I_C=-10\text{mA}$, $I_B=-1\text{mA}$		-0.09	-0.3	V
Current Gain Bandwidth Product	f_T	$V_{CE}=-6\text{V}$, $I_E=1\text{mA}$	50	100		MHz
Output Capacitance	C_{ob}	$V_{CB}=-30\text{V}$, $I_E=0$ $f=1\text{MHz}$		2	3	pF
Noise Voltage	NV			25	40	mV

 $h_{FE}(2)$ CLASSIFICATION

Classification	P	F	E
$h_{FE}(2)$	200-400	300-600	400-800



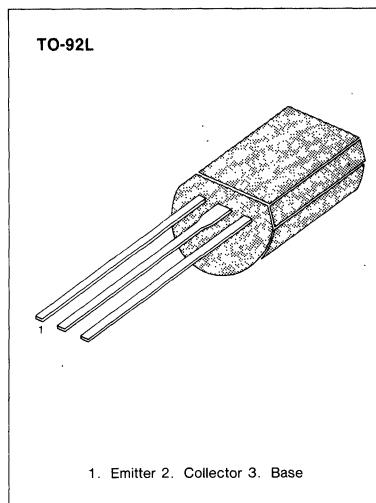




COLOR TV AUDIO OUTPUT
COLOR TV VERTICAL DEFLECTION OUTPUT

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-160	V
Collector-Emitter Voltage	V_{CEO}	-160	V
Emitter-Base Voltage	V_{EBO}	-6	V
Collector Current	I_C	-1	A
Base Current	I_B	-0.5	A
Collector Dissipation	P_C	900	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

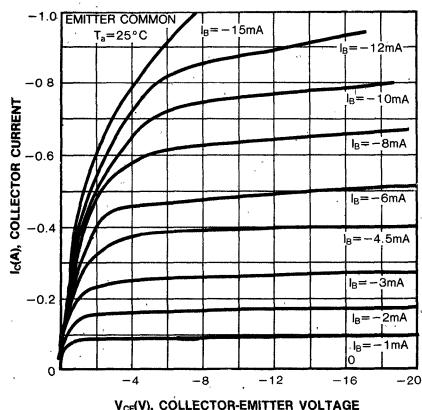
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = -150\text{V}$, $I_E = 0$			-1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -6\text{V}$, $I_C = 0$			-1	μA
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}$, $I_B = 0$	-160			V
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}$, $I_C = -200\text{mA}$	60		320	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -500\text{mA}$, $I_B = -50\text{mA}$			-1.5	V
Base Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -5\text{V}$, $I_C = -5\text{mA}$	-0.45		-0.75	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{V}$, $I_C = -200\text{mA}$	15	50	35	MHz
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}$, $I_E = 0$ $f = 1\text{MHz}$				pF

h_{FE} CLASSIFICATION

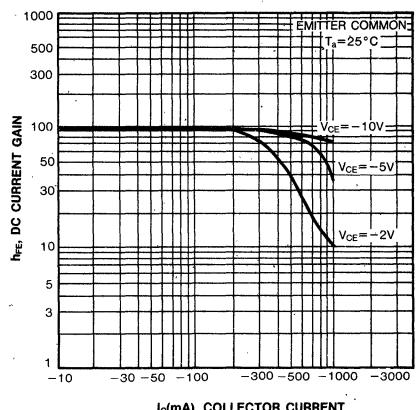
Classification	R	O	Y
h_{FE}	60-120	100-200	160-320



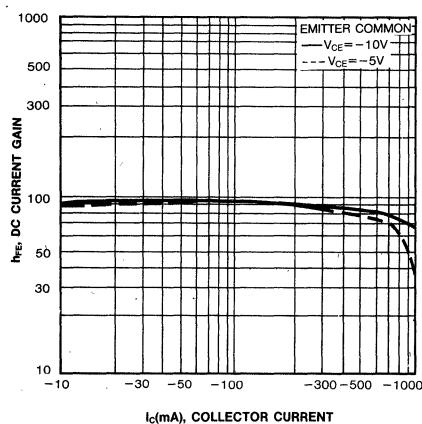
STATIC CHARACTERISTIC



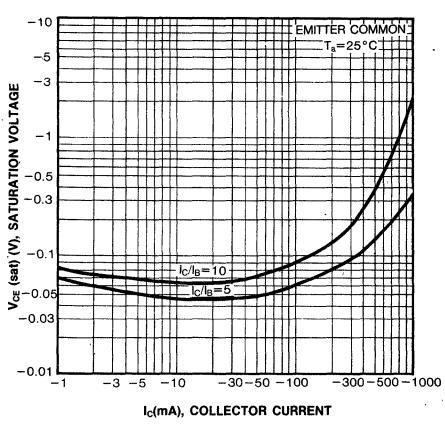
DC CURRENT GAIN



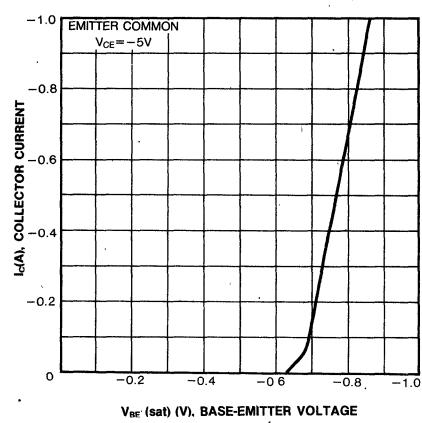
DC CURRENT GAIN



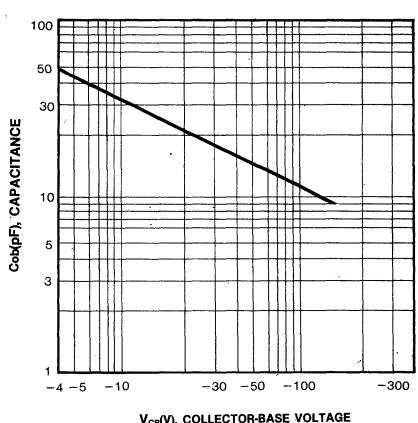
COLLECTOR-EMITTER SATURATION VOLTAGE

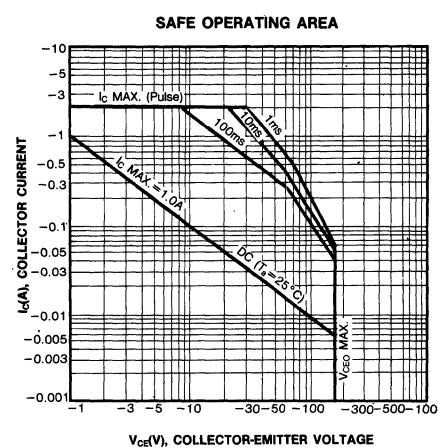
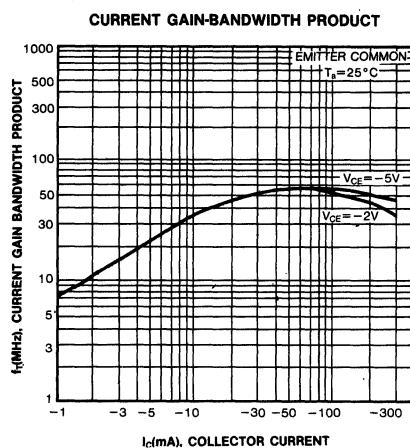


BASE-EMITTER VOLTAGE



COLLECTOR OUTPUT CAPACITANCE





LOW FREQUENCY POWER AMPLIFIER

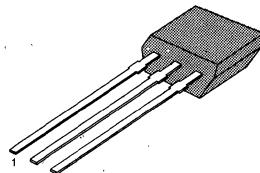
- Complement to KSC2710
- Collector Dissipation $P_C = 300\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	- 40	V
Collector-Emitter Voltage	V_{CEO}	- 20	V
Emitter-Base Voltage	V_{EBO}	- 5	V
Collector Current (DC)	I_C (DC)	- 500	mA
• Collector Current (pulse)	I_C (pulse)	- 700	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	- 55 ~ 150	°C

* PW ≤ 10mS, duty Cycle ≤ 50%.

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	- 40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	- 20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	- 5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -25\text{V}, I_E = 0$			- 100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3\text{V}, I_C = 0$			- 100	nA
• DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}, I_C = -100\text{mA}$	40		400	
• Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -500\text{mA}, I_B = -50\text{mA}$		- 0.3	- 0.4	V
• Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C = -500\text{mA}, I_B = -50\text{mA}$		- 1.0	- 1.3	V

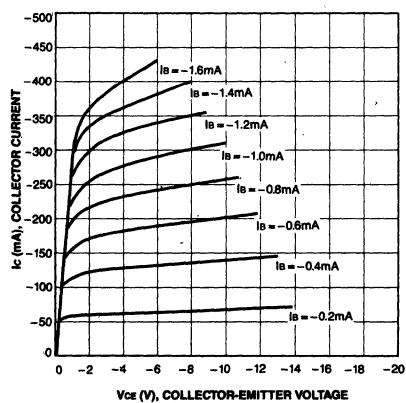
* Pulse Test: PW ≤ 350μs, duty cycle ≤ 2%

 h_{FE} CLASSIFICATION

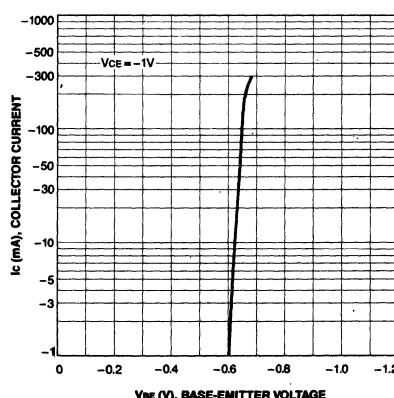
Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400



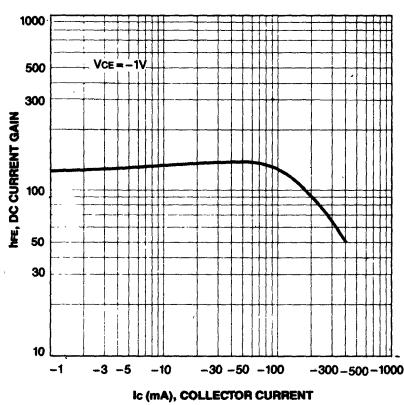
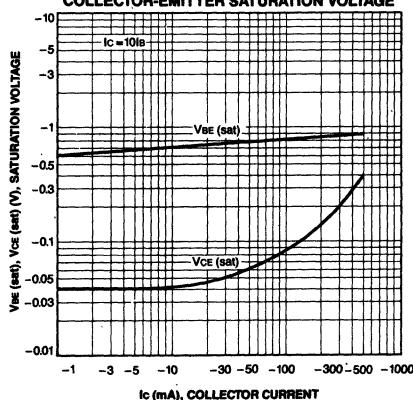
STATIC CHARACTERISTIC



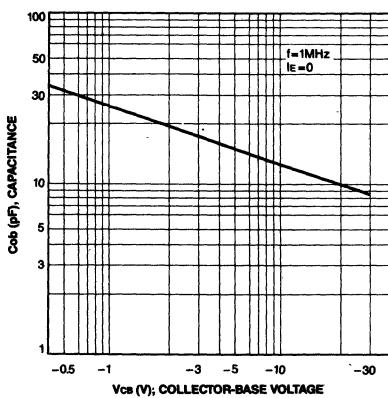
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



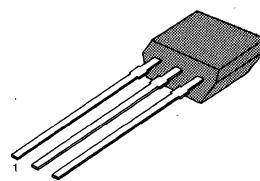
AUDIO FREQUENCY LOW NOISE AMPLIFIER

- Complement to KSC2784

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-120	V
Collector-Emitter Voltage	V_{CEO}	-120	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_c	-50	mA
Base Current	I_b	-10	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

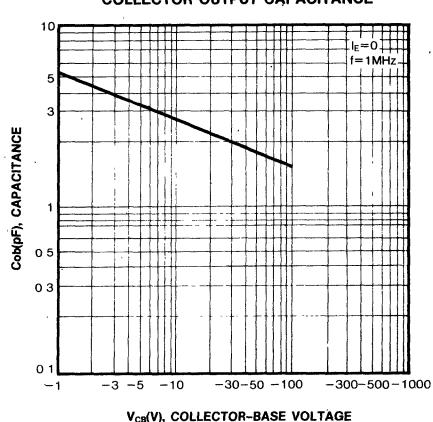
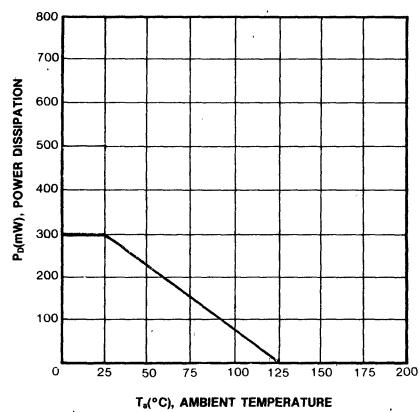
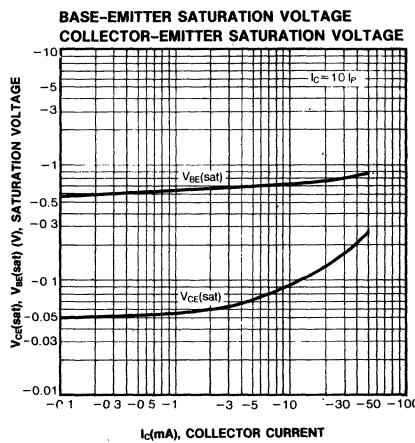
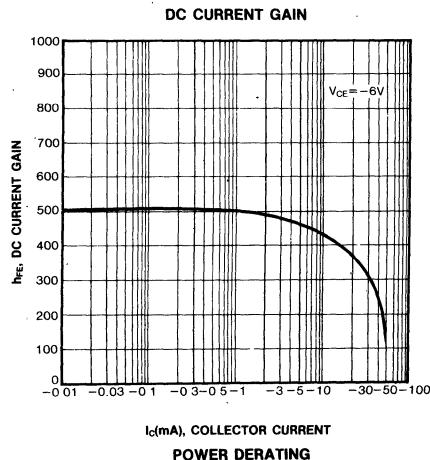
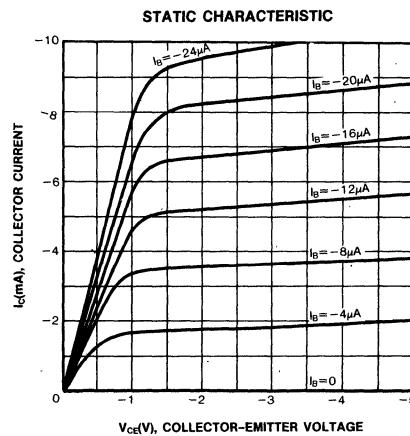
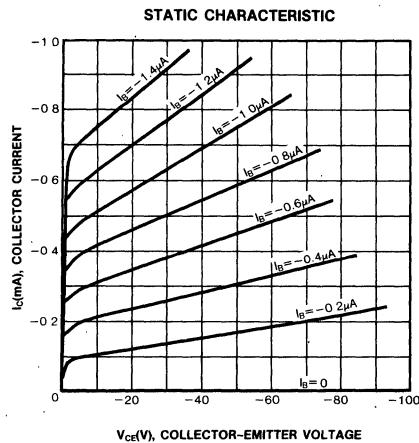
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=-120\text{V}, I_E=0$			-50	nA
Collector Cutoff Current	I_{CEO}	$V_{CE}=-100\text{V}, R_{BE}=\infty$			-1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-5\text{V}, I_C=0$			-50	nA
DC Current Gain	h_{FE1}	$V_{CE}=-6\text{V}, I_C=-0.1\text{mA}$	150	500		
	h_{FE2}	$V_{CE}=-6\text{V}, I_C=-1\text{mA}$	200	500	800	
Base Emitter On Voltage	V_{BE} (on)	$V_{CE}=-6\text{V}, I_C=-1\text{mA}$	-0.55	-0.61	-0.65	V
Collector Emitter Saturation Voltage	V_{CE} (sat)	$I_C=-10\text{mA}, I_B=-1\text{mA}$		-0.09	-0.3	V
Current Gain Bandwidth Product	f_T	$V_{CE}=-6\text{V}, I_E=1\text{mA}$	50	100		MHz
Output Capacitance	C_{ob}	$V_{CB}=-30\text{V}, I_E=0$ $f=1\text{MHz}$		2	3	pF
Noise Voltage	NV			25	40	mV

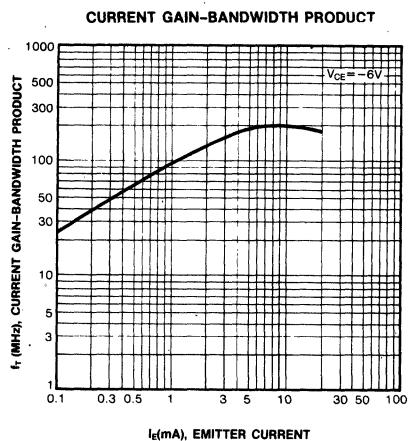
 $h_{FE}(2)$ CLASSIFICATION

Classification	P	F	E
$h_{FE}(2)$	200-400	300-600	400-800



SAMSUNG SEMICONDUCTOR





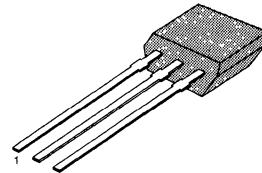
LOW FREQUENCY AMPLIFIER

- Complement to KSC2785
- Collector-Base Voltage $V_{CBO} = -60V$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-150	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92S



1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

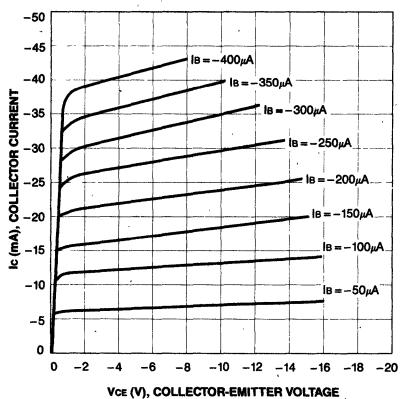
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-50			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -60V, I_E = 0$			-0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -6V, I_C = -1mA$	40		700	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -100mA, I_B = -10mA$		-0.18	-0.3	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = -6V, I_C = -1mA$	-0.50	-0.62	-0.80	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_C = -10mA$	50	180		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		2.8		pF
Noise Figure	NF	$V_{CE} = -6V, I_C = -0.3mA$ $f = 100Hz, R_s = 10K\Omega$		6.0	20	dB

 h_{FE} CLASSIFICATION

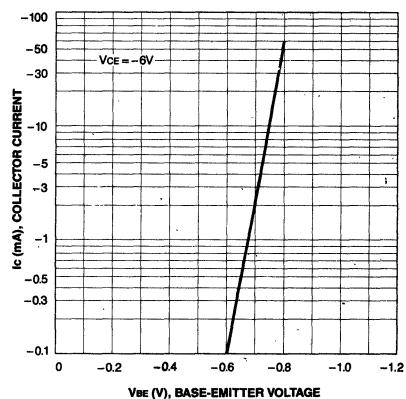
Classification	R	O	Y	G	L
h_{FE}	40-80	70-140	120-240	200-400	350-700



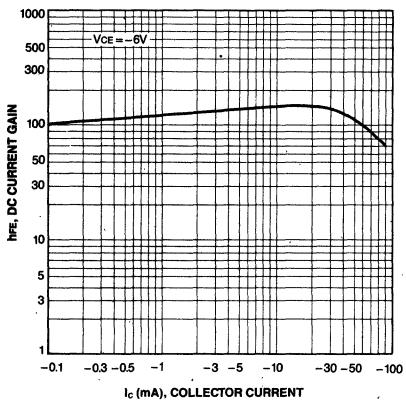
STATIC CHARACTERISTIC



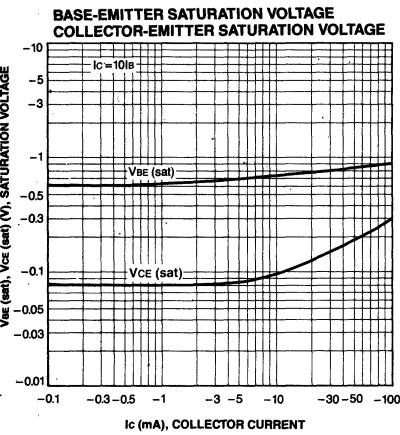
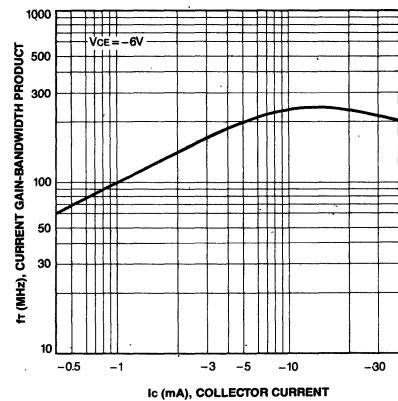
BASE-EMITTER ON VOLTAGE



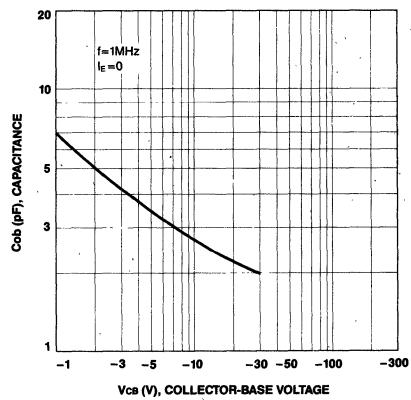
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR OUTPUT CAPACITANCE



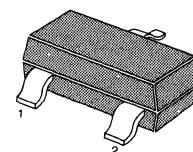
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA2859

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-35	V
Collector-Emitter Voltage	V_{CEO}	-30	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_c	-500	mA
Collector Dissipation	P_c	150	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

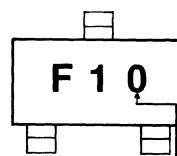
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=-35\text{V}$, $I_E=0$			-0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-5\text{V}$, $I_C=0$			-0.1	μA
DC Current Gain	h_{FE1}	$V_{CE}=-1\text{V}$, $I_C=-100\text{mA}$	70		240	
	h_{FE2}	$V_{CE}=-6\text{V}$, $I_C=-400\text{mA}$	25			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-100\text{mA}$, $I_B=-10\text{mA}$		-0.1	-0.25	V
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C=-100\text{mA}$, $V_{CE}=-1\text{V}$		-0.8	-1.0	V
Current Gain-Bandwidth Product	f_T	$I_C=-20\text{mA}$, $V_{CE}=-6\text{V}$		200		MHz
Output Capacitance	C_{ob}	$V_{CB}=-6\text{V}$, $I_E=0$ $f=1\text{MHz}$		13		pF

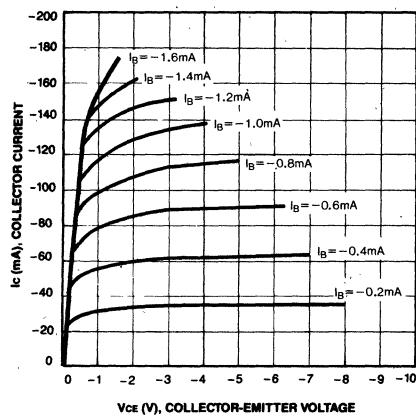
 h_{FE} CLASSIFICATION

Marking

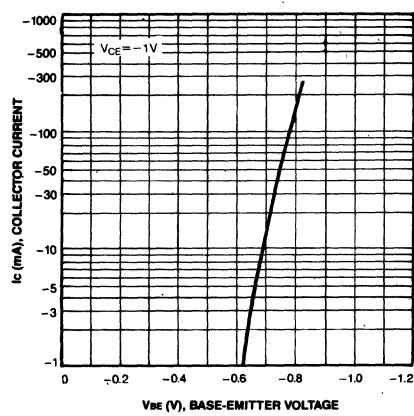
Classification	O	Y
h_{FE} (1)	70-140	120-240

 h_{FE} grade

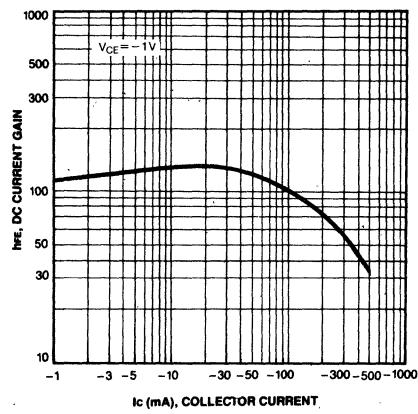
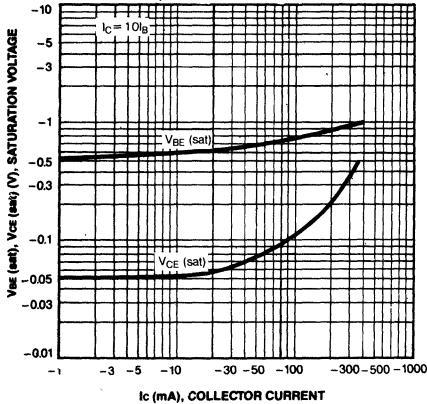
STATIC CHARACTERISTIC



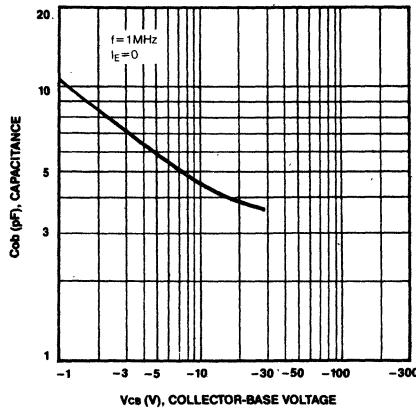
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



LOW FREQUENCY AMPLIFIER

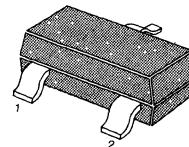
- Complement to KSC3265

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-800	mA
Base Current	I_B	-160	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

- Refer to KSA643 for graphs.

SOT-23



1. Base 2. Emitter 3. Collector

3

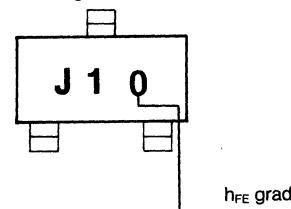
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-10\text{mA}, I_B=0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-1\text{mA}, I_C=0$	-5			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30\text{V}, I_E=0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-5\text{V}, I_C=0$			-100	nA
DC Current Gain	h_{FE1}	$V_{CE}=-1\text{V}, I_C=-100\text{mA}$	100		320	
	h_{FE2}	$V_{CE}=-1\text{V}, I_C=-800\text{mA}$	40			
Collector Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=-500\text{mA}, I_B=-20\text{mA}$	-0.5		-0.4	V
Base-Emitter (on) Voltage	$V_{BE}(\text{on})$	$V_{CE}=-1\text{V}, I_C=-10\text{mA}$			-0.8	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{V}, I_C=-10\text{mA}$		120		MHz
Output Capacitance	C_{OB}	$V_{CE}=-10\text{V}, I_C=0$		13		pF
		$f=1\text{MHz}$				

 $h_{FE}(1)$ CLASSIFICATION

Classification	O	Y
$h_{FE}(1)$	100-200	160-320

Marking

h_{FE} grade

LOW FREQUENCY POWER AMPLIFIER

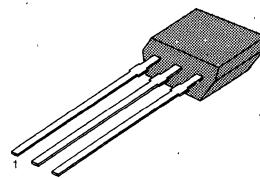
- Complement to KSC3488
- Collector Dissipation $P_C = 300\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current (DC)	I_C (DC)	-300	mA
• Collector Current (pulse)	I_C (pulse)	-500	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* PW ≤ 10ms, duty cycle ≤ 50%

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10\text{mA}, I_B = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	-5			V
Collector Cut-off Current	I_{CEO}	$V_{CB} = -25\text{V}, I_E = 0$			-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3\text{V}, I_C = 0$			-100	nA
• DC Current Gain	h_{FE}	$V_{CE} = -1\text{V}, I_C = -50\text{mA}$	70		400	nA
• Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -300\text{mA}, I_B = -30\text{mA}$		-0.35	-0.6	V

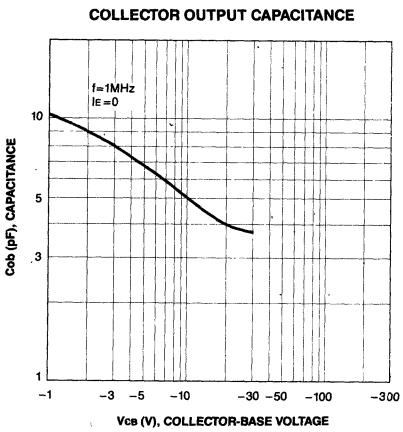
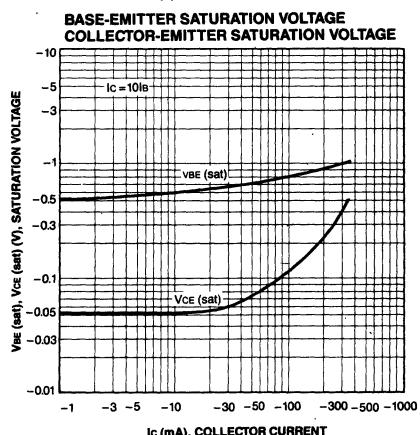
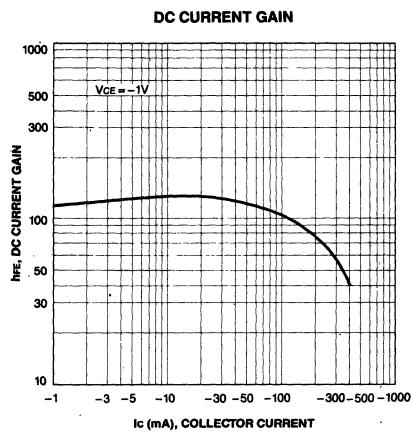
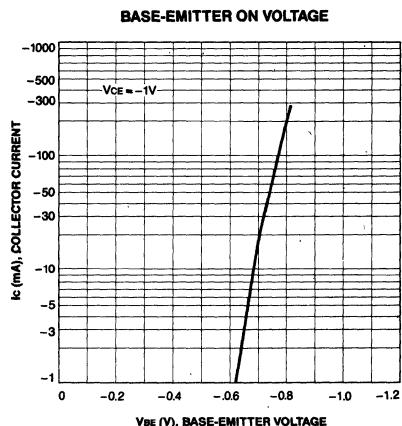
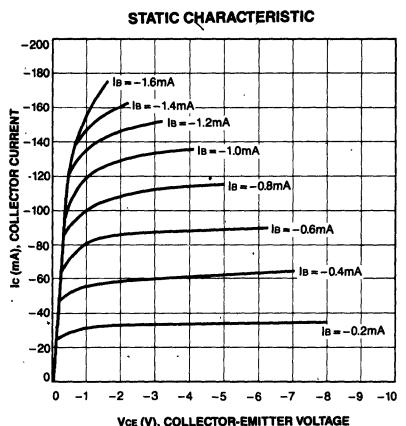
* Pulse Test: PW ≤ 350μs, duty cycle ≤ 2%

 h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400



SAMSUNG SEMICONDUCTOR



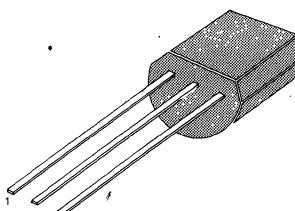
AUDIO FREQUENCY POWER AMPLIFIER

- Complement to KSD471A
- Collector Current $I_C = -1A$
- Collector Dissipation $P_C = 800mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-1.0	A
Collector Dissipation	P_C	800	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -1V, I_C = -100mA$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -1A, I_B = -0.1A$			-0.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -1A, I_B = -0.1A$			-1.2	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_C = -10mA$		110		MHz
Output Capacitance	C_{OB}	$V_{CB} = -6V, f = 1 MHz, I_E = 0$		18		pF

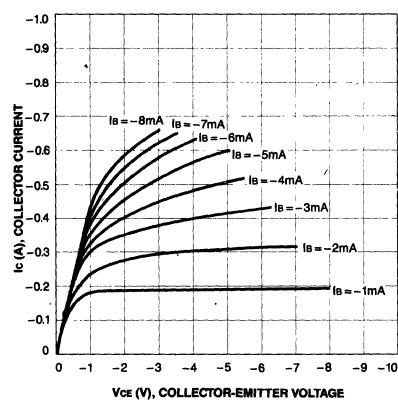
 h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400

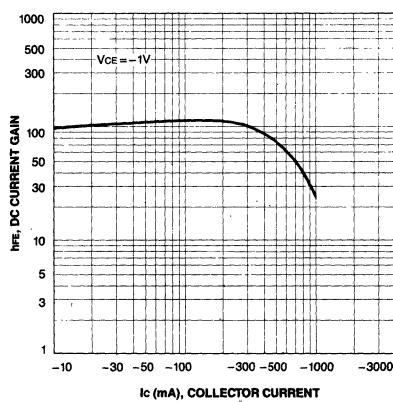


SAMSUNG SEMICONDUCTOR

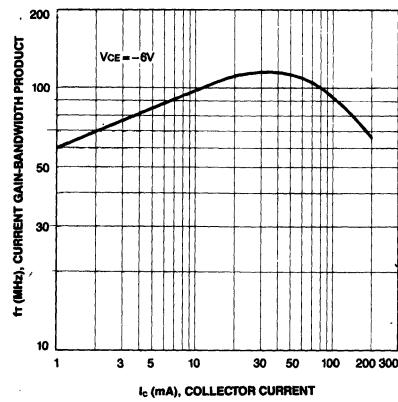
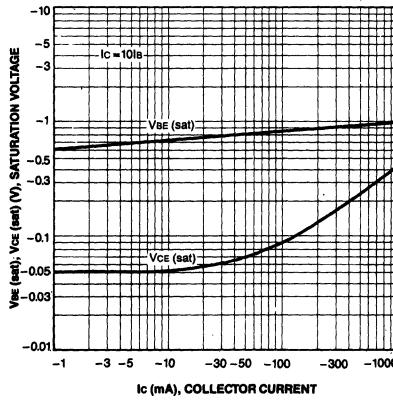
STATIC CHARACTERISTIC



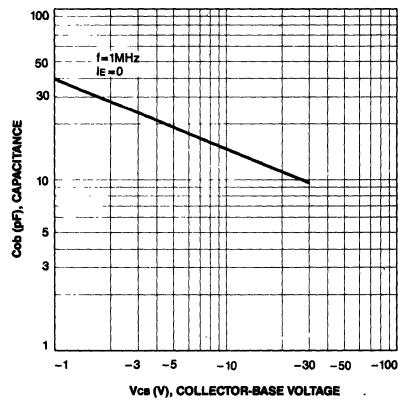
DC CURRENT GAIN



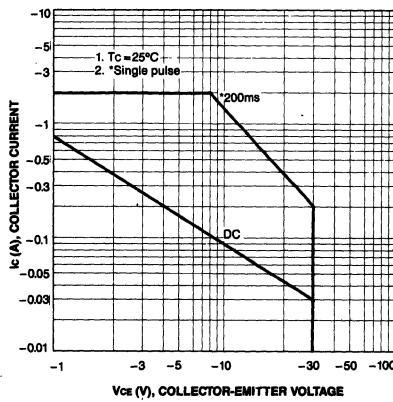
CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



SAFE OPERATING AREA



AUDIO FREQUENCY AMPLIFIER

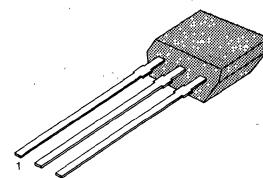
- Complement to KSD1020

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5.0	V
Collector Current (DC)	I_C	-700	mA
*Collector Current (Pulse)	I_C	-1.0	A
Collector Dissipation	P_C	350	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ\text{C}$

* PW ≤ 10 ms, duty cycle ≤ 50 %

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30\text{V}, I_E=0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-5\text{V}, I_C=0$			-100	nA
* DC Current Gain	h_{FE1}	$V_{CE}=-1\text{V}, I_C=-100\text{mA}$	70	200	400	
	h_{FE2}	$V_{CE}=-1\text{V}, I_C=-700\text{mA}$	35	100		
* Base Emitter Voltage	V_{BE}	$V_{CE}=-6\text{V}, I_C=-10\text{mA}$	-600	-640	-700	mV
* Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-700\text{mA}, I_B=-70\text{mA}$		-0.25	-0.4	V
* Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C=-700\text{mA}, I_B=-70\text{mA}$		-0.95	-1.2	V
Output Capacitance	C_{OB}	$V_{CB}=-6\text{V}, I_E=0, f=1\text{MHz}$		17	40	pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-6\text{V}, I_E=10\text{mA}$	50	160		MHz

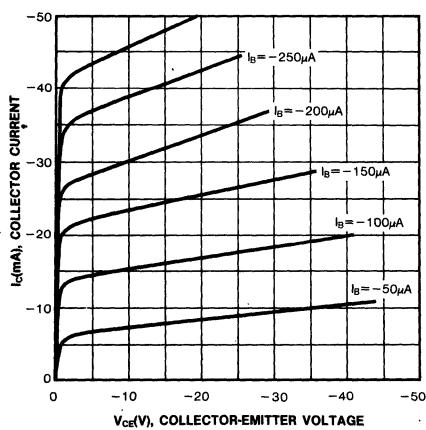
* Pulse Test: PW≤350 μs , Duty Cycle ≤ 2% Pulsed

 $h_{FE(1)}$ CLASSIFICATION

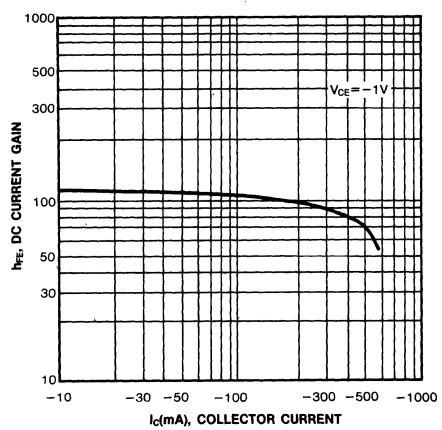
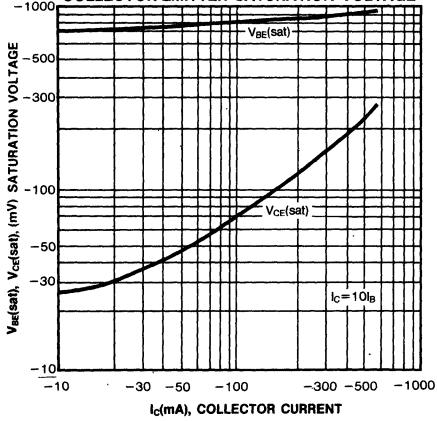
Classification	O	Y	G
$h_{FE(1)}$	70-140	120-240	200-400



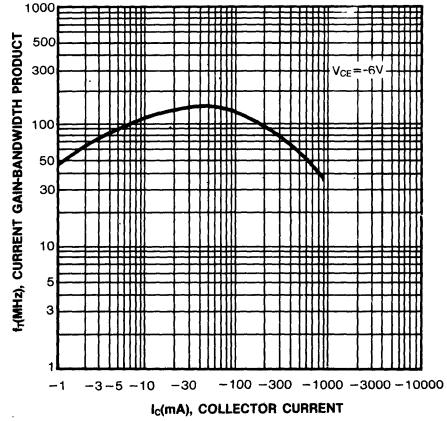
STATIC CHARACTERISTIC



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT



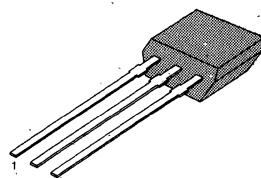
AUDIO FREQUENCY POWER AMPLIFIER

- Complement to KSD1021
- Collector Current $I_C = -1A$
- Collector Dissipation $P_C = 350mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-30	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-1.0	A
Collector Dissipation	P_C	350	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

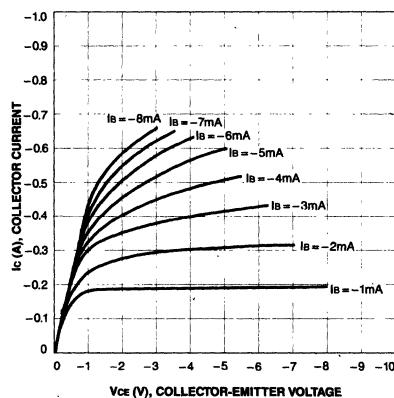
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -10mA, I_B = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	-5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$				
DC Current Gain	h_{FE}	$V_{CE} = -1V, I_C = -100mA$	70		-0.1	μA
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -1A, I_B = -0.1A$		400		V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -1A, I_B = -0.1A$		-0.5		V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = -6V, I_C = -10mA$		110		MHz
Output Capacitance	C_{ob}	$V_{CB} = -6V, f = 1 MHz, I_E = 0$		18	-1.2	pF

 h_{FE} CLASSIFICATION

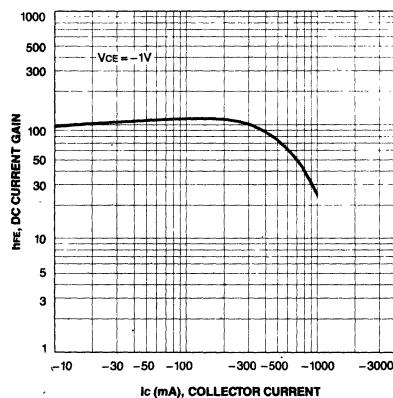
Classification	O	Y	G
h_{FE}	70-140	120-240	200-400



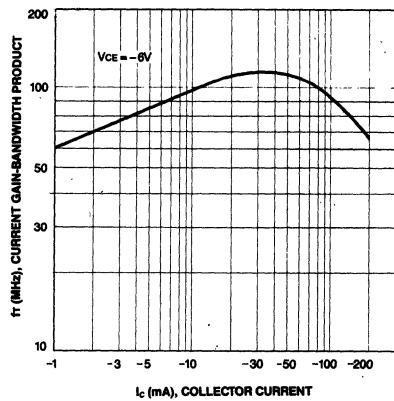
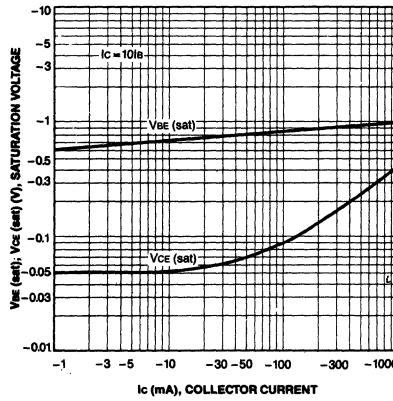
STATIC CHARACTERISTIC



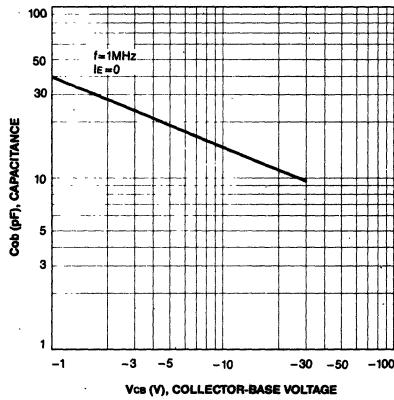
DC CURRENT GAIN



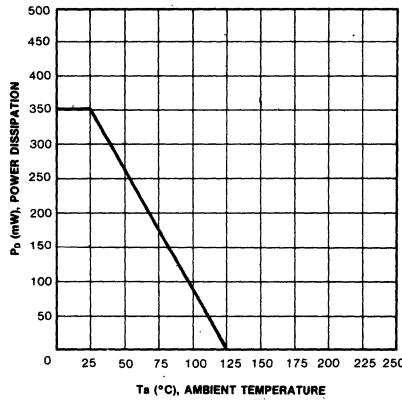
CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



POWER DERATING



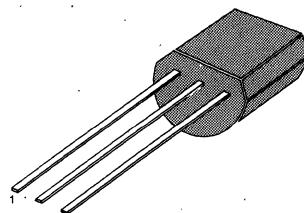
AUDIO FREQUENCY POWER AMPLIFIER MEDIUM SPEED SWITCHING

- Complement to KSD1616/1616A

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : KSB1116	V_{CBO}	-60	V
: KSB1116A		-80	V
Collector-Emitter Voltage : KSB1116	V_{CEO}	-50	V
: KSB1116A		-60	V
Emitter-Base Voltage	V_{EBO}	-6	V
Collector Current (DC)	I_c	-1	A
*Collector Current (Pulse)	I_c	-2	A
Collector Dissipation	P_c	0.75	W
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

TO-92



1. Emitter 2. Collector 3. Base

* $\text{PW} \leq 10\text{ms}$, Duty Cycle $\leq 50\%$

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = -60\text{V}, I_E = 0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -6\text{V}, I_C = 0$			-100	nA
*DC Current Gain : KSB1116	h_{FE1}	$V_{CE} = -2\text{V}, I_C = -100\text{mA}$	135		600	
: KSB1116A			135		400	
*Base Emitter On Voltage	h_{FE2}	$V_{CE} = -2\text{V}, I_C = -1\text{A}$	81			
*Collector Emitter Saturation Voltage	V_{BE} (on)	$V_{CE} = -2\text{V}, I_C = -50\text{mA}$	-600	-650	-700	mV
*Base Emitter Saturation Voltage	V_{CE} (sat)	$I_C = -1\text{A}, I_B = -50\text{mA}$		-0.2	-0.3	V
Output Capacitance	V_{BE} (sat)	$I_C = -1\text{A}, I_B = -50\text{mA}$		-0.9	-1.2	V
Cob		$V_{CB} = -10\text{V}, I_E = 0$		25		pF
Current Gain Bandwidth Product	f_T	$f = 1\text{MHz}$ $V_{CE} = -2\text{V}, I_C = -100\text{mA}$	70	120		MHz
Turn On Time	t_{on}	$V_{CC} = -10\text{V}, I_C = -100\text{mA}$		0.07		μs
Storage Time	t_s	$I_{B1} = -I_{B2} = -10\text{mA}$		0.7		μs
Fall Time	t_f	V_{BE} (off) = 2~3V		0.07		μs

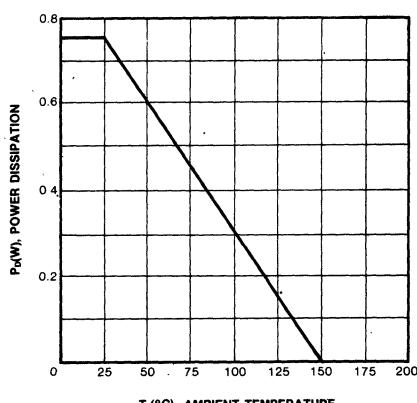
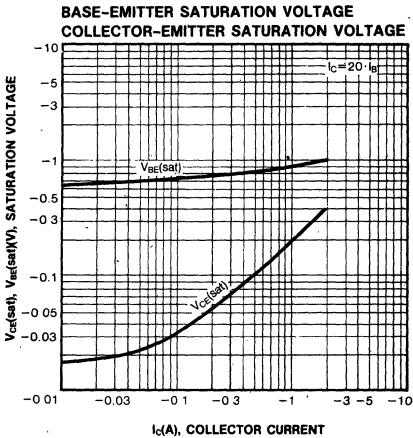
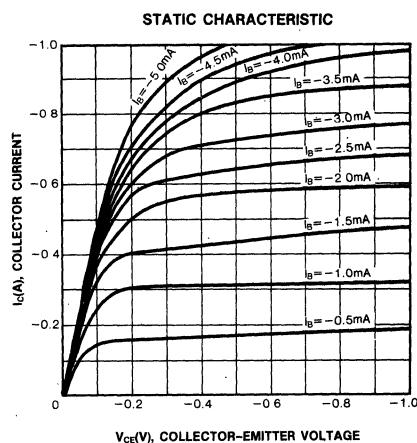
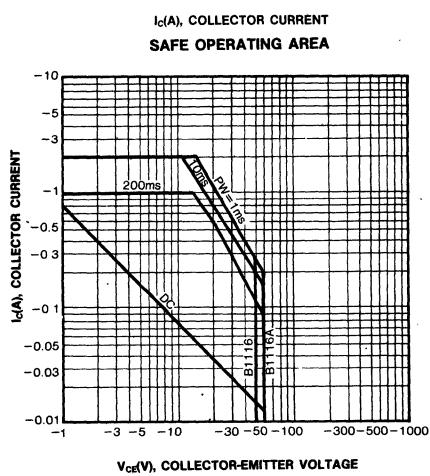
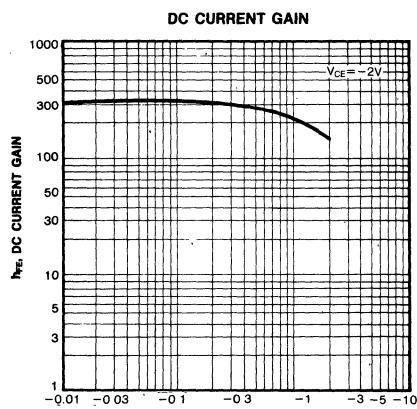
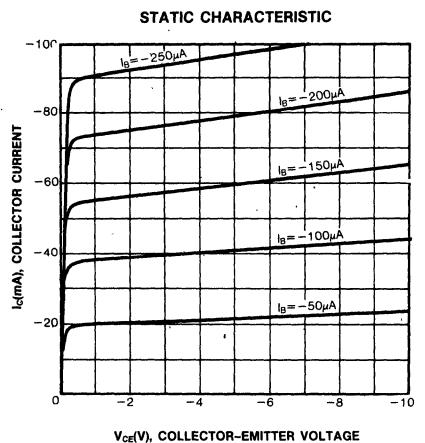
* Pulse Test: $\text{PW} \leq 350\mu\text{s}$, Duty Cycle $\leq 2\%$ Pulsed

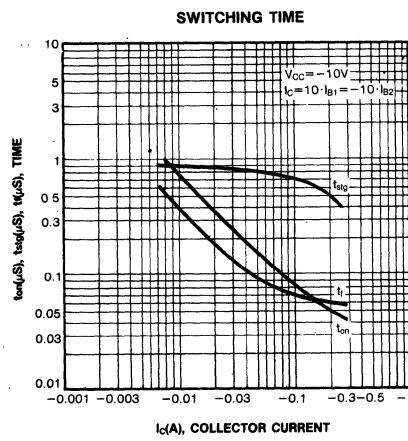
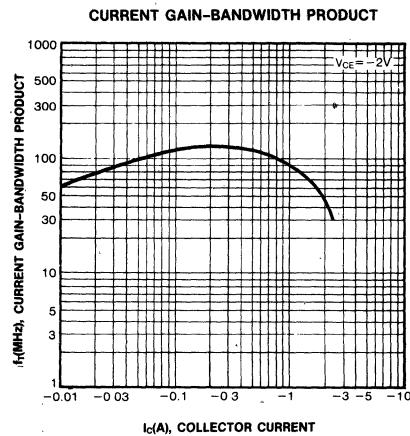
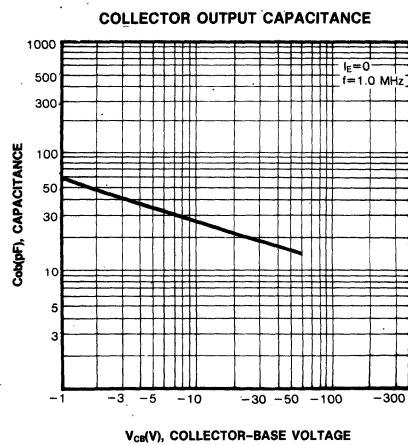
$h_{FE}(1)$ CLASSIFICATION

Classification	Y	G	L
$h_{FE}(1)$	135-270	200-400	300-600



SAMSUNG SEMICONDUCTOR





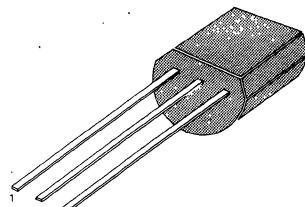
AM FREQUENCY CONVERTER IF AMPLIFIER

- Current Gain Bandwidth Product $f_T = 100\text{MHz}$ (Typ)
- Complement to KSA542

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	°C
Storage Temperature	$T_{stg.}$	-55 ~ 150	°C

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

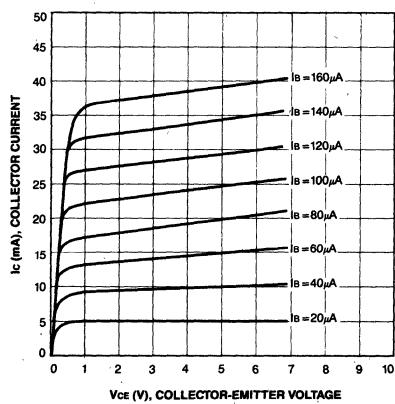
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_E = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$			1000	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$	40	0.1	0.2	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$		100		MHz
Output Capacitance	C_{ob}	$V_{CE} = 6\text{V}, I_E = 0$ $f = 1\text{MHz}$		2.6	4.4	pF

h_{FE} CLASSIFICATION

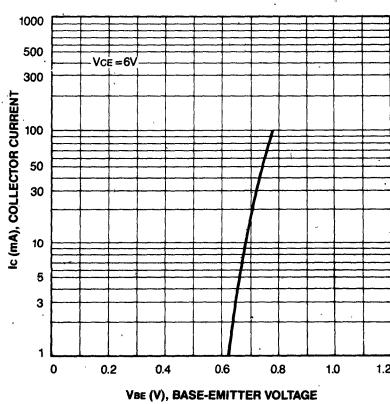
Classification	R	O	Y	G	L
h_{FE}	40-80	70-140	120-240	200-400	350-700



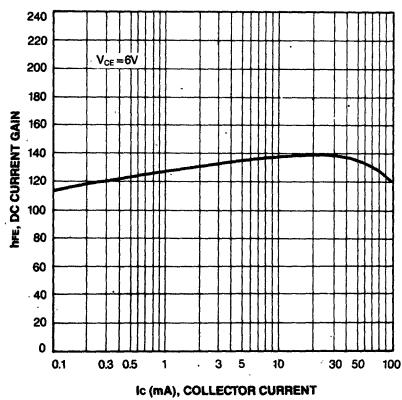
STATIC CHARACTERISTIC



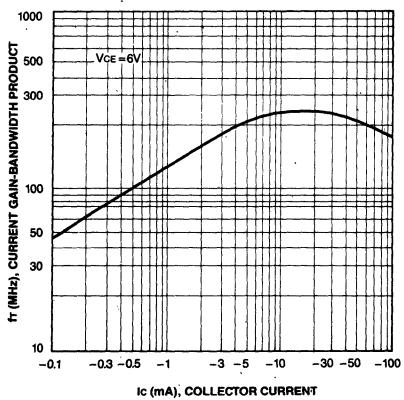
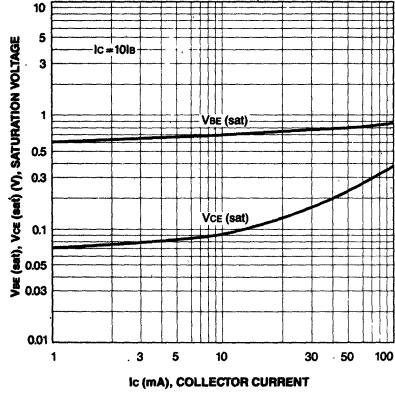
BASE-EMITTER ON VOLTAGE



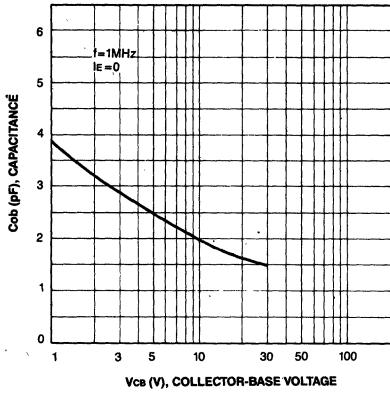
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



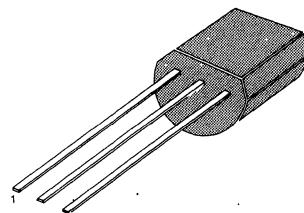
TV FINAL PICTURE IF AMPLIFIER APPLICATIONS

- $G_{Pe}=33\text{dB}$ (Typ) ($f=45\text{MHz}$)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_c	50	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



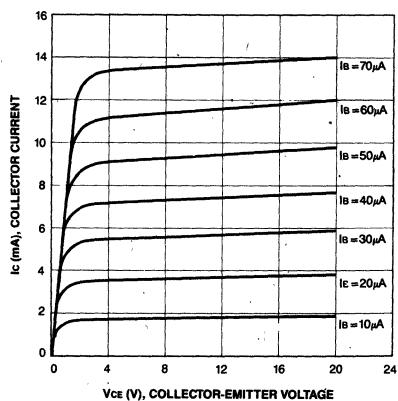
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

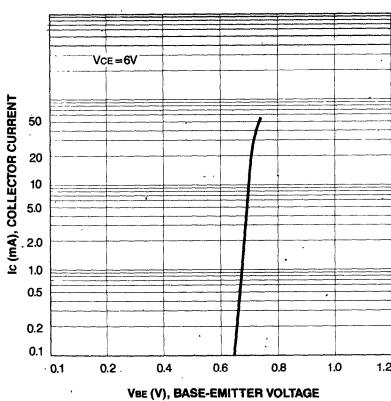
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=10\mu\text{A}, I_E=0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=5\text{mA}, I_B=0$	25			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
Emitter Cut-off Current	I_{EB0}	$V_{EB}=3\text{V}, I_c=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=12.5\text{V}, I_c=12.5\text{mA}$	20		200	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=15\text{mA}, I_B=1.5\text{mA}$			0.2	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=15\text{mA}, I_B=1.5\text{mA}$			1.5	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$	0.8		2	pF
Collector-Base Time Constant	$C_{crbb'}$	$V_{CB}=10\text{V}, I_E=-1\text{mA}$ $f=30\text{MHz}$			25	ps
Current Gain-Bandwidth Product	f_T	$V_{CE}=12.5\text{V}, I_c=12.5\text{mA}$	300			MHz
Power Gain	G_{pe}	$V_{CC}=12.5\text{V}, f=45\text{MHz}$ $I_E=-12.5\text{mA}$	28		36	dB



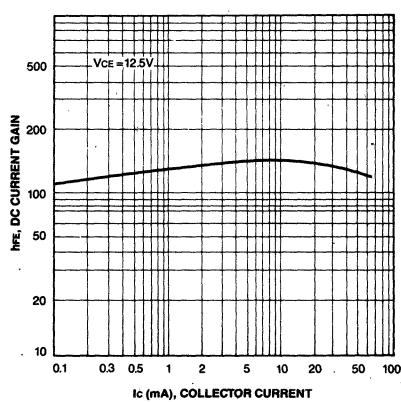
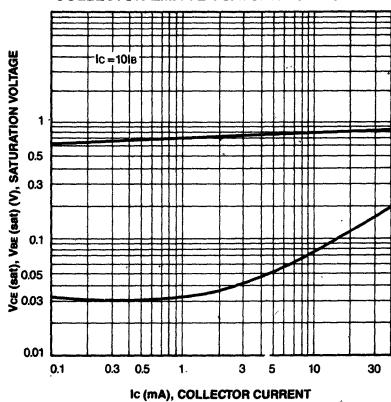
STATIC CHARACTERISTIC



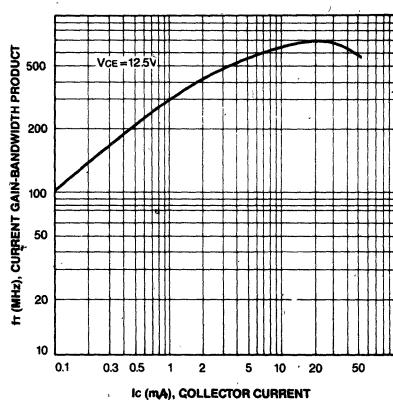
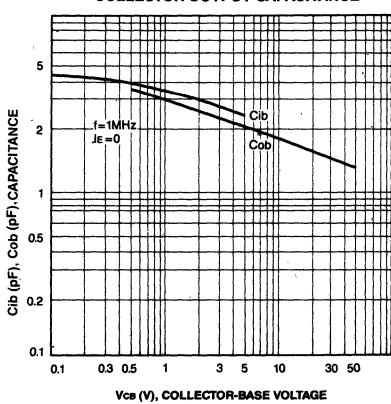
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT

COLLECTOR INPUT CAPACITANCE
COLLECTOR OUTPUT CAPACITANCE

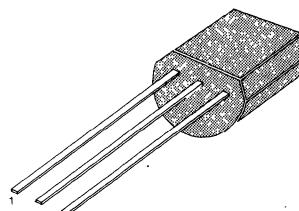
LOW FREQUENCY AMPLIFIER HIGH FREQUENCY OSCILLATOR

- Complement to KSA539
- Collector-Base Voltage $V_{CBO} = 60V$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	200	mA
Collector Dissipation	P_c	400	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

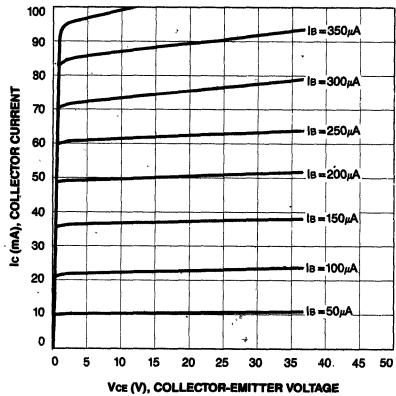
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu A, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 10mA, I_B = 0$	45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 45V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1V, I_C = 50mA$	40	400		
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$V_{CE} = 10V, I_C = 10mA$	0.6	0.65	0.9	V
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 150mA, I_B = 15mA$		0.15	0.4	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 150mA, I_B = 15mA$		0.83	1.1	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10V, I_B = 10mA$	100	200		MHz
Output Capacitance	Cob	$V_{CE} = 10V, I_E = 0$ $f = 1MHz$		4		pF

h_{FE} CLASSIFICATION

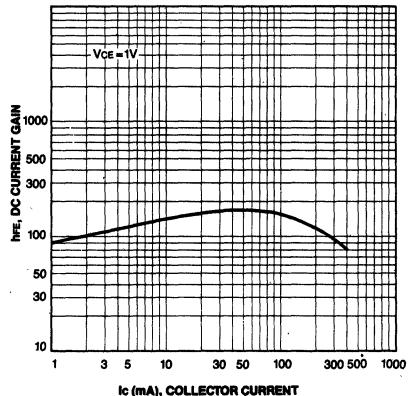
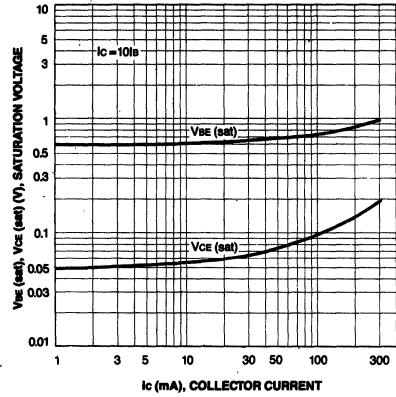
Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400



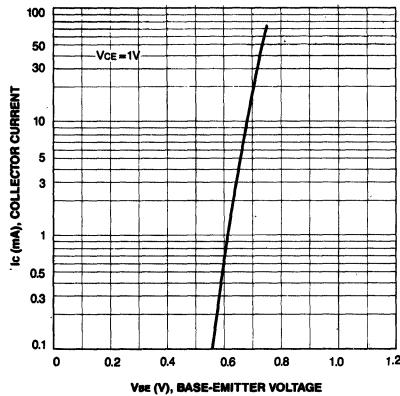
STATIC CHARACTERISTIC



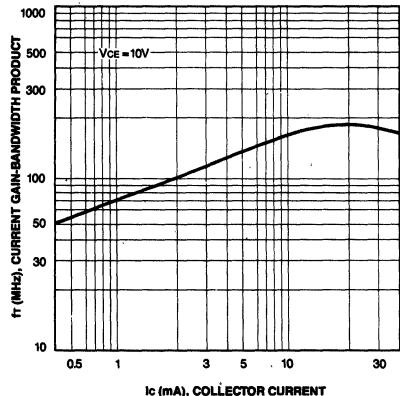
DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

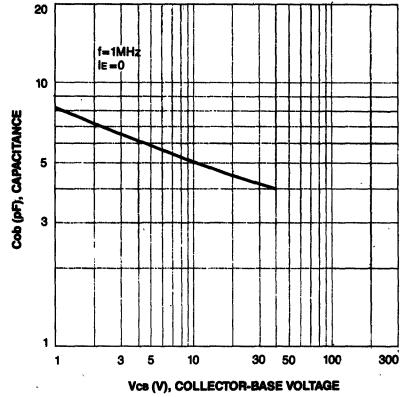
BASE-EMITTER ON VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR OUTPUT CAPACITANCE



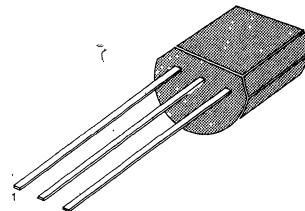
FM RADIO RF AMP, MIX, CONV, OSC, IF AMP

- High Current Gain Bandwidth Product $f_T = 250\text{MHz}$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	35	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	30	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

TO-92



1 Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

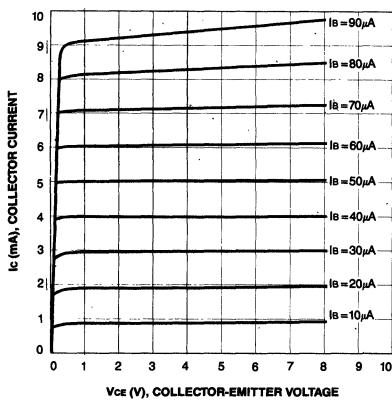
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	35			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 12\text{V}, I_C = 2\text{mA}$	40		240	
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	0.65	0.70	0.75	V
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_E = 1\text{mA}$		0.1	0.4	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 1\text{mA}$	100	250		MHz
Output Capacitance	C_{OB}	$V_{CE} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		2.0	3.2	pF

 h_{FE} CLASSIFICATION

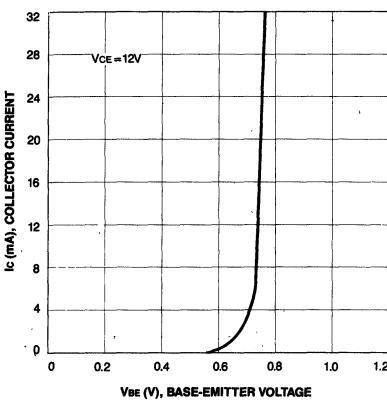
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



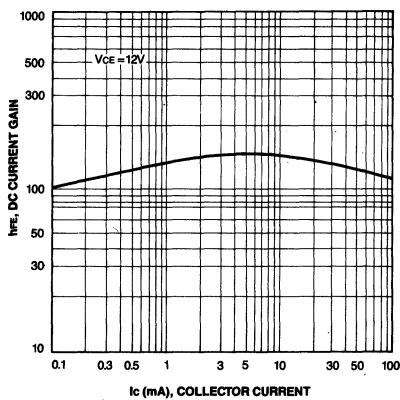
STATIC CHARACTERISTIC



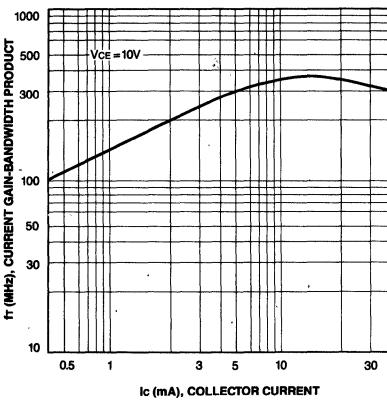
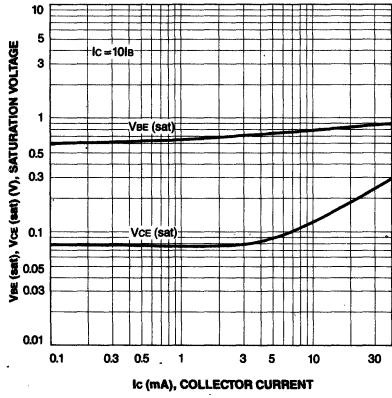
BASE-EMITTER ON VOLTAGE



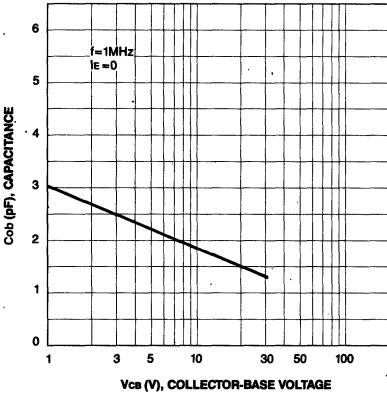
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



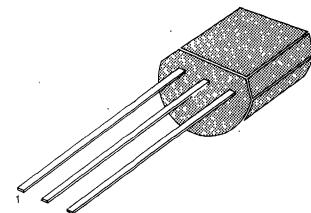
FM/AM RADIO RF AMP, CONV, OSC, IF AMP

- Current-Gain-Bandwidth Product $f_T = 200\text{MHz}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	35	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

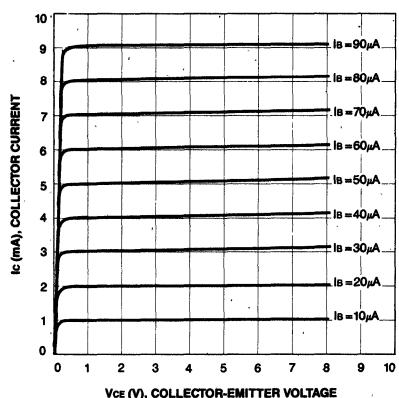
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	35			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 12\text{V}, I_C = 2\text{mA}$	40		400	
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	0.65	0.70	0.75	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.1	0.4	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 1\text{mA}$	80	200		MHz
Output Capacitance	C_{OB}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		2.0	3.5	pF

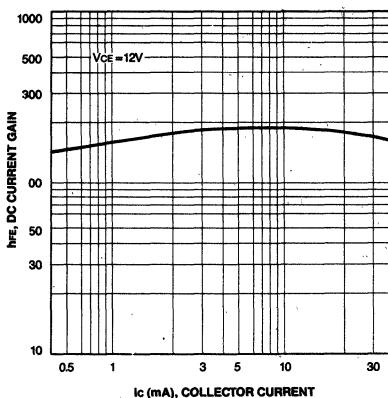
 h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

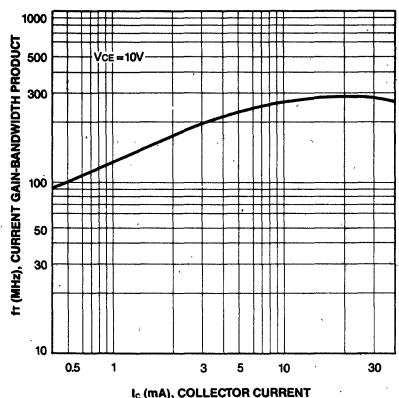
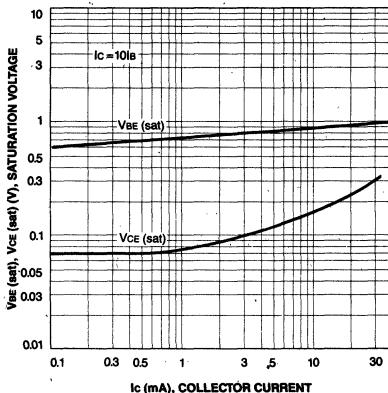
STATIC CHARACTERISTIC



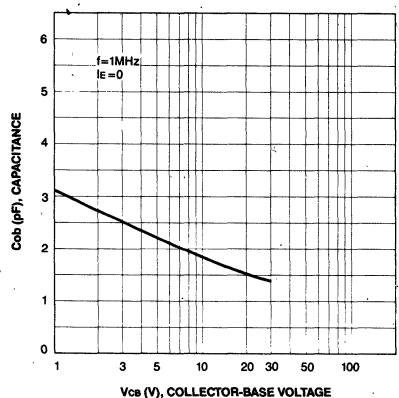
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



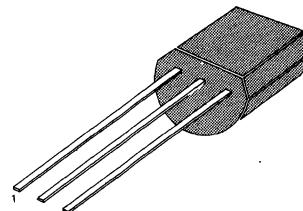
LOW FREQUENCY AMPLIFIER

- Complement to KSA545
- High Collector-Base Voltage $V_{CBO}=70V$
- Collector Dissipation $P_c=400mW$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	70	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_c	400	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

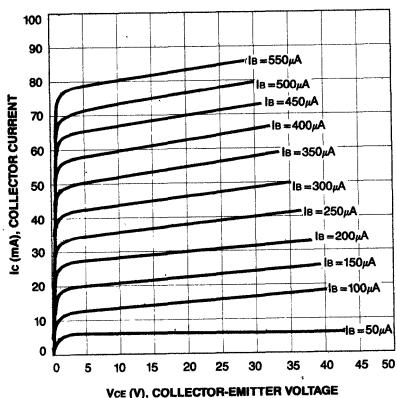
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	70			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA, I_B=0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-10\mu A, I_C=0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=45V, I_E=0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=3V, I_C=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=1V, I_C=50mA$	40		400	
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE}=10V, I_C=10mA$	0.60		0.90	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=150mA, I_B=15mA$		0.15	0.4	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=150mA, I_B=15mA$		0.83	1.1	V

 h_{FE} CLASSIFICATION

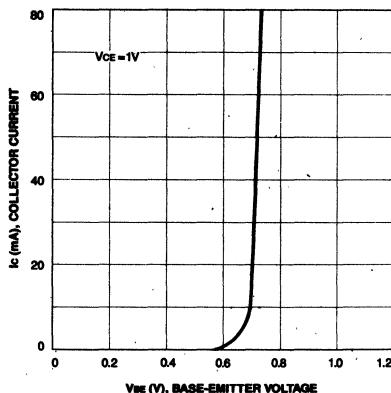
Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400



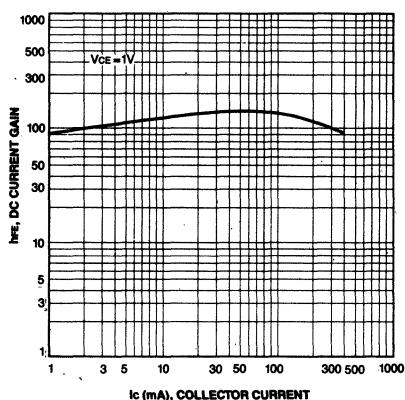
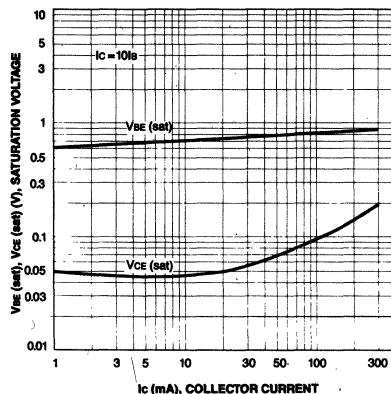
STATIC CHARACTERISTIC



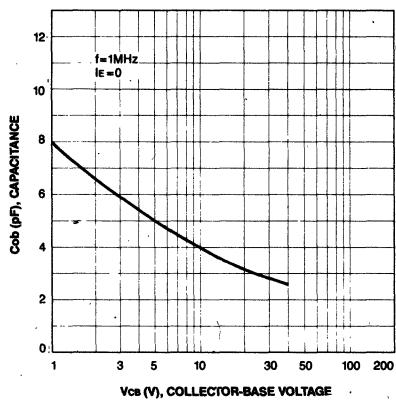
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



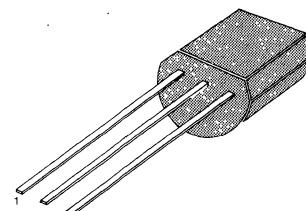
LOW FREQUENCY, LOW NOISE AMPLIFIER

- Collector-Base Voltage $V_{CBO} = 30V$
- Low Noise Level $NL = 50mV$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	50	mA
Collector Dissipation	P_c	250	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1 Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

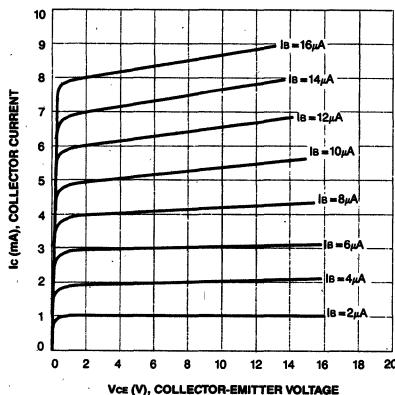
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 3V, I_C = 0.5mA$	120		1000	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 20mA, I_B = 2mA$		0.1	0.2	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 3V, I_C = 0.5mA$		0.62	0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 3V, I_C = 1mA$		100		MHz
Noise Level	NL	$V_{CC} = 12V, I_C = 0.1mA$ $R_S = 25K\Omega$ $A_V = 80dB, (f = 1KHz)$		30	50	mV

 h_{FE} CLASSIFICATION

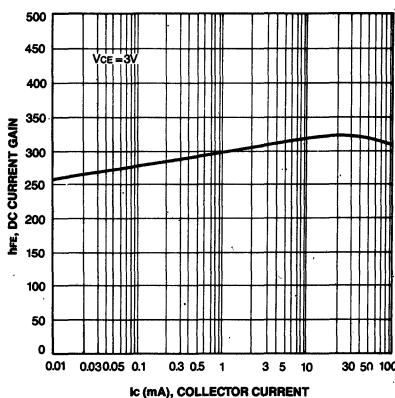
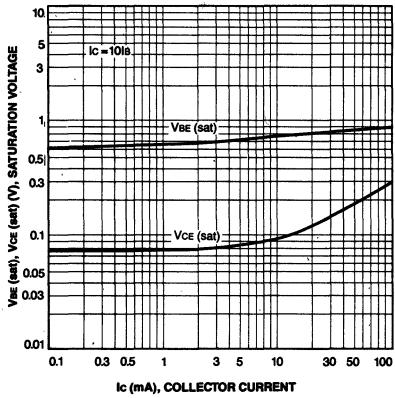
Classification	Y	G	L	V
h_{FE}	120-240	200-400	350-700	600-1000



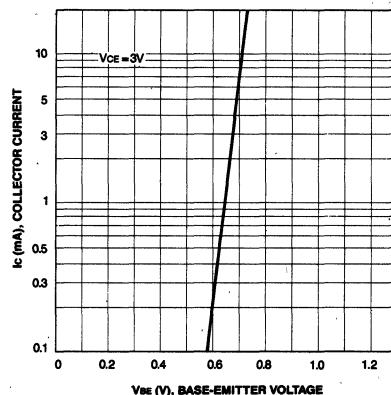
STATIC CHARACTERISTIC



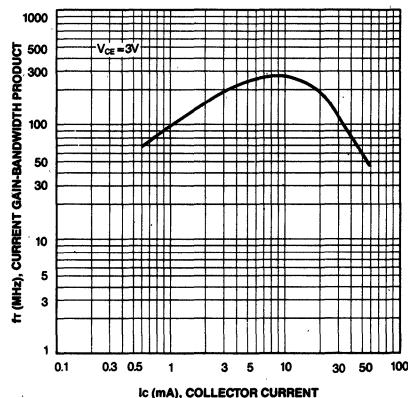
DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

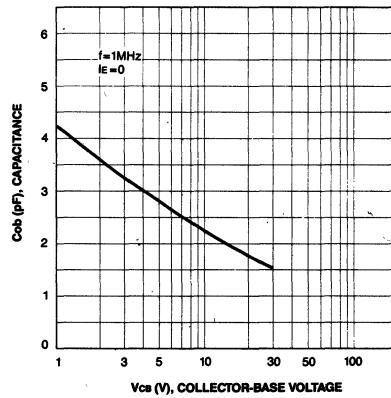
BASE-EMITTER ON VOLTAGE

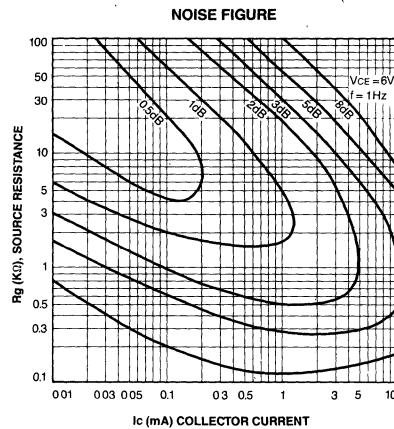
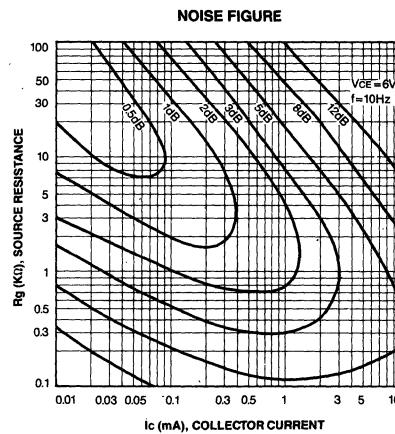
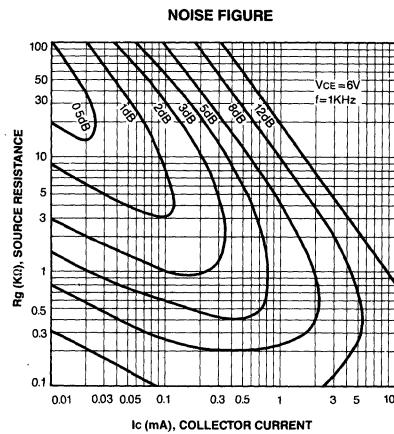


CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR OUTPUT CAPACITANCE





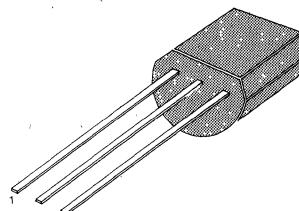
**FM CONVERTER, OSCILLATOR
HIGH FREQUENCY AMPLIFIER**

- High Current Gain Bandwidth Product $f_T = 250\text{MHz}$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	35	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

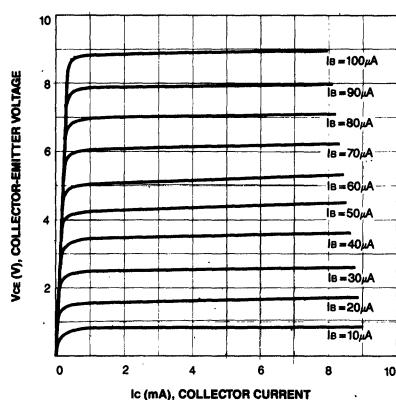
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	35			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			0.1	μA
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 1\text{mA}$	100	250		MHz
Output Capacitance	C_{OB}	$V_{CB} = 10\text{V}, I_E = 0$		2.0	3.5	pF
DC Current Gain	h_{FE}	$f = 1\text{MHz}$				
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$V_{CE} = 10\text{V}, I_C = 2\text{mA}$	40		240	V
Collector-Base Time Constant	$C_{crbb'}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$			0.6	
		$V_{CB} = 10\text{V}, I_E = -1\text{mA}$			75	ps
		$f = 31.9\text{MHz}$				

 h_{FE} CLASSIFICATION

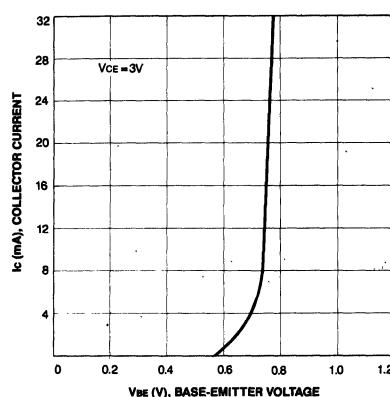
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



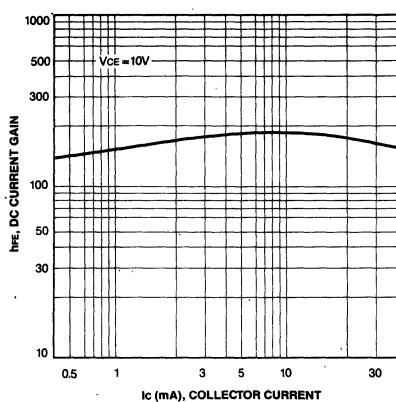
STATIC CHARACTERISTIC



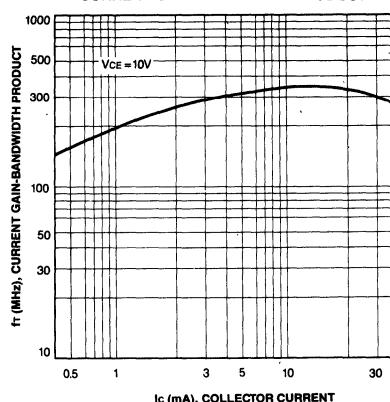
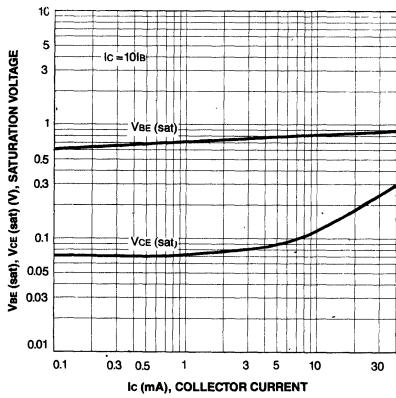
BASE-EMITTER ON VOLTAGE



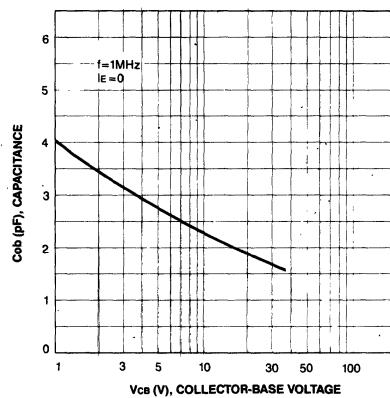
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE

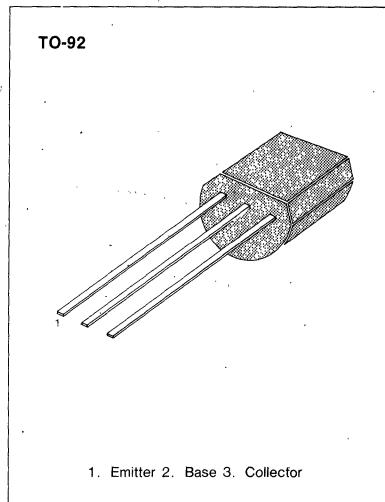


AUDIO FREQUENCY AMPLIFIER HIGH FREQUENCY OSC.

- Complement to KSA733
- Collector-Base Voltage $V_{CBO} = 60V$
- High Current Gain Bandwidth Product $f_T = 300MHz$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	150	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

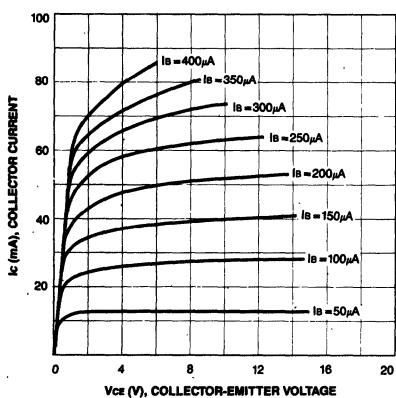
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	50			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6V, I_C = 1.0mA$	70	700		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 100mA, I_B = 10mA$		0.15	0.3	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 6V, I_C = 10mA$		300		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6V, I_E = 0$ $f = 1MHz$		2.5		pF
Noise Figure	NF	$V_{CE} = 6V, I_E = -0.5mA$ $f = 1KHz, R_S = 500\Omega$		4.0		dB

h_{FE} CLASSIFICATION

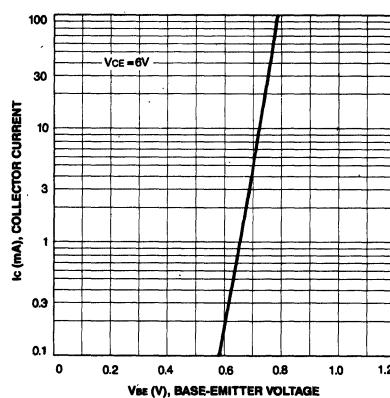
Classification	O	Y	G	L
h_{FE}	70-140	120-240	200-400	350-700



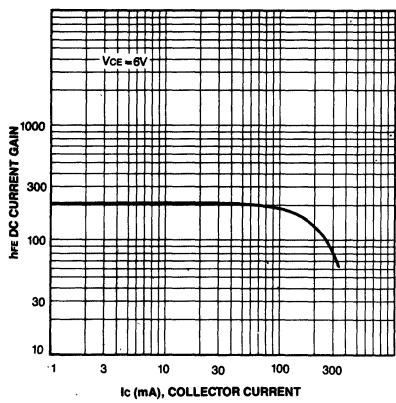
STATIC CHARACTERISTIC



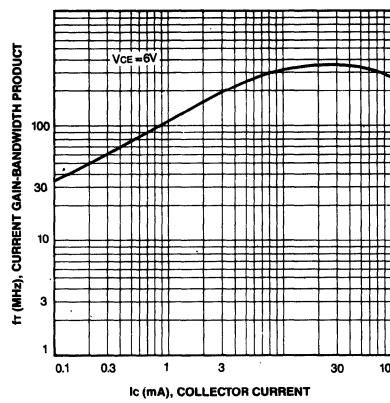
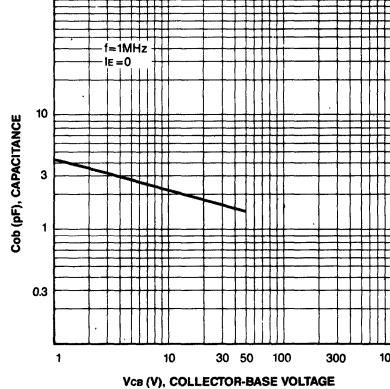
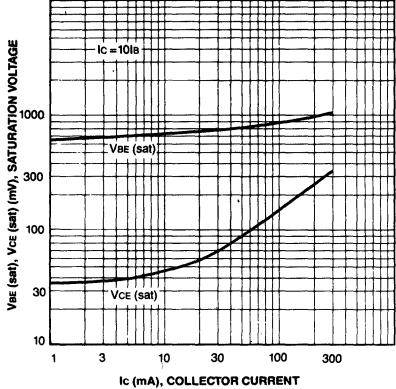
TRANSFER CHARACTERISTIC



DC CURRENT GAIN



CURRENT GAIN BANDWIDTH PRODUCT

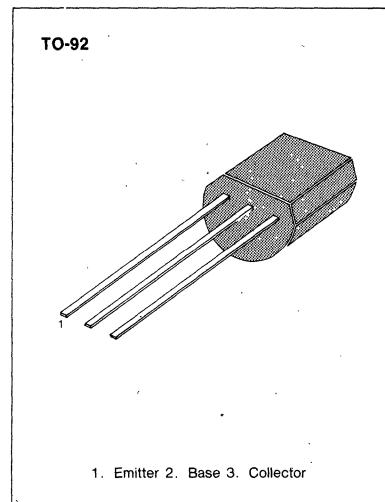
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

LOW FREQUENCY AMPLIFIER MEDIUM SPEED SWITCHING

- Complement to KSA708
- High Collector-Base Voltage $V_{CBO}=80V$
- Collector Current $I_C=700mA$
- Collector Dissipation $P_C=800mW$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	80	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	8	V
Collector Current	I_C	700	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	80			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA, I_B=0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-10\mu A, I_C=0$	8			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=60V, I_E=0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=5V, I_C=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=2V, I_C=50mA$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=500mA, I_B=50mA$		0.2	0.4	V
Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C=500mA, I_B=50mA$		0.86	1.1	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=50mA$	30	50		MHz
Output Capacitance	C_{OB}	$V_{CB}=10V, I_E=0$ $f=1MHz$		8		pF

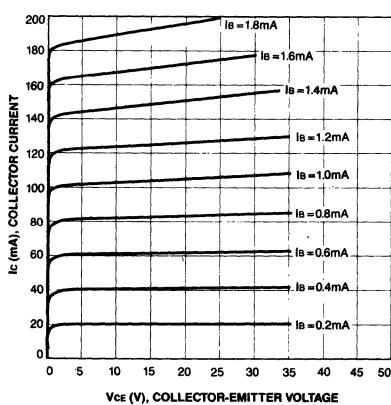
h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400

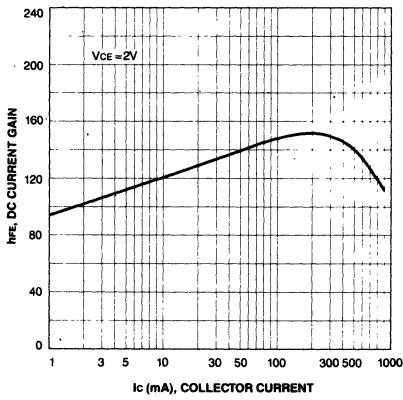


SAMSUNG SEMICONDUCTOR

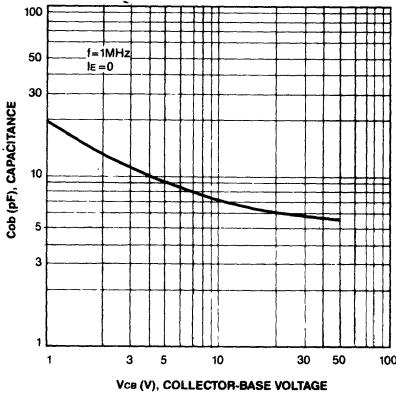
STATIC CHARACTERISTIC



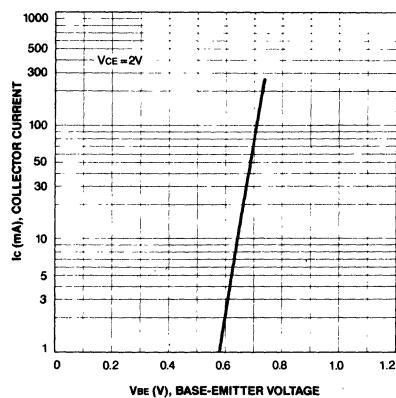
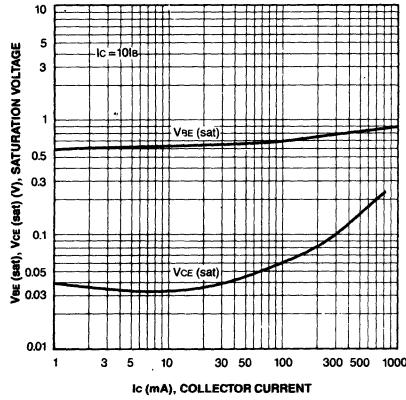
DC CURRENT GAIN



COLLECTOR OUTPUT CAPACITANCE



BASE-EMITTER ON VOLTAGE

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

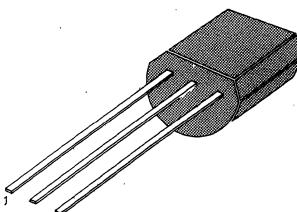
HIGH VOLTAGE AMPLIFIER

- High Collector-Base Voltage $V_{CBO} = 160V$
- Collector Current $I_C = 700mA$
- Collector Dissipation $P_C = 800mW$
- Complement to KSA709

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	160	V
Collector-Emitter Voltage	V_{CEO}	140	V
Emitter-Base Voltage	V_{EBO}	8	V
Collector Current	I_C	700	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

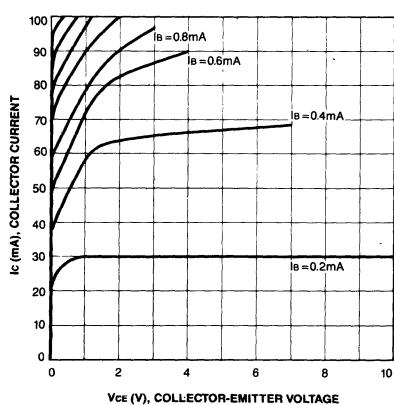
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	160			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	140			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	8			V
Collector Cut-off Current (Continuous)	I_{CBO}	$V_{CB} = 60V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 2V, I_C = 50mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 200mA, I_B = 20mA$		0.2	0.7	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 200mA, I_B = 20mA$		0.86	1.0	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10V, I_C = 50mA$	30	50		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$		8		pF

 h_{FE} CLASSIFICATION

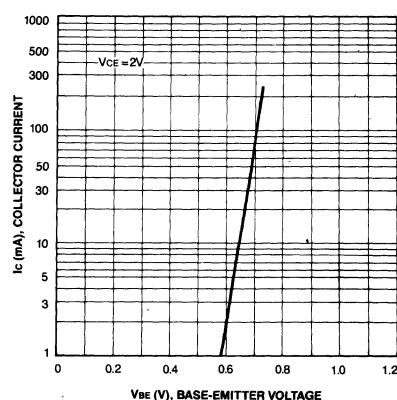
Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400



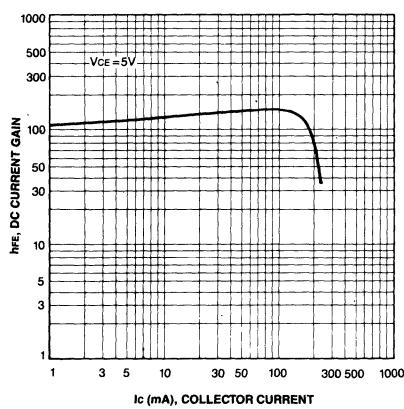
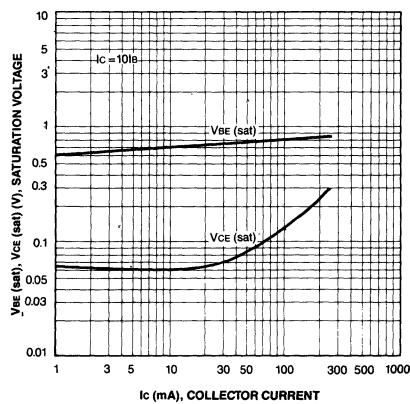
STATIC CHARACTERISTIC



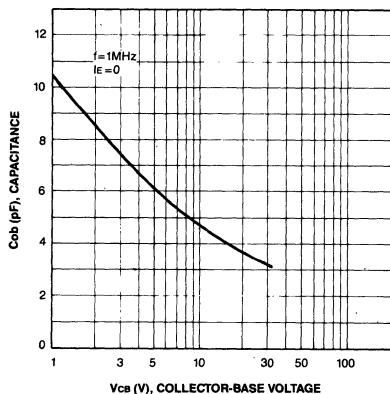
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



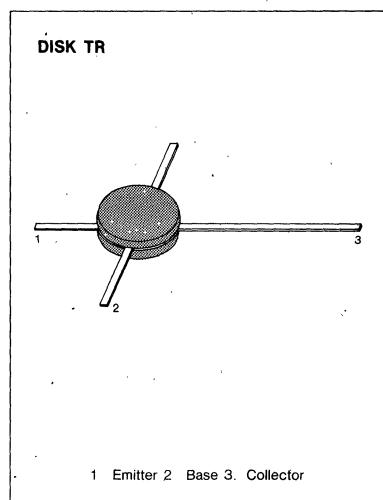
UHF TV TUNER RF AMPLIFIERLIFIER, MIXER

DISK MOLD

HIGH PG, LOW NF (PG: 18dB, NF: 2.8dB, @900MHz)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	3.0	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$



ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=25\text{V}, I_E=0$	40	80	0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=3\text{mA}$	750	1000	200	MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_E=-3\text{mA}$		0.55	0.8	pF
Output Capacitance	C_{OB}	$f=1\text{MHz}, V_{CB}=10\text{V}, I_E=0$		2.8	4.0	dB
Noise Figure	NF	$V_{CB}=10\text{V}, I_E=-3\text{mA}$ $f=900\text{MHz}$				
Power Gain	PG	$V_{CB}=10\text{V}, I_E=-3\text{mA}$ $f=900\text{MHz}$	14	18		dB
AGC Current: Only to C1070 (1)	I_{AGC}	I_E of PG -30dB $f=900\text{MHz}$	-8		-11	mA

KSC1070 (1): I_{AGC} Classification P: -9~ -11mA

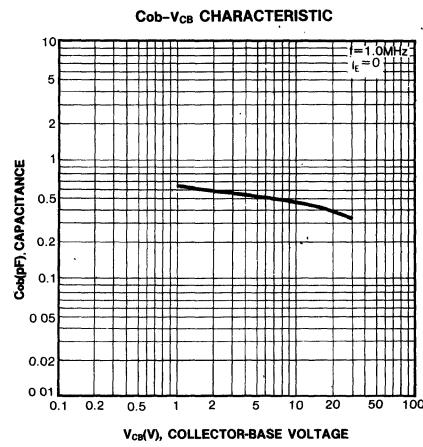
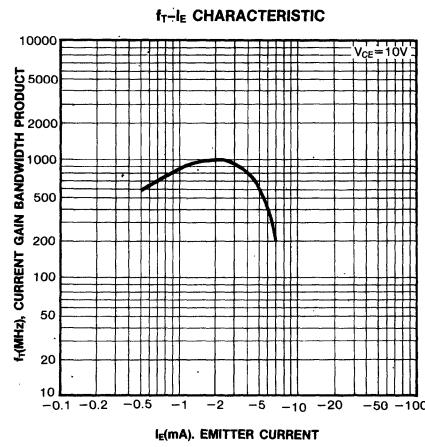
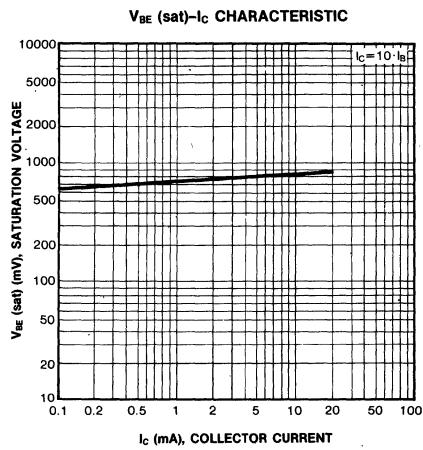
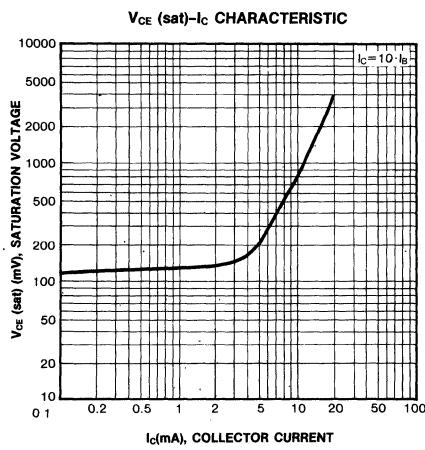
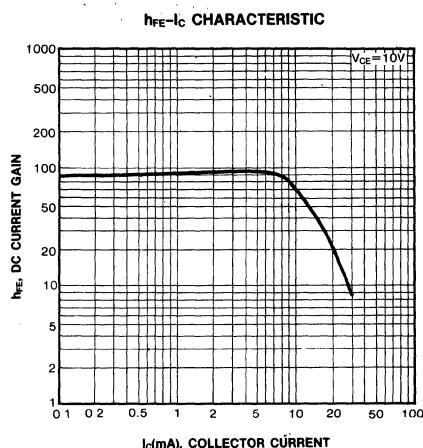
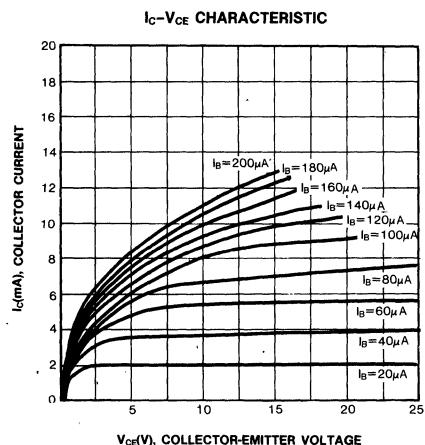
Q: -8~ -10mA

KSC1070 (2): h_{FE} Classification F: 40~200

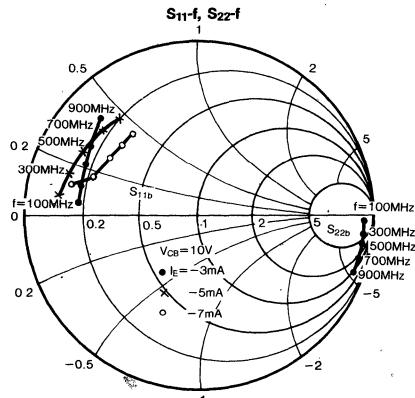
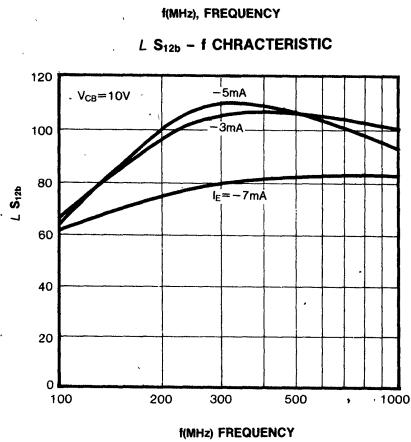
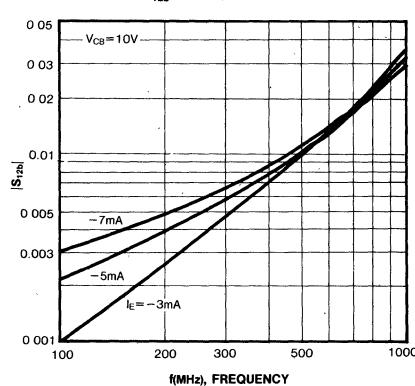
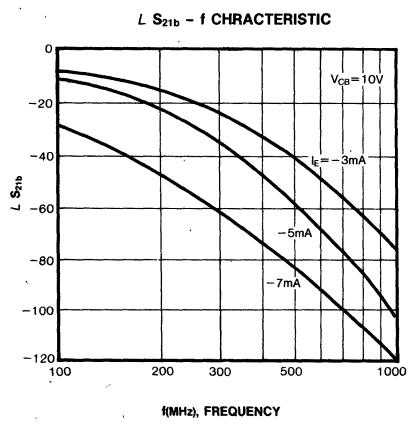
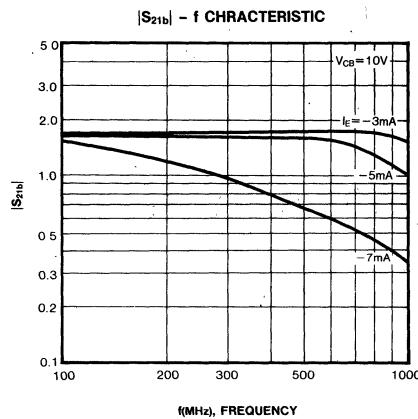
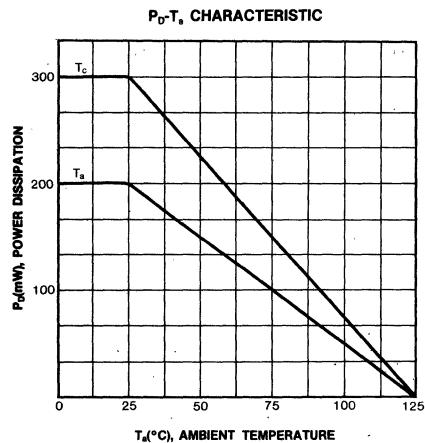


SAMSUNG SEMICONDUCTOR

KSC1070 (1)/1070 (2) NPN EPITAXIAL SILICON TRANSISTOR

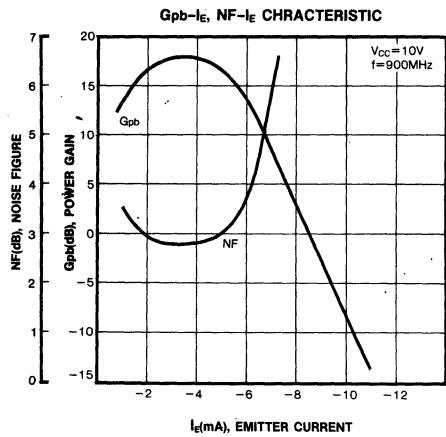
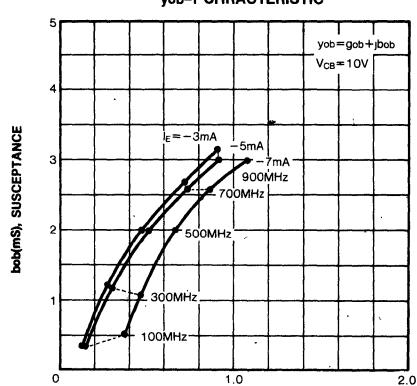
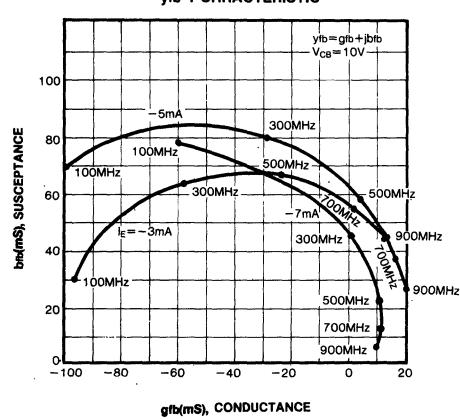
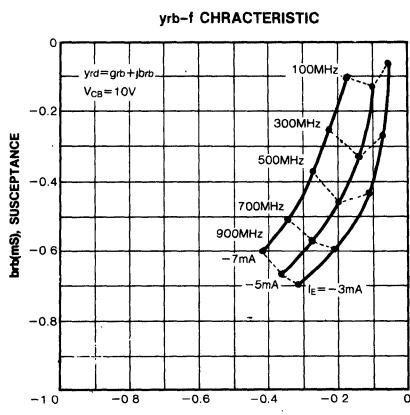
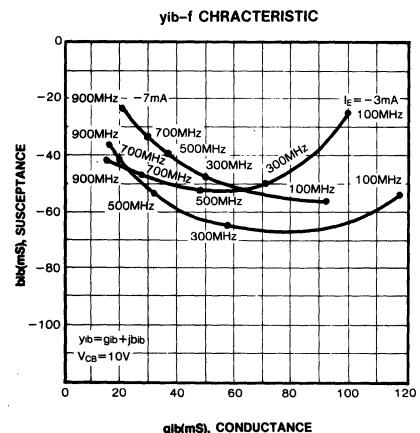


KSC1070 (1)/1070 (2) NPN EPITAXIAL SILICON TRANSISTOR

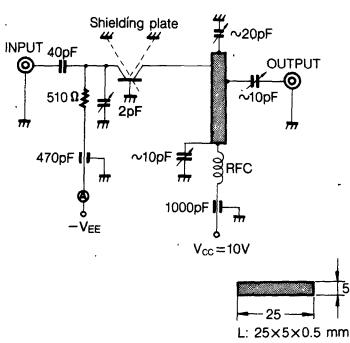


SAMSUNG SEMICONDUCTOR

KSC1070 (1)/1070 (2) NPN EPITAXIAL SILICON TRANSISTOR



900 MHz PG, NF TEST CIRCUIT

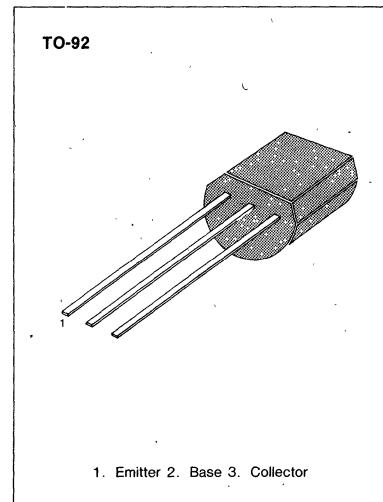


LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA707
- Collector-Base Voltage $V_{CBO} = 60V$
- Collector Dissipation $P_c = 800mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	700	mA
Collector Dissipation	P_c	800	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

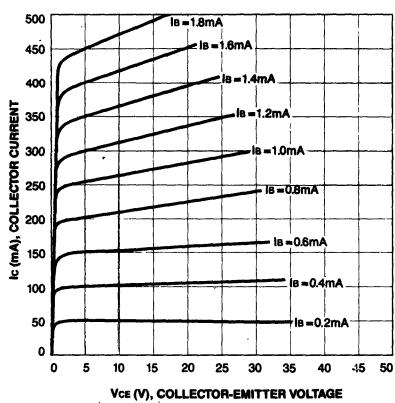
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 2V, I_C = 50mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 0.5A, I_B = 50mA$		0.24	0.4	V
Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C = 0.5A, I_B = 50mA$	0.7	0.89	1.1	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$			12	pF

 h_{FE} CLASSIFICATION

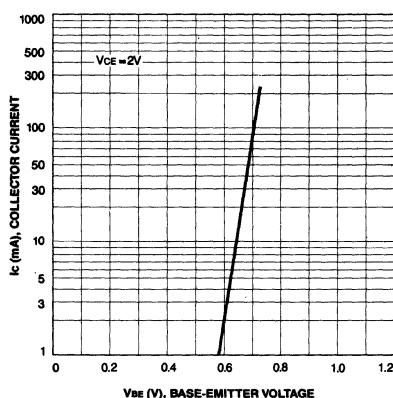
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



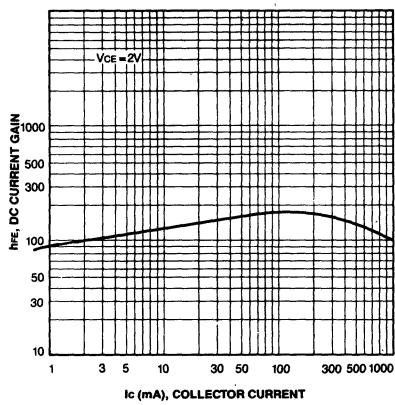
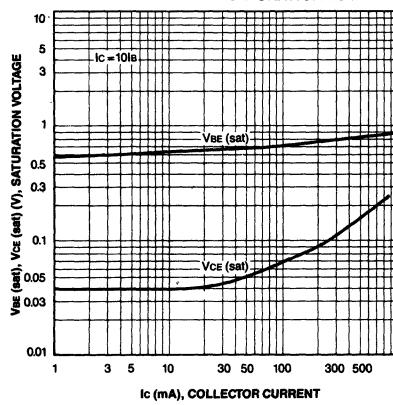
STATIC CHARACTERISTIC



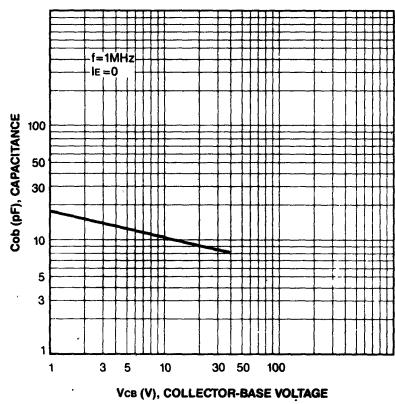
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



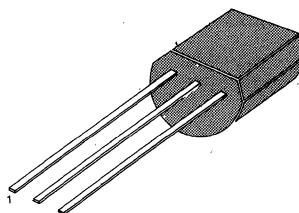
TV 1ST, 2ND PICTURE IF AMPLIFIER (FORWARD AGC)

- High Current Gain Bandwidth Product $f_T = 700\text{MHz}$
- High Power Gain $G_{PE} = 24\text{dB}$ (Typ) at 45MHz

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	30	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

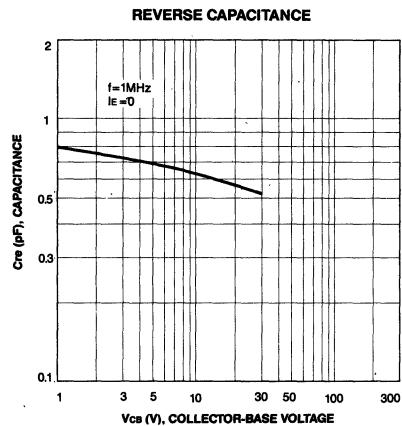
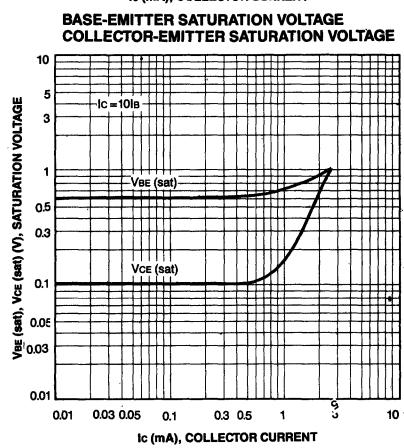
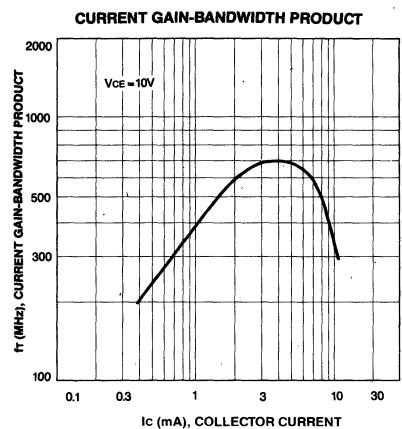
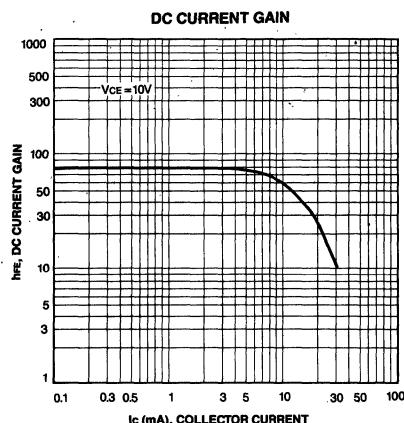
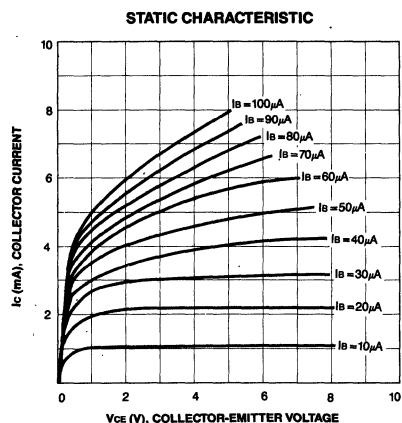
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CE} = 20\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 2\text{mA}$	40		240	
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 3\text{mA}$	400	700		MHz
Reverse Transfer Capacitance	C_{re}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		0.6		pF
Power Gain	G_{PE}	$V_{CE} = 10\text{V}, I_E = -3\text{mA}$ $f = 45\text{MHz}$	20	24		dB
AGC Voltage	V_{AGC}	$G_{PE} = -30\text{dB}$ $f = 45\text{MHz}$	4.4	5.2	6.0	V

h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



SAMSUNG SEMICONDUCTOR



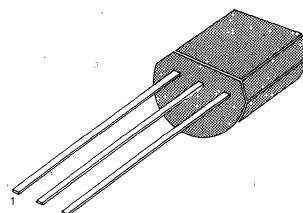
TV PIF AMPLIFIER

- High Current Gain Bandwidth Product $f_T = 700\text{MHz}$
- High Power Gain $G_{pe} = 25\text{dB}$ at 45MHz (Min)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	30	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

TO-92



1. Base 2. Emitter 3. Collector

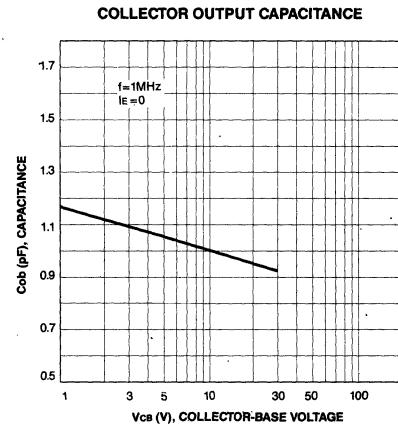
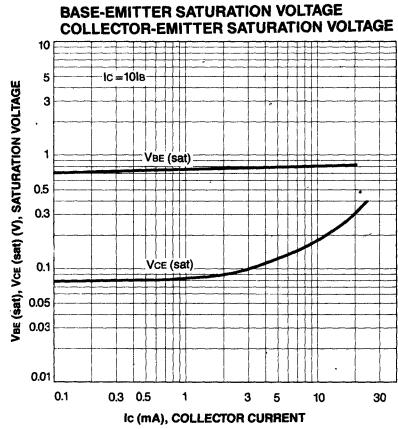
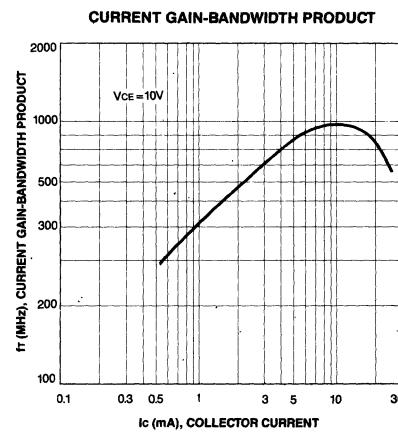
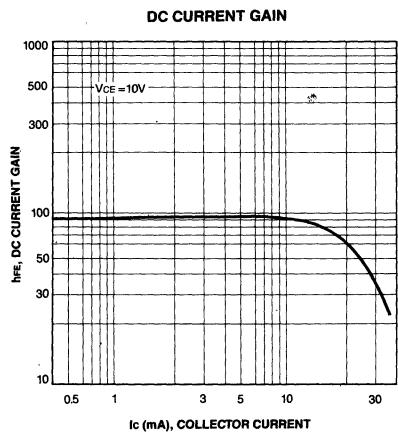
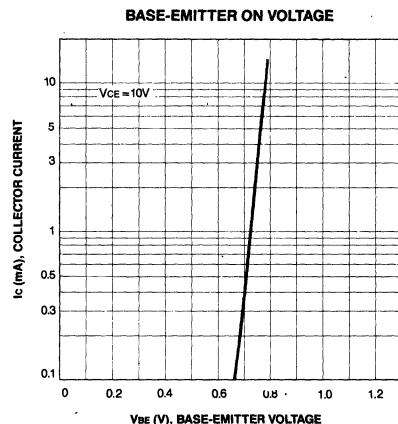
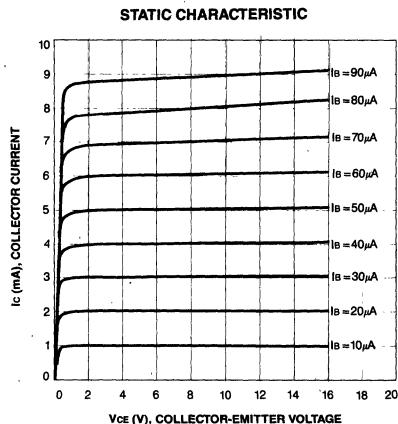
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 2\text{mA}$	40	700	240	MHz
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10, I_C = 3\text{mA}$	400			V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_E = 1\text{mA}$		0.2	0.7	pF
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$			1	dB
Power Gain	G_{pe}	$I_C = 10\text{mA}, V_{CE} = 6\text{V}$ $f = 45\text{MHz}, R_S = 50\Omega$	20	24		

 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



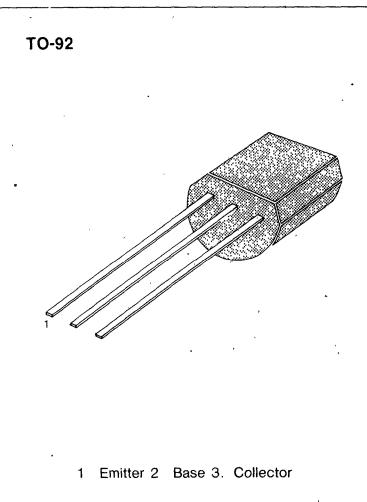


LOW FREQUENCY LOW NOISE AMPLIFIER

- Collector-Base Voltage $V_{CBO} = 50V$
- Low Noise Level $NL = 40mV$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$) ***

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 50V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_C = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 3V, I_C = 0.5mA$	120		1000	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 20mA, I_B = 2mA$		0.1	0.2	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$V_{CE} = 3V, I_C = 0.5mA$		0.62	0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 3V, I_C = 1mA$	50	100		MHz
Noise Level	NL	$V_{CE} = 12V, I_E = -0.1mA$ $R_s = 25K\Omega$ $A_v = 80dB, (f=1KHz)$		27	40	mV

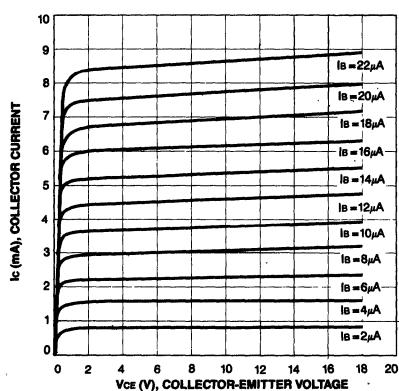
 h_{FE} CLASSIFICATION

Classification	Y	G	L	V
h_{FE}	120-240	200-400	350-700	600-1000

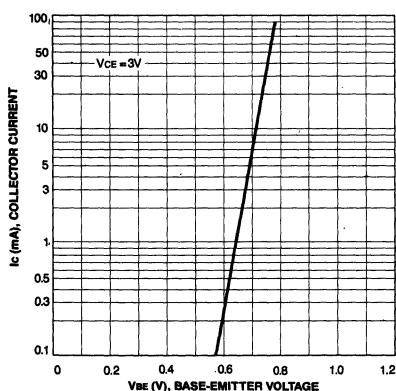


SAMSUNG SEMICONDUCTOR

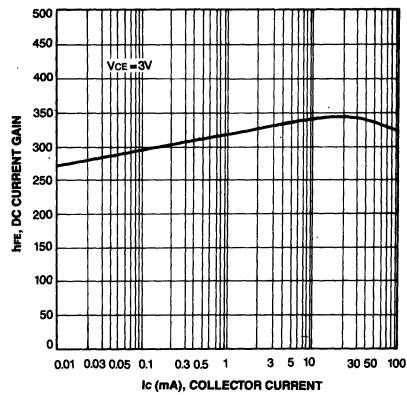
STATIC CHARACTERISTIC



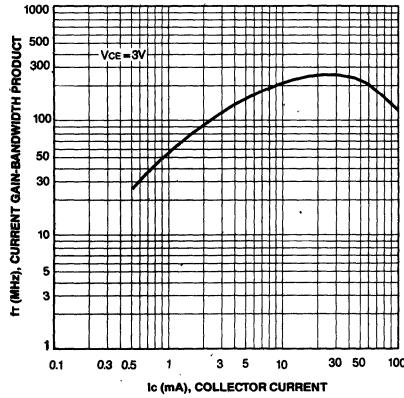
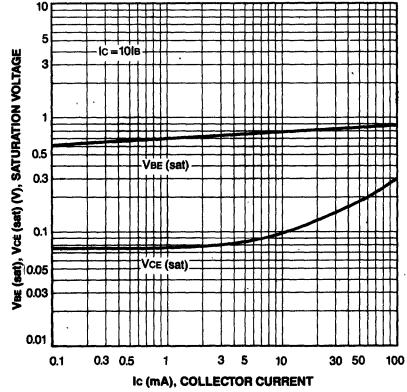
BASE-EMITTER ON VOLTAGE



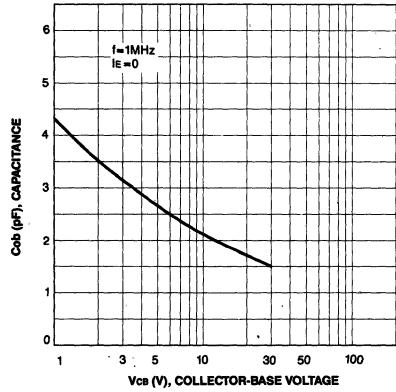
DC CURRENT GAIN

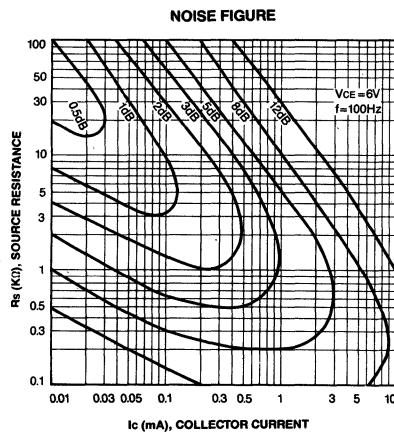
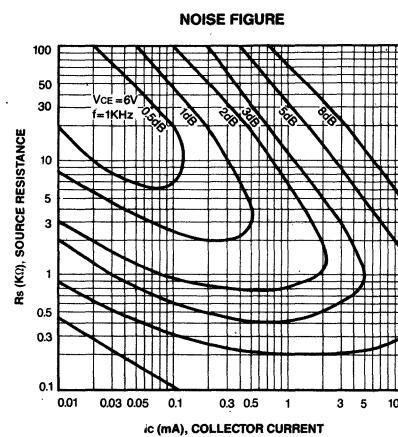
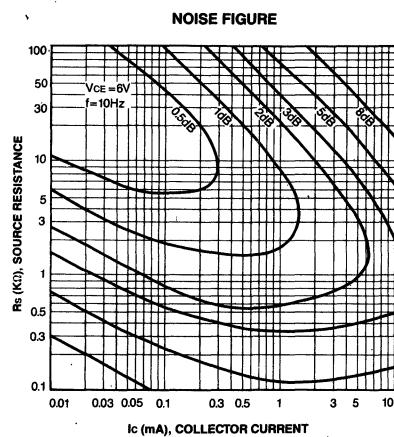


CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE





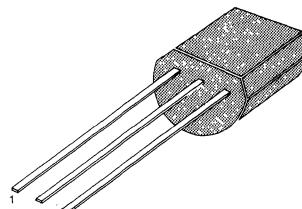
GENERAL PURPOSE AMPLIFIER

- Collector-Base Voltage $V_{CBO} = 50V$
- Collector Dissipation $P_c = 400mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_c	400	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1 Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

3

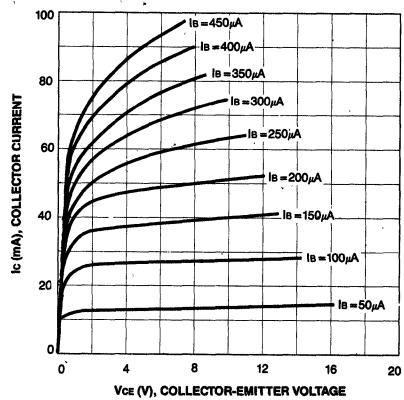
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_E = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6V, I_C = 1mA$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 30mA, I_E = 3mA$		0.08	0.50	V
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$V_{CE} = 6V, I_C = 1.0mA$		0.62	0.80	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 6V, I_C = 10mA$		300		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6V, I_E = 0$ $f = 1MHz$		2.5		pF

 h_{FE} CLASSIFICATION

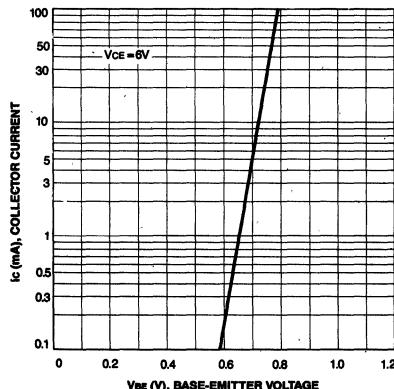
Classification	O	Y	G
h_{FE}	70-140	120-240	200-400



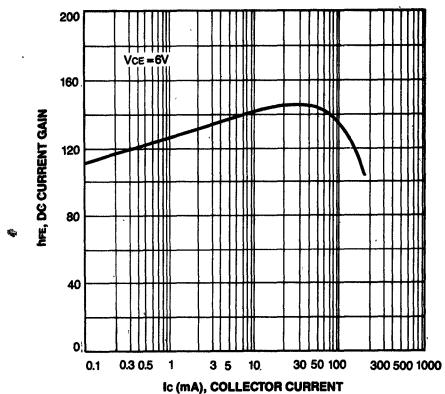
STATIC CHARACTERISTIC



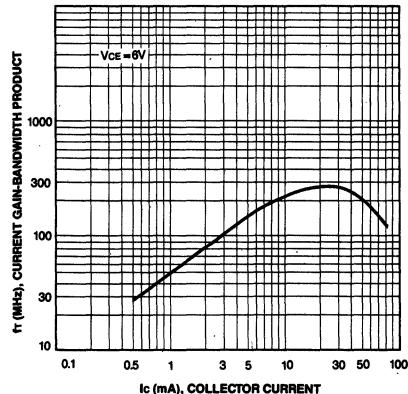
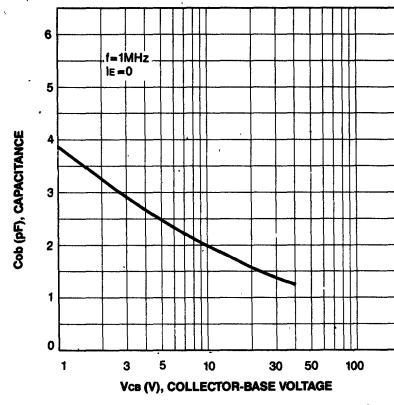
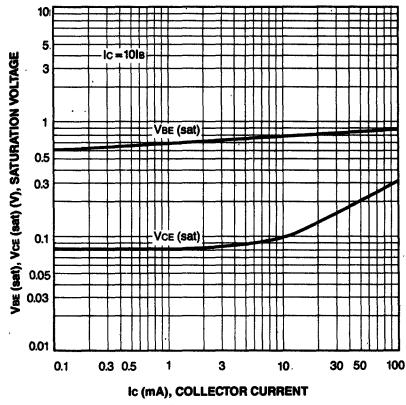
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

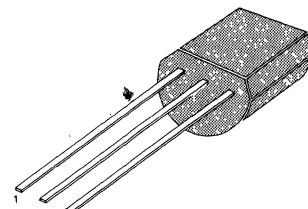
TV VHF TUNER RF AMPLIFIER (FORWARD AGC)

- High Current Gain Bandwidth Product $f_T = 700\text{MHz}$ (Typ)
- Low Noise Figure $NF = 3.0\text{dB}$ (Max) at $f = 200\text{MHz}$
- Low Reverse Transfer Capacitance $C_{RE} = 0.5\text{pF}$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

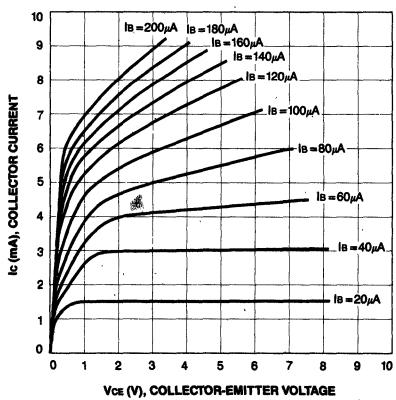
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_E = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 2\text{mA}$	40		180	
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 3\text{mA}$	400	700	400	MHz
Reverse Transfer Capacitance	C_{RE}	$f = 1\text{MHz}, V_{CB} = 10\text{V}$ $I_E = 0$		0.35	0.5	pF
Power Gain	G_P	$f = 200\text{MHz}, I_E = -3\text{mA}$ $R_S = 50\Omega, V_{CE} = 10\text{V}$	20	24		dB
AGC Current	I_{AGC}	I_E at $G_P = -30\text{dB}$ $f = 200\text{MHz}$		-10	-12	mA
Noise Figure	NF	$f = 200\text{MHz}, I_E = -3\text{mA}$ $V_{CE} = 10\text{V}, R_S = 50\Omega$		2.0	3.0	dB

h_{FE} CLASSIFICATION

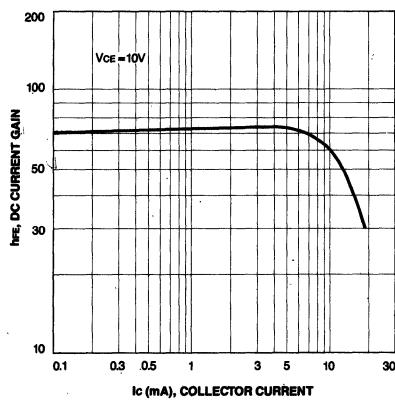
Classification	R	O	Y
h_{FE}	40-80	60-140	90-180



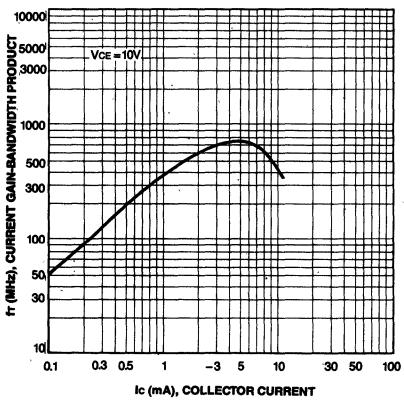
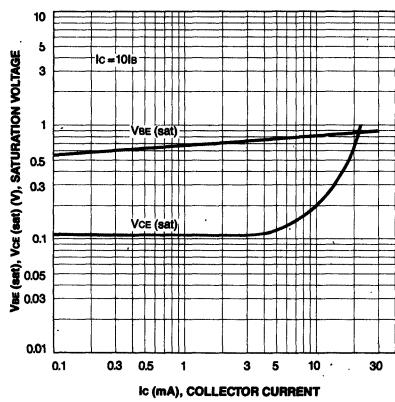
STATIC CHARACTERISTIC



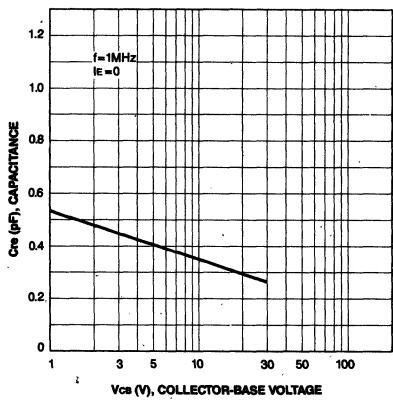
DC CURRENT GAIN



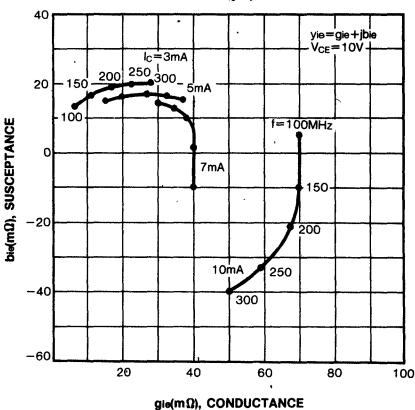
CURRENT GAIN-BANDWIDTH PRODUCT

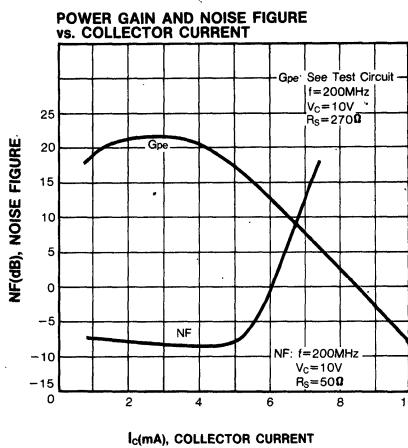
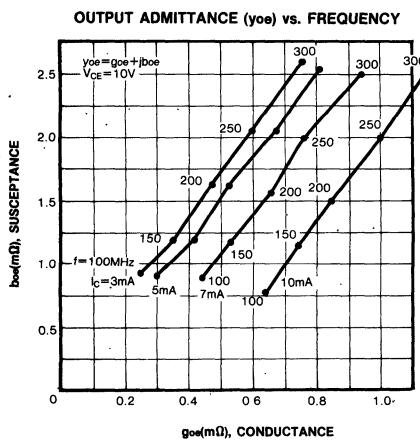
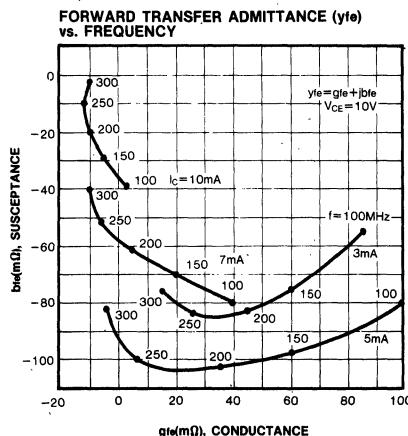
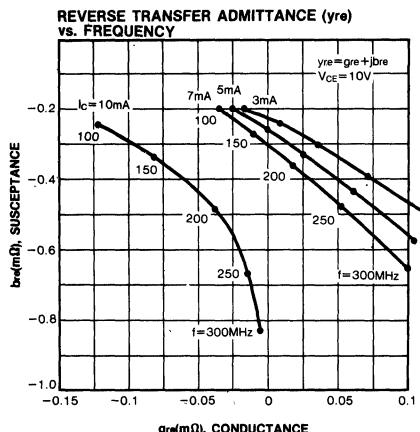
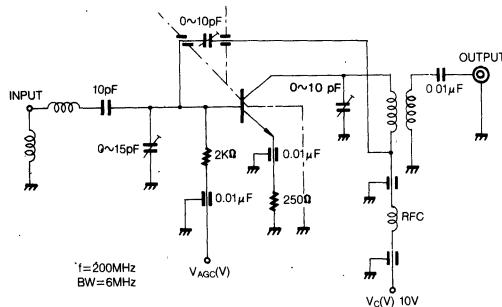
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

REVERSE CAPACITANCE



INPUT ADMITTANCE (yie) vs. FREQUENCY



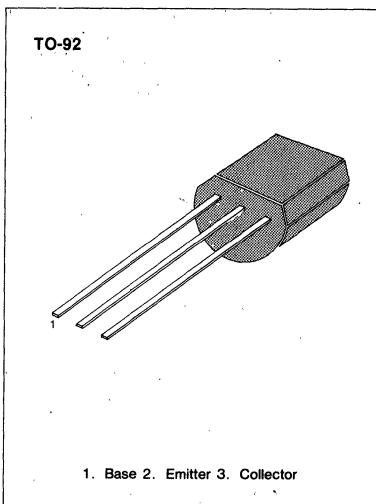
**POWER GAIN AND NOISE FIGURE TEST CIRCUIT**

TV VHF TUNER MIXER

- High Current Gain Bandwidth Product $f_T = 700\text{MHz}$ (Typ)
- High Power Gain $G_{PE} = 20\text{dB}$ (Min) at $f = 200\text{MHz}$
- Low Noise Figure $NF = 3.5\text{dB}$ (Max) at $f = 200\text{MHz}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)**

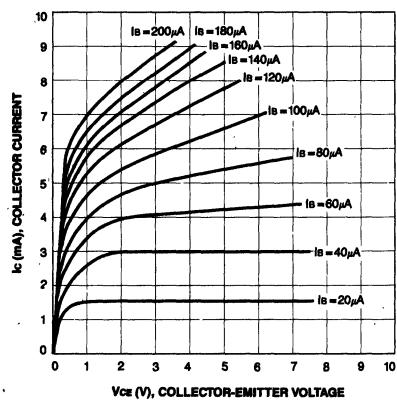
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 2\text{mA}$	40		180	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$			0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 3\text{mA}$	400	700		MHz
Reverse Transfer Capacitance	C_{RE}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		0.35	0.5	pF
Power Gain	G_{PE}	$V_{CE} = 6\text{V}, I_E = -3\text{mA}$ $R_s = 50\Omega, f = 200\text{MHz}$	20			dB
Noise Figure	NF	$V_{CE} = 6\text{V}, I_E = -3\text{mA}$ $R_s = 50\Omega, f = 200\text{MHz}$			3.5	dB

 h_{FE} CLASSIFICATION

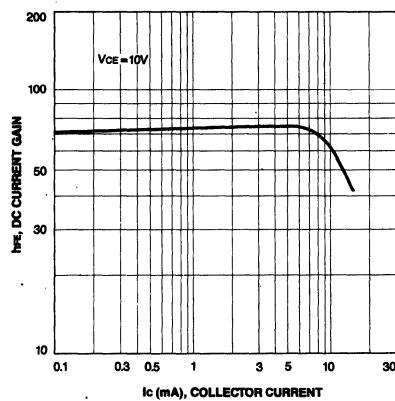
Classification	R	O	Y
h_{FE}	40-80	60-140	90-180



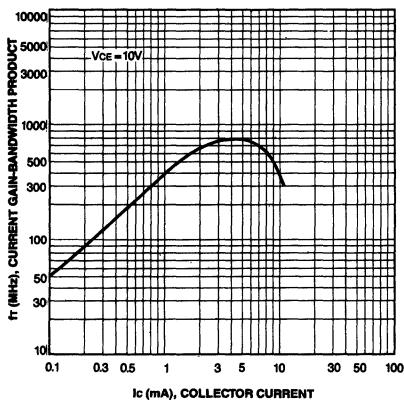
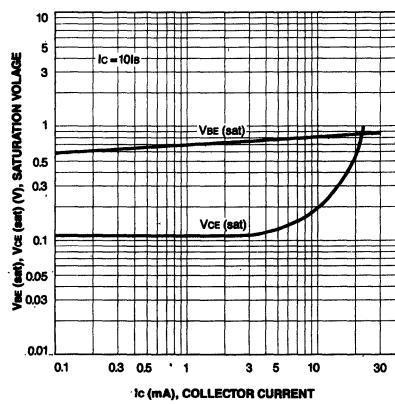
STATIC CHARACTERISTIC



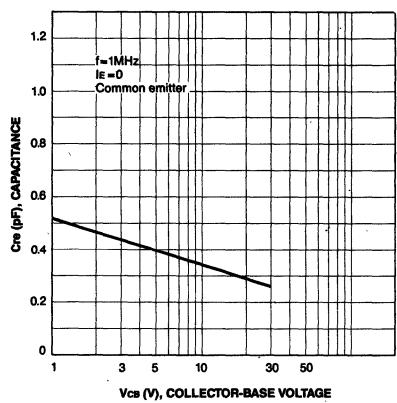
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

REVERSE CAPACITANCE



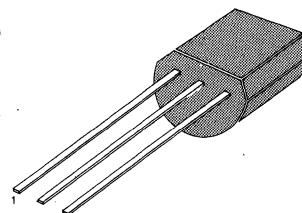
TV VHF TUNER OSCILLATOR

- High Current-Gain Bandwidth Product $f_T = 600\text{MHz}$ (Min)
- Output Capacitance $C_{ob} = 1.5\text{pF}$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

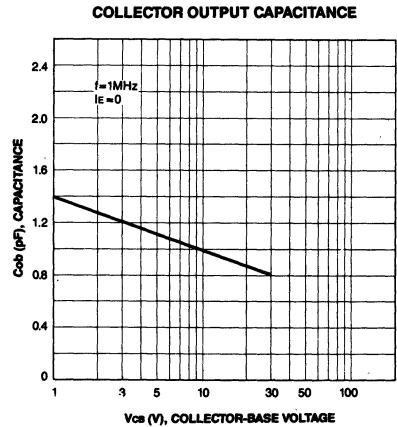
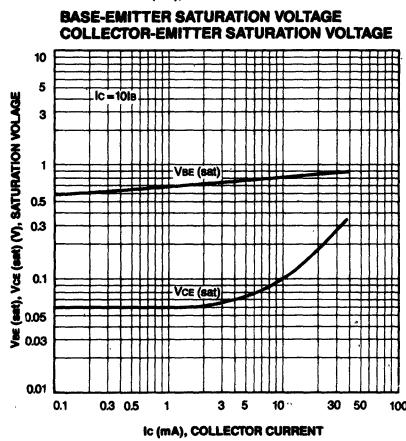
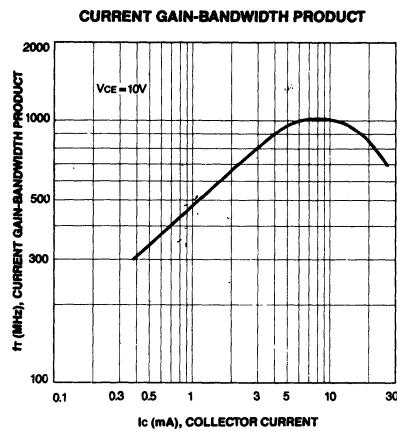
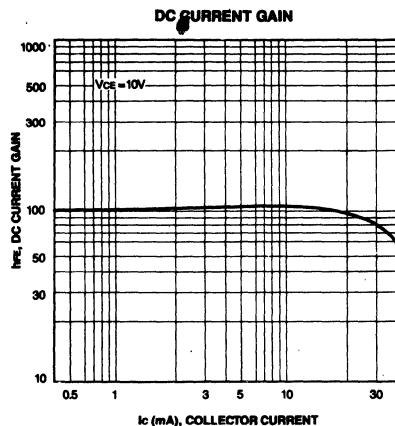
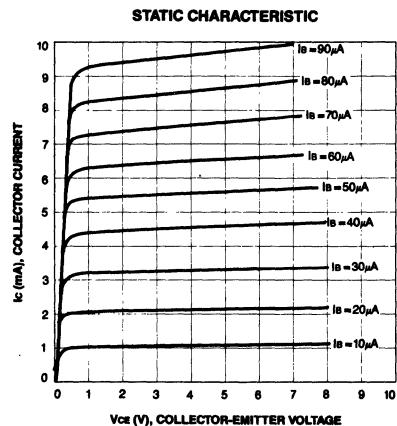
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_E = 0$	15			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 12\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -3\text{V}, I_C = 0$			0.1	V
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 5\text{mA}$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$			0.5	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 5\text{mA}$	600	1100		MHz
Output Capacitance	C_{ob}	$V_{CE} = 10\text{V}, f = 1\text{MHz}$ $I_E = 0$ *			1.5	pF

 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



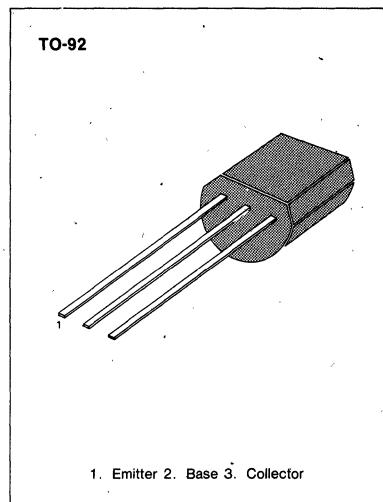


HIGH VOLTAGE TRANSISTOR

- High Collector-Emitter Voltage $V_{CEO} = 300V$
- Current Gain Bandwidth Product $f_T = 40MHz$ (Min)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	300	V
Collector-Emitter Voltage	V_{CEO}	300	V
Emitter-Base Voltage	V_{EBO}	7	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	700	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)**

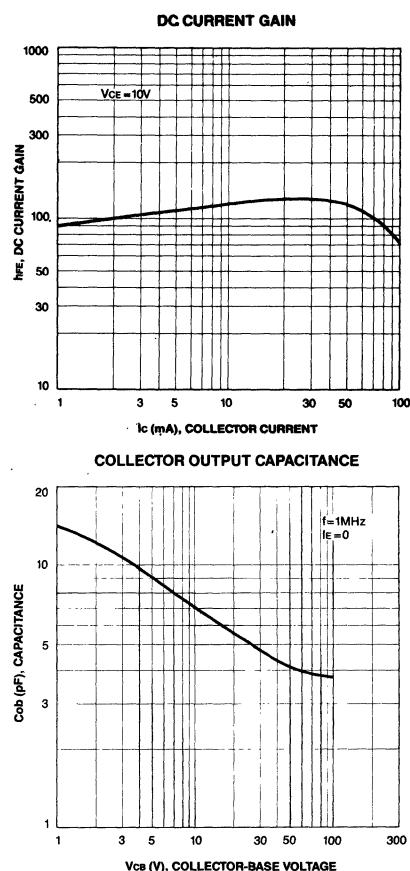
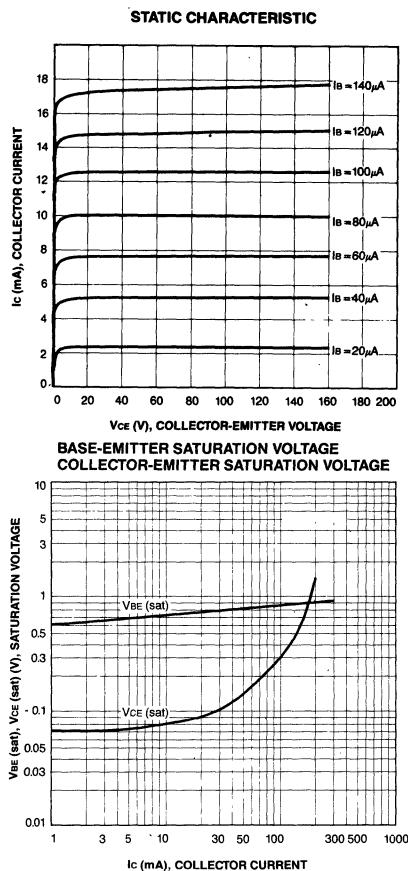
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	300			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	300			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	7			V
Collector Cutoff Current	I_{CB0}	$V_{CB} = 200V, I_E = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 10V, I_C = 10mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 50mA, I_B = 5mA$	40	80	2.0	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 30V, I_C = 10mA$				MHz
Output Capacitance	C_{OB}	$V_{CB} = 50V, I_E = 0$ $f = 1MHz$		4		pF

 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



SAMSUNG SEMICONDUCTOR

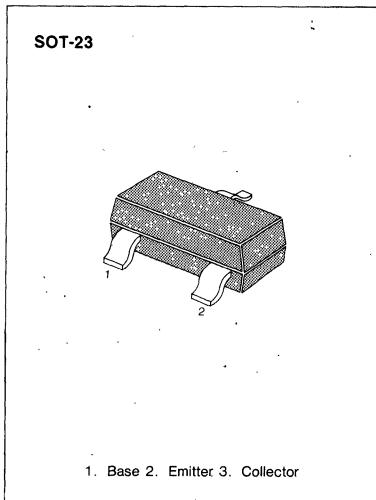


**LOW FREQUENCY AMPLIFIER
HIGH FREQUENCY OSC**

- Complement to KSA812

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

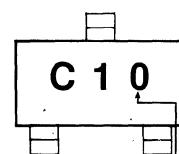
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$


ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

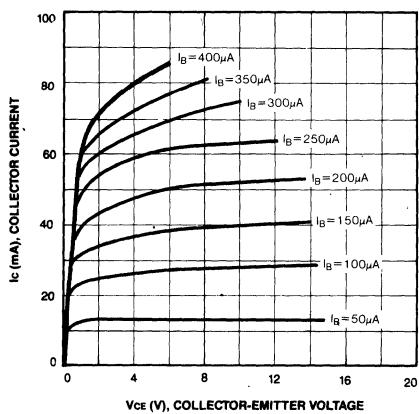
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CE}=60\text{V}, I_E=0$			0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}, I_C=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}, I_C=1\text{mA}$	90	200	600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=100\text{mA}, I_B=10\text{mA}$		0.15	0.3	V
Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C=100\text{mA}, I_B=10\text{mA}$		0.86	1.0	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$I_C=1\text{mA}, V_{CE}=6\text{V}$	0.55	0.62	0.65	V
Current Gain-Bandwidth Product	f_T	$I_E=-10\text{mA}, V_{CE}=6\text{V}$		250		MHz
Output Capacitance	C_{ob}	$V_{CE}=6\text{V}, I_E=0$ $t=1\text{MHz}$			3	pF

 h_{FE} CLASSIFICATION

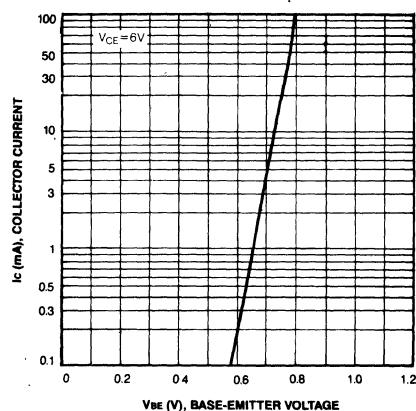
Classification	O	Y	G	L
h_{FE}	90-180	135-270	200-400	300-600

Marking

 h_{FE} grade

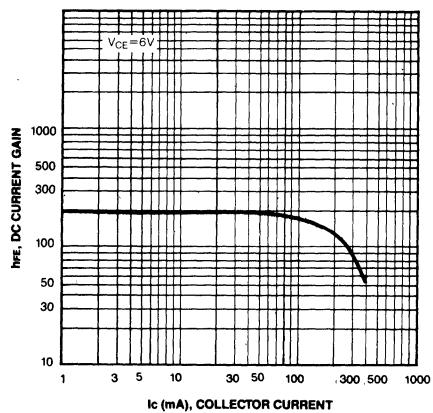
STATIC CHARACTERISTIC



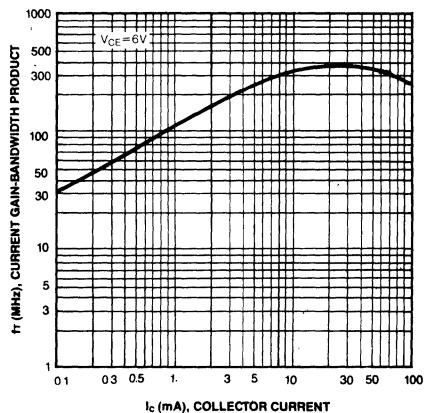
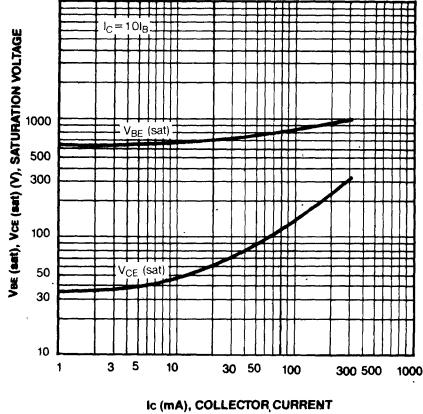
TRANSFER CHARACTERISTIC



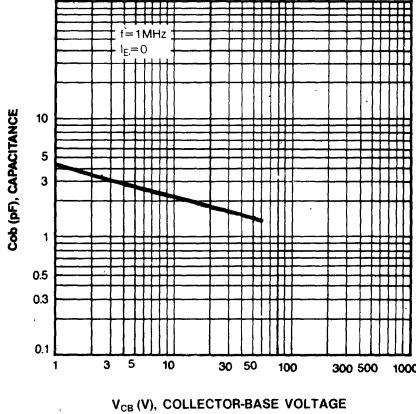
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE

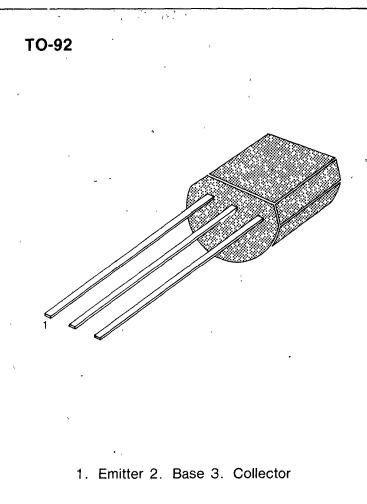


**TV PIF AMPLIFIER, FM TUNER RF AMPLIFIER,
MIXER, OSCILLATOR**

- High Current-Gain-Bandwidth Product $f_T = 600\text{MHz}$ (Typ)
- High Power Gain $G_{pe} = 22\text{dB}$ at $f = 100\text{MHz}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

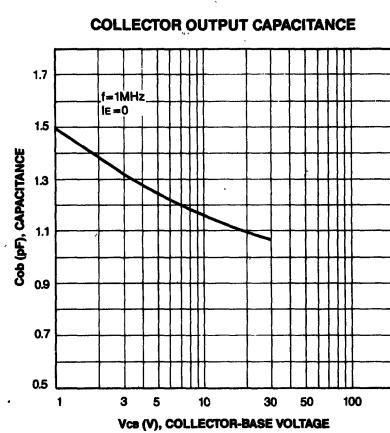
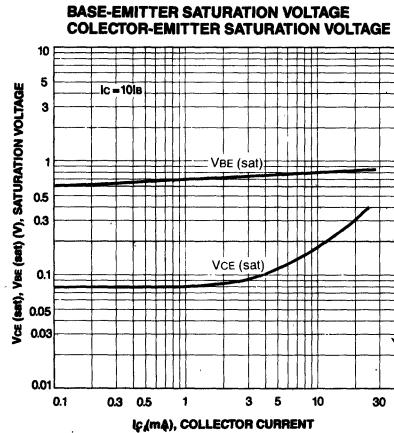
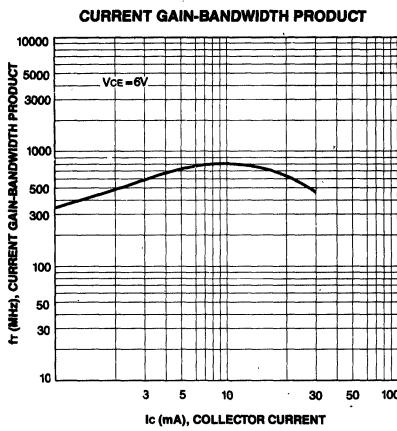
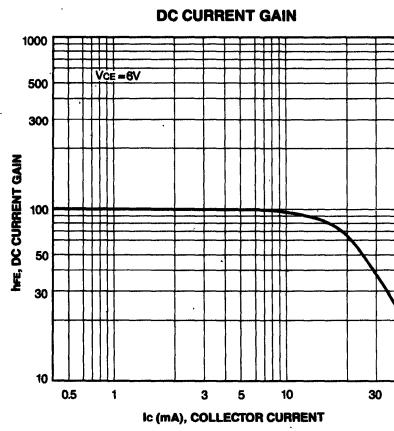
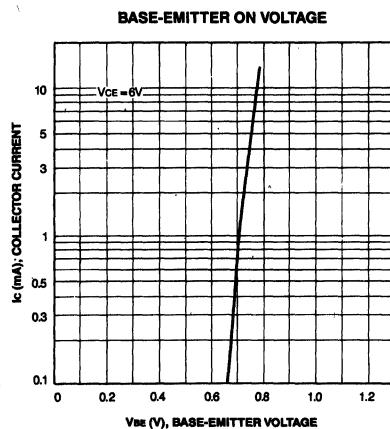
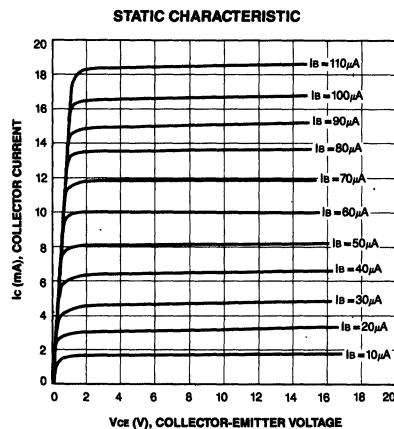

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

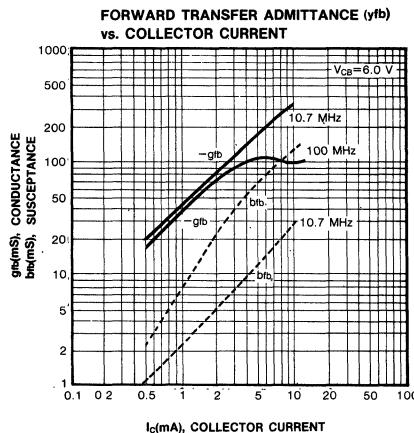
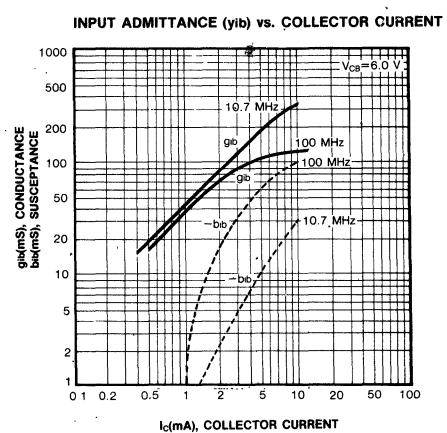
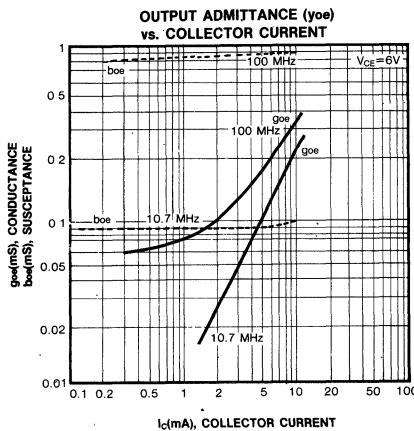
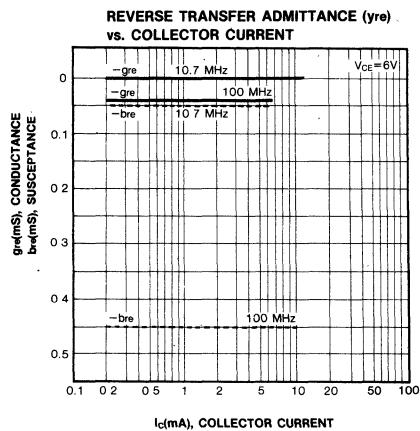
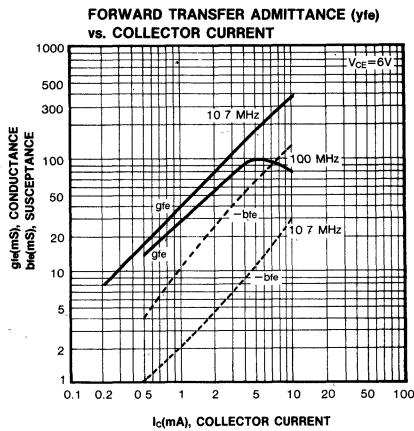
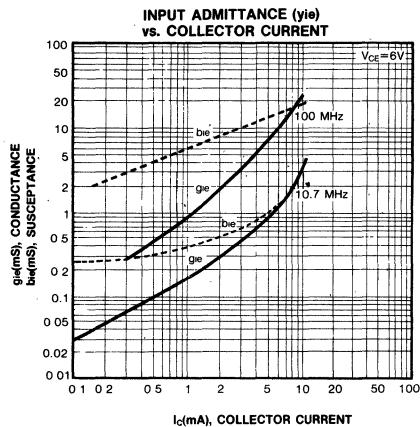
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	40		240	
Base-Emitter On Voltage	V_{BE} (on)	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$		0.72		V
Collector-Emitter Saturation Voltage	V_{CE} (sat)	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.1	0.3	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	400	600		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6\text{V}, I_E = 0$ $f = 1\text{MHz}$		1.2		pF
Collector-Base Time Constant	$C_{crbb'}$	$V_{CE} = 6\text{V}, I_E = -1\text{mA}$ $f = 31.9\text{MHz}$		12	15	ps
Common Source Noise Figure	NF	$V_{CE} = 6\text{V}, I_E = -1\text{mA}$ $R_S = 50\Omega, f = 100\text{MHz}$		3.0	5.0	dB
Power Gain	G_{pe}	$V_{CE} = 6\text{V}, I_E = -1\text{mA}$ $R_S = 50\Omega, f = 100\text{MHz}$ (Typ)	18	22		dB

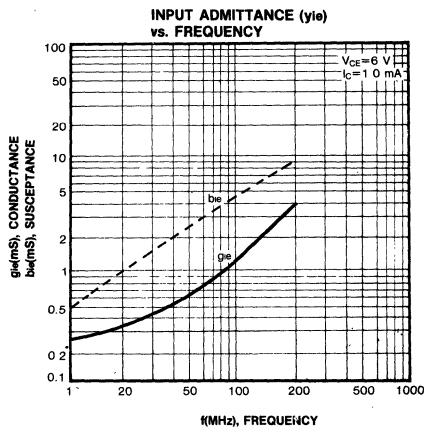
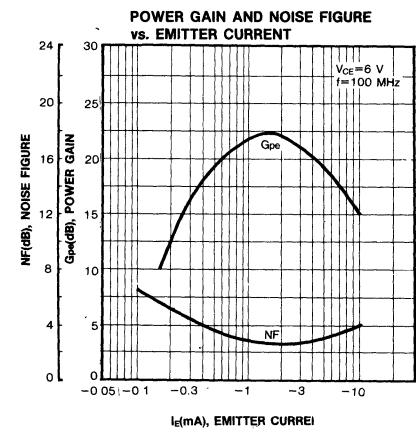
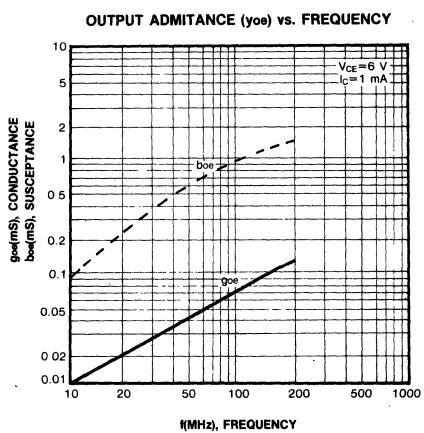
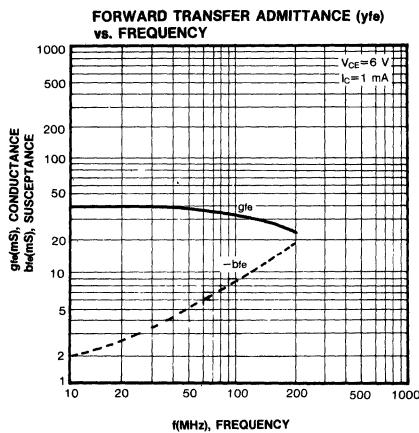
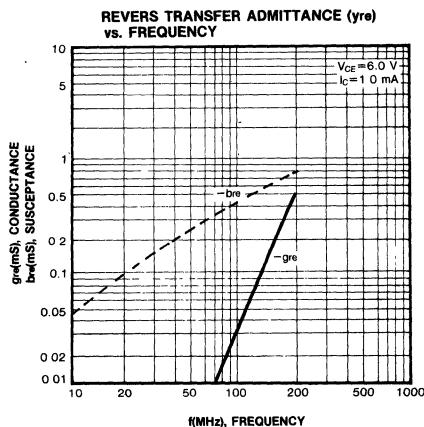
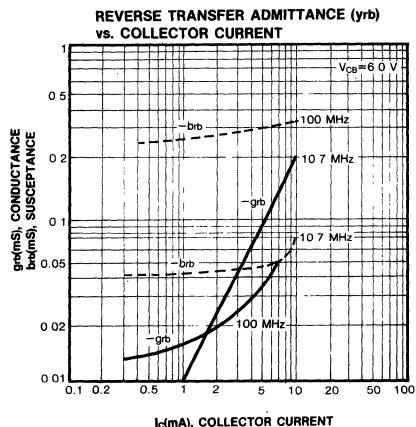
 h_{FE} CLASSIFICATION

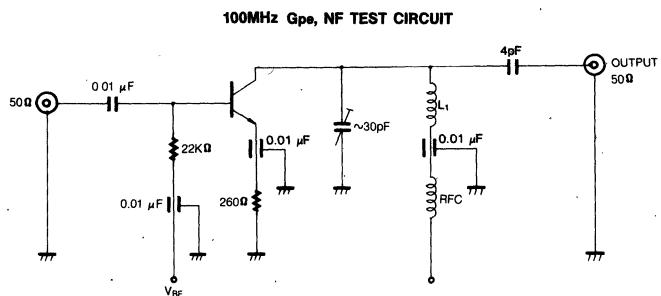
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240











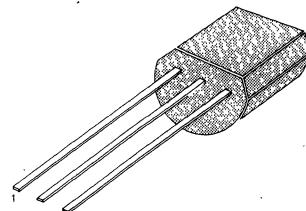
FM/AM RF AMP, MIX, CONV, OSC, IF

- Collector-Base Voltage $V_{CEO} = 30V$
- High Current Gain Bandwidth Product $f_T = 300MHz$ (Typ)
- Low Collector Capacitance Cob: $2.0PF$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	50	mA
Collector Dissipation	P_c	250	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

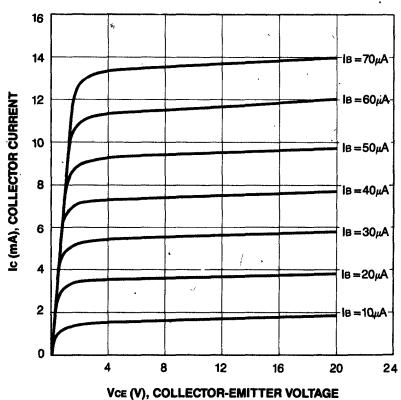
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 10\mu A, I_e = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 5mA, I_b = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_e = 10\mu A, I_c = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 50V, I_e = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_c = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6V, I_c = 1mA$	40		240	
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$V_{CE} = 6V, I_c = 1mA$		0.67	0.75	V
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_c = 10mA, I_b = 1mA$		0.08	0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 6V, I_c = 1mA$	150	300	300	MHz
Output Capacitance	Cob	$f = 1MHz, V_{CB} = 6V$		2.0	2.5	PF

 h_{FE} CLASSIFICATION

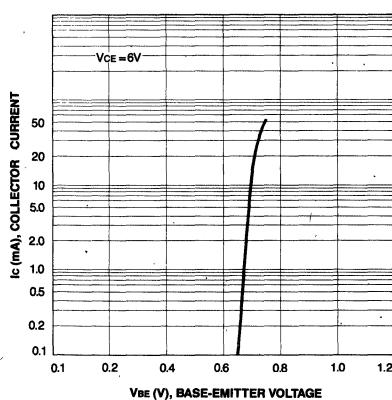
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



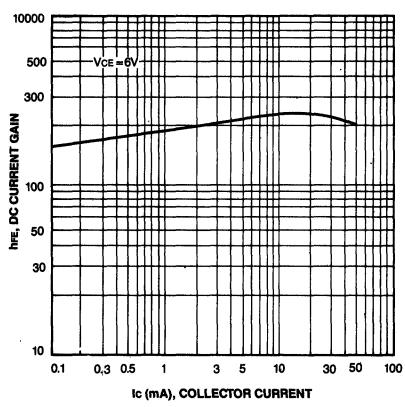
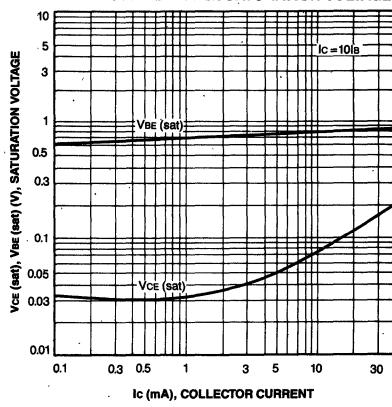
STATIC CHARACTERISTIC



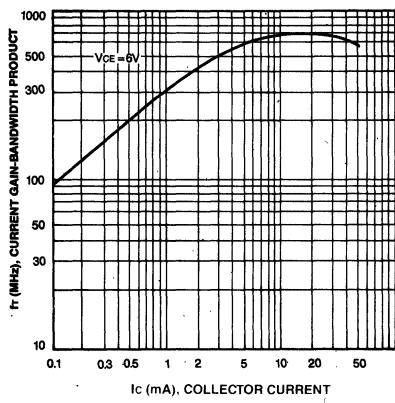
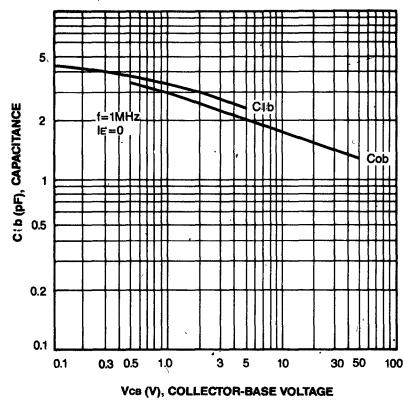
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT

COLLECTOR INPUT CAPACITANCE
COLLECTOR OUTPUT CAPACITANCE

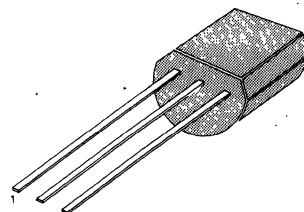
TV VHF, UHF TUNER OSCILLATOR

- High Current Gain Bandwidth Product $f_T = 1100\text{MHz}$ (Typ)
- Output Capacitance $C_{ob} = 1.5\text{pF}$ (Max)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

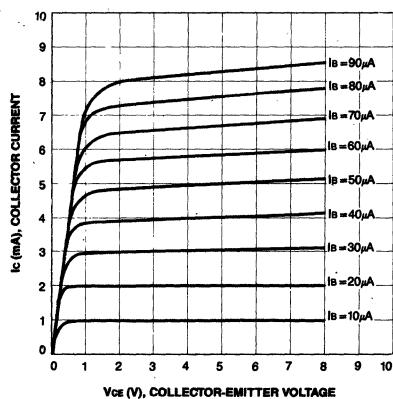
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	15			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 12\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 5.0\text{mA}$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_E = 1\text{mA}$			0.5	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 5\text{mA}$	800	1100		MHz
Output Capacitance	C_{ob}	$V_{CE} = 10\text{V}, f = 1\text{MHz}$			1.5	pF
Collector-Base Time Constant	$C_{cb \cdot rbb'}$	$I_E = 0$ $V_{CE} = 10\text{V}, f = 31.9\text{MHz}$ $I_E = -0.5\text{mA}$		10	20	ps

 h_{FE} CLASSIFICATION

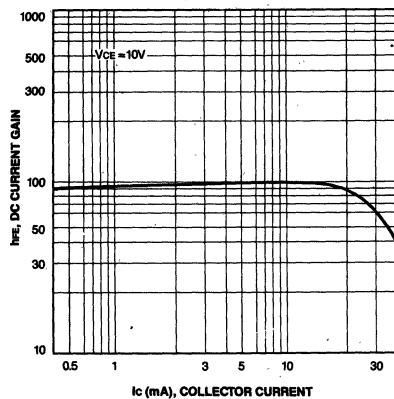
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



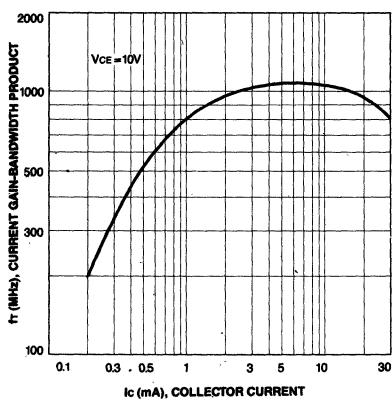
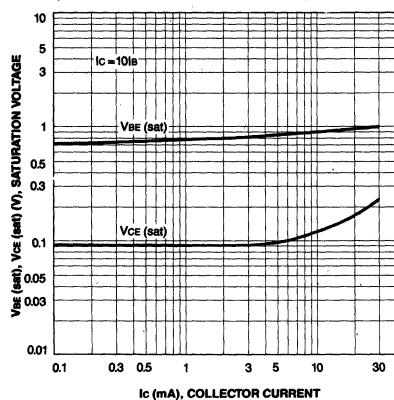
STATIC CHARACTERISTIC



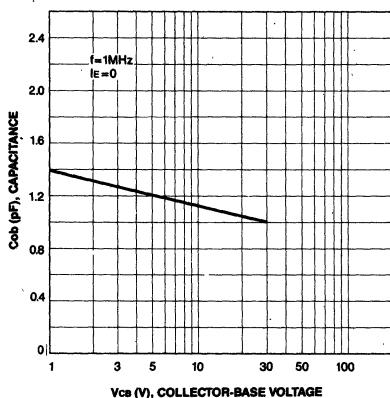
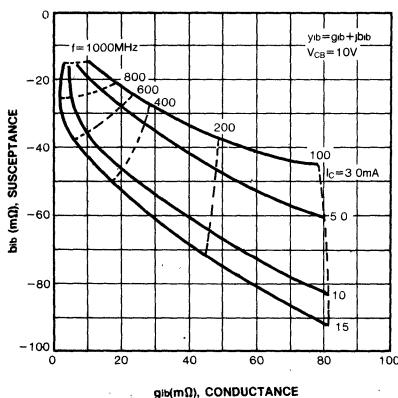
DC CURRENT GAIN

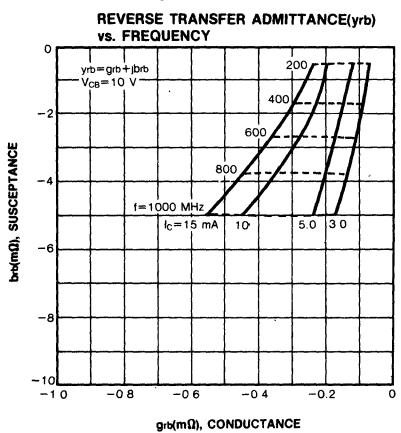
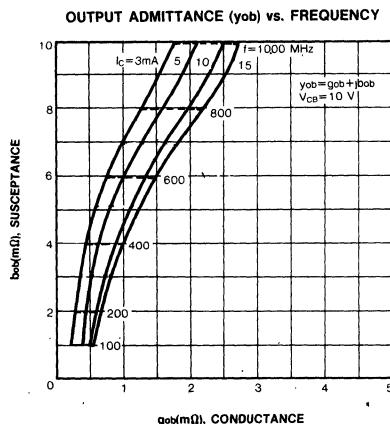
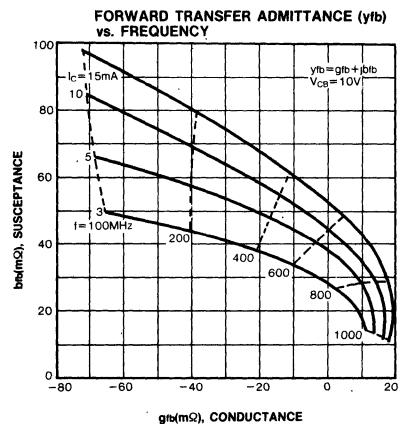


CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE

INPUT ADMITTANCE (y_{ib}) vs. FREQUENCY



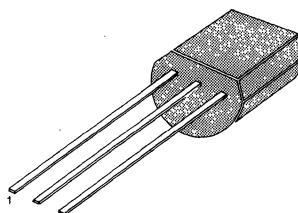
AUDIO FREQUENCY LOW NOISE AMPLIFIER

- Complement to KSA992

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	120	V
Collector-Emitter Voltage	V_{CEO}	120	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Base Current	I_B	10	mA
Collector Dissipation	P_C	500	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=120\text{V}, I_E=0$			50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}, I_C=0$			50	nA
DC Current Gain	h_{FE1}	$V_{CE}=6\text{V}, I_C=0.1\text{mA}$	150	580		
	h_{FE2}	$V_{CE}=6\text{V}, I_C=1\text{mA}$	200	600	1200	
Base Emitter On Voltage	$V_{BE} \text{ (on)}$	$V_{CE}=6\text{V}, I_C=1\text{mA}$	0.55	0.59	0.65	V
Collector Emitter Saturation Voltage	$V_{CE \text{ (sat)}}$	$I_C=10\text{mA}, I_B=1\text{mA}$		0.07	0.3	V
Current Gain Bandwidth Product	f_T	$V_{CE}=6\text{V}, I_E=-1\text{mA}$	50	110		MHz
Output Capacitance	C_{ob}	$V_{CB}=30\text{V}, I_E=0$		1.6	2.5	pF
Noise Voltage	NV	$f=1\text{MHz}$		25	40	mV

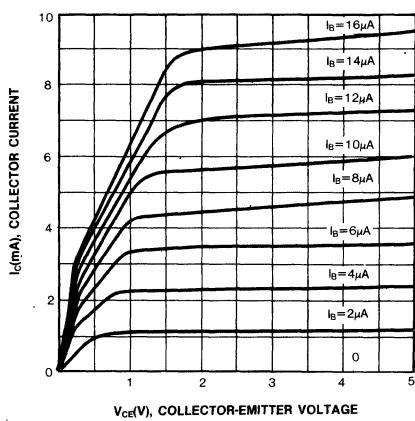
 $h_{FE}(2)$ CLASSIFICATION

Classification	P	F	E	U
$h_{FE}(2)$	200-400	300-600	400-800	600-1200

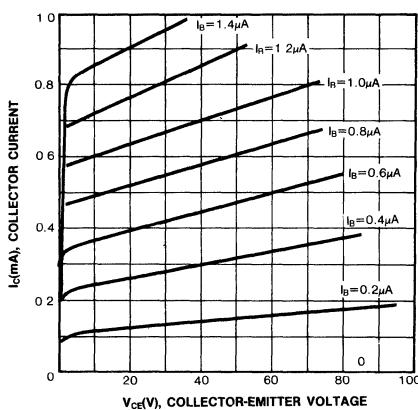


SAMSUNG SEMICONDUCTOR

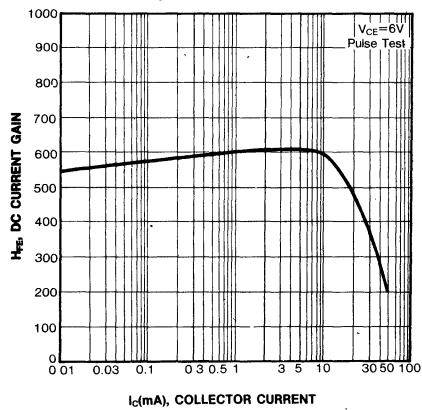
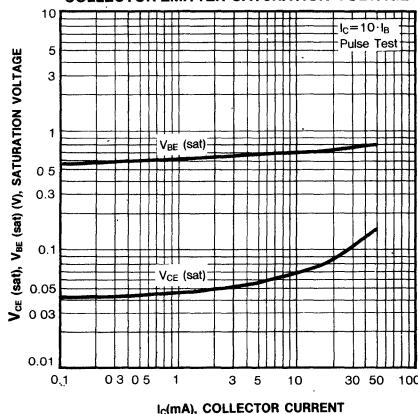
STATIC CHARACTERISTIC



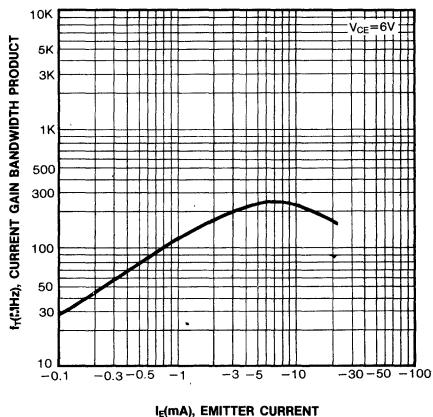
STATIC CHARACTERISTIC



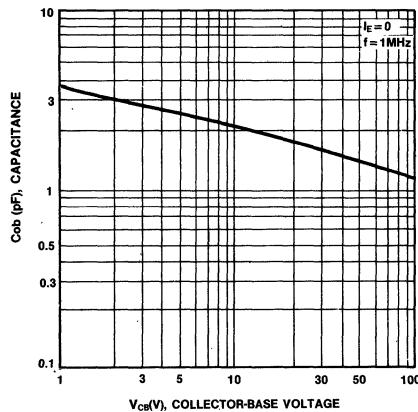
DC CURRENT GAIN

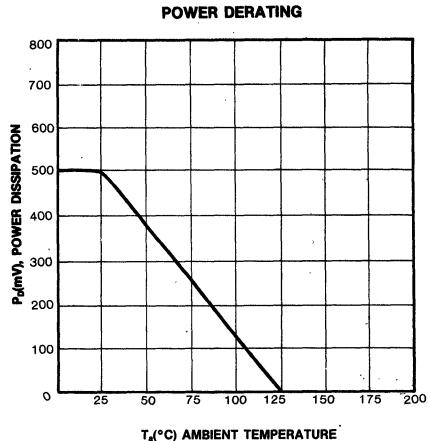
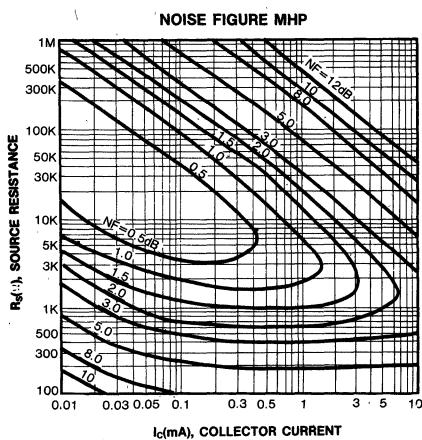
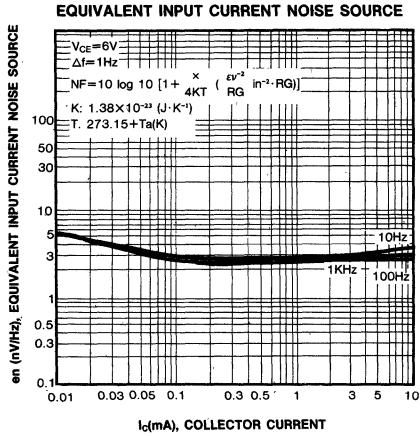
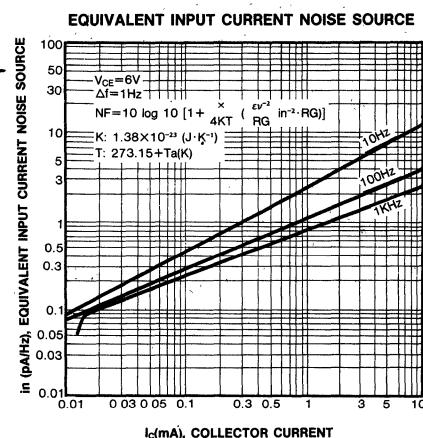
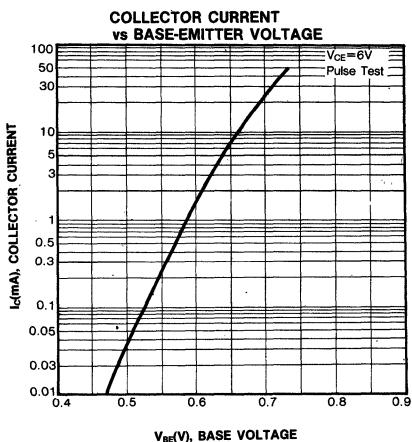
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR OUTPUT CAPACITANCE





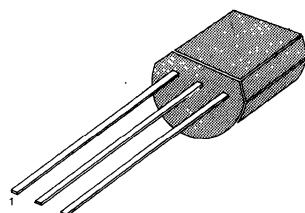
GENERAL PURPOSE APPLICATIONS
HIGH TOTAL POWER DISIPATION
(PT=600 mW)

High h_{FE} and LOW $V_{CE(sat)}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	700	mA
Base Current	I_B	150	mA
Collector Dissipation	P_C	600	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

TO-92



1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
*Base Emitter Voltage	V_{BE}	$V_{CE}=6\text{V}$, $I_c=10\text{mA}$	600	640	700	mV
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}$, $I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_c=0$			100	nA
*DC Current Gain	h_{FE1}	$V_{CE}=1\text{V}$, $I_c=100\text{mA}$	90	200	400	
	h_{FE2}	$V_{CE}=1\text{V}$, $I_c=700\text{mA}$	50	140		
*Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_c=700\text{mA}$, $I_B=70\text{mA}$		0.2	0.6	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_c=700\text{mA}$, $I_B=70\text{mA}$		0.95	1.2	V
Output Capacitance	C_{ob}	$V_{CB}=6\text{V}$, $I_E=0$, $f=1\text{MHz}$		13	25	pF
Current Gain Bandwidth Product	f_T	$V_{CE}=6\text{V}$, $I_E=10\text{mA}$	50	170		MHz

* Pulse test: PW $\leq 350 \mu\text{s}$, duty cycle $\leq 2\%$ Pulsed

h_{FE1} CLASSIFICATION

Classification	R	O	Y
h_{FE1}	90-180	135-270	200-400



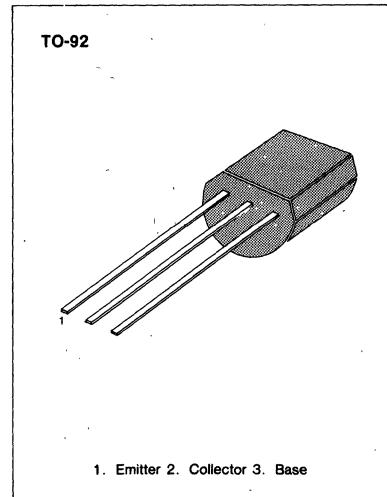
AUDIO FREQUENCY AMPLIFIER

- Complement to KSA953/KSA954

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : KSC2002	V_{CBO}	60	V
: KSC2003		80	V
Collector-Emitter Voltage : KSC2002	V_{CEO}	60	V
: KSC2003		80	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current (DC)	I_c	300	mA
*Collector Current (Pulse)	I_c	500	mA
Collector Dissipation	P_c	600	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

* PW≤10ms, Duty Cycle ≤50%

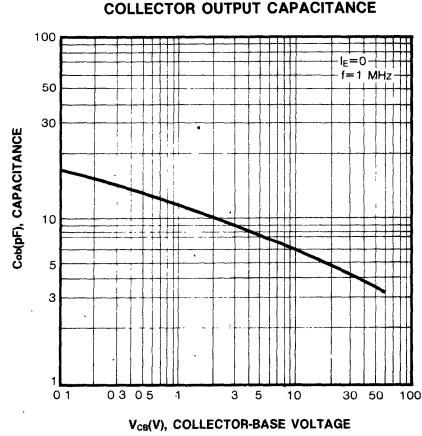
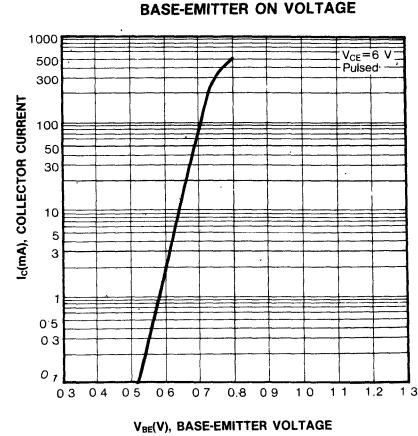
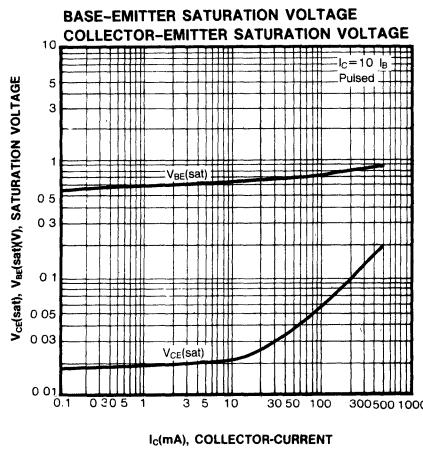
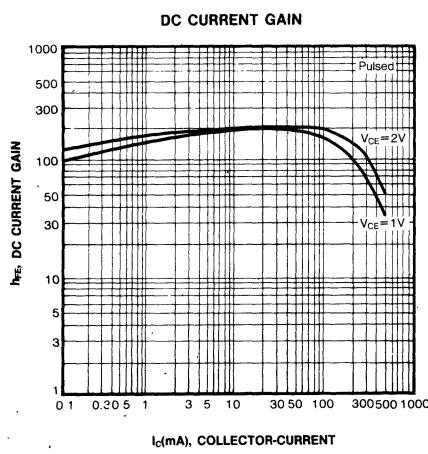
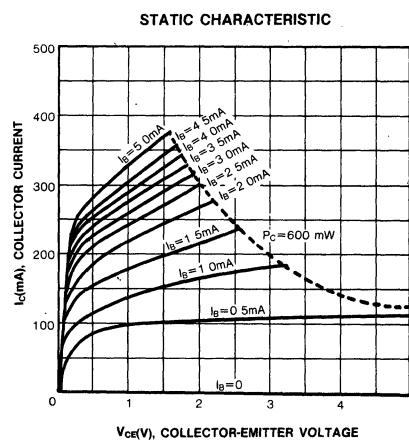
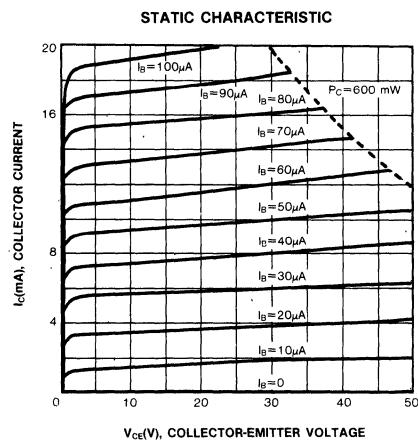
**ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)**

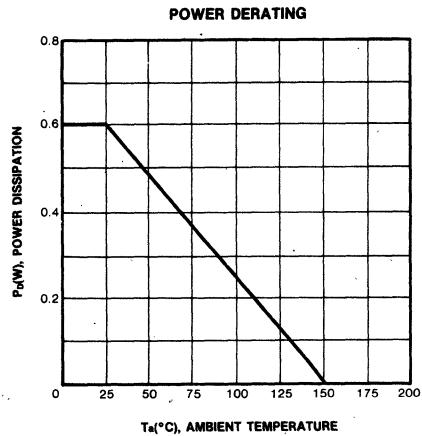
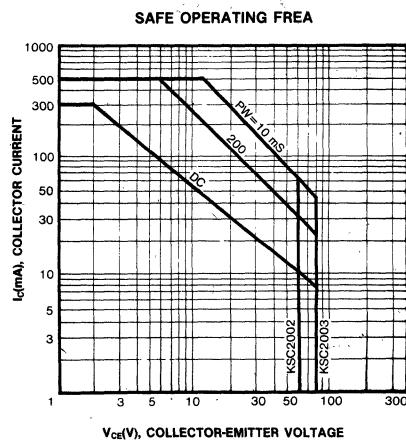
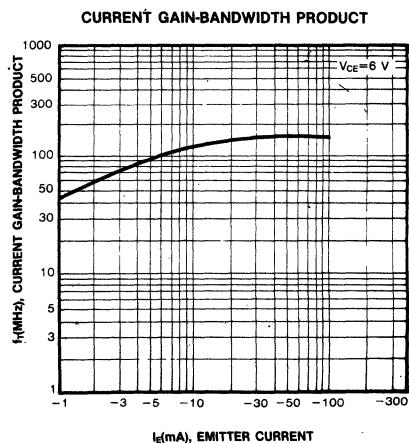
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current: KSC2002	I_{CBO}	$V_{CB}=60\text{V}, I_E=0$			100	nA
: KSC2003		$V_{CB}=80\text{V}, I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}, I_c=0$			100	nA
*DC Current Gain	h_{FE1}	$V_{CE}=1\text{V}, I_c=50\text{mA}$	90	200	400	
	h_{FE2}	$V_{CE}=2\text{V}, I_c=300\text{mA}$	30	80		
Base-Emitter On Voltage	V_{BE} (on)	$V_{CE}=6\text{V}, I_c=10\text{mA}$	600	645	700	mV
*Collector-Emitter Saturation Voltage	V_{CE} (sat)	$I_c=300\text{mA}, I_B=30\text{mA}$		0.15	0.6	V
*Base Emitter Saturation Voltage	V_{BE} (sat)	$I_c=300\text{mA}, I_B=30\text{mA}$		0.86	1.2	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=6\text{V}, I_E=-10\text{mA}$	50	140		MHz
Output Capacitance	C_{ob}	$V_{CB}=6\text{V}, I_E=0, f=1\text{MHz}$		7	15	pF

* Pulse Test: PW≤350μs, Duty Cycle≤2% Pulsed

 $h_{FE}(1)$ CLASSIFICATION

Classification	O	Y	G
$h_{FE}(1)$	90-180	135-270	200-400





HIGH FREQUENCY AMPLIFIER

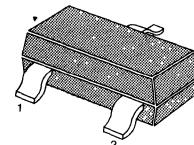
Very small size to assure good space factor in hybrid IC applications

- $f_T = 600\text{MHz}$ Typ. ($I_E = -1\text{mA}$)
- $C_{ob} = 1\text{pF}$ Typ ($V_{cb} = 6\text{V}$)
- $NF = 3\text{dB}$ Typ ($f = 100\text{MHz}$)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_c	150	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

3

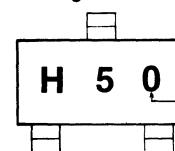
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}$, $I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6\text{V}$, $I_C = 1\text{mA}$	40	90	180	
Collector Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}$, $I_B = 1\text{mA}$		0.1	0.3	V
Output Capacitance	C_{ob}	$V_{CB} = 6\text{V}$, $I_E = 0$, $f = 1\text{MHz}$		1		pF
Current Gain Bandwidth Product	f_T	$V_{CE} = 6\text{V}$, $I_C = -1\text{mA}$	400	600		MHz
Time Constant	$C_{C-E} r_{bb}$	$V_{CB} = 6\text{V}$, $I_E = -1\text{mA}$ $f = 31.9\text{MHz}$		12		ps
Noise Figure	NF	$V_{CE} = 6\text{V}$, $I_E = -1\text{mA}$ $f = 100\text{MHz}$, $R_S = 50\Omega$		3		dB

 h_{FE} CLASSIFICATION

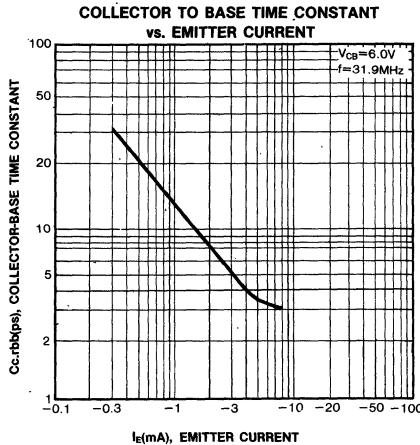
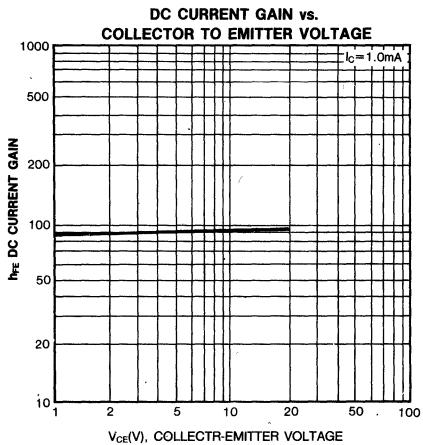
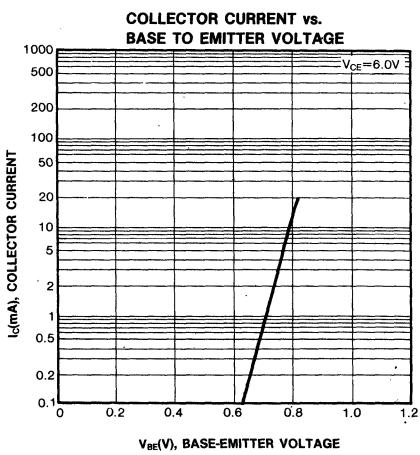
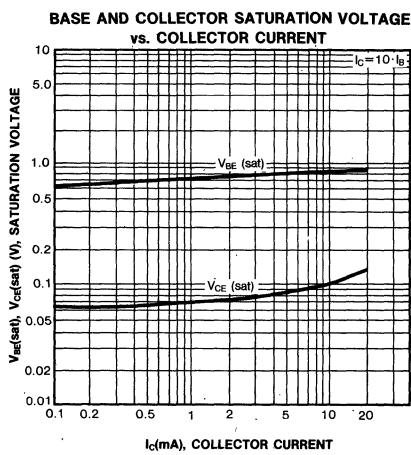
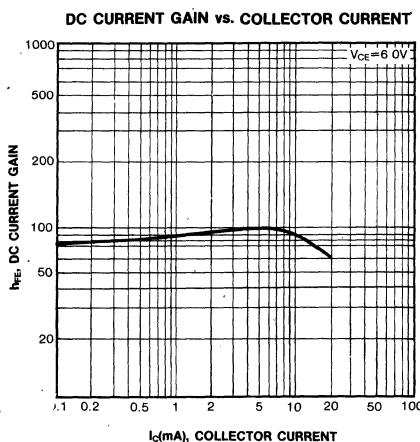
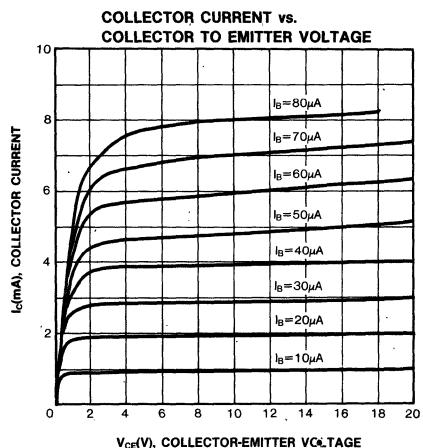
Classification	R	O	Y
h_{FE}	40-80	60-120	90-180

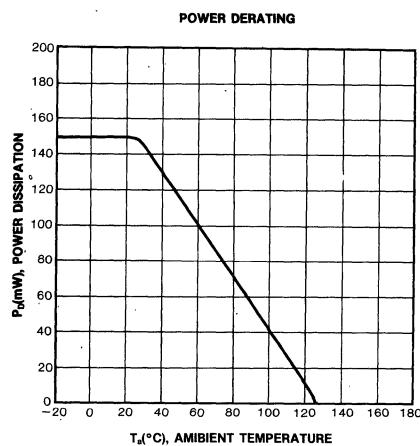
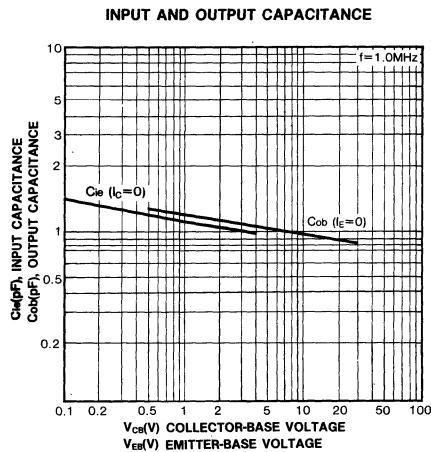
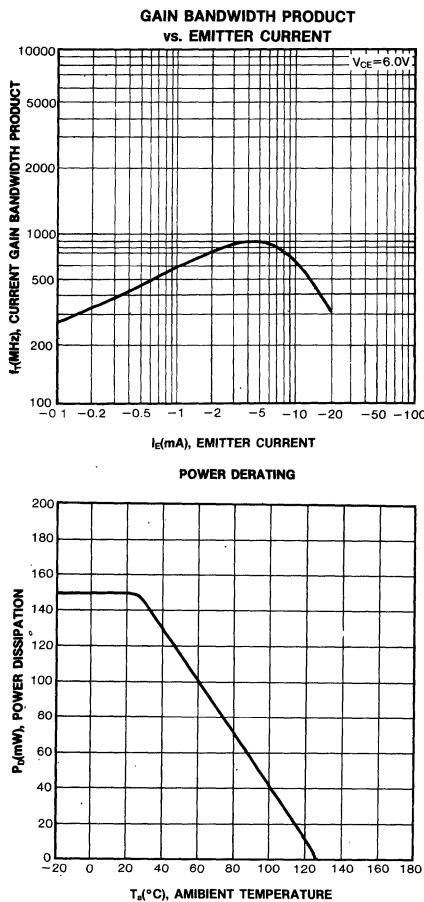
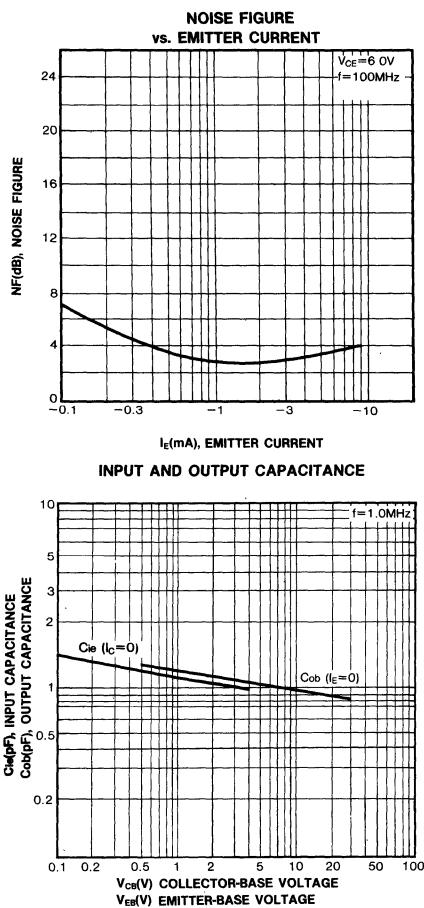
Marking



h_{FE} grade







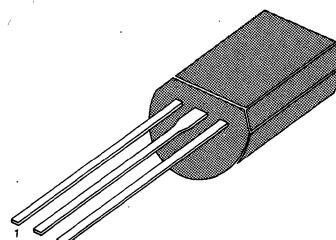
HIGH VOLTAGE POWER AMPLIFIER

- Collector — Base Voltage $V_{CBO} = 200V$
- Current Gain-Bandwidth Product $f_T = 100MHz$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	200	V
Collector-Emitter Voltage	V_{CEO}	150	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	800	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ +150	$^\circ C$

TO-92L



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

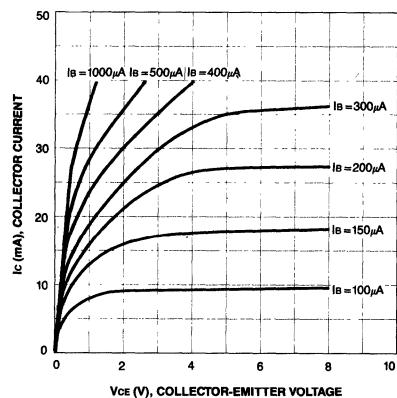
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	200			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5mA, I_B = 0$	150			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 200V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5V, I_C = 10mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10mA, I_B = 1mA$			0.5	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 30V, I_C = 10mA$		100		MHz
Output Capacitance	C_{OB}	$V_{CE} = 10V, I_E = 0$ $f = 1kHz$		3.5	5	pF

 h_{FE} CLASSIFICATION

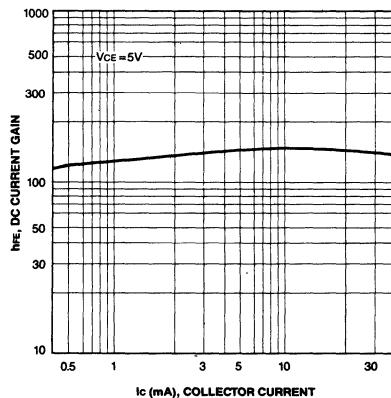
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



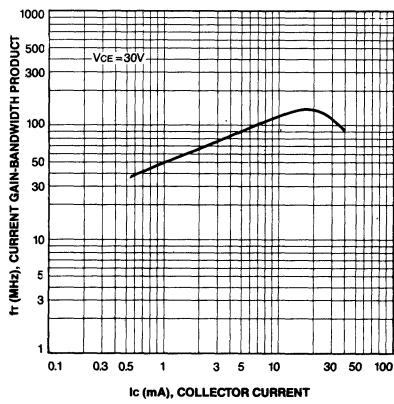
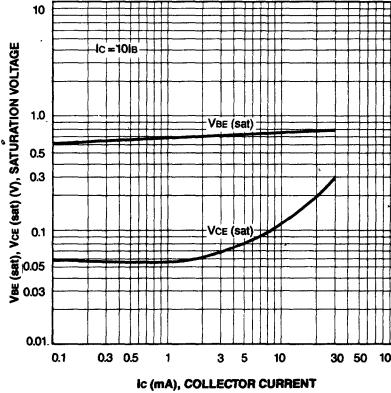
STATIC CHARACTERISTIC



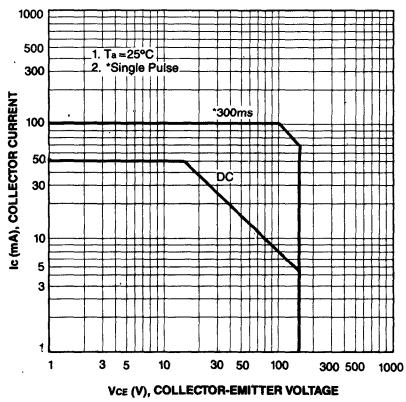
DC CURRENT GAIN



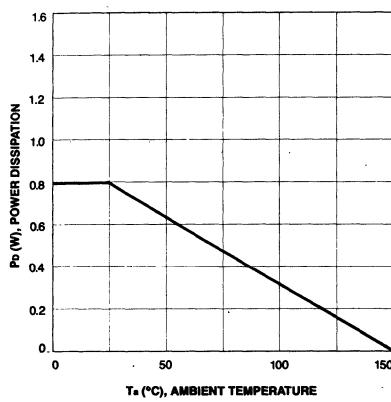
CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

SAFE OPERATING AREA



POWER DERATING

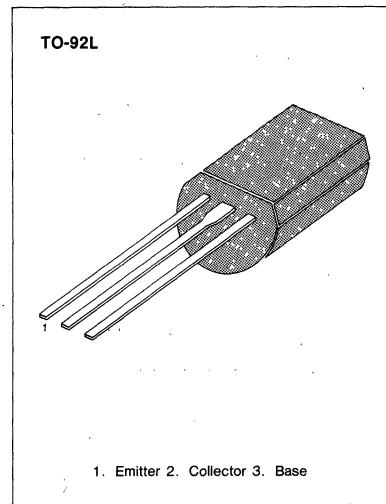


AUDIO POWER AMPLIFIER APPLICATIONS

- Driver Stage Amplifier
- Complement to KSA916

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	120	V
Collector-Emitter Voltage	V_{CEO}	120	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	800	mA
Collector Dissipation	P_c	900	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ +150	°C



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 1\text{mA}, I_E = 0$	120			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 10\text{mA}, I_B = 0$	120			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -1\text{mA}, I_C = 0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 120\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE1}	$V_{CE} = 5\text{V}, I_C = 10\text{mA}$	60			
	h_{FE2}	$V_{CE} = 5\text{V}, I_C = 100\text{mA}$	80		240	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 500\text{mA}, I_B = 50\text{mA}$		120	1	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{V}, I_C = 100\text{mA}$			240	MHz
Collector Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$			30	pF

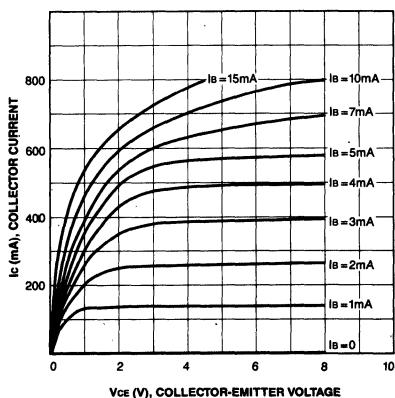
 h_{FE} CLASSIFICATION

Classification	O	Y
$h_{FE}(2)$	80-160	120-240

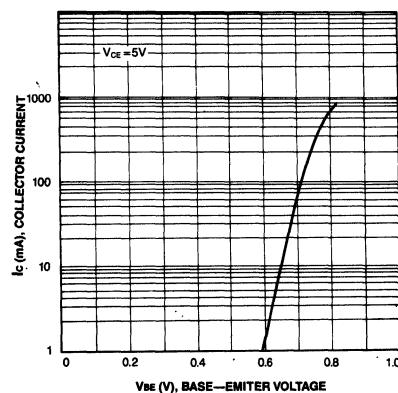


SAMSUNG SEMICONDUCTOR

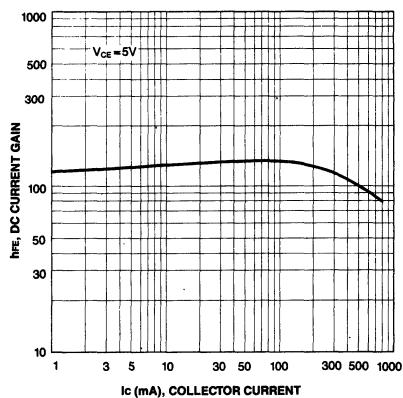
STATIC CHARACTERISTIC



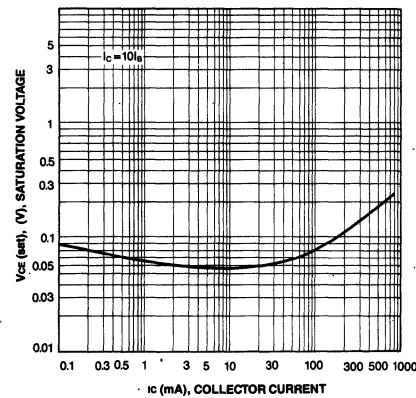
BASE-EMITTER ON VOLTAGE



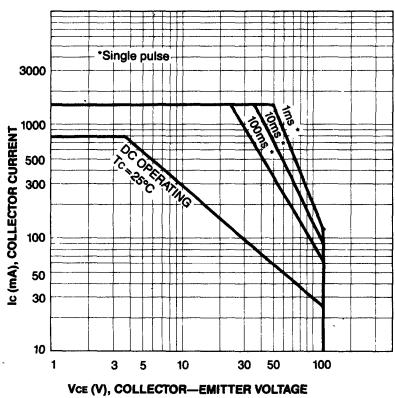
DC CURRENT GAIN



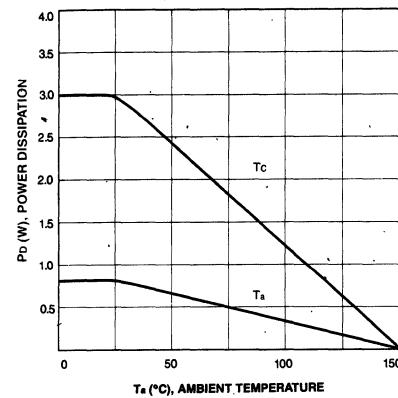
COLLECTOR-EMITTER SATURATION VOLTAGE



SAFE OPERATING AREA



POWER DERATING

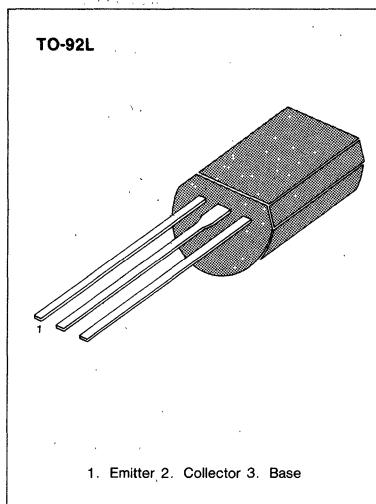


AUDIO POWER AMPLIFIER APPLICATIONS

- Complement to KSA928A
- Collector Dissipation $P_c = 1$ Watt
- 3 Watt Output Application

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	2	A
Collector Dissipation	P_c	1	W
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ +150	$^\circ\text{C}$



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

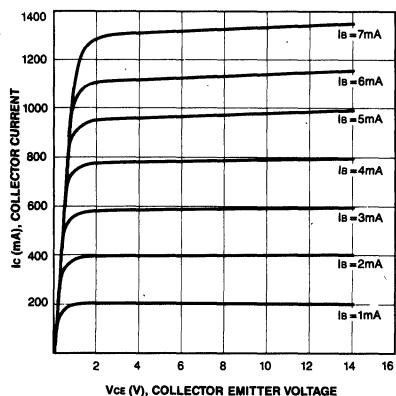
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -1\text{mA}, I_C = 0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 2\text{V}, I_C = 500\text{mA}$	100		320	
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = 2\text{V}, I_C = 500\text{mA}$			1.0	V
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$V_{CE} = 2\text{V}, I_C = 500\text{mA}$			2.0	V
Current Gain-Bandwidth Product	f_T	$I_C = 1.5\text{A}, I_B = 0.03\text{A}$		120		MHz
Output Capacitance	C_{ob}	$V_{CE} = 2\text{V}, I_C = 500\text{mA}$ $V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$		30		pF

 h_{FE} CLASSIFICATION

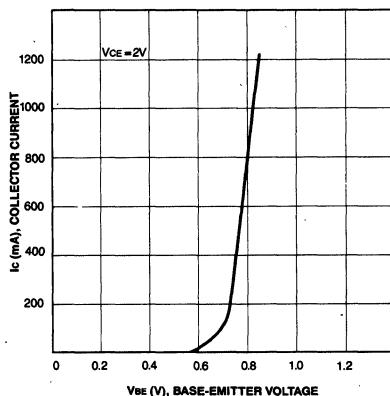
Classification	O	Y
h_{FE}	100-200	160-320



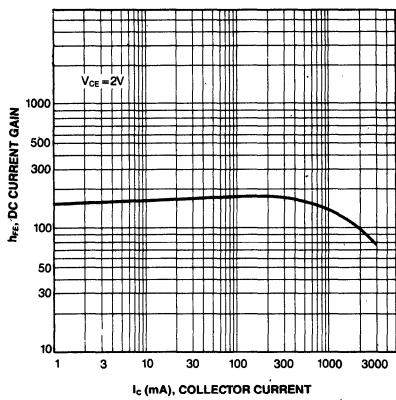
STATIC CHARACTERISTIC



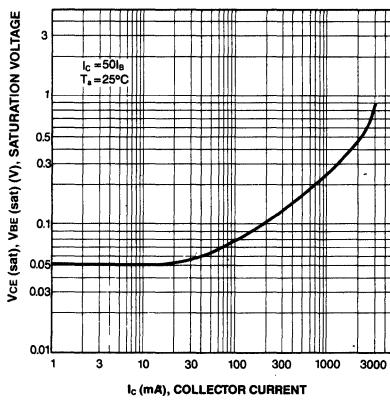
BASE-EMITTER ON VOLTAGE



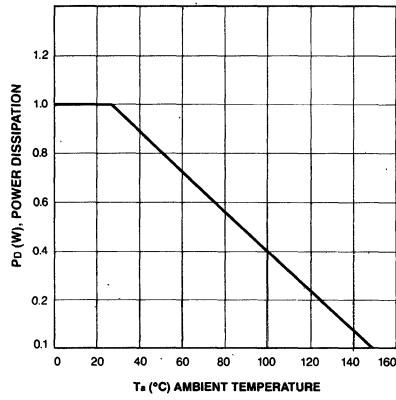
DC CURRENT GAIN



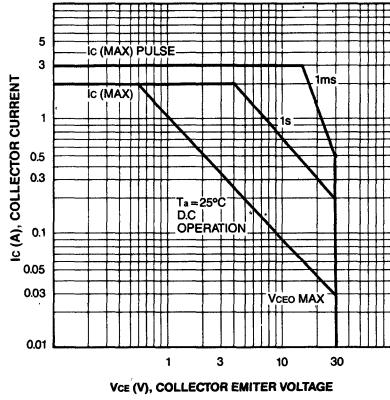
COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



SAFE OPERATING AREA



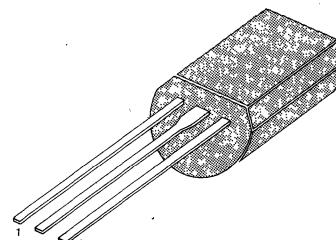
COLOR TV CHROMA OUTPUT

- Collector-Base Voltage $V_{CBO} = 300V$
- Current Gain-Bandwidth Product $f_T = 50MHz$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	300	V
Collector-Emitter Voltage	V_{CEO}	300	V
Emitter-Base Voltage	V_{EBO}	7	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	1	W
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ +150	$^\circ C$

TO-92L



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	300			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5mA, I_B = 0$	300			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	7			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 200V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10V, I_C = 20mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA, I_B = 1mA$		50	0.5	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 30V, I_C = 10mA$				MHz
Output Capacitance	C_{OB}	$V_{CB} = 10V, I_E = 0$ $f = 1MHz$		4		pF

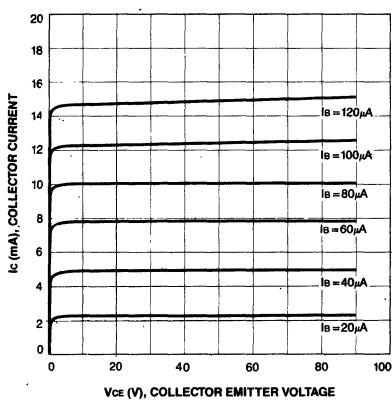
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

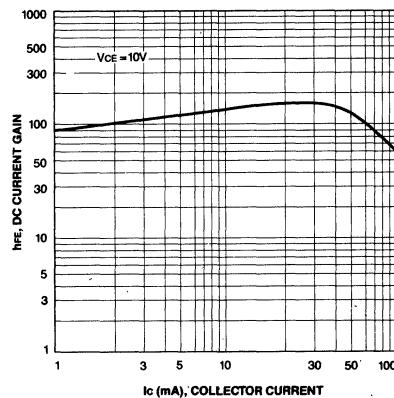
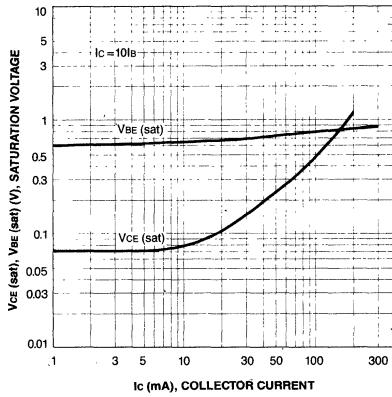


SAMSUNG SEMICONDUCTOR

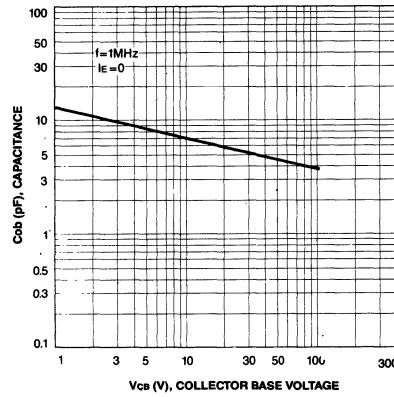
STATIC CHARACTERISTIC



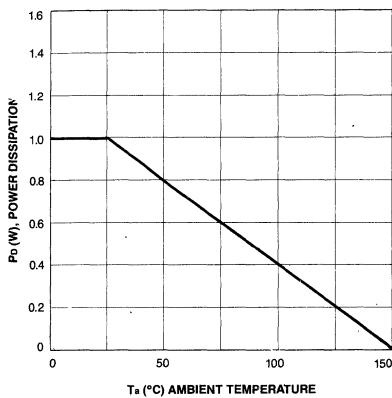
DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



POWER DERATING

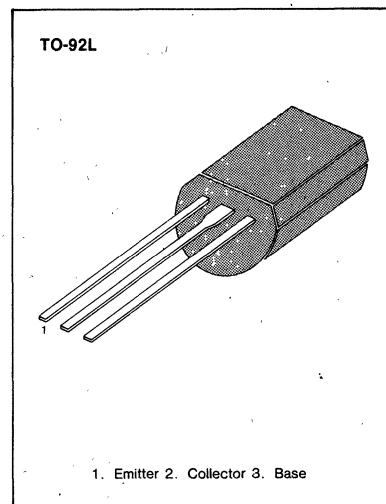


LOW FREQUENCY AMPLIFIER MEDIUM SPEED SWITCHING

- Complement to KSA931
- High Collector-Base Voltage $V_{CBO}=80V$
- Collector Current $I_C=700mA$
- Collector Dissipation $P_C=1W$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	80	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	8	V
Collector Current	I_C	700	mA
Collector Dissipation	P_C	1	W
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ +150	$^\circ C$



ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

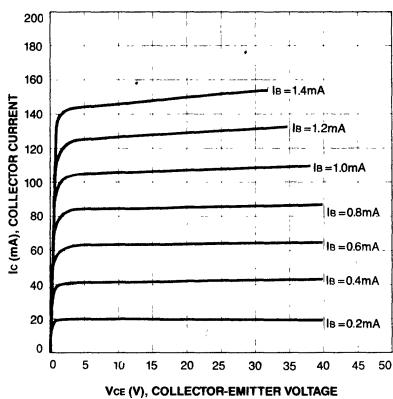
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	80			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA, I_B=0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-10\mu A, I_C=0$	8			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=60V, I_E=0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=5V, I_C=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=2V, I_C=50mA$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=500mA, I_B=50mA$		0.2	0.7	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=500mA, I_B=50mA$		0.86	1.20	V
Current-Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=50mA$	30	50		MHz
Output Capacitance	C_{OB}	$V_{CE}=10V, I_E=0$ $f=1MHz$		8		pF

h_{FE} CLASSIFICATION

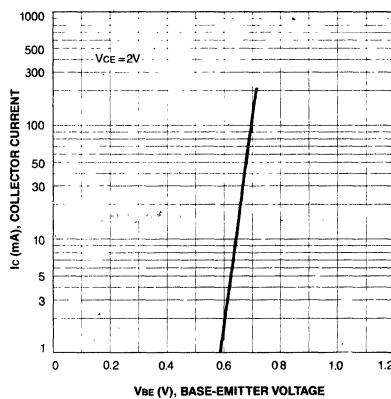
Classification	O	Y
h_{FE}	70-140	120-240



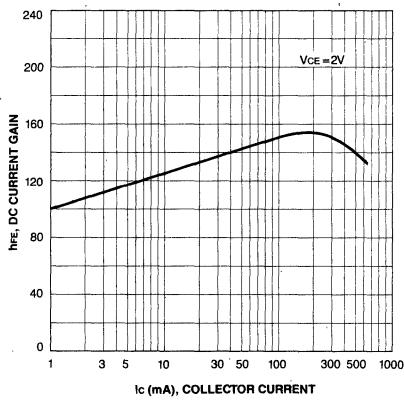
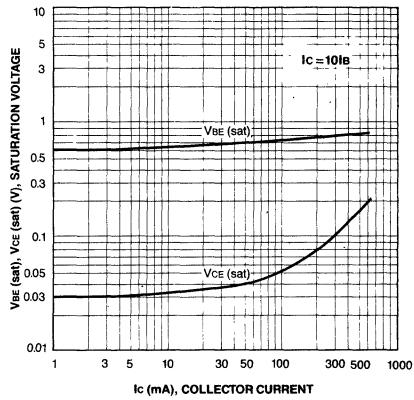
STATIC CHARACTERISTIC



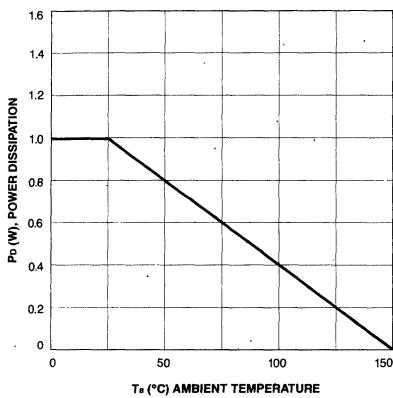
BASE-EMITTER ON VOLTAGE



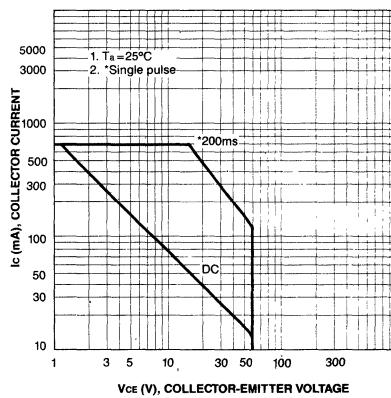
DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

POWER DERATING



SAFE OPERATING AREA

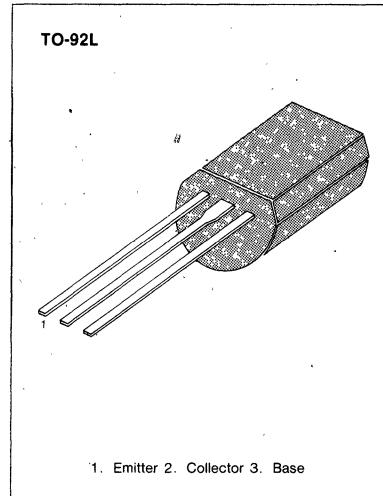


COLOR TV CHROMA OUTPUT

- Collector-Base Voltage $V_{CBO}=350V$
- Current Gain-Bandwidth Product $f_T=50MHz$ (Typ)

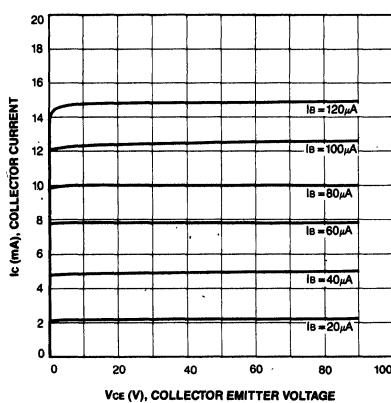
ABSOLUTE MAXIMUM RATINGS ($T_a=25^{\circ}C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	350	V
Collector-Emitter Voltage	V_{CEO}	350	V
Emitter-Base Voltage	V_{EBO}	7	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	1	W
Junction Temperature	T_J	150	$^{\circ}C$
Storage Temperature	T_{STG}	-55 ~ 150	$^{\circ}C$

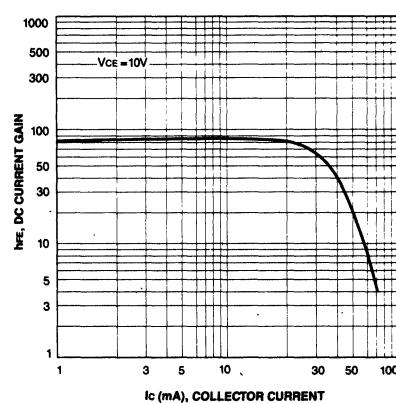
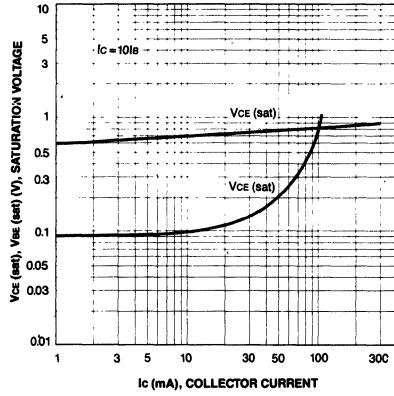
**ELECTRICAL CHARACTERISTICS ($T_a=25^{\circ}C$)**

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	350			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=5mA, I_B=0$	350			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-100\mu A, I_C=0$	7			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=200V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=200V, I_C=20mA$	30		150	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10mA, I_B=1mA$		50	0.5	V
Current Gain Bandwidth Product	f_T	$V_{CE}=10V, I_C=20mA$				MHz
Output Capacitance	C_{OB}	$V_{CB}=10V, I_E=0, f=1MHz$		8		pF

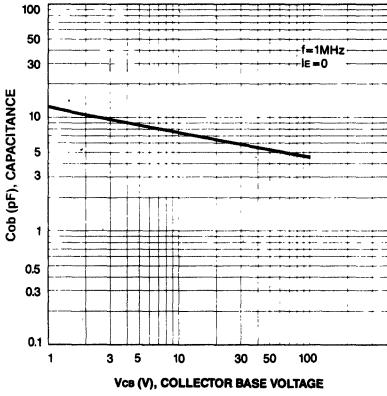
STATIC CHARACTERISTIC



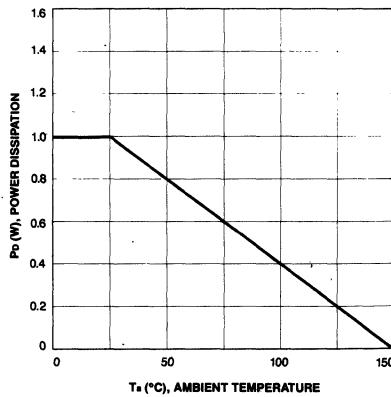
DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



POWER DERATING

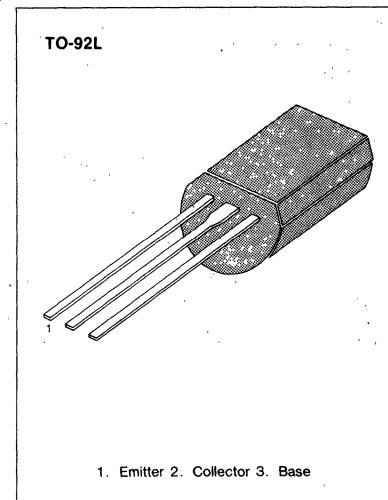


COLOR TV AUDIO OUTPUT

COLOR TV VERTICAL DEFLECTION OUTPUT

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	160	V
Collector-Emitter Voltage	V_{CEO}	160	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	1	A
Base Current	I_B	0.5	A
Collector Dissipation	P_C	900	mW
Junction Temperature	T_j	-150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

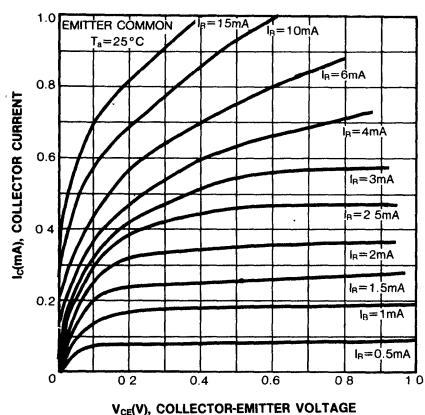
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=150\text{V}$, $I_E=0$			1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=6\text{V}$, $I_c=0$			1	μA
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=10\text{mA}$, $I_B=0$	160			V
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_c=200\text{mA}$	60		320	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=500\text{mA}$, $I_B=50\text{mA}$			1.5	V
Base Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=5\text{V}$, $I_c=5\text{mA}$	0.45		0.75	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{V}$, $I_c=200\text{mA}$	20	100	20	MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}$, $I_E=0$, $f=1\text{MHz}$				pF

 h_{FE} CLASSIFICATION

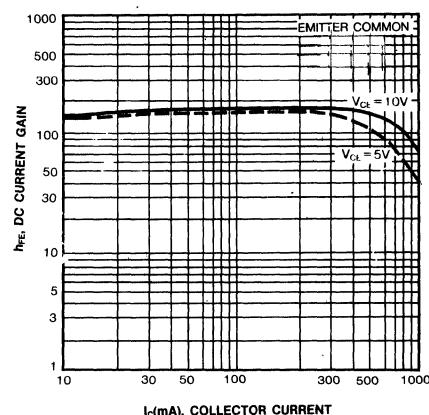
Classification	R	O	Y
h_{FE}	60-120	100-200	160-320



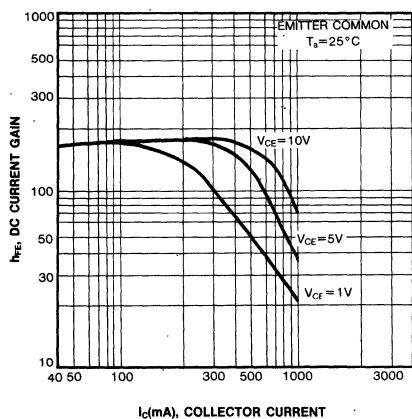
STATIC CHARACTERISTIC



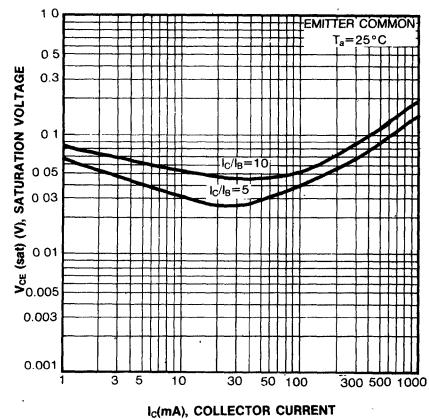
DC CURRENT GAIN



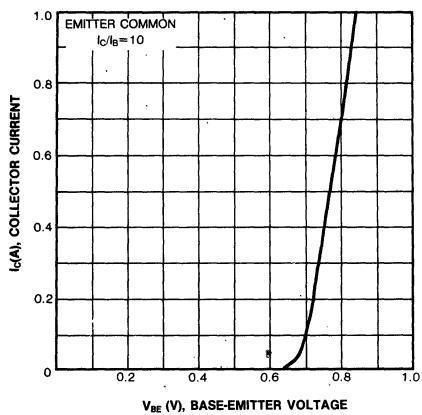
DC CURRENT GAIN



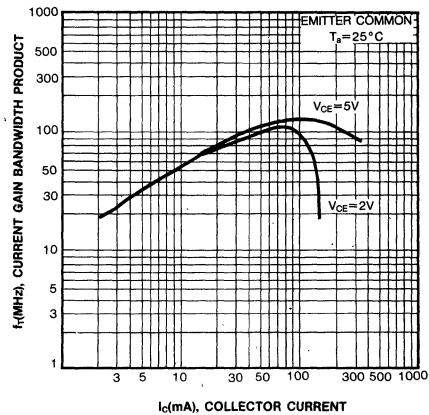
COLLECTOR-EMITTER SATURATION VOLTAGE

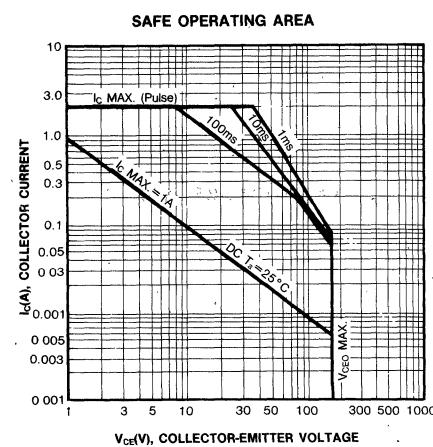
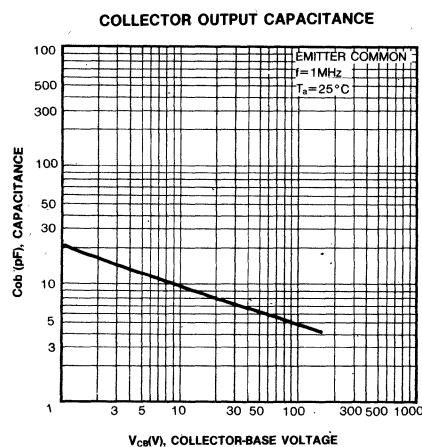


BASE-EMITTER ON VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT





MEDIUM POWER AMPLIFIER

LOW SATURATION

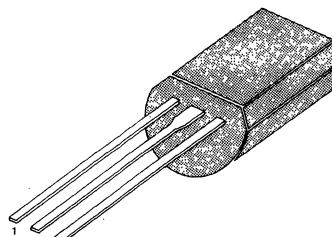
- $V_{CE}(\text{sat})=0.5V$ ($I_C=2A$, $I_B=50mA$)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CES}	30	V
Collector-Emitter Voltage	V_{CEO}	10	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current (DC)	I_C	2	A
*Collector Current (Pulse)	I_C	5	A
Base Current	I_B	0.5	A
Collector Dissipation	P_C	900	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55~150	$^\circ C$

* $PW \leq 10ms$, Duty Cycle $\leq 30\%$

TO-92L



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

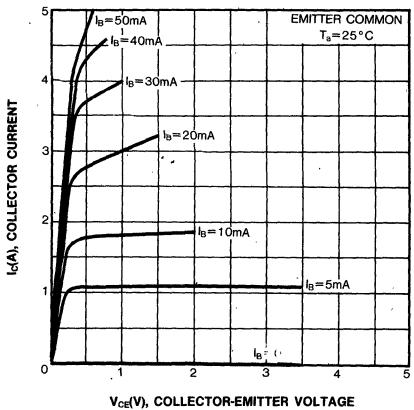
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V$, $I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=6V$, $I_C=0$			100	nA
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA$, $I_B=0$	10			V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E=1mA$, $I_C=0$	6			V
DC Current Gain	h_{FE1}	$V_{CE}=1V$, $I_C=0.5A$	140		600	
Collector Emitter Saturation Voltage	h_{FE2}	$V_{CE}=1V$, $I_C=2A$	70	200		
Base Emitter On Voltage	$V_{BE}(\text{sat})$	$I_C=2A$, $I_B=50mA$		0.2	0.5	V
Current Gain Bandwidth Product	$V_{BE}(\text{on})$	$V_{CE}=1V$, $I_C=2A$		0.86	1.5	V
Output Capacitance	f_T	$V_{CE}=1V$, $I_C=0.5A$		150		MHz
	Cob	$V_{CB}=10V$, $I_E=0$, $f=1MHz$		27		pF

$h_{FE}(1)$ CLASSIFICATION

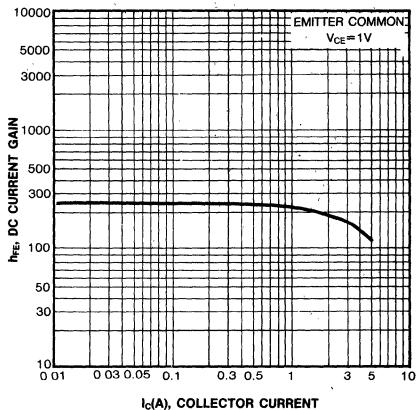
Classification	A	B	C	D
$h_{FE}(1)$	140-240	200-330	300-450	420-600



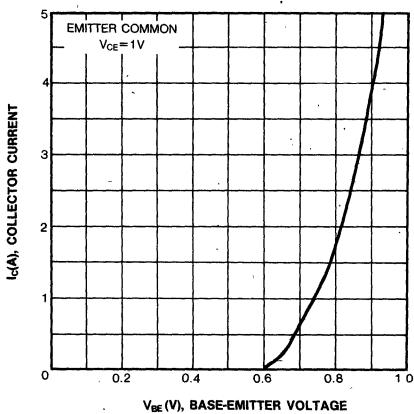
STATIC CHARACTERISTIC



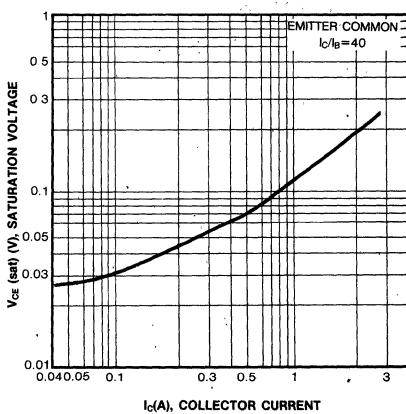
DC CURRENT GAIN



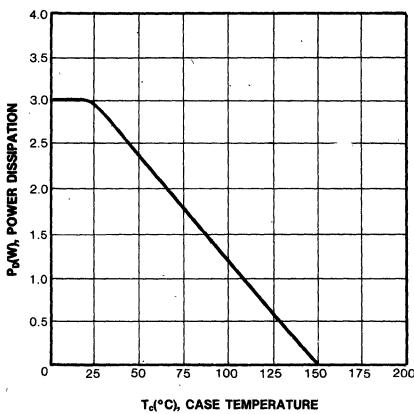
BASE-EMITTER ON VOLTAGE



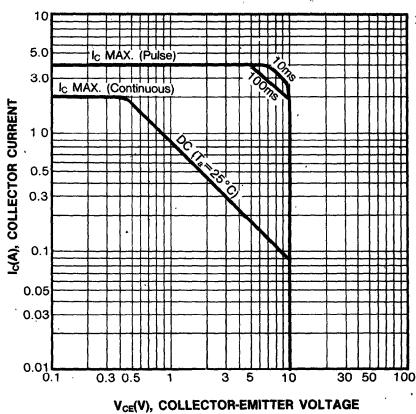
COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



SAFE OPERATING AREA



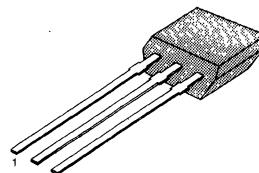
FM RADIO RF AMP, MIX, CONV, OSC, IF AMP

- High Current Gain Bandwidth Product $f_T = 250\text{MHz}$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	35	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	30	mA
Collector Dissipation	P_c	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

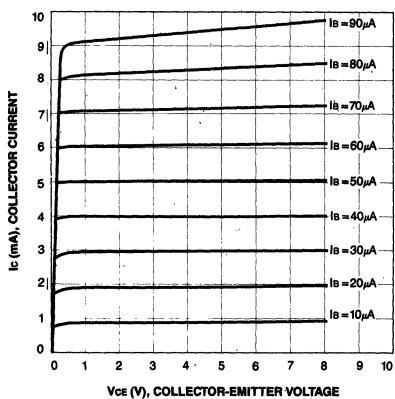
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	35			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_E = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 12\text{V}, I_C = 2\text{mA}$	40		240	
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	0.65	0.70	0.75	V
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_E = 1\text{mA}$		0.1	0.4	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 1\text{mA}$	100	250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		2.0	3.2	pF

 h_{FE} CLASSIFICATION

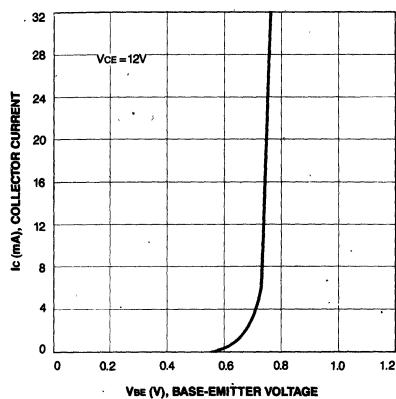
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



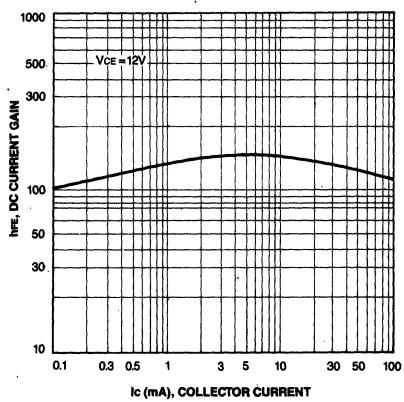
STATIC CHARACTERISTIC



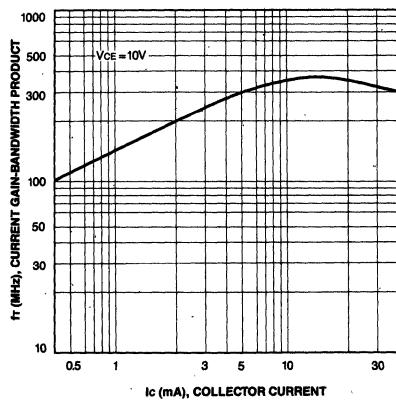
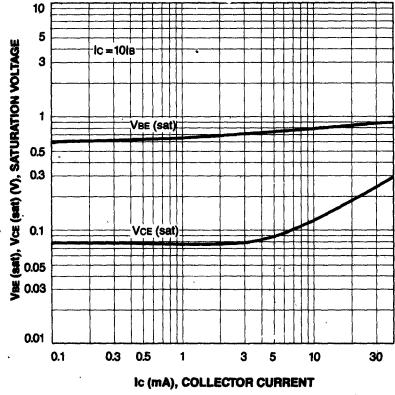
BASE-EMITTER ON VOLTAGE



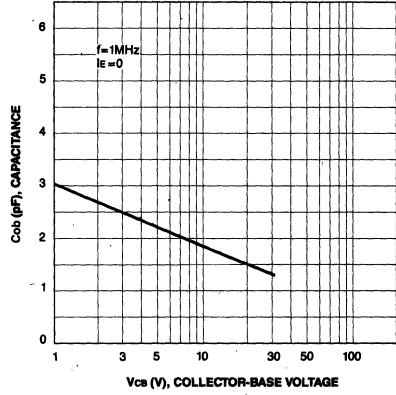
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE

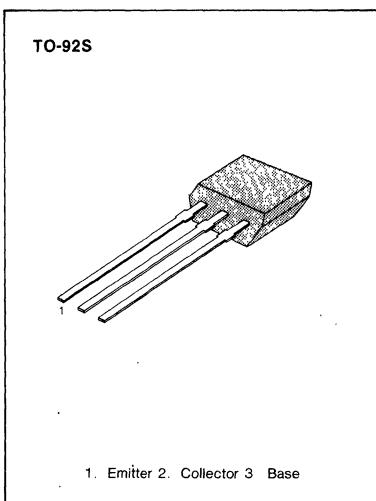


LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA1150
- Collector Dissipation $P_c = 300\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)**

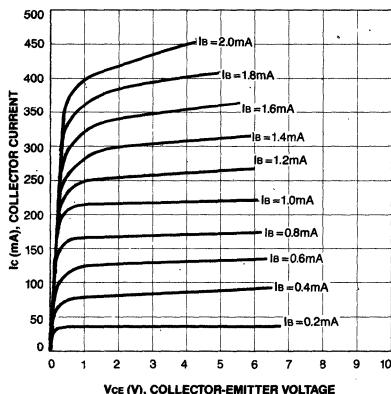
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu\text{A}, I_E = 0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 10\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_C = 0.1\text{A}$	40	0.18	400	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 0.5\text{A}, I_B = 0.05\text{A}$			0.4	V

 h_{FE} CLASSIFICATION

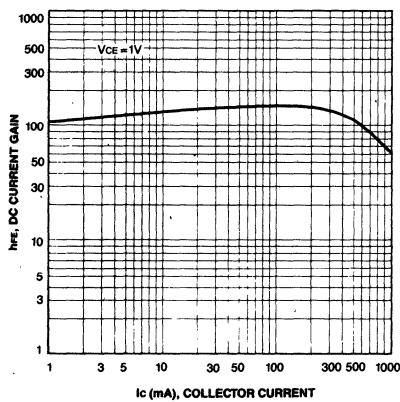
Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400



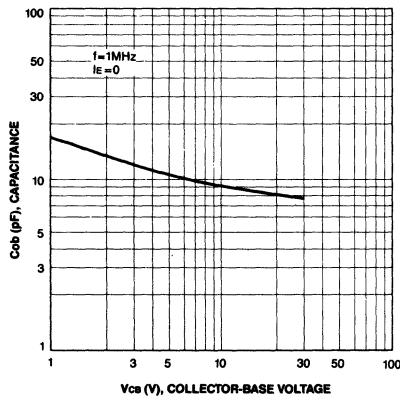
STATIC CHARACTERISTIC



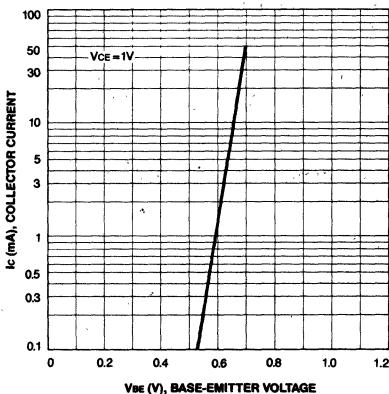
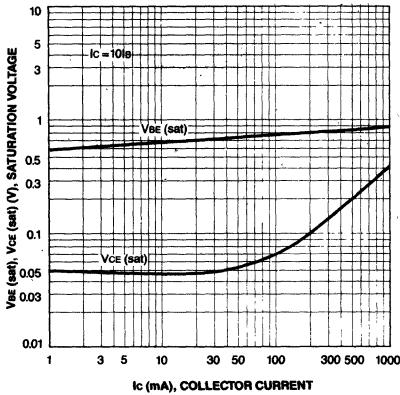
DC CURRENT GAIN



COLLECTOR OUTPUT CAPACITANCE



BASE-EMITTER ON VOLTAGE

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

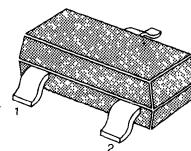
FM RADIO AMP, MIX, CONV OSC, IF AMP

- High Power Gain $G_{pe} = 30\text{dB}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	35	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_c	50	mA
Collector Dissipation	P_c	150	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

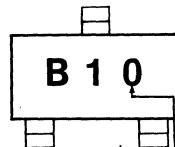
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=35\text{V}, I_E=0$			0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_C=0$			1	μA
DC Current Gain	h_{FE}	$V_{CE}=12\text{V}, I_C=2\text{mA}$	40		240	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.4	V
Base-Emitter Saturation	$V_{BE(\text{sat})}$	$I_C=10\text{mA}, I_B=1\text{mA}$			1.0	V
Current Gain-Bandwidth Product	f_T	$I_C=1\text{mA}, V_{CE}=10\text{V}$	100		400	MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		2.	3.2	pF
Power Gain	G_{pe}	$V_{CE}=6\text{V}, I_E=-1\text{mA}$ $f=10.7\text{MHz}$	27	30	33	dB

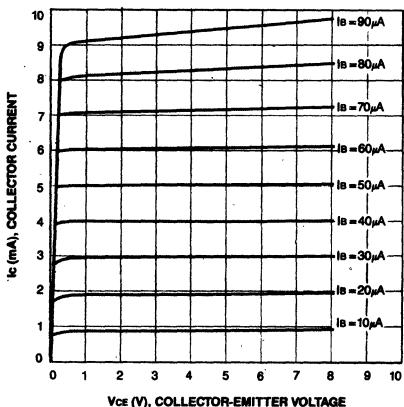
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

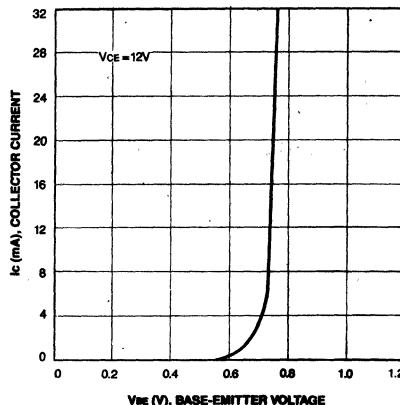
Marking

 h_{FE} grade

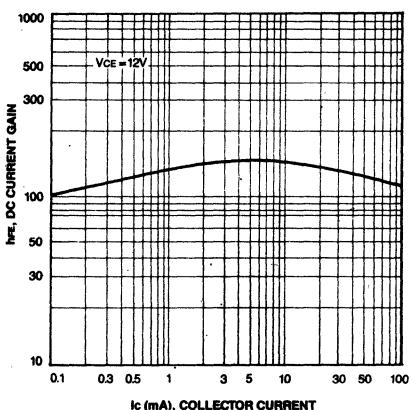
STATIC CHARACTERISTIC



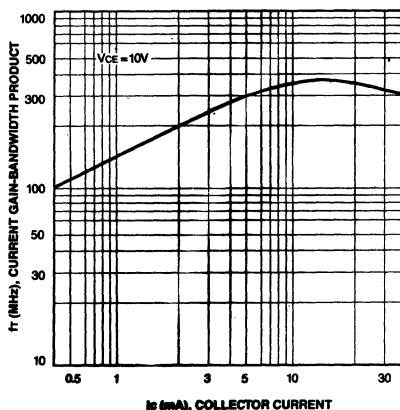
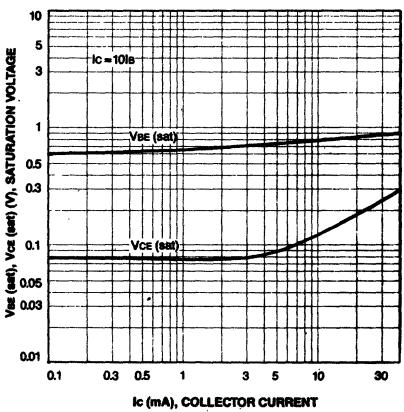
BASE-EMITTER ON VOLTAGE



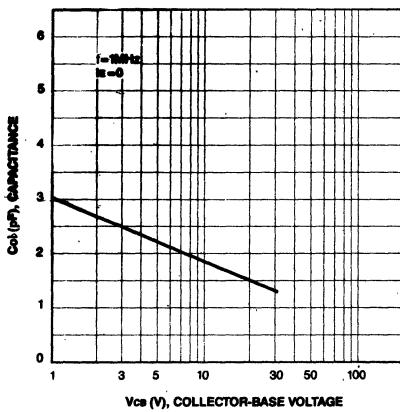
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE

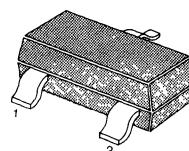


MIXER, OSC. FOR UHF TV TUNER

High f_T : 3.5GHz (TYP)ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	20	V
Collector-Emitter Voltage	V_{CEO}	12	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Current (DC)	I_c	50	mA
Collector Dissipation	P_c	150	mW
Junction Temperature	T_j	125	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~125	$^\circ\text{C}$

SOT-23

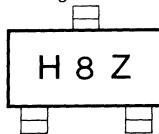


1 Base 2. Emitter 3. Collector

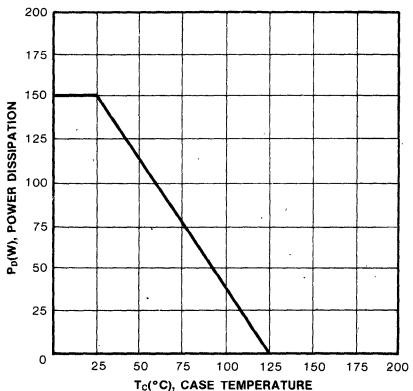
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	20			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, R_{BE}=\infty$	12			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	3			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}, I_E=0$			700	nA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=5\text{mA}$	20	90	200	
Collector Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=5\text{mA}$			0.7	V
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=10\text{mA}$	1.4	3.5	0.9	GHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$			1.5	pF

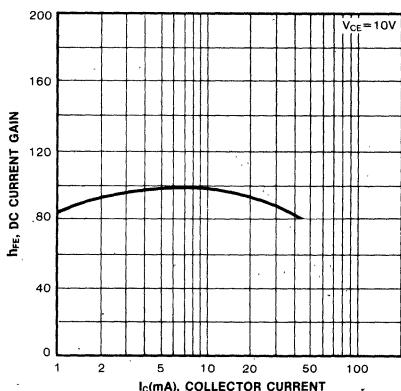
Marking



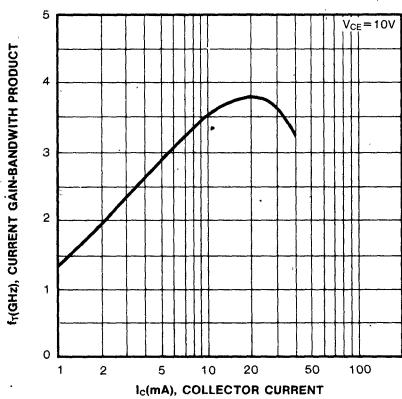
POWER DERATING



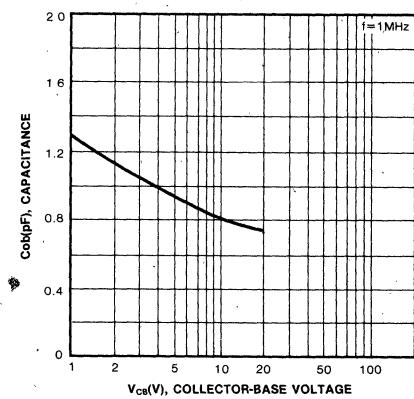
DC CURRENT GAIN



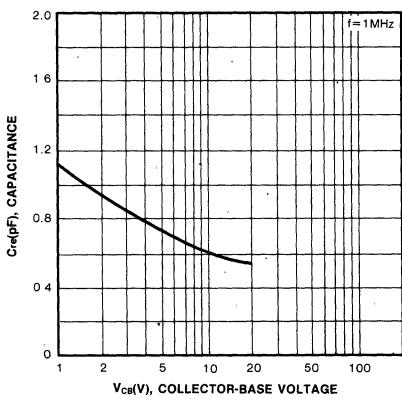
CURRENT GAIN BANDWIDTH PRODUCT



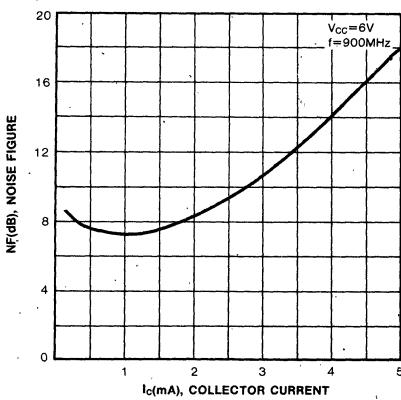
COLLECTOR OUTPUT CAPACITANCE

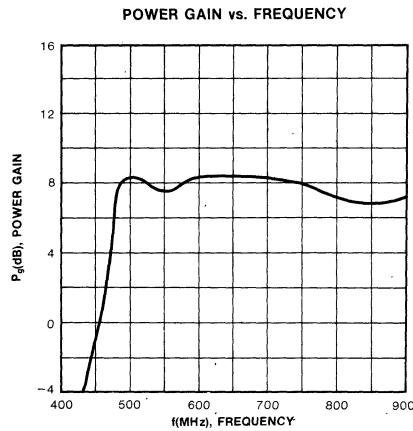
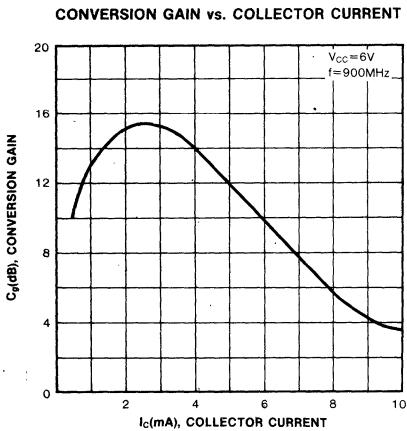
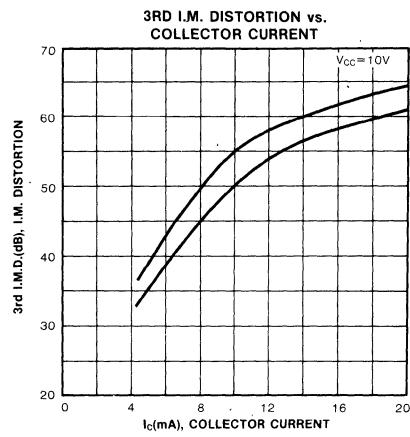
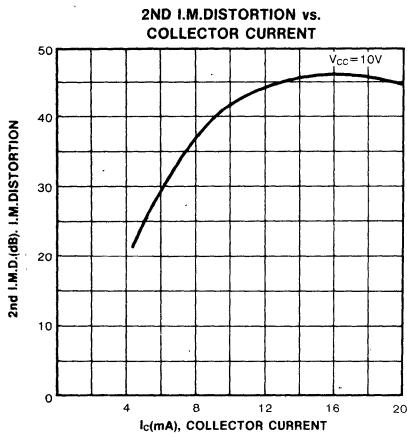
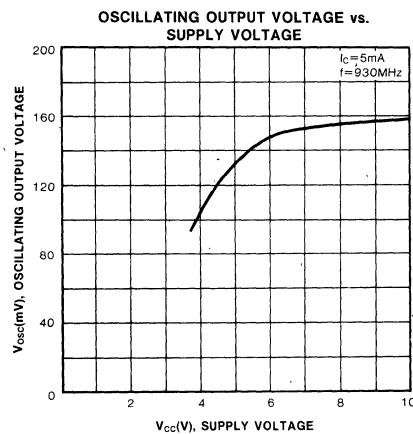
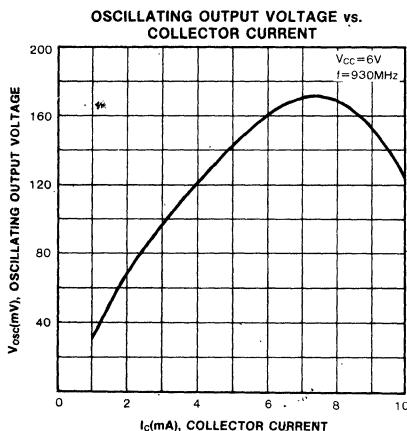


REVERSE TRANSFER CAPACITANCE



NOISE FIGURE vs. COLLECTOR CURRENT





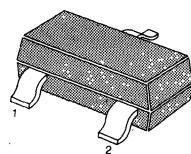
RF AMP, FOR VHF TV TUNER

- LOW NF, HIGH Gpe
- NF=2.0dB Typ. Gpe=23dB Typ. (f=200MHz)
- FORWARD AGC CAPABILITY TO 30 dB

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current (DC)	I_C	20	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

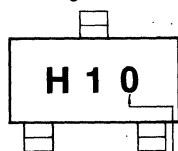
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}$, $I_C=3\text{mA}$	60	120	240	
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}$, $I_C=-3\text{mA}$	400	600		MHz
Reverse Transfer Capacitance	C_{re}	$f=1\text{MHz}$, $V_{CB}=10\text{V}$, $I_E=0$		0.3	0.5	pF
Power Gain	G_{pe}	$f=200\text{MHz}$, $I_C=3\text{mA}$	20	23		dB
AGC Current	I_{AGC}	$f=200\text{MHz}$ I_E of $G_{pe} -30\text{dB}$		-10	-12	mA
Noise Figure	NF	$f=200\text{MHz}$, $I_C=3\text{mA}$		2.0	3.0	dB

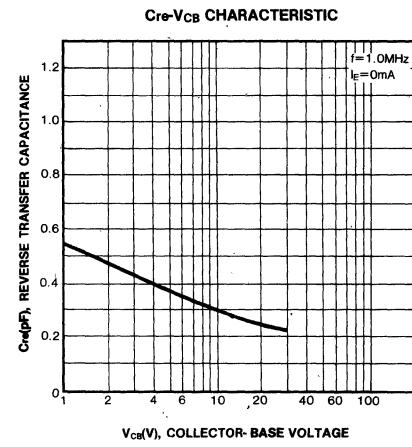
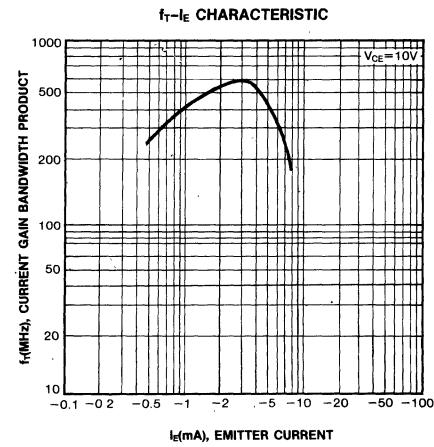
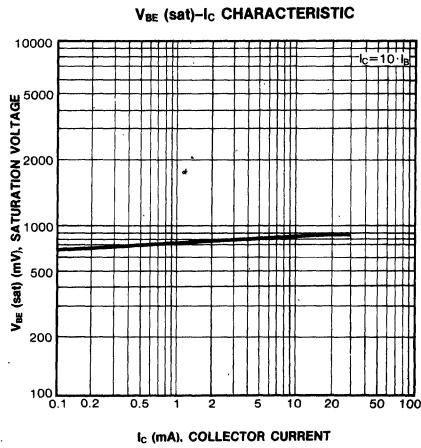
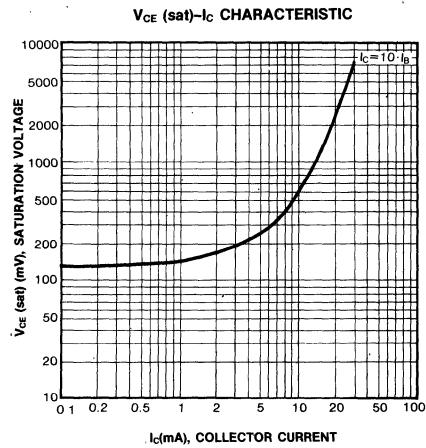
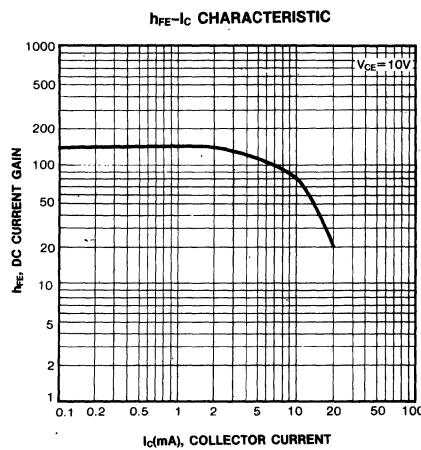
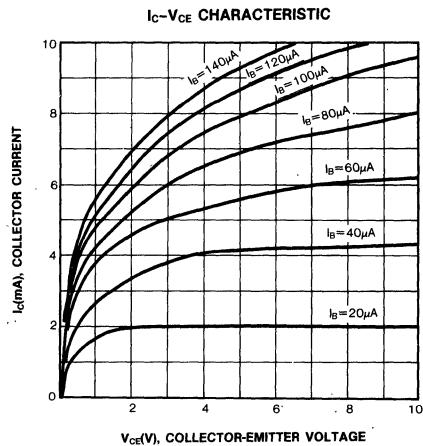
 h_{FE} CLASSIFICATION

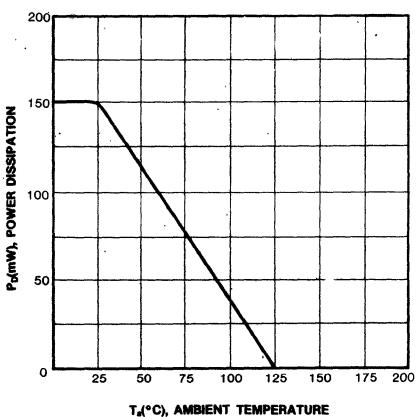
Classification	R	O	Y
h_{FE}	60-120	90-180	120-240

Marking

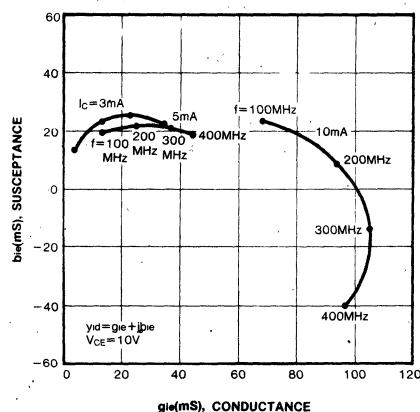
 h_{FE} grade

SAMSUNG SEMICONDUCTOR

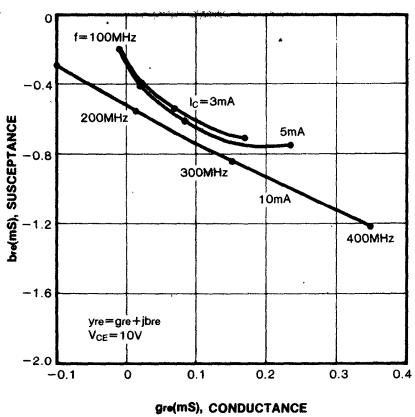


P_D-T_A CHARACTERISTIC

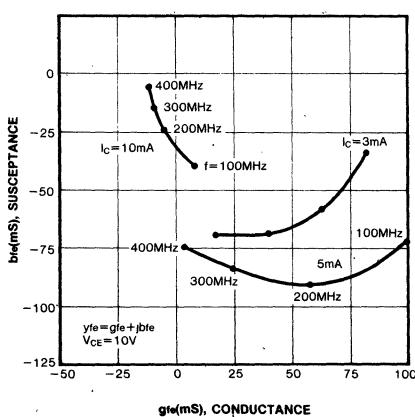
yie-f CHARACTERISTIC



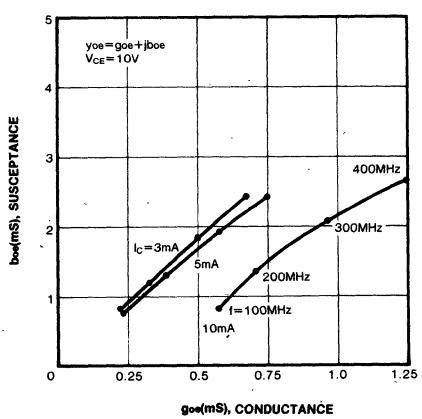
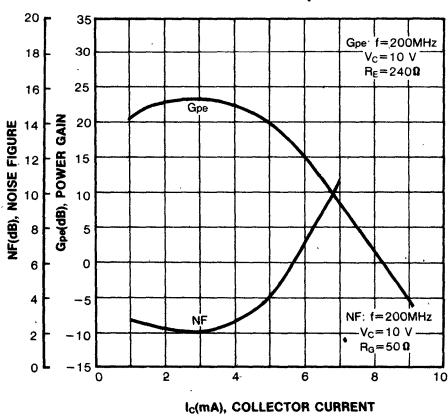
yre-f CHARACTERISTIC



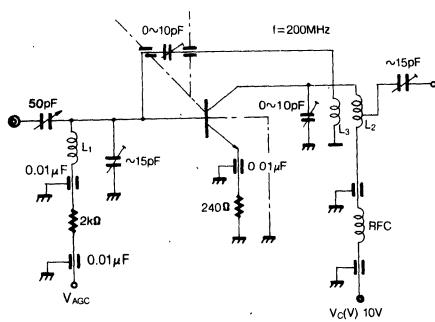
yfe-f CHARACTERISTIC



yoe-f CHARACTERISTIC

G_{pe}-I_C, NF-I_C CHARACTERISTIC

POWER GAIN AND NOISE FIGURE TEST



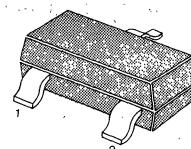
MIXER FOR VHF TV TUNER

- HIGH Gce (Typ. 23dB)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	30	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

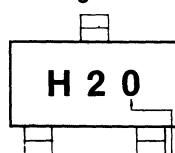
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

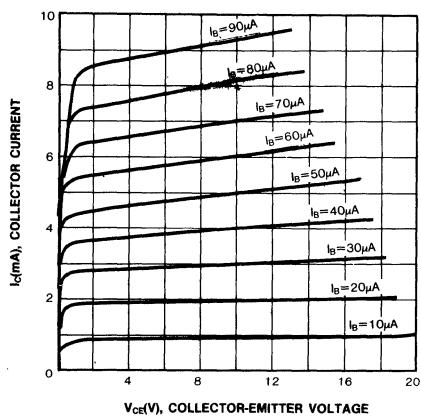
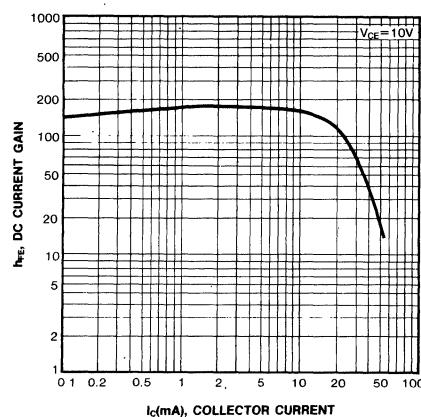
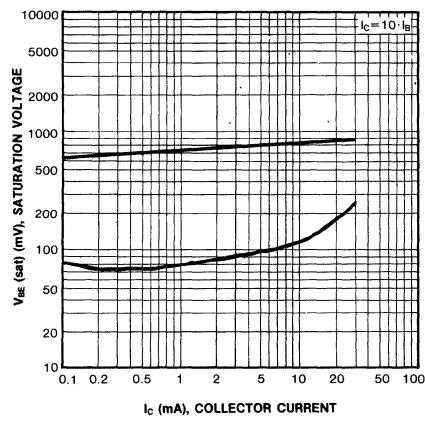
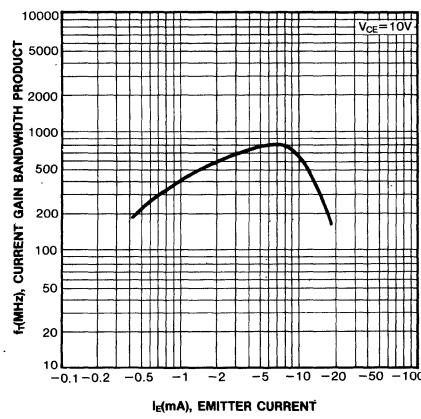
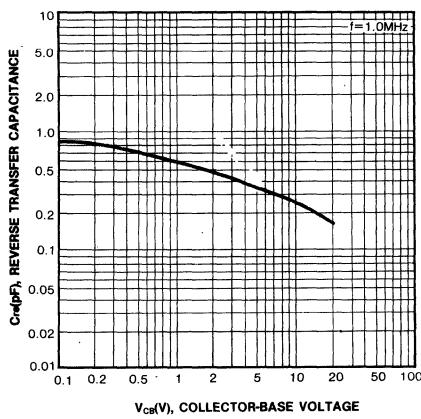
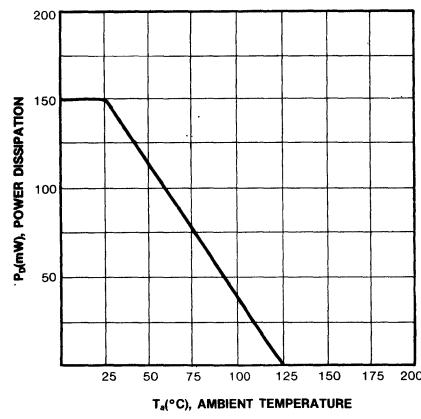
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}$, $I_C=5\text{mA}$	60	120	240	
Collector Emitter Saturation Voltage	V_{CE} (sat)	$I_C=10\text{mA}$, $I_B=1\text{mA}$			0.5	V
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}$, $I_E=-5\text{mA}$	500	850	1MHz	MHz
Reverse Transfer Capacitance	C_{re}	$V_{CB}=10\text{V}$, $I_E=0$, $f=1\text{MHz}$		0.35	0.5	pF
Conversion Gain	G_{ce}	$V_{CE}=10\text{V}$, $I_C=3\text{mA}$	15	23		dB
Noise Figure	NF	$f_{RF}=200\text{MHz}$, $I_F=58\text{MHz}$ $V_{CE}=10\text{V}$, $I_C=3\text{mA}$ $f_{RF}=200\text{MHz}$, $I_F=58\text{MHz}$		6.5		dB

 h_{FE} CLASSIFICATION

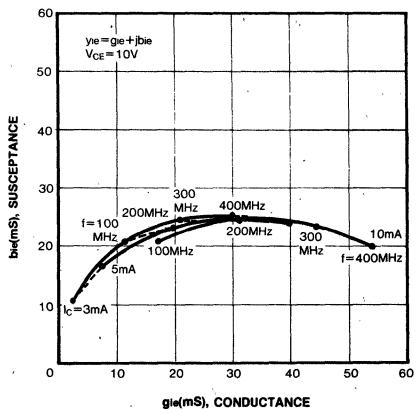
Classification	R	O	Y
h_{FE}	60-120	90-180	120-240

Marking

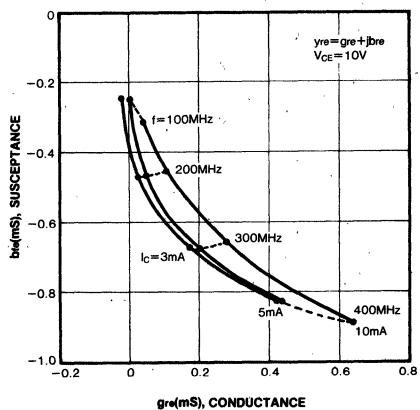
 h_{FE} grade

I_C-V_{CE} CHARACTERISTIC**h_{FE}-I_C CHARACTERISTIC****V_{ce(sat)}, V_{be(sat)}-I_c CHARACTERISTIC****f_T-I_E CHARACTERISTIC****C_{re}-V_{cb} CHARACTERISTIC****P_D-T_a CHARACTERISTIC**

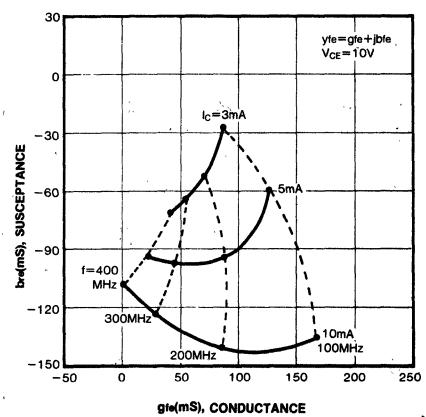
yie-f CHARACTERISTIC



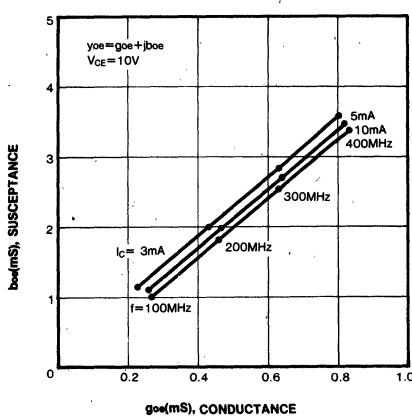
yre-f CHARACTERISTIC



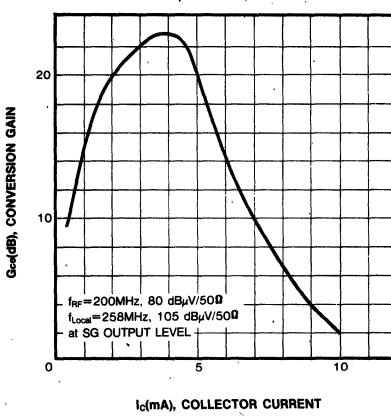
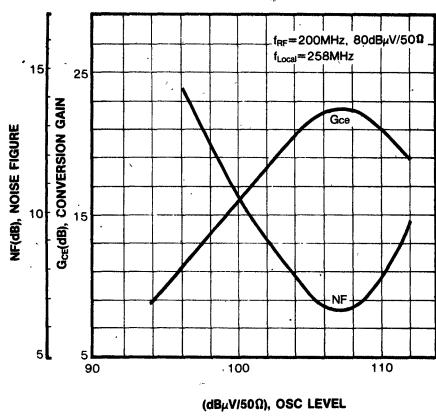
yfe-f CHARACTERISTIC



yoe-f CHARACTERISTIC



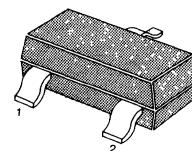
NF-OSC LEVEL, Gce-OSC LEVEL



MIXER OSCILLATOR FOR VHF TUNERHIGH f_T ($f_T = 1100\text{MHz}$ Typ.)**ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)**

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23



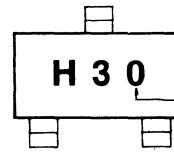
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

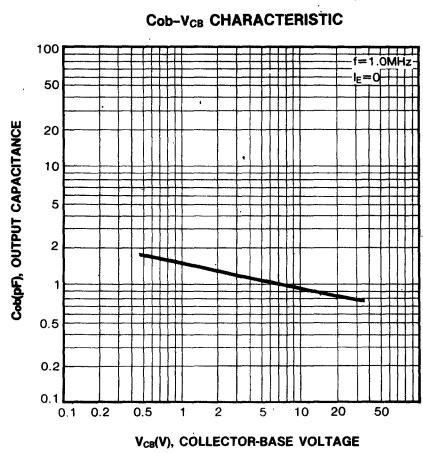
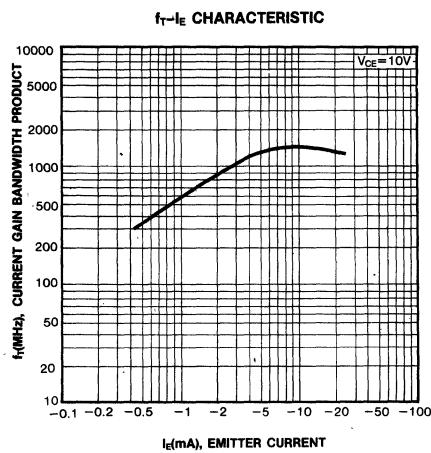
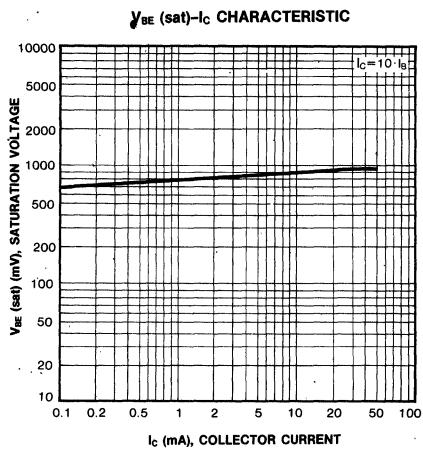
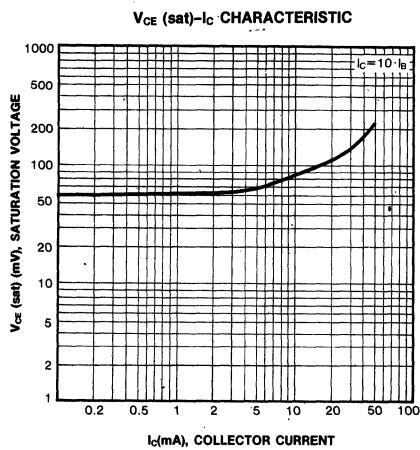
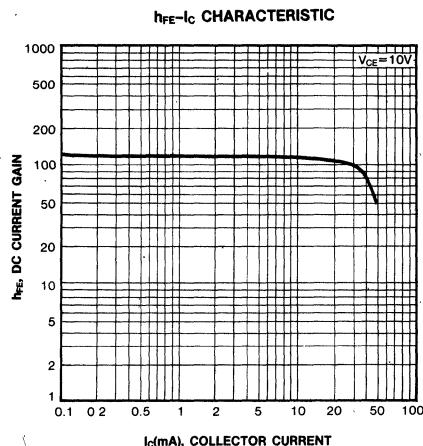
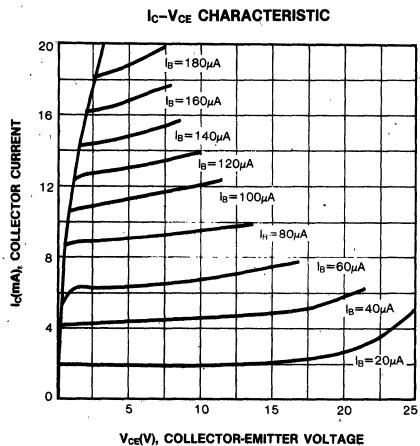
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 12\text{V}$, $I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}$, $I_C = 5\text{mA}$	60	120	240	
Collector Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}$, $I_E = 1\text{mA}$			0.5	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 10\text{V}$, $I_E = -5\text{mA}$	800	1100	1.5	MHz
Output Capacitance	C_{ob}	$f = 1\text{MHz}$, $V_{CB} = 10\text{V}$			1.5	pF
Collector Base Time Constant	$C_{C \cdot rbb}$	$I_E = 0$ $f = 31.9\text{MHz}$, $V_{CE} = 10\text{V}$ $I_E = -5\text{mA}$		10	15	ps

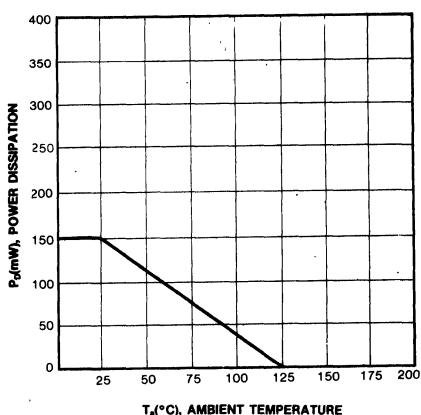
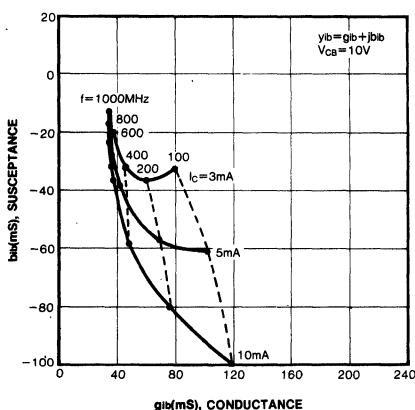
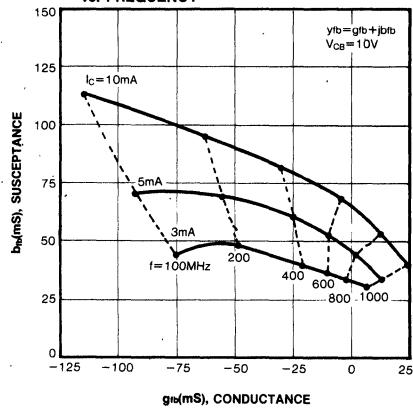
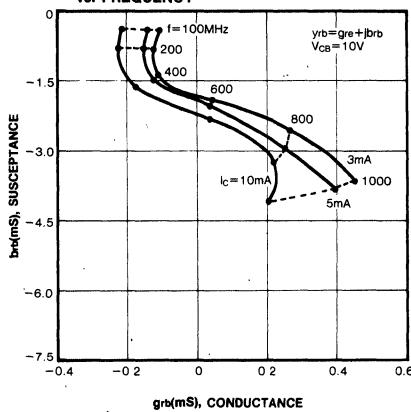
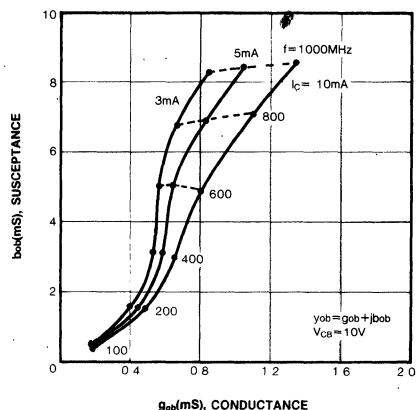
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	60-120	90-180	120-240

Marking h_{FE} grade

SAMSUNG SEMICONDUCTOR



P_D-T_a CHARACTERISTICINPUT ADMITTANCE (y_{ib}) vs. FREQUENCYFORWARD TRANSFER ADMITTANCE (y_{fb}) vs. FREQUENCYREVERSE TRANSFER ADMITTANCE (y_{rb}) vs. FREQUENCYOUTPUT ADMITTANCE (y_{ob}) vs. FREQUENCY

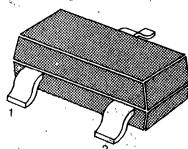
RF. MIXER FOR UHF TUNER

- HIGH POWER GAIN TYP. 17dB
- LOW NF TYP. 2.8dB

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current (DC)	I_c	20	mA
Collector Dissipation	P_c	150	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23



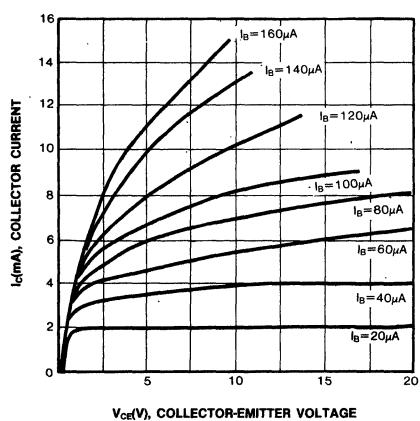
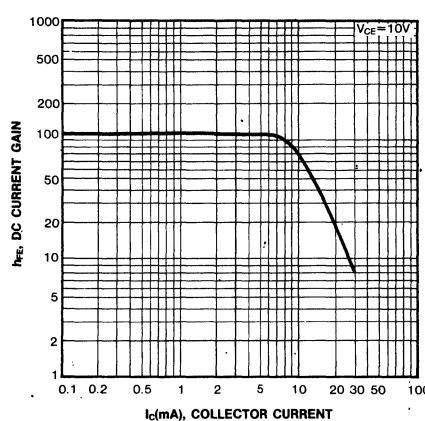
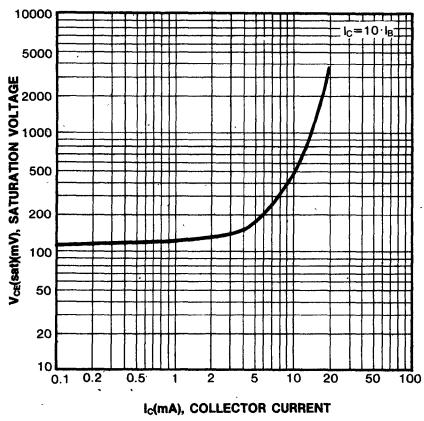
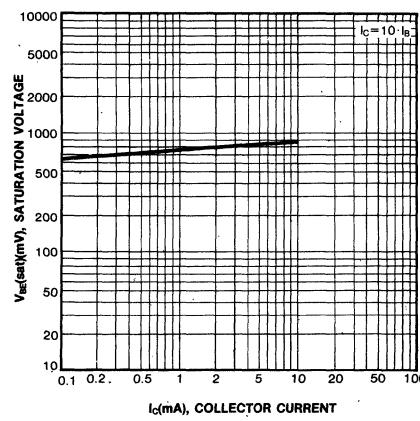
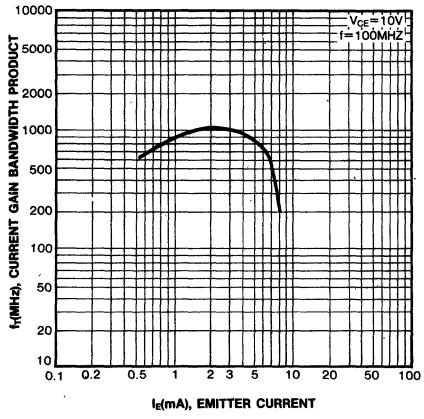
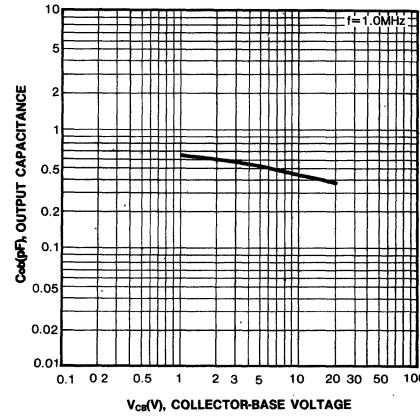
1. Base 2. Emitter 3. Collector

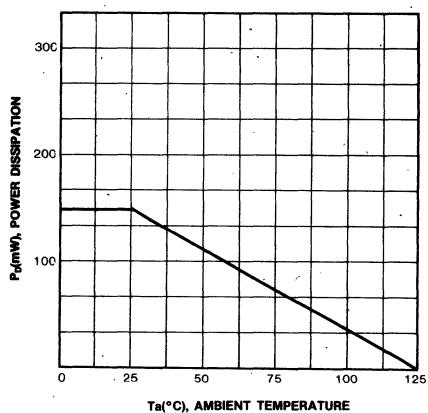
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=25\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_c=3\text{mA}$	60	120	240	
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_E=-3\text{mA}$	750	1000		MHz
Output Capacitance	C_{ob}	$f=1\text{MHz}, V_{CB}=10\text{V}, I_E=0$		0.6	0.8	pF
Noise Figure	NF	$V_{CB}=10\text{V}, I_E=-3\text{mA}$ $f=900\text{MHz}$		2.8	4.5	dB
Power Gain	G_{pb}	$V_{CB}=10\text{V}, I_E=-3\text{mA},$ $f=900\text{MHz}$	14	17		
AGC Current	I_{AGC}	$G_{pb} \text{ AGC} = I_E \text{ of } G_{pb} - 30\text{dB}$		-8	-11	mA

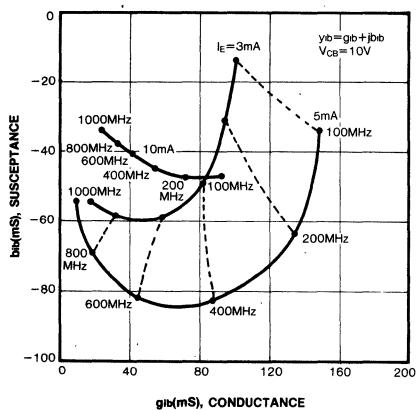
Marking



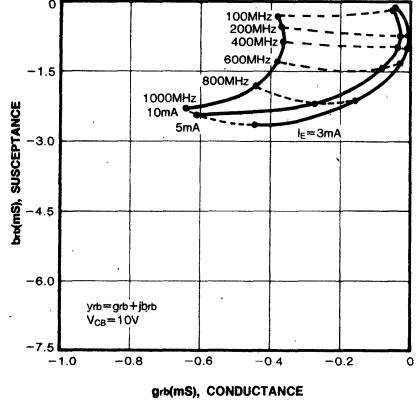
I_C-V_{CE} CHARACTERISTIC **h_{FE} -I_C CHARACTERISTIC****V_{CE(sat)}-I_C CHARACTERISTIC****V_{BE(sat)}-I_C CHARACTERISTIC****f-I_E CHARACTERISTIC****C_{ob}-V_{CB} CHARACTERISTIC**

P_D-T_A CHARACTERISTIC

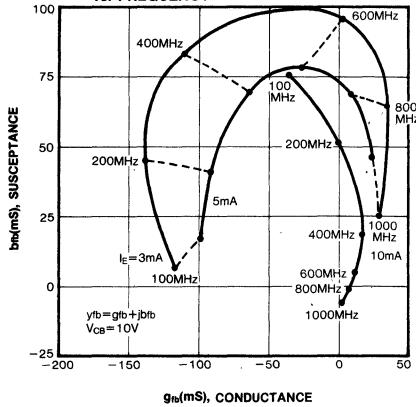
INPUT ADMITTANCE vs. FREQUENCY



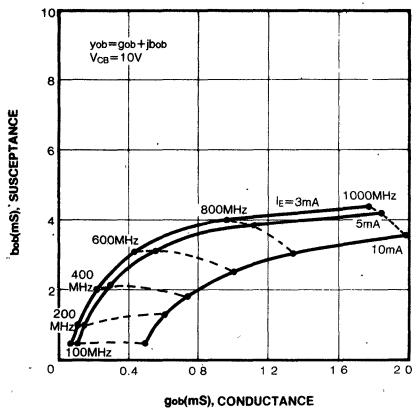
REVERSE TRANSFER ADMITTANCE vs. FREQUENCY



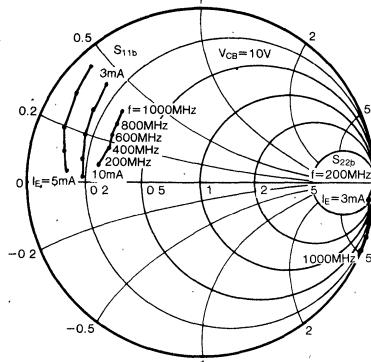
FORWARD TRANSFER ADMITTANCE vs. FREQUENCY



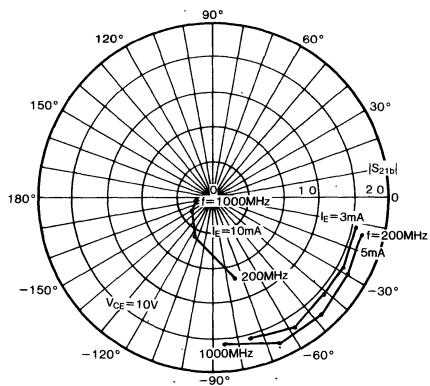
OUTPUT ADMITTANCE vs. FREQUENCY



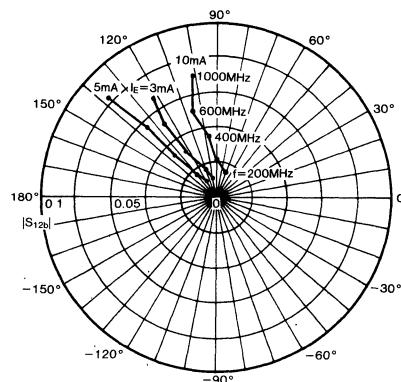
INPUT AND OUTPUT REFLECTION COEFFICIENT vs. FREQUENCY



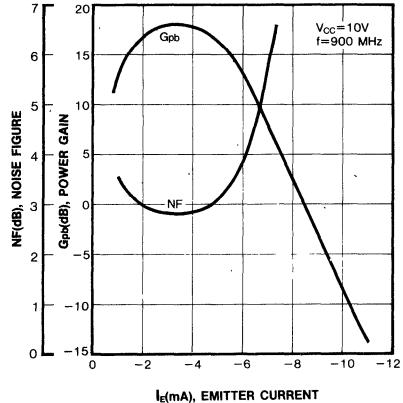
FORWARD INSERTION GAIN vs. FREQUENCY



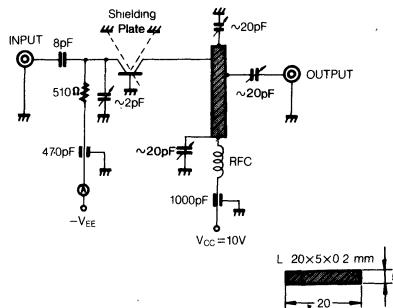
REVERSE INSERTION GAIN vs. FREQUENCY



POWER GAIN AND NOISE FIGURE vs. COLLECTOR CURRENT



900 MHz Gpb, NF TEST CIRCUIT

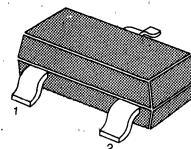


MIXER, OSCILLATOR FOR UHF TUNER

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	14	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

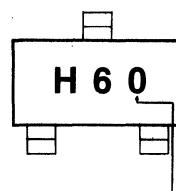
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}$, $I_C=5\text{mA}$	40	100	180	GHz
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}$, $I_C=-5\text{mA}$	1.5	2		
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}$, $I_E=0$, $f=1\text{MHz}$		1	1.3	pF
Conversion Gain	G_{CB}	$V_{CB}=10\text{V}$, $I_E=-5\text{mA}$ $f_{RF}=900\text{MHz}$, $f_{osc}=935\text{MHz}$ 115dB μ	10	12.5		dB

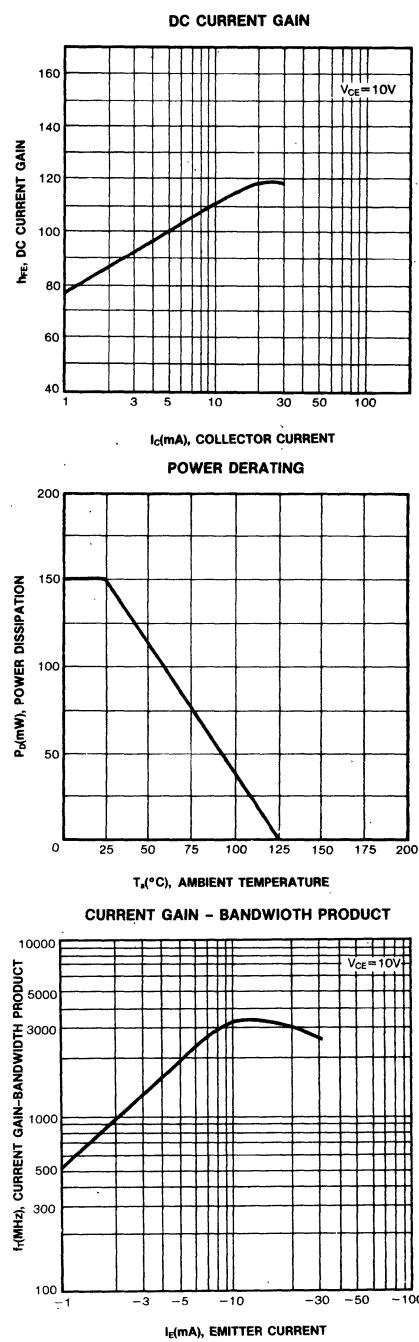
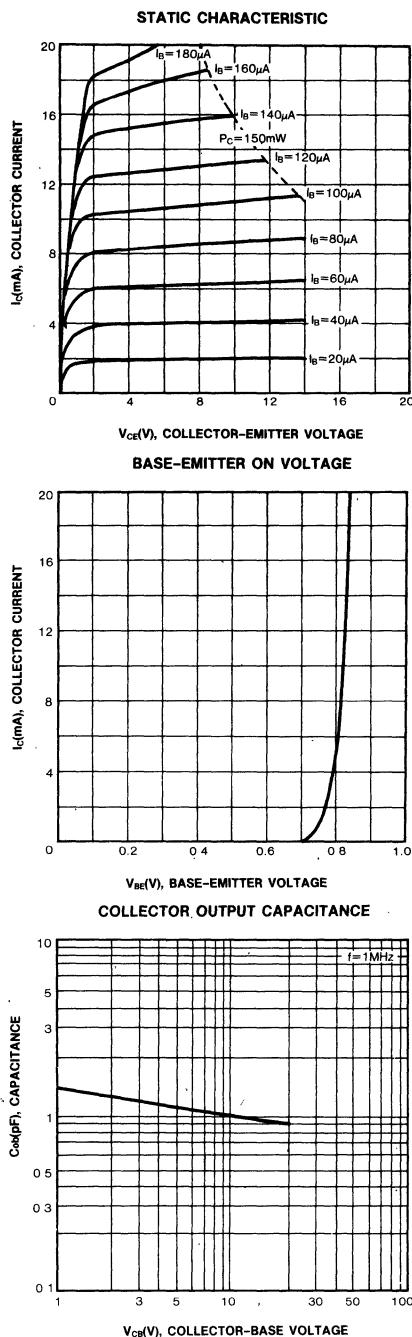
 h_{FE} CLASSIFICATION

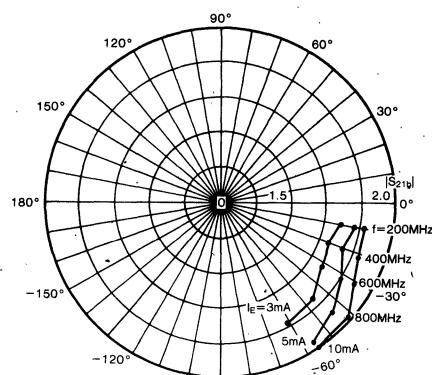
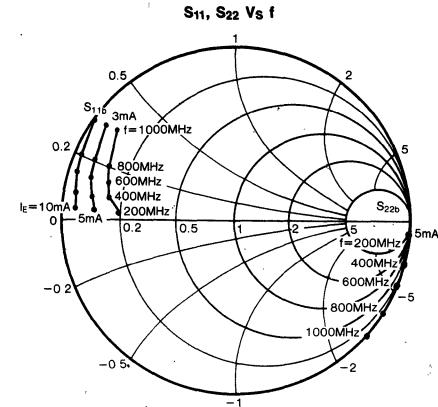
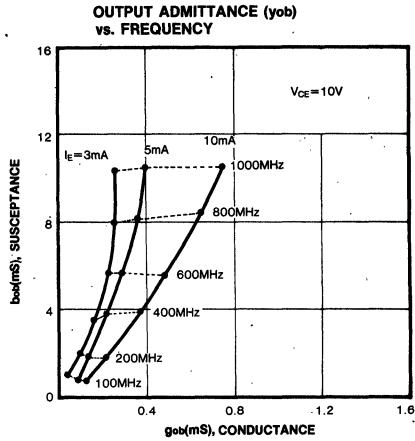
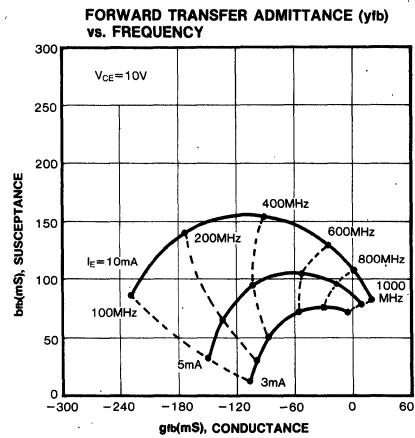
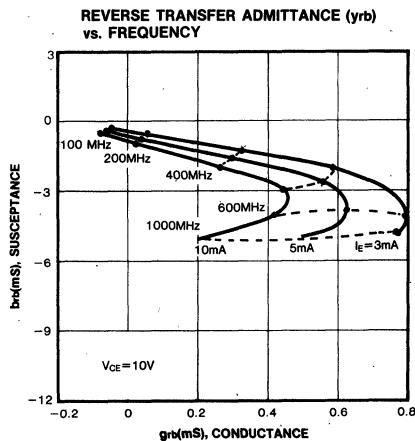
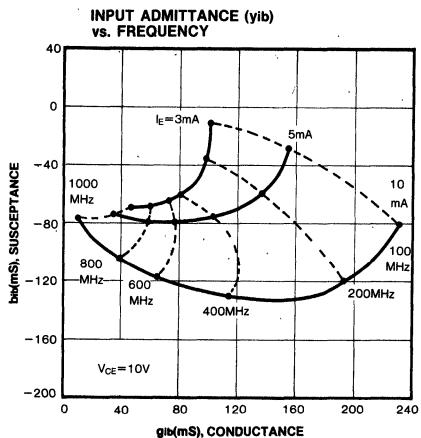
Classification	R	O	Y
h_{FE}	40-80	60-120	90-180

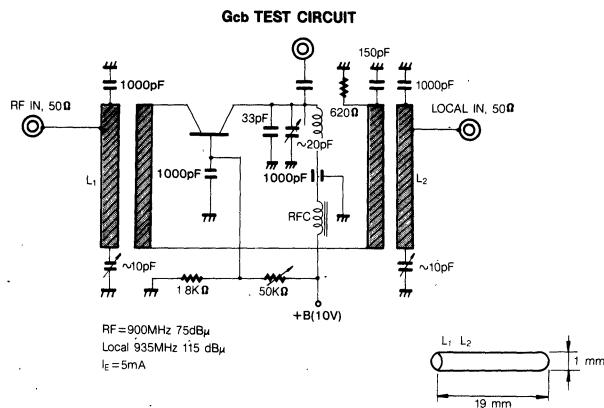
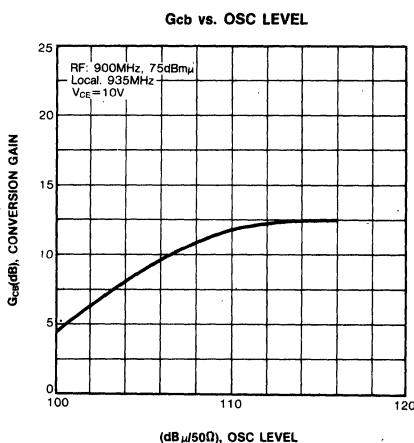
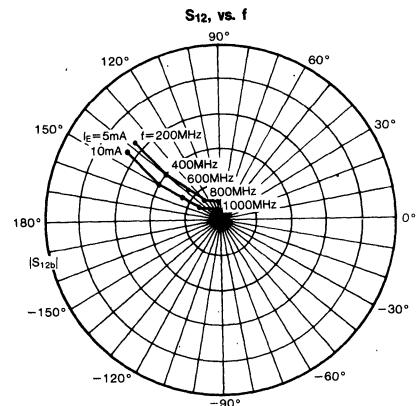
Marking

 h_{FE} grade

SAMSUNG SEMICONDUCTOR





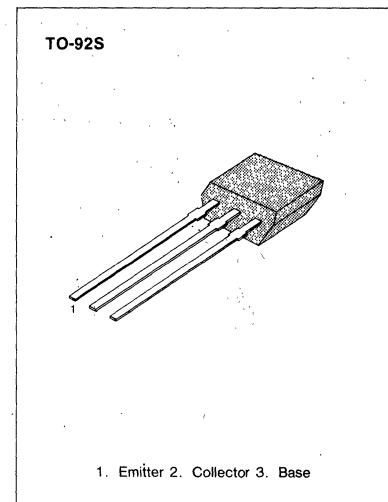


AUDIO FREQUENCY LOW NOISE AMPLIFIER

- Complement to KSA1174

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	120	V
Collector-Emitter Voltage	V_{CEO}	120	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	50	mA
Base Current	I_b	10	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

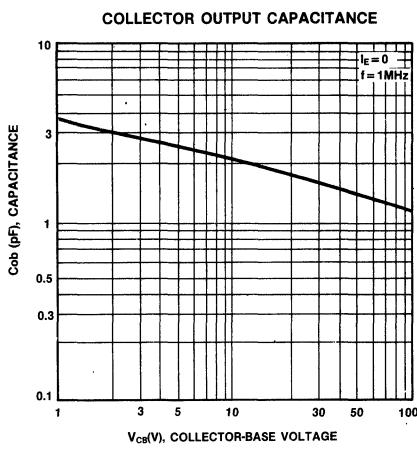
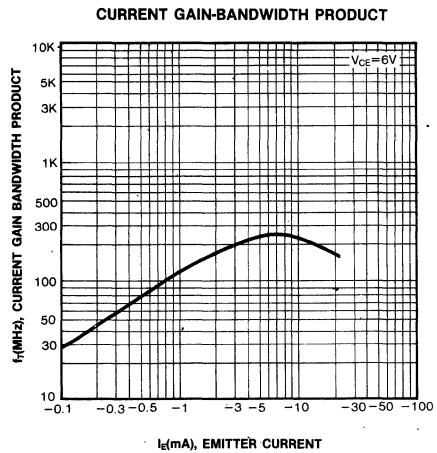
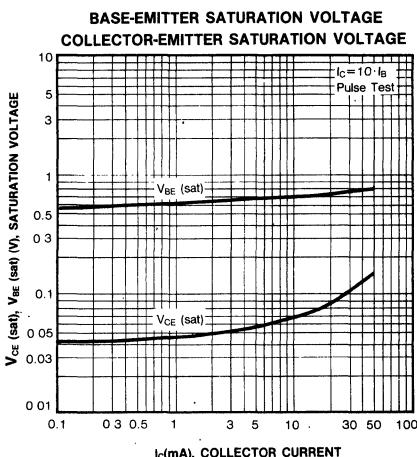
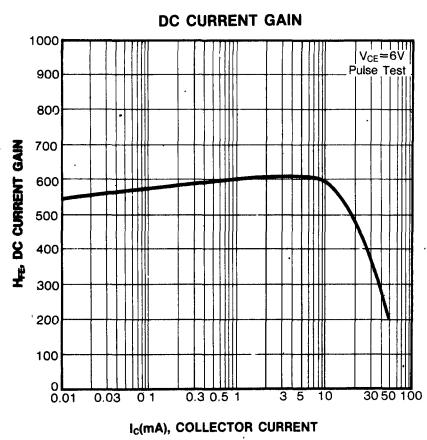
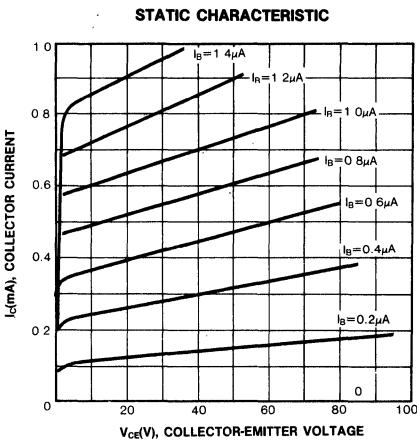
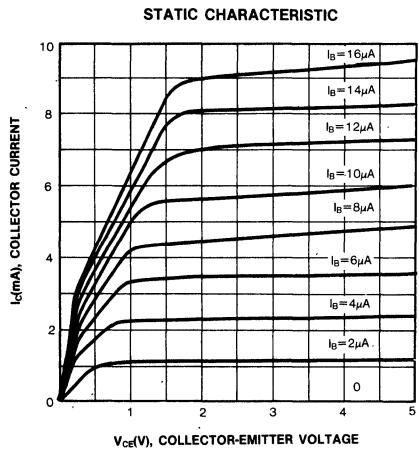
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=120\text{V}, I_e=0$			50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}, I_c=0$			50	nA
DC Current Gain	h_{FE1}	$V_{CE}=6\text{V}, I_c=0.1\text{mA}$	150	580		
	h_{FE2}	$V_{CE}=6\text{V}, I_c=1\text{mA}$	200	600	1200	
Base Emitter On Voltage	V_{BE} (on)	$V_{CE}=6\text{V}, I_c=1\text{mA}$	0.55	0.59	0.65	V
Collector Emitter Saturation Voltage	V_{CE} (sat)	$I_c=10\text{mA}, I_b=1\text{mA}$		0.07	0.3	V
Current Gain Bandwidth Product	f_T	$V_{CE}=6\text{V}, I_e=-1\text{mA}$	50	110		MHz
Output Capacitance	C_{ob}	$V_{CB}=30\text{V}, I_e=0$ $f=1\text{MHz}$		1.6	2.5	pF
Noise Voltage	NV			25	40	mV

 $h_{FE}(2)$ CLASSIFICATION

Classification	P	F	E	U
$h_{FE}(2)$	200-400	300-600	400-800	600-1200



SAMSUNG SEMICONDUCTOR



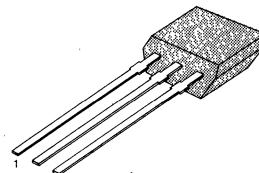
**AUDIO FREQUENCY AMPLIFIER
HIGH FREQUENCY OSC.**

- Complement to KSA1175
- Collector-Base Voltage $V_{CBO} = 60V$
- High Current Gain Bandwidth Product $f_T = 300MHz$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	150	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

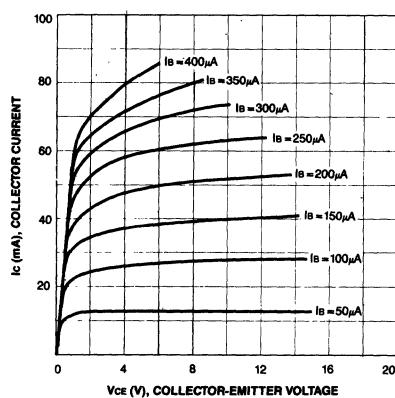
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	50			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6V, I_C = 1.0mA$	70		700	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 100mA, I_B = 10mA$		0.15	0.3	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 6V, I_C = 10mA$		300		MHz
Output Capacitance	Cob	$V_{CB} = 6V, I_E = 0$ $f = 1MHz$		2.5		pF
Noise Figure	NF	$V_{CE} = 6V, I_E = -0.5mA$ $f = 1KHz, R_s = 500\Omega$		4.0		dB

 h_{FE} CLASSIFICATION

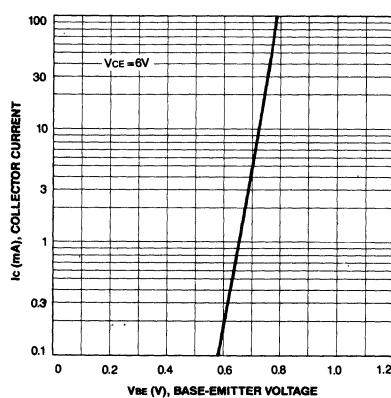
Classification	O	Y	G	L
h_{FE}	70-140	120-240	200-400	350-700



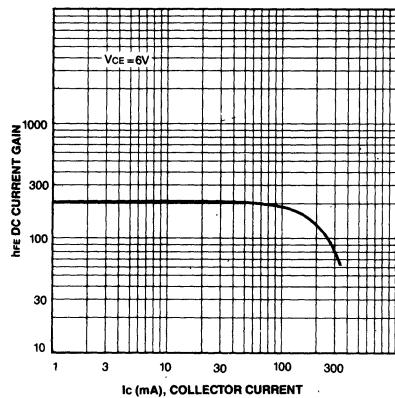
STATIC CHARACTERISTIC



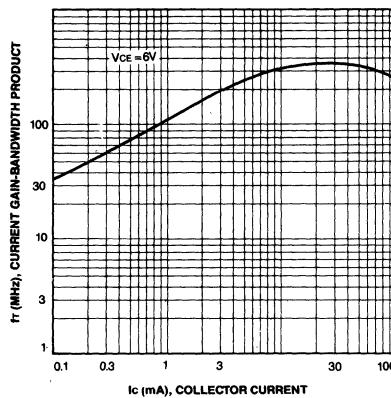
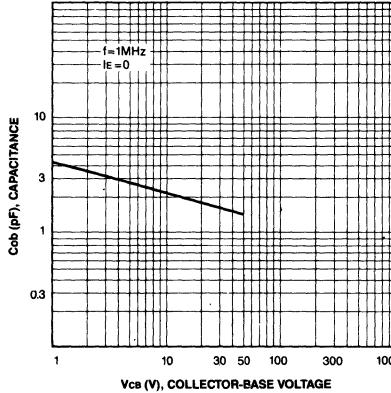
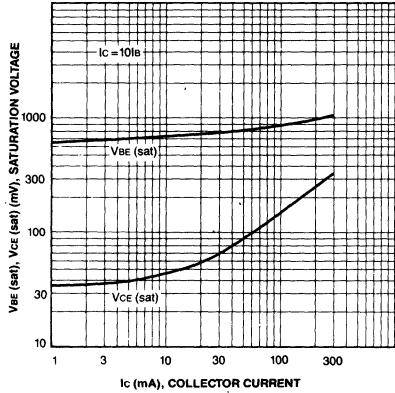
TRANSFER CHARACTERISTIC



DC CURRENT GAIN



CURRENT GAIN BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

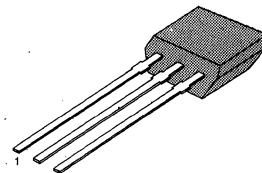
**TV PIF AMPLIFIER, FM TUNER RF AMPLIFIER,
MIXER, OSCILLATOR**

- High Current-Gain-Bandwidth Product $f_T = 600\text{MHz}$ (Typ)
- High Power Gain $G_{pe} = 22\text{dB}$ at $f = 100\text{MHz}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	20	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	40		240	
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$		0.72		V
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_E = 1\text{mA}$		0.1	0.3	V
Current-Gain-Bandwidth Product	f_T	$V_{CE} = 6\text{V}, I_C = 1\text{mA}$	400	600		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6\text{V}, I_E = 0$ $f = 1\text{MHz}$		1.2		pF
Collector-Base Time Constant	$C_{crbb'}$	$V_{CE} = 6\text{V}, I_E = -1\text{mA}$ $f = 31.9\text{MHz}$		12	15	ps
Common Source Noise Figure	NF	$V_{CE} = 6\text{V}, I_E = -1\text{mA}$ $R_s = 50\Omega, f = 100\text{MHz}$		3.0	5.0	dB
Power Gain	G_{pe}	$V_{CE} = 6\text{V}, I_E = -1\text{mA}$ $R_s = 50\Omega, f = 100\text{MHz}$ (Typ)	18	22		dB

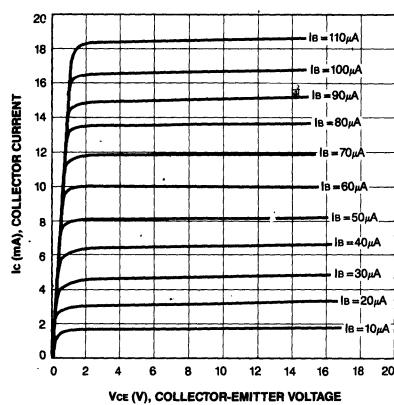
 h_{FE} CLASSIFICATION

Classification	R	O	Y
h_{FE}	40-80	70-140	120-240

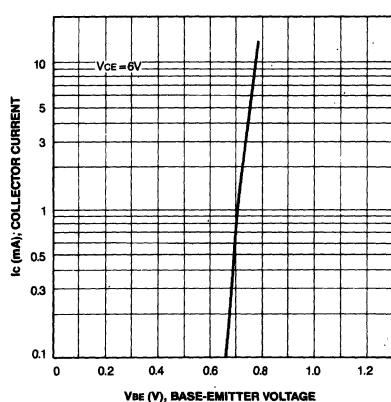


SAMSUNG SEMICONDUCTOR

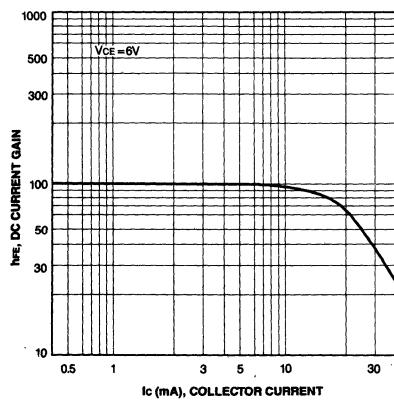
STATIC CHARACTERISTIC



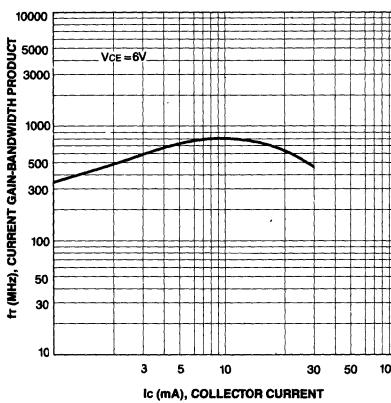
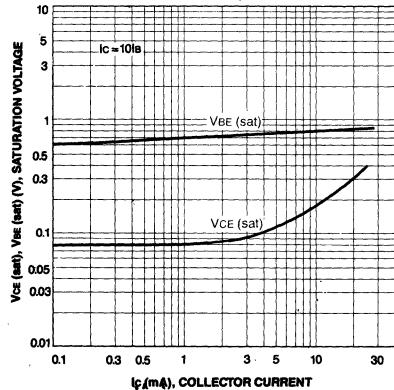
BASE-EMITTER ON VOLTAGE



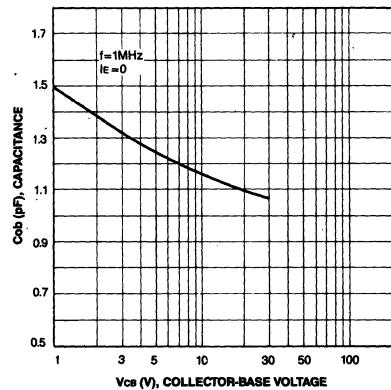
DC CURRENT GAIN

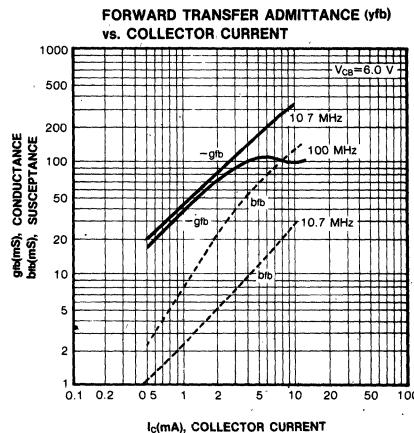
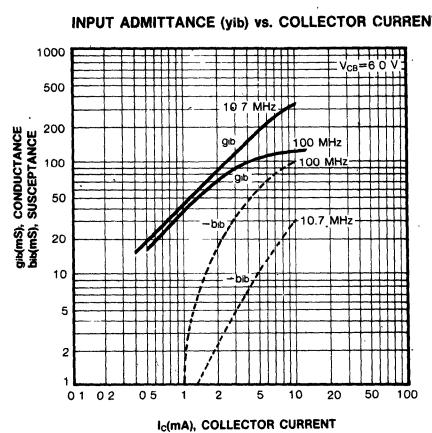
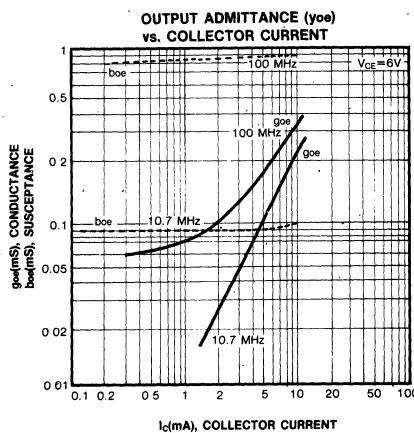
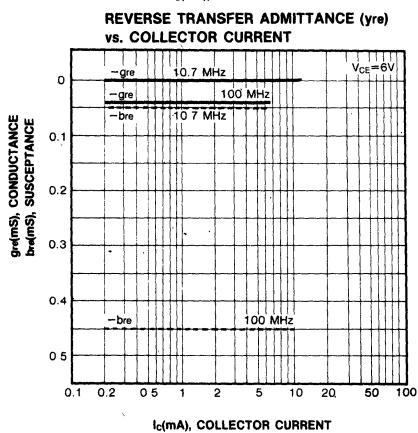
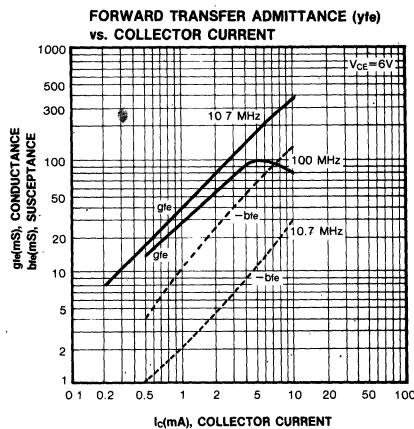
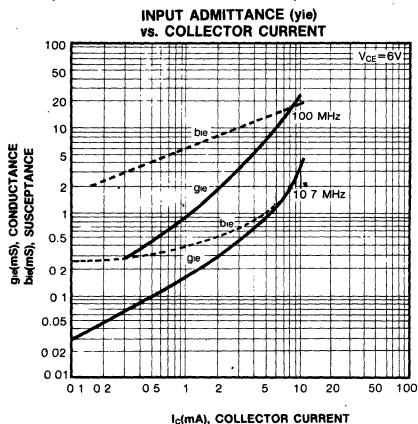


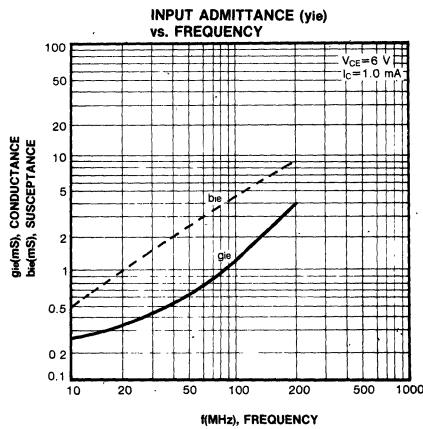
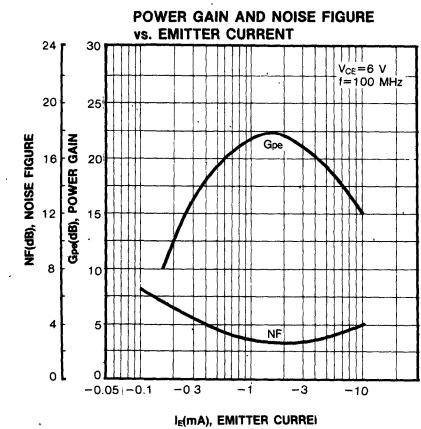
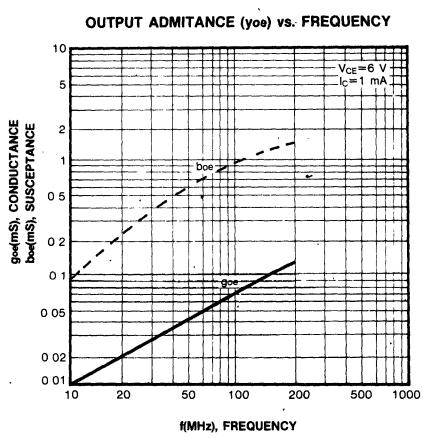
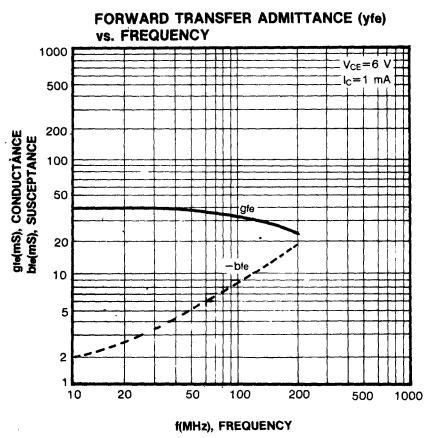
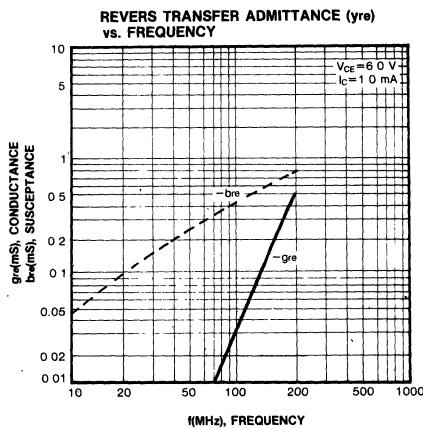
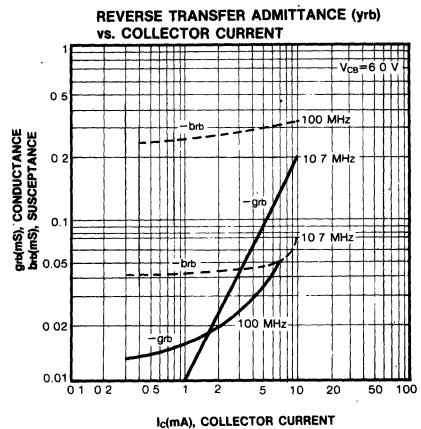
CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

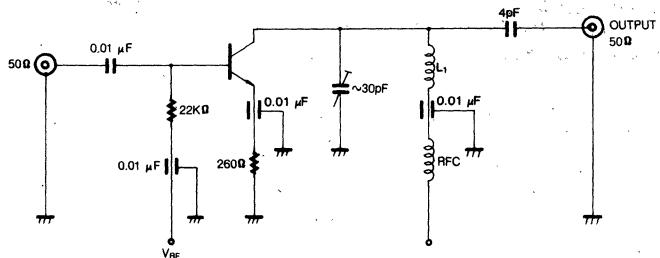
COLLECTOR OUTPUT CAPACITANCE







100MHz Gpe, NF TEST CIRCUIT



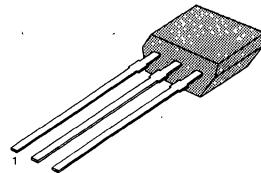
FM/AM RF AMP, MIX, CONV, OSC, IF

- Collector-Base Voltage $V_{CEO} = 30V$
- High Current Gain Bandwidth Product $f_T = 300MHz$ (Typ)
- Low Collector Capacitance $C_{ob} = 2.0PF$ (Typ)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	250	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92S



1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

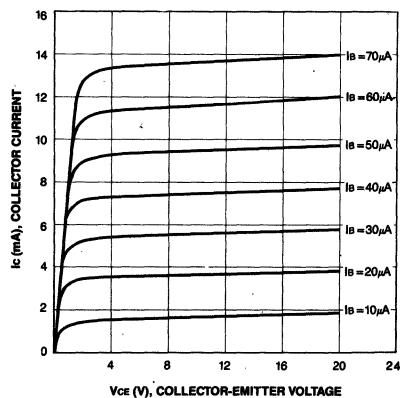
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 5mA, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 50V, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 6V, I_C = 1mA$	40		240	
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$V_{CE} = 6V, I_C = 1mA$		0.67	0.75	V
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$		0.08	0.3	$^{\circ}V$
Current Gain-Bandwidth Product	f_T	$V_{CE} = 6V, I_C = 1mA$	150	300	2.0	MHz
Output Capacitance	C_{ob}	$V_{CB} = 6V, f = 1MHz$			2.5	PF

 h_{FE} CLASSIFICATION

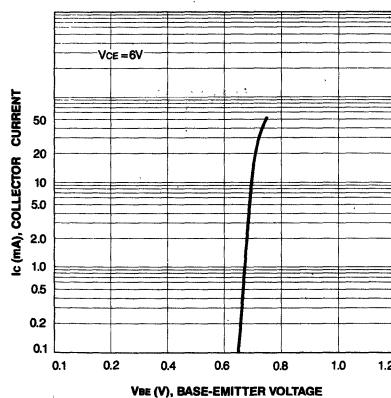
Classification	R	O	Y
h_{FE}	40-80	70-140	120-240



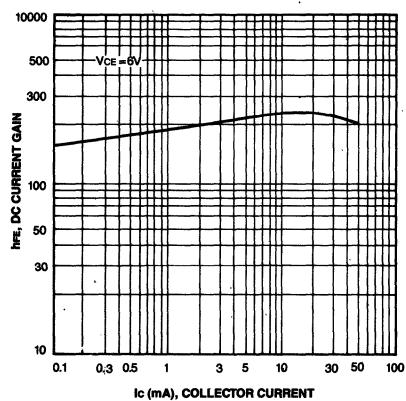
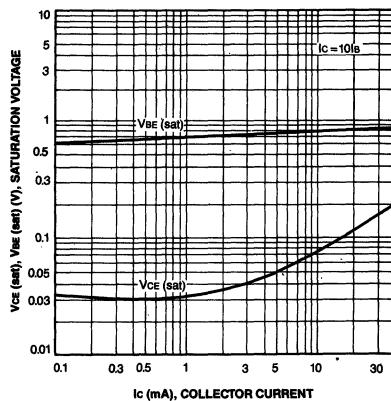
STATIC CHARACTERISTIC



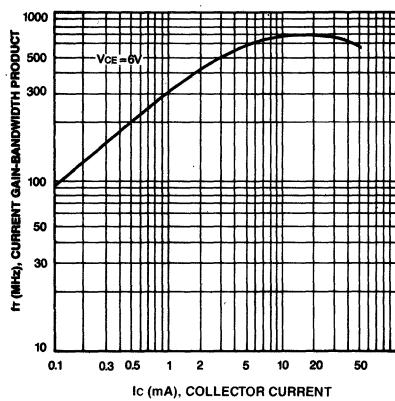
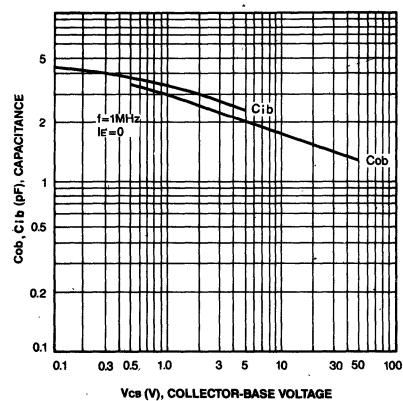
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT

COLLECTOR INPUT CAPACITANCE
COLLECTOR OUTPUT CAPACITANCE

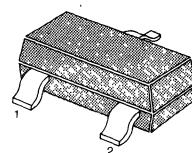
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA1182

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	35	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	150	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

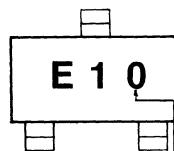
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=35V, I_E=0$			0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5V, I_C=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=1V, I_C=100\text{mA}$ $V_{CE}=6V, I_C=400\text{mA}$	70 25		240	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=100\text{mA}, I_B=10\text{mA}$		0.1	0.25	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$I_C=100\text{mA}, V_{CE}=1V$		0.8	1.0	V
Current Gain-Bandwidth Product	f_T	$I_C=20\text{mA}, V_{CE}=6V$		300		MHz
Output Capacitance	C_{ob}	$V_{CB}=6V, I_E=0$ $f=1\text{MHz}$		7		pF

 h_{FE} CLASSIFICATION

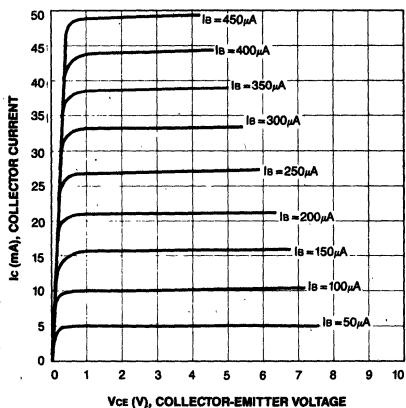
Classification	O	Y
h_{FE}	70-140	120-240

Marking

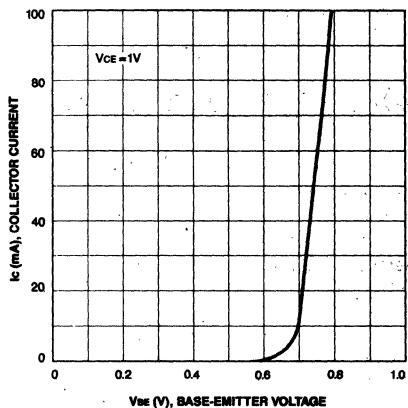
 h_{FE} grade

SAMSUNG SEMICONDUCTOR

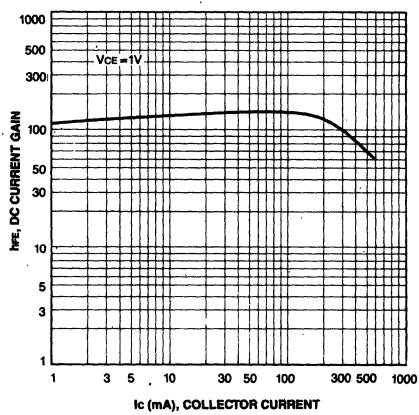
STATIC CHARACTERISTIC



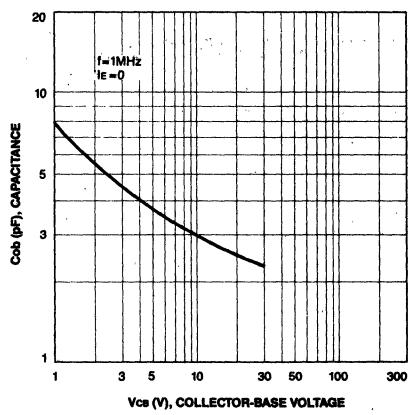
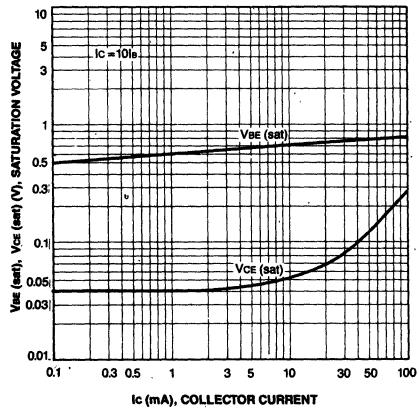
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN



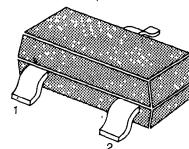
COLLECTOR OUTPUT CAPACITANCE

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

MIXER FOR UHF TV TUNER $G_{CE} = 17\text{dB}$ (TYP) $C_{re} = 0.6\text{pF}$ (TYP)**ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)**

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Current	I_C	50	mA
Base Current (DC)	I_B	25	mA
Collector Dissipation ($T_c = 25^\circ\text{C}$)	P_c	150	mW
Junction Temperature	T_j	125	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~125	$^\circ\text{C}$

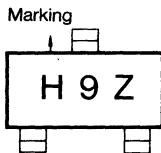
SOT-23



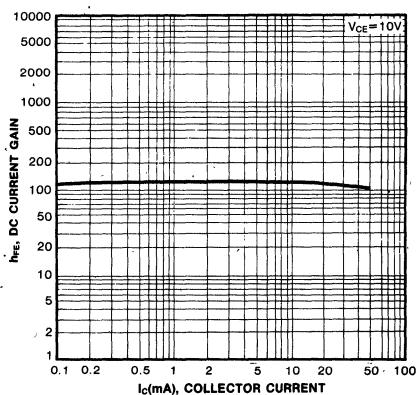
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

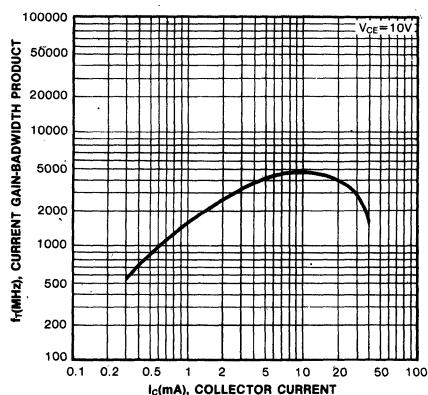
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	15			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 2\text{V}, I_C = 0$		1		μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 5\text{mA}$	40	100	200	
Current Gain Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 2\text{mA}$	1500	2400	0.9	MHz
Reverse Transient Capacitance	C_{re}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$		0.6		pF
Conversion Gain	G_{ce}	$V_{CC} = 10\text{V}, I_C = 2\text{mA}$				
Noise Figure	NF	$f = 800\text{MHz}, f_L = 830\text{MHz}$ $V_{CC} = 10\text{V}, I_C = 2\text{mA}$ $f = 800\text{MHz}, f_L = 830\text{MHz}$	12	17	8	dB



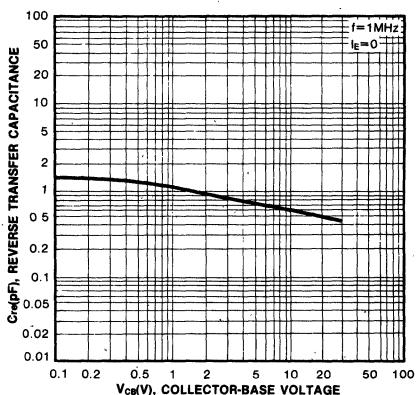
DC CURRENT GAIN



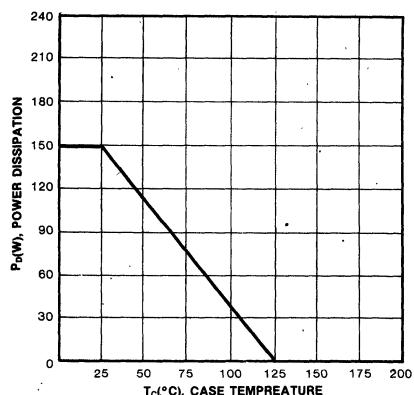
CURRENT GAIN BANDWIDTH PRODUCT



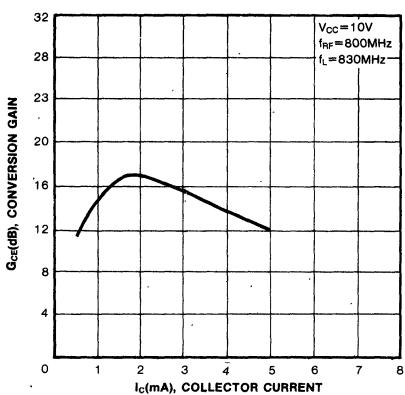
Cre-Vcb CHARACTERISTIC



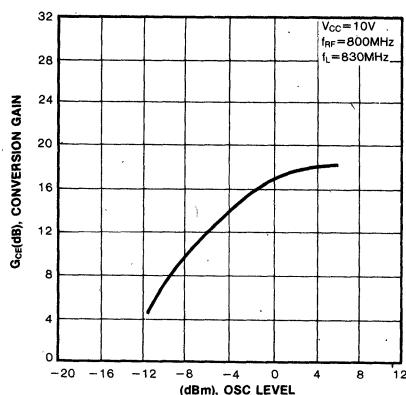
POWER DERATING



Gce-Ic CHARACTERSTIC



OSC LEVEL



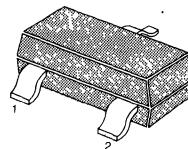
TV FINAL PICTURE AMPLIFIER APPLICATION

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_c	50	mA
Collector Dissipation	P_c	150	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to KSC388 for graphs

SOT-23



1. Base 2. Emitter 3. Collector

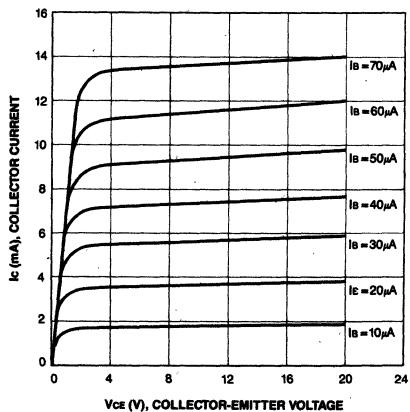
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage		$I_c = 1\text{ mA}, I_b = 0$	25		0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{ V}, I_e = 0$			0.1	uA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 3\text{ V}, I_c = 0$			0.1	uA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{ V}, I_c = 10\text{ mA}$	20	70	200	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c = 15\text{ mA}, I_b = 1.5\text{ mA}$			0.2	V
Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_c = 15\text{ mA}, I_b = 1.5\text{ mA}$			1.5	V
Current Gain-Bandwidth Product	f_T	$I_c = 10\text{ mA}, V_{CE} = 10\text{ V}$	250	600	1.6	MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{ V}, I_e = 0$ $f = 1\text{ MHz}$		1.1		pF

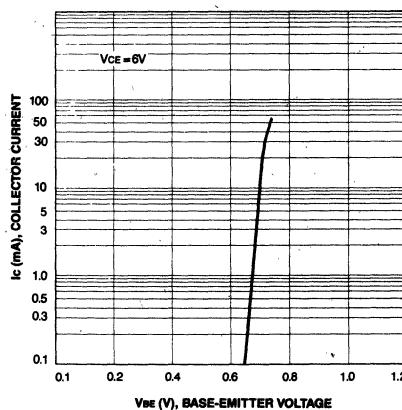
Marking



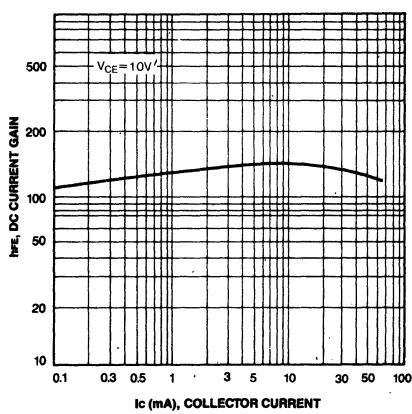
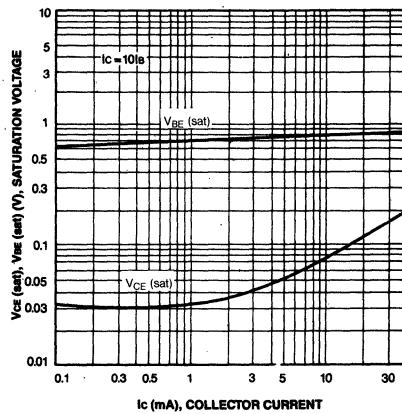
STATIC CHARACTERISTIC



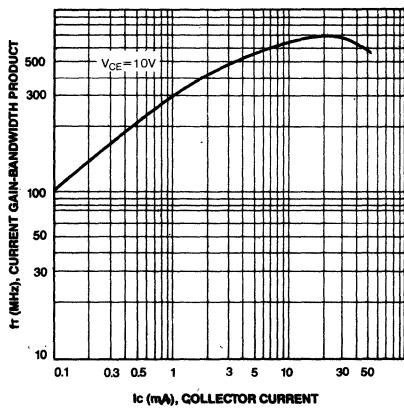
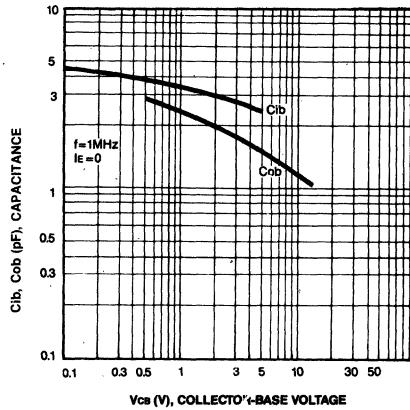
BASE-EMITTER ON VOLTAGE



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT

INPUT CAPACITANCE
COLLECTOR OUTPUT CAPACITANCE

LOW FREQUENCY AMPLIFIER

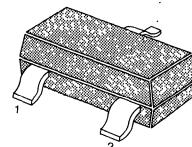
- Complement to KSA1298

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	800	mA
Base Current	I_B	160	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

- Refer to KSD261 for graphs

SOT-23



1. Base 2. Emitter 3. Collector

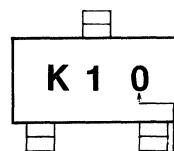
3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10\text{mA}, I_B=0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1\text{mA}, I_C=0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}, I_C=0$			100	nA
DC Current Gain	h_{FE1}	$V_{CE}=1\text{V}, I_C=100\text{mA}$	100		320	
	h_{FE2}	$V_{CE}=1\text{V}, I_C=800\text{mA}$	40			
Collector Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=500\text{mA}, I_B=20\text{mA}$			0.4	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$V_{CE}=1\text{V}, I_C=10\text{mA}$	0.5		0.8	V
Current Gain Bandwidth Product	f_T	$V_{CE}=5\text{V}, I_C=10\text{mA}$		120		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0 \text{ } f=1\text{MHz}$		13		pF

 h_{FE} (1) CLASSIFICATION

Classification	O	Y
h_{FE} (1)	100-200	160-320



h_{FE} grade

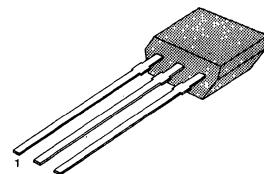
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA1378
- Collector Dissipation $P_c = 300\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	300	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

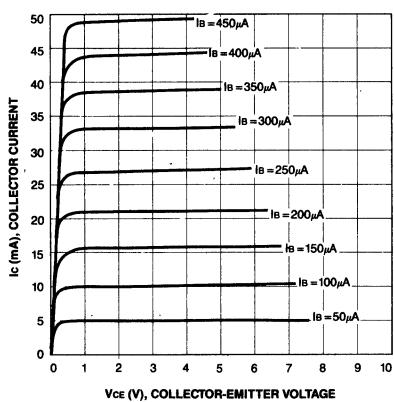
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_E=0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=10\text{mA}, I_E=0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-10\mu\text{A}, I_c=0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=25\text{V}, I_E=0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=3\text{V}, I_c=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_c=50\text{mA}$	70	0.14	400	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=309\text{mA}, I_B=30\text{mA}$			0.4	V

 h_{FE} CLASSIFICATION

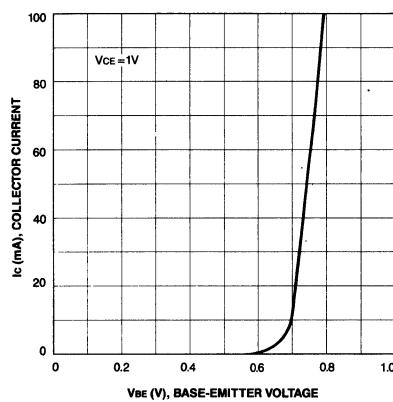
Classification	O	Y	G
h_{FE}	70-140	120-240	200-400



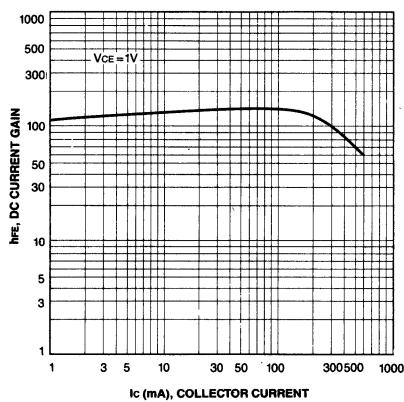
STATIC CHARACTERISTIC



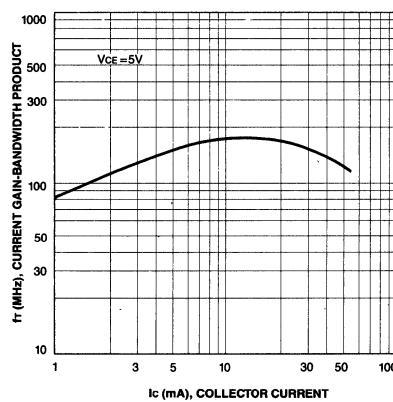
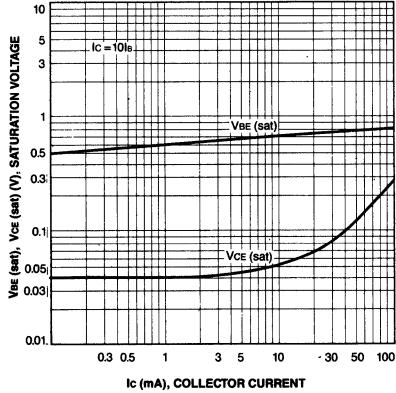
BASE-EMITTER ON VOLTAGE



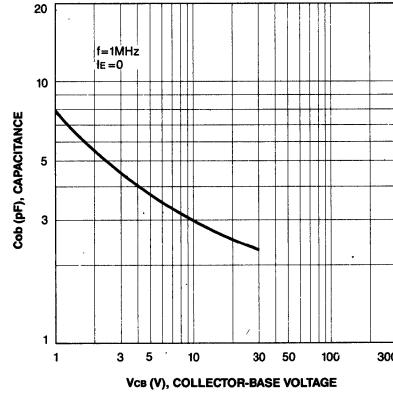
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE

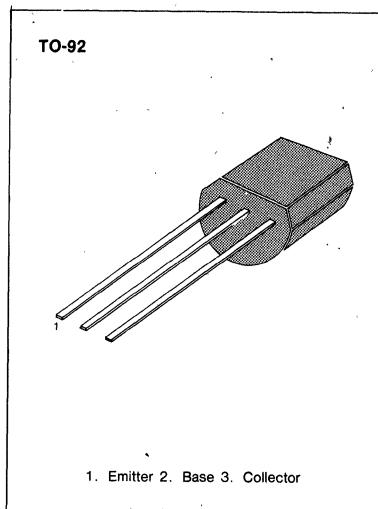


LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA642
- Collector Dissipation $P_c = 400\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	300	mA
Collector Dissipation	P_c	400	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

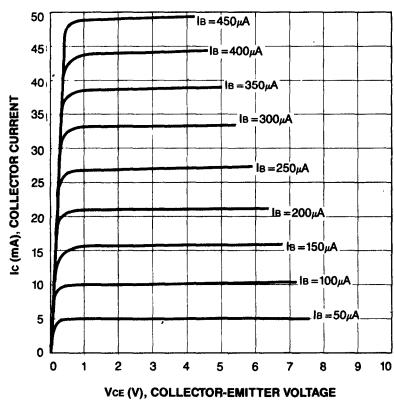
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 10\text{mA}, I_B = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_c = 50\text{mA}$	70	0.14	400	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c = 300\text{mA}, I_B = 30\text{mA}$			0.4	V

 h_{FE} CLASSIFICATION

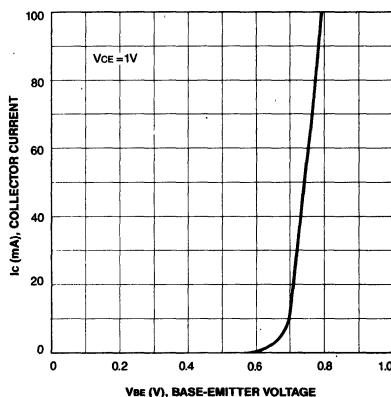
Classification	O	Y	G
h_{FE}	70-140	120-240	200-400



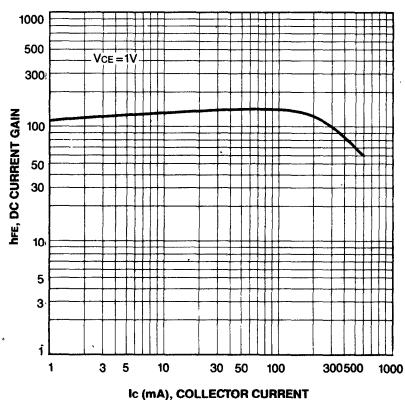
STATIC CHARACTERISTIC



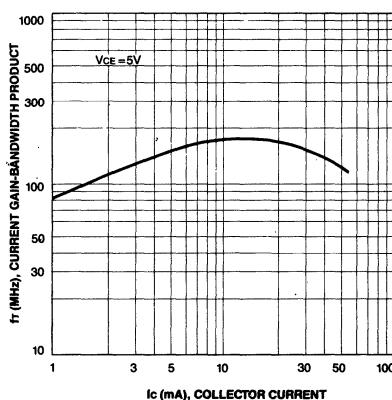
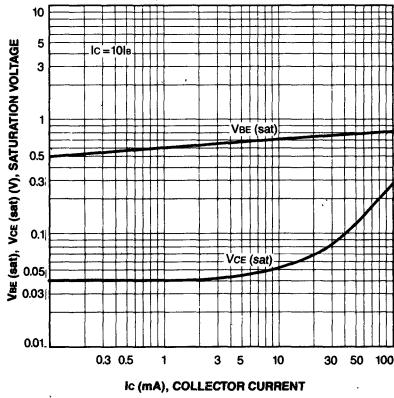
BASE-EMITTER ON VOLTAGE



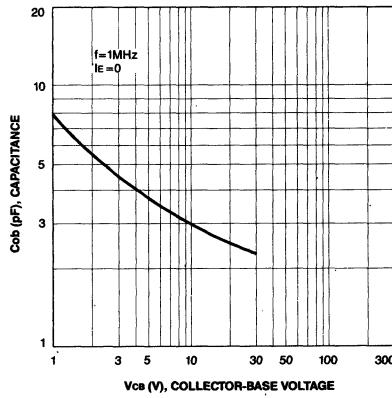
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



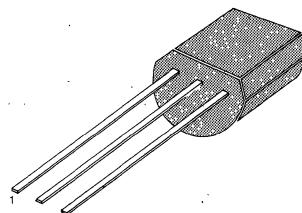
LOW FREQUENCY POWER AMPLIFIER

- Complement to KSA643
- Collector Dissipation $P_c = 500\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	500	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1 Emitter 2. Base 3. Collector

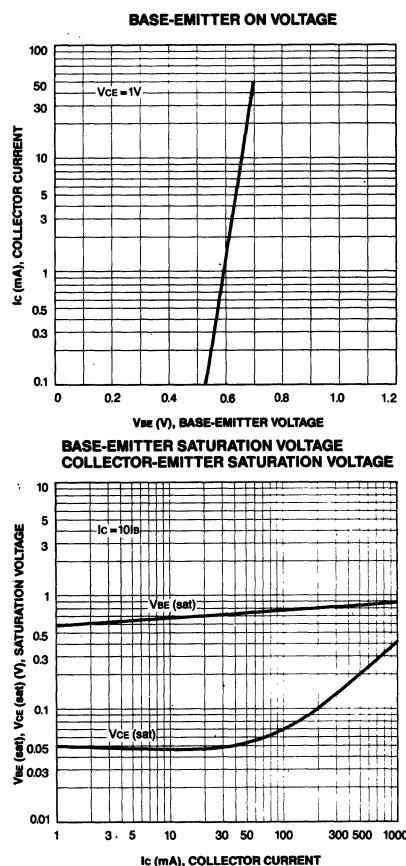
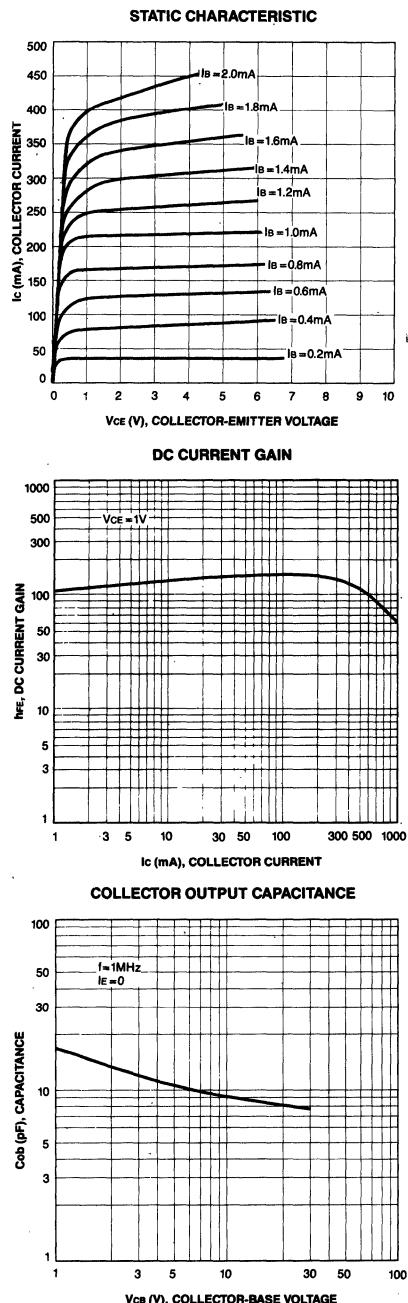
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu\text{A}, I_E = 0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 10\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$			0.1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1\text{V}, I_C = 0.1\text{A}$	40	0.18	400	μA
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c = 0.5\text{A}, I_B = 0.05\text{A}$			0.4	V

 h_{FE} CLASSIFICATION

Classification	R	O	Y	G
h_{FE}	40-80	70-140	120-240	200-400





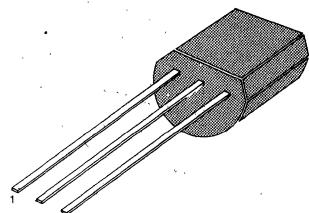
AUDIO FREQUENCY POWER AMPLIFIER

- Complement to KSB564A
- Collector Current $I_C = 1A$
- Collector Dissipation $P_C = 800mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	1	A
Collector Dissipation	P_C	800	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

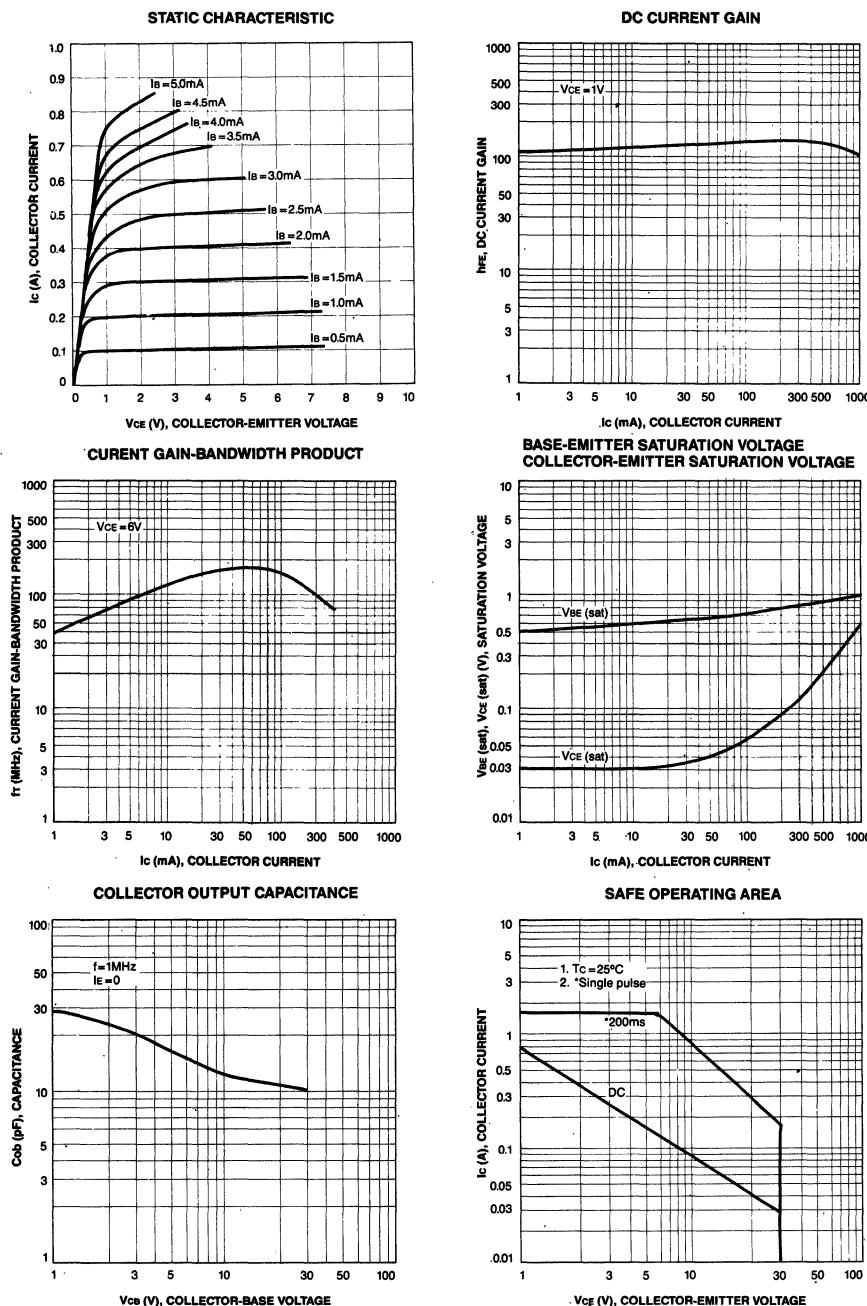
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1V, I_C = 100mA$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 1A, I_B = 0.1A$			0.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 1A, I_B = 0.1A$			1.2	V
Current Gain-Band width Product	f_T	$V_{CE} = 6V, I_C = 10mA$		130		MHz
Output Capacitance	C_{ob}	$V_{CB} = 6V, I_E = 0, f = 1MHz$			16	pF

 h_{FE} CLASSIFICATION

Classification	O	Y	G
h_{FE}	70-140	120-240	200-400





AUDIO FREQUENCY AMPLIFIER

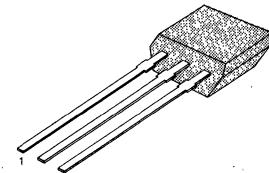
- Complement to KSB810

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current (DC)	I_c	700	mA
*Collector Current (Pulse)	I_c	1.0	A
Collector Dissipation	P_c	350	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	+55~150	$^\circ\text{C}$

* PW ≤ 10 ms, duty cycle ≤ 50 %

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

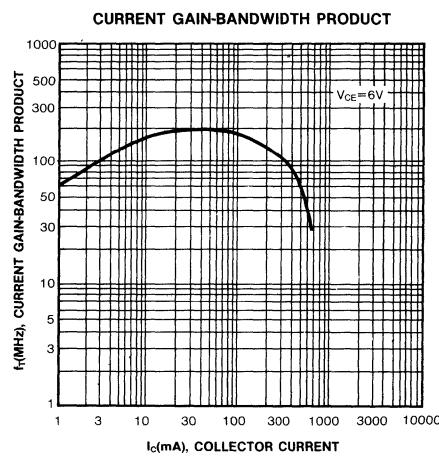
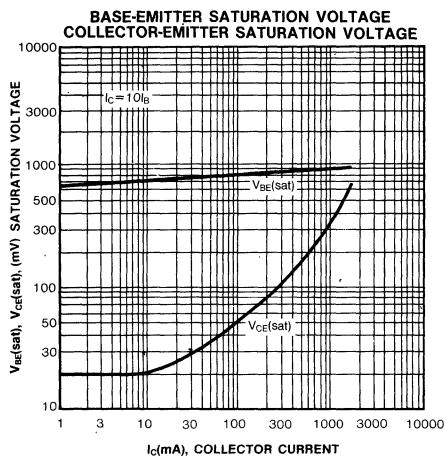
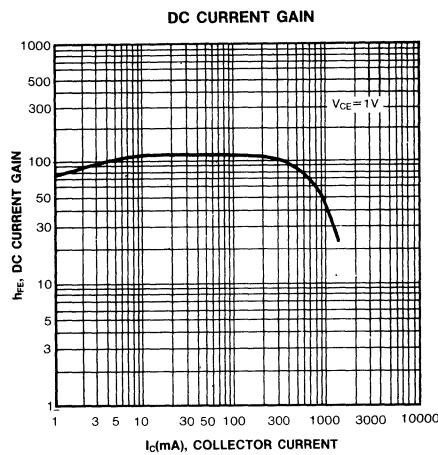
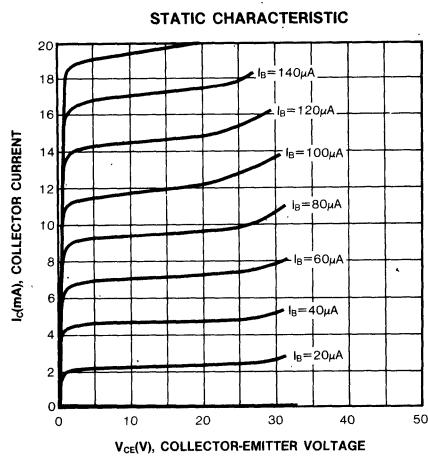
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}, I_C=0$			100	nA
* DC Current Gain	h_{FE1}	$V_{CE}=1\text{V}, I_C=100\text{mA}$	70	200	400	
	h_{FE2}	$V_{CE}=1\text{V}, I_C=700\text{mA}$	35	140		
* Base Emitter Voltage	V_{BE}	$V_{CE}=6\text{V}, I_C=10\text{mA}$	600	640	700	mV
* Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=700\text{mA}, I_B=70\text{mA}$		0.20	0.4	V
* Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=700\text{mA}, I_B=70\text{mA}$		0.95	1.2	V
Output Capacitance	C_{OB}	$V_{CB}=6\text{V}, I_E=0, f=1\text{MHz}$		13	25	pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=6\text{V}, I_E=-10\text{mA}$	50	170		MHz

* Pulse Test: PW≤350 μs , Duty Cycle ≤ 2% Pulsed

 $h_{FE}(1)$ CLASSIFICATION

Classification	O	Y	G
$h_{FE}(1)$	70-140	120-240	200-400





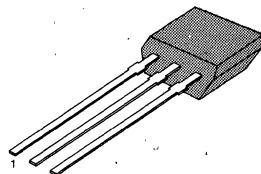
AUDIO FREQUENCY POWER AMPLIFIER

- Complement to KSB811
- Collector Current $I_C = 1A$
- Collector Dissipation $P_C = 350mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	1	A
Collector Dissipation	P_C	350	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ C$

TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

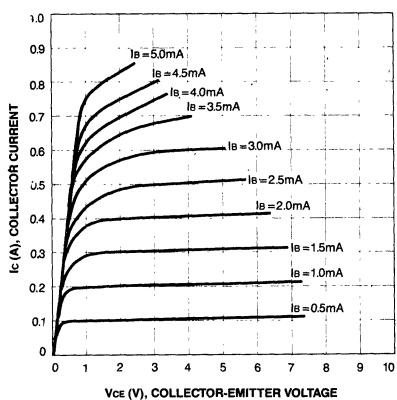
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CE} = 30V, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1V, I_C = 100mA$	70		400	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 1A, I_B = 0.1A$			0.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = 1A, I_B = 0.1A$			1.2	V
Current Gain-Band width Product	f_T	$V_{CE} = 6V, I_C = 10mA$		130		MHz
Output Capacitance	C_{ob}	$V_{CE} = 6V, I_E = 0, f = 1MHz$		16		pF

 h_{FE} CLASSIFICATION

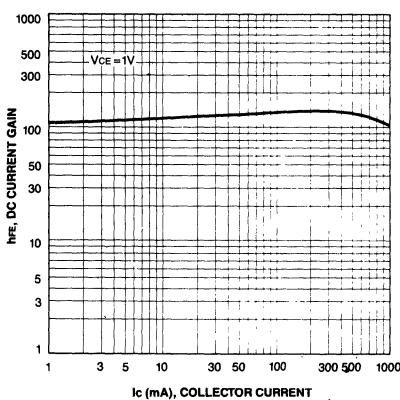
Classification	O	Y	G
h_{FE}	70-140	120-240	200-400



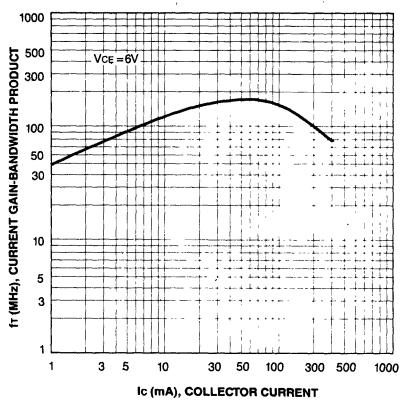
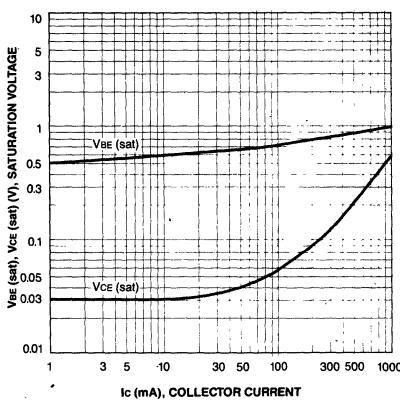
STATIC CHARACTERISTIC



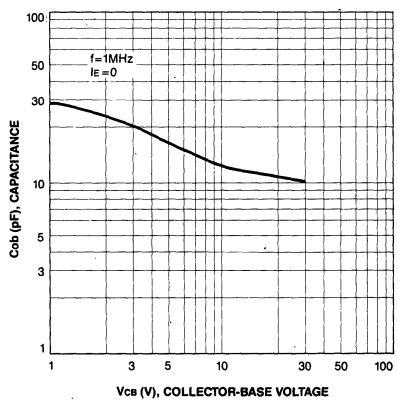
DC CURRENT GAIN



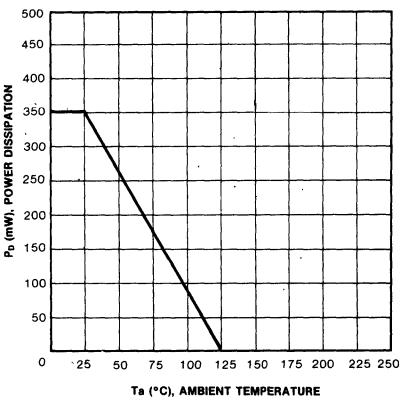
CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



POWER DERATING

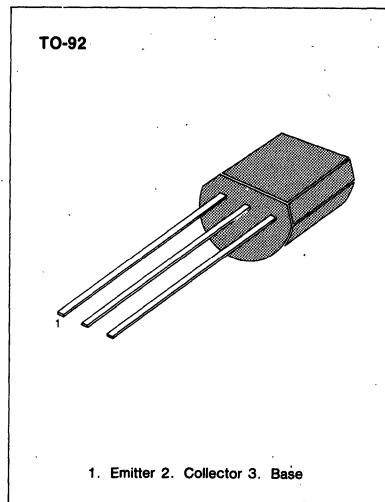


AUDIO FREQUENCY POWER AMPLIFIER MEDIUM SPEED SWITCHING

- Complement to KSB1116/1116A

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : KSD1616	V_{CBO}	60	V
: KSD1616A		120	V
Collector-Emitter Voltage : KSD1616	V_{CEO}	50	V
: KSD1616A		60	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current (DC)	I_c	1	A
* Collector Current (Pulse)	I_c	2	A
Collector Dissipation	P_c	0.75	W
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$



* PW≤10ms, Duty Cycle≤50%

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

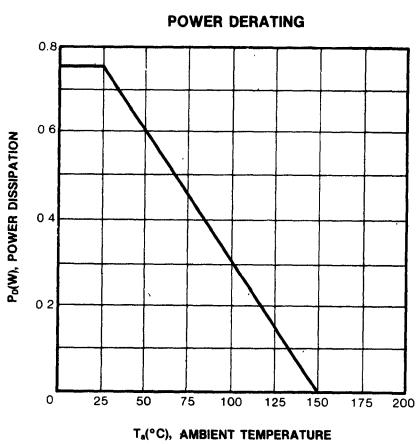
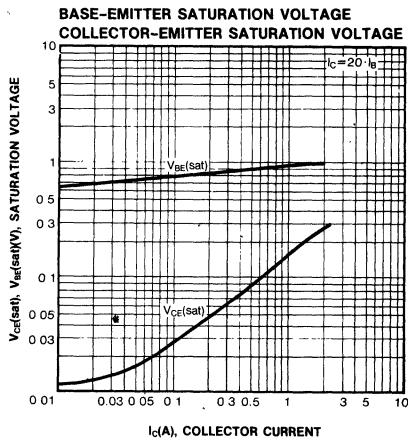
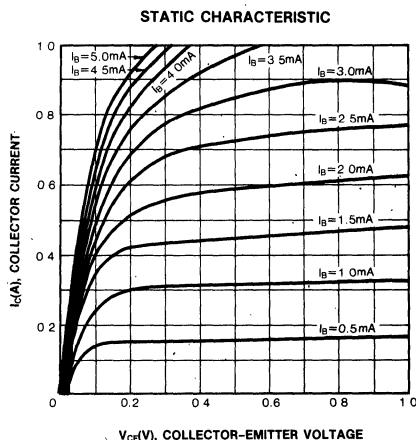
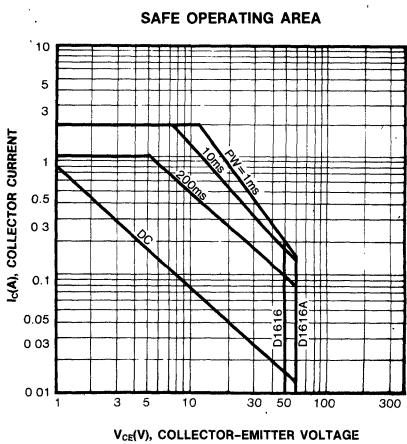
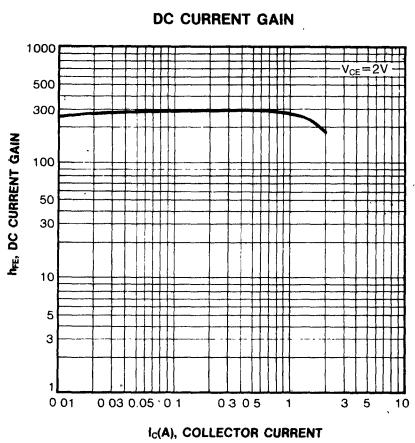
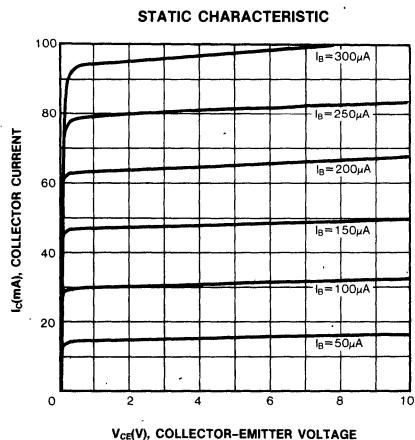
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=60\text{V}, I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=6\text{V}, I_C=0$			100	nA
* DC Current Gain : KSD1616	h_{FE1}	$V_{CE}=2\text{V}, I_C=100\text{mA}$	135		600	
: KSD1616A			135		400	
** Base Emitter On Voltage	h_{FE2}	$V_{CE}=2\text{V}, I_C=1\text{A}$	81			
* Collector Emitter Saturation Voltage	V_{BE} (on)	$V_{CE}=2\text{V}, I_C=50\text{mA}$	600	640	700	mV
* Base Emitter Saturation Voltage	V_{CE} (sat)	$I_C=1\text{A}, I_B=50\text{mA}$		0.15	0.3	V
Output Capacitance	V_{BE} (sat)	$I_C=1\text{A}, I_B=50\text{mA}$		0.9	1.2	V
Current Gain Bandwidth Product	C_{ob}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$		19		pF
	f_T	$V_{CE}=2\text{V}, I_C=100\text{mA}$	100	160		MHz
Turn On Time	t_{on}	$V_{CC}=10\text{V}, I_C=100\text{mA}$		0.07		μs
Storage Time	t_s	$I_{s1}=-I_{s2}=10\text{mA}$		0.95		μs
Fall Time	t_f	V_{BE} (off) = -2~ -3V		0.07		μs

* Pulse Test: PW≤350 μs , Duty Cycle≤2% Pulsed

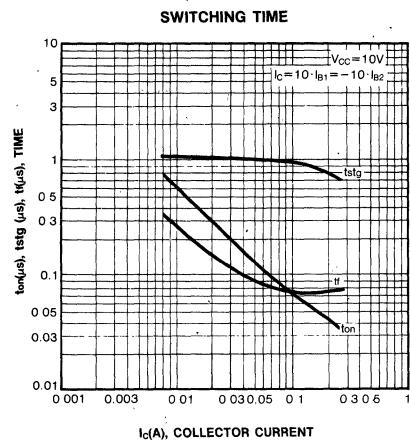
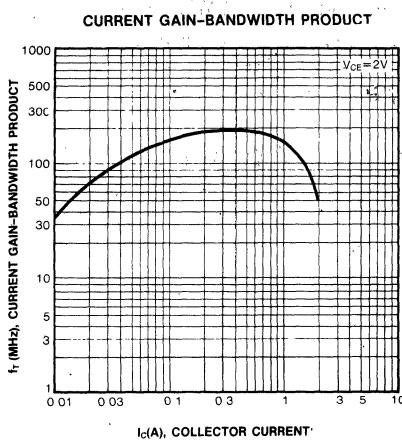
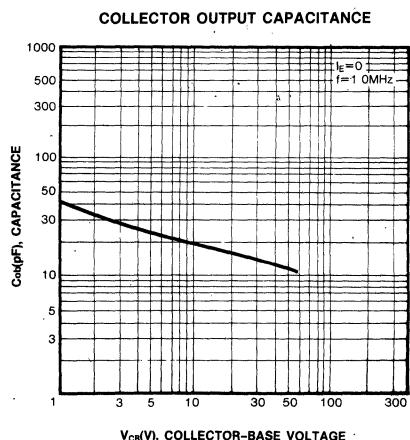
$h_{FE}(1)$ CLASSIFICATION

Classification	Y	G	L
$h_{FE}(1)$	135-270	200-400	300-600





KSD1616/1616A NPN EPITAXIAL SILICON TRANSISTOR



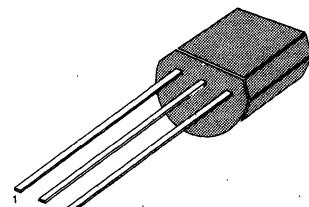
LOW NOISE PRE-AMP. USEHigh Input Impedance: $I_{gss} = 1\text{nA}$ (MAX)

Low Noise: NF=0.5dB (TYP)

High Voltage: $V_{gds} = -50\text{V}$ **ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)**

Characteristic	Symbol	Rating	Unit
Gate-Drain Voltage	V_{gds}	-50	V
Gate Current	I_g	10	mA
Collector Dissipation	P_c	100	mW
Junction Temperature	T_j	125	°C
Storage Temperature	T_{stg}	-55~125	°C

TO-92



1. Source 2. Gate 3. Drain

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

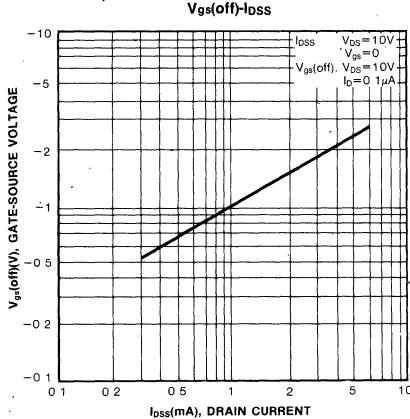
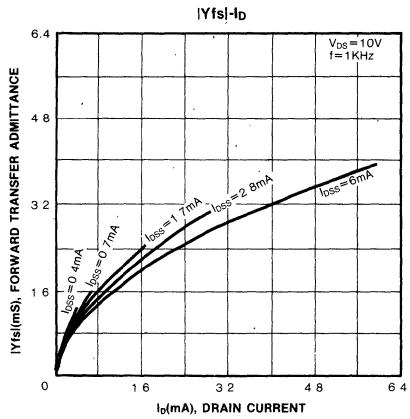
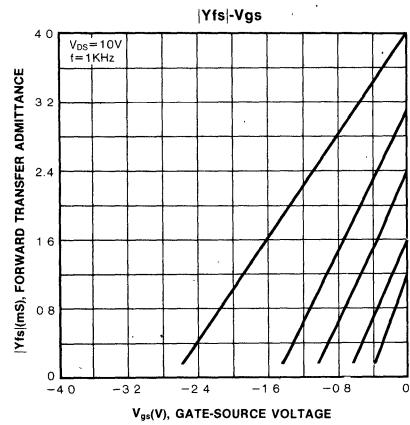
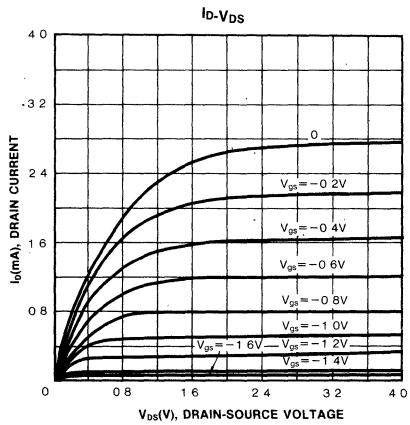
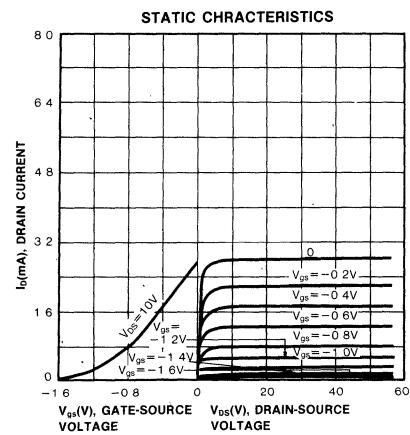
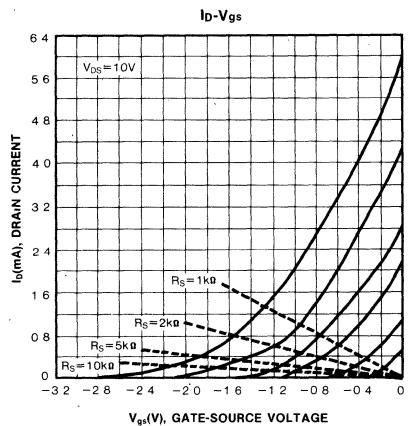
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Gate-Drain Breakdown Voltage	BV_{gds}	$V_{DS}=0, I_g = -100\mu\text{A}$	-50			V
Gate Leak Current	I_{gss}	$V_{GS} = -30\text{V}, V_{DS} = 0$			-1	nA
Drain Leak Current	I_{DSS}	$V_{DS} = 10\text{V}, V_{GS} = 0$	0.3		6.5	mA
Gate-Source Voltage	$V_{gs}(\text{off})$	$V_{DS} = 10\text{V}, I_g = 0.1\mu\text{A}$	-0.4		-5	V
Forward Transfer Admittance	$ Y_{fs} $	$V_{DS} = 10\text{V}, V_{GS} = 0, f = 1\text{KHz}$	1.2			ms
Input Capacitance	C_{iss}	$V_{DS} = 0, V_{GS} = 0, f = 1\text{MHz}$		8.2		pF
Feedback Capacitance	C_{rss}	$V_{DS} = 10\text{V}, V_{GS} = 0$ $f = 1\text{MHz}$		2.6		pF
Noise Figure	NF	$V_{DS} = -10\text{V}, V_{GS} = 0$ $f = 1\text{MHz}$ $V_{DS} = 15\text{V}, V_{GS} = 0$ $R_o = 100\text{k}\Omega$ $f = 120\text{Hz}$		0.5	5	dB

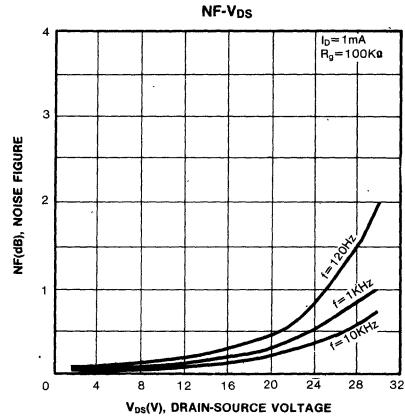
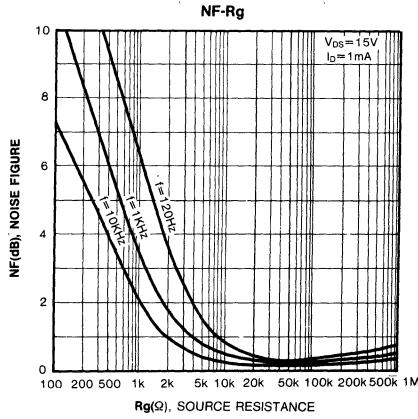
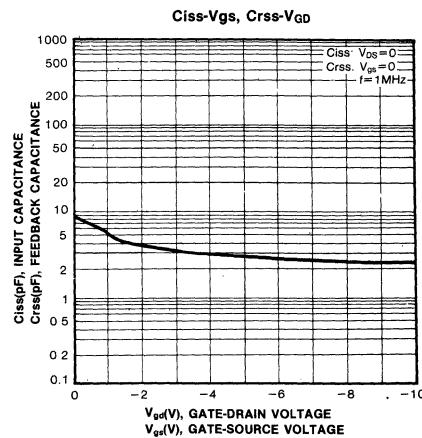
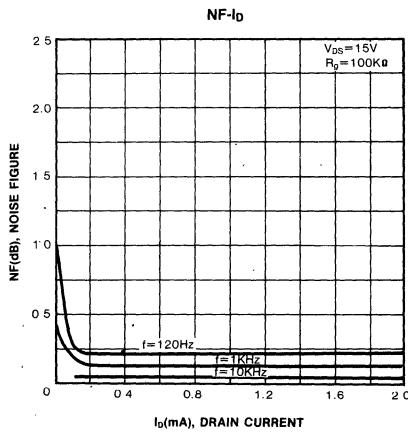
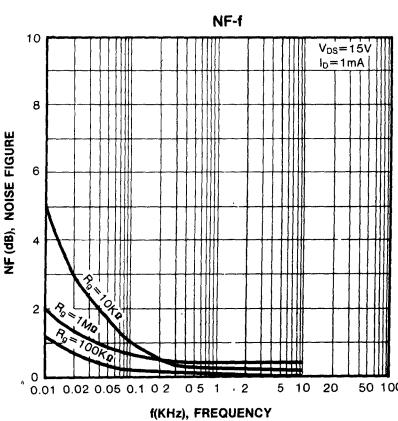
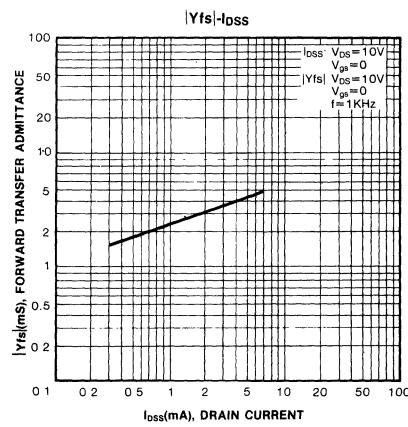
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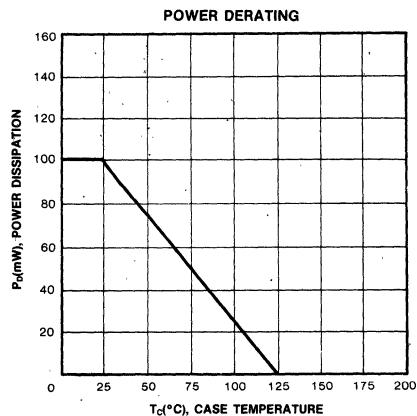
 I_{DSS} CLASSIFICATION

Classification	R	O	Y	G
$I_{DSS}(\text{mA})$	0.30-0.75	0.60-1.40	1.20-3.00	2.60-6.50









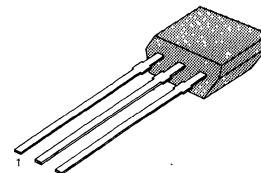
AF IMPEDANCE CONVERTER

- Built-In Diode Between G and S
- Low NV

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS0}	12	V
Gate-Drain Voltage	V_{GDO}	12	V
Drain-source Current	I_{DS0}	2	mA
Drain-Gate Current	I_{GDO}	2	mA
Gate-Source Current	I_{GSO}	2	mA
Power Dissipation	P_D	20	mW
Operate Temperature	T_{OPR}	-10~+70	°C
Storage Temperature	T_{STG}	-20~+80	°C

TO-92S



1. Source 2. Gate 3. Drain

3

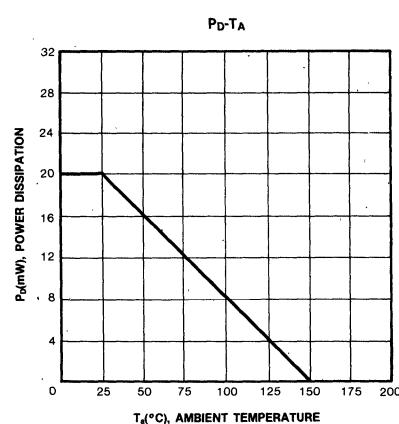
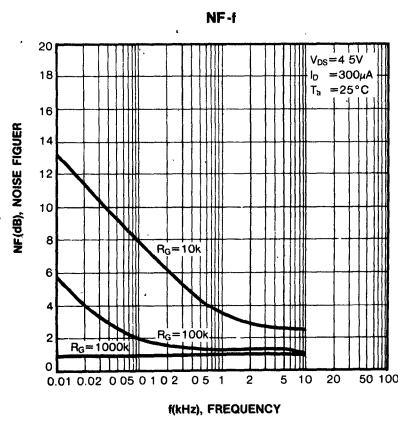
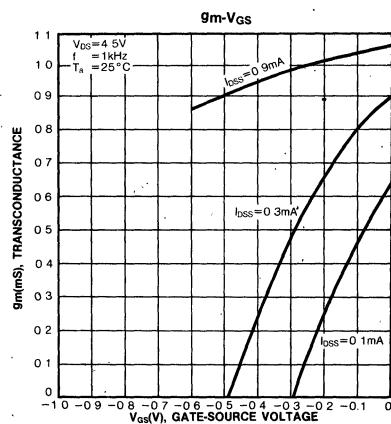
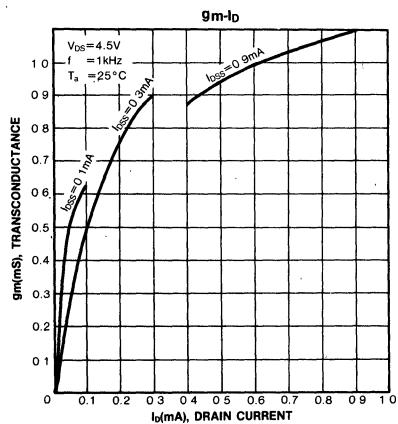
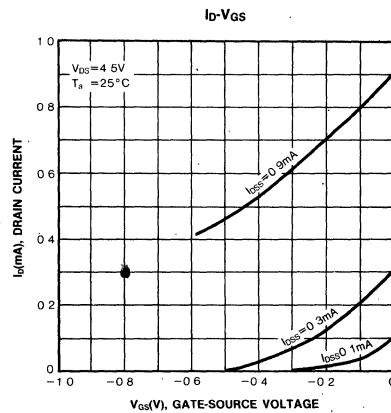
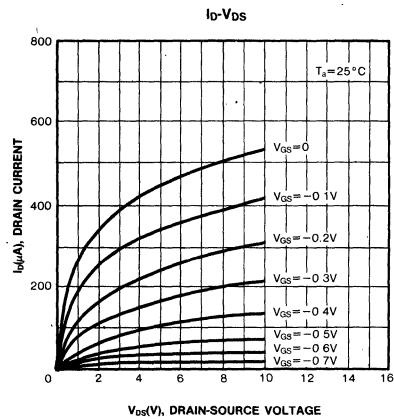
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

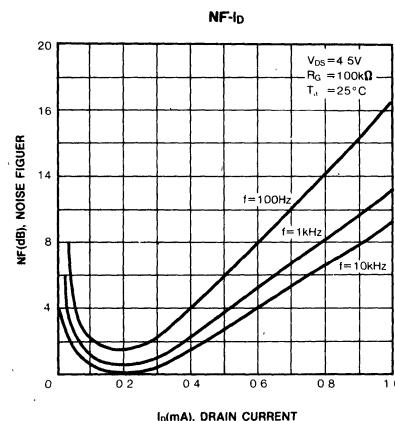
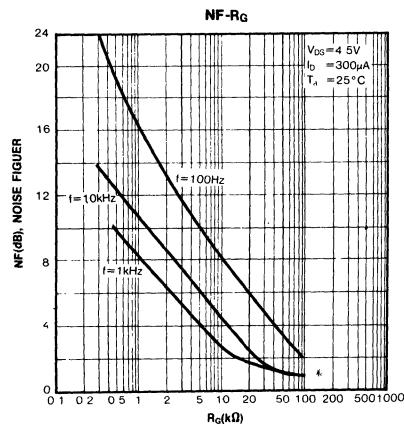
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Drain Current	I_{DSS}	$V_{DS}=4.5\text{V}$, $V_{GS}=0$, $R_S=2.2\text{k}\Omega \pm 1\%$	0.04		0.8	mA
Transconductance	g_m	$V_{DS}=4.5\text{V}$, $V_{GS}=0$, $R_S=2.2\text{k}\Omega \pm 1\%$, $f=1\text{kHz}$	300	500		μS
Noise Voltage	NV	$V_{DS}=4.5\text{V}$, $R_S=2.2\text{k}\Omega \pm 1\%$, $C_G=10\text{pF}$, A curve			4	μV
Voltage Gain	G_{V1}	$V_{DS}=4.5\text{V}$, $R_S=2.2\text{k}\Omega \pm 1\%$, $C_G=10\text{pF}$, $E_G=100\text{mV}$, $f=70\text{Hz}$		-10		dB
Voltage Gain	G_{V2}	$V_{DS}=12\text{V}$, $R_S=2.2\text{k}\Omega \pm 1\%$, $C_G=10\text{pF}$, $E_G=100\text{mV}$, $f=70\text{Hz}$		-9.5		dB
Voltage Gain	G_{V3}	$V_{DS}=1\text{V}$, $R_S=2.2\text{k}\Omega \pm 1\%$, $C_G=10\text{pF}$, $E_G=100\text{mV}$, $f=70\text{Hz}$		-11		dB

 I_{DSS} - G_V CLASSIFICATION

Classification	P	Q
I_{DSS} (mA)	0.04-0.2	0.15-0.8
G_{V1} (dB)	>-13	>-12
G_{V2} (dB)	>-12	>-11
$\Delta G_{V1}-G_{V2} $ (dB)	<3	<3
$\Delta G_{V1}-G_{V3} $ (dB)	<3	-







LOW FREQUENCY LOW NOISE AMP.

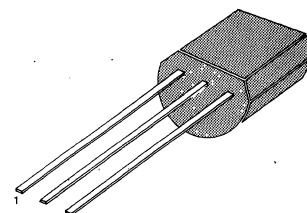
High $|Y_{fs}|$: 15mS (TYP)High Input Impedance : $I_{gss} = -1\text{nA}$

Low Noise, NF = 1dB (TYP)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Gate-Drain Voltage	V_{gds}	-50	V
Gate Current	I_g	10	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	125	°C
Storage Temperature	T_{stg}	-55~125	°C

TO-92



1. Drain 2. Gate 3. Source

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Gate-Drain Breakdown Voltage	BV_{gds}	$V_{DS}=0, I_g = -100\mu\text{A}$	-50			V
Gate Leak Current	I_{gss}	$V_{DS} = -30\text{V}, V_{GS} = 0$			-1	nA
Drain Leak Current	I_{DSS}	$V_{DS} = 10\text{V}, V_{GS} = 0$	0.6		14	mA
Gate-Source Voltage	$V_{gs}(\text{off})$	$V_{DS} = 10\text{V}, I_g = 0.1\mu\text{A}$	-0.2		-1.5	V
Forward Transfer Admittance	$ Y_{fs} $	$V_{DS} = 10\text{V}, V_{GS} = 0, f = 1\text{kHz}$	4.0	15		mS
Input Capacitance	C_{iss}	$V_{DS} = 10\text{V}, V_{GS} = 0, f = 1\text{MHz}$		13		pF
Feedback Capacitance	C_{rss}	$V_{GD} = 10\text{V}, I_D = 0$				
		$f = 1\text{MHz}$		3		pF
Noise Figure	NF1	$V_{DS} = 10\text{V}, R_g = 1\text{k}\Omega$			5	dB
	NF2	$I_D = 0.5\text{mA}, f = 10\text{Hz}$			10	
		$V_{DS} = 10\text{V}, R_g = 1\text{k}\Omega$			2	
		$I_D = 0.5\text{mA}, f = 1\text{kHz}$				dB

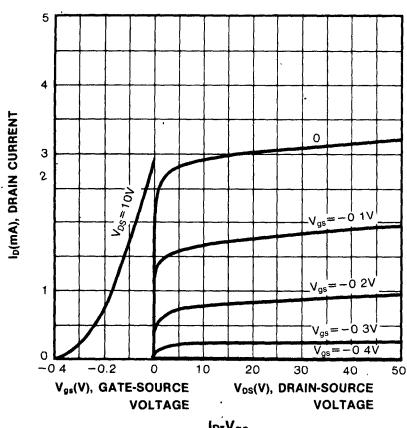
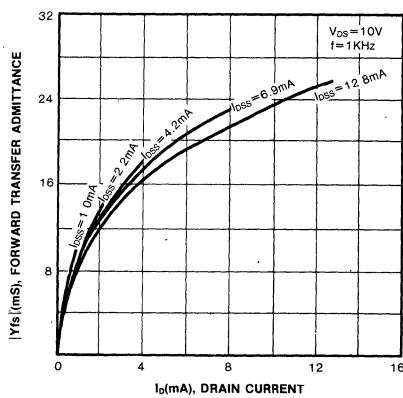
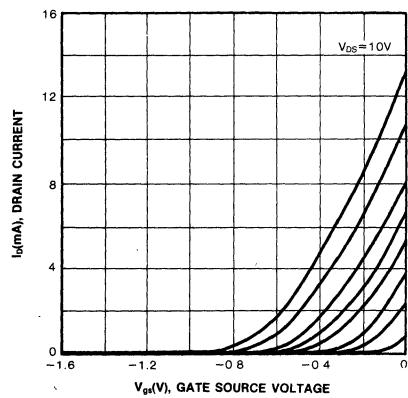
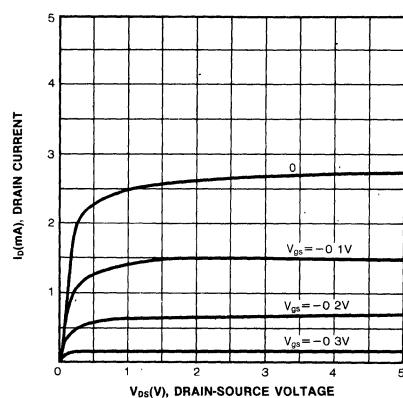
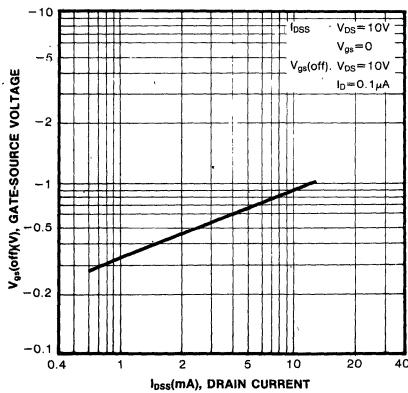
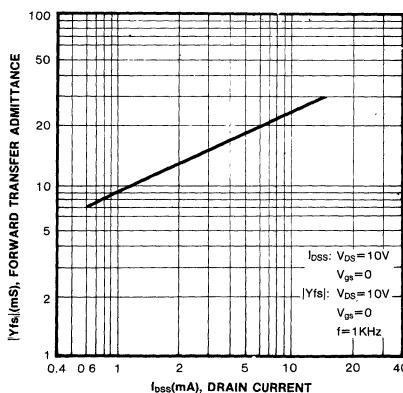
 I_{DSS} CLASSIFICATION

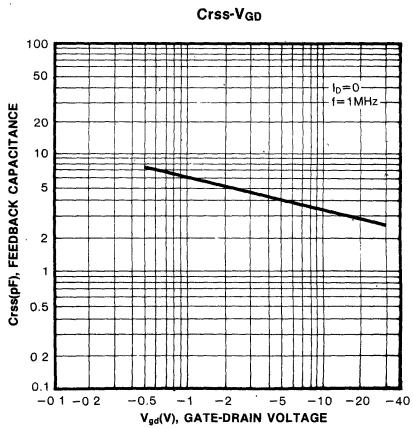
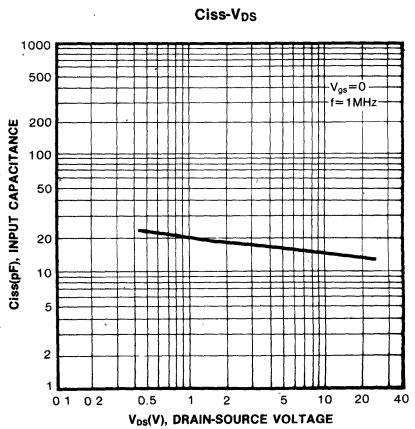
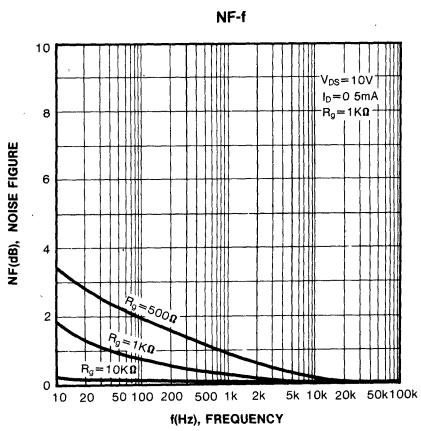
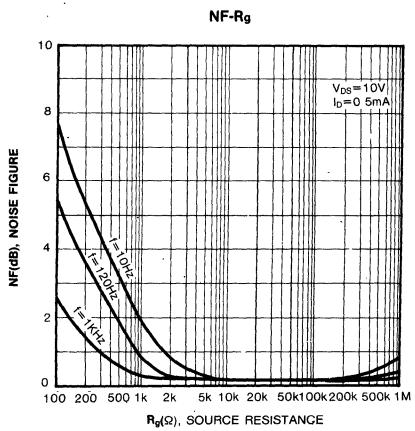
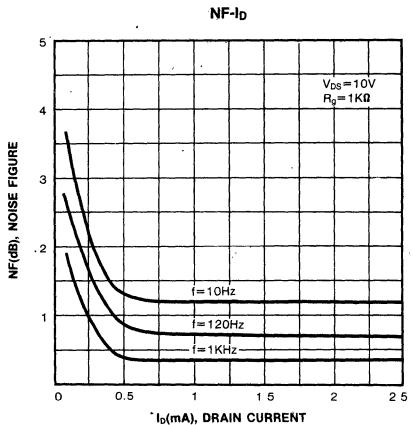
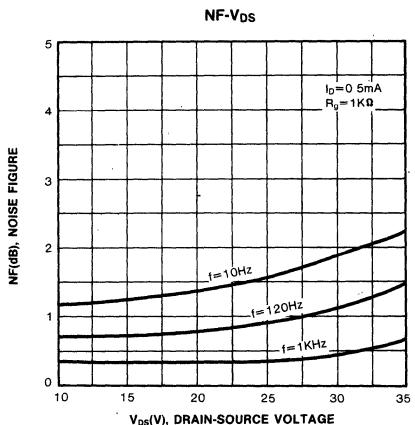
Classification	Y	G	L
$I_{DSS}(\text{mA})$	1.2-3.0	2.6-6.5	6.0-14

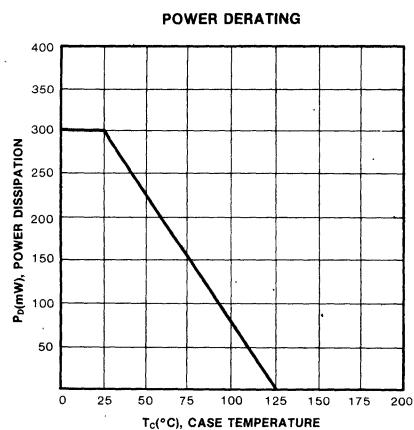


SAMSUNG SEMICONDUCTOR

STATIC CHARACTERISTIC

 $I_D - V_{ds}$  $V_{gs(\text{off})}-I_{dss}$  $|Y_{fs}| - I_{dss}$ 





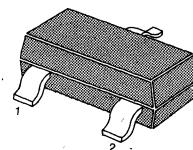
AF IMPEDANCE CONVERTER

- BUILT-IN DIODE BETWEEN G AND S
- LOW NV

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Drain Source Voltage	V_{DSO}	20	V
Drain Gate Voltage	V_{DGO}	20	V
Drain Source Current	I_{DSO}	2	mA
Drain Gate Current	I_{DGO}	2	mA
Gate Source Current	I_{GSO}	2	mA
Power Dissipation	P_D	200	mW
Operate Temperature	T_{OPR}	-20~80	°C
Storage Temperature	T_{STG}	-55~100	°C

SOT-23

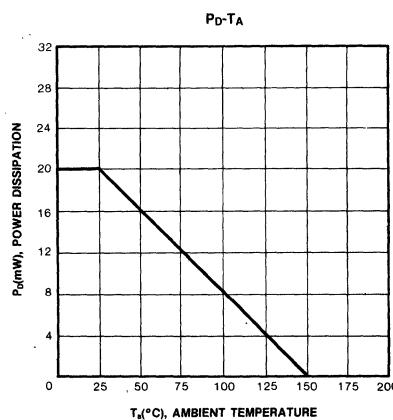
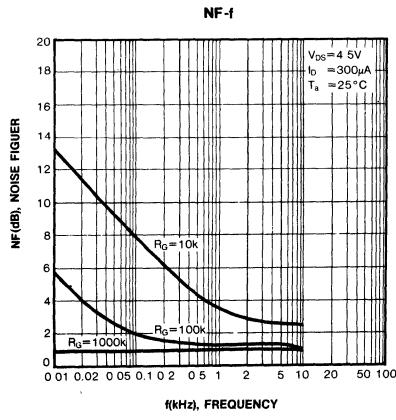
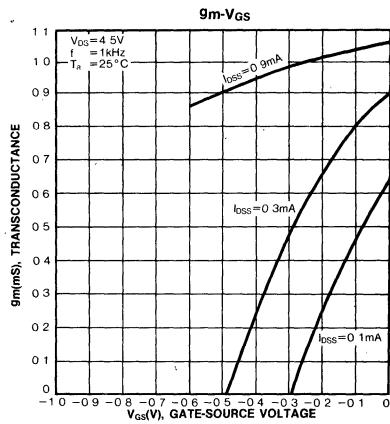
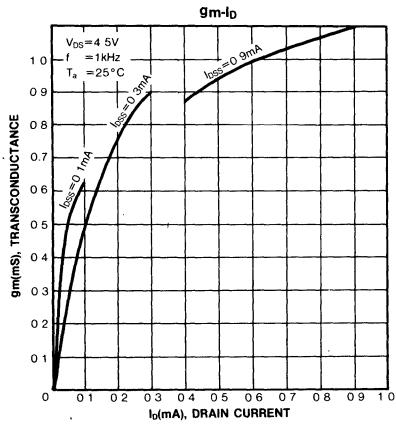
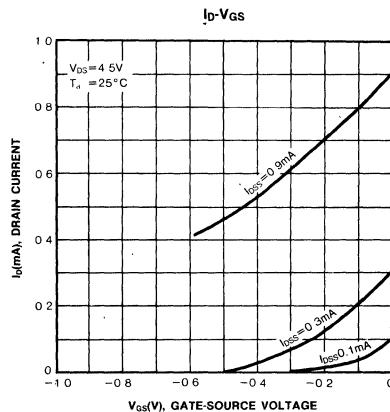
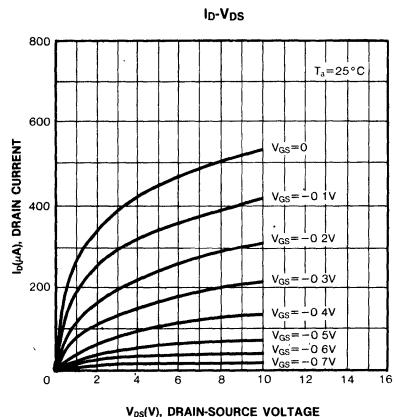


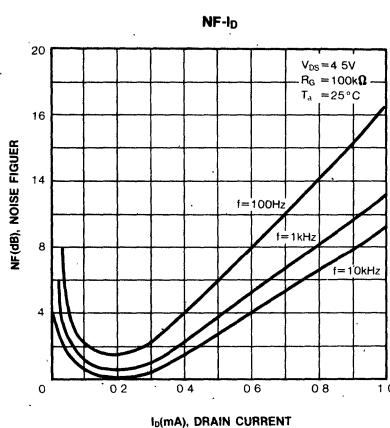
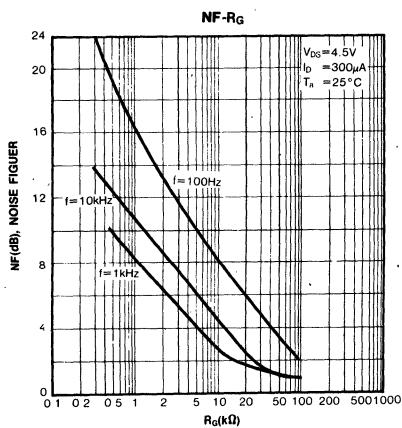
1. Drain 2. Source 3. Gate

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Drain Current	I_{DSS}	$V_{DS}=4.5\text{V}$, $V_{GS}=0$ $R_S=2.2\text{kohm} \pm 1\%$	130	200	470	μA
Transconductance	gm	$V_{DS}=4.5\text{V}$, $V_{GS}=0$ $R_S=2.2\text{kohm} \pm 1\%$, $f=1\text{kHz}$ $C_G=10\text{pF}$, A curve	0.9	1.6	4	mS μV
Voltage Gain	G_{v1}	$V_{DS}=4.5\text{V}$, $R_S=2.2\text{kohm} \pm 1\%$ $C_G=10\text{pF}$, $E_G=10\text{mV}$, $f=70\text{Hz}$	-1			dB
Voltage Gain	G_{v2}	$V_{DS}=12\text{V}$, $R_S=2.2\text{kohm} \pm 1\%$ $C_G=10\text{pF}$, $E_G=10\text{mV}$, $f=70\text{Hz}$	0			dB
Voltage Gain	G_{v3}	$V_{DS}=1.5\text{V}$, $R_S=2.2\text{kohm} \pm 1\%$ $C_G=10\text{pF}$, $E_G=10\text{mV}$, $f=70\text{Hz}$	-4			dB







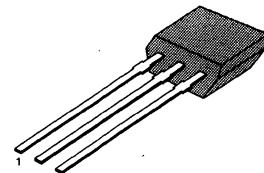
**FM TUNER
VHF AMPLIFIER**

- NF = 2.5 dB (TYP)
- $|Y_{fs}| = 9.0 \text{ mS}$ (TYP)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Gate-Drain Voltage	V_{GD}	-18	V
Gate Current	I_G	10	mA
Power Dissipation	P_D	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55~150	$^\circ\text{C}$

TO-92S



1. Drain 2. Source 3. Gate

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

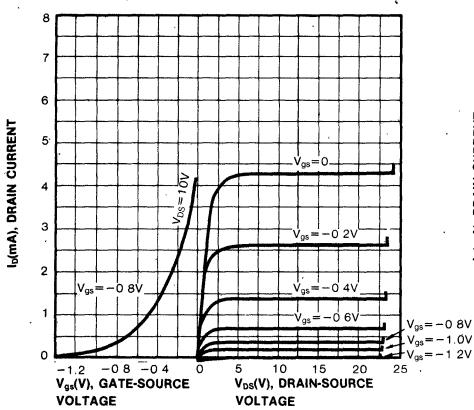
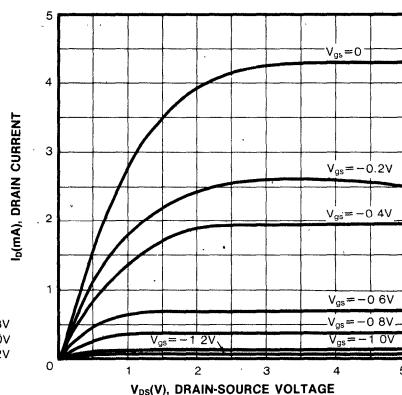
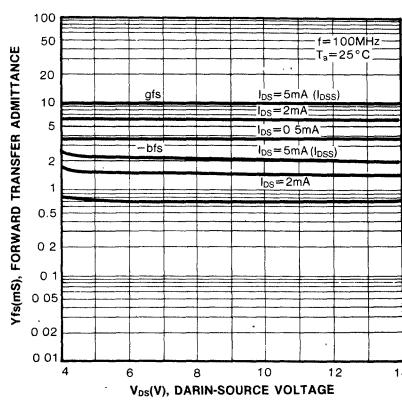
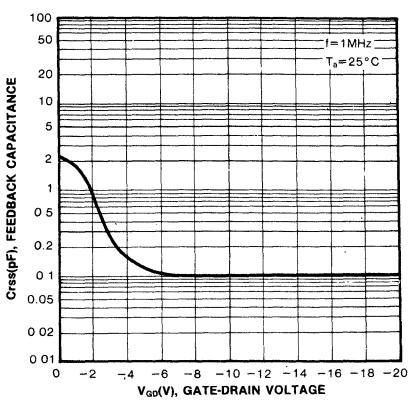
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Gate Cut-off Current	I_{GSS}	$V_{GS}=-0.5\text{V}$, $V_{DS}=0$			-10	nA
Gate-Drain Breakdown Voltage	$V(BR)_{GDO}$	$I_G=-100\mu\text{A}$, Drain			1.0	V
Drain Current	I_{DSS}	$V_{DS}=10\text{V}$, $V_{GS}=0$			10	mA
Gate-Source Cut-off Voltage	$V_{GS(\text{off})}$	$V_{DS}=10\text{V}$, $I_D=1\mu\text{A}$			4.0	V
Forward Transfer Admittance	$ Y_{fs} $	$V_{DS}=10\text{V}$, $V_{GS}=0$, $f=1\text{kHz}$		9	4.0	mS
Reverse Transfer Capacitance	C_{rss}	$V_{GD}=10\text{V}$, $f=1\text{MHz}$			0.15	pF
Power Gain	C_{PS}	$V_{DD}=10\text{V}$, $f=100\text{MHz}$		18	0.15	dB
Noise Figure	NF	$V_{DD}=10\text{V}$, $f=100\text{MHz}$		2.5	3.5	dB

 I_{DSS} CLASSIFICATION

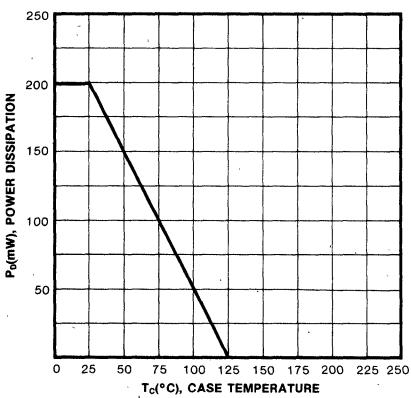
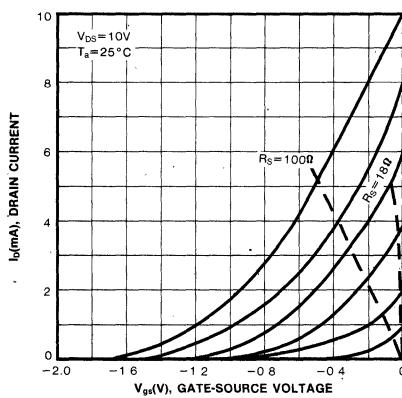
Classification	O	Y	G
I_{DSS}	1.0-3.0	2.5-6.0	5.0-10

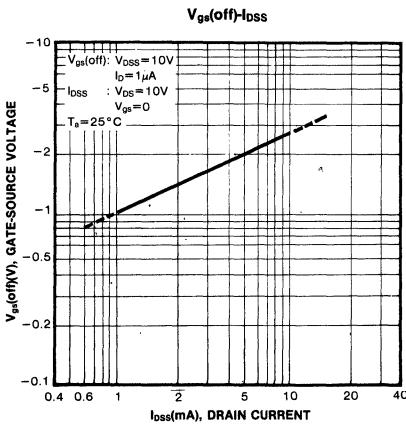
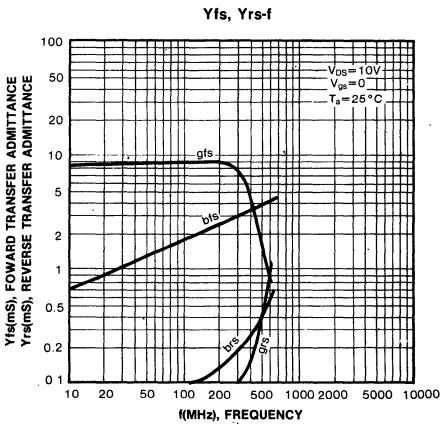
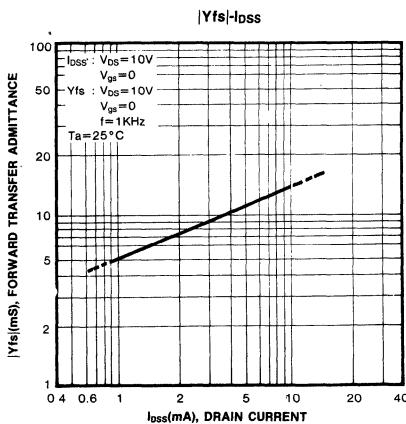
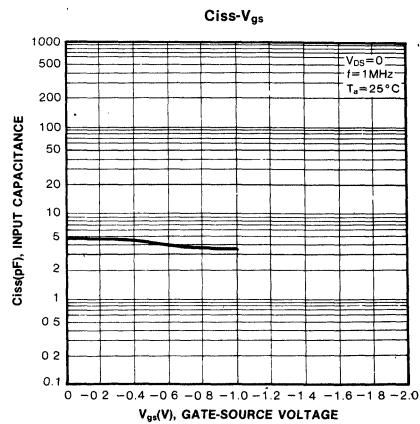
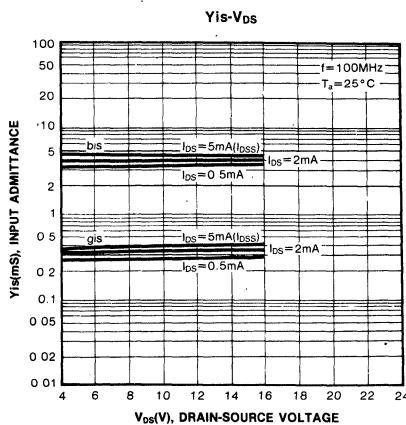
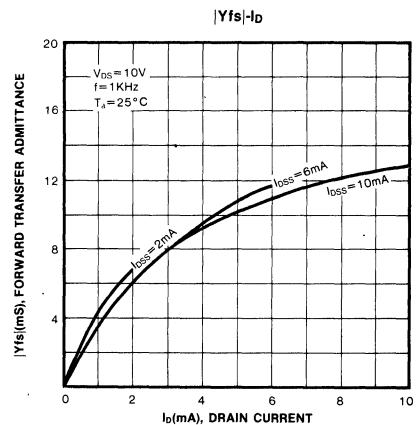


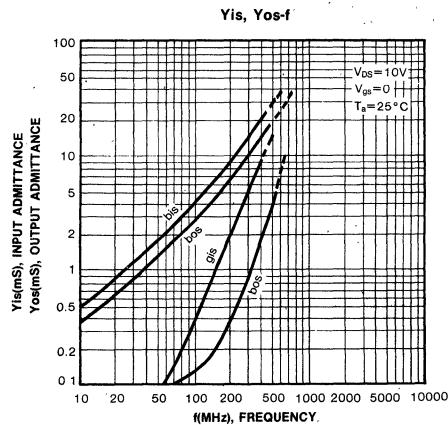
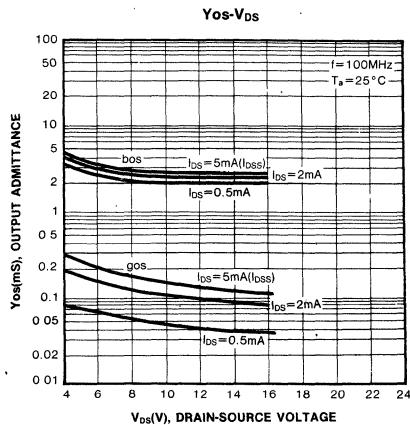
STATIC CHARACTERISTIC

 $I_d - V_{ds}$  $C_{rss} - V_{gd}$ 

POWER DERATING

 $I_d - V_{gs}$ 





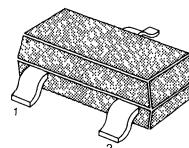
**FM TUNER
VHF AMPLIFIER**

- NF = 2.5 dB (TYP)
- $|Y_{FS}| = 9.0 \text{ mS}$ (TYP)

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Gate-Drain Voltage	V_{GDO}	-18	V
Gate Current	I_G	10	mA
Power Dissipation	P_D	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55~150	$^\circ\text{C}$

SOT-23



1. Drain 2. Gate 3. Source

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

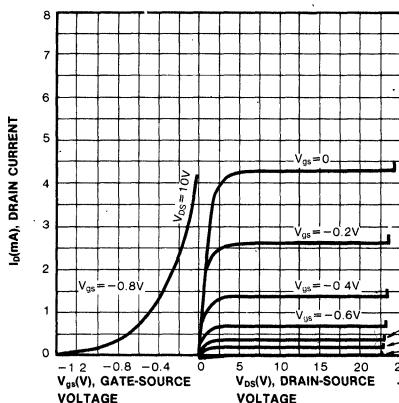
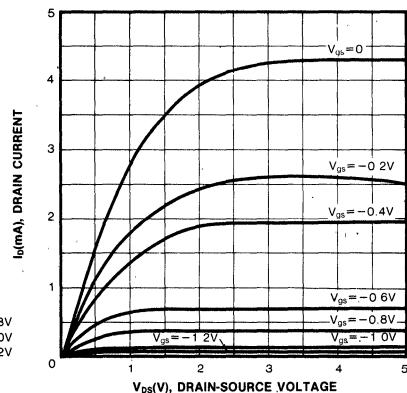
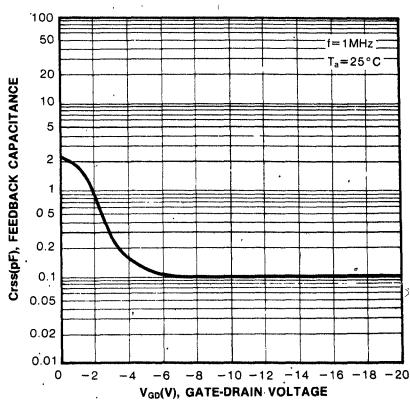
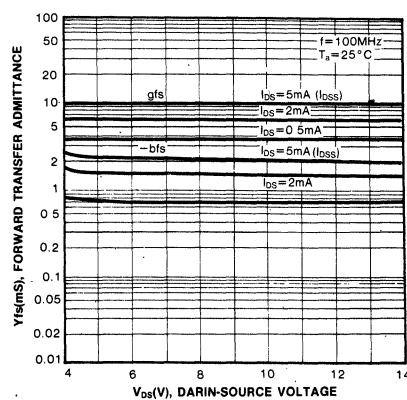
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Gate Cut-off Current	I_{GSS}	$V_{GS} = -0.5\text{V}$, $V_{DS} = 0$			-10	nA
Gate-Drain Breakdown Voltage	$V(BR)_{GDO}$	$I_G = -100\mu\text{A}$, Drain				V
Drain Current	I_{DSS}	$V_{DS} = 10\text{V}$, $V_{GS} = 0$			10	mA
Gate-Source Cut-off Voltage	$V_{GS(\text{off})}$	$V_{DS} = 10\text{V}$, $I_D = 1\mu\text{A}$			4.0	V
Forward Transfer Admittance	$ Y_{FS} $	$V_{DS} = 10\text{V}$, $V_{GS} = 0$, $f = 1\text{kHz}$		9		mS
Reverse Transfer Capacitance	C_{rss}	$V_{GD} = 10\text{V}$, $f = 1\text{MHz}$			0.15	pF
Power Gain	C_{PS}	$V_{DD} = 10\text{V}$, $f = 100\text{MHz}$		18		dB
Noise Figure	NF	$V_{DD} = 10\text{V}$, $f = 100\text{MHz}$		2.5	3.5	dB

 I_{DSS} CLASSIFICATION

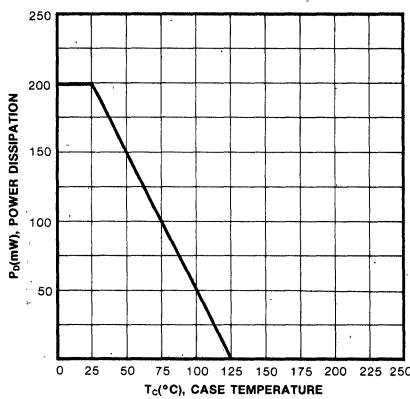
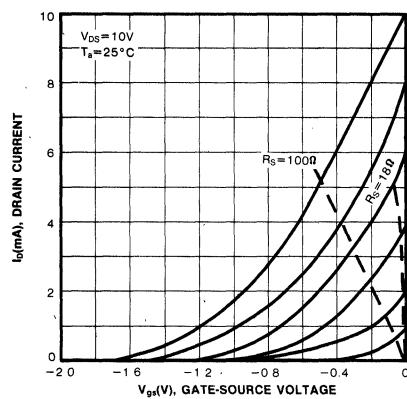
Classification	O	Y	G
I_{DSS}	1.0-3.0	2.5-6.0	5.0-10

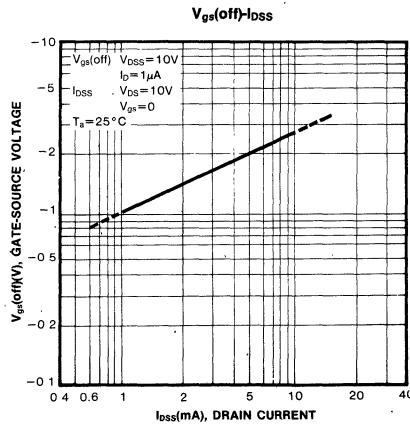
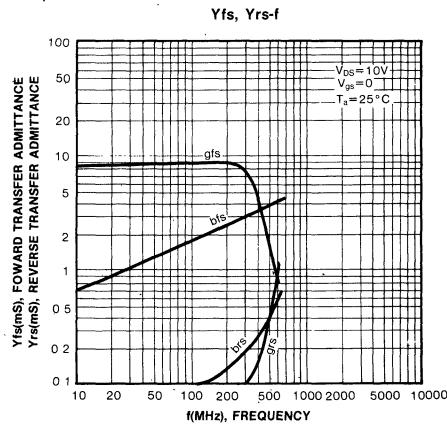
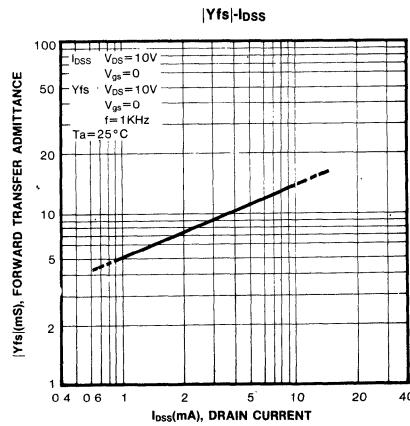
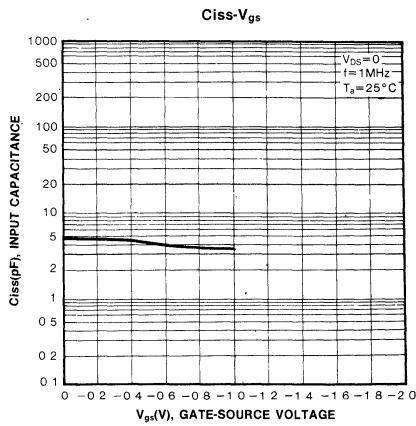
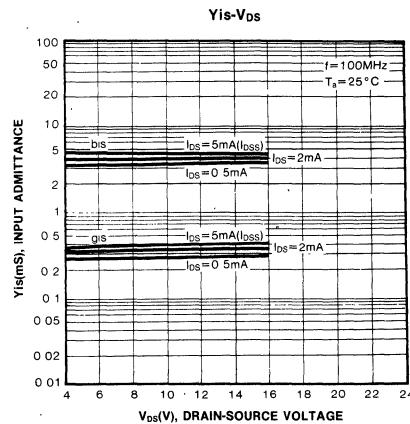
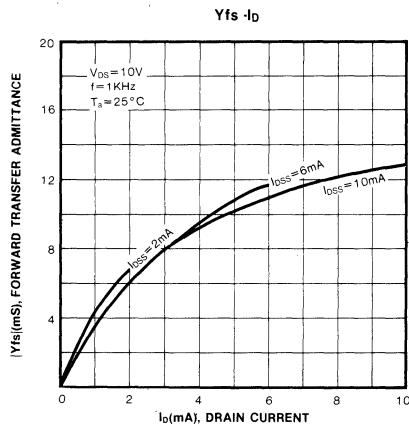


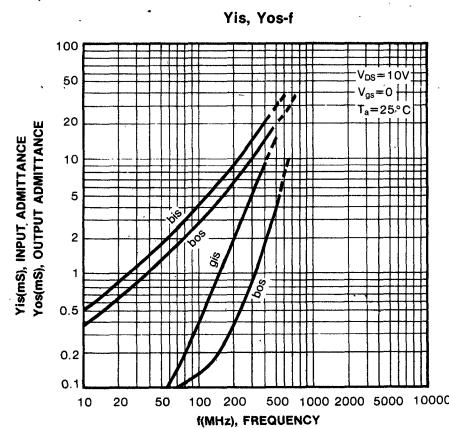
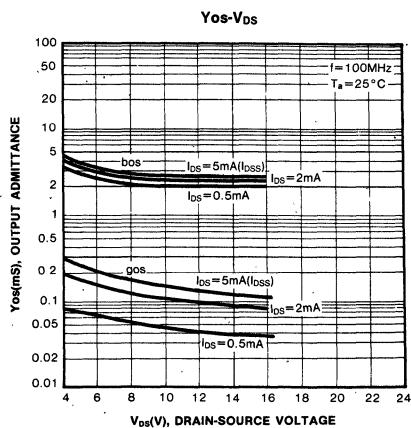
STATIC CHARACTERISTIC

 $I_d - V_{ds}$  $C_{rss}-V_{gs}$  $Y_{fs}-V_{ds}$ 

POWER DERATING

 $I_d - V_{gs}$ 





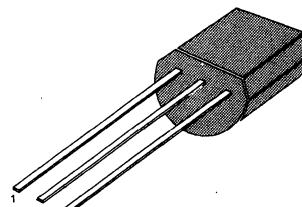
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$, $R_2=4.7\text{K}\Omega$)
- Complement to KSR2001

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92

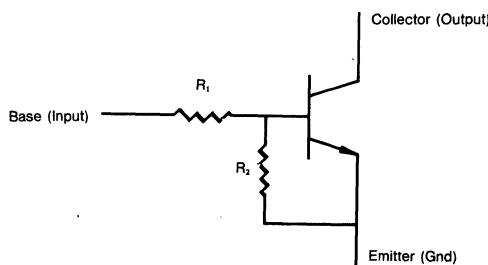


1. Emitter 2. Collector 3. Base

3

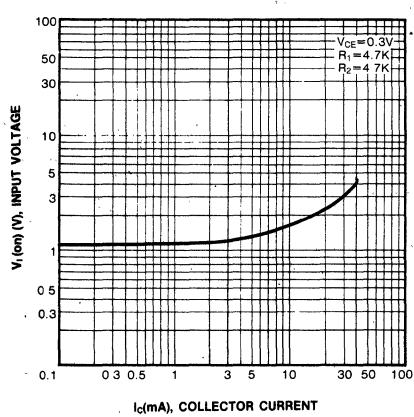
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}$ $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_C=10\text{mA}$	20			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}$, $I_B=0.5\text{mA}$		250	0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}$, $I_C=10\text{V}$				MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}$, $I_E=0$ $f=1.0\text{MHz}$		3.7		pF
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=5\text{V}$, $I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=0.3\text{V}$, $I_C=20\text{mA}$			3	V
Input Resistor	R_1		3.2	4.7	6.2	K Ω
Resistor Ratio	R_1/R_2		0.9	1	1.1	

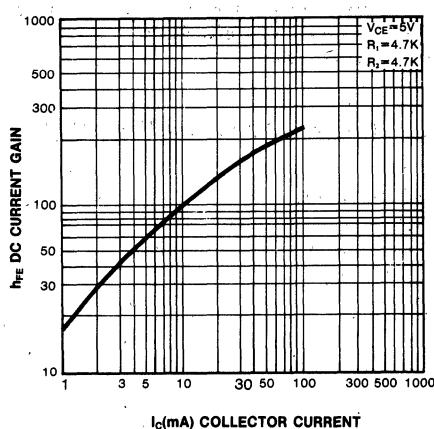
Equivalent Circuit

KSR1001 NPN EPITAXIAL SILICON TRANSISTOR

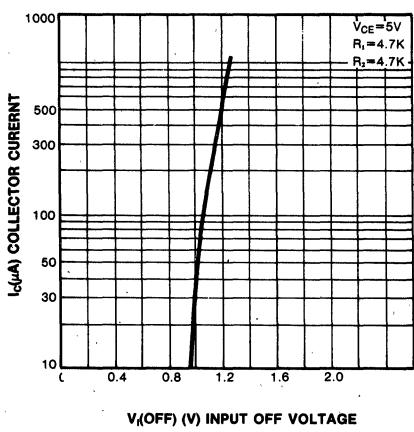
INPUT ON VOLTAGE



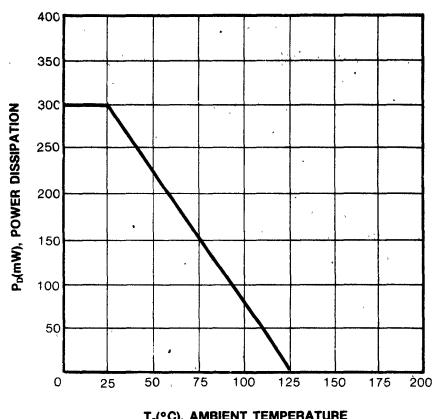
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



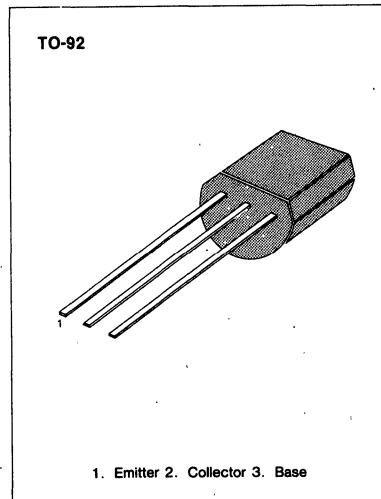
SAMSUNG SEMICONDUCTOR

SWITCHING APPLICATION (Bias Resistor Built In)

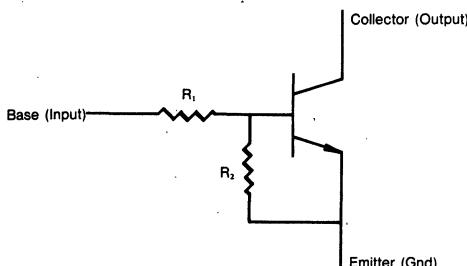
- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=10K\Omega$)
- Complement to KSR2002

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

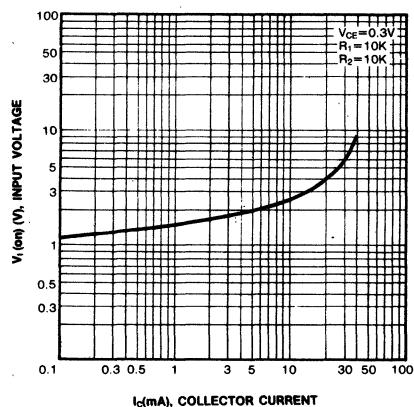
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ C$

**ELECTRICAL CHARACTERISTICS** ($T_a=25^\circ C$)

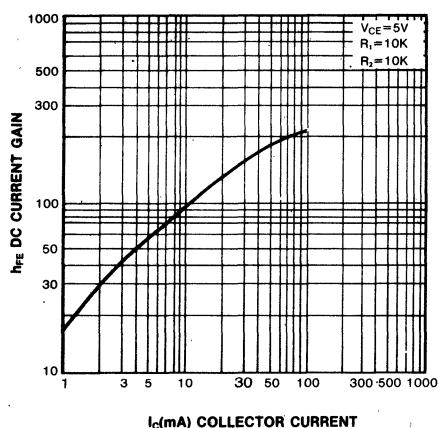
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V$, $I_C=5mA$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA$, $I_B=0.5mA$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA$, $I_C=10V$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10V$, $I_E=0$ $f=1.0MHz$		3.7		pF
Input Off Voltage	$V_{I(off)}$	$V_{CE}=5V$, $I_C=100\mu A$	0.5			V
Input On Voltage	$V_{I(on)}$	$V_{CE}=0.3V$, $I_C=10mA$			3	V
Input Resistor	R_1		7	10	13	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit

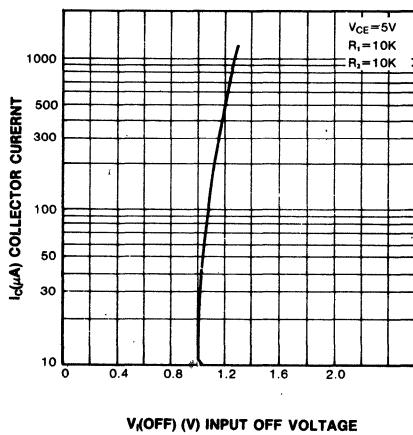
INPUT ON VOLTAGE



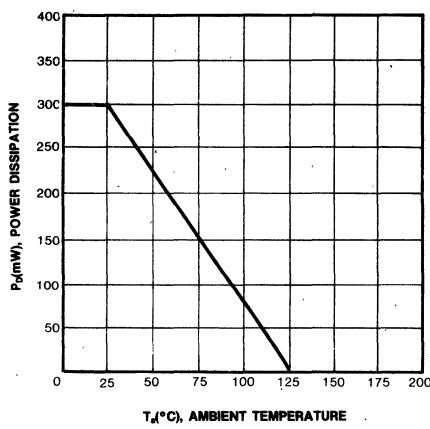
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



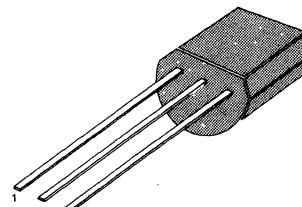
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface-circuit Driver circuit
- Built in bias Resistor ($R_1=22\text{ k}\Omega$, $R_2=22\text{ k}\Omega$)
- Complement to KSR2003

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

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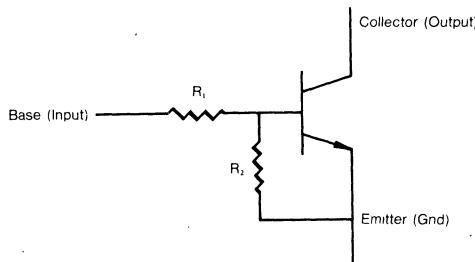


1. Emitter 2. Collector 3. Base

3

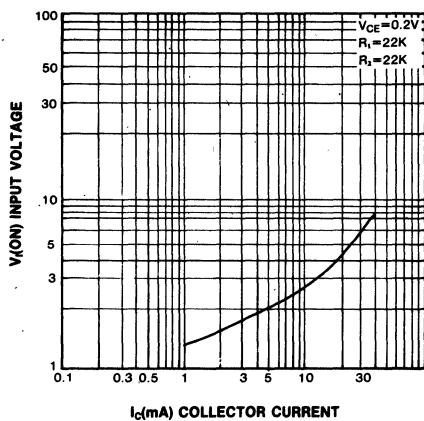
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	56			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=0.5\text{mA}$		250	0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$		3.7		MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$				pF
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=0.2\text{V}, I_C=5\text{mA}$			3.0	V
Input Resistor	R_1		15	22	29	$\text{k}\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

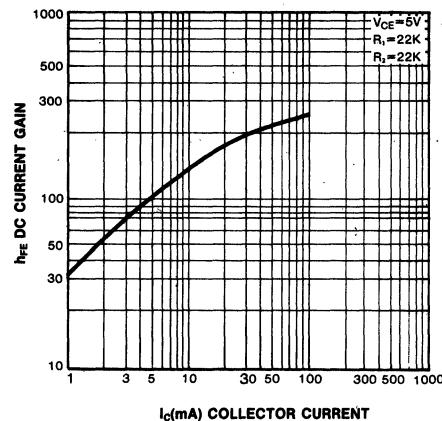
Equivalent Circuit

KSR1003 NPN EPITAXIAL SILICON TRANSISTOR

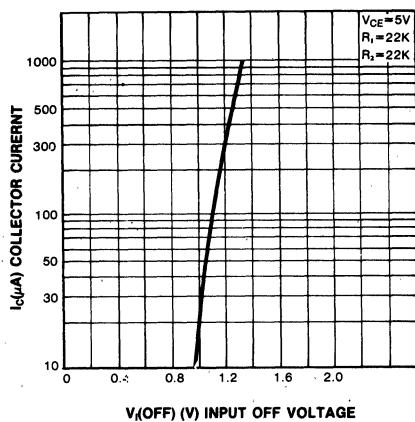
INPUT ON VOLTAGE



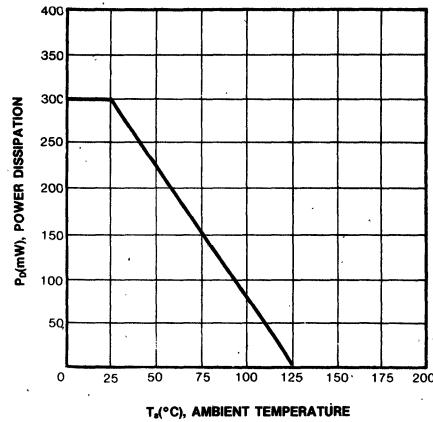
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



SAMSUNG SEMICONDUCTOR

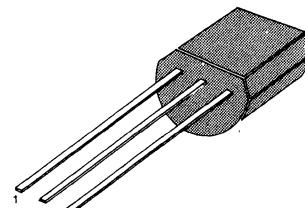
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR2004

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

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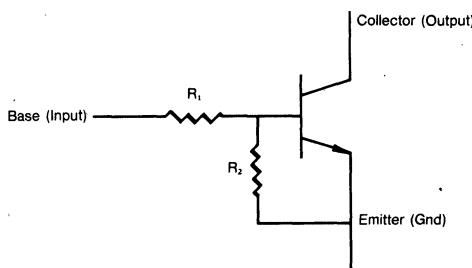


1. Emitter 2. Collector 3. Base

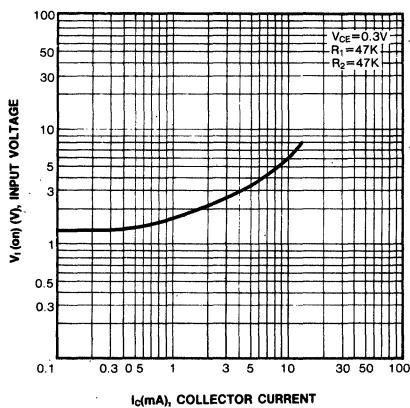
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

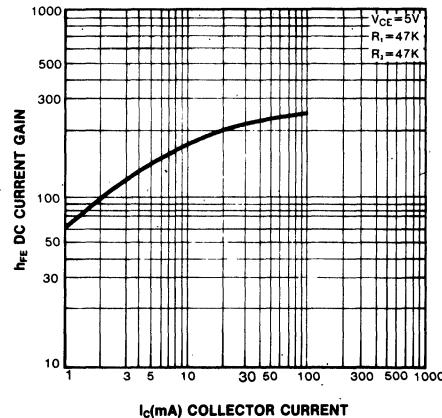
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c=10\text{mA}, I_B=0.5\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_c=10\text{V}$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		3.7		pF
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=5\text{V}, I_c=100\mu\text{A}$	0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=0.3\text{V}, I_c=5\text{mA}$			3	V
Input Resistor	R_1		32	47	62	$\text{k}\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit

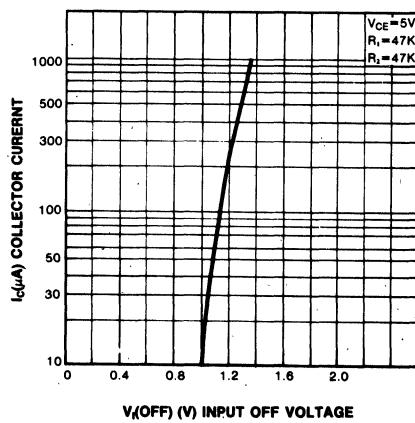
INPUT ON VOLTAGE



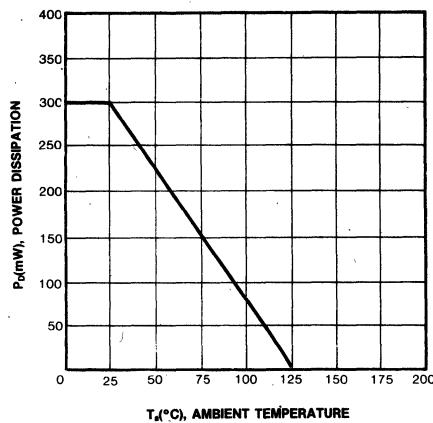
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



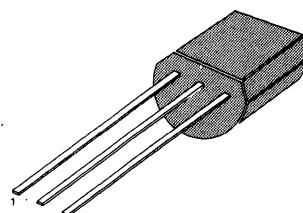
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$, $R_2=10\text{K}\Omega$)
- Complement to KSR2005

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

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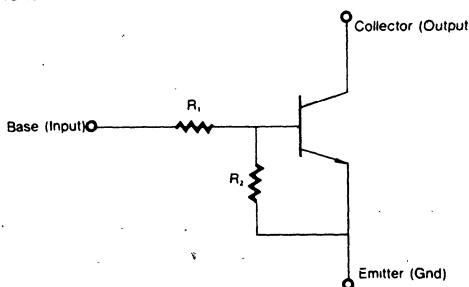


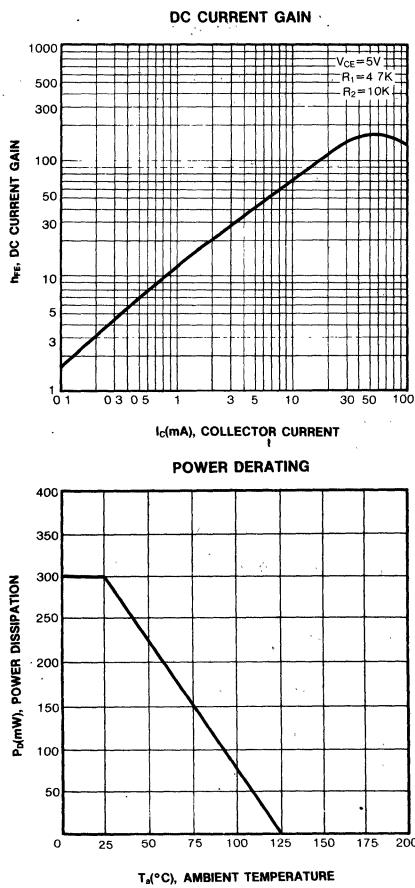
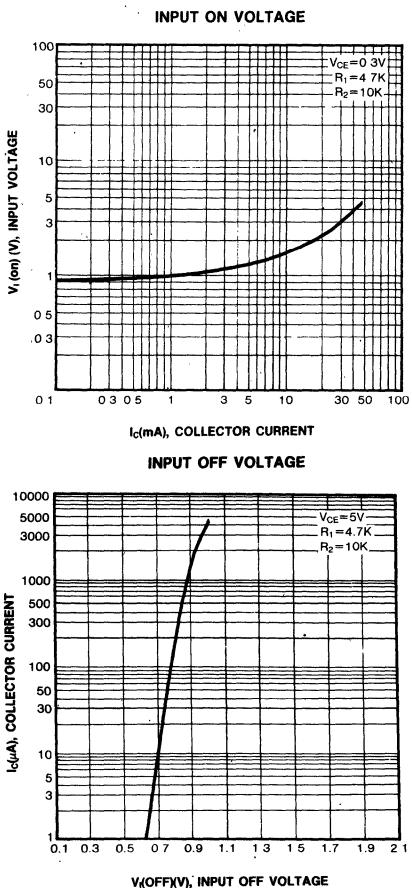
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	30			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=0.5\text{mA}$			0.3	V
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$		250		MHz
Input Off Voltage	$V_I(\text{off})$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.3			V
Input On Voltage	$V_I(\text{on})$	$V_{CE}=0.3\text{V}, I_C=20\text{mA}$			2.5	V
Input Resistor	R_I		32	4.7	6.2	K Ω
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

Equivalent Circuit



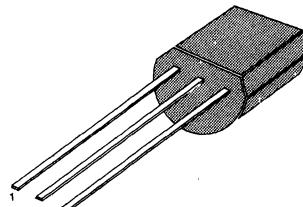
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR2006

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

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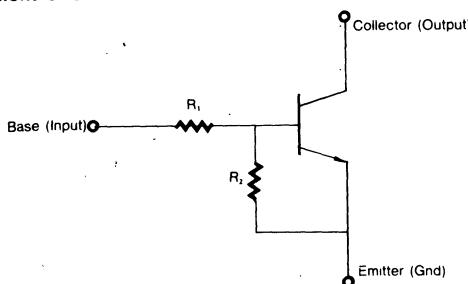


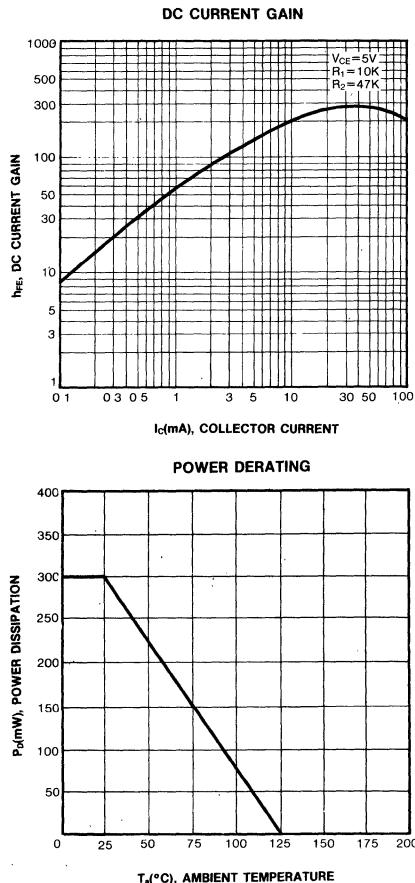
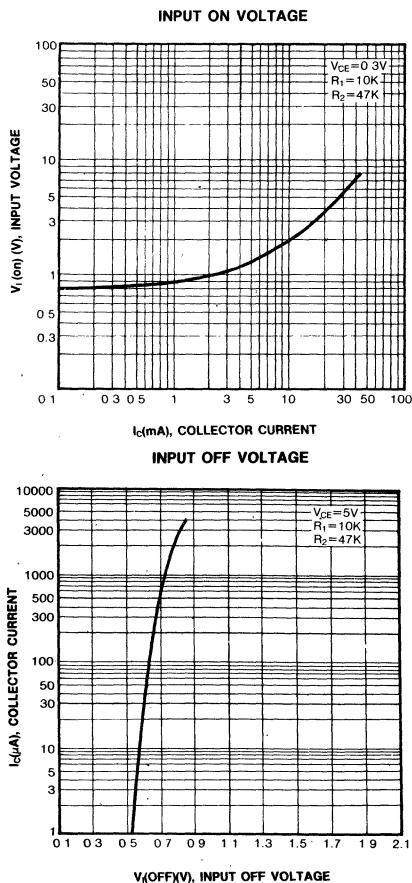
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}$, $I_B=0$	50		0.1	V
Collector Cutoff Current	I_{CB0}	$V_{CB}=40\text{V}$, $I_E=0$		68		μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_C=5\text{mA}$			0.1	μA
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}$, $I_E=0.5\text{mA}$			0.3	V
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}$, $I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}$, $I_C=5\text{mA}$			250	MHz
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=5\text{V}$, $I_C=100\mu\text{A}$	0.3			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=0.3\text{V}$, $I_C=1\text{mA}$			1.4	V
Input Resistor	R_1		7	10	13	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

Equivalent Circuit



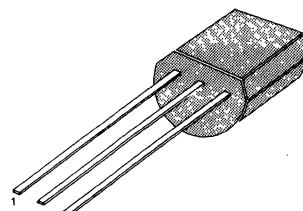
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR2007

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92

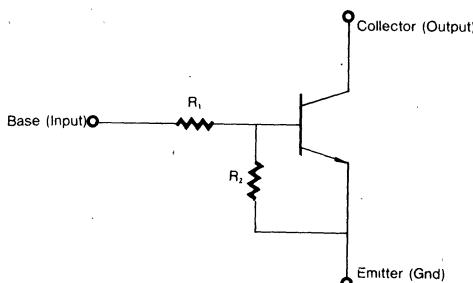


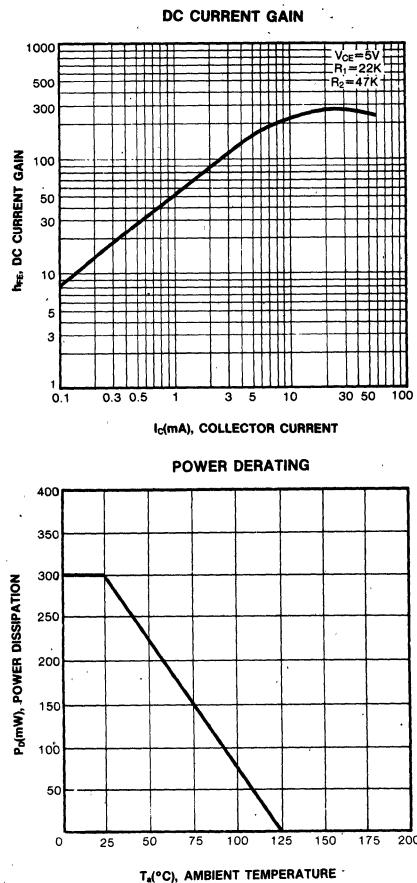
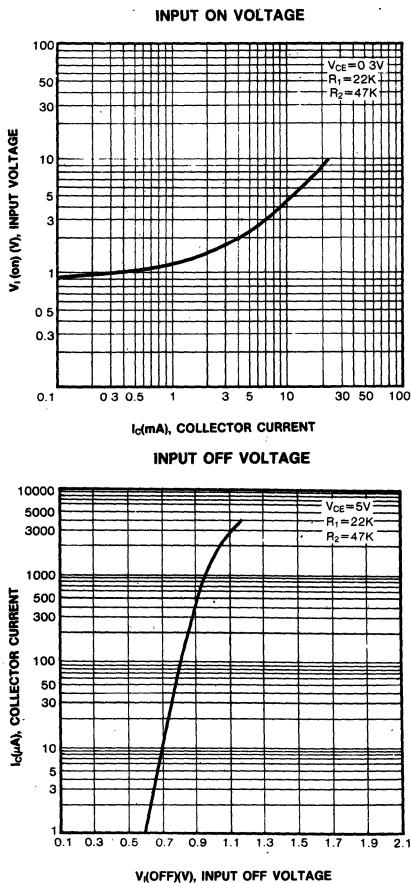
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=0.5\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$				MHz
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.4	250		V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=0.3\text{V}, I_C=2\text{mA}$			2.5	V
Input Resistor	R_i		15	22	29	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

Equivalent Circuit



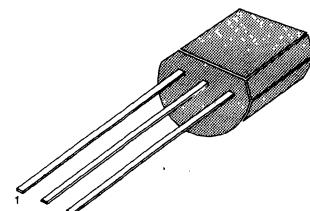
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=22\text{K}\Omega$)
- Complement to KSR2008

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

TO-92

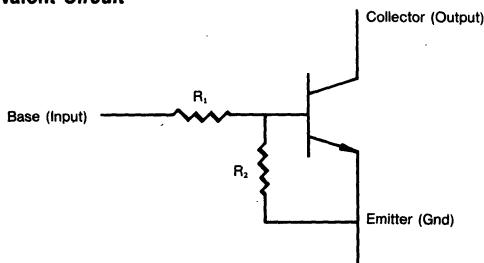


1. Emitter 2. Collector 3. Base

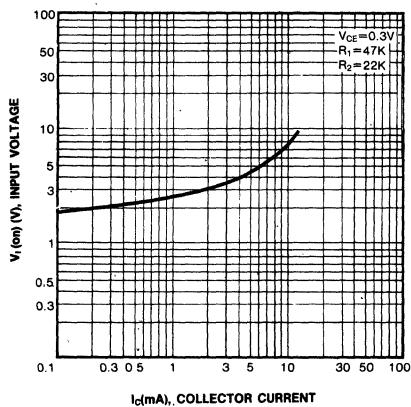
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

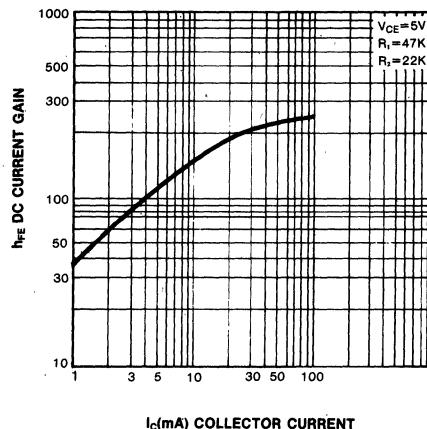
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$	56		0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$		250	0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=0.5\text{mA}$		3.7		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$				pF
Output Capacitance	C_{ob}	$V_{CE}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$				
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.8			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=0.3\text{V}, I_C=2\text{mA}$			4	V
Input Resistor	R_1		32	47	62	$\text{k}\Omega$
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

Equivalent Circuit

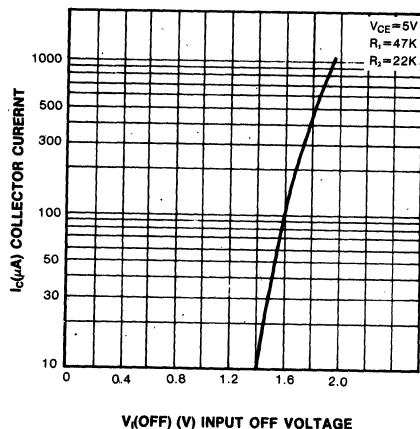
INPUT ON VOLTAGE



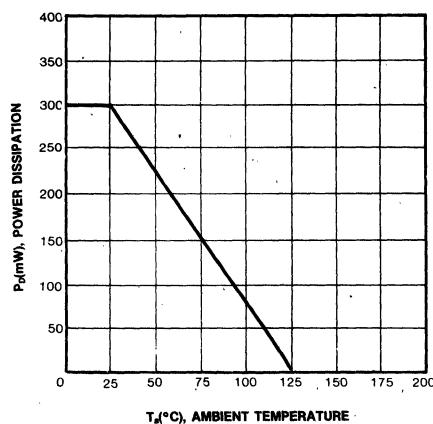
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



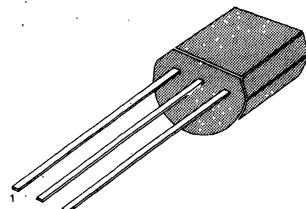
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7\text{K}\Omega$)
- Complement to KSR2009

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92

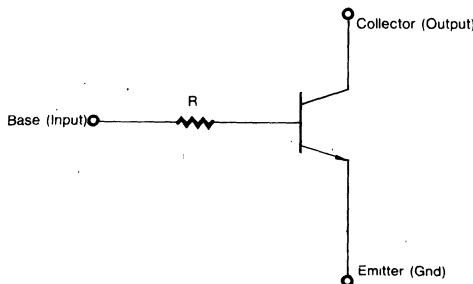


1. Emitter 2. Collector 3. Base

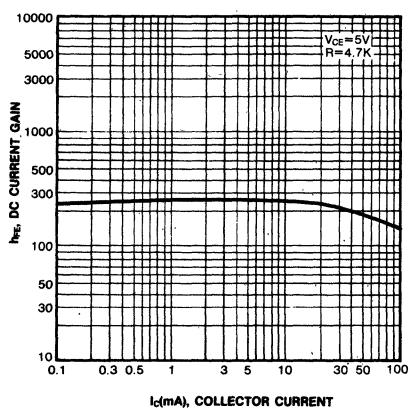
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

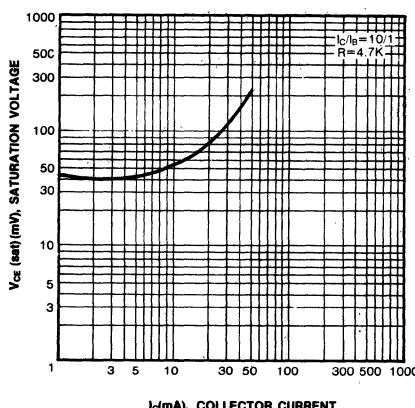
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	100		600	μA
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=1\text{mA}$		3.70	0.3	V
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$				pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$	3.2	250		MHz
Input Resistor	R			4.7	6.2	$\text{K}\Omega$

Equivalent Circuit

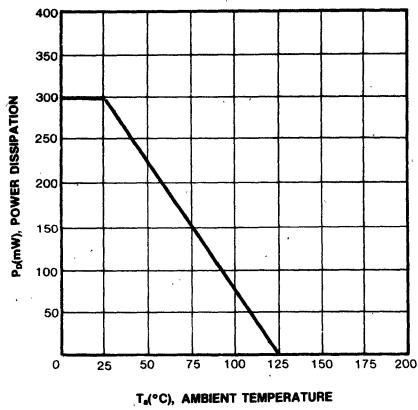
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



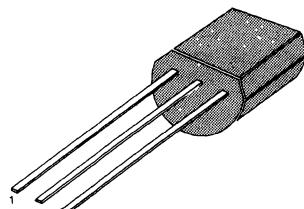
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
- Driver circuit
- Built in bias Resistor ($R=10\text{ k}\Omega$)
- Complement to KSR2010

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92

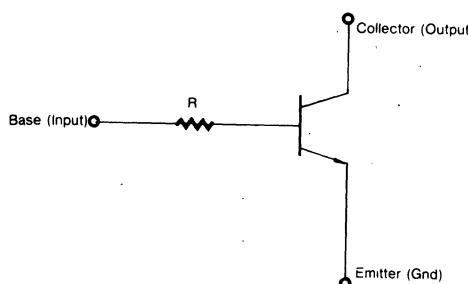


1. Emitter 2. Collector 3. Base

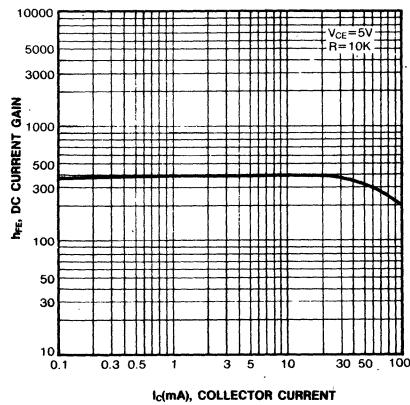
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

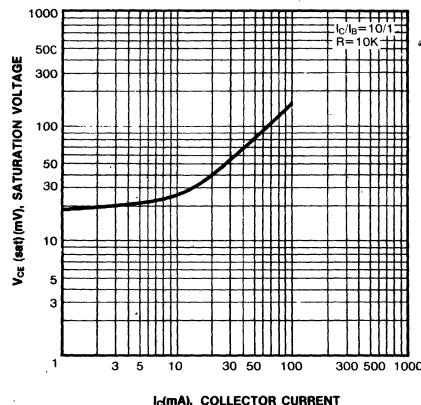
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_E=0$	40			V
Emitter-Emitter Breakdown Voltage	BV_{CEO}	$I_E=1\text{ mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{ V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{ V}, I_c=1\text{ mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c=10\text{ mA}, I_E=1\text{ mA}$		3.7	0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{ V}, I_E=0$ $f=1\text{ MHz}$				pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{ V}, I_c=5\text{ mA}$		250		MHz
Input Resistor	R		7	10	13	$\text{k}\Omega$

Equivalent Circuit

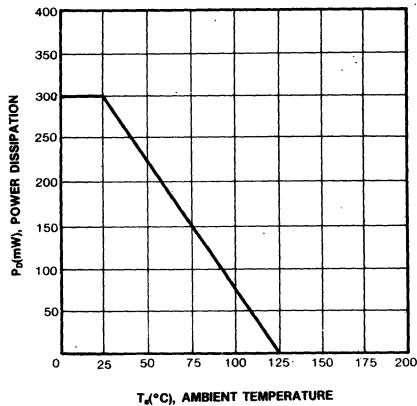
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



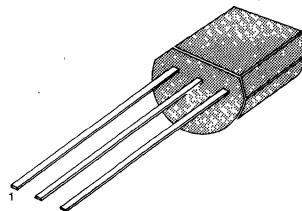
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22\text{K}\Omega$)
- Complement to KSR2011

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92

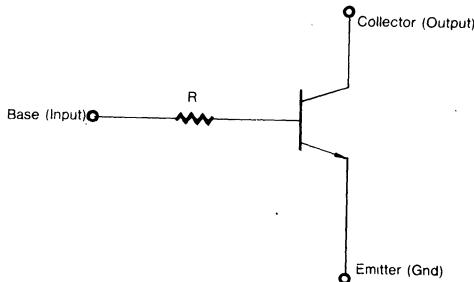


1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Emitter-Emitter Breakdown Voltage	BV_{CEO}	$I_E=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.3	V
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$		3.7		pF
Current Gain-Bandwidth Product	f_T	$f=1\text{MHz}$				MHz
Input Resistor	R	$V_{CE}=10\text{V}, I_C=5\text{mA}$	15	250	29	$\text{K}\Omega$

Equivalent Circuit

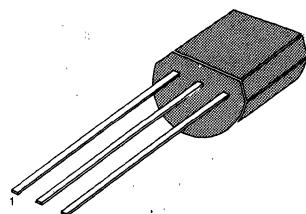
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=47\text{K}\Omega$)
- Complement to KSR2012

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

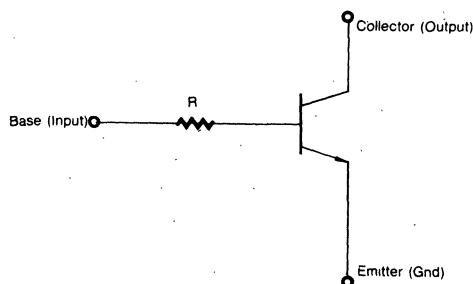
TO-92



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Emitter-Emitter Breakdown Voltage	BV_{CEO}	$I_E=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}, I_E=1\text{mA}$			0.3	V
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$		250		MHz
Input Resistor	R		32	47	62	$\text{K}\Omega$

Equivalent Circuit

SAMSUNG SEMICONDUCTOR

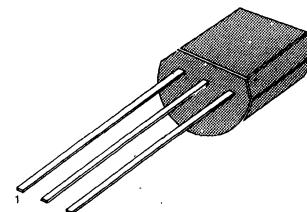
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 2.2K\Omega$, $R_2 = 47K\Omega$)
- Complement to KSR2013

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

TO-92

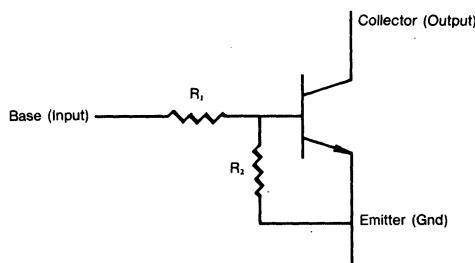


1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C = 10\mu A$, $I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu A$, $I_B = 0$	50		0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40V$, $I_E = 0$		68		μA
DC Current Gain	h_{FE}	$V_{CE} = 5V$, $I_C = 5mA$			0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10mA$, $I_B = 0.5mA$		250		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5mA$, $I_C = 10V$		3.7		pF
Output Capacitance	C_{ob}	$V_{CB} = 10V$, $I_E = 0$ $f = 1.0MHz$				
Input Off Voltage	$V_{i(off)}$	$V_{CE} = 5V$, $I_C = 100\mu A$	0.5			V
Input On Voltage	$V_{i(on)}$	$V_{CE} = 0.2V$, $I_C = 5mA$			1.1	V
Input Resistor	R_1		1.5	2.2	2.9	$K\Omega$
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

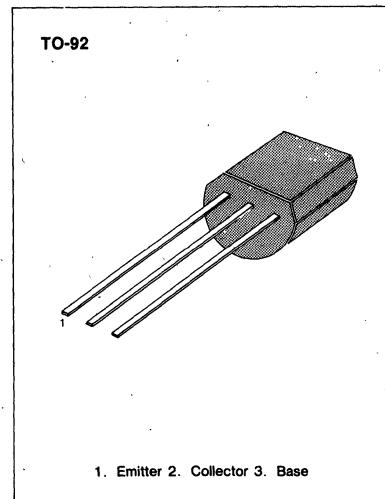
Equivalent Circuit

SWITCHING APPLICATION (Bias Resistor Built In)

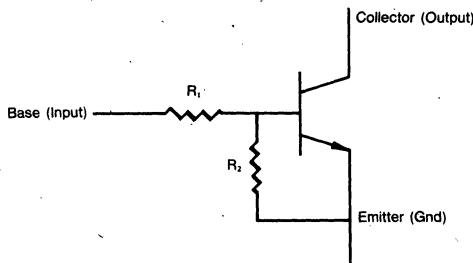
- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7\text{K}\Omega$, $R_2 = 47\text{K}\Omega$)
- Complement to KSR2014

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)**

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C = 10\mu\text{A}, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu\text{A}, I_B = 0$	50		0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40\text{V}, I_E = 0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 5\text{mA}$	68		0.3	μA
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_B = 0.5\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{mA}, I_C = 10\text{V}$		250		MHz
Output Capacitance	C_{OB}	$V_{CE} = 10\text{V}, I_E = 0$		3.7		pF
Input Off Voltage	$V_{I(\text{off})}$	$f = 1.0\text{MHz}$				
Input On Voltage	$V_{I(\text{on})}$	$V_{CE} = 5\text{V}, I_C = 100\mu\text{A}$	0.5			V
Input Resistor	R_I	$V_{CE} = 0.2\text{V}, I_C = 5\text{mA}$	3.2	4.7	6.2	V
Resistor Ratio	R_1/R_2		0.09	0.1	0.11	$\text{K}\Omega$

Equivalent Circuit

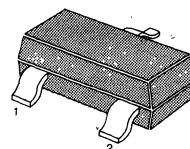
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$ $R_2=4.7\text{K}\Omega$)
- Complement to KSR2101

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23

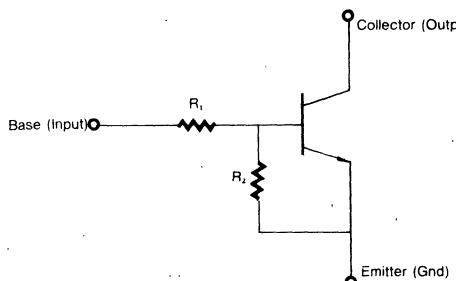
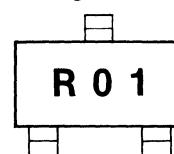


1. Base 2. Emitter 3. Collector

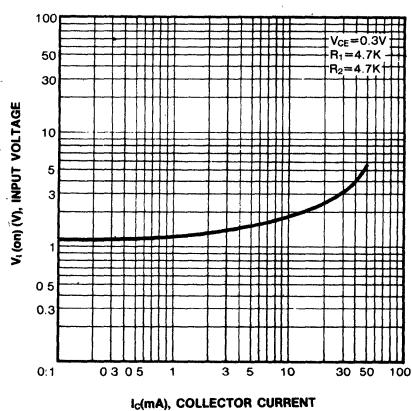
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

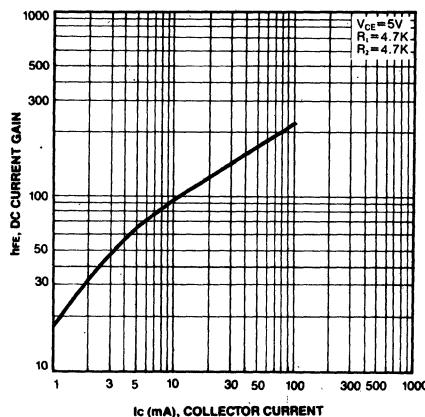
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50		0.1	μA
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$		20		
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\text{mA}$			0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_E=0.5\text{mA}$		250		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$			3.7	pF
Output Capacitance	C_{ob}	$V_{CE}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$				
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_i(\text{on})$	$V_{CE}=0.3\text{V}, I_C=20\text{mA}$		4.7	3	V
Input Resistor	R_1		3.2		6.2	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit**Marking**

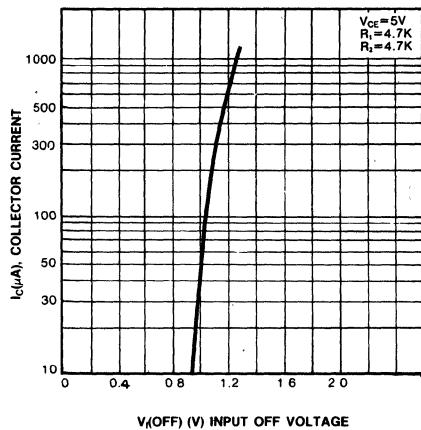
INPUT ON VOLTAGE



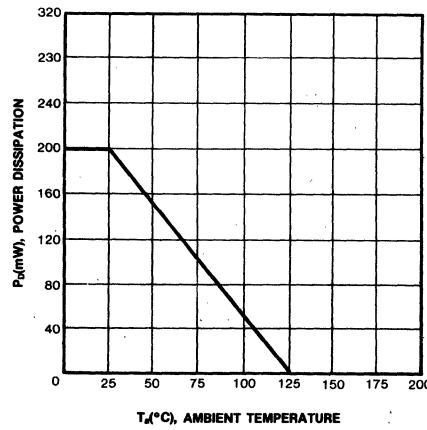
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



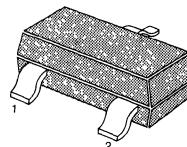
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=10K\Omega$)
- Complement to KSR2102

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$

SOT-23

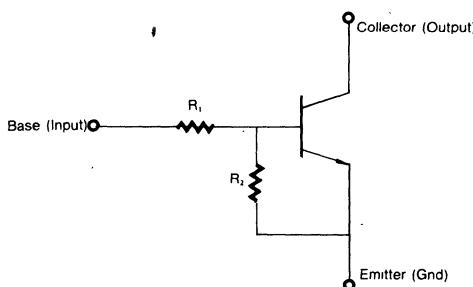
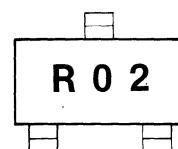


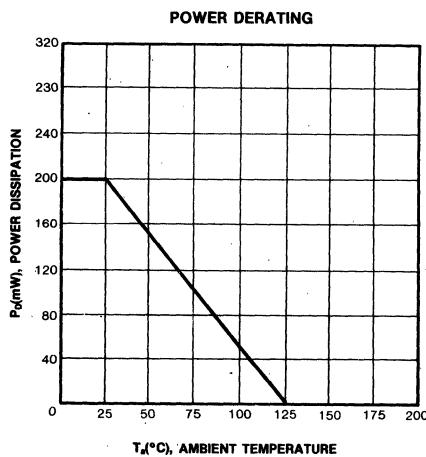
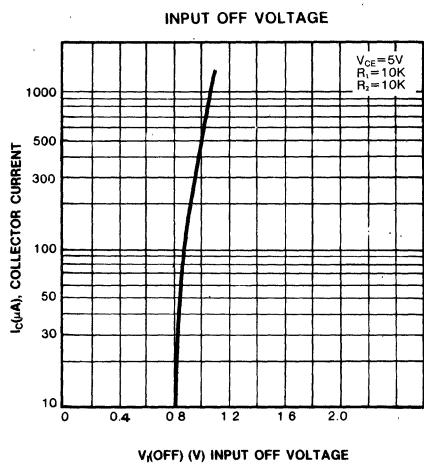
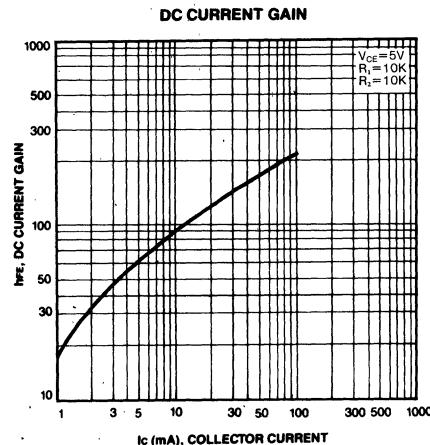
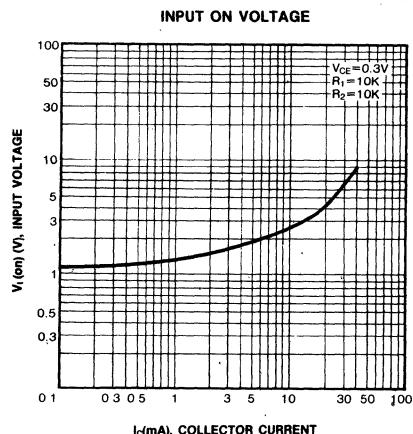
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu A$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A$, $I_B=0$	50		0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V$, $I_C=5mA$	20		0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA$, $I_B=0.5mA$		250	0.3	MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA$, $I_C=10V$		3.7		pF
Output Capacitance	C_{OB}	$V_{CB}=10V$, $I_E=0$ $f=1.0MHz$				V
Input Off Voltage	$V_{I(off)}$	$V_{CE}=5V$, $I_C=100\mu A$	0.5		3	V
Input On Voltage	$V_{I(on)}$	$V_{CE}=0.3V$, $I_C=10mA$		10	13	V
Input Resistor	R_I		7		13	$K\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit**Marking**



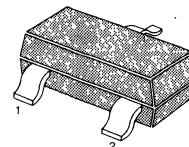
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22\text{ k}\Omega$, $R_2=22\text{ k}\Omega$)
- Complement to KSR2103

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

SOT-23



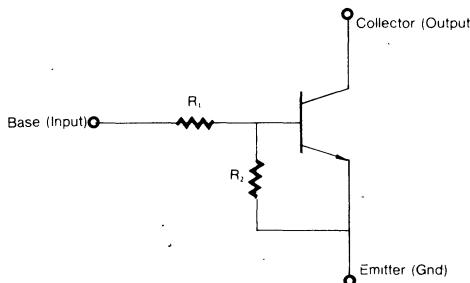
1. Base 2. Emitter 3. Collector

3

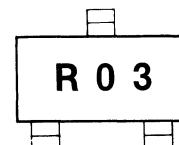
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50		0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$	56		0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$			0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=0.5\text{mA}$		250	0.3	MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$		3.7		pF
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$				V
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=0.2\text{V}, I_C=5\text{mA}$			3.0	V
Input Resistor	R_1		15	22	29	$\text{k}\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

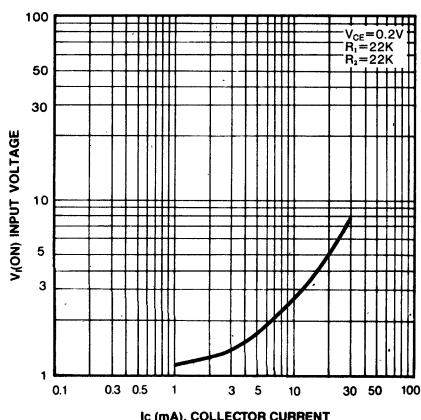
Equivalent Circuit



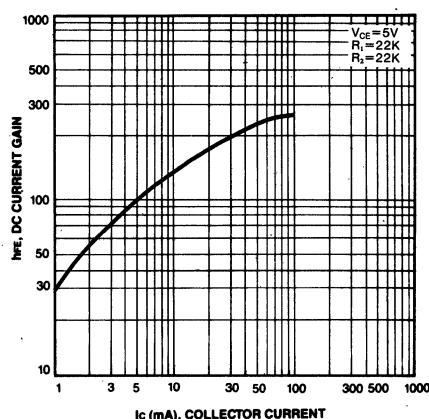
Marking



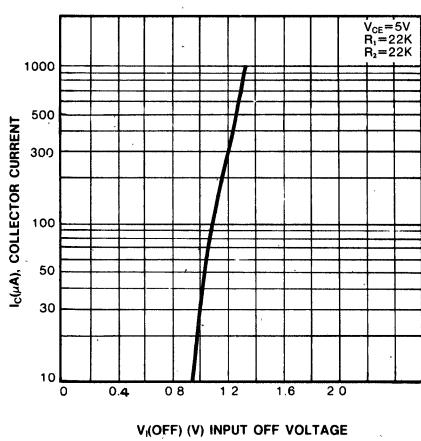
INPUT ON VOLTAGE



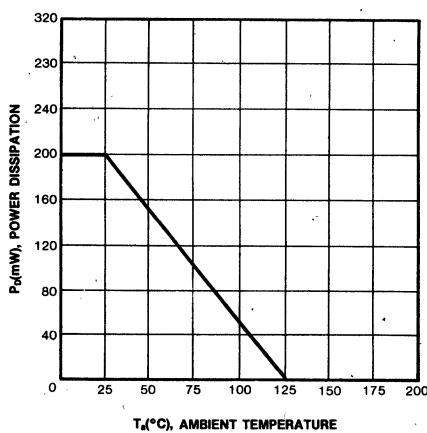
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING

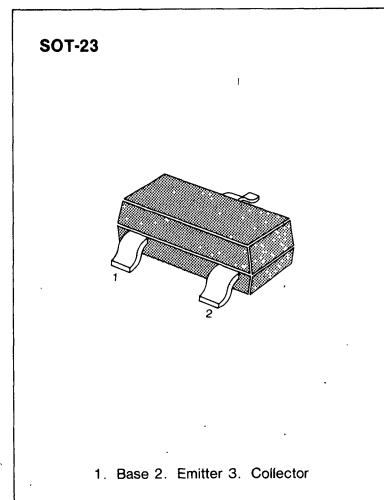


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR2104

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$



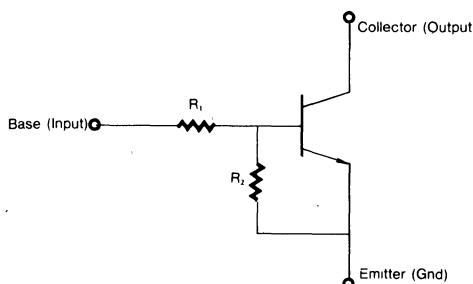
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1. Base 2. Emitter 3. Collector

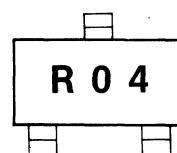
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_E=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_E=0.5\text{mA}$		250	0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$		3.7		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$				pF
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=0.3\text{V}, I_C=5\text{mA}$			3	V
Input Resistor	R_I		32	47	62	$\text{K}\Omega$
Resistor Ratio	R_I/R_2		0.9	1	1.1	

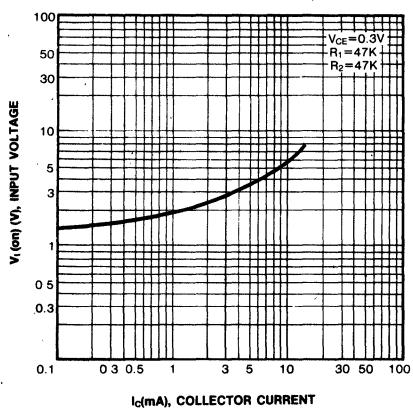
Equivalent Circuit



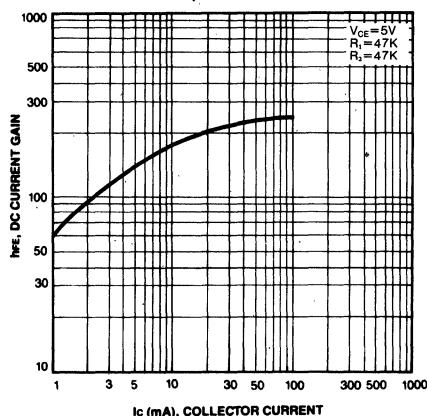
Marking



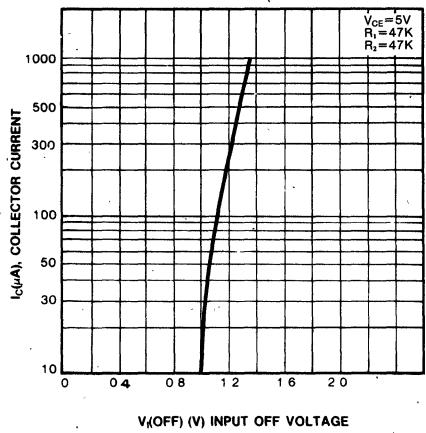
INPUT ON VOLTAGE



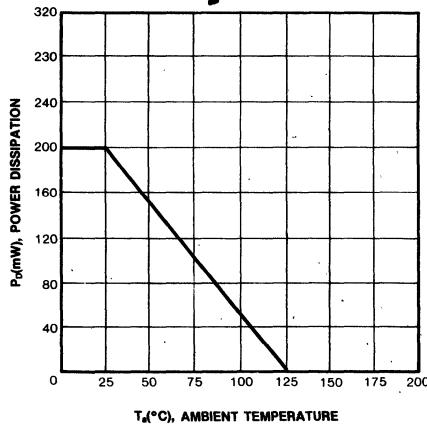
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



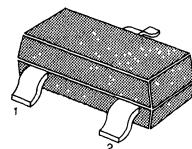
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7\text{ k}\Omega$, $R_2=10\text{ k}\Omega$)
- Complement to KSR2105

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current (max)	I_c	100	mA
Collector Dissipation	P_c	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23

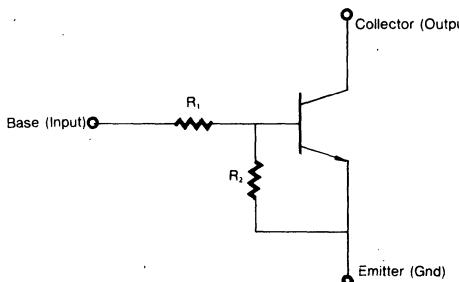
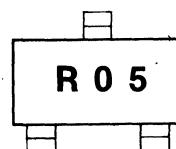


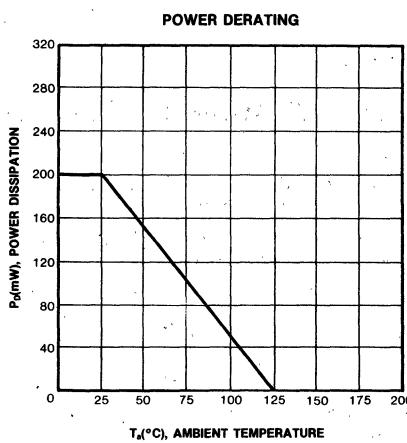
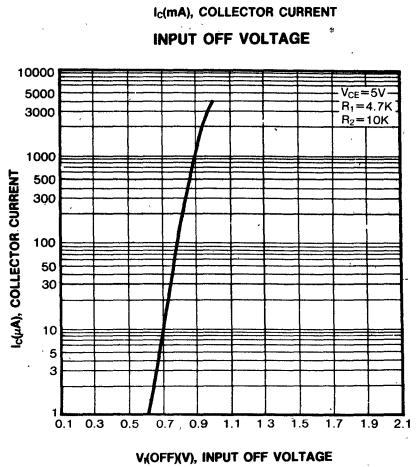
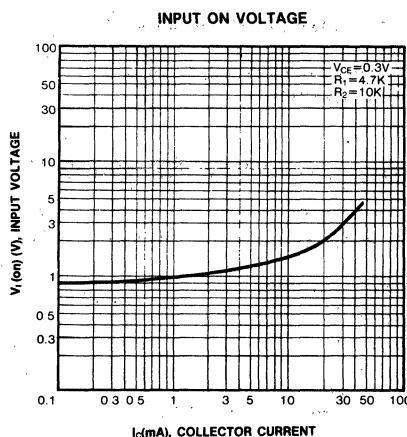
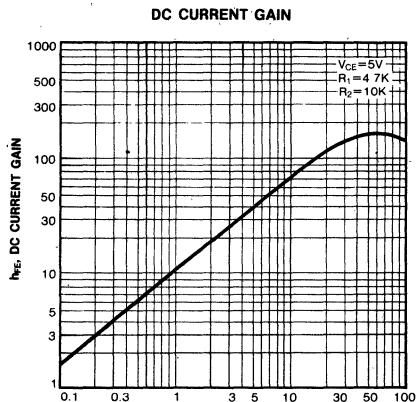
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}$, $I_B=0$	50		0.1	μA
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$			0.3	
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_C=5\text{mA}$	30		0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}$, $I_B=0.5\text{mA}$			3.7	pF
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}$, $I_E=0$ $f=1\text{MHz}$		250		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}$, $I_C=5\text{mA}$	0.3			V
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=5\text{V}$, $I_C=100\mu\text{A}$			2.5*	V
Input On Voltage	$V_i(\text{on})$	$V_{CE}=0.3\text{V}$, $I_C=20\text{mA}$	32	4.7	6.2	V
Input Resistor	R_1		0.42	0.47	0.52	$\text{k}\Omega$
Resistor Ratio	R_1/R_2					

Equivalent Circuit**Marking**



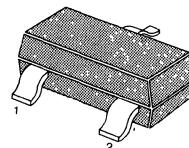
SWITCHING APPLICATION (Bias Resistor Built In)

- **Switching Circuit, Inverter, Interface circuit**
Driver circuit
- **Built in bias Resistor ($R_1=10\text{K}\Omega$, $R_2=47\text{K}\Omega$)**
- Complement to KSR2106

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

SOT-23

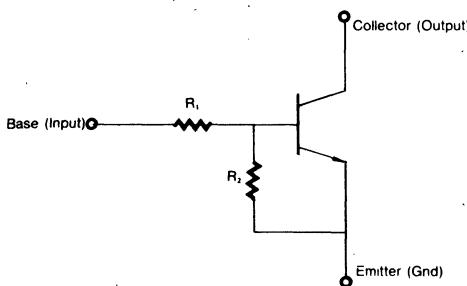
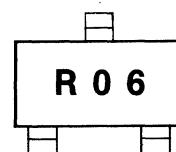


1. Base 2. Emitter 3. Collector

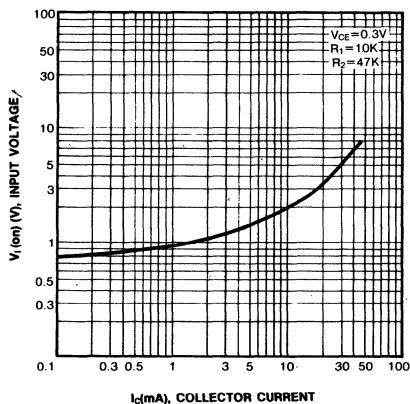
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

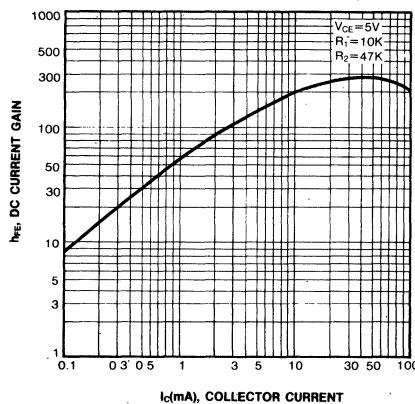
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c=10\text{mA}, I_B=0.5\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CE}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_c=5\text{mA}$			250	MHz
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=5\text{V}, I_c=100\mu\text{A}$	0.3			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=0.3\text{V}, I_c=1\text{mA}$			1.4	V
Input Resistor	R_1		7	10	13	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

Equivalent Circuit**Marking**

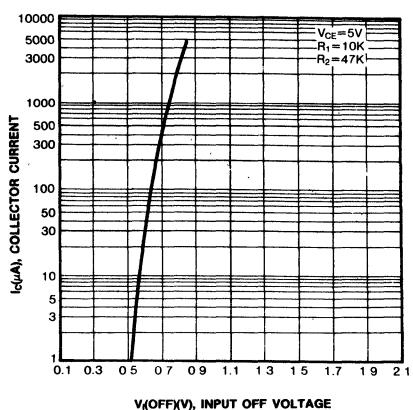
INPUT ON VOLTAGE



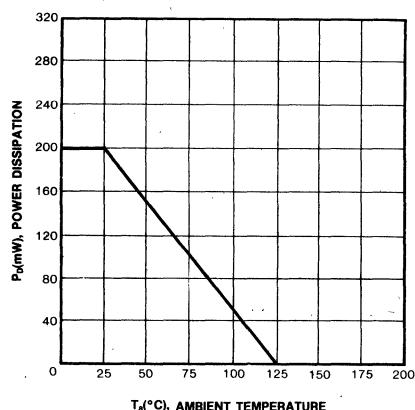
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



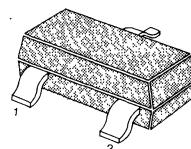
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
- Driver circuit
- Built in bias Resistor ($R_1=22\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR2107

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

SOT-23



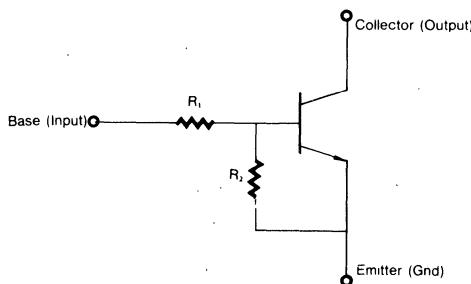
1 Base 2. Emitter 3 Collector

3

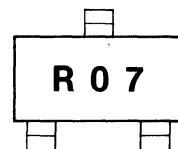
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

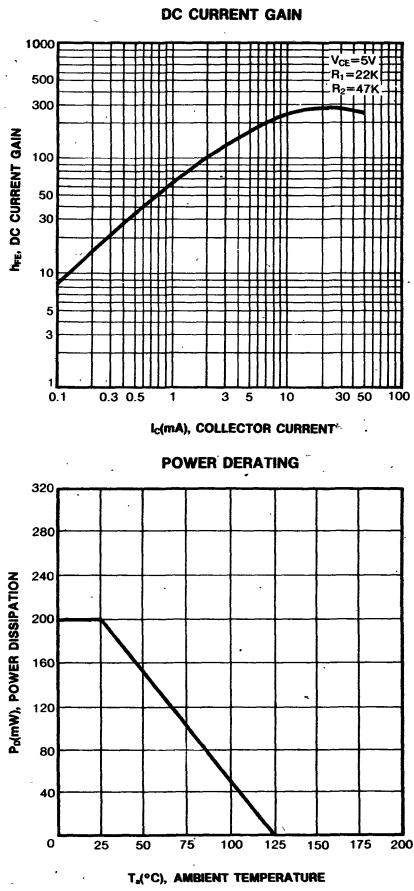
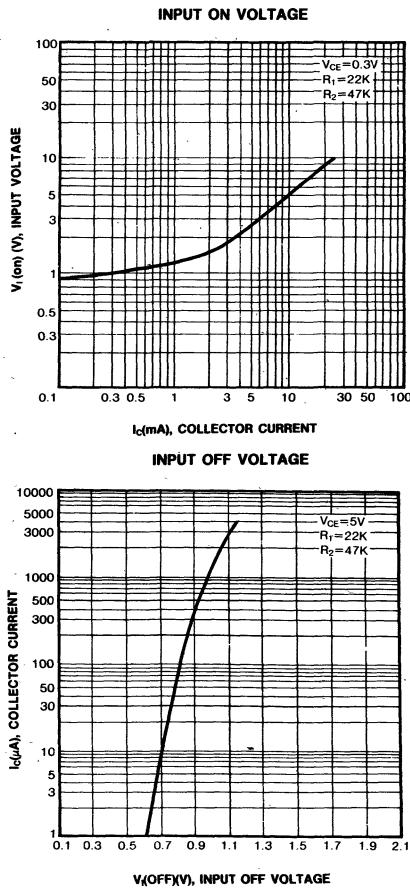
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}, I_B=0.5\text{mA}$			0.3	V
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$		250		MHz
Input Off Voltage	$V_I(\text{off})$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.4			V
Input On Voltage	$V_I(\text{on})$	$V_{CE}=0.3\text{V}, I_C=2\text{mA}$			2.5	V
Input Resistor	R_1		15	22	29	$\text{k}\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

Equivalent Circuit



Marking





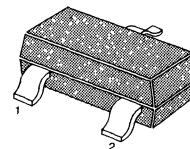
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=22\text{K}\Omega$)
- Complement to KSR2108

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

SOT-23

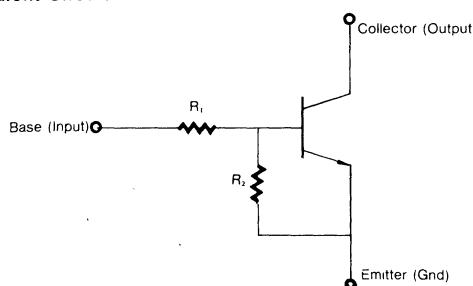
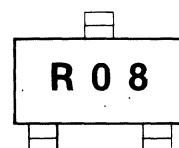


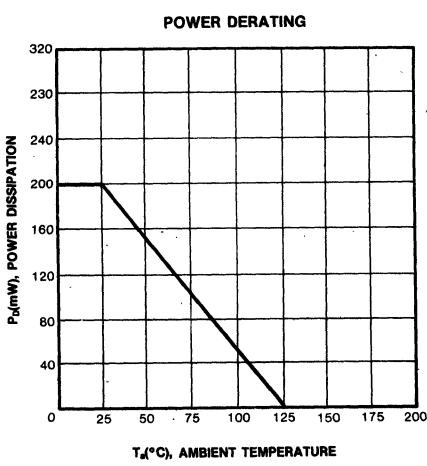
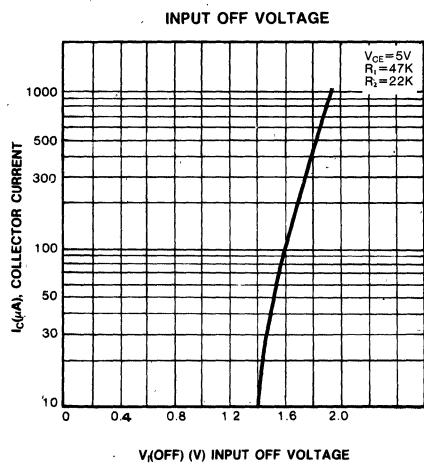
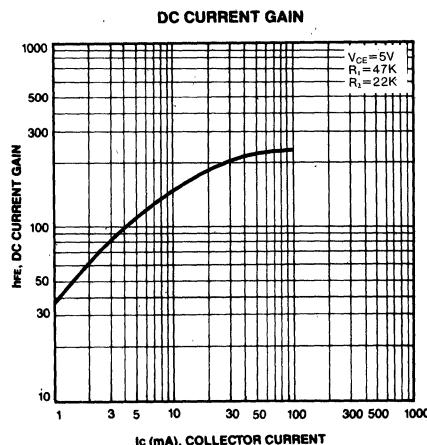
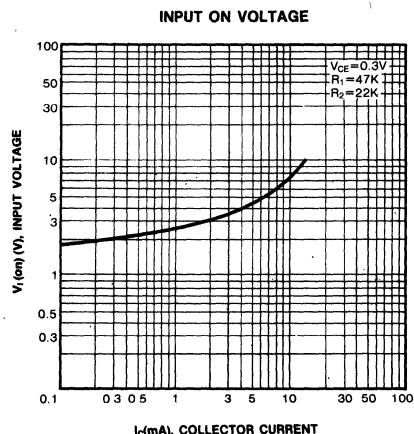
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	56			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=0.5\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$		250		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		3.7		pF
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.8			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=0.3\text{V}, I_C=2\text{mA}$			4	V
Input Resistor	R_I		32	47	62	$\text{k}\Omega$
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

Equivalent Circuit**Marking**



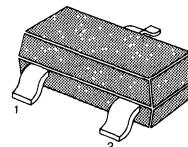
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
- Driver circuit
- Built in bias Resistor ($R=4.7\text{K}\Omega$)
- Complement to KSR2109

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

SOT-23

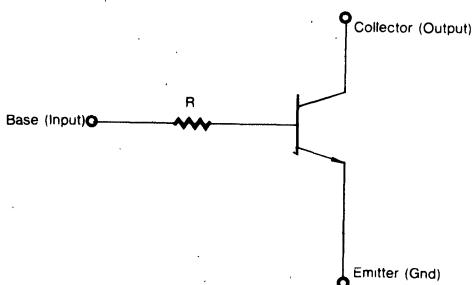
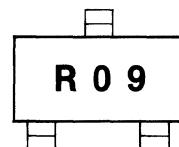


1. Base 2. Emitter 3. Collector

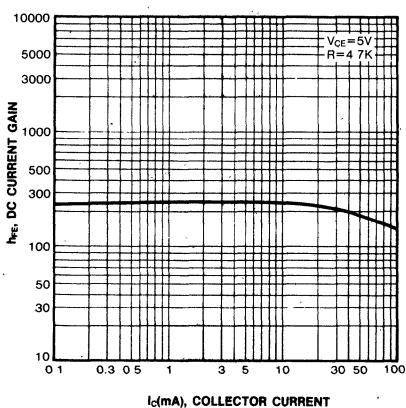
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

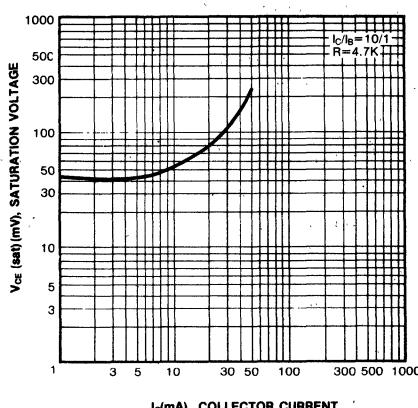
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{mA}, I_B=1\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{cb}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.70		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_c=5\text{mA}$			250	MHz
Input Resistor	R		3.2	4.7	6.2	$\text{K}\Omega$

Equivalent Circuit**Marking**

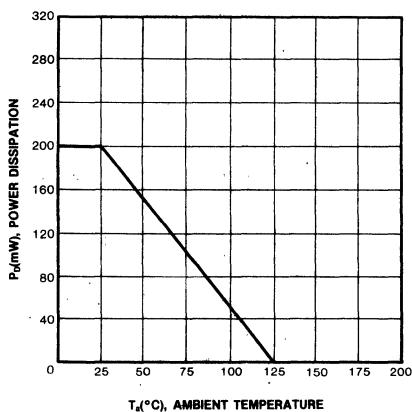
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



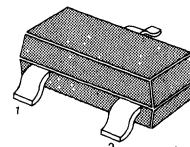
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
- Driver circuit
- Built in bias Resistor ($R=10K\Omega$)
- Complement to KSR2110

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

SOT-23

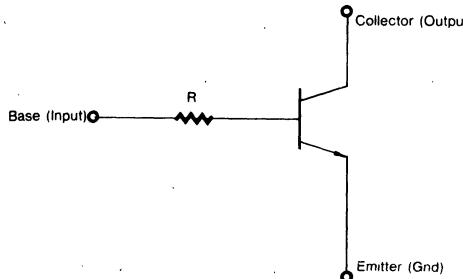
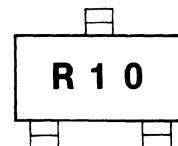


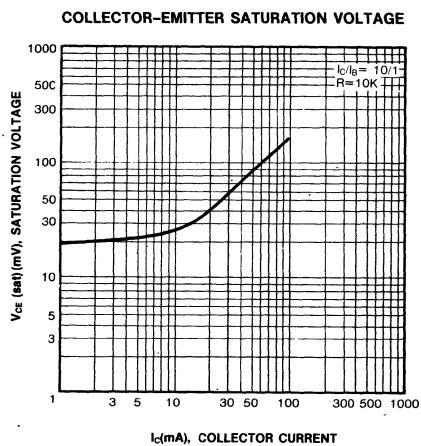
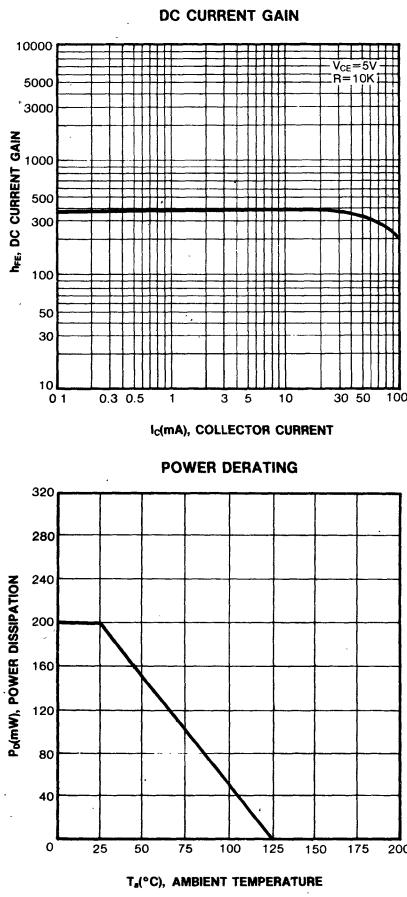
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Emitter-Emitter Breakdown Voltage	BV_{CEO}	$I_E=1mA, I_C=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_E=1mA$			0.3	V
Output Capacitance	C_{OB}	$V_{CB}=10V, I_E=0$		3.7		pF
Current Gain-Bandwidth Product	f_T	$f=1MHz$				MHz
Input Resistor	R	$V_{CE}=10V, I_C=5mA$	7	250	13	$K\Omega$

Equivalent Circuit**Marking**



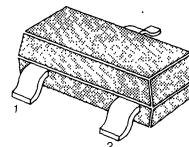
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22\text{K}\Omega$)
- Complement to KSR2111

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

SOT-23

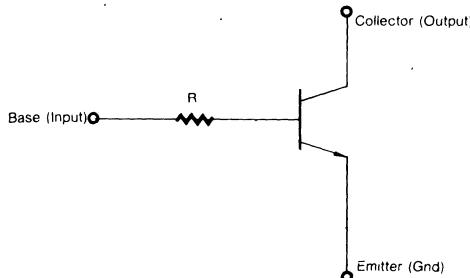
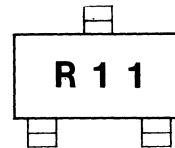


1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Emitter-Emitter Breakdown Voltage	BV_{CEO}	$I_E=1\text{mA}, I_B=0$	40		0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	100		600	μA
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_E=1\text{mA}$		3.7	0.3	V
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$				pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$	15	250		MHz
Input Resistor	R			22	29	$\text{k}\Omega$

Equivalent Circuit**Marking**

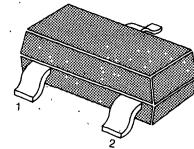
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=47\text{K}\Omega$)
- Complement to KSR2112

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 - 150	$^\circ\text{C}$

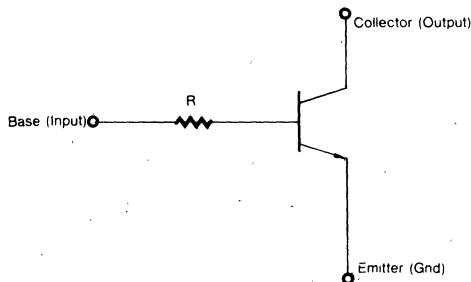
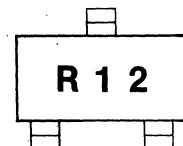
SOT-23



1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Emitter-Emitter Breakdown Voltage	BV_{CEO}	$I_E=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=1\text{mA}$		3.7	0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$				pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$	32	250		MHz
Input Resistor	R			47	62	$\text{K}\Omega$

Equivalent Circuit**Marking**

SAMSUNG SEMICONDUCTOR

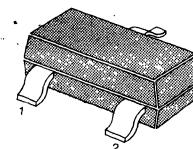
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 2.2\text{K}\Omega$, $R_2 = 47\text{K}\Omega$)
- Complement to KSR2113

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23

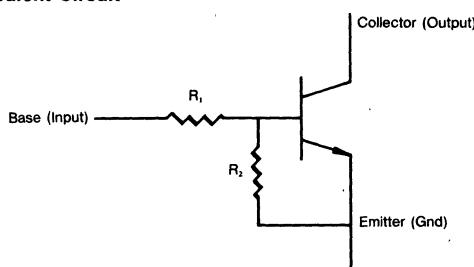
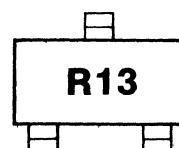


1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_E=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_E=0.5\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		3.7		pF
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=0.2\text{V}, I_C=5\text{mA}$			1.1	V
Input Resistor	R_1		1.5	2.2	2.9	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

Equivalent Circuit**Marking**

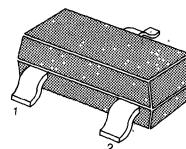
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7\text{ k}\Omega$, $R_2 = 47\text{ k}\Omega$)
- Complement to KSR2114

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

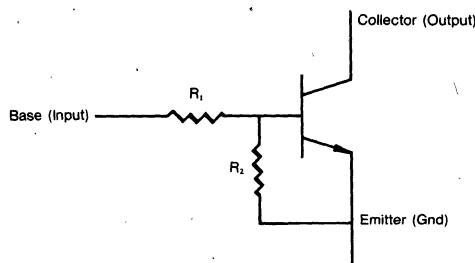
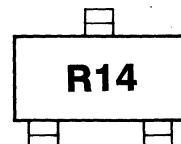
SOT-23



1 Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C = 10\mu\text{A}, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu\text{A}, I_B = 0$	50			V
Collector Cutoff Current	I_{CEO}	$V_{CB} = 40\text{V}, I_E = 0$	68		0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 5\text{mA}$		250	0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 10\text{mA}, I_E = 0.5\text{mA}$				MHz
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{mA}, I_C = 10\text{V}$				pF
Output Capacitance	C_{OB}	$V_{CE} = 10\text{V}, I_E = 0$ $f = 1.0\text{MHz}$				
Input Off Voltage	$V_{I(off)}$	$V_{CE} = 5\text{V}, I_C = 100\mu\text{A}$	0.5			V
Input On Voltage	$V_{I(on)}$	$V_{CE} = 0.2\text{V}, I_C = 5\text{mA}$			1.3	V
Input Resistor	R_I		3.2	4.7	6.2	$\text{k}\Omega$
Resistor Ratio	R_I/R_2		0.09	0.1	0.11	

Equivalent Circuit**Marking**

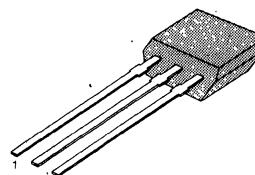
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$, $R_2=4.7\text{K}\Omega$)
- Complement to KSR2201

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92S

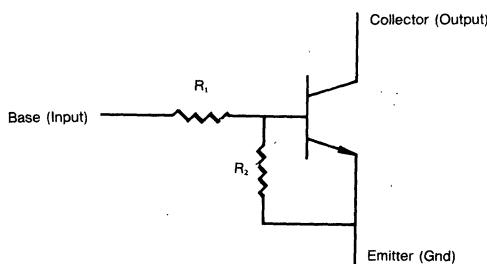


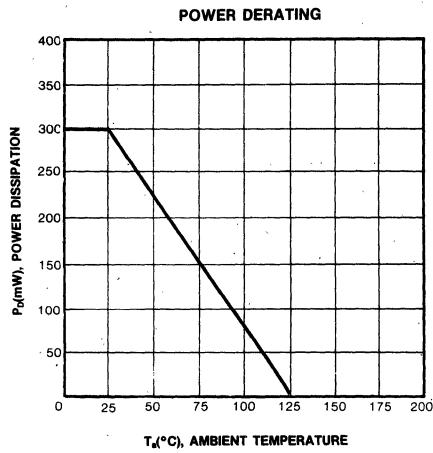
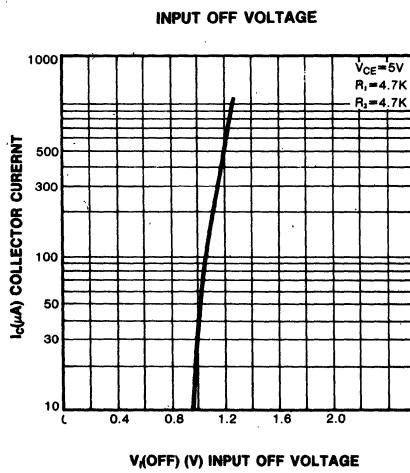
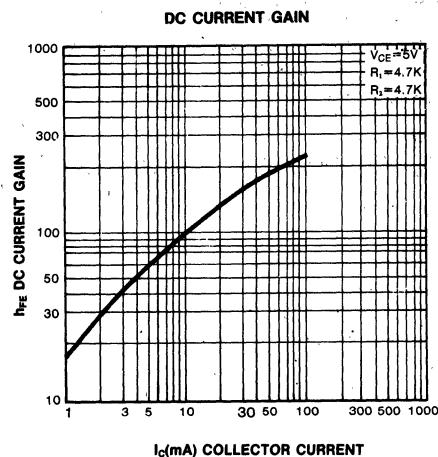
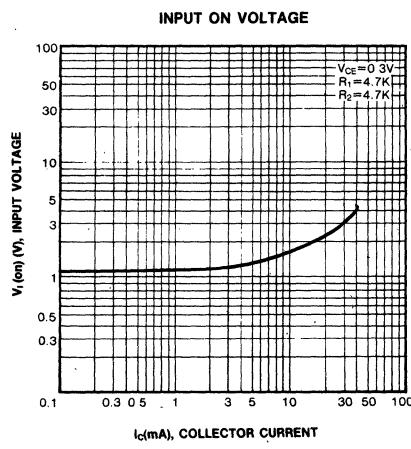
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=10\mu\text{A}$ $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$	20		0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_C=10\text{mA}$				
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10\text{mA}$, $I_B=0.5\text{mA}$		250	0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}$, $I_C=10\text{V}$				MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}$, $I_E=0$ $f=1.0\text{MHz}$		3.7		pF
Input Off Voltage	$V_{I(off)}$	$V_{CE}=5\text{V}$, $I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_{I(on)}$	$V_{CE}=0.3\text{V}$, $I_C=20\text{mA}$	3.2	4.7	3	V
Input Resistor	R_I		0.9	1	6.2	K Ω
Resistor Ratio	R_1/R_2				1.1	

Equivalent Circuit



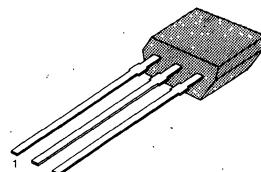
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=10K\Omega$, $R_2=10K\Omega$)
- Complement to KSR2202

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$.

TO-92S

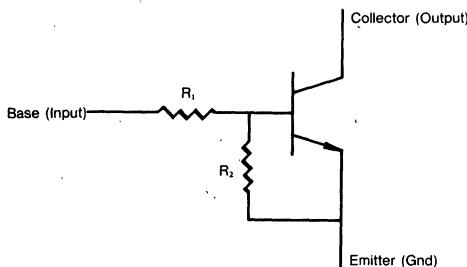


1. Emitter 2. Collector 3. Base

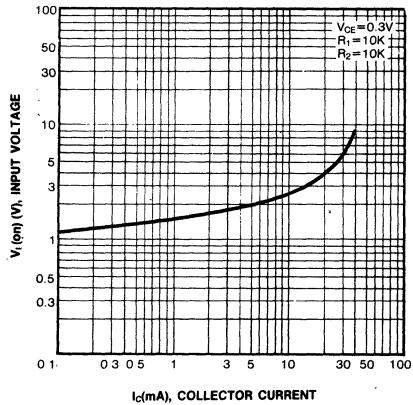
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

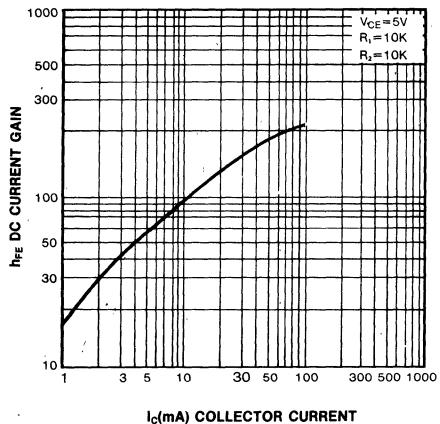
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=10\mu A$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu A$, $I_E=0$	50		0.1	μA
Collector Cutoff Current	I_{CBO}	$V_{CB}=40V$, $I_E=0$			0.3	V
DC Current Gain	h_{FE}	$V_{CE}=5V$, $I_C=5mA$	30		250	MHz
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA$, $I_E=0.5mA$			3.7	pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=5mA$, $I_C=10V$				
Output Capacitance	C_{OB}	$V_{CB}=10V$, $I_E=0$				
Input Off Voltage	$V_{I(off)}$	$f=1.0MHz$				
Input On Voltage	$V_{I(on)}$	$V_{CE}=5V$, $I_C=100\mu A$	0.5		3	V
Input Resistor	R_1	$V_{CE}=0.3V$, $I_C=10mA$		10	13	V
Resistor Ratio	R_1/R_2		7		1.1	$K\Omega$
			0.9			

Equivalent Circuit

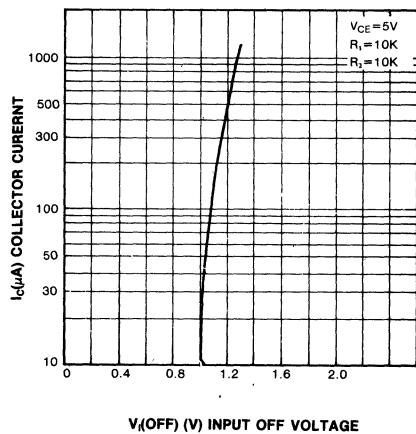
INPUT ON VOLTAGE



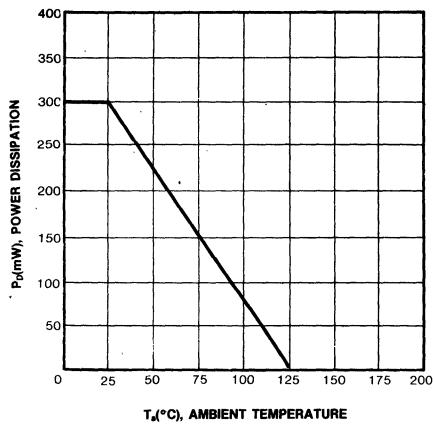
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



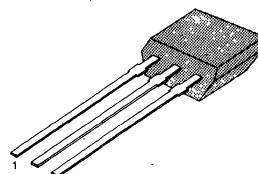
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=22\text{K}\Omega$, $R_2=22\text{K}\Omega$)
- Complement to KSR2203

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92S

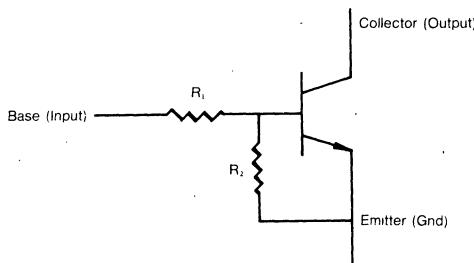


1. Emitter 2. Collector 3. Base

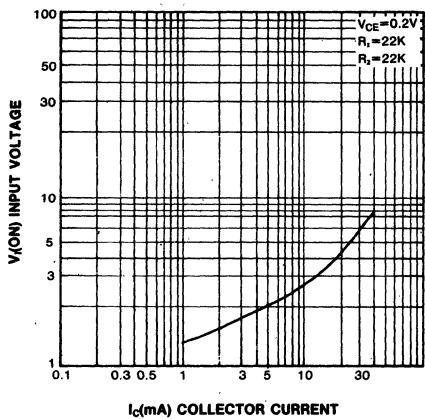
3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

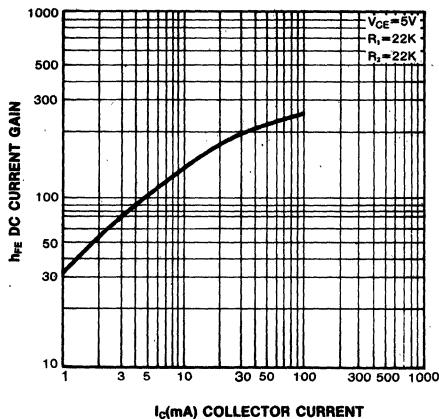
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	56			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=0.5\text{mA}$		250	0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$		3.7		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$				pF
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=0.2\text{V}, I_C=5\text{mA}$			3.0	V
Input Resistor	R_I		15	22	29	$\text{K}\Omega$
Resistor Ratio	R_I/R_2		0.9	1	1.1	

Equivalent Circuit

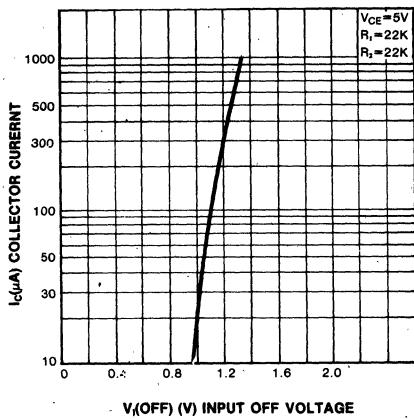
INPUT ON VOLTAGE



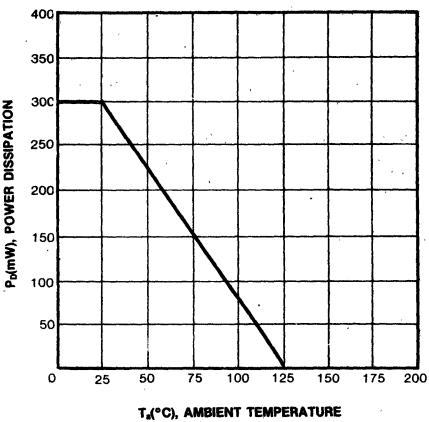
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



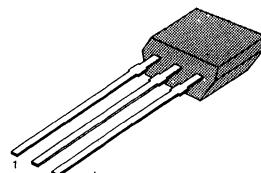
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR2204

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S

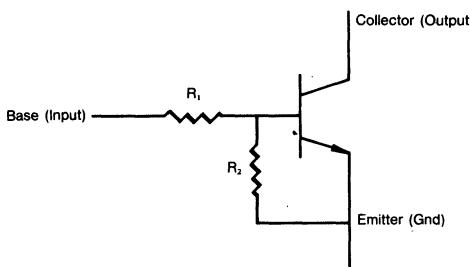


1. Emitter 2. Collector 3. Base

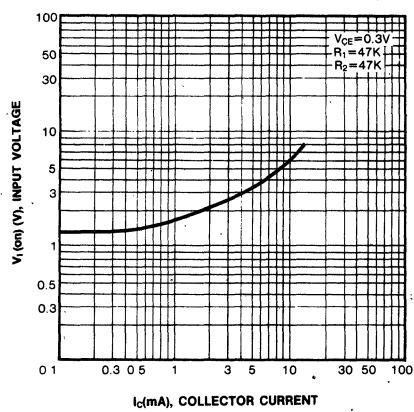
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

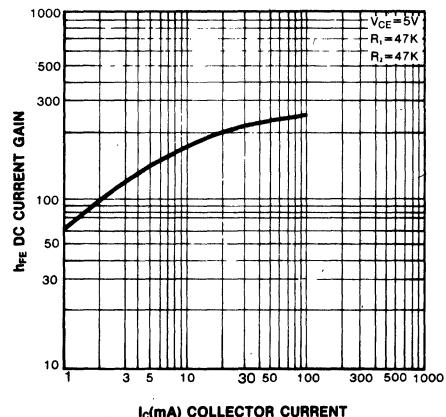
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=10\mu\text{A}$, $I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}$, $I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}$, $I_C=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}$, $I_B=0.5\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}$, $I_C=10\text{V}$		250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}$, $I_E=0$ $f=1.0\text{MHz}$		3.7		pF
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=5\text{V}$, $I_C=100\mu\text{A}$	0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=0.3\text{V}$, $I_C=5\text{mA}$			3	V
Input Resistor	R_1		32	47	62	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit

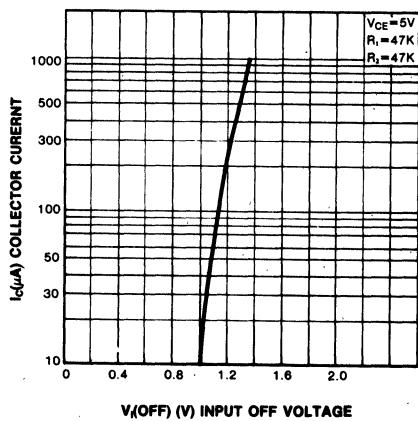
INPUT ON VOLTAGE



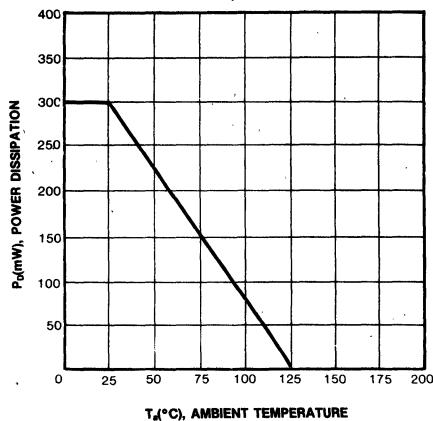
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



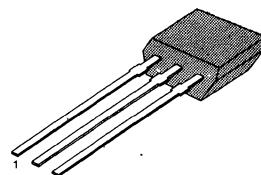
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$, $R_2=10\text{K}\Omega$)
- Complement to KSR2205

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S

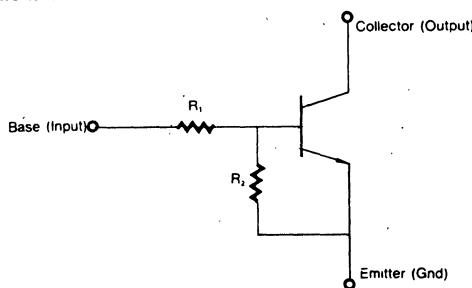


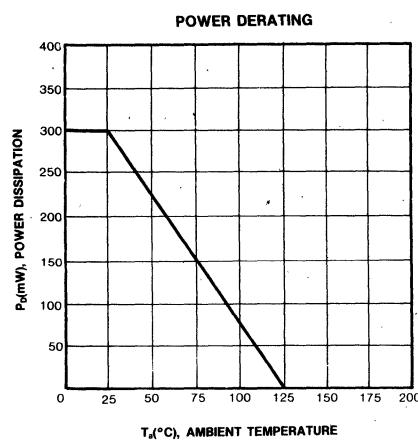
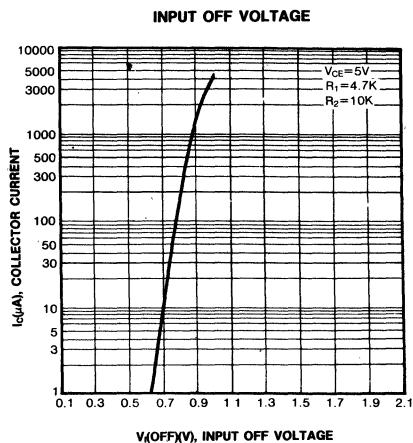
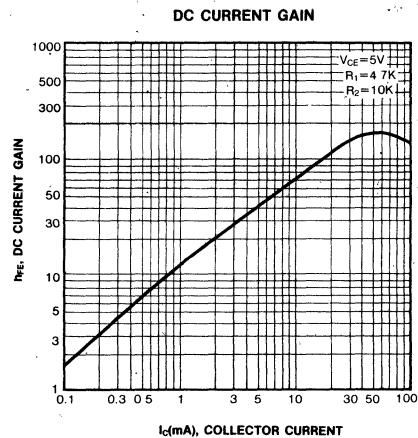
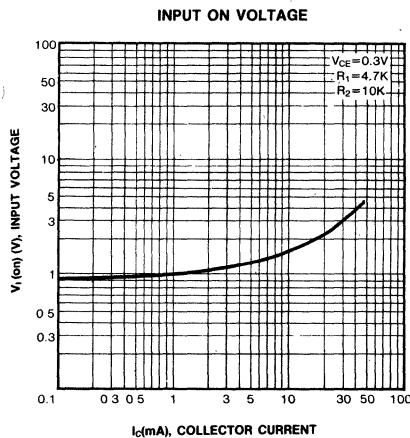
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	30			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=0.5\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$		250		MHz
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.3			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=0.3\text{V}, I_C=20\text{mA}$			2.5	V
Input Resistor	R_I		32	4.7	6.2	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

Equivalent Circuit

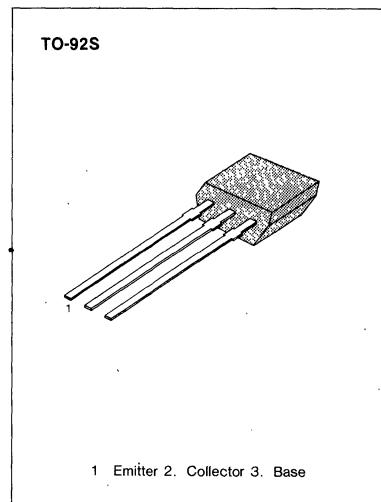


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR2206

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

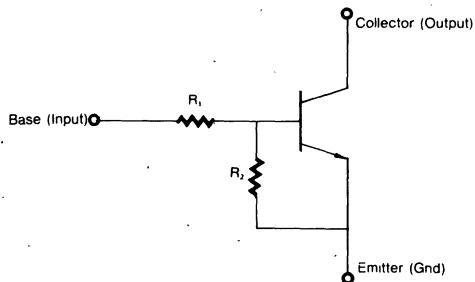
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



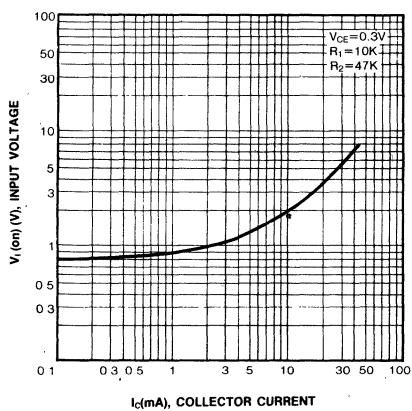
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

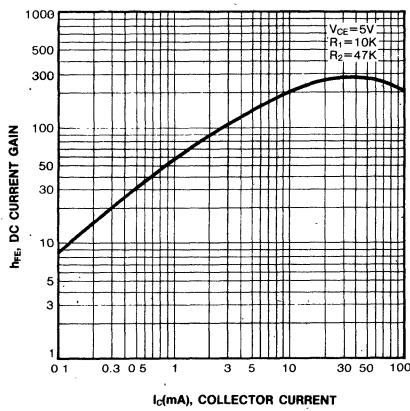
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50		0.1	μA
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$				
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=1.0\text{mA}, I_B=0.5\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$		3.7		pF
Current Gain-Bandwidth Product	f_T	$f=1\text{MHz}$		250		MHz
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=10\text{V}, I_C=5\text{mA}$	0.3			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$			1.4	V
Input Resistor	R_I	$V_{CE}=0.3\text{V}, I_C=1\text{mA}$	7	10	13	K Ω
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

Equivalent Circuit

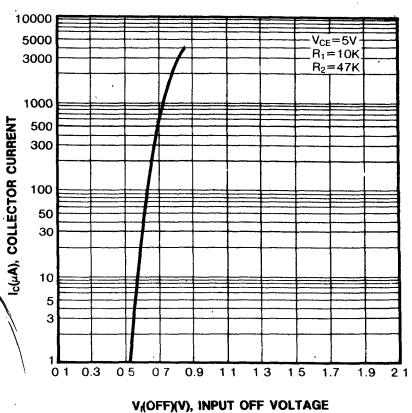
INPUT ON VOLTAGE



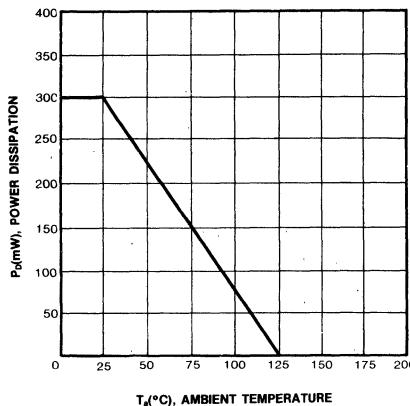
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



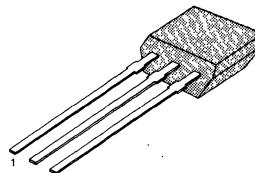
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR2207

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92S

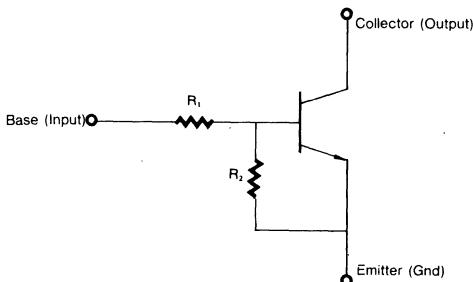


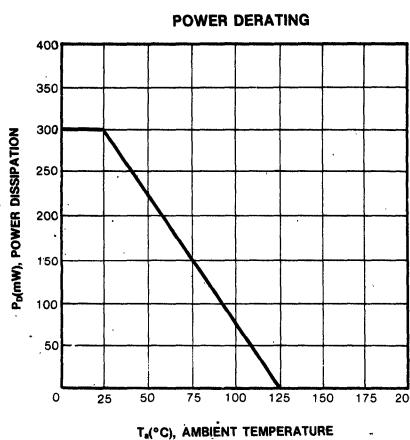
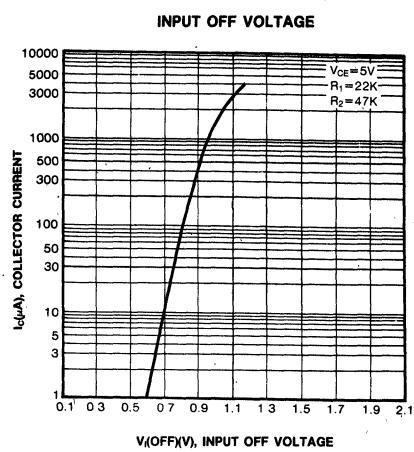
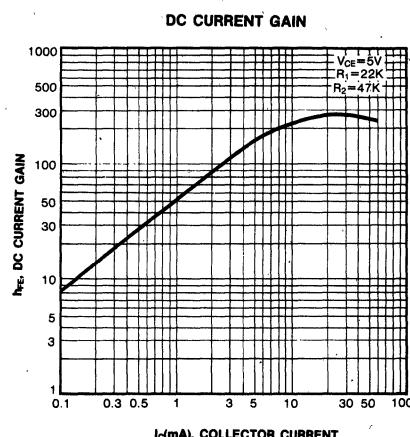
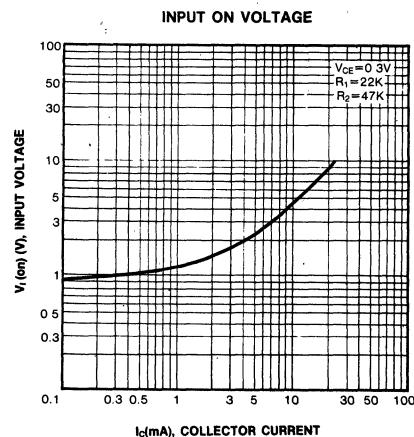
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50			V
Collector Cutoff Current	I_{CEO}	$V_{CB}=40\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=0.5\text{mA}$			0.3	V
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$		250		MHz
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.4			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=0.3\text{V}, I_C=2\text{mA}$			2.5	V
Input Resistor	R_I		15	22	29	$\text{K}\Omega$
Resistor Ratio	R_I/R_2		0.42	0.47	0.52	

Equivalent Circuit



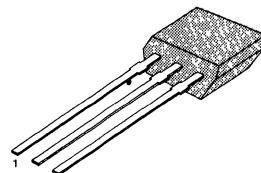
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=22\text{K}\Omega$)
- Complement to KSR2208

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92S

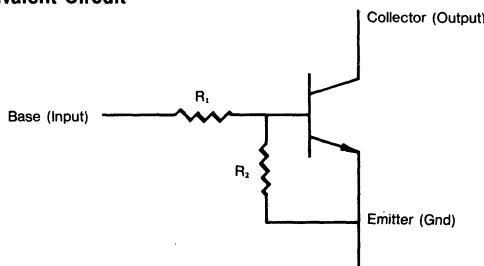


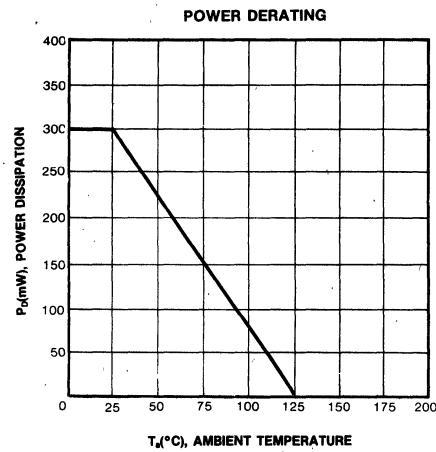
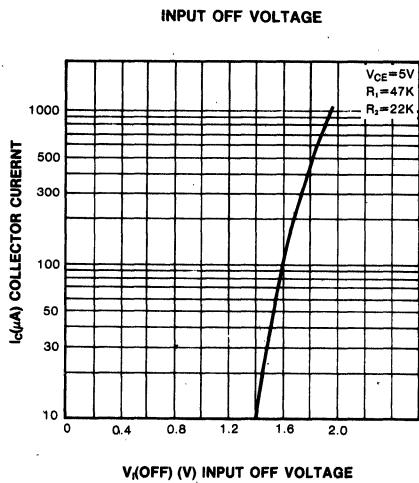
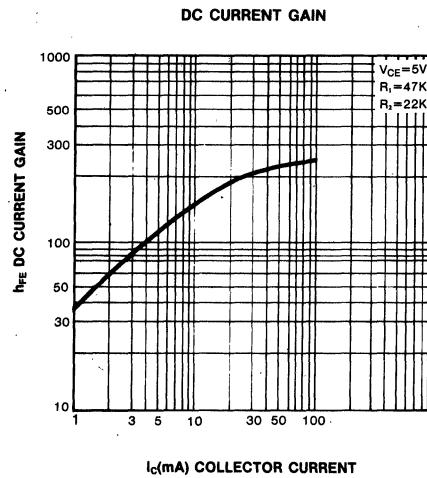
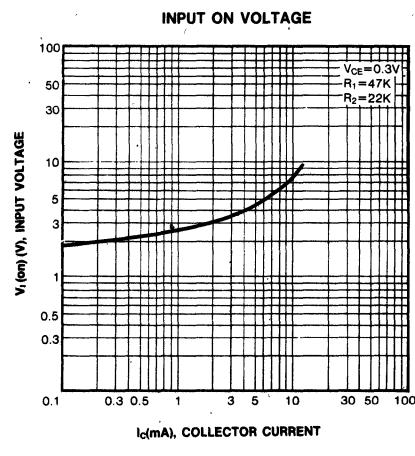
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_B=0$	50		0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$		56		μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=5\text{mA}$			250	0.3
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_E=0.5\text{mA}$			10	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{mA}, I_C=10\text{V}$			2.1	MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$			3.7	pF
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$	0.8			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=0.3\text{V}, I_C=2\text{mA}$			4	V
Input Resistor	R_I		32	47	62	K Ω
Resistor Ratio	R_1/R_2		1.9		2.4	K Ω

Equivalent Circuit



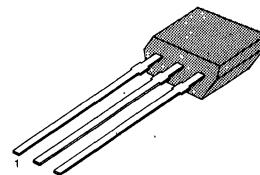
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7\text{K}\Omega$)
- Complement to KSR2209

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S

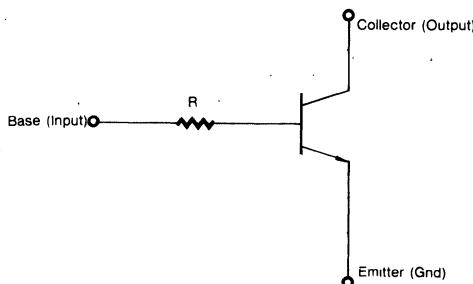


1. Emitter 2. Collector 3. Base

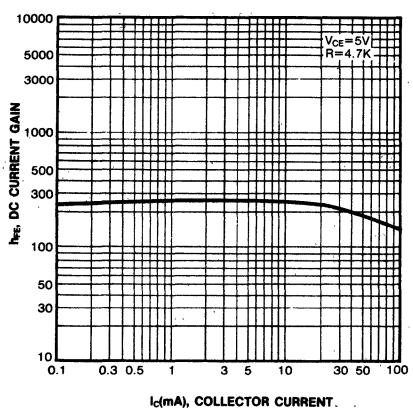
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

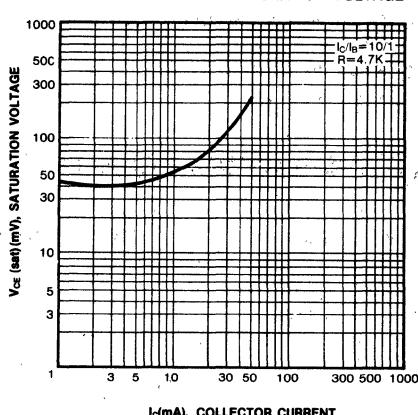
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.70		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$			250	
Input Resistor	R		3.2	4.7	6.2	MHz $\text{K}\Omega$

Equivalent Circuit

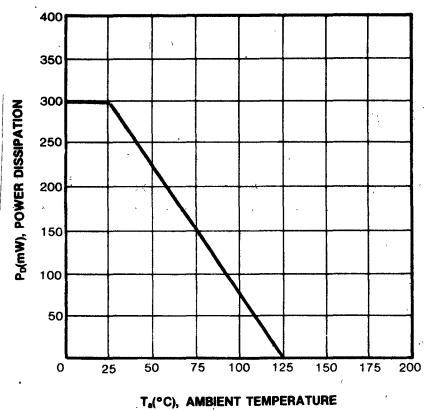
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



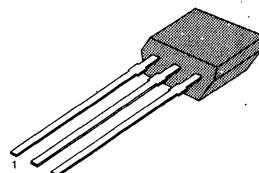
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=10K\Omega$)
- Complement to KSR2210

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55~150	°C

TO-92S

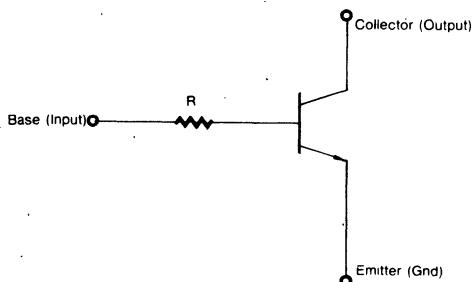


1. Emitter 2. Collector 3. Base

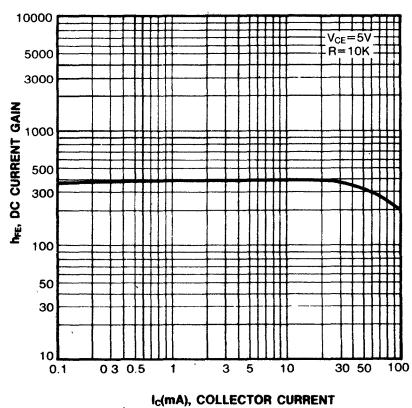
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

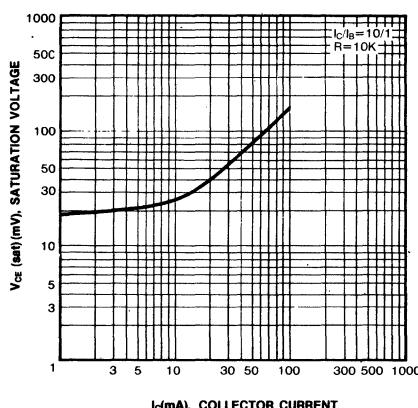
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Emitter-Emitter Breakdown Voltage	BV_{CEO}	$I_E=1mA, I_B=0$	40			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=30V, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5V, I_C=1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=10mA, I_B=1mA$			0.3	V
Output Capacitance	C_{OB}	$V_{CB}=10V, I_E=0$ $f=1MHz$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=5mA$			250	MHz
Input Resistor	R		7	10	13	$K\Omega$

Equivalent Circuit

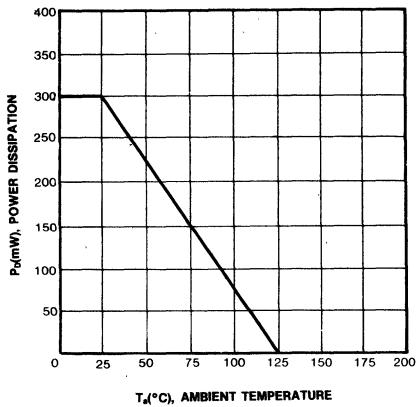
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



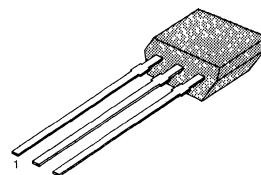
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22\text{K}\Omega$)
- Complement to KSR2211

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S

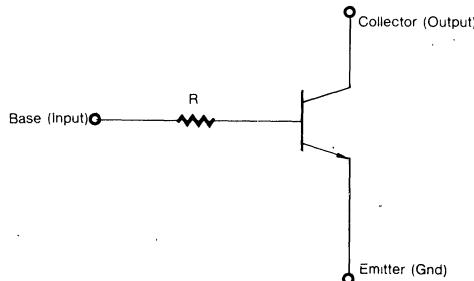


1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_E=0$	40			V
Emitter-Emitter Breakdown Voltage	BV_{CEO}	$I_E=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c=10\text{mA}, I_B=1\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_c=5\text{mA}$			250	MHz
Input Resistor	R		15	22	29	$\text{K}\Omega$

Equivalent Circuit

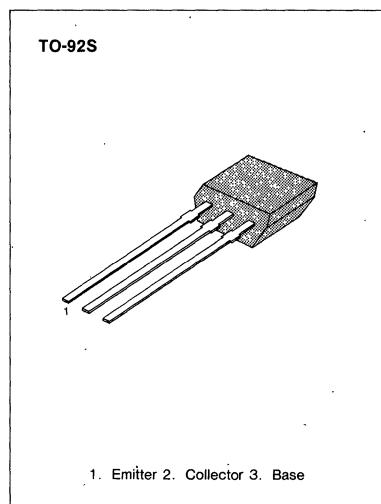
SAMSUNG SEMICONDUCTOR

SWITCHING APPLICATION (Bias Resistor Built In)

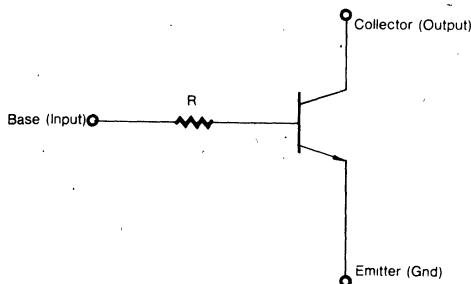
- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=47\text{K}\Omega$)
- Complement to KSR2212

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)**

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_E=0$	40			V
Emitter-Emitter Breakdown Voltage	BV_{CEO}	$I_E=1\text{mA}, I_B=0$	40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$			0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_c=10\text{mA}, I_E=1\text{mA}$			0.3	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		3.7		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_c=5\text{mA}$			250	MHz
Input Resistor	R		32	47	62	$\text{K}\Omega$

Equivalent Circuit

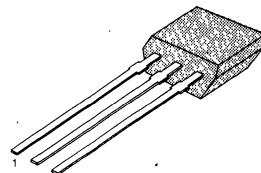
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 2.2\text{K}\Omega$, $R_2 = 47\text{K}\Omega$)
- Complement to KSR2213

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S

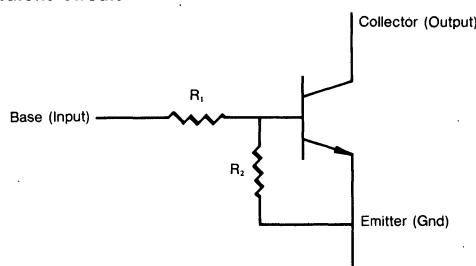


1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C = 10\mu\text{A}, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu\text{A}, I_B = 0$	50		0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40\text{V}, I_E = 0$				μA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_E = 0.5\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{mA}, I_C = 10\text{V}$		250		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1.0\text{MHz}$		3.7		pF
Input Off Voltage	$V_i(\text{off})$	$V_{CE} = 5\text{V}, I_C = 100\mu\text{A}$	0.5			V
Input On Voltage	$V_i(\text{on})$	$V_{CE} = 0.2\text{V}, I_C = 5\text{mA}$			1.1	V
Input Resistor	R_1		1.5	2.2	2.9	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

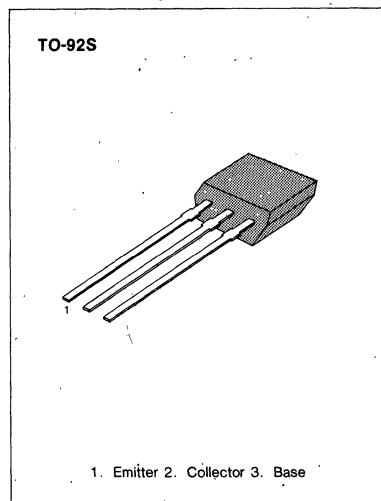
Equivalent Circuit

SWITCHING APPLICATION (Bias Resistor Built In)

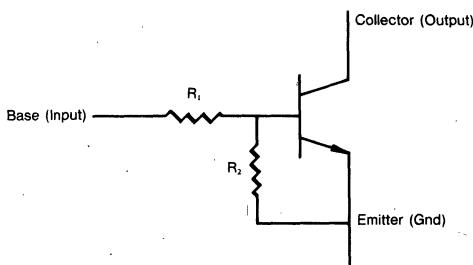
- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7\text{ k}\Omega$, $R_2 = 47\text{ k}\Omega$)
- Complement to KSR2214

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)**

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C = 10\mu\text{A}$, $I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 100\mu\text{A}$, $I_B = 0$	50		0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40\text{V}$, $I_E = 0$	68		0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}$, $I_C = 5\text{mA}$			0.3	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}$, $I_B = 0.5\text{mA}$		250		V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{mA}$, $I_C = 10\text{V}$			0.3	MHz
Output Capacitance	C_{OB}	$V_{CB} = 10\text{V}$, $I_E = 0$		3.7		pF
		$f = 1.0\text{MHz}$				
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE} = 5\text{V}$, $I_C = 100\mu\text{A}$	0.5			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE} = 0.2\text{V}$, $I_C = 5\text{mA}$			1.3	V
Input Resistor	R_I		3.2	4.7	6.2	$\text{k}\Omega$
Resistor Ratio	R_I/R_2		0.09	0.1	0.11	

Equivalent Circuit

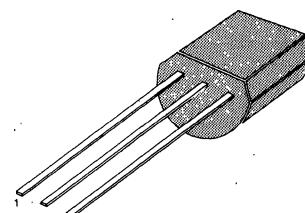
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$, $R_2=4.7\text{K}\Omega$)
- Complement to KSR1001

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_c	-100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

TO-92

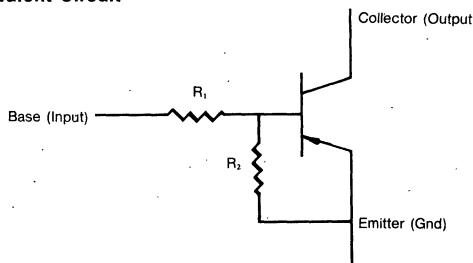


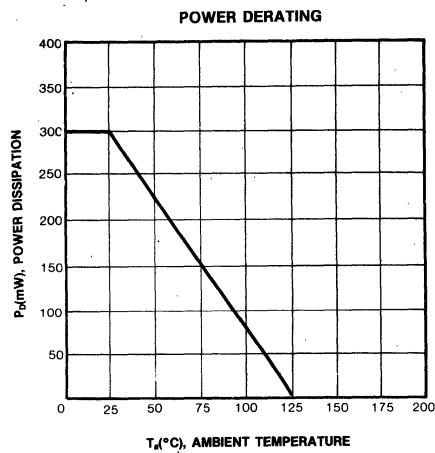
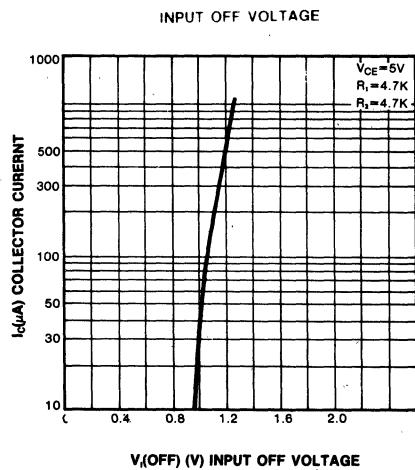
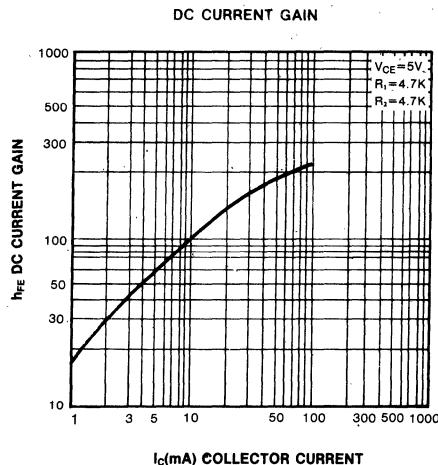
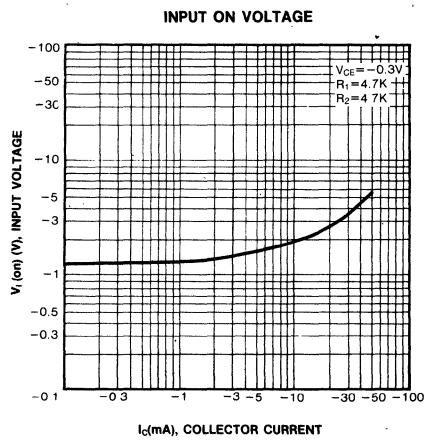
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=-10\mu\text{A}, I_e=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=-100\mu\text{A}, I_b=0$	-50		-0.1	μA
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_e=0$	20			
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_c=-10\text{mA}$				
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c=-10\text{mA}, I_b=-0.5\text{mA}$				
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_c=-10\text{V}$	200		-0.3	V
Output Capacitance	C_{ob}	$V_{CE}=-10\text{V}, I_e=0$ $f=1.0\text{MHz}$	5.5			MHz
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=-5\text{V}, I_c=-100\mu\text{A}$	-0.5			pF
Input On Voltage	$V_i(\text{on})$	$V_{CE}=-0.3\text{V}, I_c=-20\text{mA}$	3.2	4.7	6.2	V
Input Resistor	R_1		0.9	1	1.1	$\text{K}\Omega$
Resistor Ratio	R_1/R_2					

Equivalent Circuit



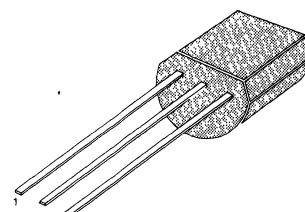
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=10\text{K}\Omega$, $R_2=10\text{K}\Omega$)
- Complement to KSR1002

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

TO-92

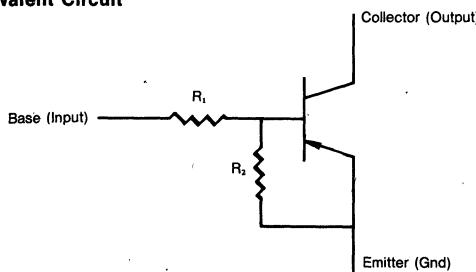


1. Emitter 2. Base 3. Collector

3

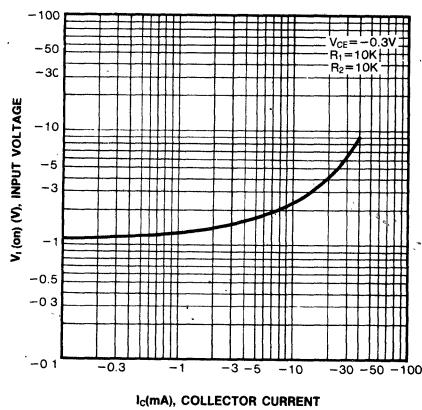
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	30			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$		200		MHz
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$		5.5		pF
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=-0.3\text{V}, I_C=-10\text{mA}$			-3	V
Input Resistor	R_I		7	10	13	$\text{K}\Omega$
Resistor Ratio	R_I/R_2		0.9	1	1.1	

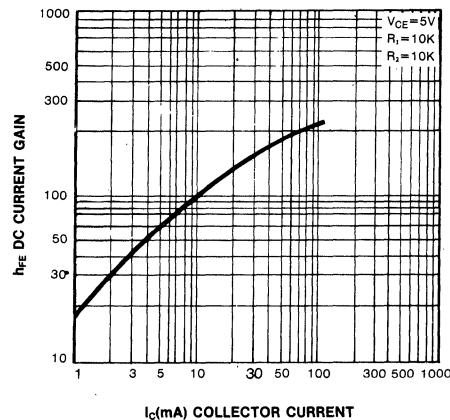
Equivalent Circuit

SAMSUNG SEMICONDUCTOR

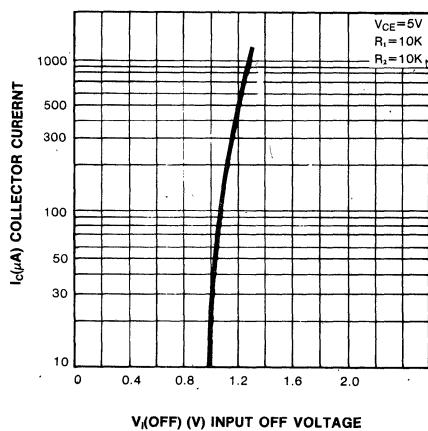
INPUT ON VOLTAGE



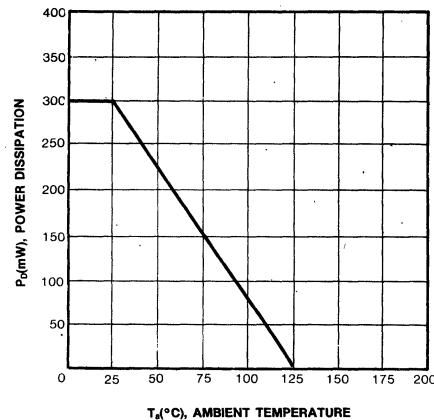
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



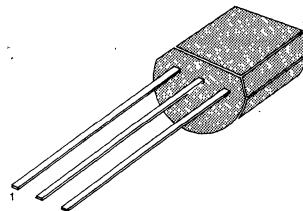
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=22\text{ k}\Omega$, $R_2=22\text{ k}\Omega$)
- Complement to KSR1003

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92

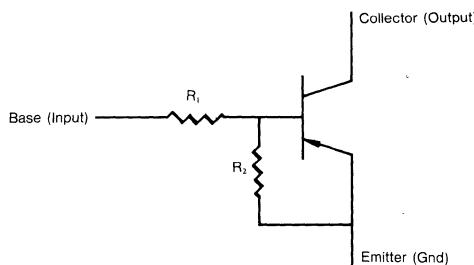


1. Emitter 2. Collector 3. Base

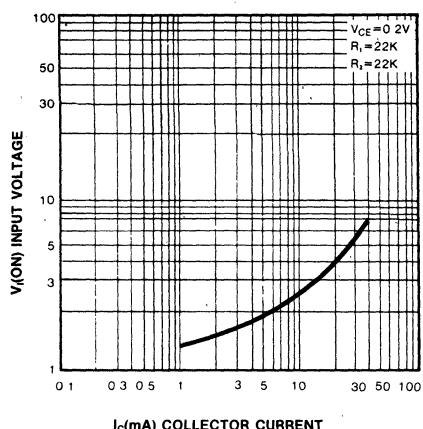
3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

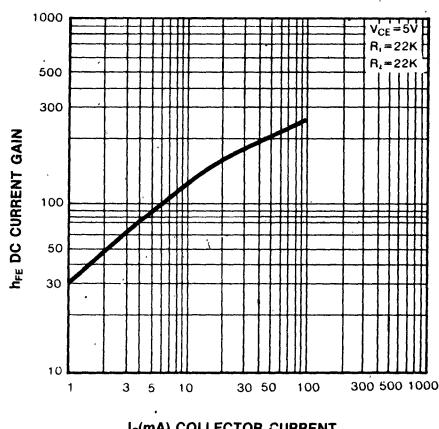
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50		-0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$				μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	56		-0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$		200		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$		5.5		pF
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$				
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=-0.2\text{V}, I_C=-5\text{mA}$			-3.0	V
Input Resistor	R_i		15	22	29	$\text{k}\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit

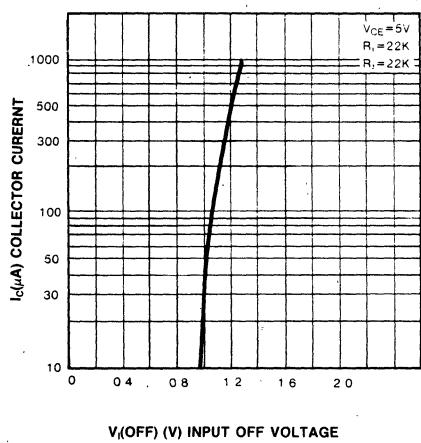
INPUT ON VOLTAGE



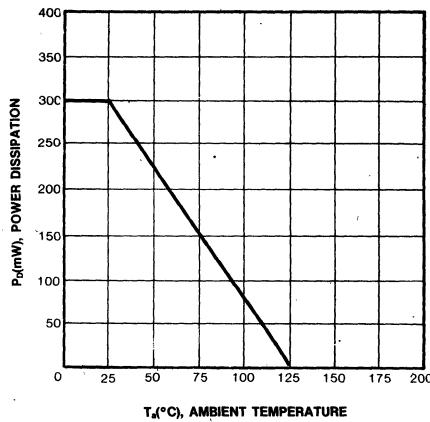
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



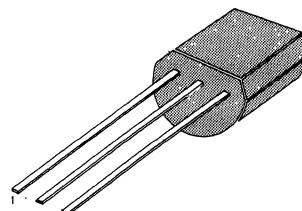
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR1004

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55~150	°C

TO-92

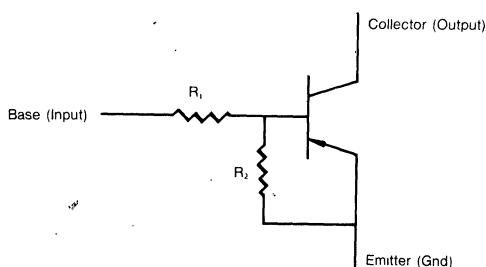


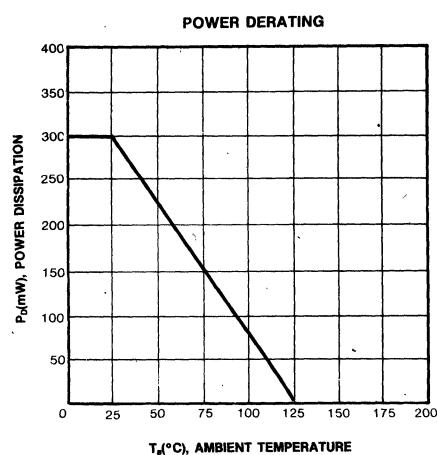
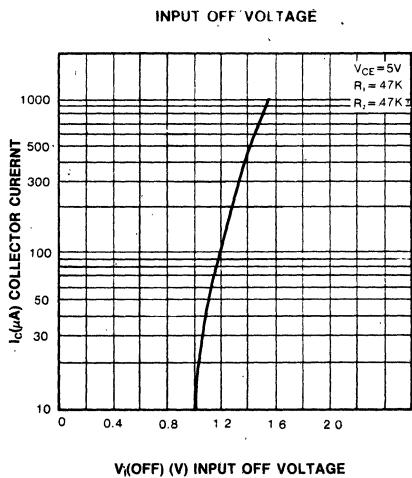
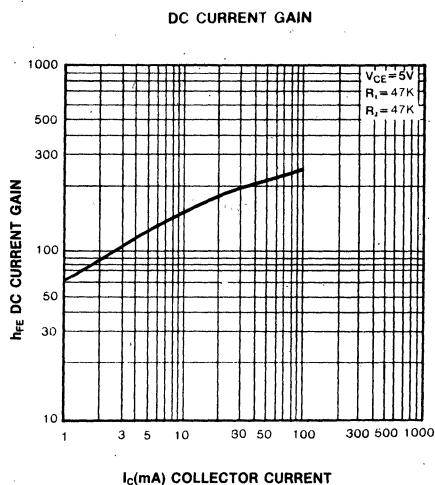
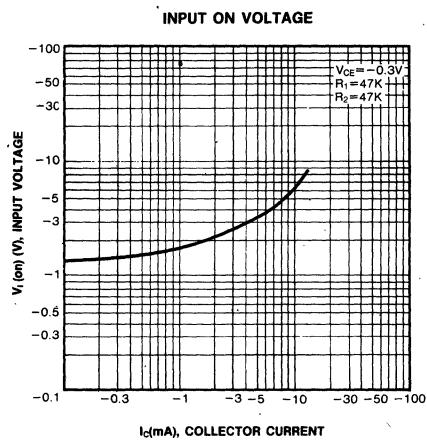
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$		200		MHz
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$		5.5		pF
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=-0.3\text{V}, I_C=-10\text{mA}$			-3	V
Input Resistor	R_I		32	47	62	KΩ
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit



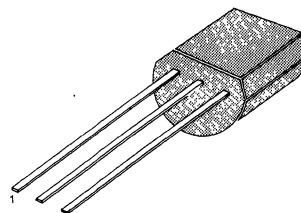
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$, $R_2=10\text{K}\Omega$)
- Complement to KSR1005

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92

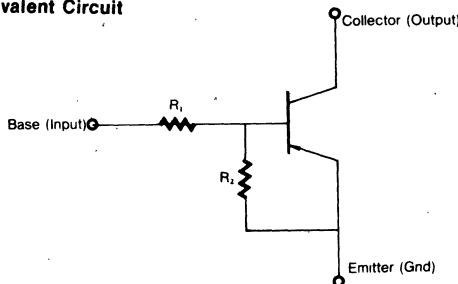


1. Emitter 2. Collector 3. Base

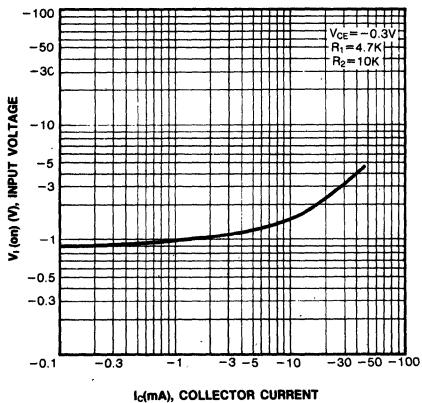
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

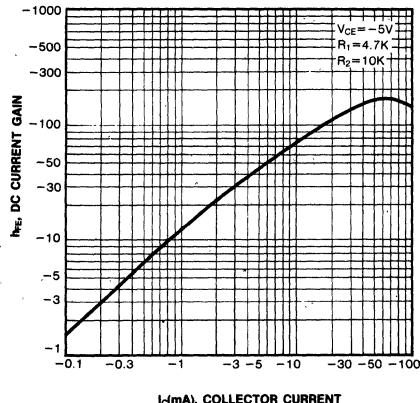
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_E=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	30			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10\text{mA}, I_E=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	C_{ob}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$		200		MHz
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.3			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=-0.3\text{V}, I_C=-20\text{mA}$			-2.5	V
Input Resistor	R_1		3.2	4.7	6.2	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

Equivalent Circuit

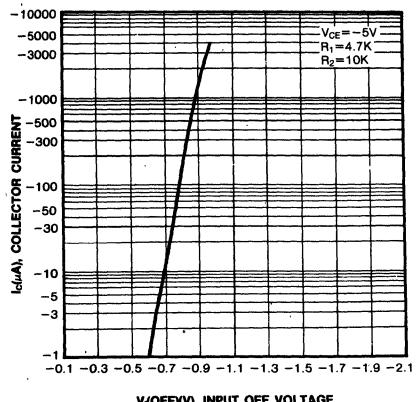
INPUT ON VOLTAGE



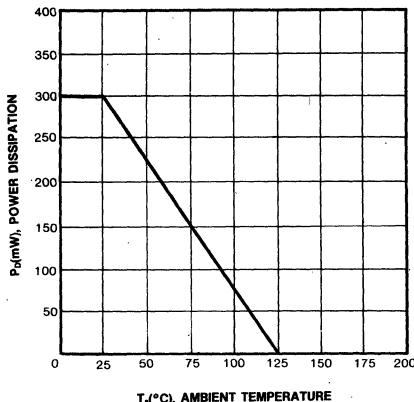
DC CURRENT GAIN

 I_C (mA), COLLECTOR CURRENT

INPUT OFF VOLTAGE

 $V_{I(OFF)}$ (mV), INPUT OFF VOLTAGE I_C (mA), COLLECTOR CURRENT

POWER DERATING

 T_A (°C), AMBIENT TEMPERATURE

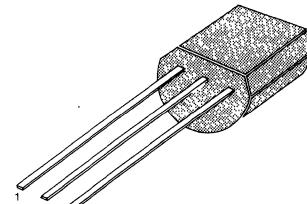
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR1006

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

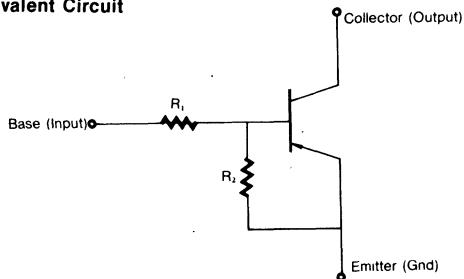
TO-92



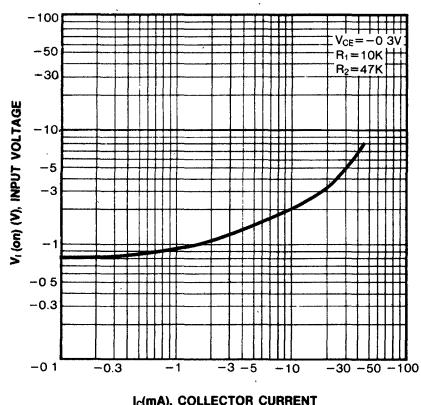
1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

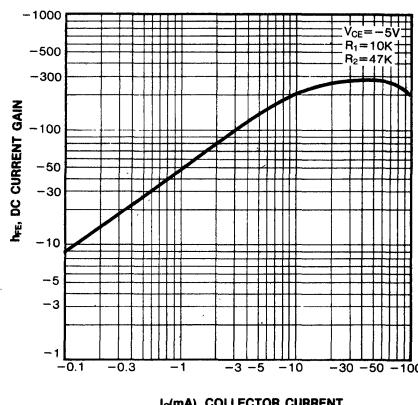
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50		-0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$		68		μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$			-0.3	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$				V
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$	-0.3	200		MHz
Input Off Voltage	$V_I(\text{off})$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$			-1.4	V
Input On Voltage	$V_I(\text{on})$	$V_{CE}=-0.3\text{V}, I_C=-1\text{mA}$				V
Input Resistor	R_1		7	10	13	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

Equivalent Circuit

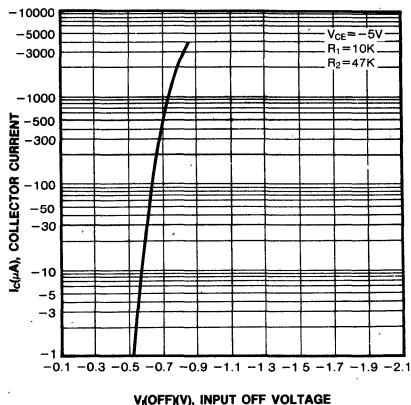
INPUT ON VOLTAGE



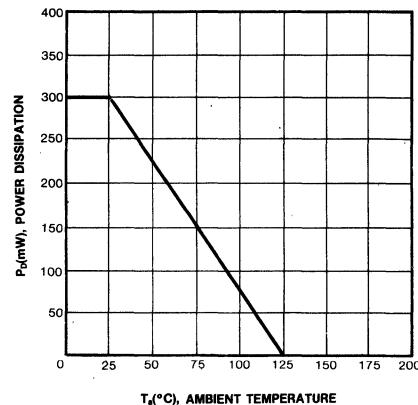
DC CURRENT GAIN

I_C(mA), COLLECTOR CURRENT

INPUT OFF VOLTAGE

V_{I(OFF)}(V), INPUT OFF VOLTAGEI_C(mA), COLLECTOR CURRENT

POWER DERATING

T_A(°C), AMBIENT TEMPERATURE

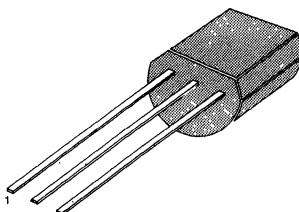
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$ $R_2=47K\Omega$)
- Complement to KSR1007

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$

TO-92

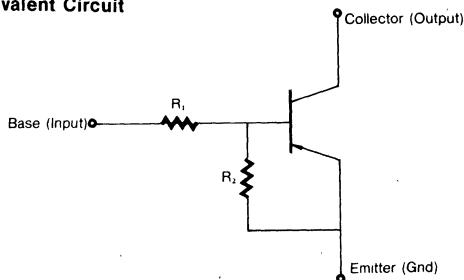


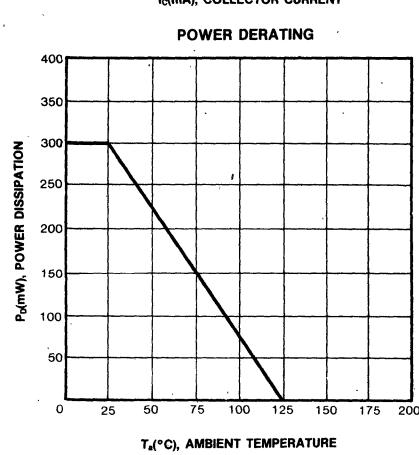
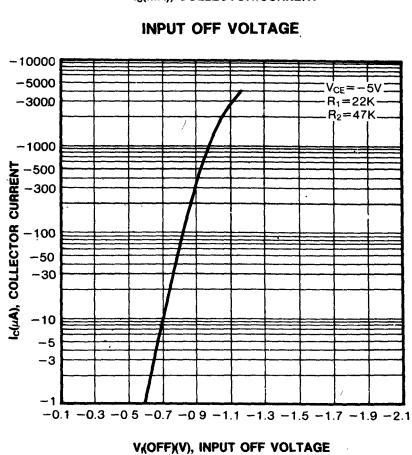
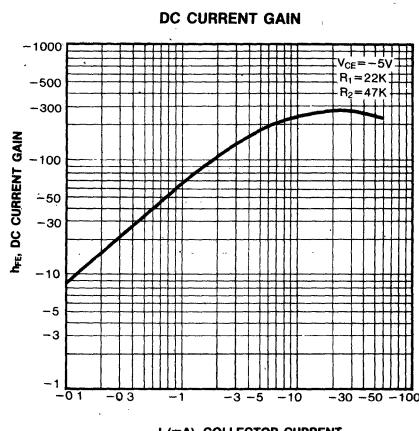
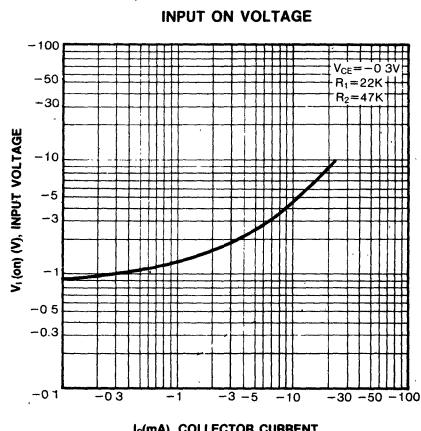
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_B=0$	-50		-0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$		68		μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$			-0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$				pF
Current Gain-Bandwidth Product	C_{OB}	$V_{CB}=-10V, I_E=0$ $f=1MHz$		5.5		
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10V, I_C=-5mA$		200		MHz
Input Off Voltage	$V_{I(off)}$	$V_{CE}=-5V, I_C=-100\mu A$	-0.4		-2.5	V
Input On Voltage	$V_{I(on)}$	$V_{CE}=-0.3V, I_C=-2mA$			22	V
Input Resistor	R_1		15	22	29	$K\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

Equivalent Circuit



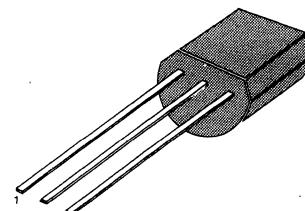
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=22\text{K}\Omega$)
- Complement to KSR1008

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92

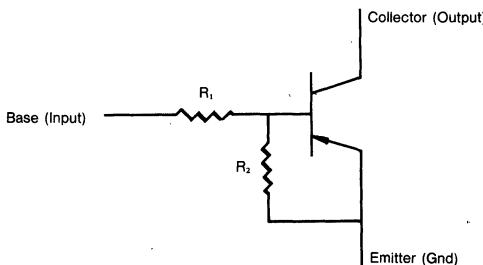


1. Emitter 2. Collector 3. Base

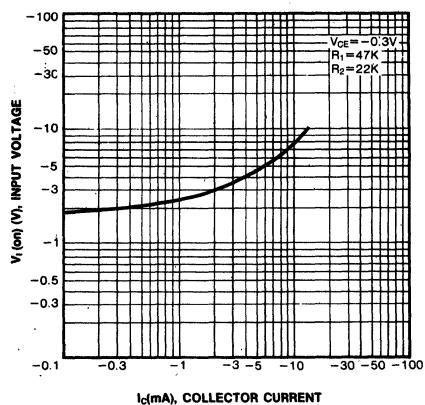
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

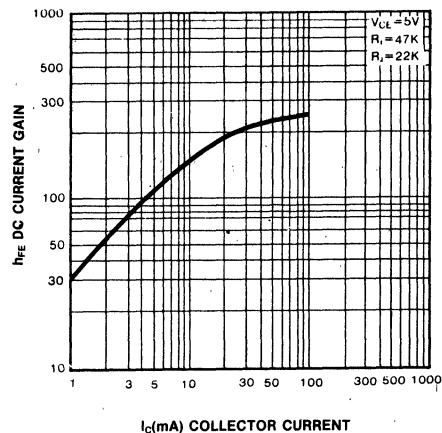
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50		-0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$	56			μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$		200	-0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$		5.5		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$				pF
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$				
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.8			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=-0.3\text{V}, I_C=-2\text{mA}$	32	47	-4	V
Input Resistor	R_1				62	K Ω
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

Equivalent Circuit

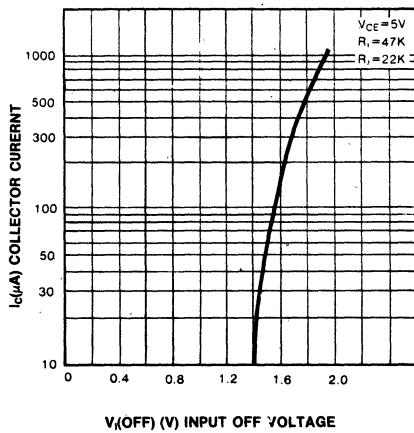
INPUT ON VOLTAGE



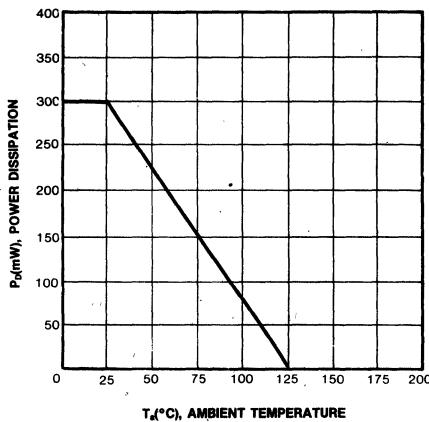
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



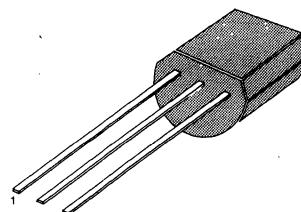
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7\text{K}\Omega$)
- Complement to KSR1009

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92

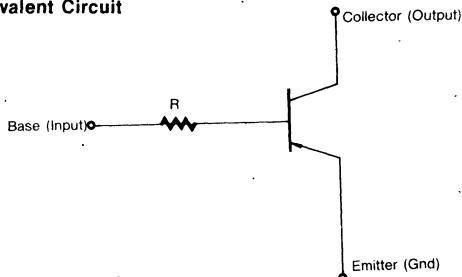


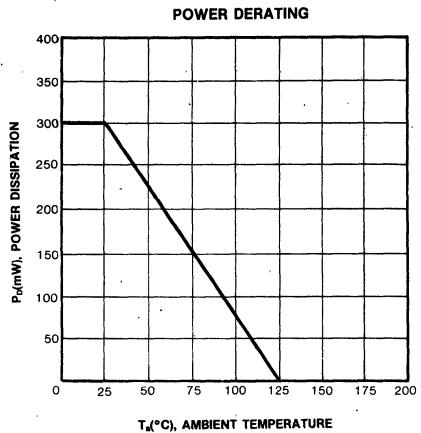
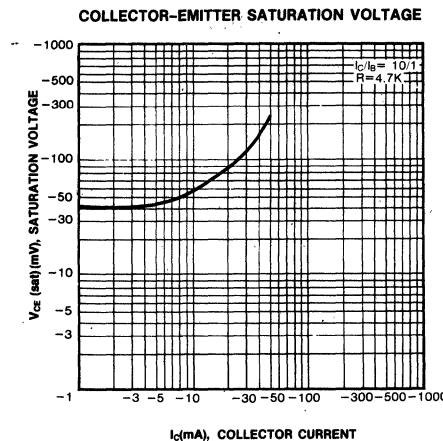
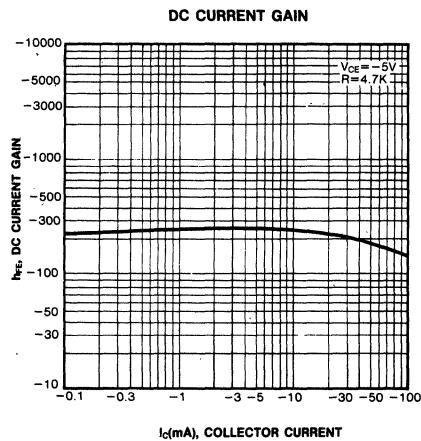
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-1\text{mA}, I_E=0$	-40		-0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30\text{V}, I_E=0$		100	600	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-1\text{mA}$			-0.3	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_E=-1\text{mA}$				V
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$			200	MHz
Input Resistor	R_I		3.2	4.7	6.2	$\text{K}\Omega$

Equivalent Circuit

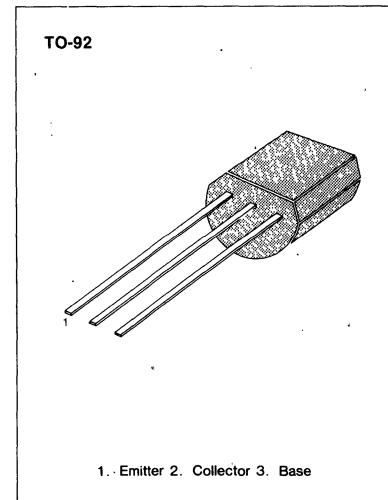


SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
- Driver circuit
- Built in bias Resistor ($R=10K$)
- Complement to KSR1010

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

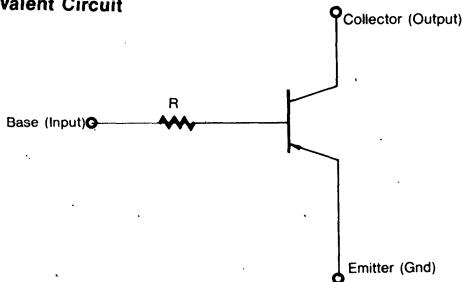
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55~150	°C

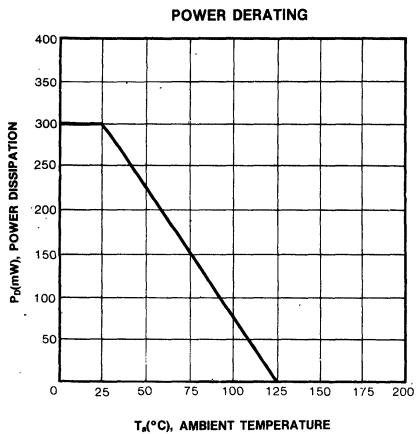
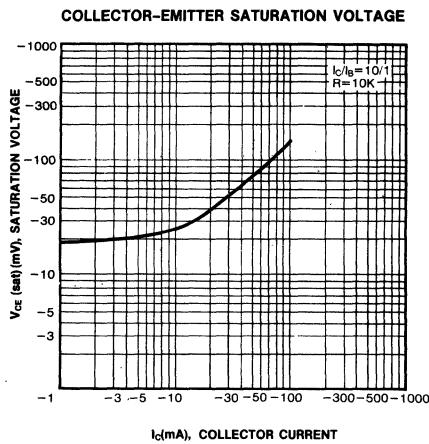
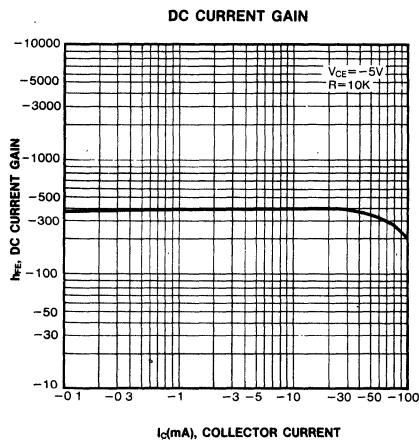


3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E = -1mA, I_B = 0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -30V, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5V, I_C = -1mA$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -10mA, I_B = -1mA$		5.5	0.3	V
Output Capacitance	C_{OB}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$				pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -5mA$	7	200		MHz
Input Resistor	R			10	13	$K\Omega$

Equivalent Circuit

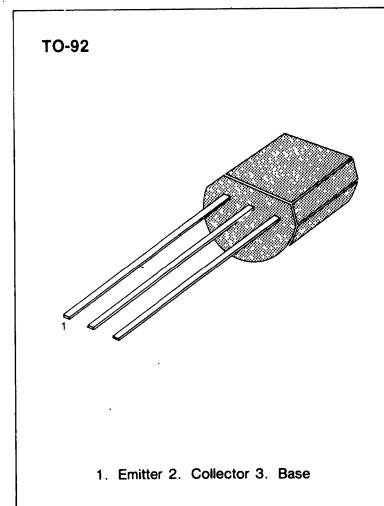


SWITCHING APPLICATION (Bias Resistor Built In)

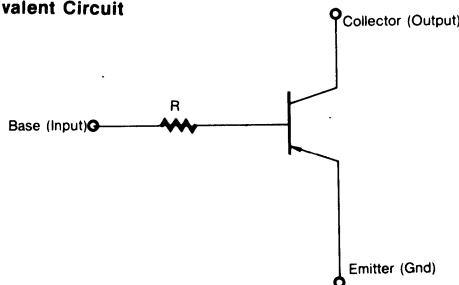
- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22\text{ k}\Omega$)
- Complement to KSR1011

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

**ELECTRICAL CHARACTERISTICS** ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E=-1\text{ mA}, I_B=0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30\text{ V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{ V}, I_C=-1\text{ mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{ mA}, I_B=-1\text{ mA}$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB}=-10\text{ V}, I_E=0$ $f=1\text{ MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{ V}, I_C=-5\text{ mA}$	15	200		MHz
Input Resistor	R			22	29	$\text{k}\Omega$

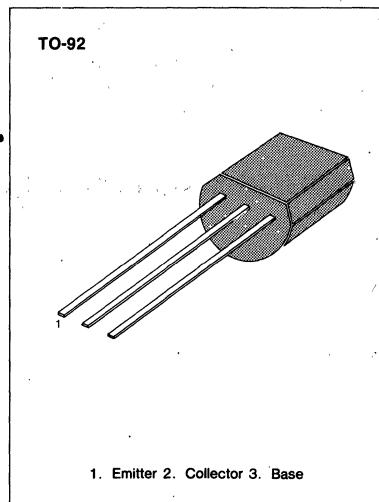
Equivalent Circuit

SWITCHING APPLICATION (Bias Resistor Built In)

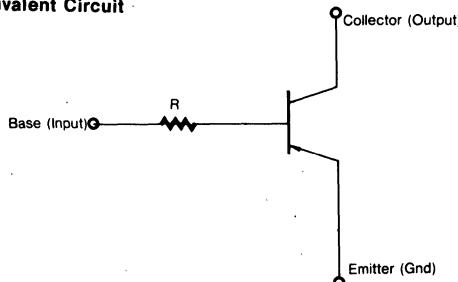
- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=47\text{K}\Omega$)
- Complement to KSR1012

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_c	-100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS** ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=-100\mu\text{A}, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=-1\text{mA}, I_B=0$	-40			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=-30\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_c=-1\text{mA}$	100		600	μA
Collector Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c=-10\text{mA}, I_B=-1\text{mA}$			-0.3	V
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_c=-5\text{mA},$		200		MHz
Input Resistor	R		32	47	62	$\text{k}\Omega$

Equivalent Circuit

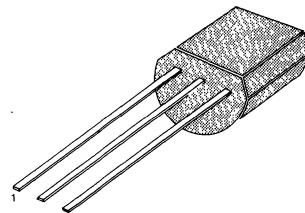
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=2.2\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR1013

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

TO-92

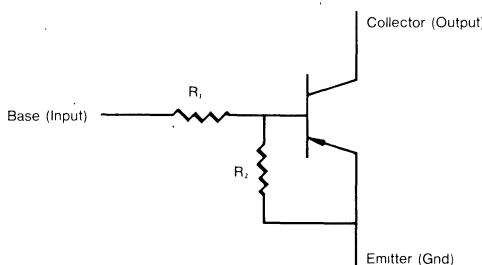


1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50		-0.1	μA
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$		68		
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$			-0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$		200		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$		5.5		pF
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$				
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=-0.2\text{V}, I_C=-10\text{mA}$		1.5	-1.1	V
Input Resistor	R_1			2.2	2.9	K Ω
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

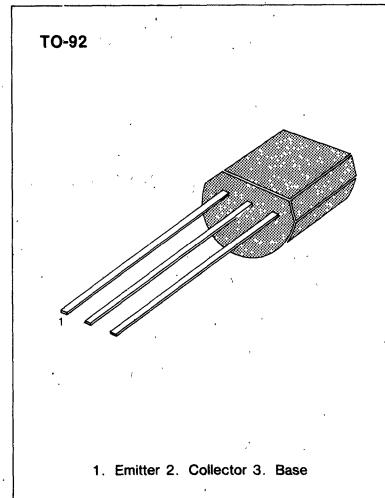
Equivalent Circuit

SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7\text{ k}\Omega$, $R_2 = 47\text{ k}\Omega$)
- Complement to KSR1014

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

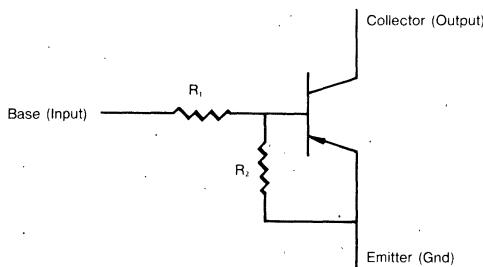
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu\text{A}, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu\text{A}, I_B = 0$	-50		-0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40\text{V}, I_E = 0$		68		μA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_C = -5\text{mA}$			-0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -10\text{mA}, I_B = -0.5\text{mA}$		200		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{mA}, I_C = -10\text{V}$		5.5		pF
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1.0\text{MHz}$				
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE} = -5\text{V}, I_C = -100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE} = -0.2\text{V}, I_C = -5\text{mA}$			-1.3	V
Input Resistor	R_1		3.2	4.7	6.2	$\text{k}\Omega$
Resistor Ratio	R_1/R_2		0.09	0.1	0.11	

Equivalent Circuit

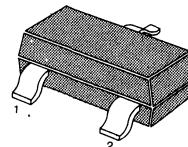
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
- Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$, $R_2=4.7\text{K}\Omega$)
- Complement to KSR1101

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

SOT-23

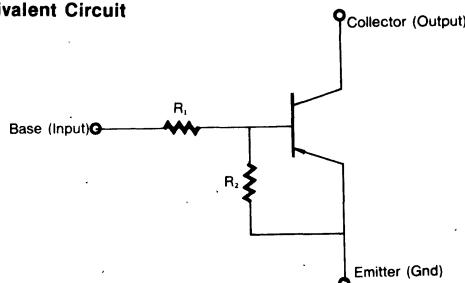
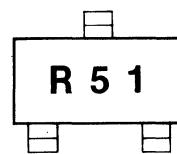


1. Base 2. Emitter 3. Collector

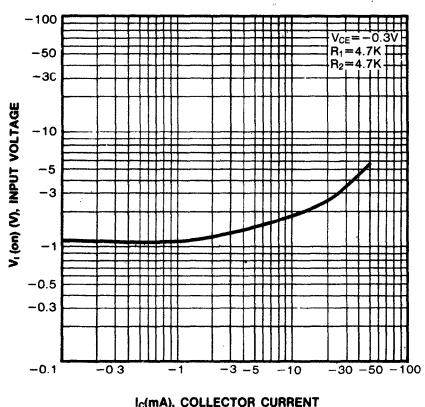
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

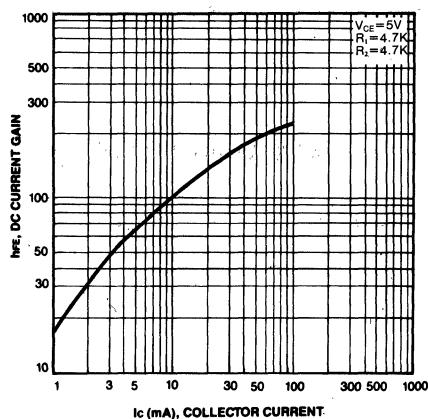
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50		-0.1	V
Collector Cutoff Current	I_{CB0}	$V_{CB}=-40\text{V}, I_E=0$	30			μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-10\text{mA}$				
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$	200			MHz
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$	5.5			pF
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=-0.3\text{V}, I_C=-20\text{mA}$	3.2	4.7	6.2	V
Input Resistor	R_1		0.9	1	1.1	$\text{K}\Omega$
Resistor Ratio	R_1/R_2					

Equivalent Circuit**Marking**

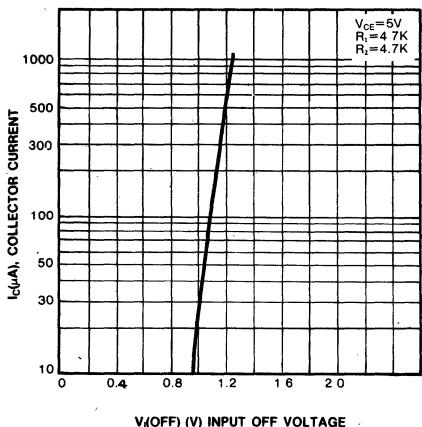
INPUT ON VOLTAGE



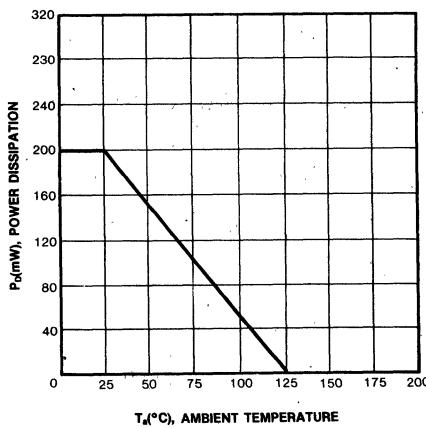
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



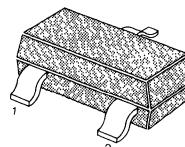
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10\text{K}\Omega$, $R_2=10\text{K}\Omega$)
- Complement to KSR1102

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

SOT-23

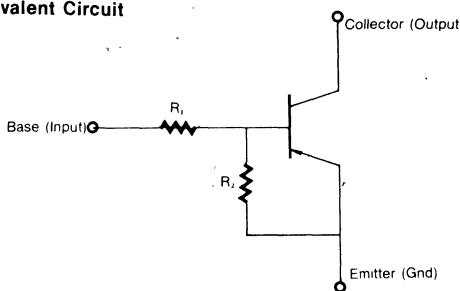
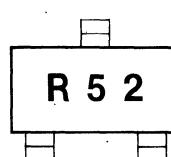


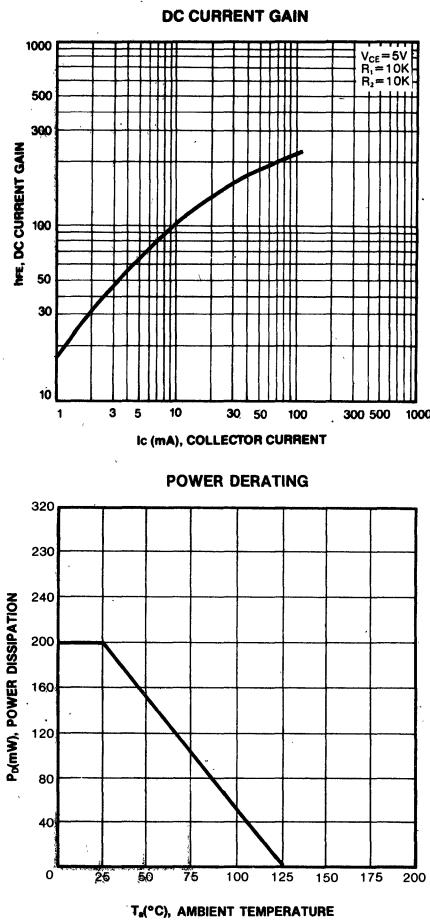
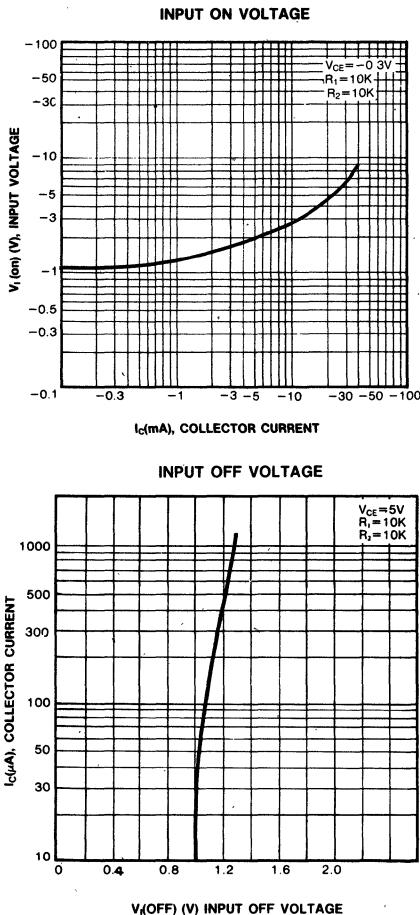
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	30			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$		200	-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$		5.5		MHz
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$				pF
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=-0.3\text{V}, I_C=-10\text{mA}$			-3	V
Input Resistor	R_1		7	10	13	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit**Marking**



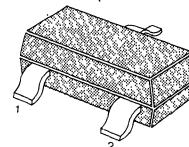
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22\text{K}\Omega$, $R_2=22\text{K}\Omega$)
- Complement to KSR1103

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

SOT-23

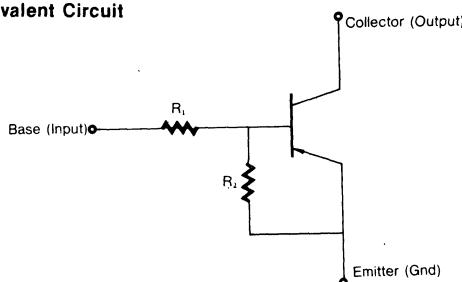
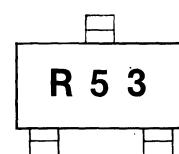


1. Base 2. Emitter 3. Collector

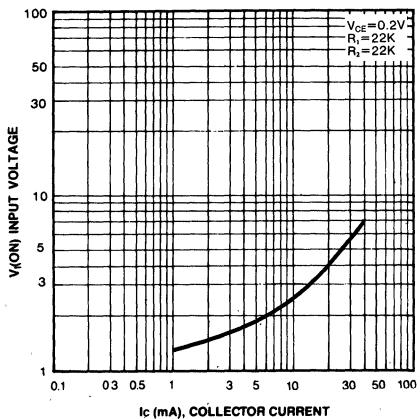
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

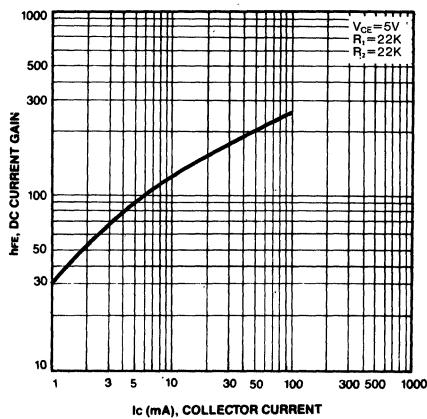
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50		-0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$				μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	56		-0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$		200		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$		5.5		pF
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$	-0.5		-3.0	V
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$				V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=-0.2\text{V}, I_C=-5\text{mA}$	15	22	29	V
Input Resistor	R_I		0.9	1	1.1	$\text{K}\Omega$
Resistor Ratio	R_1/R_2					

Equivalent Circuit**Marking**

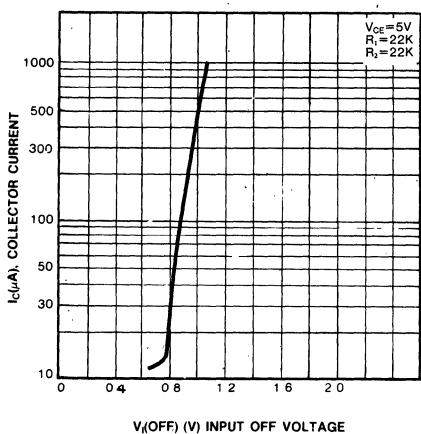
INPUT ON VOLTAGE



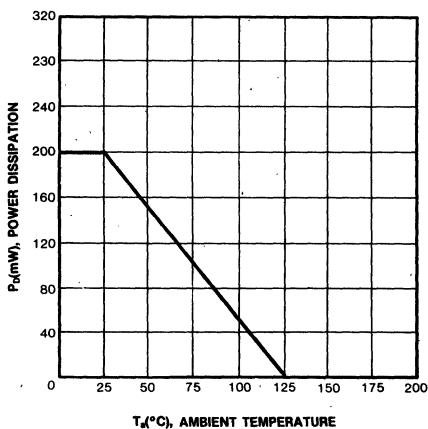
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



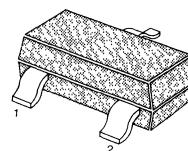
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR1104

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

SOT-23

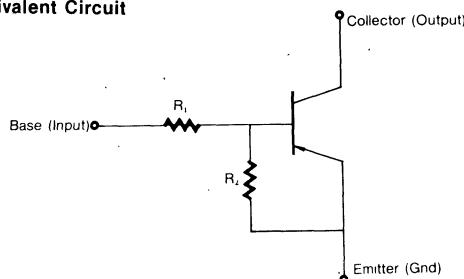
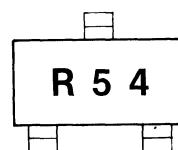


1. Base 2. Emitter 3. Collector

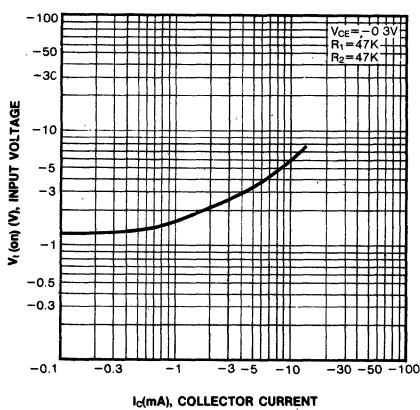
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

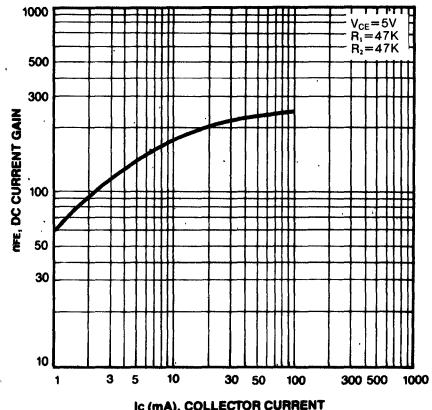
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50		-0.1	V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$		68		μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$			-0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$		200		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$		5.5		pF
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}, I_E=0$				
Input Off Voltage	$V_{i(\text{off})}$	$f=1.0\text{MHz}$				
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.5			V
Input Resistor	R_1	$V_{CE}=-0.3\text{V}, I_C=-10\text{mA}$	32	47	-3	V
Resistor Ratio	R_1/R_2		0.9	1	62	K Ω

Equivalent Circuit**Marking**

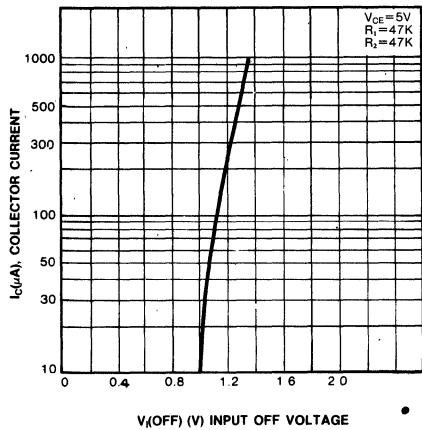
INPUT ON VOLTAGE



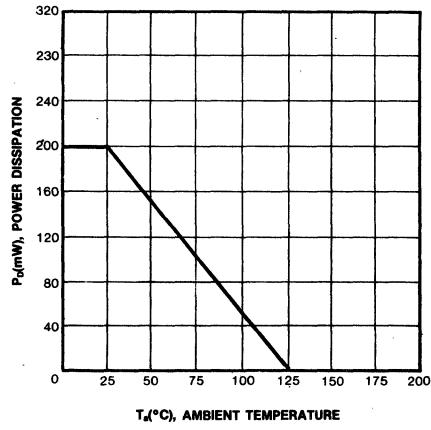
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



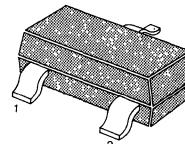
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$, $R_2=10\text{K}\Omega$)
- Complement to KSR1105

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

SOT-23

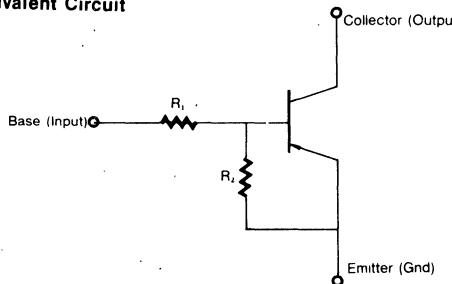
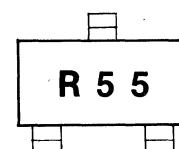


1. Base 2. Emitter 3. Collector

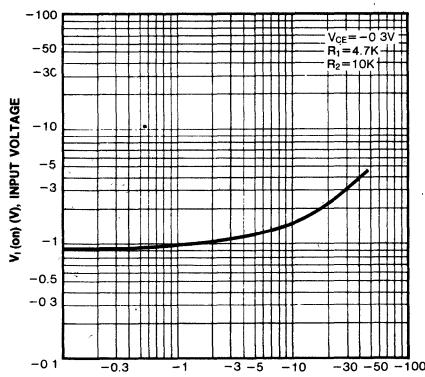
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

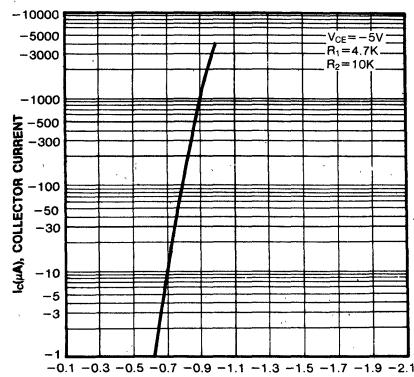
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	30			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$		200		MHz
Input Off Voltage	$V_I(\text{off})$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.3			V
Input On Voltage	$V_I(\text{on})$	$V_{CE}=-0.3\text{V}, I_C=-20\text{mA}$			-2.5	V
Input Resistor	R_I		3.2	4.7	6.2	K Ω
Resistor Ratio	R_I/R_2		0.42	0.47	0.52	

Equivalent Circuit**Marking**

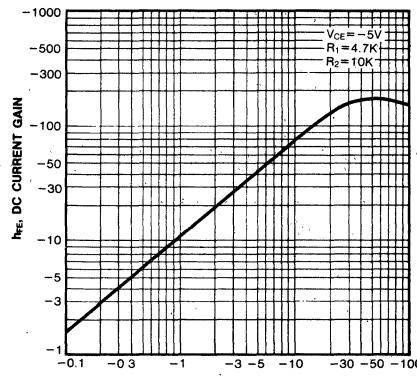
INPUT ON VOLTAGE

 I_C (mA), COLLECTOR CURRENT

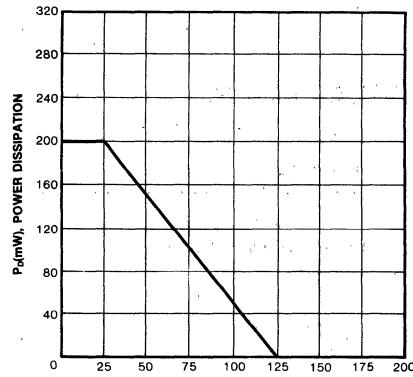
INPUT OFF VOLTAGE

 $V_{I(OFF)}$ (V), INPUT OFF VOLTAGE

DC CURRENT GAIN

 I_C (mA), COLLECTOR CURRENT

POWER DERATING

 T_A (°C), AMBIENT TEMPERATURE

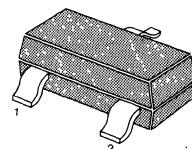
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=10\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR1106

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

SOT-23

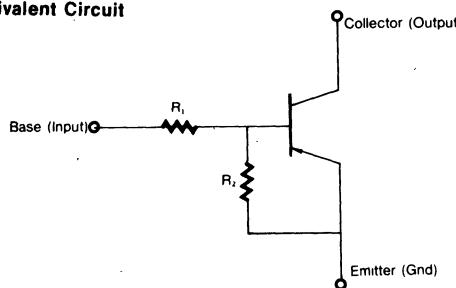
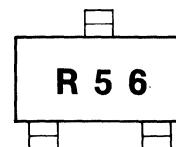


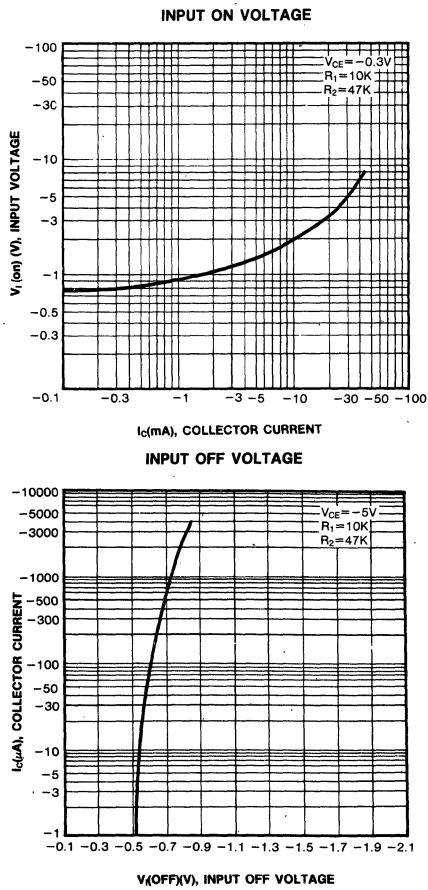
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$		200		MHz
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.3			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=-0.3\text{V}, I_C=-1\text{mA}$			-1.4	V
Input Resistor	R_I			7	10	$\text{k}\Omega$
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

Equivalent Circuit**Marking**



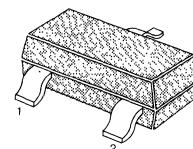
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$, $R_2=47K\Omega$)
- Complement to KSR1107

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$

SOT-23

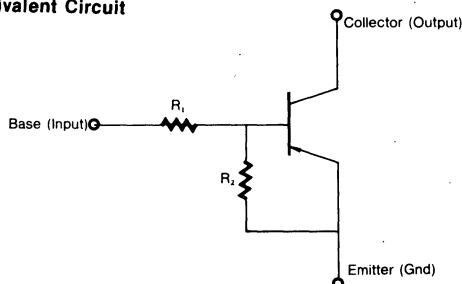
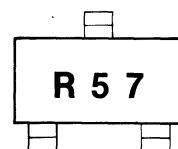


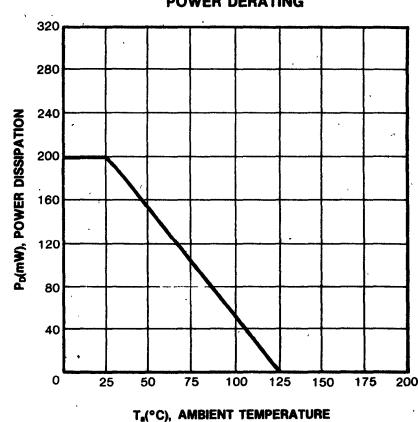
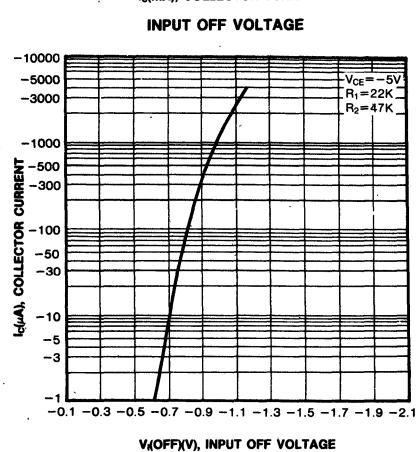
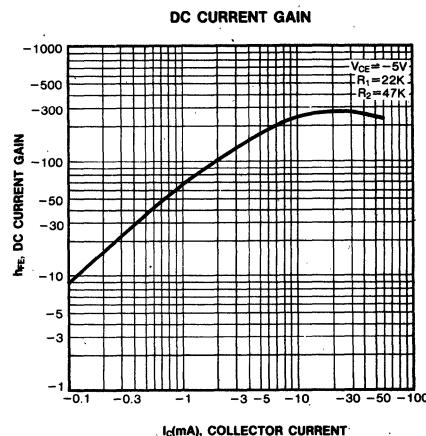
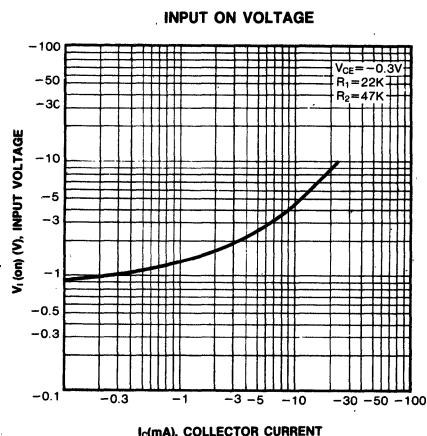
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A$, $I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A$, $I_B=0$	-50		-0.1	μA
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V$, $I_E=0$		68		
DC Current Gain	h_{FE}	$V_{CE}=-5V$, $I_C=-5mA$			-0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA$, $I_B=-0.5mA$		5.5		pF
Current Gain-Bandwidth Product	C_{OB}	$V_{CB}=-10V$, $I_E=0$ $f=1MHz$				
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10V$, $I_C=-5mA$	-0.4	200		MHz
Input Off Voltage	$V_{I(off)}$	$V_{CE}=-5V$, $I_C=-100\mu A$			-2.5	V
Input On Voltage	$V_{I(on)}$	$V_{CE}=-0.3V$, $I_C=-2mA$	15	22	29	V
Input Resistor	R_1		0.42	0.47	0.52	$K\Omega$
Resistor Ratio	R_1/R_2					

Equivalent Circuit**Marking**



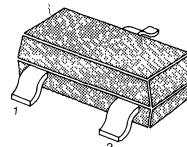
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=22\text{K}\Omega$)
- Complement to KSR1108

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

SOT-23

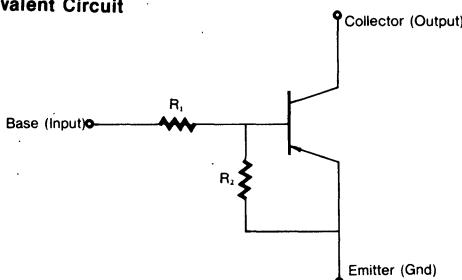
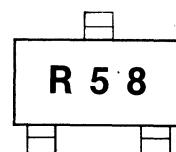


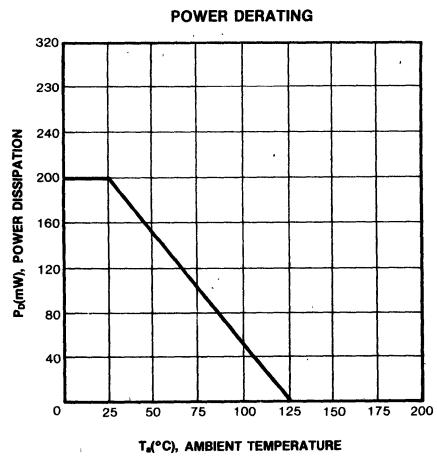
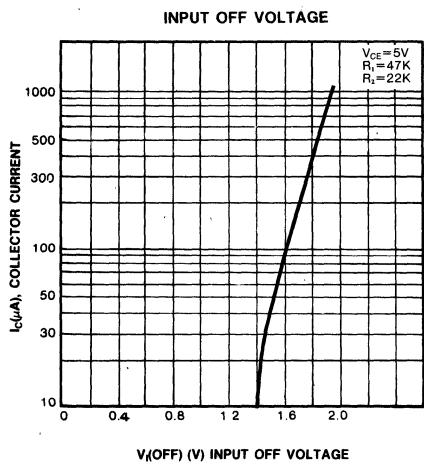
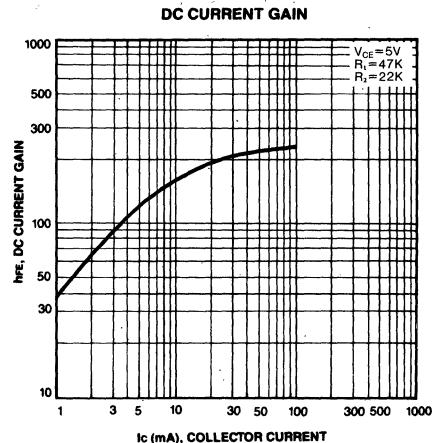
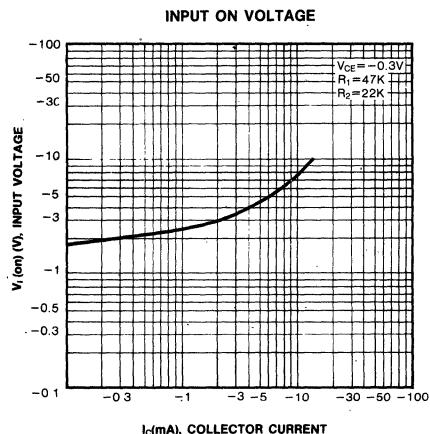
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	56			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$		200	-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$		5.5		MHz
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$				pF
Input Off Voltage	$V_{I(off)}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.8			V
Input On Voltage	$V_{I(on)}$	$V_{CE}=-0.3\text{V}, I_C=-2\text{mA}$			-4	V
Input Resistor	R_1		32	47	62	K Ω
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

Equivalent Circuit**Marking**



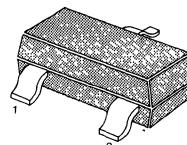
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7\text{ k}\Omega$)
- Complement to KSR1109

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{STG}	-55 ~ 150	°C

SOT-23

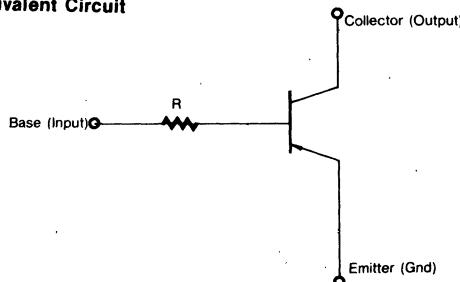
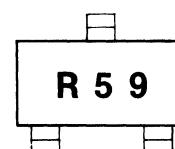


1. Base 2. Emitter 3. Collector

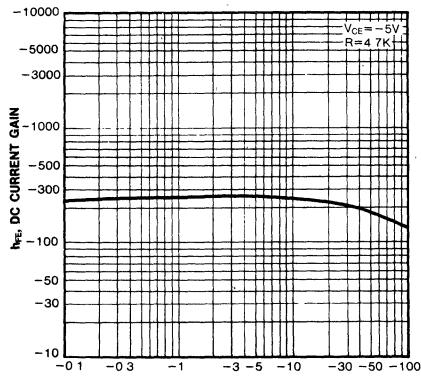
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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

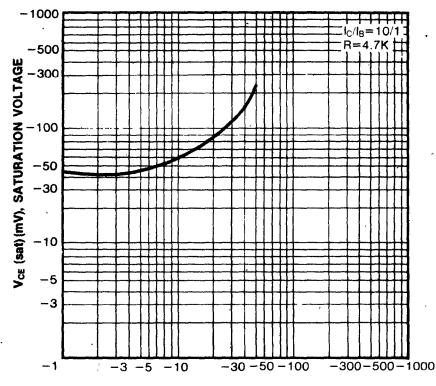
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1\text{ mA}, I_B = 0$	-40			V
Collector Cutoff Current	I_{CB0}	$V_{CB} = -30\text{ V}, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{ V}, I_C = -1\text{ mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -10\text{ mA}, I_B = -1\text{ mA}$			-0.3	V
Output Capacitance	C_{OB}	$V_{CB} = -10\text{ V}, I_E = 0$ $f = 1\text{ MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10\text{ V}, I_C = -5\text{ mA}$			200	MHz
Input Resistor	R_I		3.2	4.7	6.2	$\text{k}\Omega$

Equivalent Circuit**Marking**

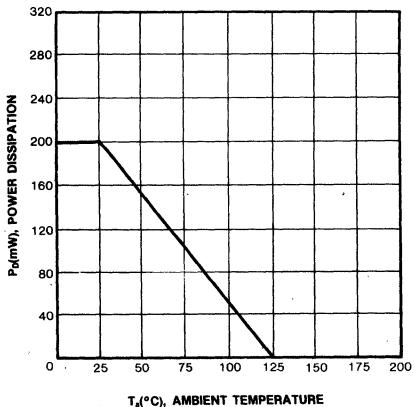
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE

 I_C (mA), COLLECTOR CURRENT I_C (mA), COLLECTOR CURRENT

POWER DERATING

 T_a (°C), AMBIENT TEMPERATURE

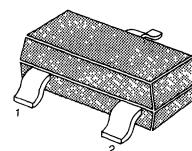
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
- Driver circuit
- Built in bias Resistor ($R=10K\Omega$)
- Complement to KSR1110

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$

SOT-23

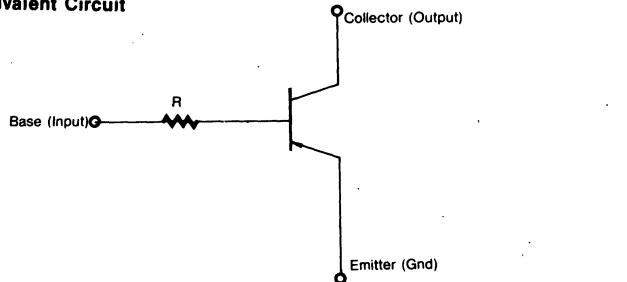
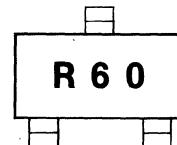


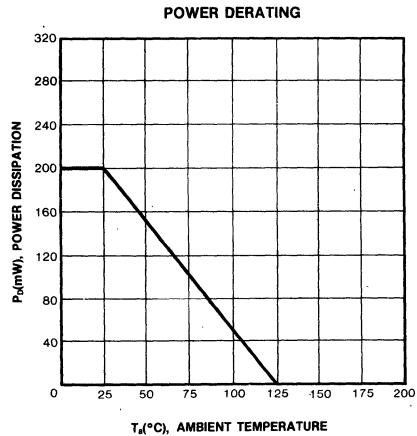
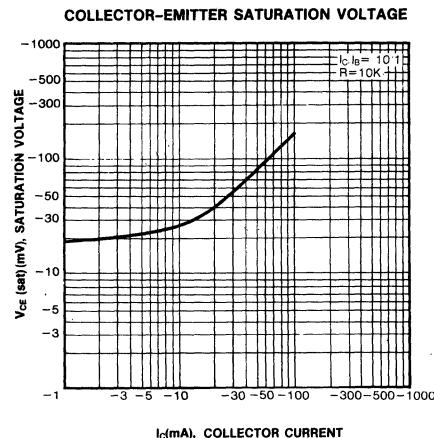
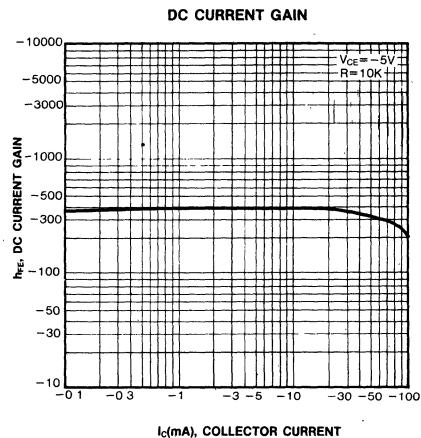
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu A, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E=-1mA, I_B=0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30V, I_E=0$	100		-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-1mA$			600	
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-1mA$			0.3	V
Output Capacitance	C_{OB}	$V_{CB}=-10V, I_E=0$		5.5		pF
Current Gain-Bandwidth Product	f_T	$f=1MHz$	7	200		MHz
Input Resistor	R	$V_{CE}=-10V, I_C=-5mA$		10	13	$K\Omega$

Equivalent Circuit**Marking**



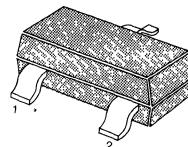
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22\text{K}\Omega$)
- Complement to KSR1111

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

SOT-23

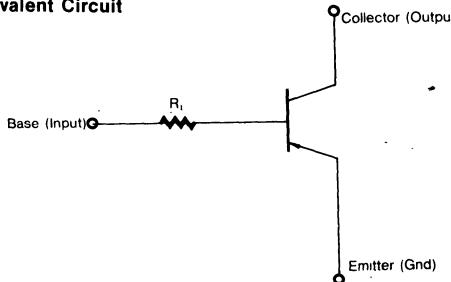
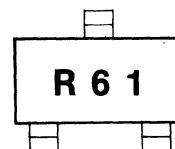


1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E=-1\text{mA}, I_B=0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-1\text{mA}$			-0.3	V
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$	15	200		MHz
Input Resistor	R_I			22	29	$\text{k}\Omega$

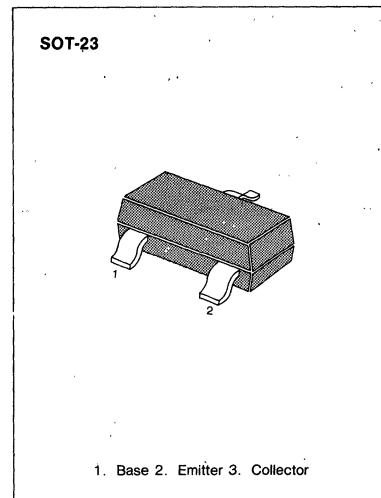
Equivalent Circuit**Marking**

SWITCHING APPLICATION (Bias Resistor Built In)

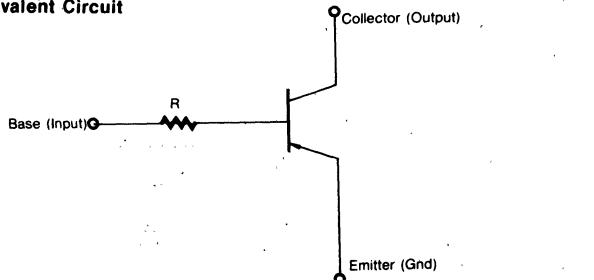
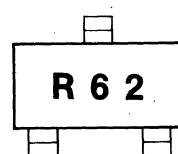
- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=47\text{ k}\Omega$)
- Complement to KSR1112

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	200	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS** ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-1\text{ mA}, I_B=0$	-40			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=-30\text{ V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{ V}, I_C=-1\text{ mA}$	100		600	
Collector Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{ mA}, I_B=-1\text{ mA}$		5.5	-0.3	V
Output Capacitance	C_{OB}	$V_{CB}=-10\text{ V}, I_E=0$ $f=1\text{ MHz}$				pF
Current Gain Bandwidth Product	f_T	$V_{CE}=-10\text{ V}, I_C=-5\text{ mA}$	32	200	62	MHz
Input Resistor	R			47		$\text{k}\Omega$

Equivalent Circuit**Marking**

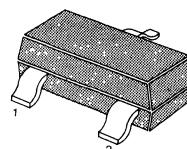
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=2.2\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR1113

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{Stg}	-55 ~ 150	°C

SOT-23

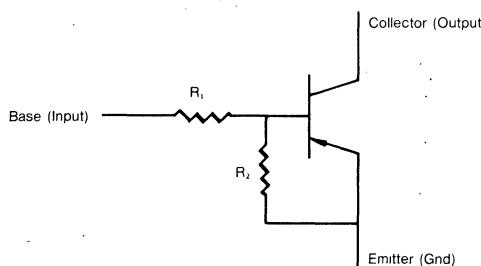
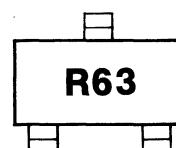


1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min.	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$		200		MHz
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$		5.5		pF
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=-0.2\text{V}, I_C=-10\text{mA}$			-1.1	V
Input Resistor	R_1		1.5	2.2	2.9	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

Equivalent Circuit**Marking**

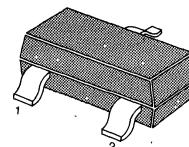
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7\text{K}\Omega$, $R_2 = 47\text{K}\Omega$)
- Complement to KSR1114

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

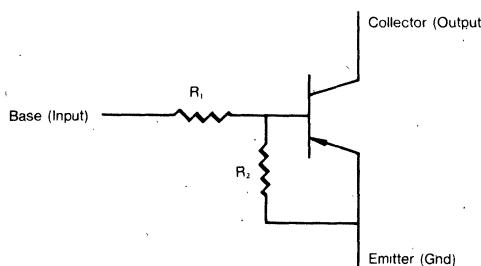
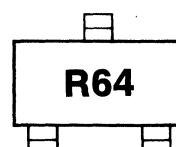
SOT-23



1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu\text{A}, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu\text{A}, I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40\text{V}, I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_C = -5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -10\text{mA}, I_B = -0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{mA}, I_C = -10\text{V}$		200		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}, I_E = 0$		5.5		pF
Input Off Voltage	$V_{i(\text{off})}$	$f = 1.0\text{MHz}$				
Input On Voltage	$V_{i(\text{on})}$	$V_{CE} = -5\text{V}, I_C = -100\mu\text{A}$	-0.5			V
Input Resistor	R_i	$V_{CE} = -0.2\text{V}, I_C = -5\text{mA}$	3.2	4.7	-1.3	V
Resistor Ratio	R_1/R_2		0.09	0.1	6.2	K Ω
					0.11	

Equivalent Circuit**Marking**

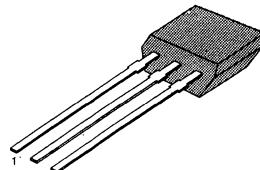
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$, $R_2=4.7\text{K}\Omega$)
- Complement to KSR1201

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55~150	$^\circ\text{C}$

TO-92S

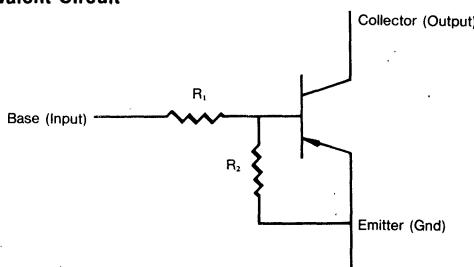


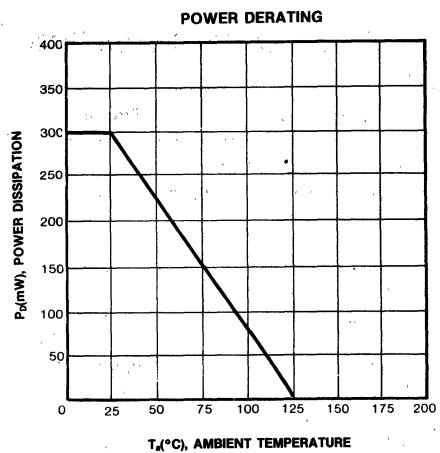
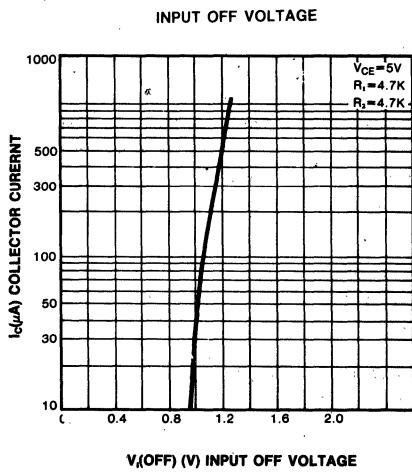
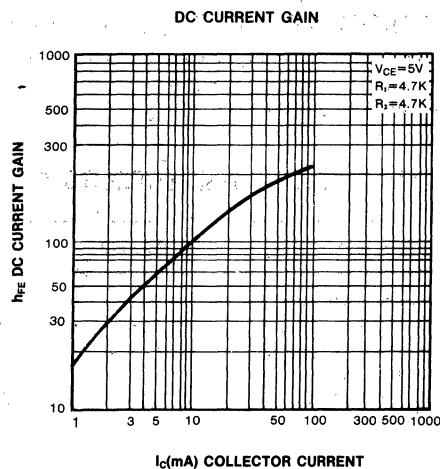
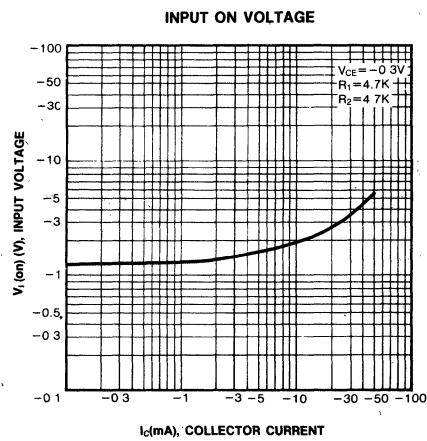
1 Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50		-0.1	μA
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$		20		
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-10\text{mA}$			-0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$		200		MHz
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$		5.5		pF
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$				
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=-0.3\text{V}, I_C=-20\text{mA}$			-3	V
Input Resistor	R_1		3.2	4.7	6.2	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit



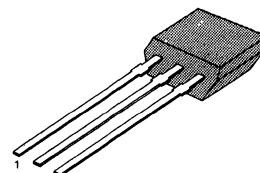
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 10\text{ k}\Omega$, $R_2 = 10\text{ k}\Omega$)
- Complement to KSR1202

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92S

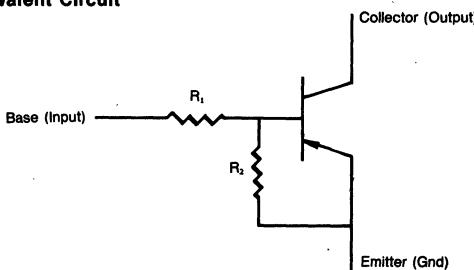


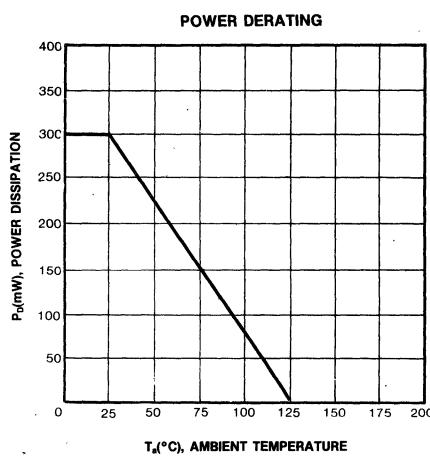
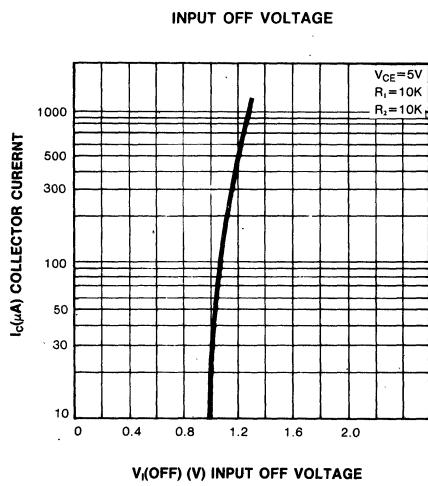
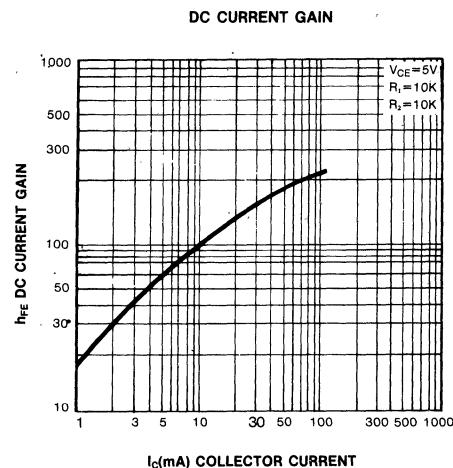
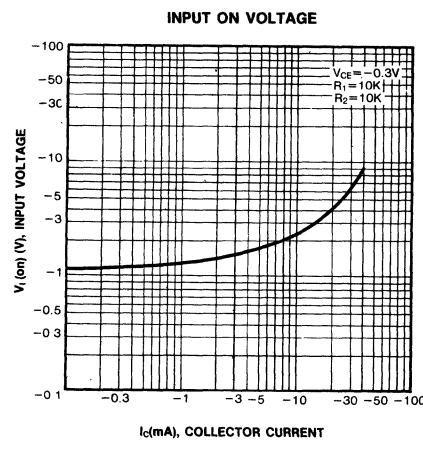
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit	
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu\text{A}, I_E = 0$	-50			V	
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu\text{A}, I_B = 0$	-50		-0.1	V	
Collector Cutoff Current	I_{CB0}	$V_{CB} = -40\text{V}, I_E = 0$		30		μA	
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_C = -5\text{mA}$			-0.1	μA	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -10\text{mA}, I_E = -0.5\text{mA}$			-0.3	V	
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{mA}, I_C = -10\text{V}$		200		MHz	
Output Capacitance	C_{OB}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1.0\text{MHz}$		5.5		pF	
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE} = -5\text{V}, I_C = -100\mu\text{A}$	-0.5			V	
Input On Voltage	$V_{I(\text{on})}$	$V_{CE} = -0.3\text{V}, I_C = -10\text{mA}$			-3	V	
Input Resistor	R_1			7	10	$\text{k}\Omega$	
Resistor Ratio	R_1/R_2			0.9	1	1.1	$\text{k}\Omega$

Equivalent Circuit



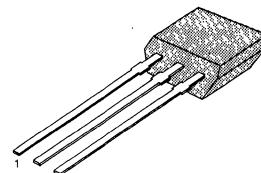
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 22\text{ k}\Omega$, $R_2 = 22\text{ k}\Omega$)
- Complement to KSR1203

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S

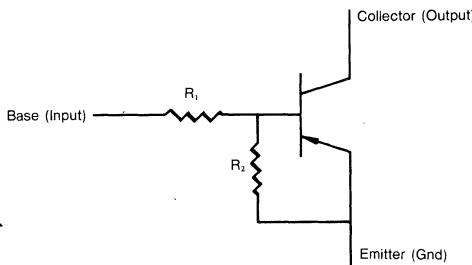


1. Emitter 2. Collector 3. Base

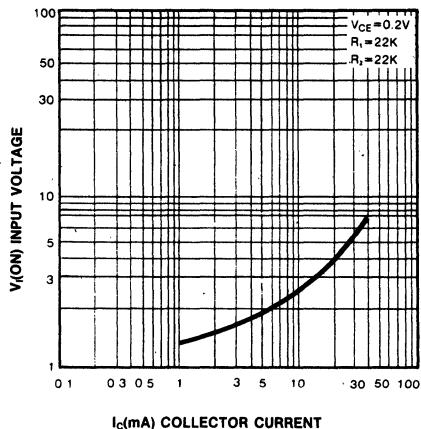
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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

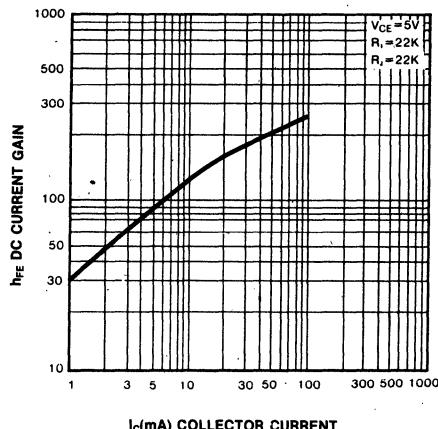
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu\text{A}$, $I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu\text{A}$, $I_B = 0$	-50		-0.1	V
Collector Cutoff Current	I_{CB0}	$V_{CB} = -40\text{V}$, $I_E = 0$		56		μA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}$, $I_C = -5\text{mA}$			-0.3	V
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -10\text{mA}$, $I_E = -0.5\text{mA}$				MHz
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{mA}$, $I_C = -10\text{V}$		200		pF
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}$, $I_E = 0$ $f = 1.0\text{MHz}$		5.5		
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE} = -5\text{V}$, $I_C = -100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE} = -0.2\text{V}$, $I_C = -5\text{mA}$			-3.0	V
Input Resistor	R_1		15	22	29	$\text{k}\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit

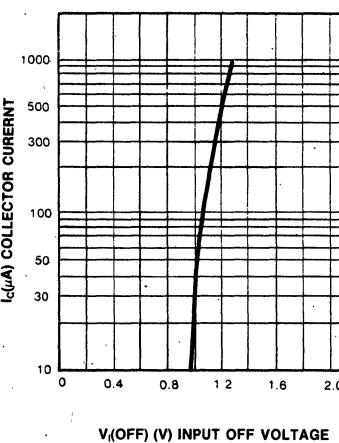
INPUT ON VOLTAGE



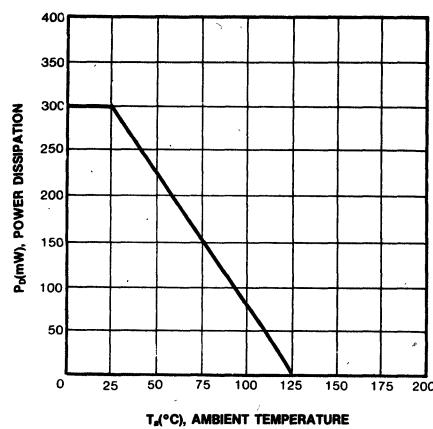
DC CURRENT GAIN



INPUT OFF VOLTAGE



POWER DERATING



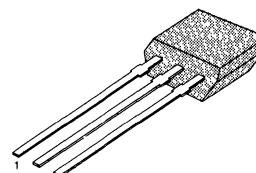
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR1204

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_c	-100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

TO-92S

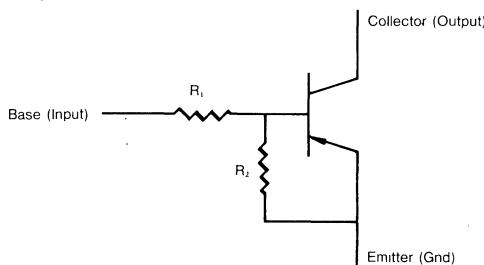


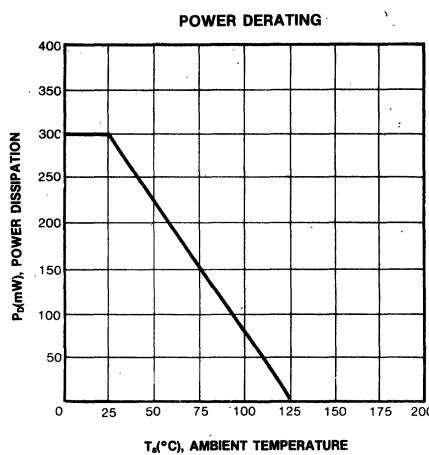
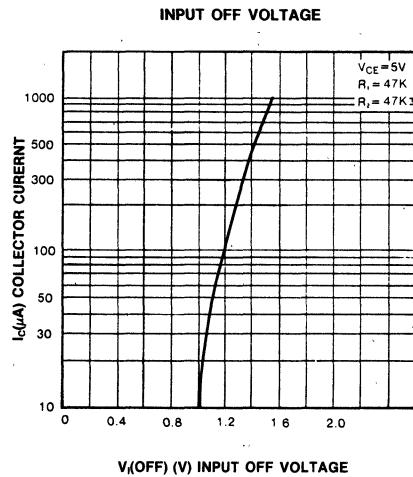
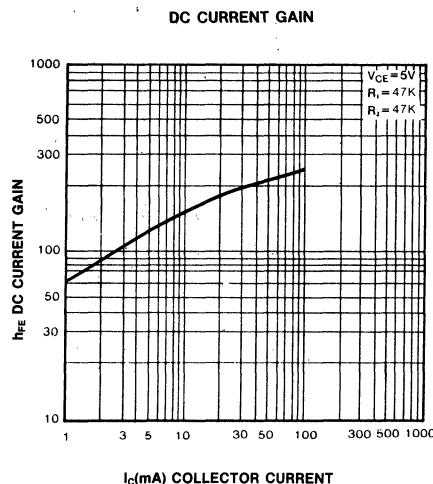
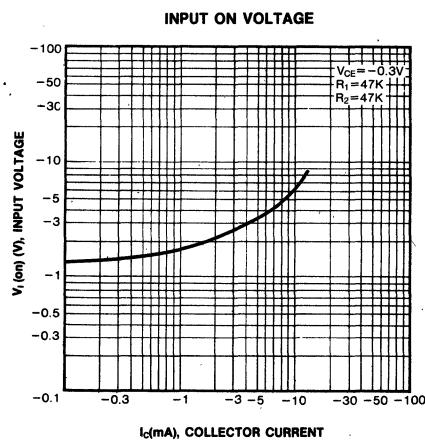
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$	68		-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_c=-5\text{mA}$				
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_c=-10\text{V}$	200			MHz
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$	5.5			pF
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=-5\text{V}, I_c=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_i(\text{on})$	$V_{CE}=-0.3\text{V}, I_c=-10\text{mA}$	32	47	62	V
Input Resistor	R_1					$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.9	1	1.1	

Equivalent Circuit



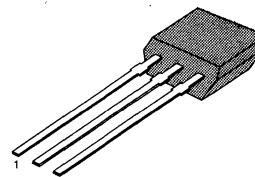
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=4.7\text{K}\Omega$, $R_2=10\text{K}\Omega$)
- Complement to KSR1205

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_c	-100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92S

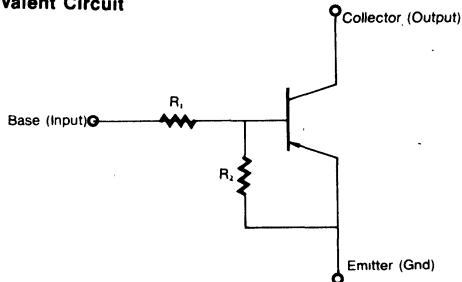


1. Emitter 2. Collector 3. Base

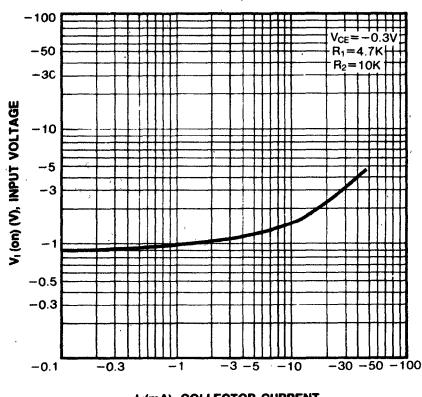
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

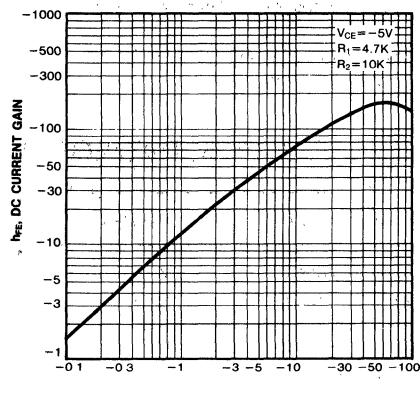
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	30			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	C_{ob}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$		200		MHz
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.3			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE}=-0.3\text{V}, I_C=-20\text{mA}$			-2.5	V
Input Resistor	R_1		3.2	4.7	6.2	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

Equivalent Circuit

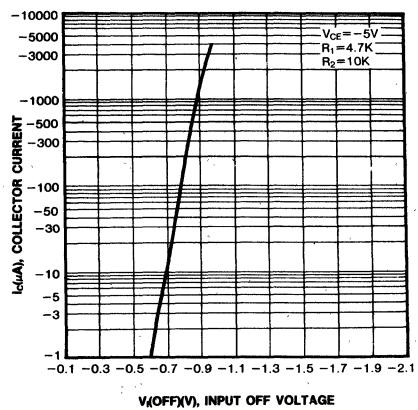
INPUT ON VOLTAGE



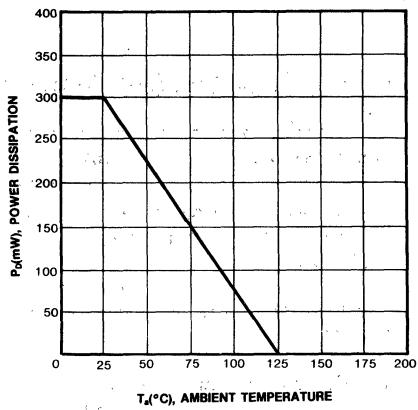
DC CURRENT GAIN

I_C(mA), COLLECTOR CURRENT

INPUT OFF VOLTAGE

V_{I(OFF)}(V), INPUT OFF VOLTAGEI_C(mA), COLLECTOR CURRENT

POWER DERATING

T_A(°C), AMBIENT TEMPERATURE

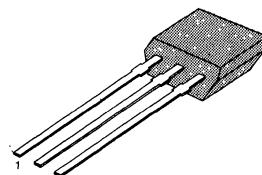
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
- Driver circuit
- Built in bias Resistor ($R_1=10\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR1206

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92S

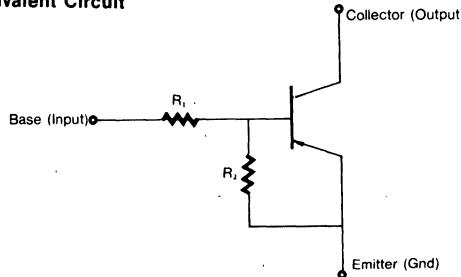


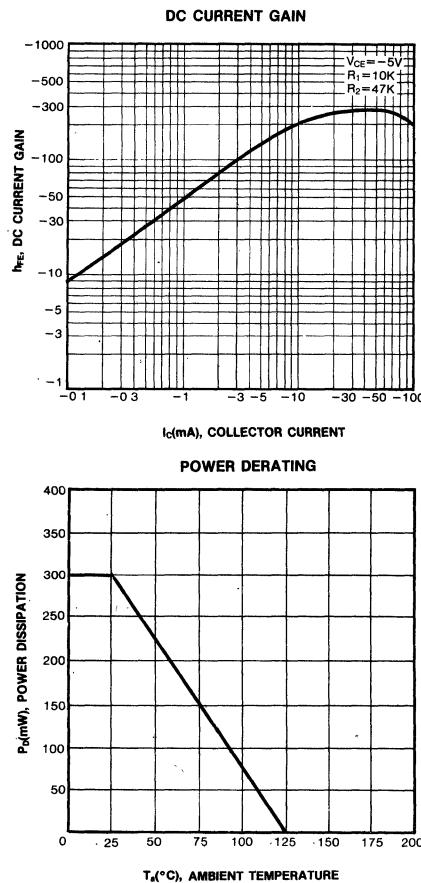
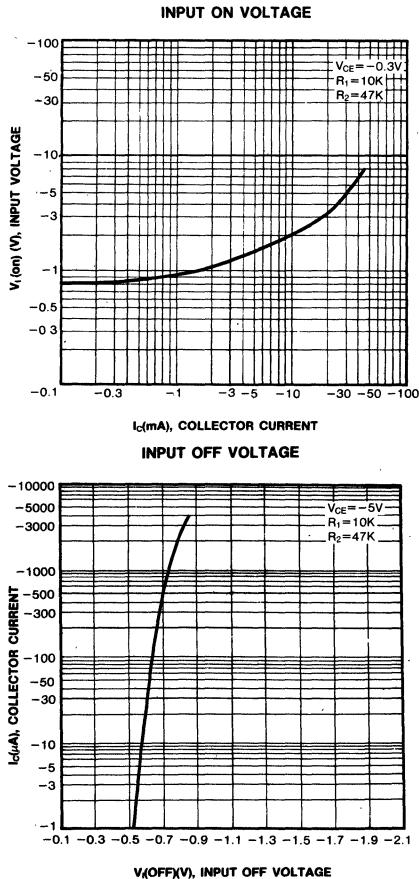
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
Output Capacitance	C_{OB}	$V_{CS}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$		200		MHz
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.3			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=-0.3\text{V}, I_C=-1\text{mA}$			-1.4	V
Input Resistor	R_I		7	10	13	K Ω
Resistor Ratio	R_1/R_2		0.19	0.21	0.24	

Equivalent Circuit



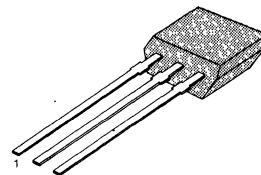
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R_1=22K\Omega$ $R_2=47K\Omega$)
- Complement to KSR1207

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_c	-100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55~150	$^\circ C$

TO-92S

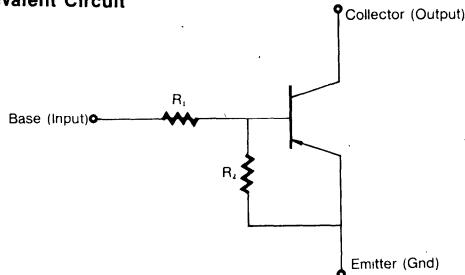


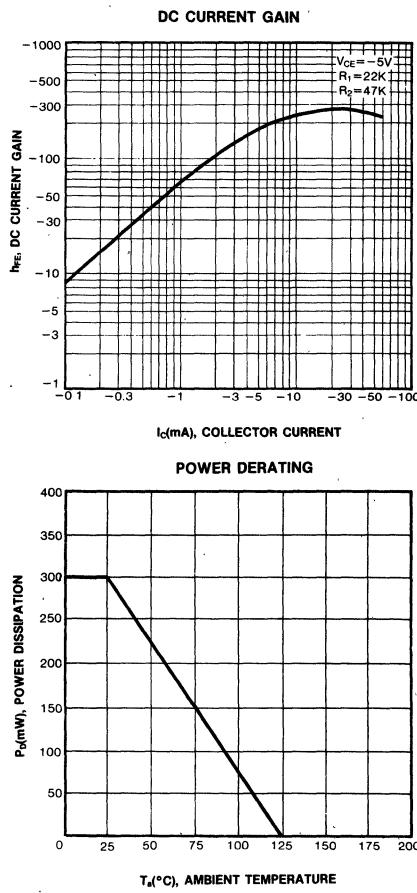
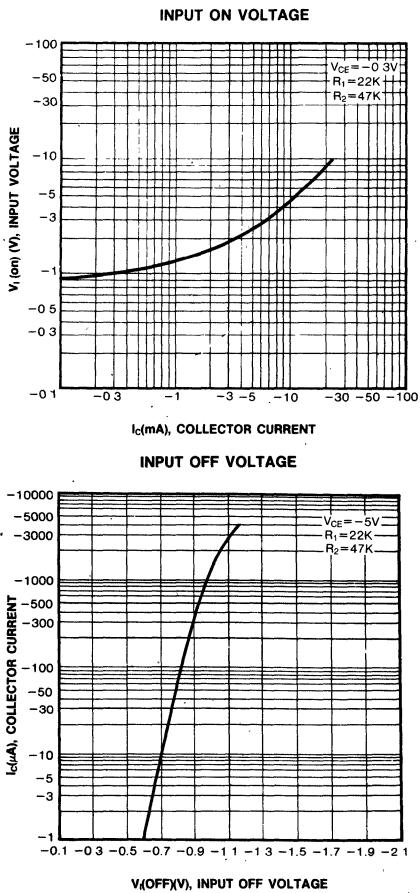
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu A, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu A, I_E=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-5mA$	68			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-0.5mA$		5.5	-0.3	V
Current Gain-Bandwidth Product	C_{ob}	$V_{CB}=-10V, I_E=0$ $f=1MHz$				pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10V, I_C=-5mA$		200		MHz
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=-5V, I_C=-100\mu A$	-0.4			V
Input On Voltage	$V_i(\text{on})$	$V_{CE}=-0.3V, I_C=-2mA$			-2.5	V
Input Resistor	R_1		15	22	29	K Ω
Resistor Ratio	R_1/R_2		0.42	0.47	0.52	

Equivalent Circuit



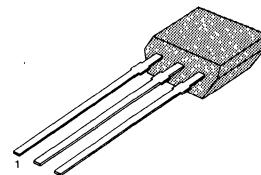
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=47\text{K}\Omega$, $R_2=22\text{K}\Omega$)
- Complement to KSR1208

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_c	-100	mA
Collector Dissipation	P_c	300	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

TO-92S

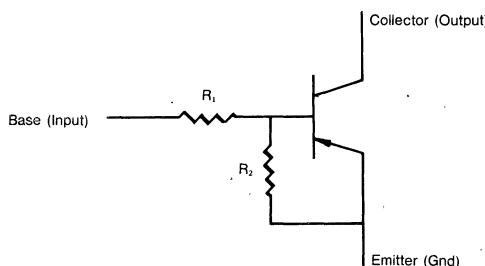


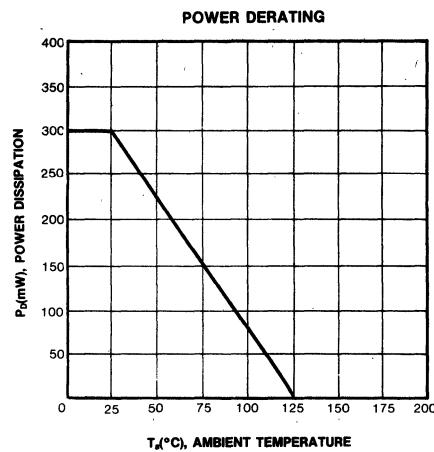
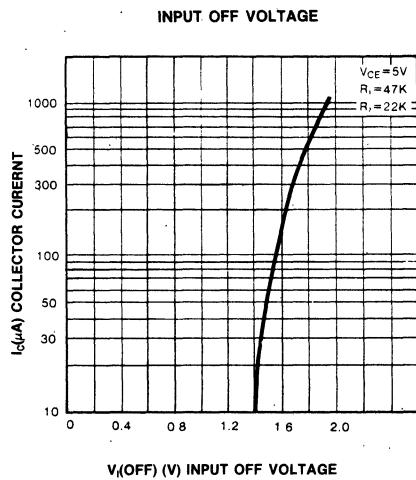
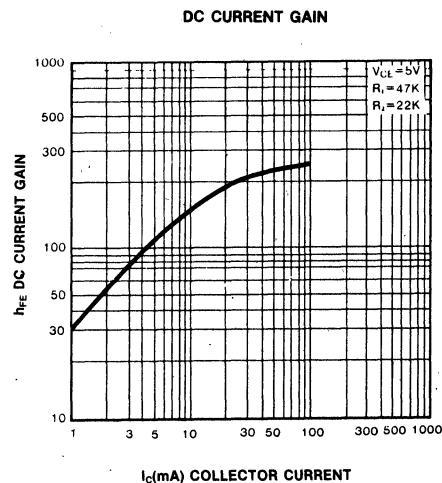
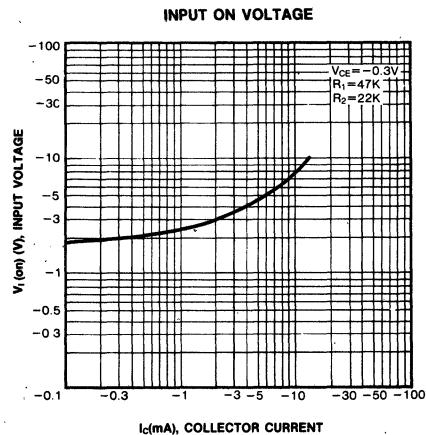
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}$, $I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}$, $I_E=0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-40\text{V}$, $I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}$, $I_C=-5\text{mA}$	56			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}$, $I_B=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}$, $I_C=-10\text{V}$		200		MHz
Output Capacitance	C_{ob}	$V_{CB}=-10\text{V}$, $I_E=0$ $f=1.0\text{MHz}$		5.5		pF
Input Off Voltage	$V_i(\text{off})$	$V_{CE}=-5\text{V}$, $I_C=-100\mu\text{A}$	-0.8			V
Input On Voltage	$V_i(\text{on})$	$V_{CE}=-0.3\text{V}$, $I_C=-2\text{mA}$			-4	V
Input Resistor	R_1		32	47	62	K Ω
Resistor Ratio	R_1/R_2		1.9	2.1	2.4	

Equivalent Circuit



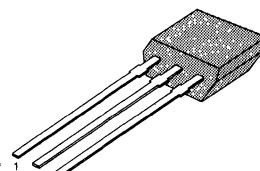
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=4.7\text{ k}\Omega$)
- Complement to KSR1209

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92S

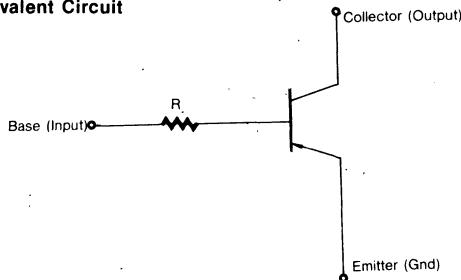


1. Emitter 2. Collector 3. Base

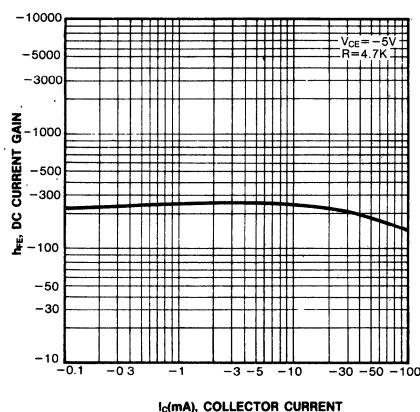
3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

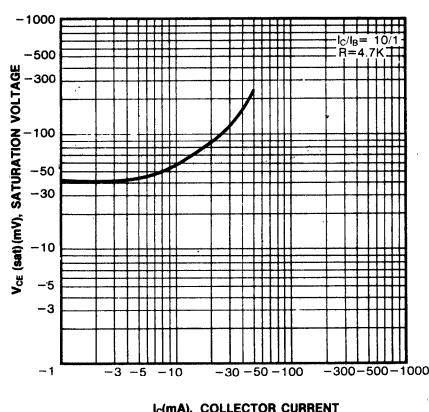
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-1\text{ mA}, I_B=0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30\text{ V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{ V}, I_C=-1\text{ mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{ mA}, I_B=-1\text{ mA}$			-0.3	V
Output Capacitance	C_{OB}	$V_{CB}=-10\text{ V}, I_E=0$		5.5		pF
Current Gain-Bandwidth Product	f_T	$f=1\text{ MHz}$			200	MHz
Input Resistor	R_I	$V_{CE}=-10\text{ V}, I_C=-5\text{ mA}$	3.2	4.7	6.2	$\text{k}\Omega$

Equivalent Circuit

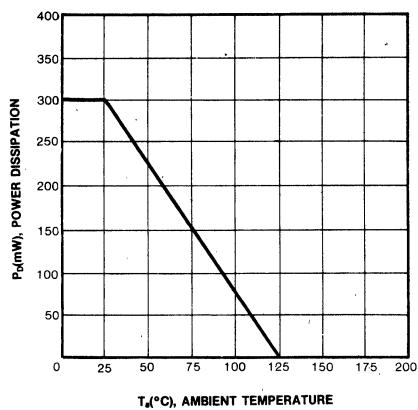
DC CURRENT GAIN



COLLECTOR-EMITTER SATURATION VOLTAGE

 I_c (mA), COLLECTOR CURRENT I_c (mA), COLLECTOR CURRENT

POWER DERATING

 T_a (°C), AMBIENT TEMPERATURE

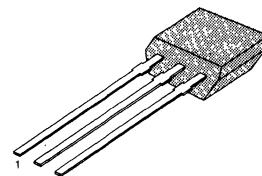
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=10\text{K}\Omega$)
- Complement to KSR1210

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ -150	$^\circ\text{C}$

TO-92S

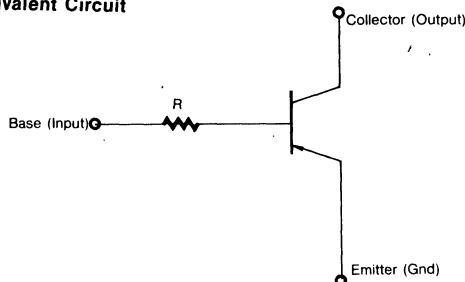


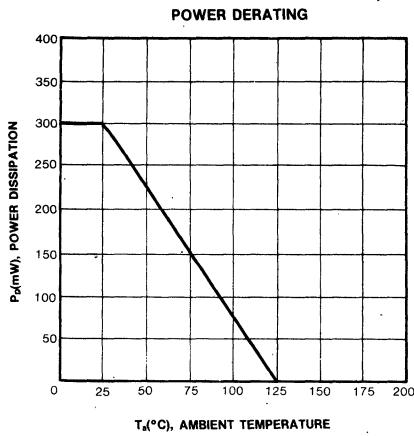
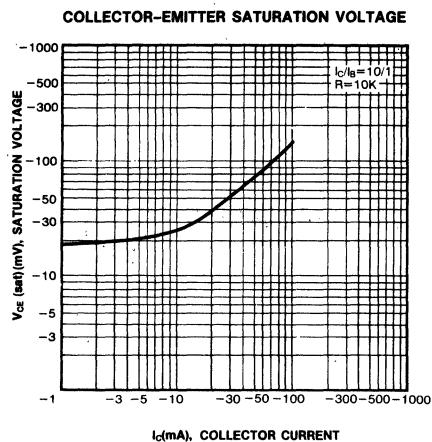
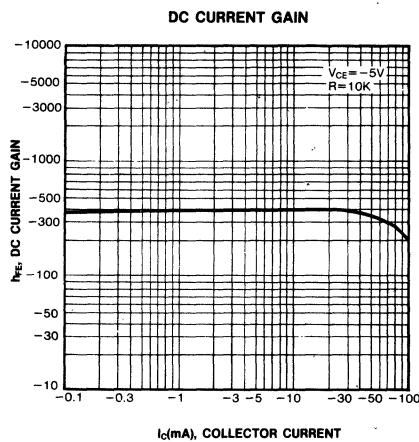
1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E=-1\text{mA}, I_B=0$	-40			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=-30\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-1\text{mA}$			0.3	V
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$	7	200		MHz
Input Resistor	R			10	13	$\text{K}\Omega$

Equivalent Circuit



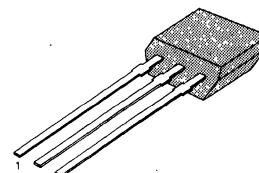
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=22\text{K}\Omega$)
- Complement to KSR1211

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92S

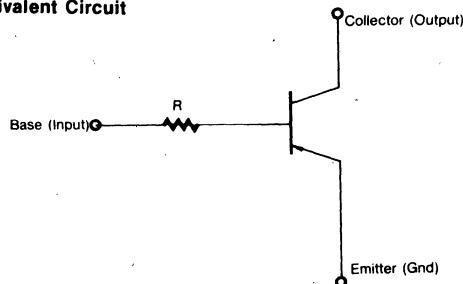


1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_E=-1\text{mA}, I_B=0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-1\text{mA}$	100		600	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-1\text{mA}$			-0.3	V
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1\text{MHz}$		5.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=-10\text{V}, I_C=-5\text{mA}$	15	200		MHz
Input Resistor	R			22	29	$\text{K}\Omega$

Equivalent Circuit

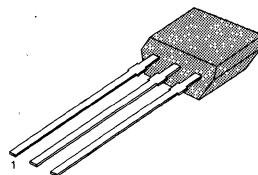
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching Circuit, Inverter, Interface circuit
Driver circuit
- Built in bias Resistor ($R=47K\Omega$)
- Complement to KSR1212

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$

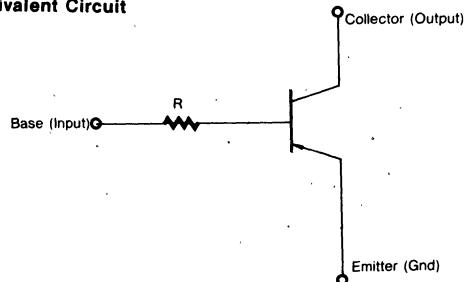
TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu A, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-1mA, I_B=0$	-40			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-30V, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5V, I_C=-1mA$	100		600	
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=-10mA, I_B=-1mA$			-0.3	V
Output Capacitance	C_{OB}	$V_{CB}=-10V, I_E=0$ $f=1MHz$		5.5		pF
Current Gain Bandwidth Product	f_T	$V_{CE}=-10V, I_C=-5mA,$ $f=1MHz$	32	200		MHz
Input Resistor	R			47	62	$K\Omega$

Equivalent Circuit

SAMSUNG SEMICONDUCTOR

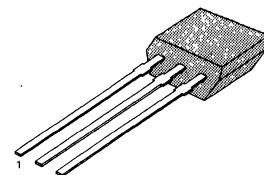
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1=2.2\text{K}\Omega$, $R_2=47\text{K}\Omega$)
- Complement to KSR1213

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

TO-92S

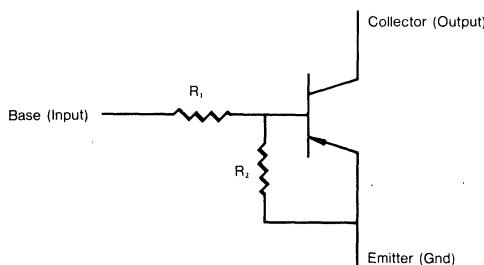


1. Emitter 2. Collector 3. Base

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-10\mu\text{A}, I_E=0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-100\mu\text{A}, I_B=0$	-50			V
Collector Cutoff Current	I_{CB0}	$V_{CB}=-40\text{V}, I_E=0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-5\text{V}, I_C=-5\text{mA}$	68			
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=-10\text{mA}, I_B=-0.5\text{mA}$			-0.3	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-5\text{mA}, I_C=-10\text{V}$	200			MHz
Output Capacitance	C_{OB}	$V_{CB}=-10\text{V}, I_E=0$ $f=1.0\text{MHz}$	5.5			pF
Input Off Voltage	$V_{I(\text{off})}$	$V_{CE}=-5\text{V}, I_C=-100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{I(\text{on})}$	$V_{CE}=-0.2\text{V}, I_C=-10\text{mA}$			-1.1	V
Input Resistor	R_1		1.5	2.2	2.9	K Ω
Resistor Ratio	R_1/R_2		0.042	0.047	0.052	

Equivalent Circuit

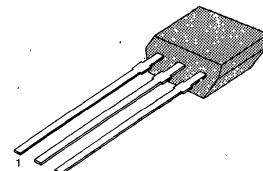
SWITCHING APPLICATION (Bias Resistor Built In)

- Switching circuit, Inverter, Interface circuit Driver circuit
- Built in bias Resistor ($R_1 = 4.7\text{K}\Omega$, $R_2 = 47\text{K}\Omega$)
- Complement to KSR1214

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Emitter-Base Voltage	V_{EBO}	-10	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	300	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

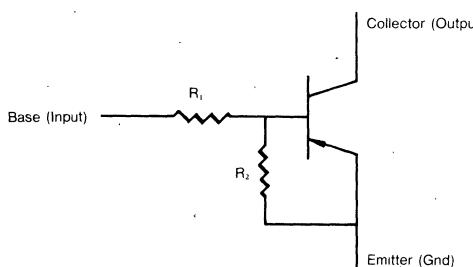
TO-92S



1. Emitter 2. Collector 3. Base

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -10\mu\text{A}$, $I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -100\mu\text{A}$, $I_B = 0$	-50			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -40\text{V}$, $I_E = 0$			-0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}$, $I_C = -5\text{mA}$	68		-0.3	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -10\text{mA}$, $I_B = -0.5\text{mA}$		200		V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{mA}$, $I_C = -10\text{V}$		5.5		MHz
Output Capacitance	C_{ob}	$V_{CB} = -10\text{V}$, $I_E = 0$ $f = 1.0\text{MHz}$				pF
Input Off Voltage	$V_{i(\text{off})}$	$V_{CE} = -5\text{V}$, $I_C = -100\mu\text{A}$	-0.5			V
Input On Voltage	$V_{i(\text{on})}$	$V_{CE} = -0.2\text{V}$, $I_C = -5\text{mA}$			-1.3	V
Input Resistor	R_i		3.2	4.7	6.2	$\text{K}\Omega$
Resistor Ratio	R_1/R_2		0.09	0.1	0.11	

Equivalent Circuit

GENERAL PURPOSE TRANSISTOR

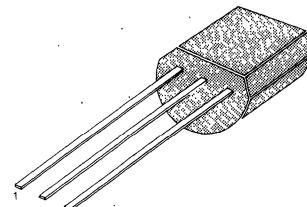
- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N3904 for graphs

TO-92



1 Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	60			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	6			V
Collector Cut-off Current	I_{CEX}	$V_{CE} = 30V, V_{EB} = 3V$			50	nA
Base Cut-off Current	I_{BL}	$V_{CE} = 30V, V_{EB} = 3V$			50	nA
*DC Current Gain	h_{FE}	$I_C = 0.1\text{mA}, V_{CE} = 1V$ $I_C = 1\text{mA}, V_{CE} = 1V$ $I_C = 10\text{mA}, V_{CE} = 1V$ $I_C = 50\text{mA}, V_{CE} = 1V$ $I_C = 100\text{mA}, V_{CE} = 1V$	20 35 50 30 15		150	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$			0.2 0.3	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$	0.65		0.85 0.95	V
Output Capacitance	C_{OB}	$V_{CE} = 5V, I_E = 0$ $f = 1\text{MHz}$			4	pF
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20V$ $f = 100\text{MHz}$	250			MHz
Turn On Time	t_{on}	$V_{CC} = 3V, V_{BE} = 0.5V$ $I_C = 10\text{mA}, I_{B1} = 1\text{mA}$			70	ns
Turn Off Time	t_{off}	$V_{CC} = 3V, I_C = 1\text{mA}$ $I_B = I_{B2} = 1\text{mA}$			225	ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

SAMSUNG SEMICONDUCTOR

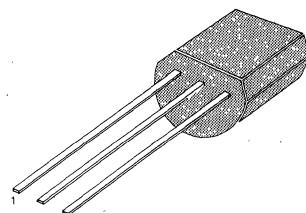
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92



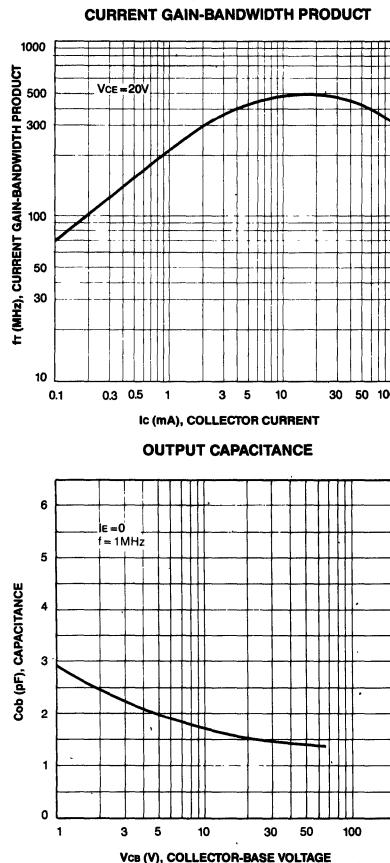
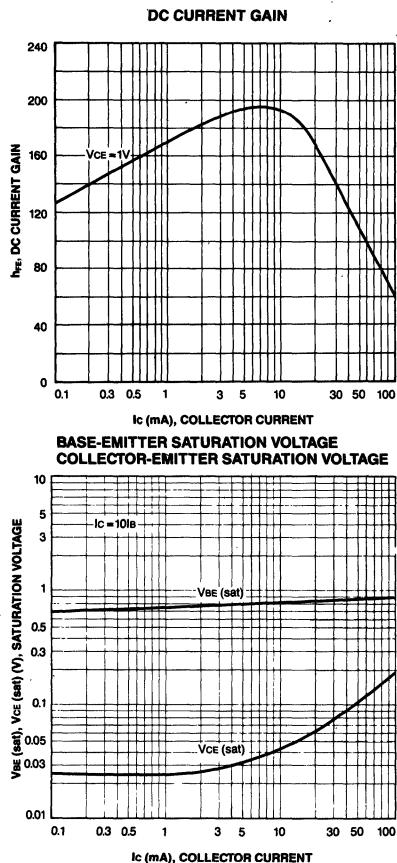
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	60			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	6			V
Collector Cut-off Current	I_{CEX}	$V_{CE} = 30V, V_{EB} = 3V$			50	nA
Base Cut-off Current	I_{BL}	$V_{CE} = 30V, V_{EB} = 3V$			50	nA
*DC Current Gain	h_{FE}	$I_C = 0.1\text{mA}, V_{CE} = 1V$ $I_C = 1\text{mA}, V_{CE} = 1V$ $I_C = 10\text{mA}, V_{CE} = 1V$ $I_C = 50\text{mA}, V_{CE} = 1V$ $I_C = 100\text{mA}, V_{CE} = 1V$	40 70 100 60 30		300	
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$			0.2 0.3	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$	0.65		0.85 0.95	V
Output Capacitance	C_{OB}	$V_{CB} = 5V, I_E = 0$ $f = 1\text{MHz}$			4	pF
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20V$ $f = 100\text{MHz}$	300			MHz
Turn On Time	t_{ON}	$V_{CC} = 3V, V_{BE} = 0.5V$ $I_C = 10\text{mA}, I_{B1} = 1\text{mA}$			70	ns
Turn Off Time	t_{OFF}	$V_{CC} = 3V, I_C = 1\text{mA}$ $I_{B1} = I_{B2} = 1\text{mA}$			250	ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

SAMSUNG SEMICONDUCTOR



GENERAL PURPOSE TRANSISTOR

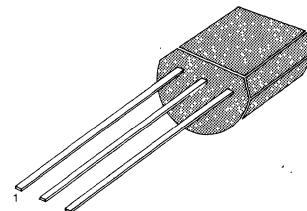
- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N3906 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	40			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Base Cut-off Current	I_{BL}	$V_{CE} = 30V, V_{BE} = 3V$			50	nA
Collector Cut-off Current	I_{CEX}	$V_{CE} = 30V, V_{BE} = 3V$			50	nA
*DC Current Gain	h_{FE}	$I_C = 0.1\text{mA}, V_{CE} = 1V$ $I_C = 1\text{mA}, V_{CE} = 1V$ $I_C = 10\text{mA}, V_{CE} = 1V$ $I_C = 50\text{mA}, V_{CE} = 1V$ $I_C = 100\text{mA}, V_{CE} = 1V$	30 40 50 30 15		150	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_E = 1\text{mA}$ $I_C = 50\text{mA}, I_E = 5\text{mA}$			0.25 0.4	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$	0.65		0.85 0.95	V
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20V$ $f = 100\text{MHz}$	200			MHz
Output Capacitance	C_{OB}	$V_{CB} = 5V, I_E = 0$ $f = 100\text{KHz}$			4.5	pF
Turn On Time	t_{on}	$V_{CC} = 3V, V_{BE} = 0.5V$ $I_C = 10\text{mA}, I_{B1} = 1\text{mA}$			70	ns
Turn Off Time	t_{off}	$V_{CC} = 3V, I_C = 10\text{mA}$ $I_B = I_{B2} = 1\text{mA}$			260	ns

* Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

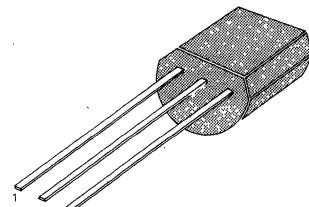
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



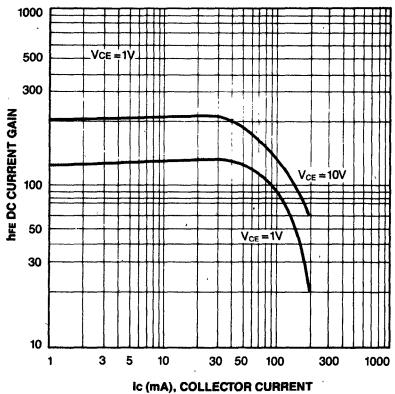
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

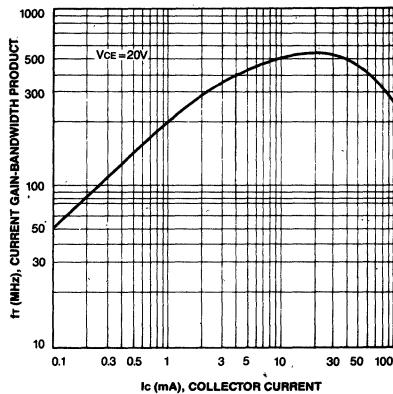
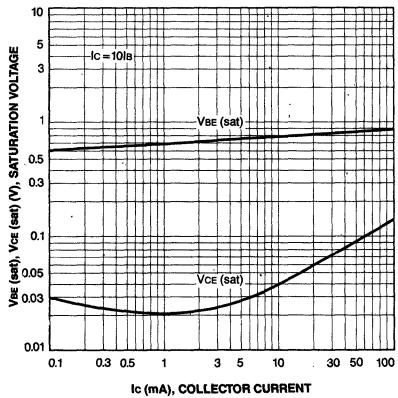
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	40			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_E = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Base Cut-off Current	I_{BL}	$V_{CE} = 30V, V_{BE} = 3V$			50	nA
Collector Cut-off Current	I_{CEX}	$V_{CE} = 30V, V_{BE} = 3V$		50		nA
*DC Current Gain	h_{FE}	$I_C = 0.1\text{mA}, V_{CE} = 1V$ $I_C = 1\text{mA}, V_{CE} = 1V$ $I_C = 10\text{mA}, V_{CE} = 1V$ $I_C = 50\text{mA}, V_{CE} = 1V$ $I_C = 100\text{mA}, V_{CE} = 1V$	60 80 100 60 30		300	
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_E = 1\text{mA}$ $I_C = 50\text{mA}, I_E = 5\text{mA}$			0.25 0.4	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10\text{mA}, I_E = 1\text{mA}$ $I_C = 50\text{mA}, I_E = 5\text{mA}$	0.65		0.85 0.95	V
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20V$ $f = 100\text{MHz}$	250			MHz
Output Capacitance	C_{OB}	$V_{CB} = 5V, I_E = 0$ $f = 100\text{KHz}$			4.5	pF
Turn On Time	t_{on}	$V_{CC} = 3V, V_{BE} = 0.5V$ $I_C = 10\text{mA}, I_{B1} = 1\text{mA}$			70	ns
Turn Off Time	t_{off}	$V_{CC} = 3V, I_C = 10\text{mA}$ $I_{B1} = I_{B2} = 1\text{mA}$			300	ns

* Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

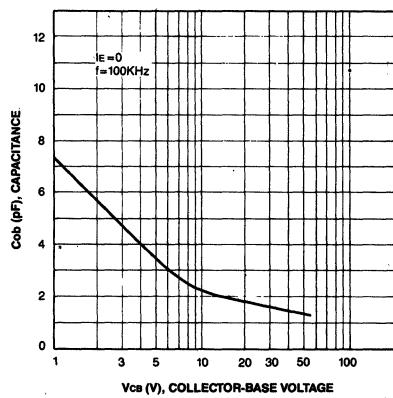
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE



GENERAL PURPOSE TRANSISTOR

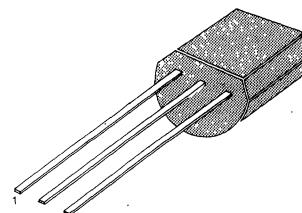
- Collector-Emitter Voltage: $V_{CEO} = 30V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

• Refer to 2N3904 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	40			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 2\text{mA}, V_{CE} = 1V$ $I_C = 50\text{mA}, V_{CE} = 1V$	50 25		150	
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 50\text{mA}, I_B = 5\text{mA}$			0.3	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 50\text{mA}, I_B = 5\text{mA}$			0.95	V
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20V$ $f = 10\text{MHz}$	250			MHz
Output Capacitance	C_{ob}	$V_{CB} = 5V, I_E = 0$ $f = 1\text{MHz}$			4	pF
Collector-Base Capacitance	C_{cb}	$V_{CB} = 5V, I_E = 0$ $f = 100\text{KHz}$			4	pF

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



GENERAL PURPOSE TRANSISTOR

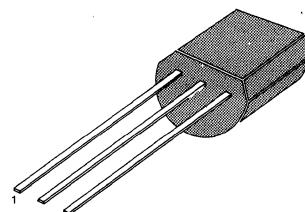
- Collector-Emitter Voltage: $V_{CEO} = 25V$
- Collector Dissipation: P_c (max) = 625mW

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

• Refer to 2N3904 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu A, I_E = 0$	30			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$		50	360	nA
*DC Current Gain	h_{FE}	$I_C = 2mA, V_{CE} = 1V$ $I_C = 50mA, V_{CE} = 1V$	120	60		
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 50mA, I_B = 5mA$			0.3	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 50mA, I_B = 5mA$			0.95	V
Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 20V$ $f = 100MHz$	300			MHz
Output Capacitance	C_{ob}	$V_{CB} = 5V, I_E = 0$ $f = 1MHz$			4	pF
Collector-Base Capacitance	C_{cb}	$V_{CB} = 5V, I_E = 0$ $f = 100KHz$			4	pF

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



AMPLIFIER TRANSISTOR

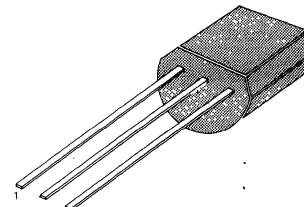
- Collector-Emitter Voltage: $V_{CEO} = 30\text{ V}$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	30	V
Collector-Base Voltage	V_{CBO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_c	200	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* Refer to 2N3906 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 1\text{mA}, I_B = 0$	30			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 10\mu\text{A}, I_E = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20\text{V}, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3\text{V}, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 2\text{mA}, V_{CE} = 1\text{V}$ $I_C = 50\text{mA}, V_{CE} = 1\text{V}$	50		150	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 50\text{mA}, I_B = 5\text{mA}$	25		0.4	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 50\text{mA}, I_B = 5\text{mA}$			0.95	
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20\text{V}$ $f = 100\text{MHz}$	200			MHz
Collector Base Capacitance	C_{cb}	$V_{CB} = 5\text{V}, I_E = 0$			4.5	pF
Noise Figure	NF	$f = 1\text{MHz}$ $I_C = 100\mu\text{A}, V_{CE} = 5\text{V}$ $R_G = 1\text{k}\Omega$ Noise Bandwidth = 10Hz to 15.7KHz			5	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



AMPLIFIER TRANSISTOR

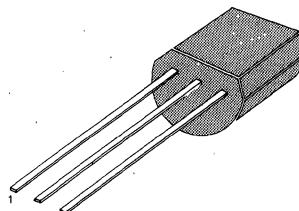
- Collector-Emitter Voltage: $V_{CEO} = 25V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	25	V
Collector-Base Voltage	V_{CBO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N3906 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	25			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 2\text{mA}, V_{CE} = 1V$ $I_C = 50\text{mA}, V_{CE} = 1V$	120		360	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 50\text{mA}, I_B = 5\text{mA}$	60		0.4	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 50\text{mA}, I_B = 5\text{mA}$			0.95	
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20V$ $f = 100\text{MHz}$	250			MHz
Collector Base Capacitance	C_{cb}	$V_{CB} = 5V, I_E = 0$ $f = 1\text{MHz}$			4.5	pF
Noise Figure	NF	$I_C = 100\mu\text{A}, V_{CE} = 5V$ $R_g = 1\text{k}\Omega$ Noise Bandwidth = 10Hz to 15.7KHz			4	dB

Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

SAMSUNG SEMICONDUCTOR

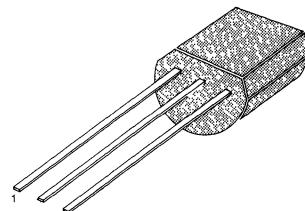
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

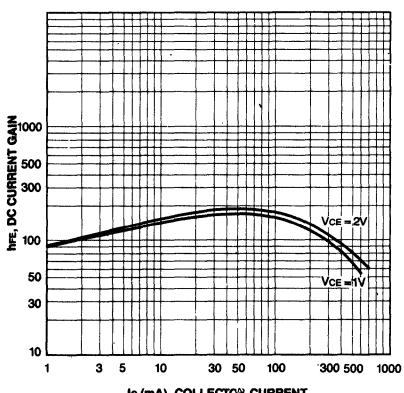
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

3

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	60			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	6			V
Collector Cut-off Current	I_{CEX}	$V_{CE} = 35V, V_{EB} = 0.4V$				
*DC Current Gain	β_{FE}	$I_C = 1\text{mA}, V_{CE} = 1V$ $I_C = 10\text{mA}, V_{CE} = 1V$ $I_C = 150\text{mA}, V_{CE} = 1V$ $I_C = 500\text{mA}, V_{CE} = 2V$ $I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$	20 40 50 20 0.4 0.75	100 150		nA
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$			0.4 0.75	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$		0.95	1.2	V
Collector-Base Capacitance	C_{CB}	$V_{CB} = 5V, I_E = 0$ $f = 100\text{KHz}$			6.5	pF
Current Gain Bandwidth Product	f_T	$I_C = 20\text{mA}, V_{CE} = 10V$ $f = 100\text{MHz}$	200			MHz
Turn On Time	t_{on}	$V_{CC} = 30V, V_{EB} = 2V$ $I_C = 150\text{mA}, I_{B1} = 15\text{mA}$			35	ns
Turn Off Time	t_{off}	$V_{CC} = 30V, I_C = 150\text{mA}$ $I_{B1} = I_{B2} = 15\text{mA}$			255	ns

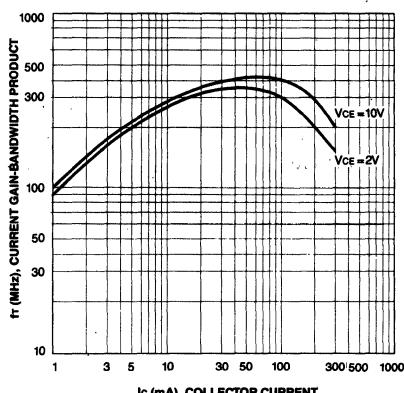
* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

DC CURRENT GAIN

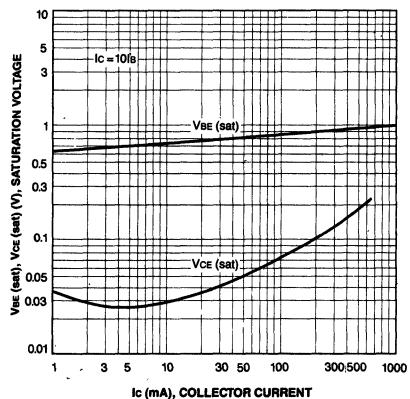


I_c (mA), COLLECTOR CURRENT
COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE

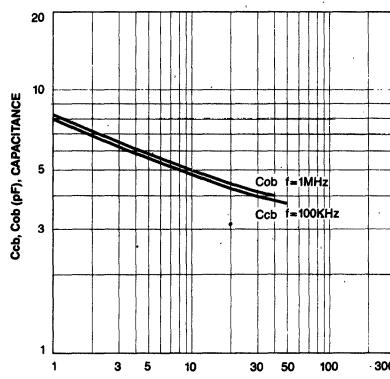
CURRENT GAIN-BANDWIDTH PRODUCT



I_c (mA), COLLECTOR CURRENT
COLLECTOR-BASE CAPACITANCE
OUTPUT CAPACITANCE



I_c (mA), COLLECTOR CURRENT



V_{cb} (V), COLLECTOR-BASE VOLTAGE



GENERAL PURPOSE TRANSISTOR

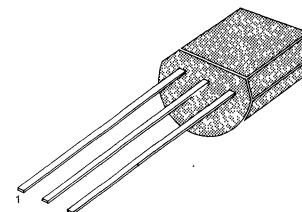
- Collector-Emitter Voltage: $V_{CEO}=40V$
- Collector Dissipation: $P_c \text{ (max)}=625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_c	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N4400 for graphs

TO-92



1. Emitter 2 Base 3 Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_E=0$	60			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=1\text{mA}, I_B=0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_c=0$	6			V
Collector Cut-off Current	I_{CEX}	$V_{CE}=35V, V_{EB}=0.4V$			100	nA
*DC Current Gain	h_{FE}	$I_c=0.1\text{mA}, V_{CE}=1\text{V}$ $I_c=1\text{mA}, V_{CE}=1\text{V}$ $I_c=10\text{mA}, V_{CE}=1\text{V}$ $I_c=150\text{mA}, V_{CE}=1\text{V}$ $I_c=500\text{mA}, V_{CE}=2\text{V}$ $I_c=150\text{mA}, I_B=15\text{mA}$	20 40 80 100 40		300	
*Collector-Emitter Saturation Voltage	$V_{CE} \text{ (sat)}$	$I_c=150\text{mA}, I_B=50\text{mA}$ $I_c=500\text{mA}, I_B=50\text{mA}$			0.4 0.75	V
*Base-Emitter Saturation Voltage	$V_{BE} \text{ (sat)}$	$I_c=150\text{mA}, I_B=15\text{mA}$ $I_c=500\text{mA}, I_B=50\text{mA}$	0.75		0.95 1.2	V
Collector-Base Capacitance	C_{cb}	$V_{CB}=5\text{V}, I_E=0$ $f=100\text{KHz}$			6.5	pF
Current Gain Bandwidth Product	f_T	$I_c=20\text{mA}, V_{CE}=10\text{V}$ $f=100\text{MHz}$	250			MHz
Turn On Time	t_{on}	$V_{CC}=30\text{V}, V_{EB}=2\text{V}$ $I_c=150\text{mA}, I_{B1}=15\text{mA}$			35	ns
Turn Off Time	t_{off}	$V_{CC}=30\text{V}, I_c=150\text{mA}$ $I_{B1}=I_{B2}=15\text{mA}$			255	ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



SAMSUNG SEMICONDUCTOR

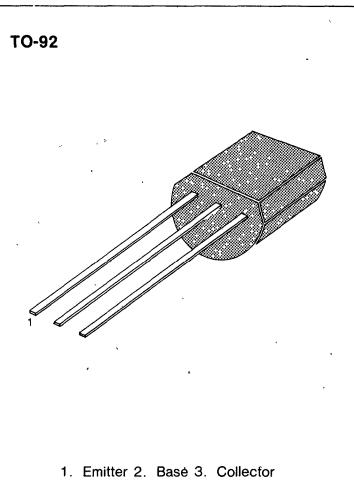
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO}=40V$
- Collector Dissipation: $P_c \text{ (max)}=625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N4403 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 0.1\text{mA}, I_E = 0$	40			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 1\text{mA}, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 0.1\text{mA}, I_C = 0$	5			V
Collector Cut-off Current	I_{CEX}	$V_{CE} = 35V, V_{BE} = 0.4V$			100	nA
Base Cut-off Current	I_{BEV}	$V_{CE} = 35V, V_{BE} = 0.4V$			100	nA
DC Current Gain	h_{FE}	$I_c = 1\text{mA}, V_{CE} = 1V$ $I_c = 10\text{mA}, V_{CE} = 1V$ * $I_c = 150\text{mA}, V_{CE} = 2V$ * $I_c = 500\text{mA}, V_{CE} = 2V$	30 50 50 20		150	
*Collector-Emitter Saturation Voltage	$V_{CE} \text{ (sat)}$	$I_c = 150\text{mA}, I_B = 15\text{mA}$ $I_c = 500\text{mA}, I_B = 50\text{mA}$			0.4 0.75	V
*Base-Emitter Saturation Voltage	$V_{BE} \text{ (sat)}$	$I_c = 150\text{mA}, I_B = 15\text{mA}$ $I_c = 500\text{mA}, I_B = 50\text{mA}$	0.75		0.95 1.3	V
Current Gain Bandwidth Product	f_T	$I_c = 20\text{mA}, V_{CE} = 10V$ $f = 100\text{MHz}$	150			MHz
Collector-Base Capacitance	C_{cb}	$V_{CB} = 10V, I_E = 0$ $f = 140\text{KHz}$			8.5	pF
Turn On Time	t_{on}	$V_{CC} = 30V, I_c = 150\text{mA}$ $I_{B1} = 15\text{mA}, V_{BE} = 2.0V$			35	ns
Turn Off Time	t_{off}	$V_{CC} = 30V, I_c = 150\text{mA}$ $I_{B1} = I_{B2} = 15\text{mA}$			255	ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



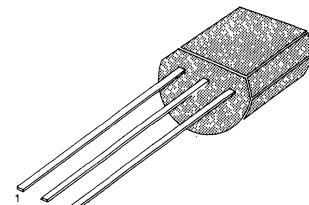
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



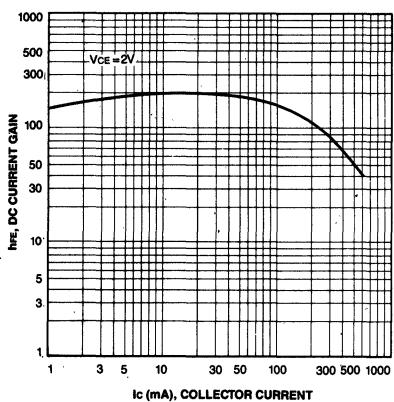
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

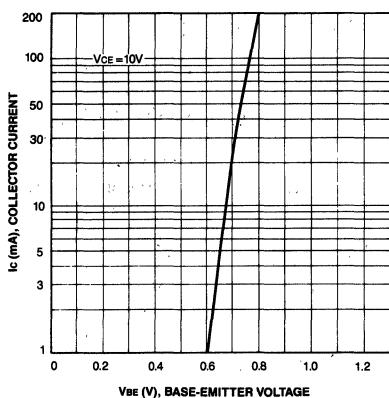
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 0.1\text{mA}, I_E = 0$	40			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 0.1\text{mA}, I_C = 0$	5			V
Collector Cut-off Current	I_{CEX}	$V_{CE} = 35V, V_{BE} = 0.4V$			100	nA
Base Cut-off Current	I_{SEV}	$V_{CE} = 35V, V_{BE} = 0.4V$			100	nA
DC Current Gain	h_{FE}	$I_C = 0.1\text{mA}, V_{CE} = 1V$ $I_C = 1\text{mA}, V_{CE} = 1V$ $I_C = 10\text{mA}, V_{CE} = 1V$ * $I_C = 150\text{mA}, V_{CE} = 2V$ * $I_C = 500\text{mA}, V_{CE} = 2V$ $I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$	30 60 100 100 20		300	
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$			0.4 0.75	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$	0.75		0.95 1.3	V
Current Gain Bandwidth Product	f_T	$I_C = 20\text{mA}, V_{CE} = 10V$ $f = 100\text{MHz}$	200			MHz
Collector-Base Capacitance	C_{cb}	$V_{CB} = 10V, I_E = 0$ $f = 140\text{KHz}$			8.5	pF
Turn On Time	t_{on}	$V_{CC} = 30V, I_C = 150\text{mA}$ $I_{B1} = 15\text{mA}, V_{BE} = 2.0V$			35	ns
Turn Off Time	t_{off}	$V_{CC} = 30V, I_C = 150\text{mA}$ $I_{B1} = I_{B2} = 15\text{mA}$			255	ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

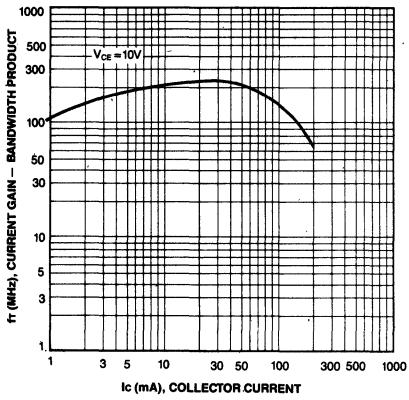
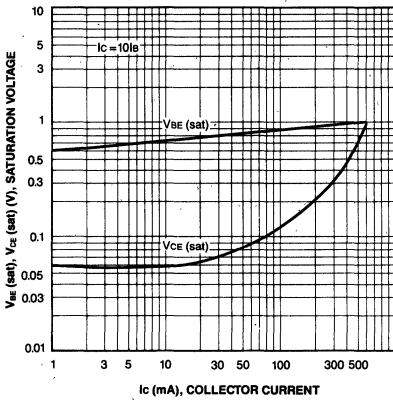
DC CURRENT GAIN



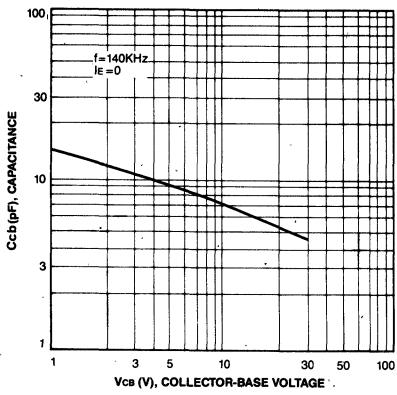
BASE-EMITTER ON VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR-BASE CAPACITANCE



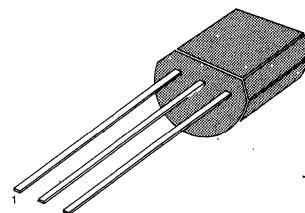
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 50V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Current	I_c	50	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

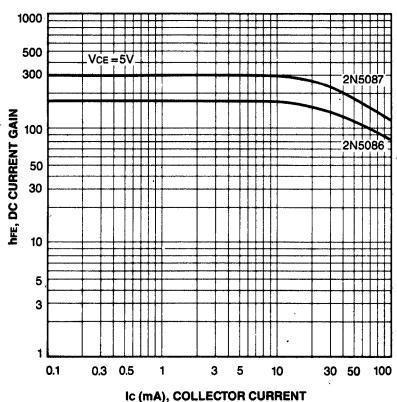
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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

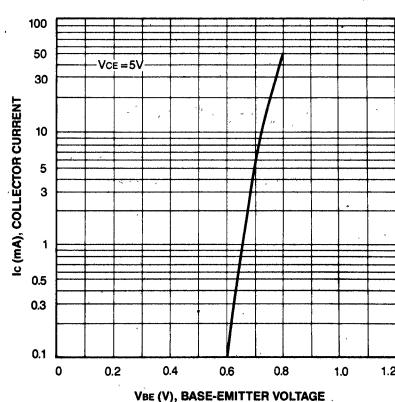
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu\text{A}, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 1\text{mA}, I_E = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 10V, I_E = 0$			10	nA
		$V_{CB} = 35V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_c = 0$		50		nA
DC Current Gain	h_{FE}	$I_c = 100\mu\text{A}, V_{CE} = 5V$ $I_c = 1\text{mA}, V_{CE} = 5V$	150		500	
		* $I_c = 10\text{mA}, V_{CE} = 5V$	150			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_c = 10\text{mA}, I_B = 1\text{mA}$			0.3	V
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_c = 1\text{mA}, V_{CE} = 5V$			0.85	V
Current Gain Bandwidth Product	f_T	$I_c = 500\mu\text{A}, V_{CE} = 5V$ $f = 20\text{MHz}$	40			MHz
Collector-Base Capacitance	C_{cb}	$V_{CB} = 5V, I_E = 0$ $f = 100\text{KHz}$			4	pF
Noise Figure	NF	$I_c = 20\mu\text{A}, V_{CE} = 5V$ $R_s = 10K\Omega$ $f = 10\text{Hz to } 15.7\text{KHz}$ $I_c = 100\mu\text{A}, V_{CE} = 5V$ $R_s = 3K\Omega, f = 1\text{KHz}$			3	dB
					3	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

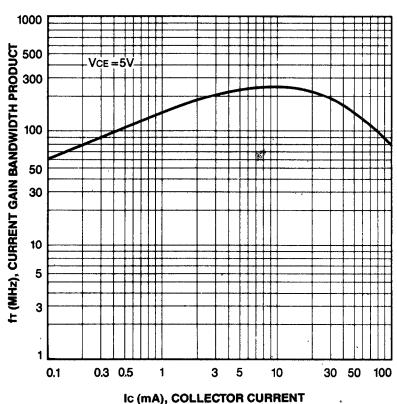
DC CURRENT GAIN



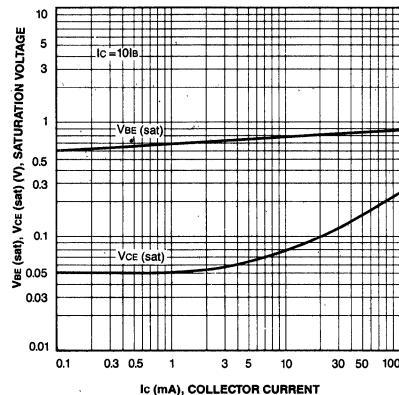
BASE-EMITTER ON VOLTAGE



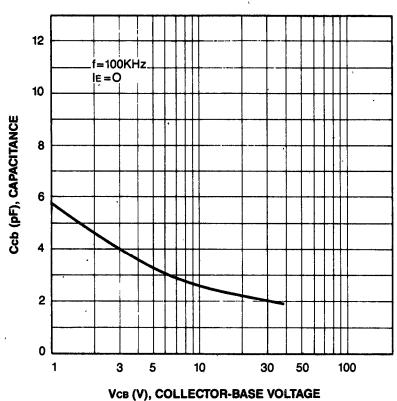
CURRENT GAIN BANDWIDTH PRODUCT



BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



COLLECTOR-BASE CAPACITANCE



AMPLIFIER TRANSISTOR

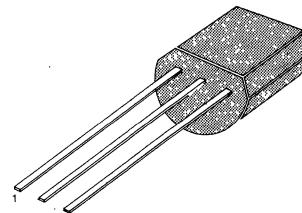
- Collector-Emitter Voltage: $V_{CEO} = 50V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Current	I_C	50	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* Refer to 2N5086 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	50			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_E = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 10V, I_E = 0$			10	nA
Emitter Cut-off Current	I_{EBO}	$V_{CB} = 35V, I_E = 0$			50	nA
DC Current Gain	h_{FE}	$V_{BE} = 3V, I_C = 0$	250	50	800	nA
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100\mu\text{A}, V_{CE} = 5V$				V
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 1\text{mA}, V_{CE} = 5V$	250			V
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 5V$		0.3	0.85	MHz
Collector-Base Capacitance	C_{cb}	$I_C = 10\text{mA}, I_B = 1\text{mA}$	40			pF
Noise Figure	NF	$I_C = 1\text{mA}, V_{CE} = 5V$ $R_S = 10K\Omega$ $f = 10\text{Hz}$ to 15.7KHz $I_C = 100\mu\text{A}, V_{CE} = 5V$ $R_S = 3K\Omega, f = 1\text{KHz}$			2	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



SAMSUNG SEMICONDUCTOR

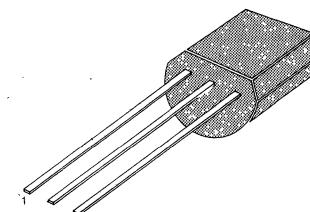
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 30V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	35	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4.5	V
Collector Current	I_c	50	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

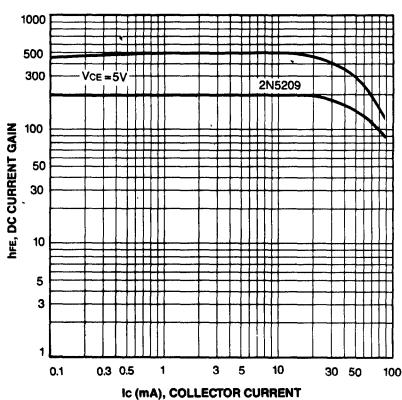
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu\text{A}, I_E = 0$	35			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 1\text{mA}, I_E = 0$	30			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20V, I_E = 0$		50		nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$ $V_{BE} = 4.5V, I_C = 0$		50		nA
DC Current Gain	h_{FE}	$I_c = 100\mu\text{A}, V_{CE} = 5V$ $I_c = 1\text{mA}, V_{CE} = 5V$ * $I_c = 10\text{mA}, V_{CE} = 5V$	300 350 300	900		nA
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c = 10\text{mA}, I_E = 1\text{mA}$		0.5		V
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c = 10\text{mA}, V_{CE} = 5V$		0.8		V
Current Gain Bandwidth Product	f_T	$I_c = 500\mu\text{A}, V_{CE} = 5V$ $f = 20\text{MHz}$ $f = 100\text{KHz}$	50			MHz
Collector Base Capacitance	C_{cb}	$V_{CB} = 5V, I_E = 0$ $f = 100\text{KHz}$		4		pF
Noise Figure	NF	$I_c = 100\mu\text{A}, V_{CE} = 5V$ $R_s = 10\text{K}\Omega$ $f = 10\text{Hz to } 15.7\text{KHz}$		3		dB

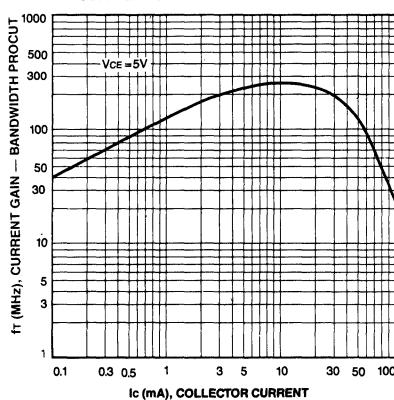
* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

SAMSUNG SEMICONDUCTOR

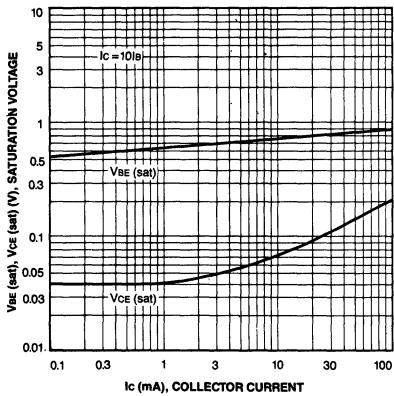
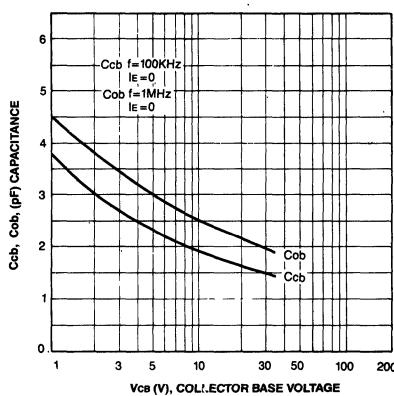
DC CURRENT GAIN



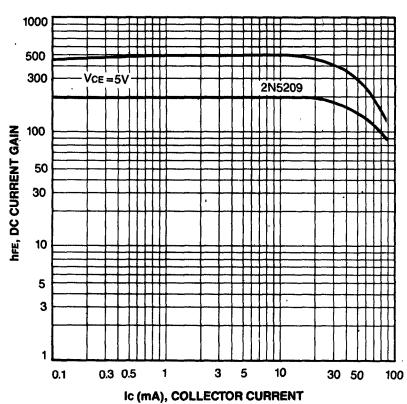
CURRENT GAIN BANDWIDTH PRODUCT



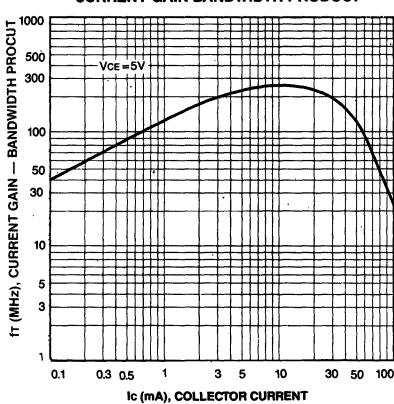
3

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGEOUTPUT CAPACITANCE
COLLECTOR-BASE CAPACITANCE

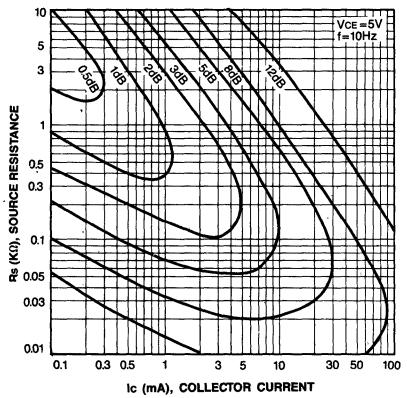
DC CURRENT GAIN



CURRENT GAIN BANDWIDTH PRODUCT



NOISE FIGURE



AMPLIFIER TRANSISTOR

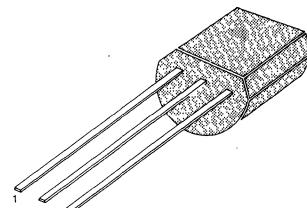
- Collector-Emitter Voltage: $V_{CEO}=25V$
- Collector Dissipation: $P_C(\max)=625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4.5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N5088 for graphs

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1 Emitter 2. Base 3. Collector

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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	30			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1mA, I_B=0$	25			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=15V, I_E=0$		50		nA
Emitter Cut-off Current	I_{EBO}	$V_{BE}=3V, I_C=0$		50		nA
DC Current Gain	h_{FE}	$V_{BE}=4.5V, I_C=0$ $I_C=100\mu A, V_{CE}=5V$ $I_C=1mA, V_{CE}=5V$	400 450 400	100 1200		nA
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$*I_C=10mA, V_{CE}=5V$			0.5	V
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=10mA, I_B=1mA$			0.8	V
Current Gain Bandwidth Product	f_T	$I_C=10mA, V_{CE}=5V$ $I_C=500\mu A, V_{CE}=5V$ $f=20MHz$	50			MHz
Collector Base Capacitance	C_{cb}	$V_{CB}=5V, I_E=0$ $f=100KHz$			4	pF
Noise Figure	NF	$I_C=100\mu A, V_{CE}=5V$ $R_S=10K\Omega$ $f=10Hz \text{ to } 15.7KHz$			2	dB

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$ 

AMPLIFIER TRANSISTOR

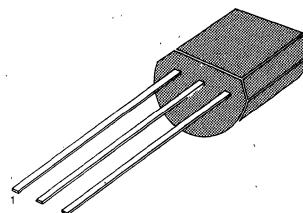
- Collector-Emitter Voltage: $V_{CEO} = 50V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	4.5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N5088 for graphs

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1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_E = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 35V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			50	nA
DC Current Gain	h_{FE}	$I_C = 100\mu\text{A}, V_{CE} = 5V$ $I_C = 1\text{mA}, V_{CE} = 5V$ * $I_C = 10\text{mA}, V_{CE} = 5V$	100 150 150		300	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$			0.7	V
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 1\text{mA}, V_{CE} = 5V$			0.85	V
Current Gain Bandwidth Product	f_T	$I_C = 500\mu\text{A}, V_{CE} = 5V$ $f = 20\text{MHz}$	30			MHz
Collector Base Capacitance	C_{cb}	$V_{CB} = 5V, I_E = 0$ $f = 100\text{KHz}$			4	pF
Noise Figure	NF	$I_C = 20\mu\text{A}, V_{CE} = 5V$ $R_S = 22\text{K}\Omega$ $f = 10\text{Hz to } 15.7\text{KHz}$ $I_C = 20\mu\text{A}, V_{CE} = 5V$ $R_S = 10\text{K}\Omega, f = 1\text{KHz}$			3	dB
					4	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

AMPLIFIER TRANSISTOR

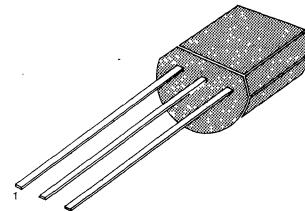
- Collector-Emitter Voltage: $V_{CEO} = 50V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	4.5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* Refer to 2N5088 for graphs

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1. Emitter 2. Base 3. Collector

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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	50			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 35V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			50	nA
DC Current Gain	h_{FE}	$I_C = 100\mu\text{A}, V_{CE} = 5V$ $I_C = 1\text{mA}, V_{CE} = 5V$ * $I_C = 10\text{mA}, V_{CE} = 5V$	200 250 250		600	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_E = 1\text{mA}$			0.7	V
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 1\text{mA}, V_{CE} = 5V$			0.85	V
Current Gain Bandwidth Product	f_T	$I_C = 500\mu\text{A}, V_{CE} = 5V$ $f = 20\text{MHz}$	30			MHz
Collector Base Capacitance	C_{cb}	$V_{CB} = 5V, I_E = 0$ $f = 100\text{KHz}$			4	pF
Noise Figure	NF	$I_C = 20\mu\text{A}, V_{CE} = 5V$ $R_S = 22\text{K}\Omega$ $f = 10\text{Hz to } 15.7\text{KHz}$ $I_C = 20\mu\text{A}, V_{CE} = 5V$ $R_S = 10\text{K}\Omega, f = 1\text{KHz}$			2 3	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



AMPLIFIER TRANSISTOR

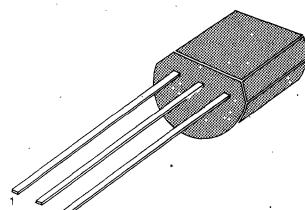
- Collector-Base Voltage: $V_{CEO} = 120V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	130	V
Collector-Emitter Voltage	V_{CEO}	120	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* Refer to 2N5401 for graphs

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1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	130			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	120			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 100\text{V}, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 1\text{mA}, V_{CE} = 5\text{V}$ $I_C = 10\text{mA}, V_{CE} = 5\text{V}$ $I_C = 50\text{mA}, V_{CE} = 5\text{V}$	30 40 40		180	
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$			0.2 0.5	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$			1 1	V
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 10\text{V}$ $f = 100\text{MHz}$	100		400	MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$			6	pF
Noise Figure	NF	$I_C = 250\mu\text{A}, V_{CE} = 5\text{V}$ $R_S = 1\text{k}\Omega$ $f = 10\text{Hz to } 15.7\text{KHz}$			8	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



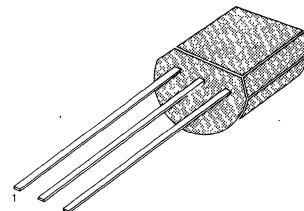
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 150V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	160	V
Collector-Emitter Voltage	V_{CEO}	150	V
Emitter-Base Voltage*	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

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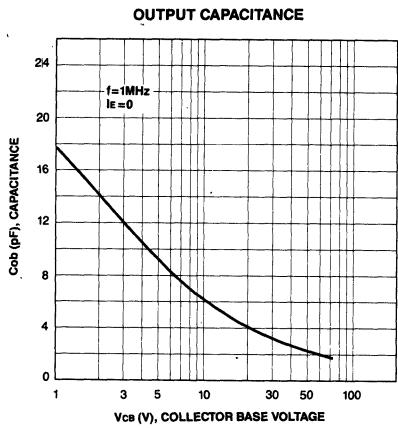
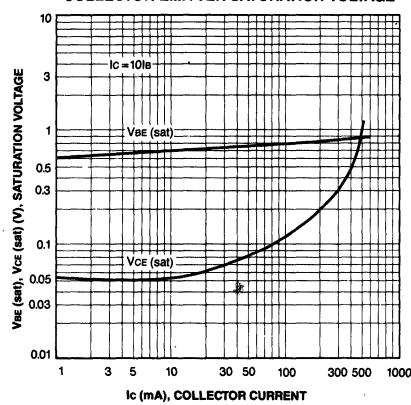
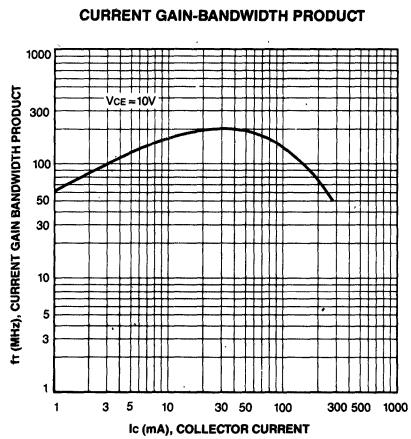
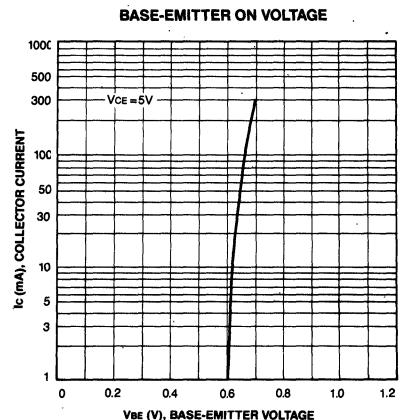
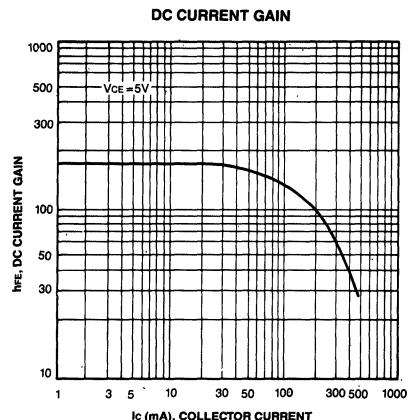
1 Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	160			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	150			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 120V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 3V, I_C = 0$		50		nA
*DC Current Gain	h_{FE}	$I_C = 1\text{mA}, V_{CE} = 5V$ $I_C = 10\text{mA}, V_{CE} = 5V$ $I_C = 50\text{mA}, V_{CE} = 5V$	50 60 50		240	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_E = 1\text{mA}$ $I_C = 50\text{mA}, I_E = 5\text{mA}$			0.2 0.5	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$			1 1	V
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 10V$ $f = 100\text{MHz}$	100		300	MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1\text{MHz}$			6	pF
Noise Figure	NF	$I_C = 250\mu\text{A}, V_{CE} = 5V$ $R_S = 1K\Omega$ $f = 10\text{Hz to } 15.7\text{KHz}$			8	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 



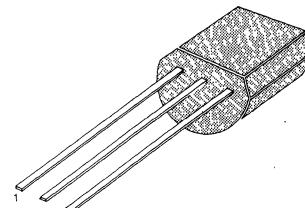
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 140V$
- Collector Dissipation: P_C (max) = 625mW

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	160	V
Collector-Emitter Voltage	V_{CEO}	140	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

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1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	160			V
*Collector-Emitter Saturation Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	140			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CE} = 100V, I_E = 0$		100		nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 4V, I_C = 0$		50		nA
*DC Current Gain	h_{FE}	$I_C = 1mA, V_{CE} = 5V$ $I_C = 10mA, V_{CE} = 5V$ $I_C = 50mA, V_{CE} = 5V$	60 60 20			
		$I_C = 10mA, I_B = 1mA$ $I_C = 50mA, I_B = 5mA$		0.15 0.25		V
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$ $I_C = 50mA, I_B = 5mA$		1 1.2		V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$ $I_C = 50mA, I_B = 5mA$		300		MHz
Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 10V$ $f = 100MHz$	100			
Output Capacitance	C_{ob}	$V_{CE} = 10V, I_E = 0$ $f = 1MHz$			6	pF
Noise Figure	NF	$I_C = 250\mu A, V_{CE} = 5V$ $R_S = 1K\Omega$ $f = 10Hz \text{ to } 15.7KHz$			10	dB

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$ 

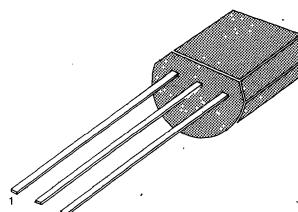
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 160V$
- Collector Dissipation: $P_C(\max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	180	V
Collector-Emitter Voltage	V_{CEO}	160	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$

TO-92



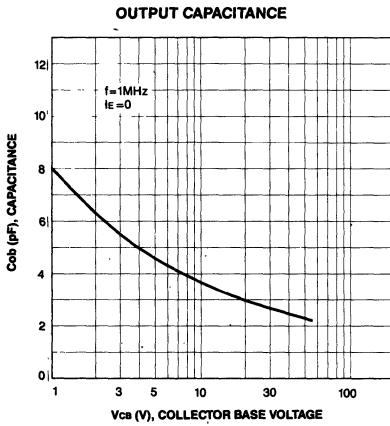
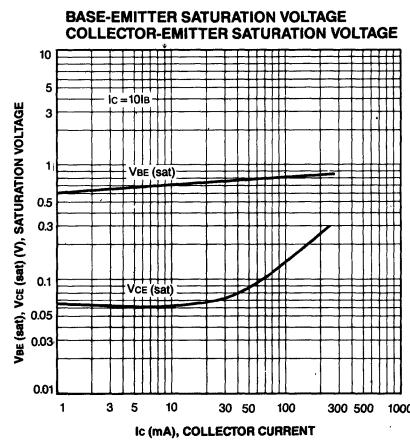
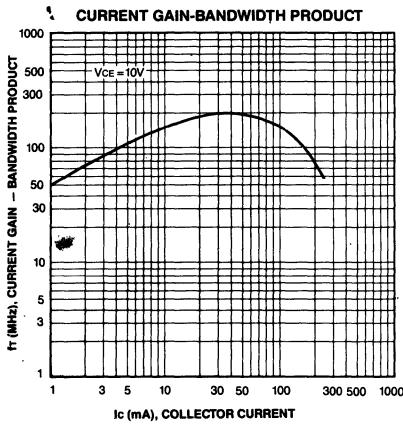
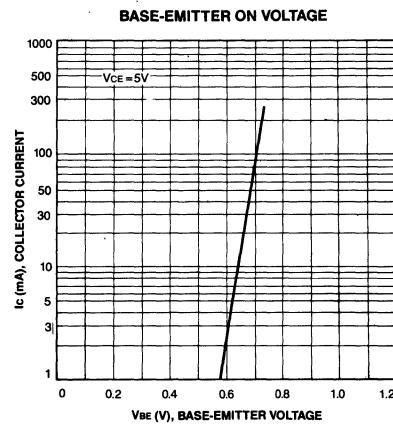
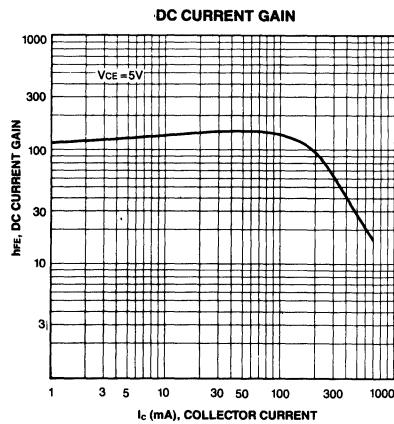
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	180			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	160			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 120V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 4V, I_C = 0$		50		nA
*DC Current Gain	h_{FE}	$I_C = 1mA, V_{CE} = 5V$	80			
		$I_C = 10mA, V_{CE} = 5V$	80		250	
		$I_C = 50mA, V_{CE} = 5V$	30			
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10mA, I_B = 1mA$		0.15		V
		$I_C = 50mA, I_B = 5mA$		0.2		V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10mA, I_B = 1mA$		1		V
		$I_C = 50mA, I_B = 5mA$		1		V
Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 10V$	100		300	MHz
Output Capacitance	C_{OB}	$f = 100MHz$			6	pF
Noise Figure	NF	$V_{CB} = 10V, I_E = 0$			8	dB
		$f = 1MHz$				
		$I_C = 250\mu A, V_{CE} = 5V$				
		$R_S = 1K\Omega$				
		$f = 10Hz \text{ to } 15.7KHz$				

*Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$ 

SAMSUNG SEMICONDUCTOR



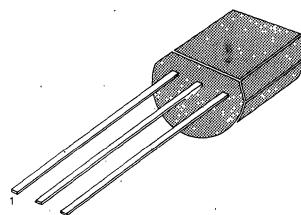
DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	40	V
Collector-Base Voltage	V_{CBO}	40	V
Emitter-Base Voltage	V_{EBO}	12	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

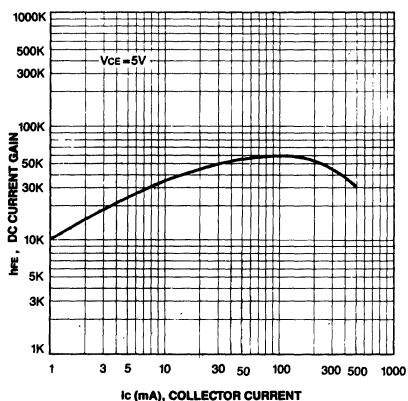
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 10\text{mA}, I_E = 0$	40			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu\text{A}, I_E = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_c = 0$	12			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$		50	nA	
Collector Cut-off Current	I_{CEO}	$V_{CE} = 25V, I_B = 0$		1	μA	
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_c = 0$		50	nA	
*DC Current Gain	h_{FE}	$I_c = 10\text{mA}, V_{CE} = 5V$ $I_c = 100\text{mA}, V_{CE} = 5V$ $I_c = 500\text{mA}, V_{CE} = 5V$	10K 20K 14K	100K 200K 140K		
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_c = 50\text{mA}, I_E = 0.5\text{mA}$ $I_c = 500\text{mA}, I_E = 0.5\text{mA}$		0.71 0.9	1.2 1.5	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_c = 500\text{mA}, I_E = 0.5\text{mA}$		1.52	2	V
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_c = 50\text{mA}, V_{CE} = 5V$		1.24	1.75	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1\text{MHz}$		5.4	7	pF
Noise Figure	NF	$I_c = 1\text{mA}, V_{CE} = 5V$ $R_s = 100\text{K}\Omega$ $f = 10\text{KHz to } 15.7\text{ KHz}$		3	10	dB

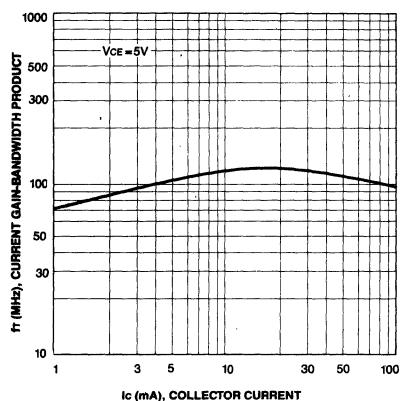
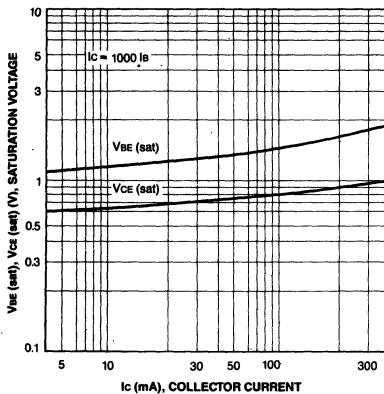
*Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

SAMSUNG SEMICONDUCTOR

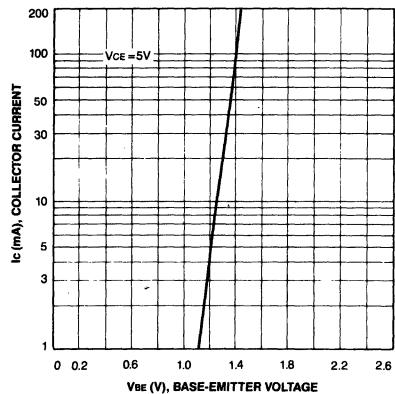
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

BASE-EMITTER ON VOLTAGE



AMPLIFIER TRANSISTOR

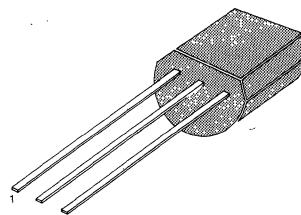
- Collector-Emitter Voltage: $V_{CEO} = 50V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_c	200	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N5088 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu\text{A}, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 1\text{mA}, I_B = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			10	nA
Collector Cut-off Current	I_{CEO}	$V_{CE} = 30V, I_B = 0$			25	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 5V, I_C = 0$			10	nA
DC Current Gain	β_{FE}	$I_c = 10\mu\text{A}, V_{CE} = 5V$ $I_c = 100\mu\text{A}, V_{CE} = 5V$ $I_c = 1\text{mA}, V_{CE} = 5V$ $I_c = 10\text{mA}, V_{CE} = 5V$	250 250 250 250		650	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_c = 10\text{mA}, I_B = 0.5\text{mA}$ $I_c = 100\text{mA}, I_B = 5\text{mA}$			0.2 0.6	V
* Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_c = 1\text{mA}, V_{CE} = 5V$	0.56		0.66	V
Current Gain Bandwidth Product	f_T	$I_c = 1\text{mA}, V_{CE} = 5V$	100		700	MHz
Output Capacitance	C_{OB}	$V_{CB} = 10V, I_E = 0$ $f = 1\text{MHz}$			3	pF
Noise Figure/Noise Voltage Level	NF/N_V	$I_c = 100\mu\text{A}, V_{CE} = 5V$ (1) $R_S = 10K\Omega, BW = 1\text{Hz}$ $f = 100\text{Hz}$ (2) $R_S = 50K\Omega, BW = 15.7\text{kHz}$ $f = 10\text{Hz} - 10\text{kHz}$ (3) $R_S = 500\Omega, BW = 1\text{Hz}$ $f = 10\text{Hz}$			3/18.1 6/5.7 3.5/4.3	dB/nV dB/ μ V dB/nV



AMPLIFIER TRANSISTOR

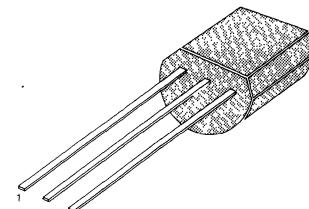
- Collector-Emitter Voltage: $V_{CEO} = 50V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N5088 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			10	nA
Collector Cut-off Current	I_{CEO}	$V_{CE} = 30V, I_B = 0$			25	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 5V, I_C = 0$			10	nA
DC Current Gain	β_{FE}	$I_C = 10\mu\text{A}, V_{CE} = 5V$ $I_C = 100\mu\text{A}, V_{CE} = 5V$ $I_C = 1\text{mA}, V_{CE} = 5V$ $I_C = 10\text{mA}, V_{CE} = 5V$	250 250 250 250		650	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 0.5\text{mA}$ $I_C = 100\text{mA}, I_B = 5\text{mA}$ $I_C = 1\text{mA}, V_{CE} = 5V$ $I_C = 10\text{mA}, V_{CE} = 5V$			0.2 0.6 0.66 700	V V V MHz
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C = 1\text{mA}, V_{CE} = 5V$	0.56			
Current Gain Bandwidth Product	f_T	$I_C = 1\text{mA}, V_{CE} = 5V$	100			
Output Capacitance	C_{OB}	$V_{CE} = 10V, I_E = 0$ $f = 100\text{MHz}$ $f = 1\text{MHz}$			3	pF
Noise Figure/Noise Voltage Level	NF/N _V	$I_C = 100\mu\text{A}, V_{CE} = 5V$ (1) $R_S = 10\text{K}\Omega, BW = 1\text{Hz}$ $f = 100\text{Hz}$ (2) $R_S = 50\text{K}\Omega, BW = 15.7\text{kHz}$ $f = 10\text{Hz} - 10\text{kHz}$ (3) $R_S = 50\Omega, BW = 1\text{Hz}$ $f = 10\text{Hz}$			2/16.2 4/4.6 3/4.1	dB/nV dB/ μV dB/nV



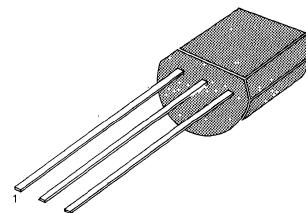
HIGH VOLTAGE TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 250V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	250	V
Collector-Emitter Voltage	V_{CEO}	250	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92

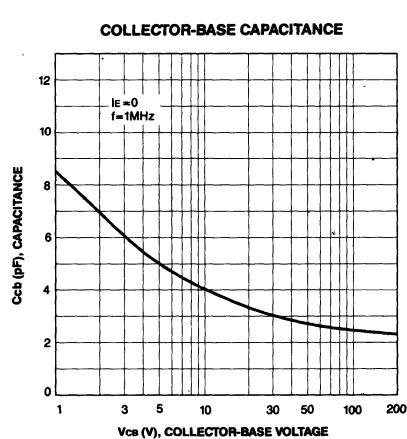
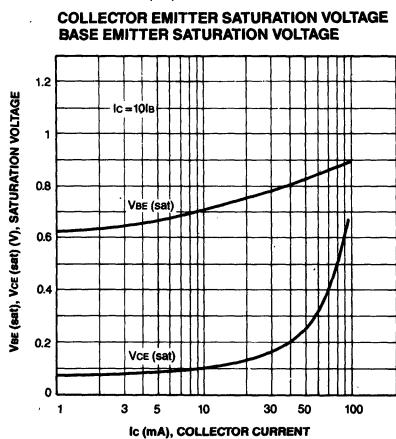
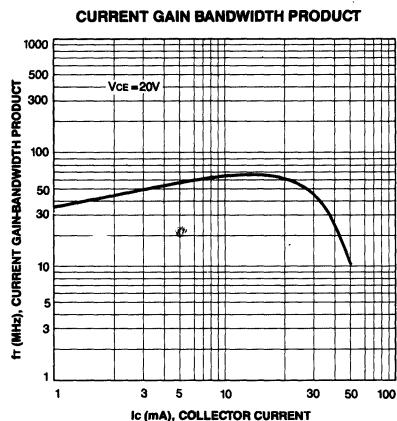
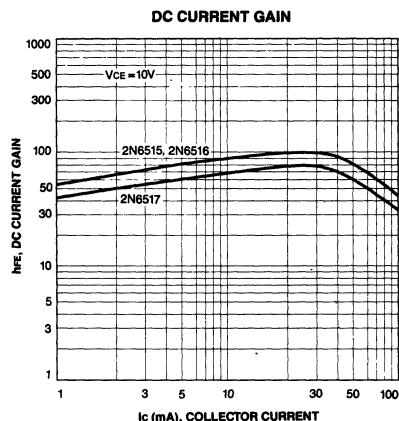


1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_E = 0$	250			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	250			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 150V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 5V, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 1\text{mA}, V_{CE} = 10V$ $I_C = 10\text{mA}, V_{CE} = 10V$ $I_C = 30\text{mA}, V_{CE} = 10V$ $I_C = 50\text{mA}, V_{CE} = 10V$ $I_C = 100\text{mA}, V_{CE} = 10V$	35 50 50 45 25		300 220	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 20\text{mA}, I_B = 2\text{mA}$ $I_C = 30\text{mA}, I_B = 3\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$ $I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 20\text{mA}, I_B = 2\text{mA}$ $I_C = 30\text{mA}, I_B = 3\text{mA}$ $V_{CB} = 20V, I_E = 0$			0.3 0.35 0.5 1 0.75 0.85 0.9 6	V V V V V V V pF
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 20\text{mA}, I_B = 2\text{mA}$ $I_C = 30\text{mA}, I_B = 3\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$ $I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 20\text{mA}, I_B = 2\text{mA}$ $I_C = 30\text{mA}, I_B = 3\text{mA}$ $V_{CB} = 20V, I_E = 0$			0.75 0.85 0.9 1 0.75 0.85 0.9 6	V V V V V V V MHz
Collector-Base Capacitance	C_{cb}	$f = 1\text{MHz}$				
*Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20V$ $f = 20\text{MHz}$	40		200	MHz
Base Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100\text{mA}, V_{CE} = 10V$			2	V

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 



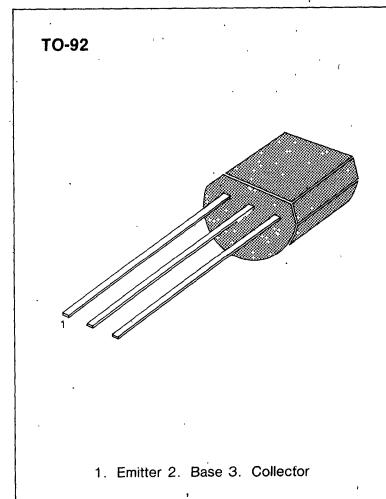
HIGH VOLTAGE TRANSISOTR

- Collector-Emitter Voltage: $V_{CEO} = 300V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	300	V
Collector-Emitter Voltage	V_{CEO}	300	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N6515 for graphs

**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)**

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	300			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	300			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CE} = 200V, I_E = 0$			50	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5V, I_C = 0$			50	nA
*DC Current Gain	h_{FE}	$I_C = 1\text{mA}, V_{CE} = 10V$ $I_C = 10\text{mA}, V_{CE} = 10V$ $I_C = 30\text{mA}, V_{CE} = 10V$ $I_C = 50\text{mA}, V_{CE} = 10V$ $I_C = 100\text{mA}, V_{CE} = 10V$	30 45 45 40 20		270 200	nA
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 20\text{mA}, I_B = 2\text{mA}$ $I_C = 30\text{mA}, I_B = 3\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$ $I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 20\text{mA}, I_B = 2\text{mA}$ $I_C = 30\text{mA}, I_B = 3\text{mA}$			0.3 0.35 0.5 1 0.75 0.85 0.9	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 50\text{mA}, I_B = 5\text{mA}$ $I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 20\text{mA}, I_B = 2\text{mA}$ $I_C = 30\text{mA}, I_B = 3\text{mA}$			6	pF
Collect-Base Capacitance	C_{cb}	$V_{CB} = 20V, I_E = 0$ $f = 1\text{MHz}$			200	MHz
*Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20V$ $f = 20\text{MHz}$	40		200	MHz
Base Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100\text{mA}, V_{CE} = 10V$			2	V

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



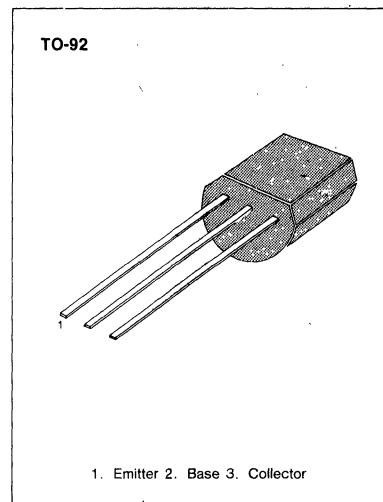
HIGH VOLTAGE TRANSISOTR

- Collector-Emitter Voltage: $V_{CEO} = 350V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	350	V
Collector-Emitter Voltage	V_{CEO}	350	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N6515 for graphs



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_E = 0$	350			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	350			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 250\text{V}, I_E = 0$		50	nA	
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$		50	nA	
* DC Current Gain	h_{FE}	$I_C = 1\text{mA}, V_{CE} = 10\text{V}$ $I_C = 10\text{mA}, V_{CE} = 10\text{V}$ $I_C = 30\text{mA}, V_{CE} = 10\text{V}$ $I_C = 50\text{mA}, V_{CE} = 10\text{V}$ $I_C = 100\text{mA}, V_{CE} = 10\text{V}$	20 30 30 20 15	200 200		
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 20\text{mA}, I_B = 2\text{mA}$ $I_C = 30\text{mA}, I_B = 3\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$		0.3 0.35 0.5 1		V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$ $I_C = 20\text{mA}, I_B = 2\text{mA}$ $I_C = 30\text{mA}, I_B = 3\text{mA}$ $I_C = 50\text{mA}, I_B = 5\text{mA}$		0.75 0.85 0.9		V
Collector-Base Capacitance	C_{CB}	$V_{CB} = 20\text{V}, I_E = 0$ $f = 1\text{MHz}$		8		pF
* Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20\text{V}$ $f = 20\text{MHz}$	40		200	MHz
Base Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100\text{mA}, V_{CE} = 10\text{V}$		2		V

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

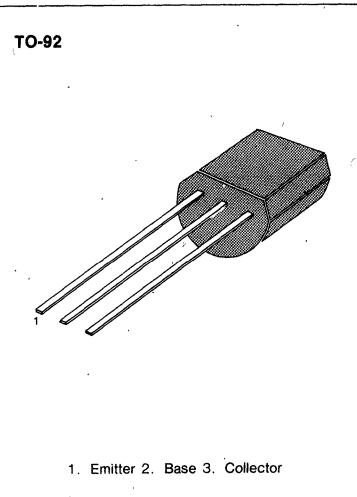


HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-250	V
Collector-Emitter Voltage	V_{CEO}	-250	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Base Current	I_B	-250	mA
Collector Dissipation	P_C	0.625	W
Derate above 25°C		5	$\text{mW}/^\circ\text{C}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55~150	$^\circ\text{C}$

- Refer to 2N6520 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-250		V
*Collector Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1\text{mA}, I_B = 0$	-250		V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E = -10\mu\text{A}, I_C = 0$	-5		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -150\text{V}, I_E = 0$		-50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -4\text{V}, I_C = 0$		-50	nA
*DC Current Gain	h_{FE}	$V_{CE} = -10\text{V}, I_C = -1\text{mA}$ $V_{CE} = -10\text{V}, I_C = -10\text{mA}$ $V_{CE} = -10\text{V}, I_C = -30\text{mA}$ $V_{CE} = -10\text{V}, I_C = -50\text{mA}$ $V_{CE} = -10\text{V}, I_C = -100\text{mA}$	35 50 50 45 25		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = -10\text{mA}, I_B = -1\text{mA}$ $I_C = -20\text{mA}, I_B = -2\text{mA}$ $I_C = -30\text{mA}, I_B = -3\text{mA}$ $I_C = -50\text{mA}, I_B = -5\text{mA}$ $I_C = -10\text{mA}, I_B = -1\text{mA}$ $I_C = -20\text{mA}, I_B = -2\text{mA}$ $I_C = -30\text{mA}, I_B = -3\text{mA}$	-0.30 -0.35 -0.50 -1 -0.75 -0.85 -0.90		V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$V_{CE} = -10\text{V}, I_C = -100\text{mA}$ $I_C = -10\text{mA}, I_B = -1\text{mA}$ $I_C = -20\text{mA}, I_B = -2\text{mA}$ $I_C = -30\text{mA}, I_B = -3\text{mA}$	-2		V
Base Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE} = -10\text{V}, I_C = -100\text{mA}$	40	200	MHz
*Current Gain Bandwidth Product	f_T	$V_{CE} = -20\text{V}, I_C = -10\text{mA}, f = 20\text{MHz}$		6	pF
Collector Base Capacitance	C_{cb}	$V_{CB} = -20\text{V}, I_E = 0, f = 1\text{MHz}$		100	pF
Emitter Base Capacitance	C_{eb}	$V_{EB} = -0.5\text{V}, I_C = 0, f = 1\text{MHz}$			
Turn On Time	t_{on}	$V_{BE}(\text{off}) = -2\text{V}, V_{CC} = -100\text{V}$ $I_C = -50\text{mA}, I_B1 = -10\text{mA}$		200	ns
Turn Off Time	t_{off}	$V_{CC} = -100\text{V}, I_C = -50\text{mA}$ $I_B1 = I_B2 = -10\text{mA}$		3.5	ns

* Pulse Test: $PW \leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



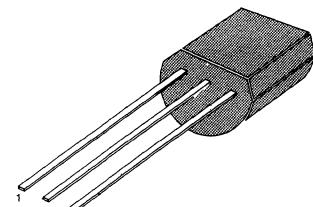
HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-300	V
Collector-Emitter Voltage	V_{CEO}	-300	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Base Current	I_B	-250	mA
Collector Dissipation	P_C	0.625	W
Derate above 25°C		5	mW/ $^\circ\text{C}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

- Refer to 2N6520 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-300		V
*Collector Emitter Breakdown Voltage	BV_{CEO}	$I_C=-1\text{mA}, I_B=0$	-300		V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E=-10\mu\text{A}, I_C=0$	-5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-200\text{V}, I_E=0$		-50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-4\text{V}, I_C=0$		-50	nA
* DC Current Gain	h_{FE}	$V_{CE}=-10\text{V}, I_C=-1\text{mA}$ $V_{CE}=-10\text{V}, I_C=-10\text{mA}$ $V_{CE}=-10\text{V}, I_C=-30\text{mA}$ $V_{CE}=-10\text{V}, I_C=-50\text{mA}$ $V_{CE}=-10\text{V}, I_C=-100\text{mA}$	30 45 45 40 20	270 200 -1	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=-10\text{mA}, I_B=-1\text{mA}$ $I_C=-20\text{mA}, I_B=-2\text{mA}$ $I_C=-30\text{mA}, I_B=-3\text{mA}$ $I_C=-50\text{mA}, I_B=-5\text{mA}$		-0.30 -0.35 -0.50 -1	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=-10\text{mA}, I_E=-1\text{mA}$ $I_C=-20\text{mA}, I_E=-2\text{mA}$ $I_C=-30\text{mA}, I_E=-3\text{mA}$		-0.75 -0.85 -0.90	V
Base Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=-10\text{V}, I_C=-100\text{mA}$		-2	V
*Current Gain Bandwidth Product	f_T	$V_{CE}=-20\text{V}, I_C=-10\text{mA}, f=20\text{MHz}$	40	200	MHz
Collector Base Capacitance	C_{cb}	$V_{CB}=-20\text{V}, I_E=0, f=1\text{MHz}$		6	pF
Emitter Base Capacitance	C_{eb}	$V_{EB}=-0.5\text{V}, I_C=0, f=1\text{MHz}$		100	pF
Turn On Time	t_{on}	$V_{BE}(\text{off})=-2\text{V}, V_{CC}=-100\text{V}$ $I_C=-50\text{mA}, I_B1=-10\text{mA}$		200	ns
Turn Off Time	t_{off}	$V_{CC}=-100\text{V}, I_C=-50\text{mA}$ $I_B1=I_B2=-10\text{mA}$		3.5	ns

* Pulse Test: PW≤300μs, Duty Cycle≤2%

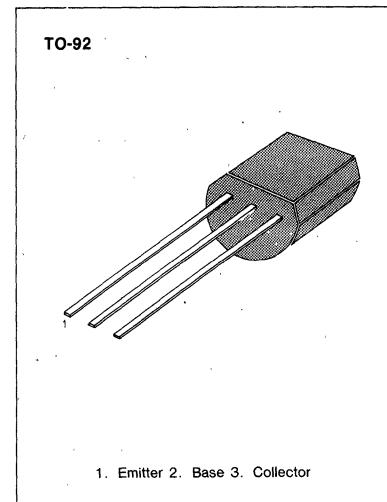


SAMSUNG SEMICONDUCTOR

HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

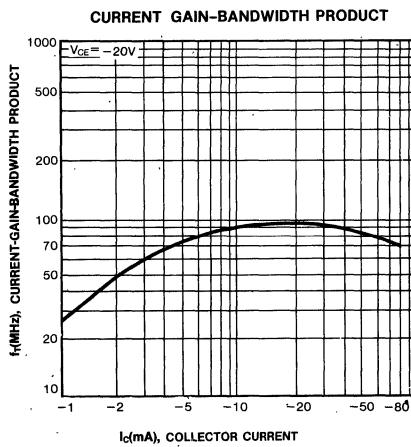
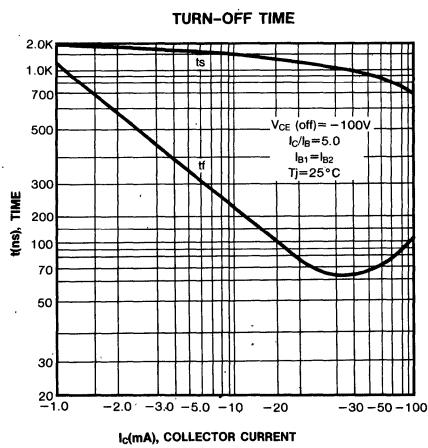
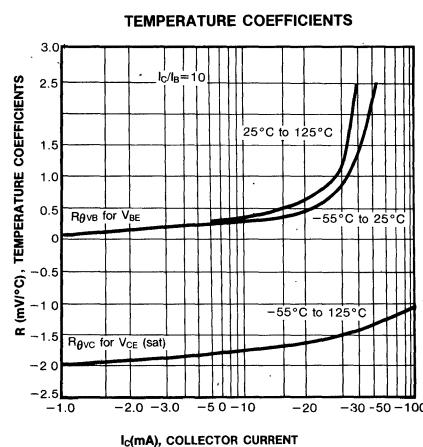
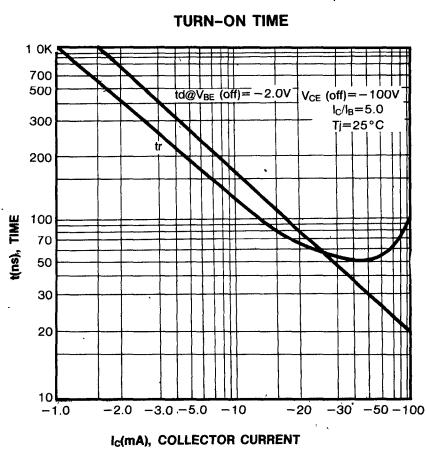
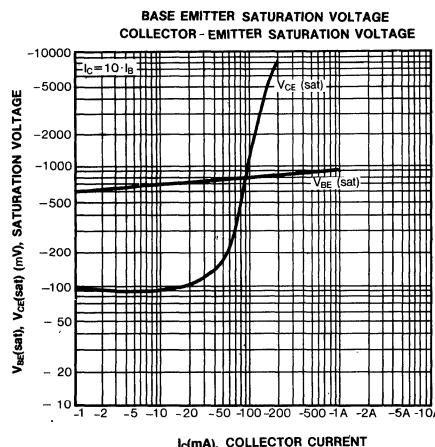
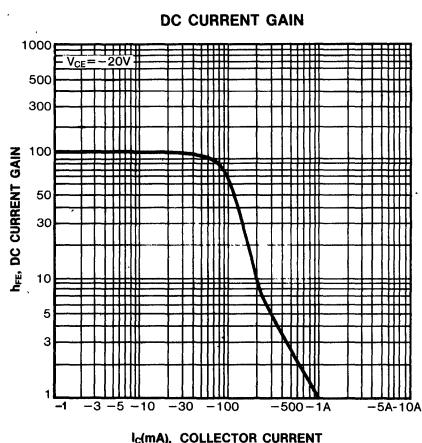
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-350	V
Collector-Emitter Voltage	V_{CEO}	-350	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Base Current	I_B	-250	mA
Collector Dissipation	P_C	0.625	W
Derate above 25°C		5	$\text{mW}/^\circ\text{C}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-350		V
*Collector Emitter Breakdown Voltage	BV_{CEO}	$I_C=-1\text{mA}, I_B=0$	-350		V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E=-10\mu\text{A}, I_C=0$	-5		V
Collector Cutoff Current	I_{CBO}	$V_{CE}=-250\text{V}, I_E=0$		-50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-4\text{V}, I_C=0$		-50	nA
*DC Current Gain	h_{FE}	$V_{CE}=-10\text{V}, I_C=-1\text{mA}$ $V_{CE}=-10\text{V}, I_C=-10\text{mA}$ $V_{CE}=-10\text{V}, I_C=-30\text{mA}$ $V_{CE}=-10\text{V}, I_C=-50\text{mA}$ $V_{CE}=-10\text{V}, I_C=-100\text{mA}$	20 30 30 20 15	200 200	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=-10\text{mA}, I_B=-1\text{mA}$ $I_C=-20\text{mA}, I_B=-2\text{mA}$ $I_C=-30\text{mA}, I_B=-3\text{mA}$ $I_C=-50\text{mA}, I_B=-5\text{mA}$		-0.30 -0.35 -0.50 -1	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=-10\text{mA}, I_B=-1\text{mA}$ $I_C=-20\text{mA}, I_B=-2\text{mA}$ $I_C=-30\text{mA}, I_B=-3\text{mA}$		-0.75 -0.85 -0.90	V
Base Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=-10\text{V}, I_C=-100\text{mA}$		-2	V
*Current Gain Bandwidth Product	f_T	$V_{CE}=-20\text{V}, I_C=-10\text{mA}, f=20\text{MHz}$	40	200	MHz
Collector Base Capacitance	C_{cb}	$V_{CB}=-20\text{V}, I_E=0, f=1\text{MHz}$		6	pF
Emitter Base Capacitance	C_{eb}	$V_{EB}=-0.5\text{V}, I_C=0, f=1\text{MHz}$		100	pF
Turn On Time	t_{on}	$V_{BE}(\text{off})=-2\text{V}, V_{CC}=-100\text{V}$ $I_C=-50\text{mA}, I_B1=-10\text{mA}$		200	ns
Turn Off Time	t_{off}	$V_{CC}=-100\text{V}, I_C=-50\text{mA}$ $I_B1=I_B2=-10\text{mA}$		3.5	ns

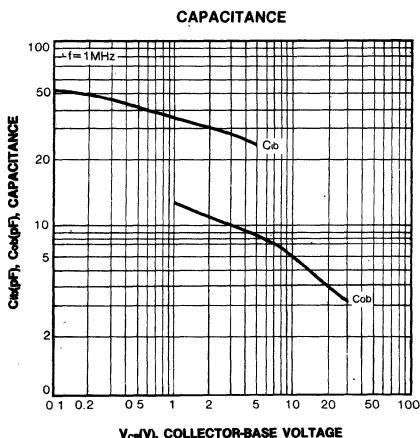
* Pulse Test: PW≤300μs, Duty Cycle≤2%





2N6520

PNP EPITAXIAL SILICON TRANSISTOR



SAMSUNG SEMICONDUCTOR

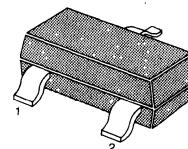
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23



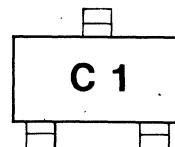
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

3

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=10\mu\text{A}, I_E=0$	30		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=2.0\text{mA}, I_B=0$	20		V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_c=100\mu\text{A}, V_{EB}=0$	30		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=2.0\text{mA}$	120	260	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{mA}, I_B=0.5\text{mA}$		0.3	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c=2.0\text{mA}, V_{CE}=5\text{V}$	0.6	0.75	V
Output Capacitance	C _{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		7	pF
Noise Figure	NF	$I_c=0.2\text{mA}, V_{CE}=5\text{V}$ $f=1\text{KHz}, R_S=2\text{K}\Omega$		10	dB

Marking



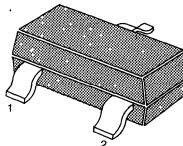
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

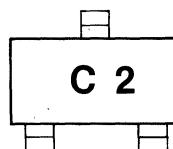


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	30		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2.0\text{mA}, I_B=0$	20		V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C=100\mu\text{A}, V_{EB}=0$	30		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=2.0\text{mA}$	215	500	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.5\text{mA}$		0.3	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2.0\text{mA}, V_{CE}=5\text{V}$	0.6	0.75	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		7	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$ $f=1\text{KHz}, R_S=2\text{K}\Omega$		10	dB

Marking



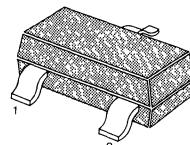
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5088 for graphs

SOT-23



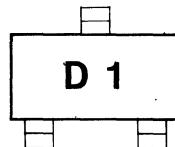
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	30		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2\text{mA}, I_E=0$	20		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=2.0\text{mA}$	110	220	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_E=0.5\text{mA}$		0.25	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2\text{mA}, V_{CE}=5\text{V}$	0.55	0.7	V
Output Capacitance	C _{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		4	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$ $R_S=2\text{K}\Omega, f=1\text{kHz}$		10	dB

Marking



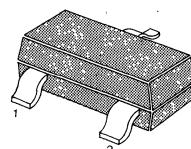
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5088 for graphs

SOT-23



1 Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=10\mu\text{A}, I_E=0$	30		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=2\text{mA}, I_B=0$	20		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=2.0\text{mA}$	200	450	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{mA}, I_B=0.5\text{mA}$		0.25	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c=2\text{mA}, V_{CE}=5\text{V}$	0.55	0.7	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		4	pF
Noise Figure	NF	$I_c=0.2\text{mA}, V_{CE}=5\text{V}$ $R_S=2\text{K}\Omega, f=1\text{kHz}$		10	dB

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

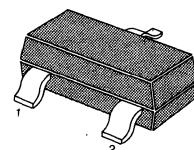
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT 5088 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=10\mu\text{A}, I_E=0$	30		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=2\text{mA}, I_B=0$	20		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=2.0\text{mA}$	420	800	
Collector-Emitter Saturation Voltage	V_{CE} (sat)	$I_c=10\text{mA}, I_B=0.5\text{mA}$		0.25	V
Base-Emitter On Voltage	V_{BE} (on)	$I_c=2\text{mA}, V_{CE}=5\text{V}$	0.55	0.7	V
Output Capacitance	C _{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		4	pF
Noise Figure	NF	$I_c=0.2\text{mA}, V_{CE}=5\text{V}$ $R_S=2\text{K}\Omega, f=1\text{KHz}$		10	dB

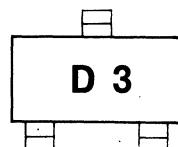
SOT-23



1. Base 2. Emitter 3. Collector

3

Marking



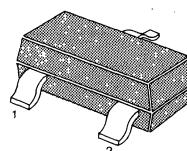
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	32	V
Collector-Emitter Voltage	V_{CEO}	32	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT3904 for graphs

SOT-23

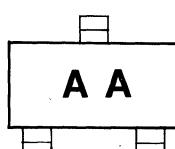


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2.0\text{mA}, I_B=0$	32		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1.0\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current		$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
Emitter Cutoff Current		$V_{EB}=4\text{V}, I_C=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=2.0\text{mA}$	120	220	
		$V_{CE}=5\text{V}, I_C=50\text{mA}$	60		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=50\text{mA}, I_B=1.25\text{mA}$		0.55	V
		$I_C=10\text{mA}, I_B=0.25\text{mA}$		0.35	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=50\text{mA}, I_B=1.25\text{mA}$	0.7	1.05	V
		$I_C=50\text{mA}, I_B=0.25\text{mA}$	0.6	0.85	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=5\text{V}, I_C=2.0\text{mA}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=5\text{V}$	125		MHz
		$f=1\text{MHz}$			
Output Capacitance	C_{ob}	$V_{CE}=10\text{V}, I_E=0$		4.5	pF
		$f=1.0\text{MHz}$			
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$		6	dB
		$R_S=2\text{K}\Omega, f=1\text{kHz}$			
Turn On Time	t_{on}	$I_C=10\text{mA}, I_{B1}=1\text{mA}$		150	ns
Turn Off Time	t_{off}	$V_{BB}=3.6\text{V}, I_{B2}=1\text{mA}$		800	ns
		$R_1=R_2=5\text{K}\Omega, R_L=990\Omega$			

Marking



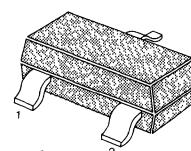
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	32	V
Collector-Emitter Voltage	V_{CEO}	32	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT3904 for graphs

SOT-23



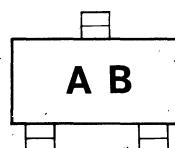
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

3

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=2.0\text{mA}, I_E=0$	32		V
Emitter-Base Breakdown Voltage	BV_{FBO}	$I_E=1.0\mu\text{A}, I_c=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_c=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=10\mu\text{A}$ $V_{CE}=5\text{V}, I_c=2.0\text{mA}$	20 180	310	
		$V_{CE}=1\text{V}, I_c=50\text{mA}$	70		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=50\text{mA}, I_B=1.25\text{mA}$ $I_c=10\text{mA}, I_B=0.25\text{mA}$		0.55 0.35	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=50\text{mA}, I_B=1.25\text{mA}$ $I_c=50\text{mA}, I_B=0.25\text{mA}$	0.7 0.6	1.05 0.85	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=5\text{V}, I_c=2.0\text{mA}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$I_c=10\text{mA}, V_{CE}=5\text{V}$ $f=1\text{MHz}$	125		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		4.5	pF
Noise Figure	NF	$I_c=0.2\text{mA}, V_{CE}=5\text{V}$ $R_S=2\text{k}\Omega, f=1\text{kHz}$		6	dB
Turn On Time	t_{on}	$I_c=10\text{mA}, I_{B1}=1\text{mA}$		150	ns
Turn Off Time	t_{off}	$V_{BB}=3.6\text{V}, I_{B2}=1\text{mA}$ $R_1=R_2=5\text{k}\Omega, R_L=990\Omega$		800	ns

Marking



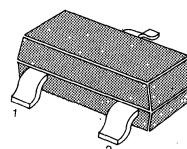
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	32	V
Collector-Emitter Voltage	V_{CEO}	32	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

- Refer to MMBT3904 for graphs

SOT-23

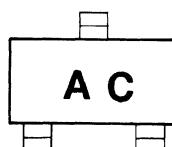


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2.0\text{mA}, I_E=0$	32		V
Emitter-Base Breakdown Voltage	BV_{FBO}	$I_E=1.0\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_C=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\mu\text{A}$ $V_{CE}=5\text{V}, I_C=2.0\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$	40 250 90	460	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=50\text{mA}, I_B=1.25\text{mA}$ $I_C=10\text{mA}, I_B=0.25\text{mA}$		0.55 0.35	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=50\text{mA}, I_B=1.25\text{mA}$ $I_C=50\text{mA}, I_B=0.25\text{mA}$	0.7 0.6	1.05 0.85	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=5\text{V}, I_C=2.0\text{mA}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=5\text{V}$ $f=1\text{MHz}$	125		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		4.5	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$ $R_S=2\text{K}\Omega, f=1\text{kHz}$		6	dB
Turn On Time	t_{on}	$I_C=10\text{mA}, I_{B1}=1\text{mA}$		150	ns
Turn Off Time	t_{off}	$V_{BB}=3.6\text{V}, I_{B2}=1\text{mA}$ $R_1=R_2=5\text{K}\Omega, R_L=990\Omega$		800	ns

Marking



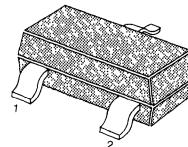
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	32	V
Collector-Emitter Voltage	V_{CEO}	32	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	$T_{stg.}$	150	$^\circ\text{C}$

- Refer to MMBT3904 for graphs

SOT-23



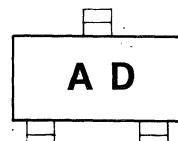
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

3

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=2.0\text{mA}, I_b=0$	32		V
Emitter-Base Breakdown Voltage	BV_{BRO}	$I_e=1.0\mu\text{A}, I_r=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_c=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=10\mu\text{A}$ $V_{CE}=5\text{V}, I_c=2.0\text{mA}$ $V_{CE}=1\text{V}, I_c=50\text{mA}$	100 380 100	630	nA
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=50\text{mA}, I_b=1.25\text{mA}$ $I_c=10\text{mA}, I_b=0.25\text{mA}$		0.55 0.35	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_r=50\text{mA}, I_p=1.25\text{mA}$ $I_c=50\text{mA}, I_b=0.25\text{mA}$	0.7 0.6	1.05 0.85	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=5\text{V}, I_c=2.0\text{mA}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$I_c=10\text{mA}, V_{CE}=5\text{V}$ $f=1\text{MHz}$	125		MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_b=0$ $f=1.0\text{MHz}$		4.5	pF
Noise Figure	NF	$I_c=0.2\text{mA}, V_{CE}=5\text{V}$ $R_s=2\text{k}\Omega, f=1\text{KHz}$		6	dB
Turn On Time	t_{on}	$I_c=10\text{mA}, I_{B1}=1\text{mA}$		150	ns
Turn Off Time	t_{off}	$V_{BB}=3.6\text{V}, I_{B2}=1\text{mA}$ $R_1=R_2=5\text{k}\Omega, R_L=990\Omega$		800	ns

Marking



GENERAL PURPOSE TRANSISTOR

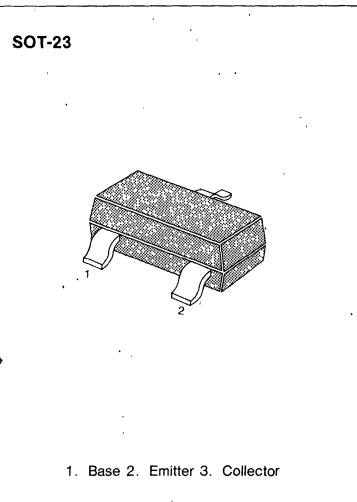
ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	32	V
Collector-Emitter Voltage	V_{CEO}	32	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

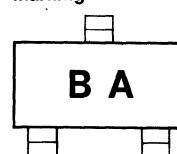
- Refer to MMBT5086 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=2\text{mA}, I_b=0$	32		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_e=1\mu\text{A}, I_c=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
DC Current Gain	h_{FE}	$V_{CF}=5\text{V}, I_c=2\text{mA}$	120	220	
		$V_{CE}=1\text{V}, I_c=50\text{mA}$	60		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{mA}, I_b=0.25\text{mA}$		0.25	V
		$I_c=50\text{mA}, I_b=1.25\text{mA}$		0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=10\text{mA}, I_b=0.25\text{mA}$	0.6	0.85	V
		$I_c=50\text{mA}, I_b=1.25\text{mA}$	0.68	1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c=2\text{mA}, V_{CF}=5\text{V}$	0.6	0.75	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_e=0$		6	pF
		$f=1\text{MHz}$			
Noise Figure	NF	$I_c=0.2\text{mA}, V_{CE}=5\text{V}$		6	dB
		$R_s=2\text{k}\Omega, f=1\text{KHz}$			
Turn On Time	t_{on}	$I_c=10\text{mA}, I_{b1}=1\text{mA}$		150	ns
Turn Off Time	t_{off}	$I_{b2}=1\text{mA}, V_{BB}=3.6\text{V}$		800	ns
		$R_L=990\Omega$			



Marking



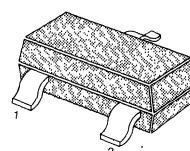
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	32	V
Collector-Emitter Voltage	V_{CEO}	32	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

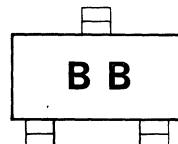


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2\text{mA}, I_B=0$	32		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\mu\text{A}$ $V_{CE}=5\text{V}, I_C=2\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$	20 140 80	310	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$		0.25 0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$	0.6 0.68	0.85 1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2\text{mA}, V_{CF}=5\text{V}$	0.6	0.75	V
Output Capacitance	C _{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		6	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$ $R_S=2\text{K}\Omega, f=1\text{KHz}$		6	dB
Turn On Time	t _{on}	$I_C=10\text{mA}, I_B=1\text{mA}$		150	ns
Turn Off Time	t _{off}	$I_B=1\text{mA}, V_{BB}=3.6\text{V}$ $R_L=990\Omega$		800	ns

Marking



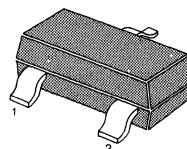
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBR}	32	V
Collector-Emitter Voltage	V_{CEO}	32	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

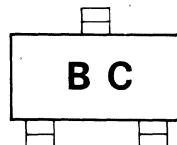


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=2\text{mA}, I_B=0$	32		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=10\mu\text{A}$ $V_{CE}=5\text{V}, I_c=2\text{mA}$ $V_{CE}=1\text{V}, I_c=50\text{mA}$	40 250 100	460	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{mA}, I_B=0.25\text{mA}$ $I_c=50\text{mA}, I_B=1.25\text{mA}$		0.25 0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=10\text{mA}, I_B=0.25\text{mA}$ $I_c=50\text{mA}, I_B=1.25\text{mA}$	0.6 0.68	0.85 1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c=2\text{mA}, V_{CE}=5\text{V}$	0.6	0.75	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		6	pF
Noise Figure	NF	$I_c=0.2\text{mA}, V_{CE}=5\text{V}$ $R_s=2\text{k}\Omega, f=1\text{KHz}$		6	dB
Turn On Time	t_{on}	$I_c=10\text{mA}, I_{B1}=1\text{mA}$		150	ns
Turn Off Time	t_{off}	$I_{B2}=1\text{mA}, V_{BE}=3.6\text{V}$ $R_L=990\Omega$		800	ns

Marking



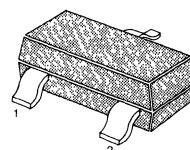
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	32	V
Collector-Emitter Voltage	V_{CEO}	32	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

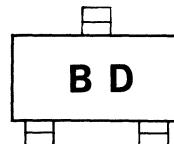


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=2\text{mA}, I_b=0$	32		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_e=1\mu\text{A}, I_c=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=10\mu\text{A}$ $V_{CE}=5\text{V}, I_c=2\text{mA}$ $V_{CE}=1\text{V}, I_c=50\text{mA}$	100 380 100	630	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{mA}, I_b=0.25\text{mA}$ $I_c=50\text{mA}, I_b=1.25\text{mA}$		0.25 0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=10\text{mA}, I_b=0.25\text{mA}$ $I_c=50\text{mA}, I_b=1.25\text{mA}$	0.6 0.68	0.85 1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c=2\text{mA}, V_{CE}=5\text{V}$	0.6	0.75	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_e=0$ $f=1\text{MHz}$		6	pF
Noise Figure	NF	$I_c=0.2\text{mA}, V_{CE}=5\text{V}$ $R_s=2\text{K}\Omega, f=1\text{kHz}$		6	dB
Turn On Time	t_{on}	$I_c=10\text{mA}, I_{b1}=1\text{mA}$		150	ns
Turn Off Time	t_{off}	$I_{b2}=1\text{mA}, V_{BB}=3.6\text{V}$ $R_L=990\Omega$	800		ns

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

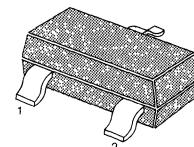
Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

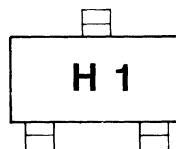
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2.0\text{mA}, I_B=0$	45		V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C=100\mu\text{A}, V_{EB}=0$	50		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=2.0\text{mA}$	120	260	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_E=0.5\text{mA}$		0.3	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2.0\text{mA}, V_{CE}=5\text{V}$	0.6	0.75	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		7.0	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5.0\text{V}$ $R_S=2.0\text{k}\Omega, f=1.0\text{KHz}$		10	dB

SOT-23



1. Base 2. Emitter 3. Collector

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

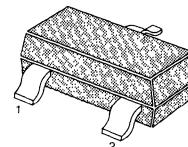
Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=2.0\text{mA}, I_b=0$	45		V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_c=100\mu\text{A}, V_{EB}=0$	50		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_c=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=2.0\text{mA}$	215	500	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{mA}, I_b=0.5\text{mA}$		0.3	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c=2.0\text{mA}, V_{CE}=5\text{V}$	0.6	0.75	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		7.0	pF
Noise Figure	NF	$I_c=0.2\text{mA}, V_{CE}=5.0\text{V}$ $R_s=2.0\text{K}\Omega, f=1.0\text{KHz}$		10	dB

SOT-23



1. Base 2. Emitter 3. Collector

3

Marking



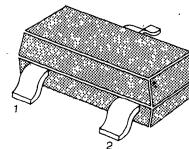
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

- Refer to MMBT5088 for graphs

SOT-23

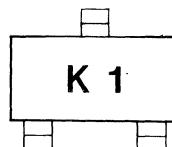


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2\text{mA}, I_B=0$	45			V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C=2\text{mA}, V_{EB}=0$	45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$			100	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=2\text{mA}$	110		220	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.5\text{mA}$ $I_C=50\text{mA}, I_B=2.5\text{mA}$		0.21	0.25	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=50\text{mA}, I_B=2.5\text{mA}$		0.85		V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2\text{mA}, V_{CE}=5\text{V}$	0.6		0.75	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=5\text{V}$ $f=35\text{MHz}$		300		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$			4	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$ $R_S=2\text{K}\Omega, f=1\text{KHz}$			10	dB

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

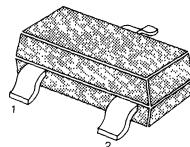
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

- Refer to MMBT5088 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2\text{mA}, I_E=0$	45			V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C=2\text{mA}, V_{EB}=0$	45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$			100	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=2\text{mA}$	200		450	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.5\text{mA}$		0.21	0.25	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=50\text{mA}, I_B=2.5\text{mA}$		0.85		V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2\text{mA}, V_{CE}=5\text{V}$	0.6		0.75	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=5\text{V}$ $f=35\text{MHz}$		300		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$			4	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$ $R_S=2\text{K}\Omega, f=1\text{kHz}$			10	dB

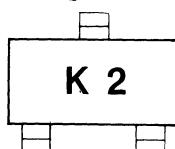
SOT-23



1. Base 2. Emitter 3. Collector

3

Marking



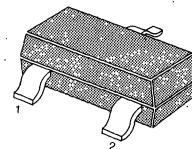
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	200	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5088 for graphs

SOT-23

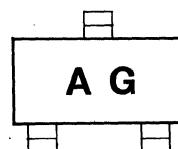


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=2\text{mA}, I_B=0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_C=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=2\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$	120 60	220	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$		0.35 0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=50\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$	0.6 0.7	0.85 1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2\text{mA}, V_{CE}=5\text{V}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{V}, I_C=10\text{mA}$ $f=100\text{MHz}$	125		MHz
Output Capacitance	C_{ob}	$V_{CE}=10\text{V}, I_E=0$ $f=1\text{MHz}$		4.5	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$ $f=1\text{KHz}, R_S=2\text{K}\Omega$		6	dB
Turn On Time	t_{on}	$I_C=10\text{mA}, I_{B1}=1\text{mA}$		150	ns
Turn Off Time	t_{off}	$I_{B2}=1\text{mA}, V_{BB}=3.6\text{V}$ $R_L=990\Omega, R_1=R_2=5\text{K}\Omega$		800	ns

Marking



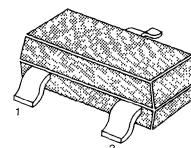
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

- Refer to MMBT3904 for graphs

SOT-23

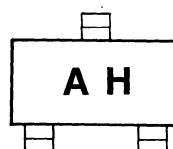


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2.0\text{mA}, I_B=0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1.0\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_C=0$		20	nA
DC Current Gain	β	$V_{CE}=5\text{V}, I_C=10\mu\text{A}$	20		
		$V_{CE}=5\text{V}, I_C=2.0\text{mA}$	180	310	
		$V_{CE}=1\text{V}, I_C=50\text{mA}$	70		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.25\text{mA}$		0.35	V
		$I_C=50\text{mA}, I_B=1.25\text{mA}$		0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=50\text{mA}, I_B=0.25\text{mA}$	0.6	0.85	V
		$I_C=50\text{mA}, I_B=1.25\text{mA}$	0.7	1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2.0\text{mA}, V_{CE}=5\text{V}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=5\text{V}$	125		MHz
		$f=1\text{MHz}$			
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$		4.5	pF
		$f=100\text{MHz}$			
Noise Figure	NF	$V_{CE}=5\text{V}, I_C=0.2\text{mA}$		6	dB
		$R_S=2\text{k}\Omega, f=1\text{kHz}$			
Turn On Time	t_{ON}	$I_C=10\text{mA}, I_{B1}=1.0\text{mA}$		150	ns
Turn Off Time	t_{OFF}	$V_{BB}=3.6\text{V}, I_{B2}=1.0\text{mA}$		800	ns
		$R_1=R_2=5\text{k}\Omega, R_L=990\Omega$			

Marking



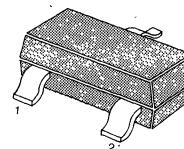
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT3904 for graphs

SOT-23

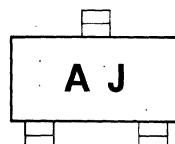


1 Base 2 Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2.0\text{mA}, I_E=0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1.0\mu\text{A}, I_B=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_C=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\mu\text{A}$ $V_{CE}=5\text{V}, I_C=2.0\text{mA}$	40 250	460	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$V_{CE}=1\text{V}, I_C=50\text{mA}$ $I_C=10\text{mA}, I_E=0.25\text{mA}$ $I_C=50\text{mA}, I_E=1.25\text{mA}$	90	0.35 0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=50\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$	0.6 0.7	0.85 1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2.0\text{mA}, V_{CE}=5\text{V}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=5\text{V}$ $f=100\text{MHz}$	125		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		4.5	pF
Noise Figure	NF	$V_{CE}=5\text{V}, I_C=0.2\text{mA}$ $R_S=2K\Omega, f=1\text{KHz}$		6	dB
Turn On Time	t_{on}	$I_C=10\text{mA}, I_{B1}=1.0\text{mA}$		150	ns
Turn Off Time	t_{off}	$V_{BB}=3.6\text{V}, I_{B2}=1.0\text{mA}$ $R_1=R_2=5K\Omega, R_L=990\Omega$		800	ns

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

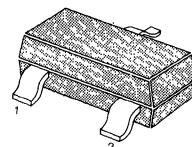
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

- Refer to MMBT3904 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2.0\text{mA}, I_E=0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1.0\mu\text{A}, I_B=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_C=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\mu\text{A}$ $V_{CE}=5\text{V}, I_C=2.0\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$	100 380 100	630	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=1.0\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$		0.35 0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=50\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$	0.6 0.7	0.85 1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2.0\text{mA}, V_{CE}=5\text{V}$	0.55	0.75	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=5\text{V}$ $f=100\text{MHz}$	125		MHz
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		4.5	pF
Noise Figure	NF	$V_{CE}=5\text{V}, I_C=0.2\text{mA}$ $R_S=2\text{K}\Omega, f=1\text{kHz}$		6	dB
Turn On Time	t_{ON}	$I_C=10\text{mA}, I_{B1}=1.0\text{mA}$		150	ns
Turn Off Time	t_{OFF}	$V_{BB}=3.6\text{V}, I_{B2}=1.0\text{mA}$ $R_1=R_2=5\text{K}\Omega, R_L=990\Omega$		800	ns

SOT-23



1. Base 2. Emitter 3. Collector

3

Marking



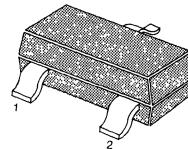
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

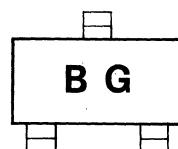


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2\text{mA}, I_E=0$	45		V
Emitter-Base Saturation Voltage	BV_{EBO}	$I_E=1\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=2\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$	120 60	220	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_E=0.25\text{mA}$ $I_C=50\text{mA}, I_E=1.25\text{mA}$		0.25 0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_E=0.25\text{mA}$ $I_C=50\text{mA}, I_E=1.25\text{mA}$	0.6 0.68	0.85 1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2\text{mA}, V_{CF}=5\text{V}$	0.6	0.75	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		6	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$ $R_S=2\text{K}\Omega, f=1\text{KHz}$		6	dB
Turn On Time	t_{on}	$I_C=10\text{mA}, I_{B1}=1\text{mA}$		150	ns
Turn Off Time	t_{off}	$I_{B2}=1\text{mA}, V_{BB}=3.6\text{V}$ $R_L=990\Omega$		800	ns

Marking



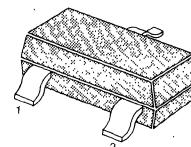
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	Tstg	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23



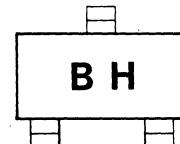
1 Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

3

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2\text{mA}, I_B=0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_F=1\mu\text{A}, I_E=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\mu\text{A}$ $V_{CE}=5\text{V}, I_C=2\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$	30 140 80	310	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$		0.25 0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$	0.6 0.68	0.85 1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2\text{mA}, V_{CE}=5\text{V}$	0.6	0.75	V
Output Capacitance	Cob	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		6	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$ $f=1\text{KHz}, R_S=2\text{K}\Omega$		6	dB
Turn On Time	ton	$I_C=10\text{mA}, I_{B1}=1\text{mA}$		150	ns
Turn Off Time	toff	$I_{B2}=1\text{mA}, V_{BE}=3.6\text{V}$ $R_L=990\Omega$		800	ns

Marking



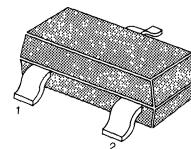
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

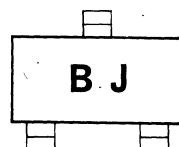


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 2\text{mA}, I_B = 0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_F = 1\mu\text{A}, I_C = 0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE} = 32\text{V}, V_{BE} = 0$		20	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 10\mu\text{A}$ $V_{CE} = 5\text{V}, I_C = 2\text{mA}$ $V_{CE} = 1\text{V}, I_C = 50\text{mA}$	40 250 100	460	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 0.25\text{mA}$ $I_C = 50\text{mA}, I_B = 1.25\text{mA}$		0.25 0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 0.25\text{mA}$ $I_C = 50\text{mA}, I_B = 1.25\text{mA}$	0.6 0.68	0.85 1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C = 2\text{mA}, V_{CE} = 5\text{V}$	0.6	0.75	V
Output Capacitance	C_{ob}	$V_{CE} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		6	pF
Noise Figure	NF	$I_C = 0.2\text{mA}, V_{CE} = 5\text{V}$ $f = 1\text{kHz}, R_S = 2\text{K}\Omega$		6	dB
Turn On Time	t_{on}	$I_C = 10\text{mA}, I_{B1} = 1\text{mA}$		150	ns
Turn Off Time	t_{off}	$I_{B2} = 1\text{mA}, V_{BB} = 3.6\text{V}$ $R_L = 990\Omega$		800	ns

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

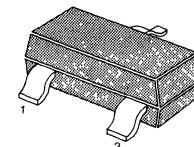
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	45	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2\text{mA}, I_B=0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=1\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CES}	$V_{CE}=32\text{V}, V_{BE}=0$		20	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\mu\text{A}$ $V_{CE}=5\text{V}, I_C=2\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$	100 380 110	630	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$		0.25 0.55	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.25\text{mA}$ $I_C=50\text{mA}, I_B=1.25\text{mA}$	0.6 0.68	0.85 1.05	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=2\text{mA}, V_{CE}=5\text{V}$	0.6	0.75	V
Output Capacitance	C _{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		6	pF
Noise Figure	NF	$I_C=0.2\text{mA}, V_{CE}=5\text{V}$ $R_S=2\text{k}\Omega, f=1\text{kHz}$		6	dB
Turn On Time	t _{on}	$I_C=10\text{mA}, I_{B1}=1\text{mA}$		150	ns
Turn Off Time	t _{off}	$I_{B2}=1\text{mA}, V_{BB}=3.6\text{V}$ $R_L=990\Omega$		800	ns

SOT-23



1. Base 2. Emitter 3. Collector

3

Marking



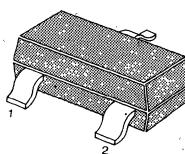
DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

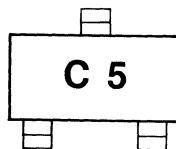


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	50		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1.0\text{mA}, I_B = 0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5		V
Collector Cutoff Current	I_{CB0}	$V_{CB} = 40\text{V}, I_E = 0$		50	nA
Emitter Cutoff Current	I_{EB0}	$V_{EB} = 5.0\text{V}, I_C = 0$		50	nA
DC Current Gain	β_{FE}	$V_{CE} = 3\text{V}, I_C = 0.1\text{mA}$	150		
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$V_{CE} = 3\text{V}, I_C = 0.5\text{mA}$	135	270	V
Current Gain-Bandwidth Product	f_T	$I_C = 20\text{mA}, I_B = 2.0\text{mA}$ $I_C = 1.0\text{mA}, V_{CE} = 6.0\text{V}$ $f = 100\text{MHz}$	75	0.3	MHz

Marking



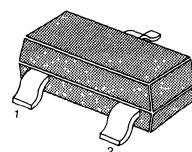
DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

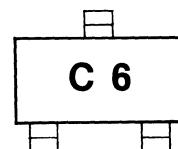


1 Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	50		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1.0\text{mA}, I_B=0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5.0\text{V}, I_C=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=3\text{V}, I_C=0.1\text{mA}$	150		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$V_{CE}=3\text{V}, I_C=0.5\text{mA}$	200	400	V
Current Gain-Bandwidth Product	f_T	$I_C=20\text{mA}, I_B=2.0\text{mA}$ $I_C=1.0\text{mA}, V_{CE}=6.0\text{V}$ $f=100\text{MHz}$	75	0.3	MHz

Marking



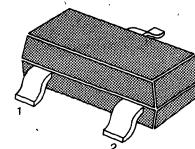
DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

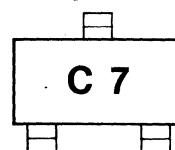


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	50		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1.0\text{mA}, I_B=0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5.0\text{V}, I_C=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=3\text{V}, I_C=0.1\text{mA}$	150		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$V_{CE}=3\text{V}, I_C=0.5\text{mA}$	300	600	V
Current Gain-Bandwidth Product	f_T	$I_C=20\text{mA}, I_B=2.0\text{mA}$ $I_C=1.0\text{mA}, V_{CE}=6.0\text{V}$ $f=100\text{MHz}$	75	0.3	MHz

Marking



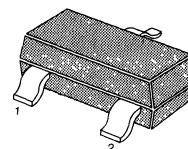
DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

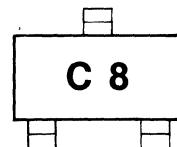


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	50		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1.0\text{mA}, I_B=0$	45		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5.0\text{V}, I_C=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=3\text{V}, I_C=0.1\text{mA}$ $V_{CE}=3\text{V}, I_C=0.5\text{mA}$	150	900	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=20\text{mA}, I_B=2.0\text{mA}$	450	0.3	V
Current Gain-Bandwidth Product	f_T	$I_C=1.0\text{mA}, V_{CE}=6.0\text{V}$ $f=100\text{MHz}$	75		MHz

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

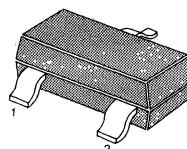
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature.	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

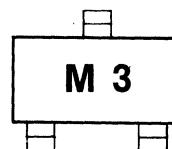
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_c=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}$, $I_c=1\text{mA}$		120	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=30\text{mA}$, $I_E=3\text{mA}$		0.5	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c=1\text{mA}$, $V_{CE}=6\text{V}$	60	0.8	V

SOT-23



1. Base 2. Emitter 3. Collector

Marking



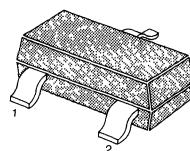
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

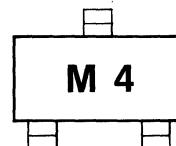


1 Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}$, $I_C=1\text{mA}$	90	180	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=30\text{mA}$, $I_B=3\text{mA}$		0.5	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$I_C=1\text{mA}$, $V_{CE}=6\text{V}$		0.8	V

Marking



GENERAL PURPOSE TRANSISTOR

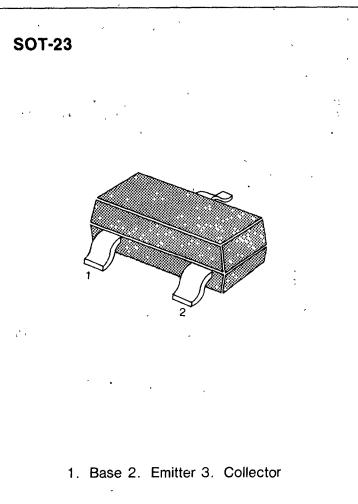
ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

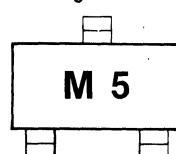
- Refer to MMBT5086 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 40\text{V}$, $I_E = 0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5\text{V}$, $I_C = 0$		100	nA
DC Current Gain	h_{FE}	$V_{CE} = 6\text{V}$, $I_C = 1\text{mA}$	135	270	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 30\text{mA}$, $I_B = 3\text{mA}$		0.5	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$I_C = 1\text{mA}$, $V_{CE} = 6\text{V}$		0.8	V



Marking



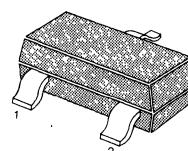
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23



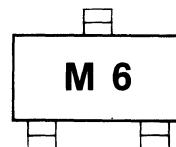
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}, I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}, I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}, I_C=1\text{mA}$		400	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=30\text{mA}, I_B=3\text{mA}$		0.5	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=1\text{mA}, V_{CE}=6\text{V}$		0.8	V

Marking



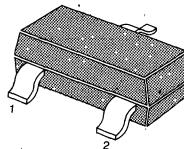
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

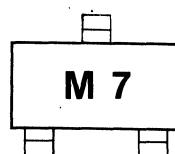


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}$, $I_C=1\text{mA}$	300	600	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=30\text{mA}$, $I_E=3\text{mA}$		0.5	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=1\text{mA}$, $V_{CE}=6\text{V}$		0.8	V

Marking

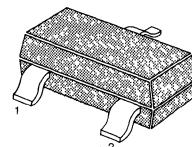


AM/FM RF AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	50	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



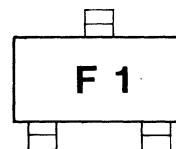
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}$, $I_E=0$			100	nA
DC Current Gain	h_{FE}	$V_{CE}=3\text{V}$, $I_c=0.5\text{mA}$	30		60	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{mA}$, $I_B=1.0\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$I_c=1\text{mA}$, $V_{CE}=6\text{V}$ $f=100\text{MHz}$	150			MHz
Output Capacitance	C_{ob}	$V_{CB}=6\text{V}$, $I_E=0$ $f=1\text{MHz}$		2		pF
Noise Figure	NF	$I_c=0.5\text{mA}$, $V_{CE}=6\text{V}$ $f=1\text{MHz}$, $R_g=500\Omega$			2.5	dB

Marking

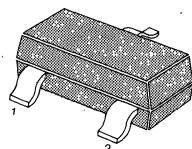


AM/FM RF AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

SOT-23

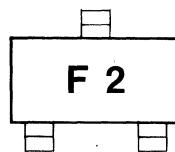


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}$, $I_E=0$	40		100	nA
DC Current Gain	h_{FE}	$V_{CE}=3\text{V}$, $I_C=0.5\text{mA}$			80	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}$, $I_E=1.0\text{mA}$	150		0.3	V
Current Gain-Bandwidth Product	f_T	$I_C=1\text{mA}$, $V_{CE}=6\text{V}$ $f=100\text{MHz}$				MHz
Output Capacitance	C_{ob}	$V_{CB}=6\text{V}$, $I_E=0$ $f=1\text{MHz}$		2		pF
Noise Figure	NF	$I_C=0.5\text{mA}$, $V_{CE}=6\text{V}$ $f=1\text{MHz}$, $R_g=500\Omega$		2.5		dB

Marking

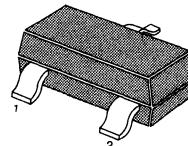


AM/FM RF AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



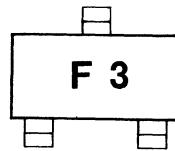
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB} = 15\text{V}$, $I_E = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 3\text{V}$, $I_C = 0.5\text{mA}$	60		120	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}$, $I_B = 1.0\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$I_C = 1\text{mA}$, $V_{CE} = 6\text{V}$ $f = 100\text{MHz}$	150			MHz
Output Capacitance	C_{ob}	$V_{CB} = 6\text{V}$, $I_E = 0$ $f = 1\text{MHz}$		2		pF
Noise Figure	NF	$I_C = 0.5\text{mA}$, $V_{CE} = 6\text{V}$ $f = 1\text{MHz}$, $R_g = 500\Omega$		2.5		dB

Marking

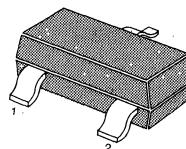


AM/FM RF AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

SOT-23

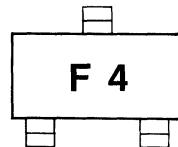


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}$, $I_E=0$			100	nA
DC Current Gain	h_{FE}	$V_{CE}=3\text{V}$, $I_C=0.5\text{mA}$	90		180	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}$, $I_B=1.0\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$I_C=1\text{mA}$, $V_{CE}=6\text{V}$ $f=100\text{MHz}$	150			MHz
Output Capacitance	C_{OB}	$V_{CB}=6\text{V}$, $I_E=0$ $f=1\text{MHz}$		2		pF
Noise Figure	NF	$I_C=0.5\text{mA}$, $V_{CE}=6\text{V}$ $f=1\text{MHz}$, $R_g=500\Omega$			2.5	dB

Marking

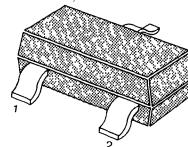


AM/FM RF AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit.
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	50	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



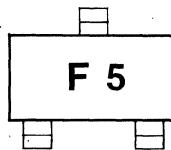
1. Base 2. Emitter 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}$, $I_E=0$			100	nA
DC Current Gain	h_{FE}	$V_{CE}=3\text{V}$, $I_c=0.5\text{mA}$	135		270	
Collector-Emitter Saturation Voltage	V_{CE} (sat)	$I_c=10\text{mA}$, $I_b=1.0\text{mA}$			0.3	V
Current Gain-Bandwidth Product	f_T	$I_c=1\text{mA}$, $V_{CE}=6\text{V}$ $f=100\text{MHz}$	150			MHz
Output Capacitance	C_{ob}	$V_{CB}=6\text{V}$, $I_E=0$ $f=1\text{MHz}$		2		pF
Noise Figure	NF	$I_c=0.5\text{mA}$, $V_{CE}=6\text{V}$ $f=1\text{MHz}$, $R_g=500\Omega$			2.5	dB

Marking

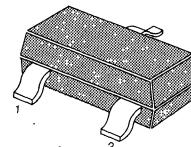


AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	35	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

SOT-23

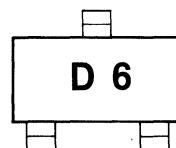


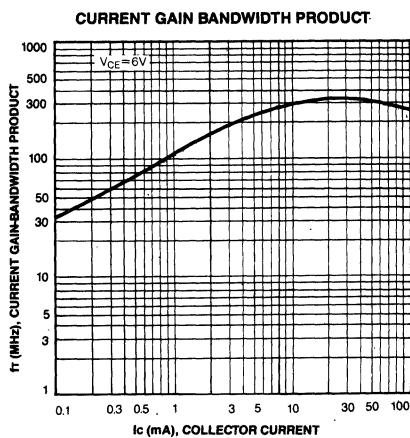
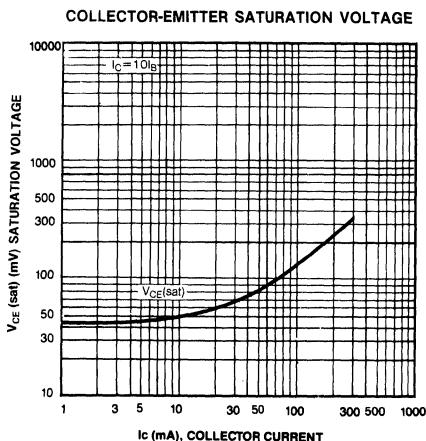
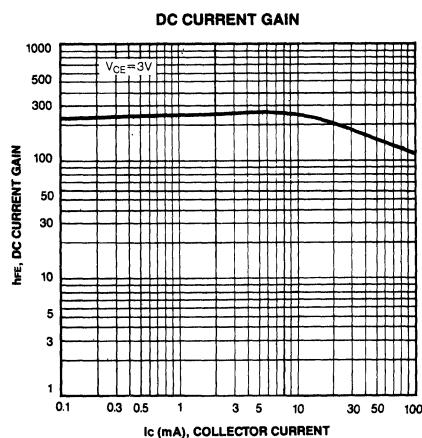
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=25\text{V}, I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}, I_C=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=3\text{V}, I_C=0.1\text{mA}$	150		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$V_{CE}=3\text{V}, I_C=0.5\text{mA}$	200	400	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=100\text{mA}, I_E=10\text{mA}$	0.55	0.3	V
Current Gain-Bandwidth Product	f_T	$I_C=0.5\text{mA}, V_{CE}=3\text{V}$ $V_{CE}=6\text{V}, I_E=1.0\text{mA}$ $f=100\text{MHz}$	100	0.65	MHz

Marking





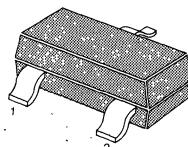
AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	35	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBC1622D6 for graphs

SOT-23

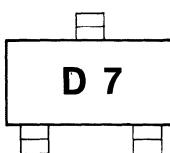


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=25\text{V}$, $I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_c=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=3\text{V}$, $I_c=0.1\text{mA}$ $V_{CE}=3\text{V}$, $I_c=0.5\text{mA}$	150 300	600	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=100\text{mA}$, $I_b=10\text{mA}$		0.3	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c=0.5\text{mA}$, $V_{CE}=3\text{V}$	0.55	0.65	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=6\text{V}$, $I_E=1\text{mA}$ $f=100\text{MHz}$	100		MHz

Marking



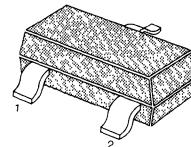
AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	35	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBC1622D6 for graphs

SOT-23

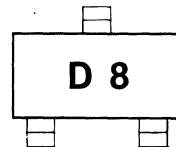


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=25\text{V}$, $I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_C=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=3\text{V}$, $I_C=0.1\text{mA}$	150		
Collector-Emitter Saturation Voltage	V_{CE} (sat)	$V_{CE}=3\text{V}$, $I_C=0.5\text{mA}$	450	900	V
Base-Emitter On Voltage	V_{BE} (on)	$I_C=100\text{mA}$, $I_B=10\text{mA}$		0.3	V
Current Gain-Bandwidth Product	f_T	$I_C=0.5\text{mA}$, $V_{CE}=3\text{V}$	0.55	0.65	MHz
		$V_{CE}=6\text{V}$, $I_E=1\text{mA}$ $f=100\text{MHz}$	100		

Marking

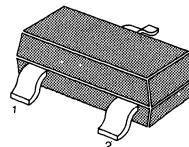


AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

SOT-23

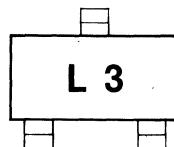


1. Base 2. Emitter 3. Collector

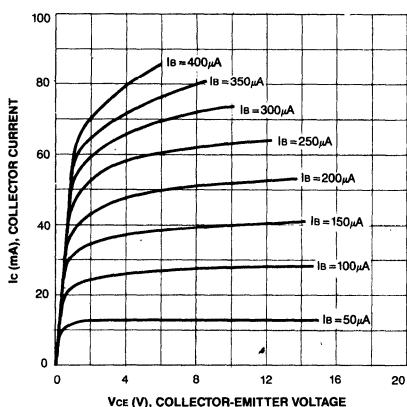
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}$, $I_C=1.0\text{mA}$	60	120	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=100\text{mA}$, $I_B=10\text{mA}$		0.3	V
Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C=100\text{mA}$, $I_B=10\text{mA}$		1.0	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$I_C=1.0\text{mA}$, $V_{BE}=6\text{V}$	0.6	0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=6\text{V}$, $I_E=10\text{mA}$ $f=100\text{MHz}$	200		MHz

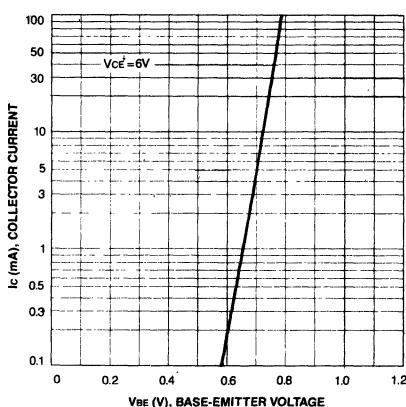
Marking



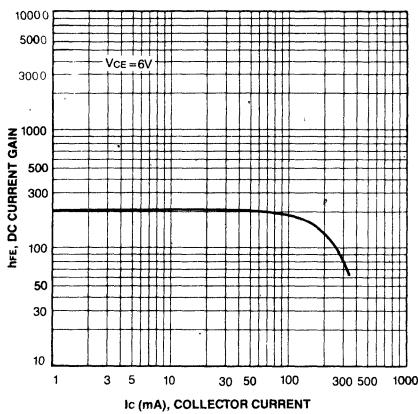
STATIC CHARACTERISTIC



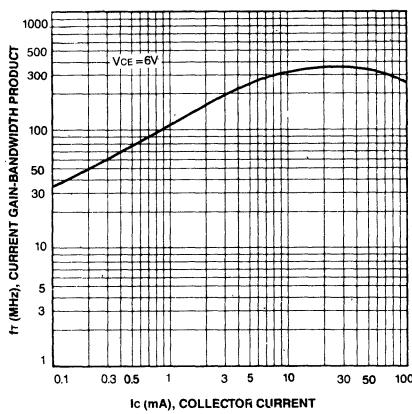
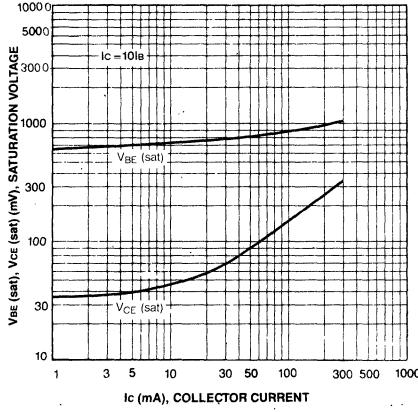
TRANSFER CHARACTERISTIC



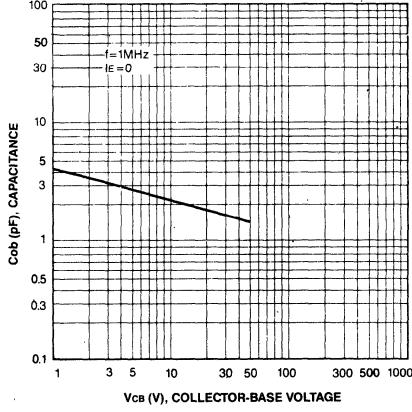
DC CURRENT GAIN



CURRENT GAIN BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE



AMPLIFIER TRANSISTOR

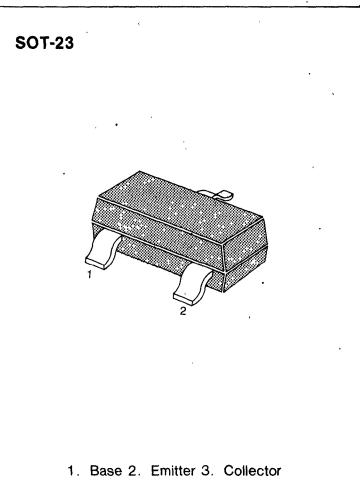
ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

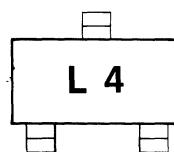
- Refer to MMBC1623L3 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}$, $I_C=1.0\text{mA}$	90	180	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=100\text{mA}$, $I_B=10\text{mA}$		0.3	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=100\text{mA}$, $I_B=10\text{mA}$		1.0	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=1.0\text{mA}$, $V_{rf}=6\text{V}$	0.6	0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=6\text{V}$, $I_E=10\text{mA}$ $f=100\text{MHz}$	200		MHz



Marking



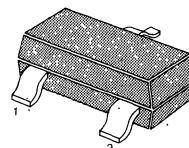
AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	.50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBC1623L3 for graphs

SOT-23

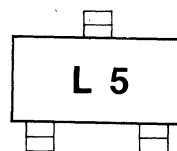


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_c=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}$; $I_c=1.0\text{mA}$	135	270	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c=100\text{mA}$, $I_b=10\text{mA}$		0.3	V
Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_c=100\text{mA}$, $I_b=10\text{mA}$		1.0	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$I_c=1.0\text{mA}$, $V_{CF}=6\text{V}$	0.6	0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=6\text{V}$, $I_E=10\text{mA}$ $f=100\text{MHz}$	200		MHz

Marking



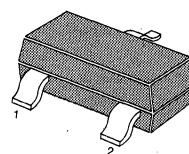
AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBC1623L3 for graphs

SOT-23

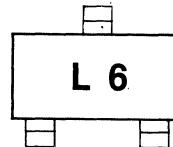


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}$, $I_C=1.0\text{mA}$	200	400	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=100\text{mA}$, $I_B=10\text{mA}$		0.3	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=100\text{mA}$, $I_B=10\text{mA}$		1.0	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=1.0\text{mA}$, $V_{CE}=6\text{V}$	0.6	0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=6\text{V}$, $I_E=10\text{mA}$ $f=100\text{MHz}$	200		MHz

Marking



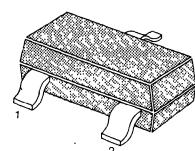
AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5.0	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBC1623L3 for graphs

SOT-23

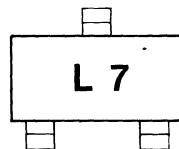


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I_{CBO}	$V_{CB}=40\text{V}$, $I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}$, $I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=6\text{V}$, $I_C=1.0\text{mA}$	300	600	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=100\text{mA}$, $I_B=10\text{mA}$		0.3	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=100\text{mA}$, $I_B=10\text{mA}$		1.0	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=1.0\text{mA}$, $V_B=-6\text{V}$	0.6	0.7	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=6\text{V}$, $I_E=10\text{mA}$ $f=100\text{MHz}$	200		MHz

Marking

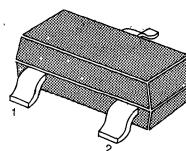


RF AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	20	V
Collector-Emitter Voltage	V_{CEO}	12	V
Emitter-Base Voltage	V_{EBO}	2.5	V
Collector Current	I_c	50	mA
Collector Dissipation ($T_a=25^\circ\text{C}$)	P_c	350	mW
Derate above 25°C		2.8	mW/ $^\circ\text{C}$
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

SOT-23

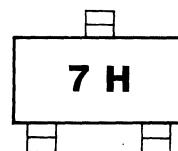


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=0.01\text{mA}, I_E=0$	20		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=3\text{mA}, I_B=0$	12		V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E=0.01\text{mA}, I_C=0$	2.5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}, I_E=0$		0.02	μA
DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_c=3\text{mA}$	25	0.4	V
Collector Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{mA}, I_B=1\text{mA}$		1	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=10\text{mA}, I_E=1\text{mA}$			V
Current Gain Bandwidth Product	f_T	$V_{CE}=6\text{V}, I_c=5\text{mA}, f=100\text{MHz}$	900		MHz
Collector Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0, f=0.1\text{MHz to } 1\text{MHz}$		1	pF
Small Signal Current Gain	h_{fe}	$V_{CE}=6\text{V}, I_c=2\text{mA}, f=1\text{KHz}$	25	4.5	dB
Noise Figure	NF	$V_{CE}=6\text{V}, I_c=1.5\text{mA}, f=200\text{MHz}$			
Common Emitter Amplifier Power Gain	G_{pe}	$R_S=50\Omega$			
		$V_{CE}=6\text{V}, I_c=5\text{mA}, f=200\text{MHz}$	15		dB

Marking

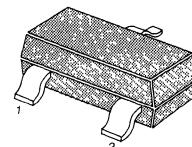


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	Tstg	150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

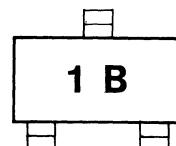
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

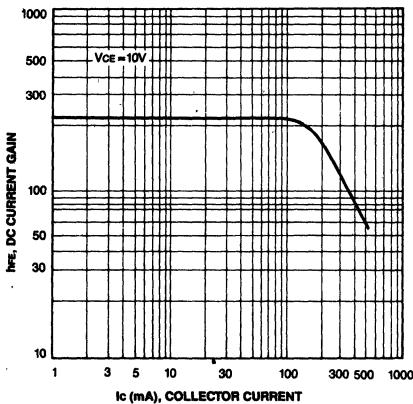
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	60		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10\text{mA}, I_B=0$	30		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CEX}	$V_{CE}=60\text{V}, V_{BE}=3\text{V}$		10	nA
Collector Cutoff Current	I_{CBO}	$V_{CB}=50\text{V}, I_E=0$		0.01	μA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=0.1\text{mA}$ $V_{CE}=10\text{V}, I_C=1.0\text{mA}$ $V_{CE}=10\text{V}, I_C=10\text{mA}$ * $V_{CE}=10\text{V}, I_C=150\text{mA}$ * $V_{CE}=10\text{V}, I_C=500\text{mA}$	35 50 75 100 30	300	
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=150\text{mA}, I_B=15\text{mA}$ $I_C=500\text{mA}, I_B=50\text{mA}$		0.4 1.6	V
* Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=150\text{mA}, I_B=15\text{mA}$ $I_C=500\text{mA}, I_B=50\text{mA}$		1.3 2.6	V
Current Gain-Bandwidth Product	f_T	$I_C=20\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	250		MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		8.0	pF
Turn On Time	t_{on}	$V_{CC}=30\text{V}, V_{BE}=0.5\text{V}$ $I_C=150\text{mA}, I_{B1}=15\text{mA}$		35	ns
Turn Off Time	t_{off}	$V_{CC}=30\text{V}, I_C=150\text{mA}$ $I_{B1}=I_{B2}=15\text{mA}$		285	ns

* Pulse test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

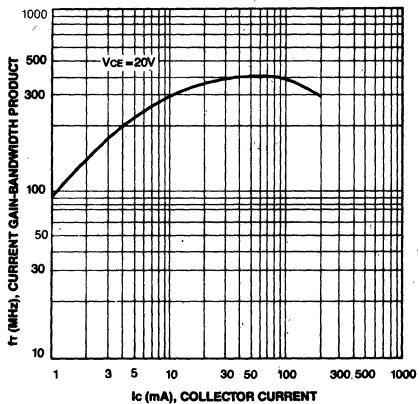
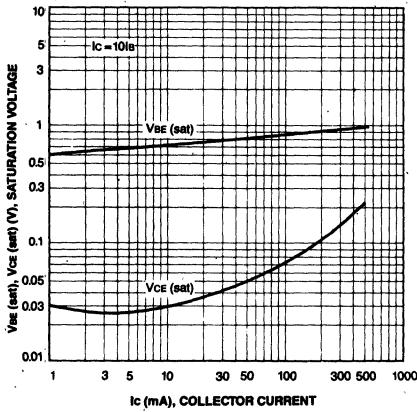
Marking



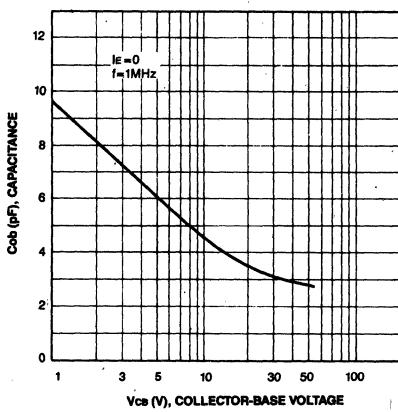
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE



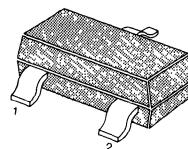
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	75	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_c	600	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT2222 for graphs

SOT-23



1. Base 2. Emitter 3. Collector

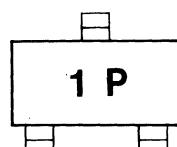
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

3

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=10\mu\text{A}, I_E=0$	75		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=10\text{mA}, I_B=0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	6		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=60\text{V}, I_E=0$		0.01	μA
* DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_c=0.1\text{mA}$ $V_{CE}=10\text{V}, I_c=1\text{mA}$ $V_{CE}=10\text{V}, I_c=10\text{mA}$ $V_{CE}=10\text{V}, I_c=150\text{mA}$ $V_{CE}=10\text{V}, I_c=500\text{mA}$	35 50 75 100 40	300	
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=150\text{mA}, I_B=15\text{mA}$ $I_c=500\text{mA}, I_B=50\text{mA}$		0.3 1.0	V
* Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=150\text{mA}, I_B=15\text{mA}$ $I_c=500\text{mA}, I_B=50\text{mA}$	0.6	1.2 2.0	V
Current Gain-Bandwidth Product	f_T	$I_c=20\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	300		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		8	pF
Noise Figure	NF	$I_c=100\mu\text{A}, V_{CE}=10\text{V}$ $R_S=1\text{k}\Omega, f=1\text{KHz}$	4	4	dB
Turn On Time	t_{on}	$V_{CC}=30\text{V}, I_c=150\text{mA}$ $V_{BE}=0.5\text{V}, I_{B1}=15\text{mA}$		35	ns
Turn Off Time	t_{off}	$V_{CC}=30\text{V}, I_c=150\text{mA}$ $I_{B1}=I_{B2}=15\text{mA}$		285	ns

* Pulse test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Marking



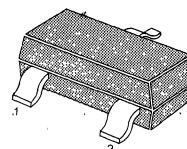
LOW NOISE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

- Refer to MMBT5088 for graphs

SOT-23

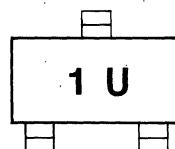


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	60		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	60		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 45\text{V}, I_E = 0$		10	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5\text{V}, I_C = 0$		10	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 1\text{mA}$ $V_{CE} = 5\text{V}, I_C = 10\text{mA}$	250	800	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 1\text{mA}, I_B = 0.1\text{mA}$		0.35	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C = 1\text{mA}, V_{CE} = 5\text{V}$		0.95	V
Output Capacitance	C_{ob}	$V_{CB} = 5.0\text{V}, I_E = 0$ $f = 1\text{MHz}$		6	pF
Noise Figure	NF	$I_C = 10\mu\text{A}, V_{CE} = 5\text{V}$ $R_S = 10\text{K}\Omega, f = 1\text{kHz}$		3	dB

Marking



GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

SOT-23



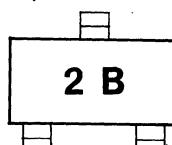
1. Base 2. Emitter 3. Collector

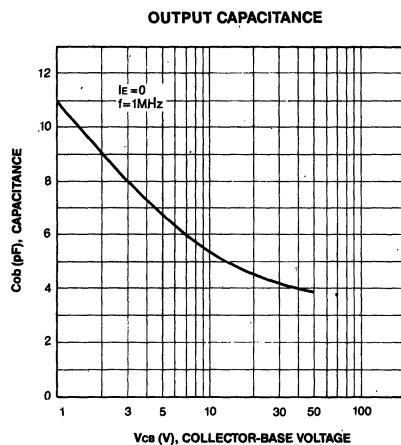
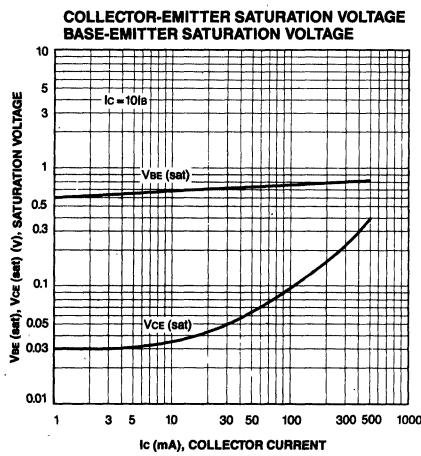
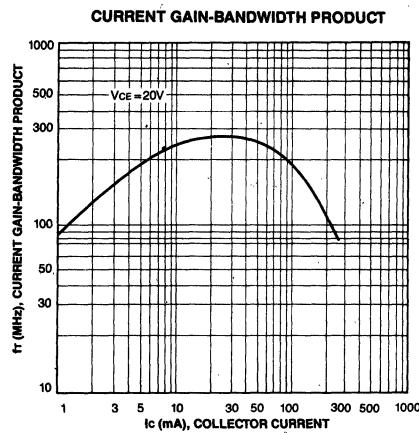
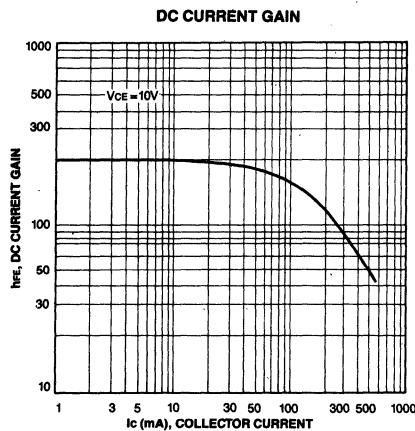
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	60		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5		V
Collector Cutoff Current	I_{CE0}	$V_{CE} = 30\text{V}, V_{BE} = 0.5\text{V}$		50	nA
Collector Cutoff Current	I_{CB0}	$V_{CB} = 50\text{V}, I_E = 0$		0.02	μA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 0.1\text{mA}$ $V_{CE} = 10\text{V}, I_C = 1.0\text{mA}$ $V_{CE} = 10\text{V}, I_C = 10\text{mA}$ * $V_{CE} = 10\text{V}, I_C = 150\text{mA}$ * $V_{CE} = 10\text{V}, I_C = 500\text{mA}$	35 50 75 100 30	300	
*Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$		0.4 1.6	V
*Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$		1.3 2.6	V
Current Gain-Bandwidth Product	f_T	$I_C = 50\text{mA}, V_{CE} = 20\text{V}$ $f = 100\text{MHz}$	200		MHz
Output Capacitance	C_{OB}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1.0\text{MHz}$		8.0	pF
Turn On Time	t_{on}	$V_{CC} = 30\text{V}, I_C = 150\text{mA}$ $I_{B1} = 15\text{mA}$		45	ns
Turn Off Time	t_{off}	$V_{CC} = 6\text{V}, I_C = 150\text{mA}$ $I_{B1} = I_{B2} = 15\text{mA}$		100	ns

*Pulse Test: Pulse Width < 300μs, Duty Cycle < 2%

Marking





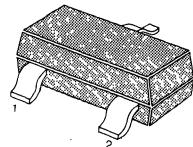
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	600	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

*Refer to MMBT2907 for graphs

SOT-23



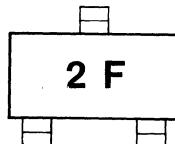
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=10\mu\text{A}, I_E=0$	60		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=10\text{mA}, I_B=0$	60		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_c=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=50\text{V} I_E=0$			
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_c=0.1\text{mA}$ $V_{CE}=10\text{V}, I_c=1.0\text{mA}$ $V_{CE}=10\text{V}, I_c=10\text{mA}$ * $V_{CE}=10\text{V}, I_c=150\text{mA}$ * $V_{CE}=10\text{V}, I_c=500\text{mA}$	75 100 100 100 50	0.01 300	μA
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=150\text{mA}, I_B=15\text{mA}$ $I_c=500\text{mA}, I_B=50\text{mA}$		0.4 1.6	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=150\text{mA}, I_B=15\text{mA}$ $I_c=500\text{mA}, I_B=50\text{mA}$		1.3 2.6	V
Current Gain-Bandwidth Product	f_T	$I_c=50\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	200		MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		8	pF
Turn On Time	t_{on}	$V_{CC}=30\text{V}, I_c=150\text{mA}$ $I_{B1}=15\text{mA}$		50	ns
Turn Off Time	t_{off}	$V_{CC}=6\text{V}, I_c=150\text{mA}$ $I_{B1}=I_{B2}=15\text{mA}$		110	ns

*Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Marking



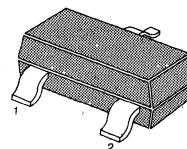
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

*Refer to MMBT3904 for graphs

SOT-23



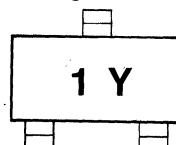
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	60		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	6		V
Collector Cutoff Current	I_{CEX}	$V_{CE}=30\text{V}, V_{EB}=3\text{V}$		50	nA
*DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_C=0.1\text{mA}$	20		
		$V_{CE}=1\text{V}, I_C=1\text{mA}$	35		
		$V_{CE}=1\text{V}, I_C=10\text{mA}$	50	150	
		$V_{CE}=1\text{V}, I_C=50\text{mA}$	30		
		$V_{CE}=1\text{V}, I_C=100\text{mA}$	15		
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$		0.2	V
		$I_C=50\text{mA}, I_B=5\text{mA}$		0.3	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$	0.65	0.85	V
		$I_C=50\text{mA}, I_B=5\text{mA}$		0.95	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	250		MHz
Output Capacitance	C_{ob}	$V_{CB}=5\text{V}, I_E=0$ $f=1\text{MHz}$		4	pF
Noise Figure	NF	$I_C=100\mu\text{A}, V_{CE}=5\text{V}$ $R_S=1\text{K}\Omega$ $f=10\text{Hz}$ to 15.7KHz		6	dB
Turn On Time	t_{on}	$V_{CC}=3\text{V}, V_{BE}=0.5\text{V}$ $I_C=10\text{mA}, I_{B1}=1\text{mA}$		70	ns
Turn Off Time	t_{off}	$V_{CC}=3\text{V}, I_C=10\text{mA}$ $I_{B1}=I_{B2}=1\text{mA}$		225	ns

*Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Marking

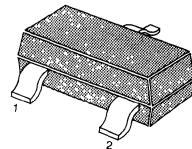


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_c	200	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

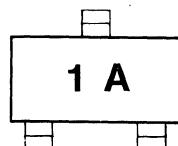
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

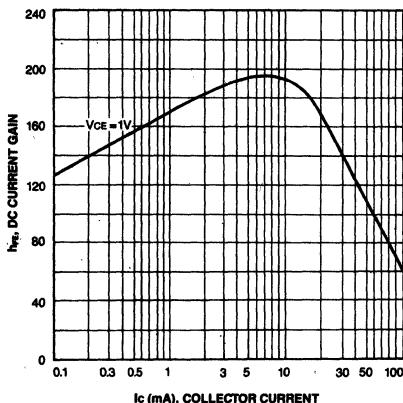
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=10\mu\text{A}, I_E=0$	60		V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=1\text{mA}, I_B=0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	6		V
Collector Cutoff Current	I_{CEX}	$V_{CE}=30\text{V}, V_{EB}=3\text{V}$		50	nA
* DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_C=0.1\text{mA}$ $V_{CE}=1\text{V}, I_C=1\text{mA}$ $V_{CE}=1\text{V}, I_C=10\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$ $V_{CE}=1\text{V}, I_C=100\text{mA}$	40 70 100 60 30	300	
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{mA}, I_E=1\text{mA}$ $I_c=50\text{mA}, I_E=5\text{mA}$		0.2 0.3	V
* Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=10\text{mA}, I_E=1\text{mA}$ $I_c=50\text{mA}, I_E=5\text{mA}$	0.65	0.85 0.95	V
Current Gain-Bandwidth Product	f_T	$I_c=10\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	300		MHz
Output Capacitance	C_{ob}	$V_{CB}=5\text{V}, I_E=0$ $f=1\text{MHz}$		4	pF
Noise Figure	NF	$I_c=100\mu\text{A}, V_{CE}=5\text{V}$ $R_S=1\text{k}\Omega$		5	dB
Turn On Time	t_{on}	$V_{CC}=3\text{V}, V_{BE}=0.5\text{V}$ $I_c=10\text{mA}, I_{B1}=1\text{mA}$		70	ns
Turn Off Time	t_{off}	$V_{CC}=3\text{V}, I_c=10\text{mA}$ $I_{B1}=I_{B2}=1\text{mA}$		250	ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

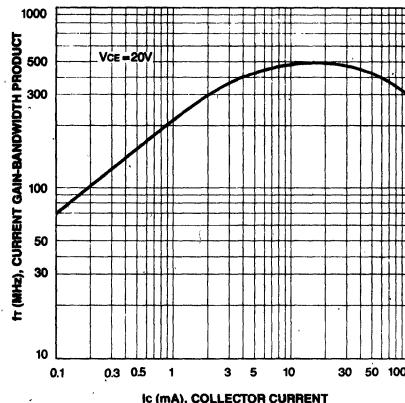
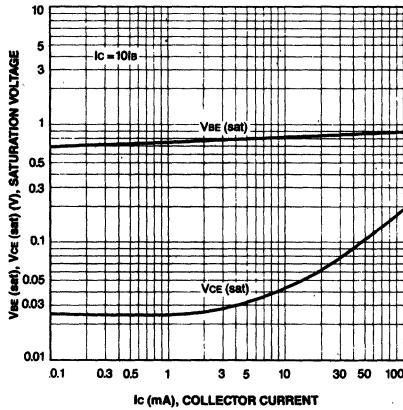
Marking



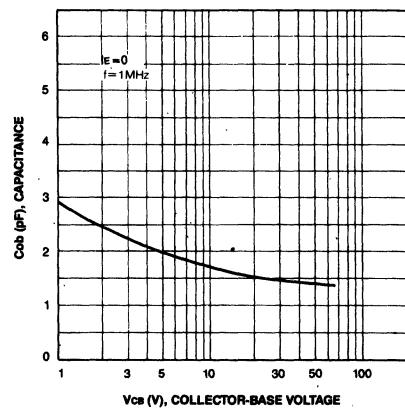
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE

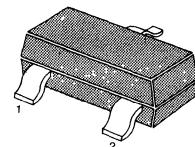


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

SOT-23



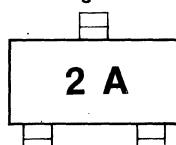
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

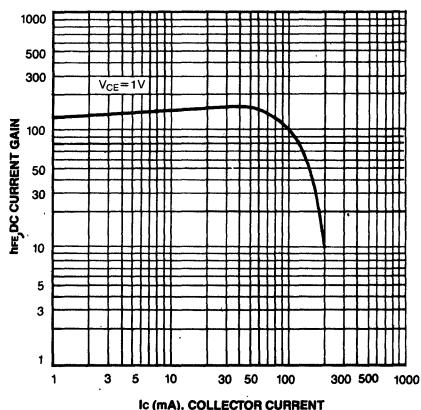
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	40		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1.0\text{mA}, I_B=0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CEX}	$V_{CE}=30\text{V}, V_{EB}=3\text{V}$			
*DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_C=0.1\text{mA}$ $V_{CE}=1\text{V}, I_C=1\text{mA}$ $V_{CE}=1\text{V}, I_C=10\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$ $V_{CE}=1\text{V}, I_C=100\text{mA}$	60 80 100 60 30	50 300	nA
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$ $I_C=50\text{mA}, I_B=5.0\text{mA}$		0.25 0.4	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=1.0\text{mA}$ $I_C=50\text{mA}, I_B=5.0\text{mA}$	0.65	0.85 0.95	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	250		MHz
Output Capacitance	C_{OB}	$V_{CB}=5\text{V}, I_E=0$ $f=1.0\text{MHz}$		4.5	pF
Noise Figure	NF	$I_C=100\mu\text{A}, V_{CE}=5\text{V}$ $R_S=1\text{K}\Omega$ $f=10\text{Hz}$ to 15.7kHz		4	dB
Turn On Time	t_{on}	$V_{CC}=3\text{V}, V_{BE}=0.5\text{V}$ $I_C=10\text{mA}, I_{B1}=1\text{mA}$		70	ns
Turn Off Time	t_{off}	$V_{CC}=3\text{V}, I_C=10\text{mA}$ $I_{B1}=I_{B2}=1\text{mA}$		300	ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

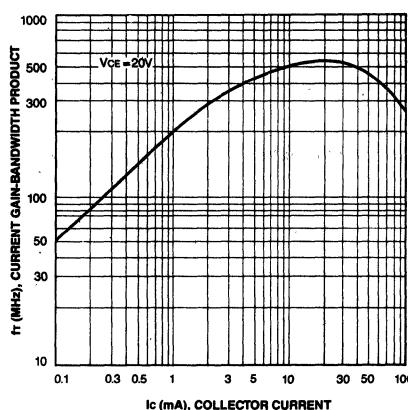
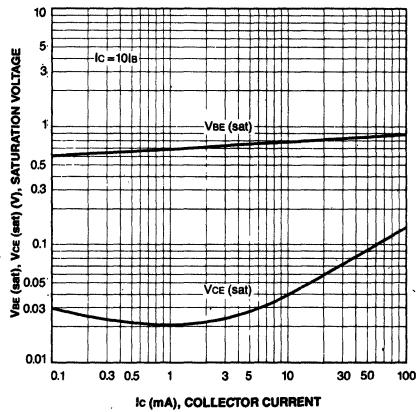
Marking



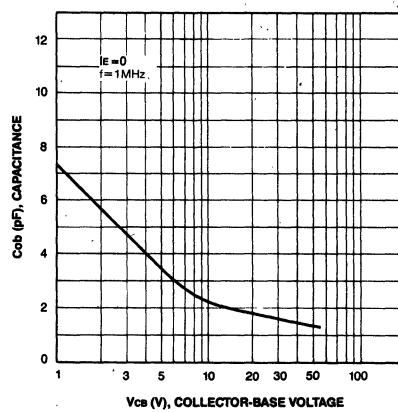
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE

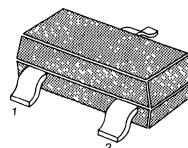


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C}/\text{W}$

SOT-23



1. Base 2. Emitter 3. Collector

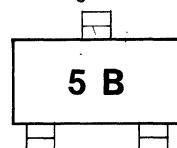
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ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	40		V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_E=0$	30		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{BE}=3\text{V}, I_C=0$		50	nA
* DC Current Gain	β_{FE}	$V_{CE}=1\text{V}, I_C=2\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$	50	150	
* Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=50\text{mA}, I_B=5\text{mA}$	25	0.3	V
* Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C=50\text{mA}, I_B=5\text{mA}$		0.95	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=20\text{V}, I_C=10\text{mA}, f=100\text{MHz}$	250		MHz
Collector Output Capacitance	C_{ob}	$V_{CB}=5\text{V}, I_E=0, f=100\text{MHz}$		4	pF
Collector Input Capacitance	C_{ib}	$V_{BE}=0.5\text{V}, I_C=0, f=100\text{KHz}$		8	pF
Collector-Base Capacitance	C_{cb}	$V_{CB}=5\text{V}, I_E=0, f=100\text{KHz}$		4	pF
Noise Figure	NF	$V_{CE}=5\text{V}, I_C=100\mu\text{A}, R_s=1\text{k}\Omega$ Noise Bandwidth=10Hz to 15.7KHz		6	dB

* Pulse Test: PW≤300μs, Duty Cycle≤2%

Marking



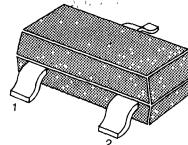
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT3904 for graphs

SOT-23



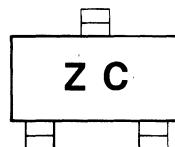
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	30		V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1.0\text{mA}, I_B=0$	25		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=3\text{V}, I_C=0$		50	nA
* DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_C=2\text{mA}$ $V_{CE}=1\text{V}, I_C=50\text{mA}$	120 60	360	
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=50\text{mA}, I_B=5.0\text{mA}$		0.3	V
* Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=50\text{mA}, I_B=5.0\text{mA}$		0.95	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	300		MHz
Output Capacitance	C_{ob}	$V_{CB}=5\text{V}, I_E=0$ $f=1.0\text{MHz}$		4	pF
Noise Figure	NF	$I_C=100\mu\text{A}, V_{CE}=5\text{V}$ $R_S=1\text{K}\Omega$ $f=10\text{Hz to } 15.7\text{KHz}$		5	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Marking



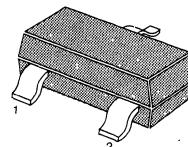
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_c	200	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT 3906 for graphs

SOT-23



1. Base 2. Emitter 3. Collector

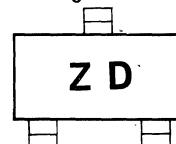
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

3

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=10\mu\text{A}, I_E=0$	30		V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=1\text{mA}, I_E=0$	30		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	4		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=3\text{V}, I_C=0$		50	nA
* DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_c=2.0\text{mA}$ $V_{CE}=1\text{V}, I_c=50\text{mA}$	25	150	
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=50\text{mA}, I_B=5.0\text{mA}$		0.4	V
* Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=50\text{mA}, I_B=5.0\text{mA}$		0.95	V
Current Gain-Bandwidth Product	f_T	$I_c=10\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	200		MHz
Collector Base Capacitance	C_{cb}	$V_{CB}=5\text{V}, I_E=0$ $f=100\text{KHz}$		4.5	pF
Noise Figure	NF	$I_c=100\mu\text{A}, V_{CE}=5\text{V}$ $R_s=1\text{K}\Omega,$ $f=10\text{Hz} \text{ to } 15.7\text{KHz}$		5	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Marking

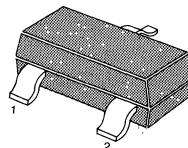


GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-25	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_c	-200	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$

SOT-23



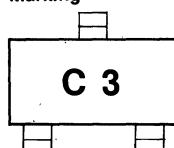
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=-10\mu\text{A}, I_E=0$	-25		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=-1\text{mA}, I_E=0$	-25		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-10\mu\text{A}, I_C=0$	-4		
Collector Cutoff Current	I_{CBO}	$V_{CB}=-20\text{V}, I_E=0$		-50	nA
Emitter Cutoff Current	I_{EBO}	$V_{BE}=-3\text{V}, I_C=0$		-50	nA
*DC Current Gain	h_{FE}	$V_{CE}=-1\text{V}, I_c=-2\text{mA}$ $V_{CE}=-1\text{V}, I_c=-50\text{mA}$	120 60	360	
*Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c=-50\text{mA}, I_E=-5\text{mA}$		-0.4	V
*Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_c=-50\text{mA}, I_B=-5\text{mA}$		-0.95	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-20\text{V}, I_c=-10\text{mA}, f=100\text{MHz}$	250		MHz
Collector Input Capacitance	C_{ib}	$V_{BE}=-0.5\text{V}, I_c=0, f=1\text{MHz}$		10	pF
Collector-Base Capacitance	C_{cb}	$V_{CB}=-5\text{V}, I_E=0, f=1\text{MHz}$		4.5	pF
Noise Figure	NF	$V_{CE}=-5\text{V}, I_c=-100\mu\text{A}, R_s=1\text{k}\Omega$ Noise Bandwidth=10Hz to 15.7KHz		4	dB

* Pulse Test: PW≤300μs, Duty Cycle≤2%

Marking

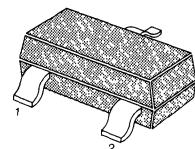


SWITCHING TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_c	600	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



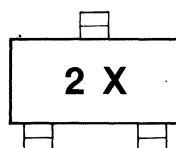
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

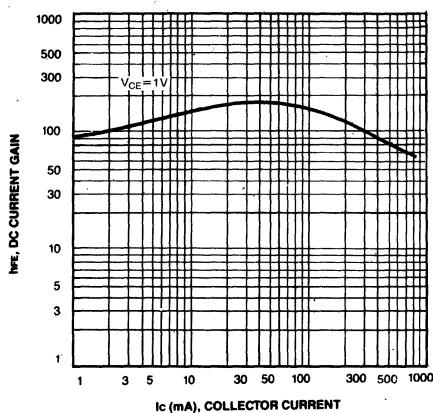
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_E=0$	60		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=1.0\text{mA}, I_B=0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_C=0$	6		V
Base Cutoff Current	I_{BEV}	$V_{CE}=35\text{V}, V_{EB}=0.4\text{V}$		100	nA
Collector Cutoff Current	I_{CEX}	$V_{CE}=35\text{V}, V_{BE}=0.4\text{V}$		100	nA
*DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_c=0.1\text{mA}$ $V_{CE}=1\text{V}, I_c=1\text{mA}$ $V_{CE}=1\text{V}, I_c=10\text{mA}$ $V_{CE}=1\text{V}, I_c=150\text{mA}$ $V_{CE}=2\text{V}, I_c=500\text{mA}$	20 40 80 100 40	300	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=150\text{mA}, I_B=15\text{mA}$ $I_c=500\text{mA}, I_B=50\text{mA}$		0.4 0.75	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=150\text{mA}, I_B=15\text{mA}$ $I_c=500\text{mA}, I_B=50\text{mA}$	0.75	0.95 1.2	V
Current Gain-Bandwidth Product	f_T	$I_c=20\text{mA}, V_{CE}=10\text{V}$ $f=100\text{MHz}$	250		MHz
Collector Base Capacitance	C_{cb}	$V_{cb}=5\text{V}, I_E=0$ $f=100\text{KHz}$		6.5	pF
Turn On Time	t_{on}	$V_{CC}=30\text{V}, V_{BE}=2\text{V}$ $I_c=150\text{mA}, I_{B1}=15\text{mA}$		35	ns
Turn Off Time	t_{off}	$V_{CC}=30\text{V}, I_c=150\text{mA}$ $I_{B1}=I_{B2}=15\text{mA}$		255	ns

*Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

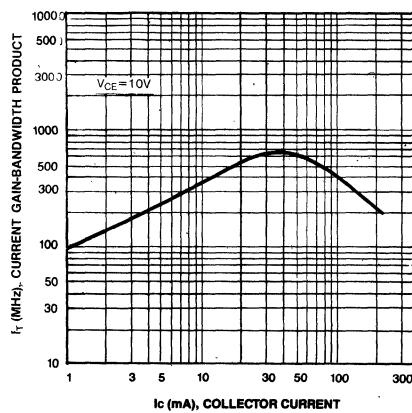
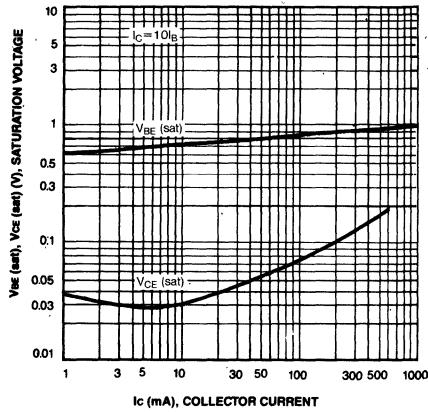
Marking



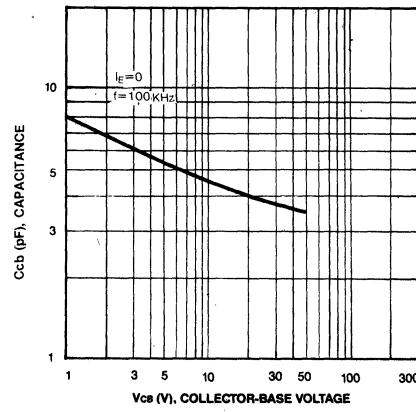
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE

COLLECTOR-BASE CAPACITANCE

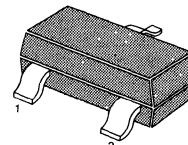


SWITCHING TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	600	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



1. Base 2. Emitter 3. Collector

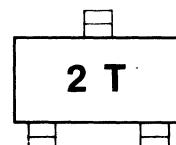
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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

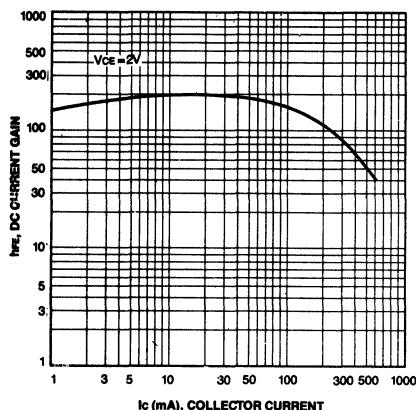
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 0.1\text{ mA}, I_E = 0$	40		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 1.0\text{ mA}, I_B = 0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 0.1\text{ mA}, I_C = 0$	5		V
Base Cutoff Current	I_{BEV}	$V_{CE} = 35\text{ V}, V_{BE} = 0.4\text{ V}$		0.1	μA
Collector Cutoff Current	I_{CEX}	$V_{CE} = 35\text{ V}, V_{BE} = 0.4\text{ V}$		0.1	μA
DC Current Gain	h_{FE}	$V_{CE} = 1\text{ V}, I_C = 0.1\text{ mA}$ $V_{CE} = 1\text{ V}, I_C = 1.0\text{ mA}$ $V_{CE} = 1\text{ V}, I_C = 10\text{ mA}$ * $V_{CE} = 2\text{ V}, I_C = 150\text{ mA}$ * $V_{CE} = 2\text{ V}, I_C = 500\text{ mA}$	30 60 100 100 20	300	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 150\text{ mA}, I_E = 15\text{ mA}$ $I_C = 500\text{ mA}, I_E = 50\text{ mA}$		0.4 0.75	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 150\text{ mA}, I_B = 15\text{ mA}$ $I_C = 500\text{ mA}, I_B = 50\text{ mA}$	0.75	0.95 1.3	V
Current Gain-Bandwidth Product	f_T	$I_C = 20\text{ mA}, V_{CE} = 10\text{ V}$ $f = 100\text{ MHz}$	200		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB} = 10\text{ V}, I_E = 0$ $f = 140\text{ kHz}$		8.5	pF
Turn On Time	t_{on}	$V_{CC} = 30\text{ V}, V_{BE} = 2\text{ V}$ $I_C = 150\text{ mA}, I_{B1} = 15\text{ mA}$		35	ns
Turn Off Time	t_{off}	$V_{CC} = 30\text{ V}, I_C = 150\text{ mA}$ $I_{B1} = I_{B2} = 15\text{ mA}$		255	ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

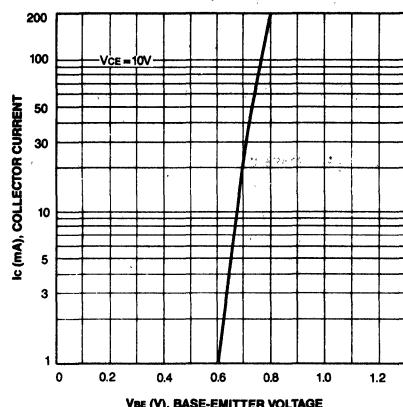
Marking



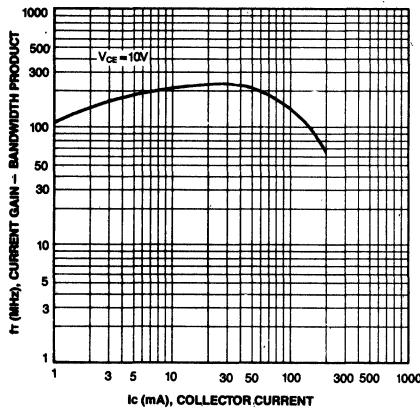
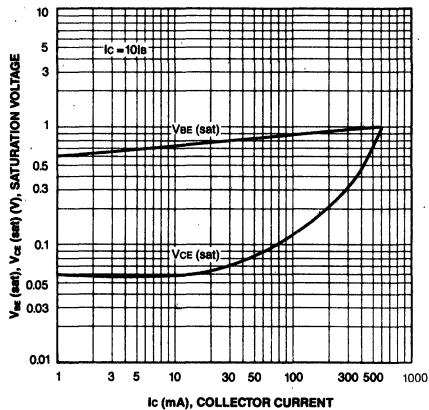
DC CURRENT GAIN



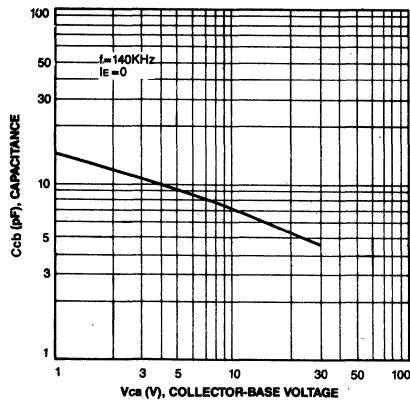
BASE-EMITTER ON VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR-BASE CAPACITANCE

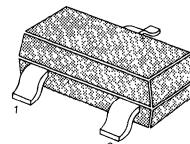


LOW NOISE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Current	I_C	50	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



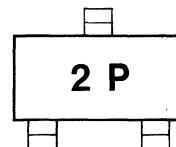
1. Base 2. Emitter 3. Collector

3

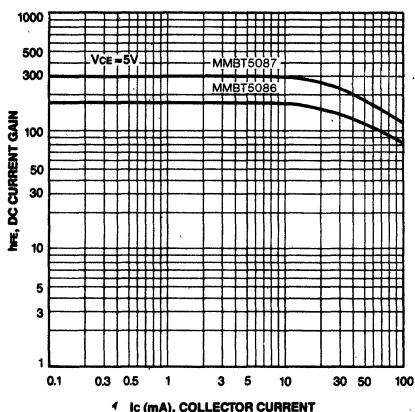
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	50		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	50		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=35\text{V}, I_E=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$ $V_{CE}=5\text{V}, I_C=1\text{mA}$ $V_{CE}=5\text{V}, I_C=10\text{mA}$	150 150 150	500	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$		0.3	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$		0.85	V
Current Gain-Bandwidth Product	f_T	$I_C=500\mu\text{A}, V_{CE}=5\text{V}$ $f=20\text{MHz}$	40		MHz
Output Capacitance	C_{ob}	$V_{CB}=5\text{V}, I_E=0$ $f=100\text{kHz}$		4	pF
Noise Figure	NF	$I_C=100\mu\text{A}, V_{CE}=5\text{V}$ $f=1\text{KHz}, R_S=3\text{K}\Omega$		3	dB

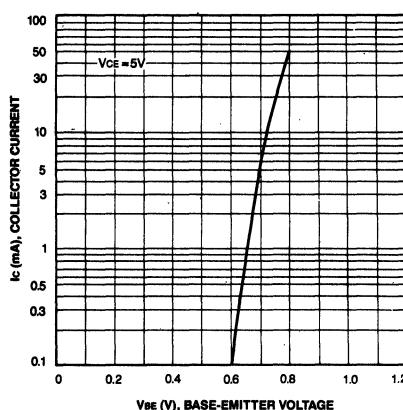
Marking



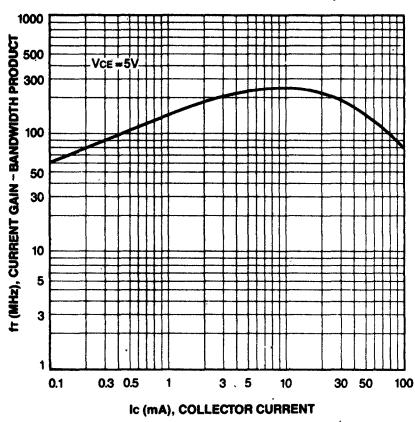
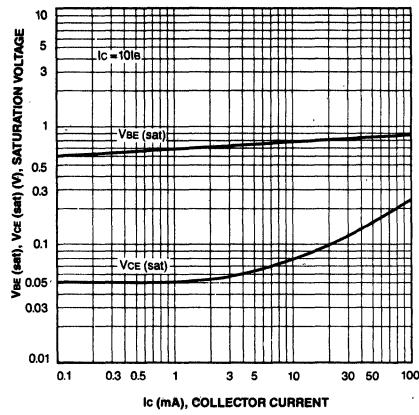
DC CURRENT GAIN



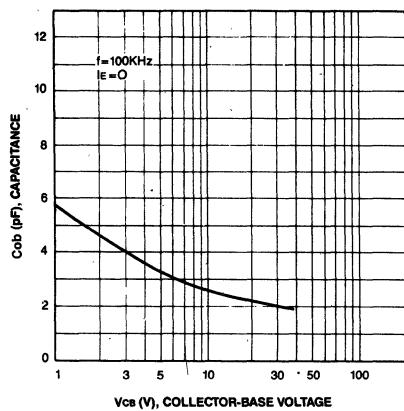
BASE-EMITTER ON VOLTAGE



CURRENT GAIN BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE



LOW NOISE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

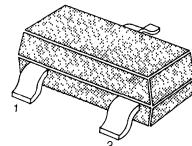
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Current	I_c	50	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_E=0$	50		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_r=1\text{ mA}, I_h=0$	50		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=35\text{ V}, I_E=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{ V}, I_c=100\mu\text{A}$ $V_{CE}=5\text{ V}, I_c=1.0\text{ mA}$ $V_{CE}=5\text{ V}, I_c=10\text{ mA}$	250	800	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=10\text{ mA}, I_B=1.0\text{ mA}$		0.3	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=10\text{ mA}, I_B=1.0\text{ mA}$		0.85	V
Current Gain-Bandwidth Product	f_T	$I_c=500\mu\text{A}, V_{CE}=5\text{ V}$ $f=20\text{ MHz}$	40		MHz
Output Capacitance	C_{ob}	$V_{CB}=5\text{ V}, I_E=0$ $f=100\text{ kHz}$		4.0	pF
Noise Figure	NF	$V_{CE}=5\text{ V}, I_c=20\text{ mA}$ $R_S=10\text{ k}\Omega$ $f=10\text{ Hz to }15.7\text{ kHz}$ $V_{CE}=5\text{ V}, I_c=100\mu\text{A}$ $R_S=3\text{ k}\Omega, f=1\text{ kHz}$		2	dB
				2	dB

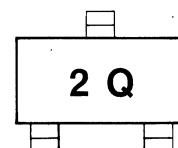
SOT-23



1. Base 2. Emitter 3. Collector

3

Marking

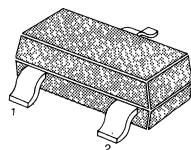


LOW NOISE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	35	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4.5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23

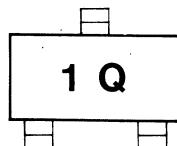


1. Base 2. Emitter 3. Collector

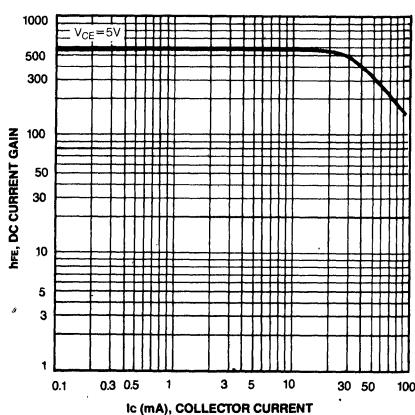
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	35		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_E=0$	30		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=20\text{V}, I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{BE}=3\text{V}, I_C=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$ $V_{CE}=5\text{V}, I_C=1\text{mA}$ $V_{CE}=5\text{V}, I_C=10\text{mA}$	300 350 300	900	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1.0\text{mA}$		0.5	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=1.0\text{mA}$		0.8	V
Current Gain-Bandwidth Product	f_T	$I_C=500\mu\text{A}, V_{CE}=5\text{V}$ $f=20\text{MHz}$	50		MHz
Collector Base Capacitance	C_{cb}	$V_{CB}=5\text{V}, I_E=0$ $f=100\text{kHz}$		4	pF
Noise Figure	NF	$I_C=100\mu\text{A}, V_{CE}=5\text{V}$ $R_S=10\text{K}\Omega$ $f=10\text{Hz to } 15.7\text{kHz}$		3	dB

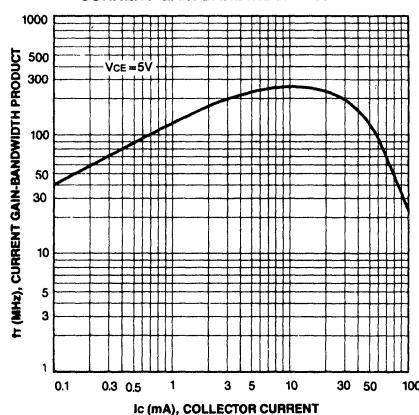
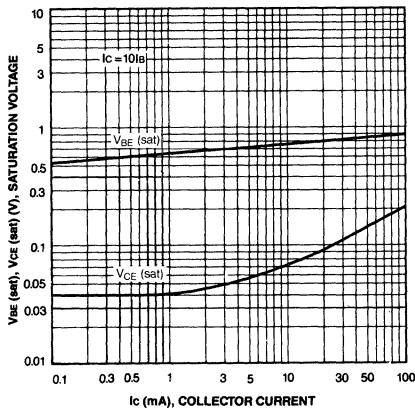
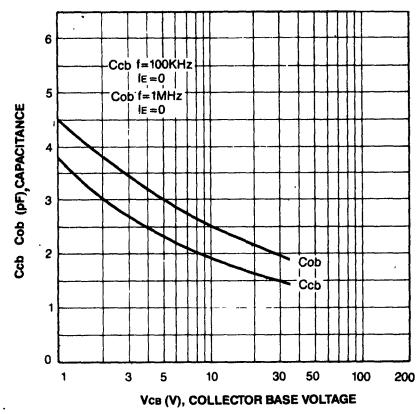
Marking



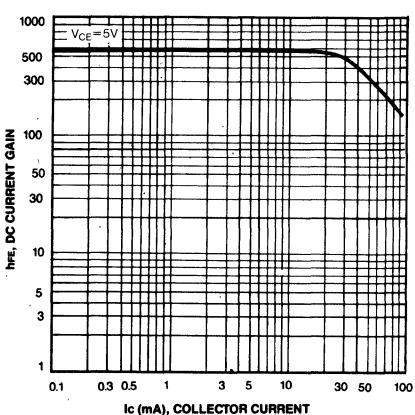
DC CURRENT GAIN



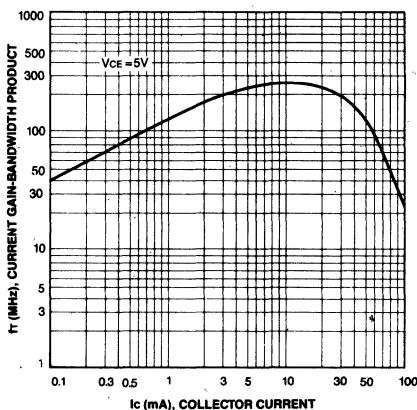
CURRENT GAIN BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGEOUTPUT CAPACITANCE
COLLECTOR-BASE CAPACITANCE

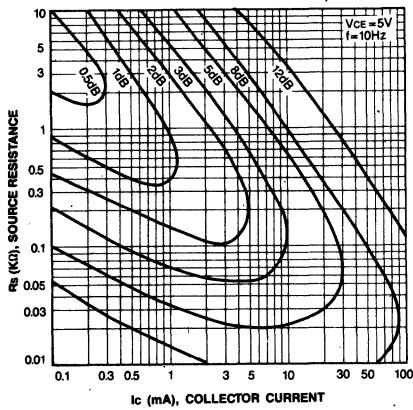
DC CURRENT GAIN



CURRENT GAIN BANDWIDTH PRODUCT



NOISE FIGURE



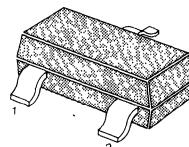
LOW NOISE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4.5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5088 for graphs

SOT-23

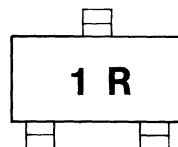


1 Base 2 Emitter 3 Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	30		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1.0\text{mA}, I_B=0$	25		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}, I_E=0$		50	nA
Emitter Cutoff Current	I_{EBO}	$V_{BE}=4.5\text{V}, I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=100\mu\text{A}$ $V_{CE}=5\text{V}, I_C=1\text{mA}$ $V_{CE}=5\text{V}, I_C=10\text{mA}$	400 450 400	1200	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1.0\text{mA}$		0.5	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=1.0\text{mA}$		0.8	V
Current Gain-Bandwidth Product	f_T	$I_C=500\mu\text{A}, V_{CE}=5\text{V}$ $f=20\text{MHz}$	50		MHz
Collector Base Capacitance	C_{cb}	$V_{CB}=5.0\text{V}, I_E=0$ $f=100\text{kHz}$		4	pF
Noise Figure	NF	$I_C=100\mu\text{A}, V_{CE}=5\text{V}$ $R_S=10\text{k}\Omega$ $f=10\text{Hz to } 15.7\text{kHz}$		2	dB

Marking

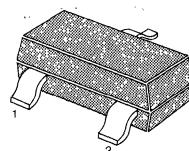


HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	160	V
Collector-Emitter Voltage	V_{CEO}	150	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

SOT-23

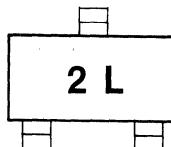


1. Base 2. Emitter 3. Collector

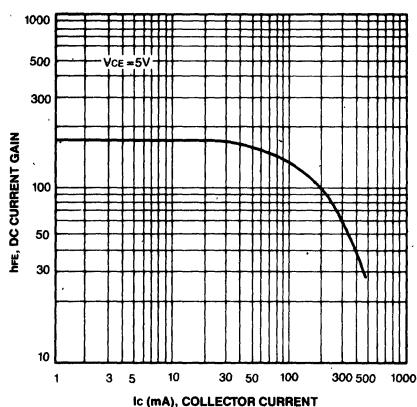
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	160		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1.0\text{mA}, I_B=0$	150		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=100\text{V}, I_E=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1.0\text{mA}$	50		
		$V_{CE}=5\text{V}, I_C=10\text{mA}$	60	240	
		$V_{CE}=5\text{V}, I_C=50\text{mA}$	50		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1.0\text{mA}$		0.2	V
		$I_C=50\text{mA}, I_B=5\text{mA}$		0.5	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=1.0\text{mA}$		1.0	V
		$I_C=50\text{mA}, I_B=5\text{mA}$		1.0	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=10\text{V}$ $f=100\text{MHz}$	100	300	MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		6.0	pF
Noise Figure	NF	$V_{CE}=5\text{V}, I_C=200\mu\text{A}$ $R_S=10\Omega$ $f=10\text{Hz}$ to 15.7KHz		8.0	dB

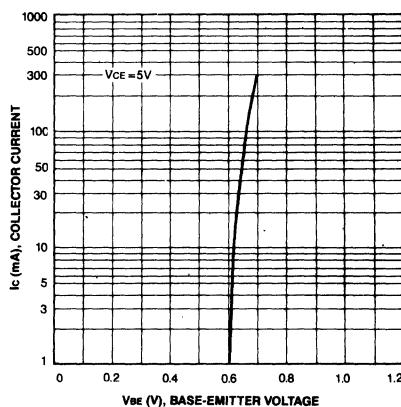
Marking



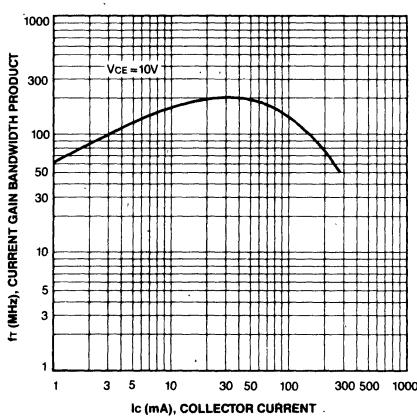
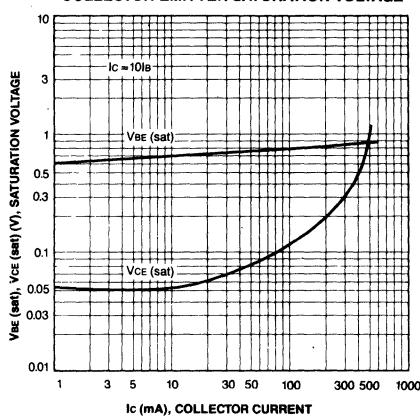
DC CURRENT GAIN



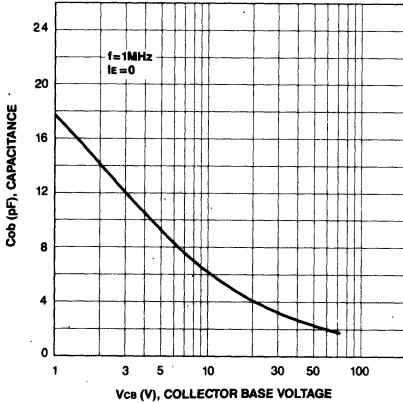
BASE-EMITTER ON VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE

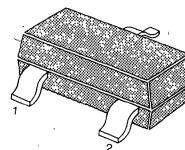


HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	160	V
Collector-Emitter Voltage	V_{CEO}	140	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

SOT-23

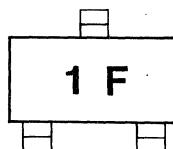


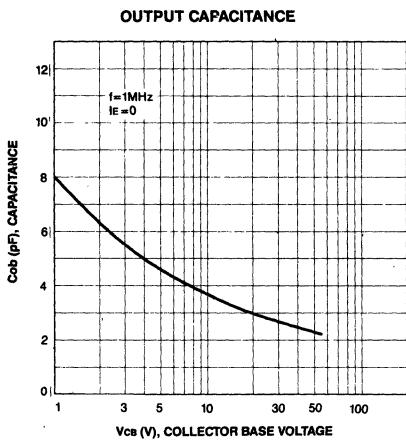
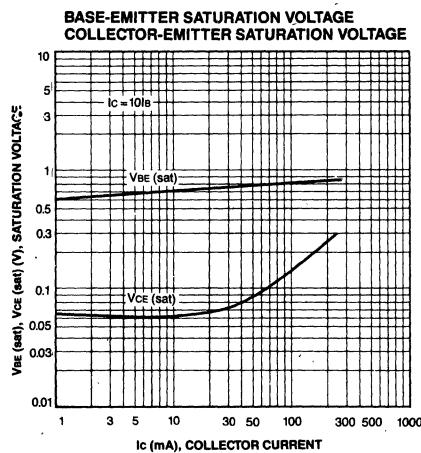
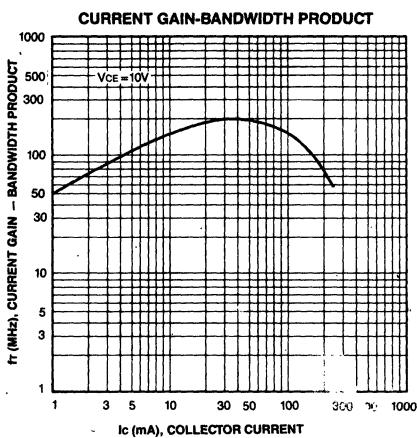
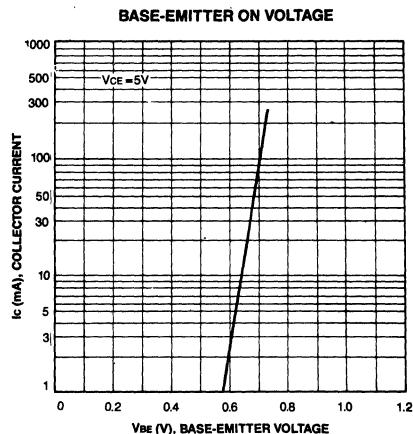
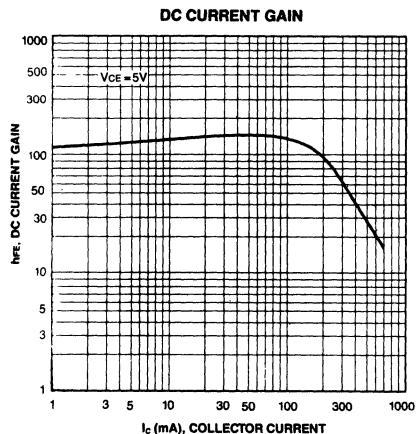
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	160		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	140		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	6		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=100\text{V}, I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_C=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1.0\text{mA}$ $V_{CE}=5\text{V}, I_C=10\text{mA}$ $V_{CE}=5\text{V}, I_C=50\text{mA}$	60 60 20	250	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$ $I_C=50\text{mA}, I_B=5\text{mA}$		0.15 0.25	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$ $I_C=50\text{mA}, I_B=5\text{mA}$		1.0 1.2	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=10\text{V}$ $f=100\text{MHz}$	100	300	MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		6.0	pF

Marking



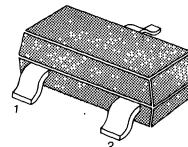


DARLINGTON TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	.12	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

SOT-23

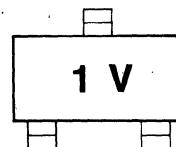


1. Base 2. Emitter 3. Collector

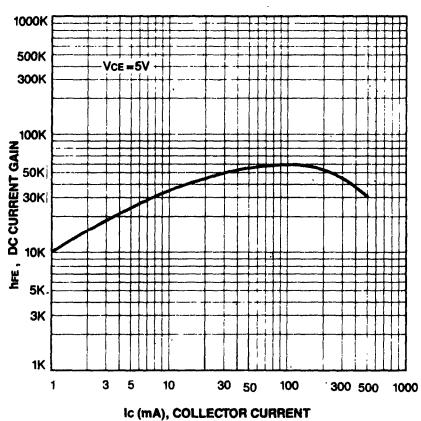
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10\text{mA}, I_B=0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	12		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$		50	nA
Collector Cutoff Current	I_{CEO}	$V_{CE}=25\text{V}, I_B=0$		1	μA
Emitter Cutoff Current	I_{EBO}	$V_{BE}=10\text{V}, I_C=0$		50	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\text{mA}$ $V_{CE}=5\text{V}, I_C=100\text{mA}$ $V_{CE}=5\text{V}, I_C=500\text{mA}$	10,000 20,000 14,000	100,000 200,000 140,000	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=50\text{mA}, I_B=0.5\text{mA}$ $I_C=500\text{mA}, I_B=0.5\text{mA}$		1.2 1.5	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=500\text{mA}, I_B=0.5\text{mA}$		2.0	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=50\text{mA}, V_{CE}=5\text{V}$		1.75	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		7	pF
Noise Figure	NF	$I_C=1\text{mA}, V_{CE}=5\text{V}$ $R_S=100\text{K}\Omega$ $f=1\text{KHz to } 15.7\text{KHz}$		10	dB

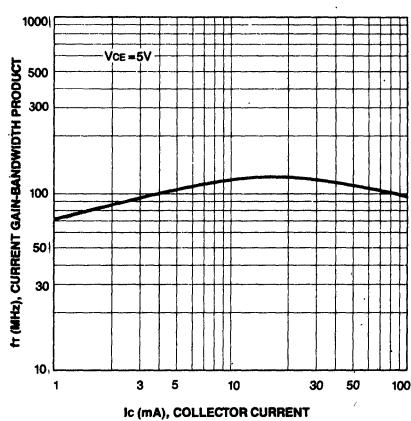
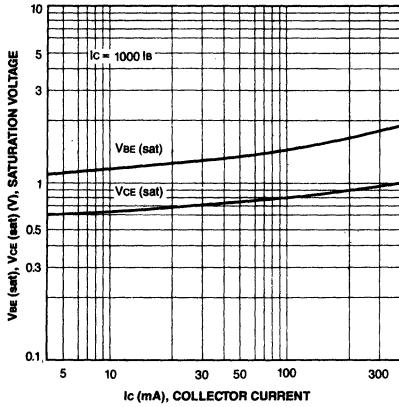
Marking



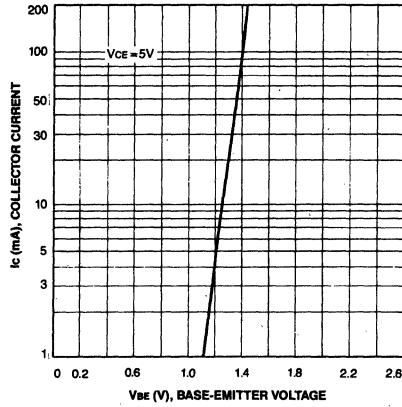
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

BASE-EMITTER ON VOLTAGE



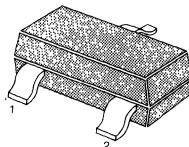
AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	50	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

- Refer to MMBT5088 for graphs

SOT-23

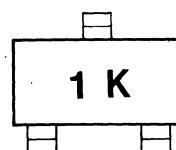


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 0.1\text{mA}, I_E = 0$	60		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1.0\text{mA}, I_B = 0$	50		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$		0.01	μA
Collector Cutoff Current	I_{CEO}	$V_{CE} = 30\text{V}, I_B = 0$		0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 5.0\text{V}, I_C = 0$		0.01	μA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 0.01\text{mA}$ $V_{CE} = 5\text{V}, I_C = 0.1\text{mA}$ $V_{CE} = 5\text{V}, I_C = 1.0\text{mA}$ $V_{CE} = 5\text{V}, I_C = 10\text{mA}$	250 250 250 250	650	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_E = 0.5\text{mA}$ $I_C = 100\text{mA}, I_E = 5\text{mA}$		0.2 0.6	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$I_C = 1\text{mA}, V_{CE} = 5\text{V}$	0.56	0.66	V
Current Gain-Bandwidth Product	f_T	$I_C = 1.0\text{mA}, V_{CE} = 5\text{V}$ $f = 100\text{MHz}$	100	700	MHz
Output Capacitance	C_{OB}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1.0\text{MHz}$		3	pF

Marking



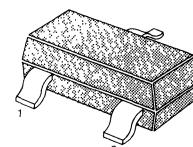
AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	55	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_c	200	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT5088 for graphs

SOT-23

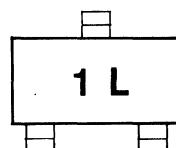


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=0.1\text{mA}, I_E=0$	55		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1.0\text{mA}, I_B=0$	45		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$		0.01	μA
Collector Cutoff Current	I_{CEO}	$V_{CE}=30\text{V}, I_B=0$		0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5.0\text{V}, I_C=0$		0.01	μA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=0.01\text{mA}$ $V_{CE}=5\text{V}, I_C=0.1\text{mA}$ $V_{CE}=5\text{V}, I_C=1.0\text{mA}$ $V_{CE}=5\text{V}, I_C=10\text{mA}$	500 500 500 500	1250	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=0.5\text{mA}$ $I_C=100\text{mA}, I_B=5\text{mA}$		0.2 0.6	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=1\text{mA}, V_{CE}=5\text{V}$	0.56	0.66	V
Current Gain-Bandwidth Product	f_T	$I_C=1.0\text{mA}, V_{CE}=5\text{V}$ $f=100\text{MHz}$	100	700	MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1.0\text{MHz}$		3	pF

Marking



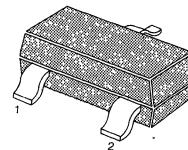
DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current (max)	I_c	500	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$

- Refer to MPSA05 for graphs

SOT-23



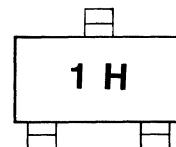
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=1\text{mA}, I_b=0$	60		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_e=100\mu\text{A}, I_c=0$	4		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=60\text{V}, I_b=0$		0.1	μA
Collector Cutoff Current	I_{CEO}	$V_{CE}=60\text{V}, I_b=0$		0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_c=10\text{mA}$ $V_{CE}=1\text{V}, I_c=100\text{mA}$	50	50	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=100\text{mA}, I_b=10\text{mA}$		0.25	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=1\text{V}, I_c=100\text{mA}$	100	1.2	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=2\text{V}, I_c=10\text{mA}, f=100\text{MHz}$			MHz

* Pulse Test: $PW \leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Marking



DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	80	V
Collector-Emitter Voltage	V_{CEO}	80	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{stg}	150	°C
Thermal Resistance Junction to Ambient	$R_{th(j/a)}$	357	°C/W

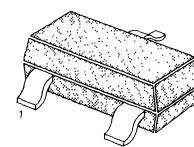
- Refer to MPSA05 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	80		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_C=0$	4		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=80\text{V}, I_E=0$		0.1	μA
Collector Cutoff Current	I_{CEO}	$V_{CE}=60\text{V}, I_B=0$		0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_C=10\text{mA}$	50		
		$V_{CE}=1\text{V}, I_C=100\text{mA}$	50		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=100\text{mA}, I_B=10\text{mA}$		0.25	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=1\text{V}, I_C=100\text{mA}$		1.2	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=2\text{V}, I_C=10\text{mA}, f=100\text{MHz}$	100		MHz

* Pulse Test: PW≤300μs, Duty Cycle≤2%

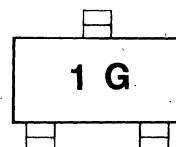
SOT-23



1. Base 2. Emitter 3. Collector

3

Marking



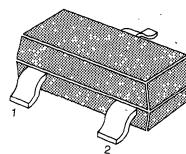
DARLINGTON AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CES}	30	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	300	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

- Refer to MMBT6427 for graphs

SOT-23

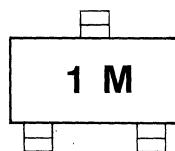


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	$I_B \text{ CES}$	$I_C=100\mu\text{A}, I_B=0$	30		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=10\text{V}, I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\text{mA}$ $V_{CE}=5\text{V}, I_C=100\text{mA}$	5,000 10,000		
Collector-Emitter Saturation Voltage	$V_{CE} \text{ (sat)}$	$I_C=100\text{mA}, I_B=0, 1\text{mA}$		1.5	V
Base-Emitter On Voltage	V_{BE}	$I_C=100\text{mA}, V_{CE}=5\text{V}$		2.0	V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=5\text{V}$ $f=100\text{MHz}$	125		MHz

Marking



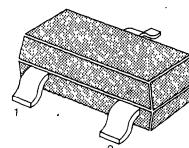
DARLINGTON AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CES}	30	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_c	300	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT6427 for graphs

SOT-23

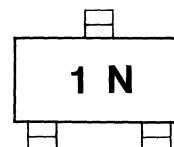


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_c=100\mu\text{A}, I_B=0$	30		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=10\text{V}, I_C=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=10\text{mA}$ $V_{CE}=5\text{V}, I_c=100\text{mA}$	10,000 20,000		
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=100\text{mA}, I_B=0.1\text{mA}$		1.5	V
Base-Emitter On Voltage	V_{BE}	$I_c=100\text{mA}, V_{CE}=5\text{V}$		2.0	V
Current Gain-Bandwidth Product	f_T	$I_c=10\text{mA}, V_{CE}=5\text{V}$ $f=100\text{MHz}$	125		MHz

Marking



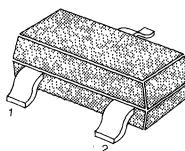
GENERAL PURPOSE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_c	100	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

- Refer to MMBT3904 for graphs

SOT-23

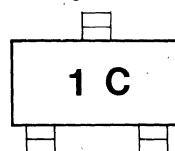


1 Base 2 Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 1.0\text{mA}, I_B = 0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_c = 0$	4		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$		100	nA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_c = 5\text{mA}$	40	400	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_c = 10\text{mA}, I_B = 1.0\text{mA}$		0.25	V
Current Gain-Bandwidth Product	f_T	$I_c = 5.0\text{mA}, V_{CE} = 10\text{V}$ $f = 100\text{MHz}$	125		MHz
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 100\text{KHz}$		4	pF

Marking

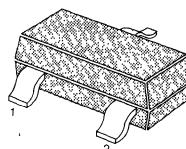


HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	300	V
Collector-Emitter Voltage	V_{CEO}	300	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C}/\text{W}$

SOT-23



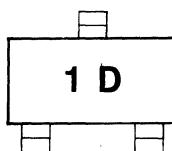
1 Base 2 Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_b=0$	300		V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=1\text{mA}, I_b=0$	300		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_e=100\mu\text{A}, I_c=0$	6		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=200\text{V}, I_e=0$		0.1	μA
Emitter Cutoff Current	I_{EBO}	$V_{BE}=6\text{V}, I_c=0$		0.1	μA
* DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_c=1\text{mA}$ $V_{CE}=10\text{V}, I_c=10\text{mA}$ $V_{CE}=10\text{V}, I_c=30\text{mA}$	25 40 40		*
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=20\text{mA}, I_b=2\text{mA}$		0.5	V
* Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=20\text{mA}, I_b=2\text{mA}$		0.9	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=20\text{V}, I_c=10\text{mA}, f=100\text{MHz}$	50		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB}=20\text{V}, I_e=0, f=1\text{MHz}$		3	pF

* Pulse Test: $PW \leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Marking

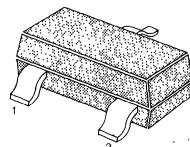


HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	200	V
Collector-Emitter Voltage	V_{CEO}	200	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



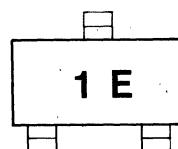
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_e=0$	200		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=1\text{mA}, I_b=0$	200		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_e=100\mu\text{A}, I_c=0$	6		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=160\text{V}, I_e=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_c=0$		100	nA
*DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_c=1\text{mA}$ $V_{CE}=10\text{V}, I_c=10\text{mA}$ $V_{CE}=10\text{V}, I_c=30\text{mA}$	25 40 40		
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=20\text{mA}, I_b=2\text{mA}$		0.5	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c=20\text{mA}, I_b=2\text{mA}$		0.9	V
Current Gain-Bandwidth Product	f_T	$I_c=10\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	50		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB}=20\text{V}, I_e=0$ $f=1\text{MHz}$		4	pF

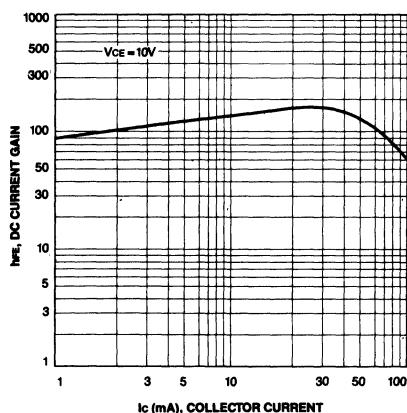
*Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Marking

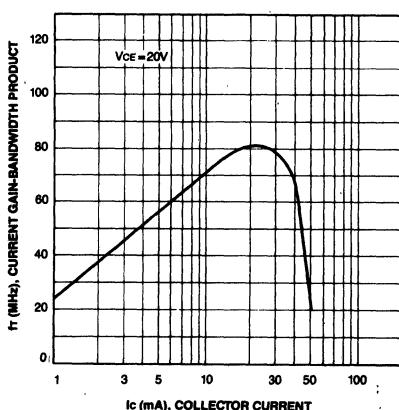
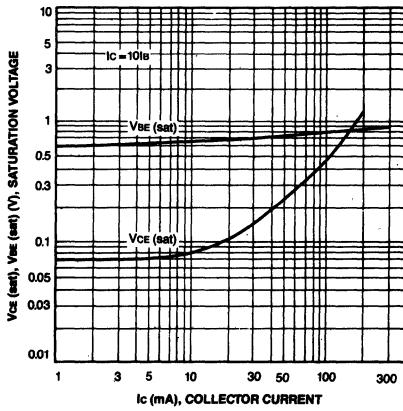


SAMSUNG SEMICONDUCTOR

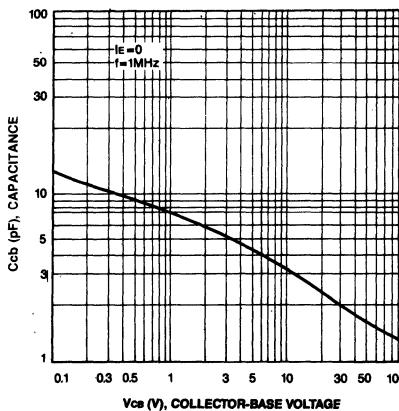
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE

COLLECTOR-BASE CAPACITANCE



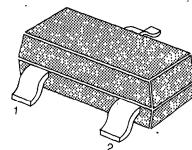
DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-60	V
Collector-Emitter Voltage	V_{CEO}	-60	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$

- Refer to MPSA55 for graphs

SOT-23



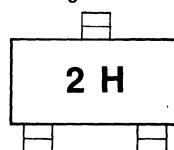
1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-1\text{mA}, I_B=0$	-60		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-100\mu\text{A}, I_C=0$	-4		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-60\text{V}, I_B=0$		-0.1	μA
Collector Cutoff Current	I_{CEO}	$V_{CE}=-60\text{V}, I_B=0$		-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-1\text{V}, I_C=-10\text{mA}$ $V_{CE}=-1\text{V}, I_C=-100\text{mA}$	50	50	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=-100\text{mA}, I_B=-10\text{mA}$		-0.25	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=-1\text{V}, I_C=-100\text{mA}$		-1.2	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-1\text{V}, I_C=-100\text{mA}, f=100\text{MHz}$	50		MHz

* Pulse Test: PW≤300μs, Duty Cycle≤2%

Marking



SAMSUNG SEMICONDUCTOR

DRIVER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-80	V
Collector-Emitter Voltage	V_{CEO}	-80	V
Emitter-Base Voltage	V_{EBO}	-4	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$

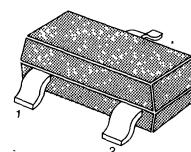
- Refer to MPSA55 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-1\text{ mA}, I_B=0$	-80		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-100\mu\text{A}, I_C=0$	-4		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-80\text{ V}, I_E=0$		-0.1	μA
Collector Cutoff Current	I_{CEO}	$V_{CE}=-60\text{ V}, I_B=0$		-0.1	μA
DC Current Gain	h_{FE}	$V_{CE}=-1\text{ V}, I_C=-10\text{ mA}$	50		
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$V_{CE}=-1\text{ V}, I_C=-100\text{ mA}$	50	-0.25	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$V_{CE}=-1\text{ V}, I_C=-100\text{ mA}$		-1.2	V
Current Gain-Bandwidth Product	f_T	$V_{CE}=-1\text{ V}, I_C=-100\text{ mA}, f=100\text{ MHz}$	50		MHz

* Pulse Test: $PW \leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

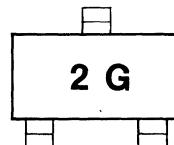
SOT-23



1. Base 2. Emitter 3. Collector

3

Marking

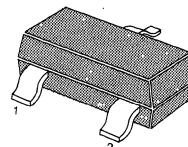


DARLINGTON TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CES}	30	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$

SOT-23



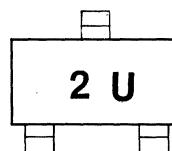
1. Base 2. Emitter 3. Collector

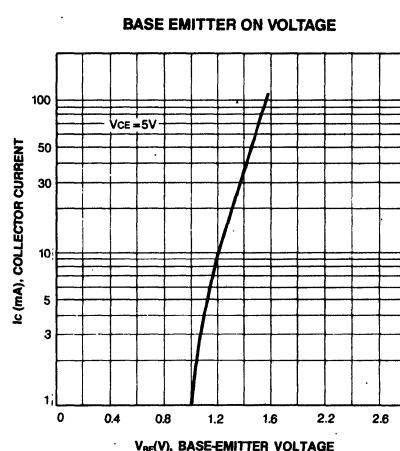
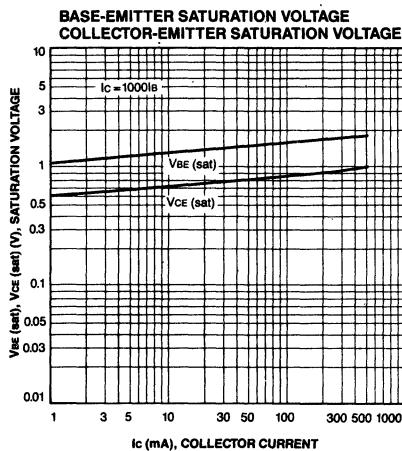
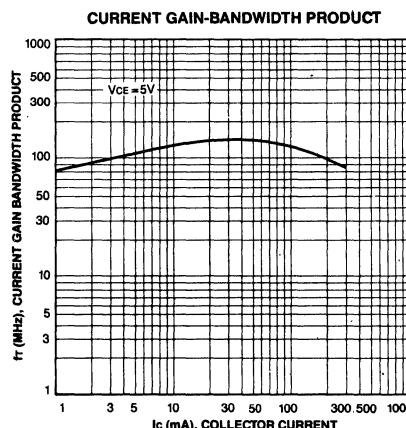
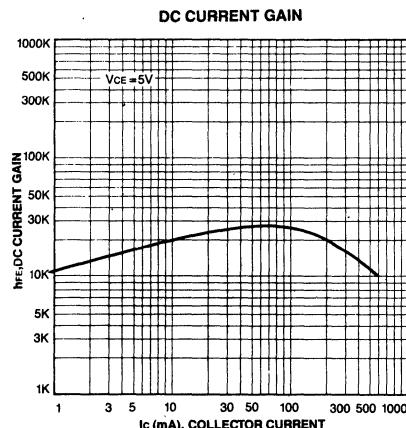
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_c=100\mu\text{A}, I_B=0$	30		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_B=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{BE}=10\text{V}, I_C=0$	100		nA
*DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_c=10\text{mA}$ $V_{CE}=5\text{V}, I_c=100\text{mA}$	5,000	10,000	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=100\text{mA}, I_B=0.1\text{mA}$		1.5	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c=100\text{mA}, V_{CE}=5\text{V}$		2	V
Current Gain-Bandwidth Product	f_T	$I_c=10\text{mA}, V_{CE}=50\text{V}$ $f=100\text{MHz}$	125		MHz

*Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Marking





DARLINGTON TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CES}	30	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{Stg}	150	$^\circ\text{C}$

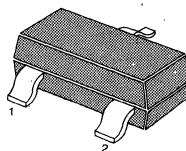
- Refer to MMBTA63 for graphs

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C=100\mu\text{A}, I_B=0$	30		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=30\text{V}, I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{BE}=10\text{V}, I_C=0$		100	nA
*DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=10\text{mA}$ $V_{CE}=5\text{V}, I_C=100\text{mA}$	10,000 20,000	1.5 2	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=100\text{mA}, I_B=0.1\text{mA}$			V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=100\text{mA}, V_{CE}=5\text{V}$			V
Current Gain-Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=50\text{V}$ $f=100\text{MHz}$	125		MHz

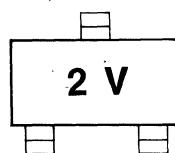
* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

SOT-23



1. Base 2. Emitter 3. Collector

Marking



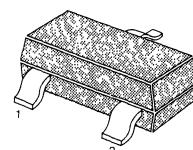
AMPLIFIER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$

- Refer to MMBT5086 for graphs

SOT-23

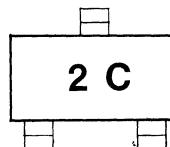


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1.0\text{mA}, I_B = 0$	40		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	4		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$		100	nA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 5.0\text{mA}$	40	400	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1.0\text{mA}$		0.25	V
Current Gain-Bandwidth Product	f_T	$I_C = 5.0\text{mA}, V_{CE} = 10\text{V}$ $f = 100\text{MHz}$	125		MHz
Output Capacitance	C_{OB}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 100\text{KHz}$		4.0	pF

Marking



HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-300	V
Collector-Emitter Voltage	V_{CEO}	-300	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$

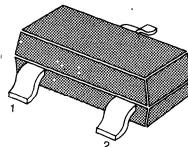
- Refer to MPSA92/93 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-300		V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1\text{mA}, I_B = 0$	-300		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	-5		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -200\text{V}, I_E = 0$		-0.25	μA
Emitter Cutoff Current	I_{EBO}	$V_{BE} = -3\text{V}, I_C = 0$		-0.1	μA
* DC Current Gain	h_{FE}	$V_{CE} = -10\text{V}, I_C = -1\text{mA}$ $V_{CE} = -10\text{V}, I_C = -10\text{mA}$ $V_{CE} = -10\text{V}, I_C = -30\text{mA}$	25 40 25		
* Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -20\text{mA}, I_B = -2\text{mA}$		-0.5	V
* Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C = -20\text{mA}, I_B = -2\text{mA}$		-0.9	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -20\text{V}, I_C = -10\text{mA}, f = 100\text{MHz}$	50		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB} = -20\text{V}, I_E = 0, f = 1\text{MHz}$		6	pF

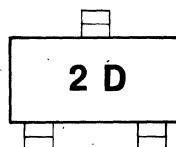
* Pulse Test: PW≤300μs, Duty Cycle≤2%

SOT-23



1. Base 2. Emitter 3. Collector

Marking



HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-200	V
Collector-Emitter Voltage	V_{CEO}	-200	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{TH(j-a)}$	357	$^\circ\text{C/W}$

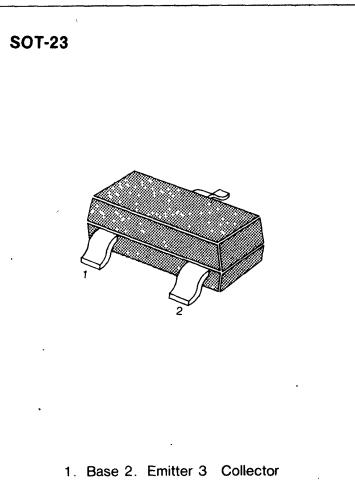
- Refer to MPSA92/93 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

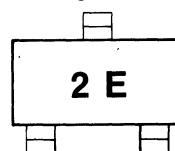
3

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-200		V
* Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1\text{mA}, I_E = 0$	-200		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	-5		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -160\text{V}, I_E = 0$		-0.25	μA
Emitter Cutoff Current	I_{EBO}	$V_{BE} = -3\text{V}, I_C = 0$		-0.1	μA
* DC Current Gain	h_{FE}	$V_{CE} = -10\text{V}, I_C = -1\text{mA}$ $V_{CE} = -10\text{V}, I_C = -10\text{mA}$ $V_{CE} = -10\text{V}, I_C = -30\text{mA}$	25 40 25		
* Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -20\text{mA}, I_E = -2\text{mA}$		-0.5	V
* Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C = -20\text{mA}, I_E = -2\text{mA}$		-0.9	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = -20\text{V}, I_C = -10\text{mA}, f = 100\text{MHz}$	50		MHz
Collector-Base Capacitance	C_{CB}	$V_{CB} = -20\text{V}, I_E = 0, f = 1\text{MHz}$		8	pF

* Pulse Test: PW $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



Marking



VHF/UHF TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

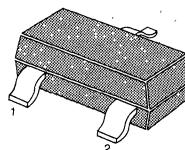
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	3	V
Collector Dissipation	P_c	350	mW
Storage Temperature	T_{stg}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C/W}$

- Refer to MPSH10/11 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

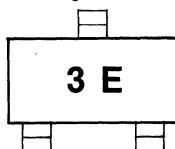
Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	30		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_E = 0$	25		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	3		V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 25\text{V}, I_E = 0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{BE} = 2\text{V}, I_C = 0$		100	nA
DC Current Gain	h_{FE}	$V_{CE} = 10\text{V}, I_C = 4\text{mA}$	60		
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 4\text{mA}, I_E = 0.4\text{mA}$		0.5	V
Base-Emitter On Voltage	V_{BE}	$V_{CE} = 10\text{V}, I_C = 4\text{mA}$		0.95	V
Current Gain-Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 4\text{mA}, f = 100\text{MHz}$	650		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$		0.7	pF
Common-Base Feedback Capacitance	C_{rb}	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$		0.65	pF
Collector Base Time Constant	$C_C \cdot r_{bb'}$	$V_{CB} = 10\text{V}, I_C = 4\text{mA}, f = 31.8\text{MHz}$		9	ps

SOT-23



1. Base 2. Emitter 3. Collector

Marking



VHF MIXER TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	350	mW
Storage Temperature	T_{STG}	150	$^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C}/\text{W}$

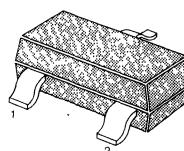
- Refer to MPSH24 for graphs.

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	4			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}, I_E=0$			50	nA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=8\text{mA}$	30			
*Current Gain-Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=8\text{mA}$ $f=100\text{MHz}$	400	620		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$		0.25		pF
Conversion Gain (213MHz to 45MHz) (60MHz to 45MHz)	C_G	$I_C=8\text{mA}, V_{CC}=20\text{V}$ Oscillator Injection=150mV	19	24	0.36	dB
			24	29		dB

* Pulse Test: $PW \leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

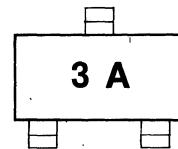
SOT-23



1. Base 2. Emitter 3. Collector

3

Marking



SAMSUNG SEMICONDUCTOR

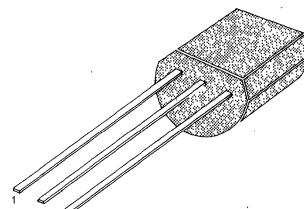
GENERAL PURPOSE TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 30V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1 Emitter 2. Base 3. Collector

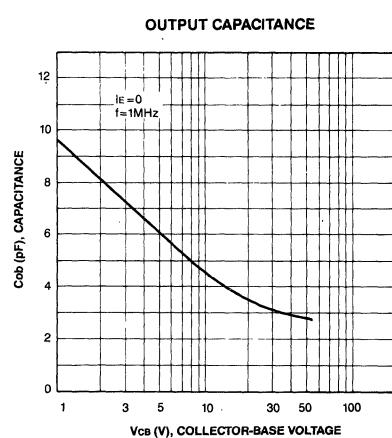
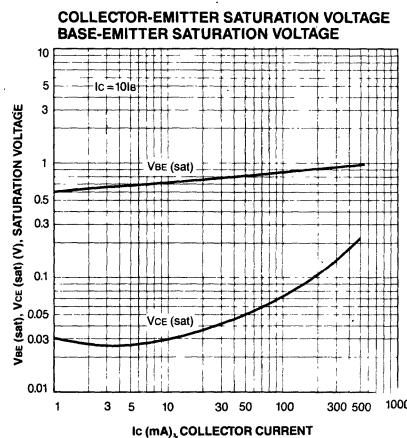
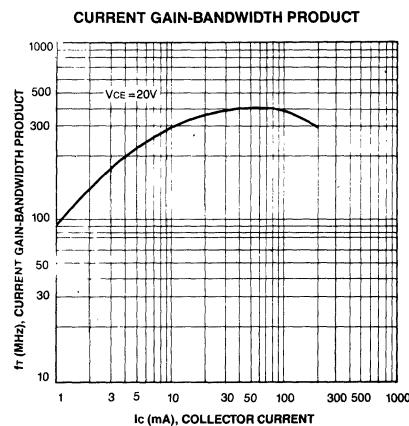
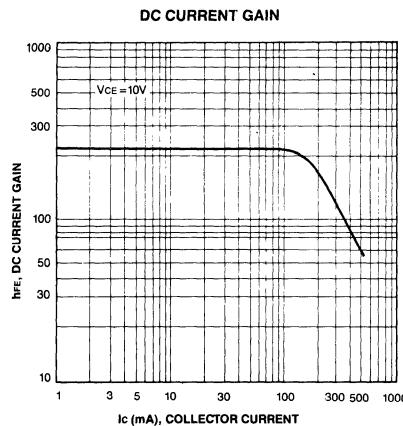
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 50V, I_E = 0$			10	nA
DC Current Gain	h_{FE}	$I_C = 0.1\text{mA}, V_{CE} = 10V$ $I_C = 1\text{mA}, V_{CE} = 10V$ $I_C = 10\text{mA}, V_{CE} = 10V$ $*I_C = 150\text{mA}, V_{CE} = 10V$ $*I_C = 500\text{mA}, V_{CE} = 10V$	35 50 75 100 30		300	
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$			0.4 1.6	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$			1.3 2.6	V
Output Capacitance	C_{OB}	$V_{CB} = 10V, I_E = 0, f = 1\text{MHz}$			8	pF
Current Gain Bandwidth Product	f_T	$I_C = 20\text{mA}, V_{CE} = 20V$ $f = 100\text{MHz}$	250			MHz
Turn On Time	t_{on}	$V_{CC} = 30V, V_{BE} = 0.5V$ $I_C = 150\text{mA}, I_{B1} = 15\text{mA}$			35	ns
Turn Off Time	t_{off}	$V_{CC} = 30V, I_C = 150\text{mA}$ $I_{B1} = I_{B2} = 15\text{mA}$			285	ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Also available as a PN2222





GENERAL PURPOSE TRANSISTOR

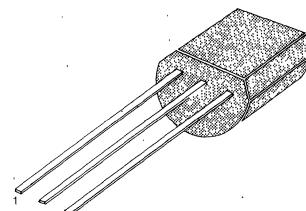
- Collector-Emitter Voltage: $V_{CEO}=40V$
- Collector Dissipation: $P_c(\text{max})=625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	75	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

*Refer to MPS2222 for graphs

TO-92



1 Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=10\mu\text{A}, I_E=0$	75			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10\text{mA}, I_B=0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=60\text{V}, I_E=0$			0.01	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=3\text{V}, I_C=0$			10	nA
DC Current Gain	h_{FE}	$I_C=0.1\text{mA}, V_{CE}=10\text{V}$ $I_C=1\text{mA}, V_{CE}=10\text{V}$ $I_C=10\text{mA}, V_{CE}=10\text{V}$ $*I_C=150\text{mA}, V_{CE}=10\text{V}$ $*I_C=500\text{mA}, V_{CE}=10\text{V}$	35 50 75 100 40		300	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=150\text{mA}, I_B=15\text{mA}$ $I_C=500\text{mA}, I_B=50\text{mA}$			0.3 1	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=150\text{mA}, I_E=15\text{mA}$ $I_C=500\text{mA}, I_E=50\text{mA}$		0.6	1.2 2	V
Current Gain Bandwidth Product	f_T	$I_C=20\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	300			MHz
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$			8	pF
Turn On Time	t_{on}	$V_{CC}=30\text{V}, I_C=150\text{mA}$			35	ns
Turn Off Time	t_{off}	$I_{B1}=15\text{mA}, V_{BE}(\text{off})=0.5\text{V}$ $V_{CC}=30\text{V}, I_C=150\text{mA}$ $I_{B1}=I_{B2}=15\text{mA}$			285	ns
Noise Figure	NF	$I_C=100\mu\text{A}, V_{CE}=10\text{V}$ $R_S=1\text{k}\Omega, f=1\text{kHz}$			4	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
 Also available as a PN2222A



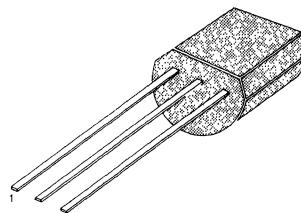
GENERAL PURPOSE TRANSISITOR

- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

3

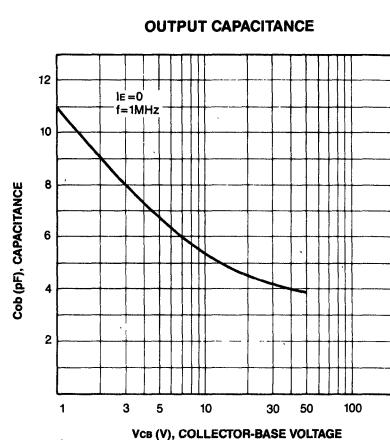
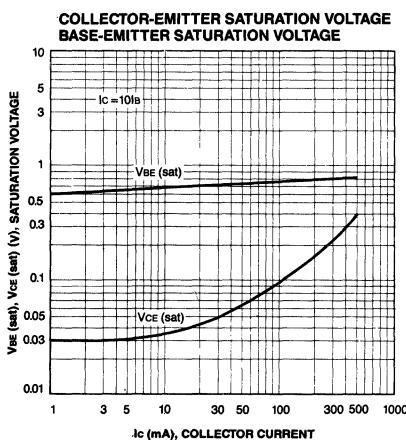
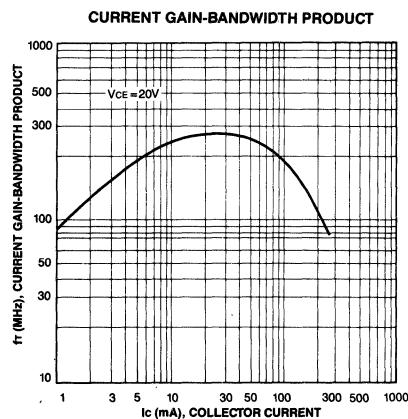
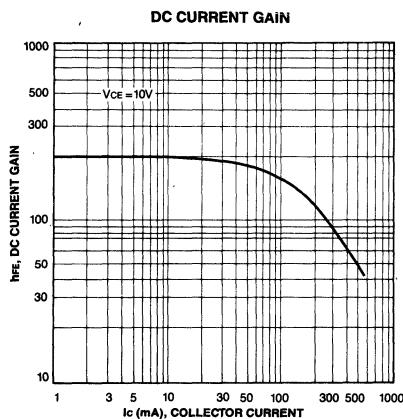
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	60			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 50V, I_E = 0$			20	nA
DC Current Gain	h_{FE}	$I_C = 0.1\text{mA}, V_{CE} = 10V$ $I_C = 1\text{mA}, V_{CE} = 10V$ $I_C = 10\text{mA}, V_{CE} = 10V$ * $I_C = 150\text{mA}, V_{CE} = 10V$ * $I_C = 500\text{mA}, V_{CE} = 10V$	35 50 75 100 30		300	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$		0.4 1.6		V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 150\text{mA}, I_B = 15\text{mA}$ $I_C = 500\text{mA}, I_B = 50\text{mA}$		1.3 2.6		V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 1\text{MHz}$		8		pF
*Current Gain Bandwidth Product	f_T	$I_C = 50\text{mA}, V_{CE} = 20V$ $f = 100\text{MHz}$	200			MHz
Turn On Time	t_{on}	$V_{CC} = 30V, I_C = 150\text{mA}$ $I_{B1} = 15\text{mA}$		45		ns
Turn Off Time	t_{off}	$V_{CC} = 6V, I_C = 150\text{mA}$ $I_{B1} = I_{B2} = 15\text{mA}$		100		ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

Also available as a PN2907





GENERAL PURPOSE TRANSISITOR

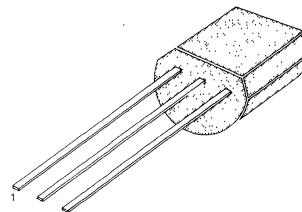
- Collector-Emitter Voltage: $V_{CEO} = 60V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

• Refer to MPS2907 for graphs

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1 Emitter 2. Base 3 Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 10\mu\text{A}, I_E = 0$	60			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 10\text{mA}, I_B = 0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CE} = 50V, I_E = 0$				
DC Current Gain	h_{FE}	$I_c = 0.1\text{mA}, V_{CE} = 10V$ $I_c = 1\text{mA}, V_{CE} = 10V$ $I_c = 10\text{mA}, V_{CE} = 10V$ * $I_c = 150\text{mA}, V_{CE} = 10V$ * $I_c = 500\text{mA}, V_{CE} = 10V$	75 100 100 100 50	10	300	nA
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c = 150\text{mA}, I_B = 15\text{mA}$ $I_c = 500\text{mA}, I_B = 50\text{mA}$		0.4 1.6		V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_c = 150\text{mA}, I_B = 15\text{mA}$ $I_c = 500\text{mA}, I_B = 50\text{mA}$		1.3 2.6		V
Output Capacitance	C_{ob}	$V_{CE} = 10V, I_E = 0$ $f = 1\text{MHz}$		8		pF
*Current Gain Bandwidth Product	f_T	$I_c = 50\text{mA}, V_{CE} = 20V$ $f = 100\text{MHz}$	200			MHz
Turn On Time	t_{on}	$V_{CC} = 30V, I_c = 150\text{mA}$ $I_{B1} = 15\text{mA}$		45		ns
Turn Off Time	t_{off}	$V_{CC} = 6V, I_c = 150\text{mA}$ $I_{B1} = I_{B2} = 15\text{mA}$		100		ns

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
Also available as a PN2907A

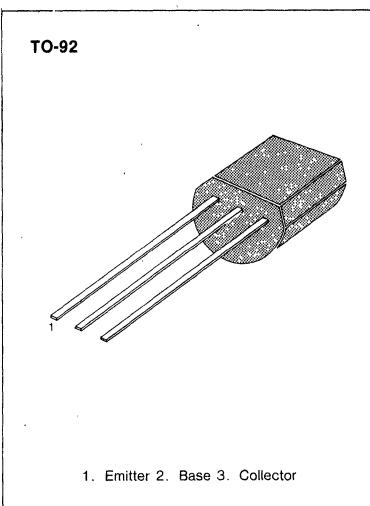


AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO}=25V$
- Collector Dissipation: P_c (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



1. Emitter 2. Base 3. Collector

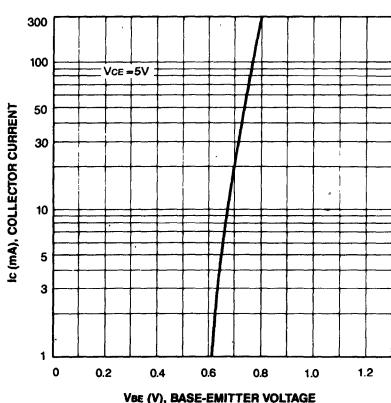
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA, I_B=0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu A, I_C=0$	5			
Collector Cut-off Current	I_{CBO}	$V_{CB}=20V, I_E=0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE}=3V, I_C=0$			100	nA
*DC Current Gain	h_{FE}	$I_C=50mA, V_{CE}=5V$	60		300	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=50mA, I_B=5mA$			0.25	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$			12	pF
Current Gain Bandwidth Product	f_T	$I_C=50mA, V_{CE}=5V$ $f=20MHz$	100			MHz
* Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=50mA, V_{CE}=5V$	0.6		1	V

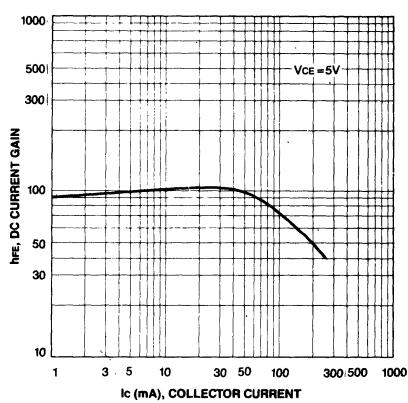
* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



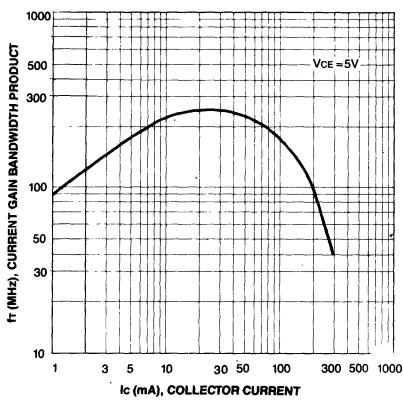
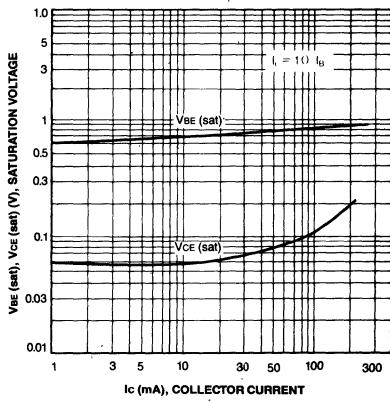
BASE-EMITTER ON VOLTAGE



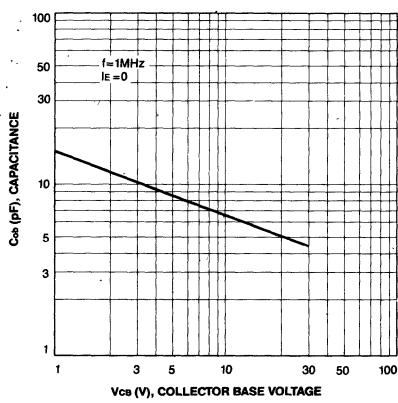
DC CURRENT GAIN



CURRENT GAIN BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE



AMPLIFIER TRANSISTOR

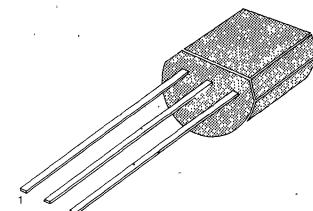
- Collector-Emitter Voltage: $V_{CEO} = 30V$
- Collector Dissipation: P_c (max) = 625mW

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

* Refer to MPS3702 for graphs

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1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu A, I_E = 0$	50			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 10mA, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	5			V
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CE} = 20V, I_E = 0$			100	nA
*DC Current Gain	h_{FE}	$I_c = 50\mu A, V_{CE} = 5V$			150	
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_c = 50mA, I_B = 5mA$	30		0.25	V
Output Capacitance	C_{ob}	$V_{ce} = 10V, I_E = 0$ $f = 1MHz$			12	pF
Current Gain Bandwidth Product	f_T	$I_c = 50mA, V_{CE} = 5V$ $f = 20MHz$	100			MHz
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_c = 50mA, V_{CE} = 5V$	0.6		1	V

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



GENERAL PURPOSE TRANSISTOR

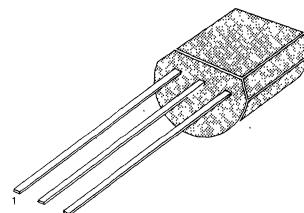
- Collector-Emitter Voltage: $V_{CEO}=30V$
- Collector Dissipation: $P_c(\text{max})=625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N4400 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_E=0$	50			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=10\text{mA}, I_B=0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_C=0$	5			V
Emitter Cut-off Current	I_{EBO}	$V_{BE}=3V, I_C=0$		100	100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB}=20V, I_E=0$		100	100	nA
*DC Current Gain	h_{FE}	$I_C=50\text{mA}, V_{CE}=2V$		300		
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=100\text{mA}, I_B=5\text{mA}$		0.6		V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$		12		pF
Current Gain Bandwidth Product	f_T	$f=1\text{MHz}$ $I_C=50\text{mA}, V_{CE}=2V$	100			MHz
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$f=20\text{MHz}$ $I_C=100\text{mA}, V_{CE}=2V$	0.5		1	V

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

GENERAL PURPOSE TRANSISTOR

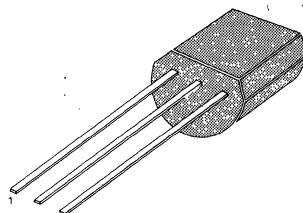
- Collector-Emitter Voltage: $V_{CEO} = 30V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_c	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N4400 for graphs

TO-92



1 Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu\text{A}, I_E = 0$	50			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 10\text{mA}, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	5			V
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3\text{V}, I_C = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20\text{V}, I_E = 0$			100	nA
*DC Current Gain	h_{FE}	$I_c = 50\text{mA}, V_{CE} = 2\text{V}$			150	nA
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c = 100\text{mA}, I_B = 5\text{mA}$	50		0.8	V
Output Capacitance	C_{ob}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$			12	pF
Current Gain Bandwidth Product	f_T	$I_c = 50\text{mA}, V_{CE} = 2\text{V}$ $f = 20\text{MHz}$	100			MHz
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c = 100\text{mA}, V_{CE} = 2\text{V}$	0.5		1	V

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



SAMSUNG SEMICONDUCTOR

GENERAL PURPOSE TRANSISTOR

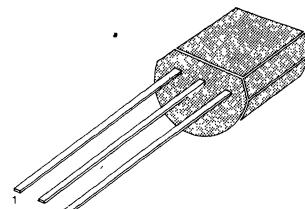
- Collector-Emitter Voltage: $V_{CEO}=20V$
- Collector Dissipation: $P_c(\max)=625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

• Refer to 2N4400 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA, I_E=0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu A, I_C=0$	5			V
Emitter Cut-off Current	I_{EBO}	$V_{BE}=3V, I_C=0$		100	nA	
Collector Cut-off Current	I_{CBO}	$V_{CB}=20V, I_E=0$		100	nA	
*DC Current Gain	h_{FE}	$I_C=50mA, V_{CE}=2V$	30		600	nA
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=100mA, I_B=5mA$			1	V
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=1MHz$			12	pF
Current Gain Bandwidth Product	f_T	$I_C=50mA, V_{CE}=2V$ $f=20MHz$	100			MHz
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=100mA, V_{CE}=2V$	0.5		1	V

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



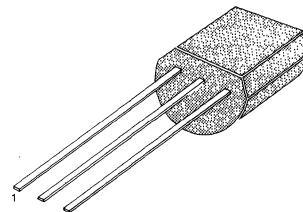
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 60V$
- Collector Dissipation: $P_C (\text{max}) = 200\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	60	V
Collector-Emitter Voltage	V_{CES}	60	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Dissipation	P_C	200	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_B = 0$	60			V
*Collector-Emitter Sustaining Voltage	$BV_{CEO(\text{SUS})}$	$I_C = 5\text{mA}, I_B = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 10\mu\text{A}, V_{BE} = 0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			10	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$			20	nA
DC Current Gain	h_{FE}	$I_C = 100\mu\text{A}, V_{CE} = 5V$ $I_C = 1\text{mA}, V_{CE} = 5V$ $I_C = 10\text{mA}, V_{CE} = 5V$	100 100 100		300	
*Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_B = 0.5\text{mA}$			0.25	V
*Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C = 10\text{mA}, I_B = 0.5\text{mA}$			0.9	V
Output Capacitance	C_{ob}	$V_{CB} = 5V, I_E = 0$ $f = 1\text{MHz}$			6	pF
Noise Figure	NF	$I_C = 20\mu\text{A}, V_{CE} = 5V$ $R_S = 10\text{k}\Omega, f = 1\text{kHz}$ $I_C = 250\mu\text{A}, V_{CE} = 5V$ $R_S = 1\text{k}\Omega, f = 1\text{kHz}$			3	dB
					3	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

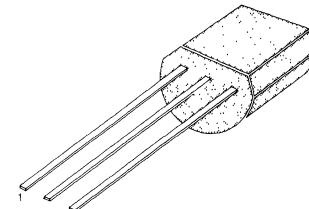
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 200\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	40	V
Collector-Emitter Voltage	V_{CES}	40	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Dissipation	P_C	150	mW
Junction Temperature	T_J	-55 ~ 150	°C
Storage Temperature	T_{Stg}		°C

TO-92



1 Emitter 2 Base 3 Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	40			V
*Collector-Emitter Sustaining Voltage	$BV_{CEO}(\text{sus})$	$I_C = 5\text{mA}, I_B = 0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 5\text{mA}, V_{BE} = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 50V, I_E = 0$		10		nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$		20		nA
DC Current Gain	h_{FE}	$I_C = 100\mu\text{A}, V_{CE} = 5V$ $I_C = 1\text{mA}, V_{CE} = 5V$ $I_C = 10\text{mA}, V_{CE} = 5V$	250 250 250	700		
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 0.5\text{mA}$		0.25		V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 0.5\text{mA}$		0.9		V
Output Capacitance	C _{ob}	$V_{CB} = 5V, I_E = 0$ $f = 1\text{MHz}$		6		pF
Noise Figure	NF	$I_C = 20\mu\text{A}, V_{CE} = 5V$ $R_S = 10\text{k}\Omega, f = 1\text{KHz}$ $I_C = 250\mu\text{A}, V_{CE} = 5V$ $R_S = 1\text{k}\Omega, f = 1\text{KHz}$		2		dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

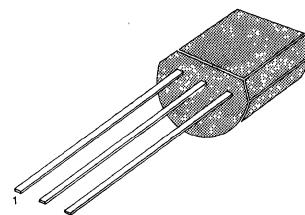
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 60V$
- Collector Dissipation: $P_C (\text{max}) = 200\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	60	V
Collector-Emitter Voltage	V_{CES}	60	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Dissipation	P_C		mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 10\mu\text{A}, I_E = 0$	60			V
*Collector-Emitter Sustaining Voltage	$BV_{CEO} (\text{sus})$	$I_C = 5\text{mA}, I_B = 0$	60			V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 5\text{mA}, V_{BE} = 0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$		10		nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 3V, I_C = 0$		20		nA
DC Current Gain	h_{FE}	$I_C = 100\mu\text{A}, V_{CE} = 5V$	250	700		
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 0.5\text{mA}$		0.25		V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 0.5\text{mA}$		0.9		V
Output Capacitance	C_{ob}	$V_{CB} = 5V, I_E = 0$ $f = 1\text{MHz}$		6		pF
Noise Figure	NF	$I_C = 20\mu\text{A}, V_{CE} = 5V$ $R_S = 10\text{K}\Omega, f = 1\text{KHz}$ $I_C = 250\mu\text{A}, V_{CE} = 5V$ $R_S = 1\text{K}\Omega, f = 1\text{KHz}$		2		dB
				2		dB



AMPLIFIER TRANSISTOR

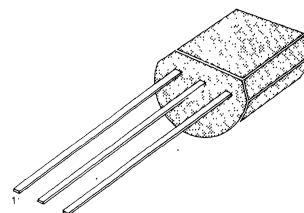
- Collector-Emitter Voltage: $V_{CEO} = 25V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	25	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to MPSA10 for graphs

TO-92



1 Emitter 2 Base 3 Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	25		100	V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 25V, I_E = 0$			100	nA
Collector Cut-off Current	I_{CES}	$V_{CE} = 25V, V_{BE} = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 5V, I_C = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 10\text{mA}, V_{CE} = 10V$	100		500	nA
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$			0.25	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$			0.25	V
Current Gain Bandwidth Product	f_T	$I_C = 2\text{mA}, V_{CE} = 5V$			1.2	MHz
Base Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 10\text{mA}, V_{CE} = 10V$	0.5	0.75 120		V

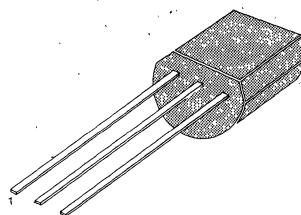
* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

HIGH FREQUENCY TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	20	V
Collector-Emitter Voltage	V_{CEO}	12	V
Emitter-Base Voltage	V_{EBO}	2.5	V
Collector Current	I_C	50	mA
Collector Dissipation ($T_a=25^\circ\text{C}$) Derate above 25°C	P_C	200 1.14	mW mW/ $^\circ\text{C}$
Collector Dissipation ($T_c=25^\circ\text{C}$) Derate above 25°C	P_C	300 1.71	mW mW/ $^\circ\text{C}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Emitter Sustaining Voltage	$V_{CEO}(\text{sus})$	$I_C=3\text{mA}, I_B=0$	12		V
Collector Base Breakdown Voltage	BV_{CBO}	$I_C=0.001\text{mA}, I_E=0$	20		V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E=0.01\text{mA}, I_C=0$	2.5		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}, I_E=0$		0.02	μA
		$V_{CB}=15\text{V}, I_E=0, T_a=150^\circ\text{C}$		1	μA
DC Current Gain	h_{FE}	$V_{CE}=1\text{V}, I_C=3\text{mA}$	25	250	
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$		0.4	V
Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$		1	V
Current Gain Bandwidth Product	f_T	$V_{CE}=6\text{V}, I_C=5\text{mA}, f=100\text{MHz}$	900	2000	MHz
Collector Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0, f=0.1 \text{ to } 1\text{MHz}$		1	pF
Small Signal Current Gain	h_{fe}	$V_{CE}=6\text{V}, I_C=2\text{mA}, f=1\text{KHz}$	25	300	
Collector Base Time Constant	C_{crbb}	$V_{CB}=6\text{V}, I_E=2\text{mA}, f=31.9\text{MHz}$	3	14	ps
Noise Figure	NF	$V_{CE}=6\text{V}, I_C=1.5\text{mA}, f=200\text{MHz}$ $R_s=50\Omega$		4.5	dB
Common Emitter Amplifier Power Gain	Gpe	$V_{CE}=6\text{V}, I_C=5\text{mA}, f=200\text{MHz}$	15		dB



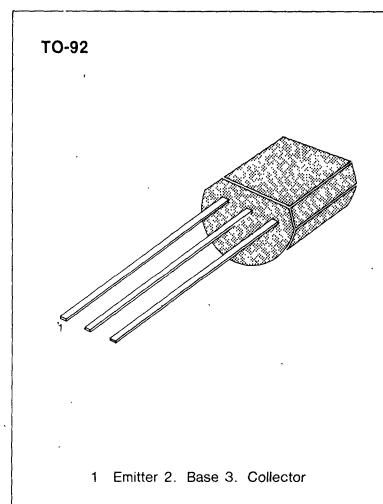
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 30V$
- Collector Dissipation: $P_c (\max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	30	V
Collector-Base Voltage	V_{CBO}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N3904 for graphs



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 500\mu A, I_B = 0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			50	nA
DC Current Gain	h_{FE}	$I_C = 2mA, V_{CE} = 10V$	90		180	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	* $I_C = 100mA, V_{CE} = 10V$	60			
Output Capacitance	C_{ob}	$I_C = 50mA, I_B = 5mA$ $V_{CB} = 10V, I_E = 0$ $f = 100KHz$			0.5 3.5	pF

*Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



AMPLIFIER TRANSISTOR

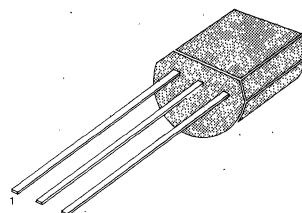
- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	40	V
Collector-Base Voltage	V_{CBO}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

• Refer to 2N3906 for graphs

TO-92



1 Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 500\mu\text{A}, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			50	nA
DC Current Gain	h_{FE}	$I_C = 2\text{mA}, V_{CE} = 10V$ * $I_C = 100\text{mA}, V_{CE} = 10V$	90	180		
Collector-Emitter Saturation voltage	$V_{CE} (\text{sat})$	$I_C = 50\text{mA}, I_E = 5\text{mA}$	60		0.5	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 100\text{KHz}$			3.5	pF

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



SAMSUNG SEMICONDUCTOR

AMPLIFIER TRANSISTOR

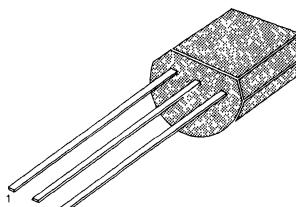
- Collector-Emitter Voltage: $V_{CEO} = 25V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* Refer to 2N3904 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 0.5\text{mA}, I_B = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			50	nA
DC Current Gain	h_{FE}	$V_{CB} = 20V, I_E = 0$ $I_C = 100\mu\text{A}, V_{CE} = 10V$ $I_C = 2\text{mA}, V_{CE} = 10V$	100	50	400	nA
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 50\text{mA}, I_B = 5\text{mA}$	200		0.5	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 100\text{KHz}$			3.5	pF
Noise Figure	NF	$I_C = 10\mu\text{A}, V_{CE} = 5V$ $R_S = 10\text{K}\Omega$ $f = 10\text{Hz to } 10\text{KHz}$			3	dB



AMPLIFIER TRANSISTOR

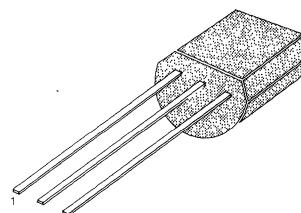
- Collector-Emitter Voltage: $V_{CEO} = 25V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* Refer to 2N3904 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 0.5\text{mA}, I_B = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4		50	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$ $V_{CB} = 20V, I_E = 0$		50	50	nA
DC Current Gain	h_{FE}	$I_C = 100\mu\text{A}, V_{CE} = 10V$ $I_C = 2\text{mA}, V_{CE} = 10V$	150		600	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 50\text{mA}, I_E = 5\text{mA}$	300		0.5	V
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 100\text{KHz}$			3.5	pF
Noise Figure	NF	$I_C = 10\mu\text{A}, V_{CE} = 5V$ $R_S = 10\text{K}\Omega$ $f = 10\text{Hz to } 10\text{KHz}$			3	dB



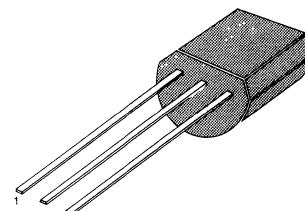
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 25V$
- Collector Dissipation: $P_C (\max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	25	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ C$

TO-92



1 Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 0.5mA, I_B = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$ $V_{CB} = 20V, I_E = 0$			50	nA
DC Current Gain	h_{FE}	$I_C = 100\mu A, V_{CE} = 10V$ $I_C = 2mA, V_{CE} = 10V$	100		50	nA
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 50mA, I_B = 5mA$			400	
Output Capacitance	C _{ob}	$V_{CB} = 10V, I_E = 0, f = 100KHz$			0.5	pF
Noise Figure	NF	$I_C = 10\mu A, V_{CE} = 5V$ $R_S = 10K\Omega$ $f = 10Hz \text{ to } 10KHz$			3.5	
					3	dB



AMPLIFIER TRANSISTOR

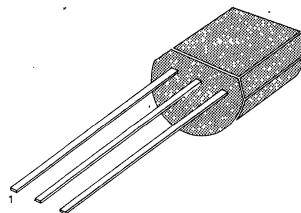
- Collector-Emitter Voltage: $V_{CEO} = 25V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	25	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N3906 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 0.5\text{mA}, I_B = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$ $V_{CB} = 20V, I_E = 0$			50	nA
DC Current Gain	h_{FE}	$I_C = 100\mu\text{A}, V_{CE} = 10V$ $I_C = 2\text{mA}, V_{CE} = 10V$	150	50	600	nA
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 50\text{mA}, I_B = 5\text{mA}$	300		0.5	V
Output Capacitance	C_{OB}	$V_{CE} = 10V, I_E = 0$ $f = 100\text{KHz}$			3.5	pF
Noise Figure	NF	$I_C = 10\mu\text{A}, V_{CE} = 5V$ $R_S = 10\text{K}\Omega$ $f = 10\text{Hz to } 10\text{KHz}$			3	dB

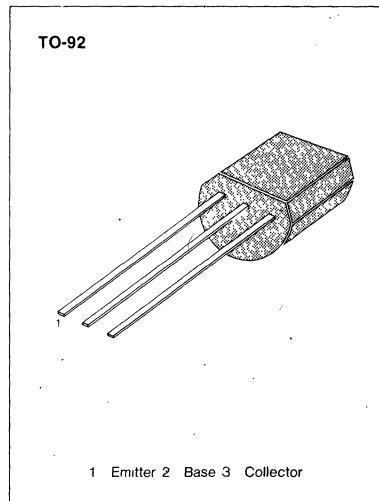


AUDIO TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 25V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	25	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	25			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	5			V
Collector Cut-off Current	I_{CEO}	$V_{CE} = 25V, I_B = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 20V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 4V, I_C = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 10\text{mA}, V_{CE} = 1V$ $I_C = 100\text{mA}, V_{CE} = 1V$ $I_C = 500\text{mA}, V_{CE} = 1V$	35 50 50		200	V
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 500\text{mA}, I_B = 50\text{mA}$	60		0.5	MHz
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 10V$ $f = 30\text{MHz}$			1.2	V
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 500\text{mA}, V_{CE} = 1V$			30	pF
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 100\text{KHz}$				

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



SAMSUNG SEMICONDUCTOR

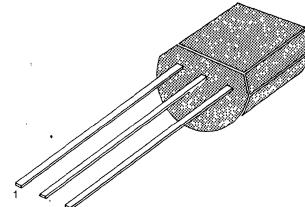
AUDIO TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO}=25V$
- Collector Dissipation: P_C (max)=625mW
- Complement to MPS6560

ABSOLUTE MAXIMUM RATINGS ($T_a=25^{\circ}\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	25	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^{\circ}\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^{\circ}\text{C}$

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1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^{\circ}\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10\text{mA}, I_B=0$	25			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_C=0$	5			V
Collector Cut-off Current	I_{CEO}	$V_{CE}=25V, I_B=0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB}=20V, I_E=0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=4V, I_C=0$			100	nA
*DC Current Gain	h_{FE}	$I_C=10\text{mA}, V_{CE}=1V$ $I_C=100\text{mA}, V_{CE}=1V$ $I_C=500\text{mA}, V_{CE}=1V$	35 50 50		200	V
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=500\text{mA}, I_B=50\text{mA}$	60		0.5	MHz
Current Gain Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=10V$ $f=30\text{MHz}$				
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=500\text{mA}, V_{CE}=1V$			1.2	V
Output Capacitance	C_{ob}	$V_{CE}=10V, I_E=0$ $f=100\text{KHz}$			30	pF

* Pulse Test: Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

SAMSUNG SEMICONDUCTOR

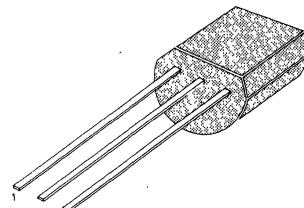
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO}=25V$
- Collector Dissipation: P_c (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	25	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	1000	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



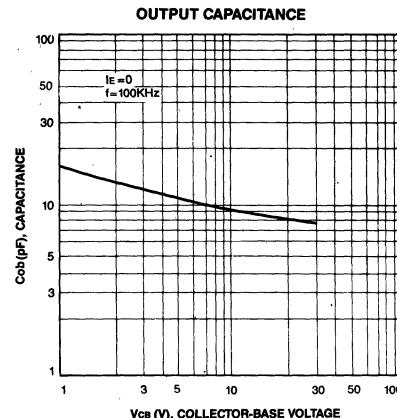
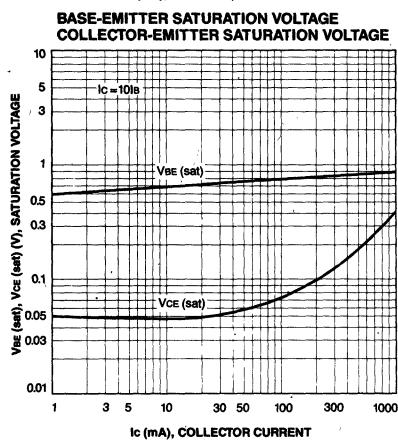
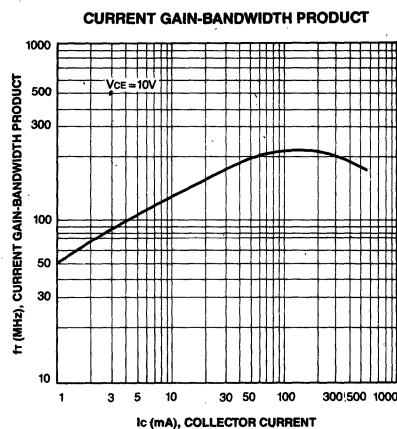
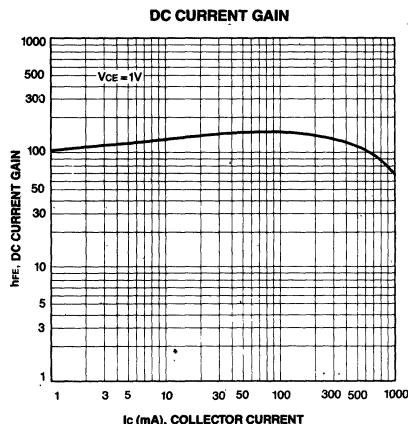
1 Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1mA, I_B=0$	25			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	25			V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu A, I_C=0$	4			V
Collector Cut-off Current	I_{CEO}	$V_{CE}=25V, I_B=0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CE}=25V, I_E=0$			100	nA
DC Current Gain	h_{FE}	$I_C=100mA, V_{CE}=1V$ $I_C=500mA, V_{CE}=1V$ $I_C=1000mA, V_{CE}=1V$	50			
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=1000mA, I_B=100mA$	50			
Current Gain Bandwidth Product	f_T	$I_C=50mA, V_{CE}=10V$ $f=30MHz$	30		0.6	V MHz
Output Capacitance	C_{ob}	$V_{CB}=10V, I_E=0$ $f=100KHz$	100		30	pF





AMPLIFIER TRANSISTOR

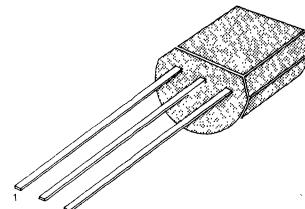
- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	1000	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to MPS6601 for graphs

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1 Emitter 2. Base 3 Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	40			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CEO}	$V_{CE} = 30V, I_B = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
DC Current Gain	h_{FE}	$I_C = 100\text{mA}, V_{CE} = 1V$ $I_C = 500\text{mA}, V_{CE} = 1V$ $I_C = 1000\text{mA}, V_{CE} = 1V$	50 50 30			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 1000\text{mA}, I_B = 100\text{mA}$	100		0.6	V
Current Gain Bandwidth Product	f_T	$I_C = 50\text{mA}, V_{CE} = 10V$ $f = 30\text{MHz}$				MHz
Output Capacitance	C_{ob}	$V_{CB} = 10V, I_E = 0$ $f = 100\text{KHz}$			30	pF



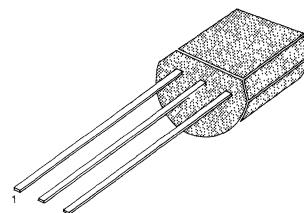
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO}=25V$
- Collector Dissipation: $P_C \text{ (max)}=625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	25	V
Collector-Base Voltage	V_{CBO}	25	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	1	A
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

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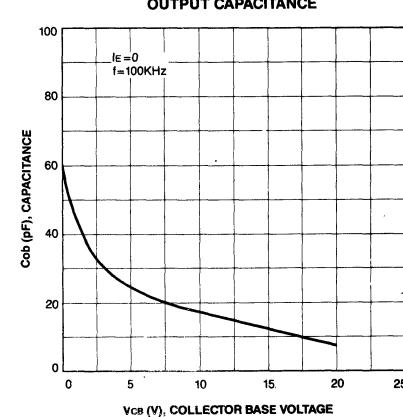
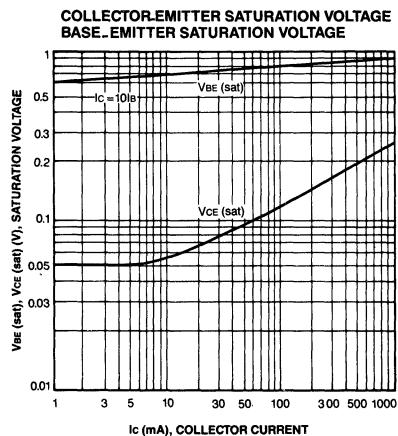
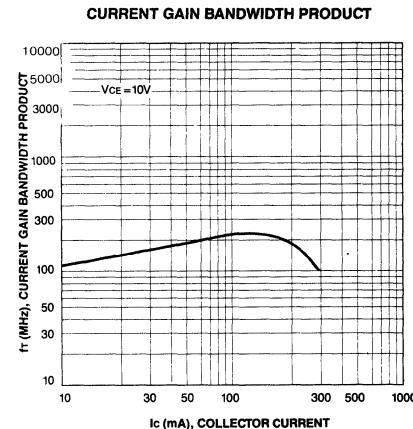
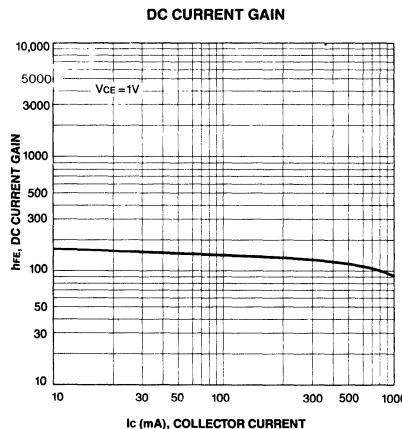


1 Emitter 2. Base 3 Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	25			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	4			V
Collector Cut-off Current	I_{CEO}	$V_{CB}=25V, I_E=0$			100	nA
Collector Cut-off Current	I_{CEO}	$V_{CE}=25V, I_B=0$			100	nA
DC Current Gain	h_{FE}	$I_C=100\text{mA}, V_{CE}=1V$ $I_C=500\text{mA}, V_{CE}=1V$ $I_C=1\text{A}, V_{CE}=1V$	50 50 30			
Collector-Emitter Saturation Voltage	$V_{CE} \text{ (sat)}$	$I_C=1\text{A}, I_B=100\text{mA}$			0.6	V
Output Capacitance	C_{OB}	$V_{CB}=10V, I_E=0$ $f=100\text{KHz}$			30	pF
Base-Emitter On Voltage	$V_{BE} \text{ (on)}$	$I_C=500\text{mA}, V_{CE}=1V$			1.2	V
Current Gain Bandwidth Product	f_T	$I_C=50\text{mA}, V_{CE}=10V$ $f=30\text{MHz}$	100			MHz
Turn On Time	t_{ON}	$V_{CC}=40V, I_C=500\text{mA}$ $I_{B1}=50\text{mA}$			55	ns
Turn Off Time	t_{OFF}	$V_{CC}=40V, I_C=500\text{mA}$ $I_{B1}=50\text{mA}$			300	ns





AMPLIFIER TRANSISTOR

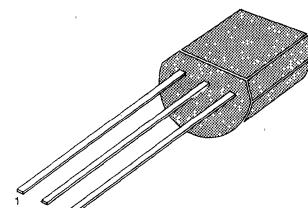
- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	200	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

* Refer to 2N5088 for graphs

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1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$				V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$ $V_{CB} = 60V, I_E = 0$	40		30	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 6V, I_C = 0$			10	nA
*DC Current Gain	h_{FE}	$I_C = 100\mu\text{A}, V_{CE} = 5V$	250		700	nA
Output Capacitance	C_{OB}	$V_{CB} = 5V, I_E = 0$ $f = 1\text{MHz}$	1		4	pF
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100\mu\text{A}, V_{CE} = 5V$	0.45		0.65	V
Noise Figure	NF	$I_C = 100\mu\text{A}, V_{CE} = 5V$ $R_S = 10\text{K}\Omega, f = 10\text{Hz}$			2	dB

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



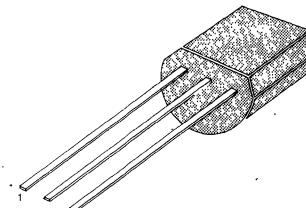
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 60V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

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1 Emitter 2. Base 3. Collector

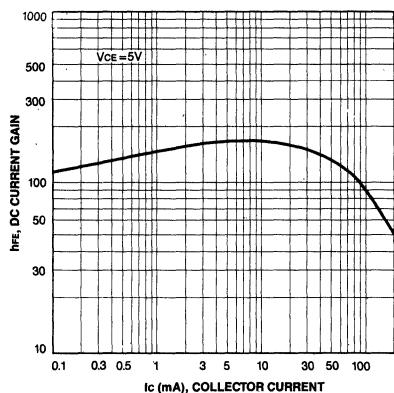
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ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

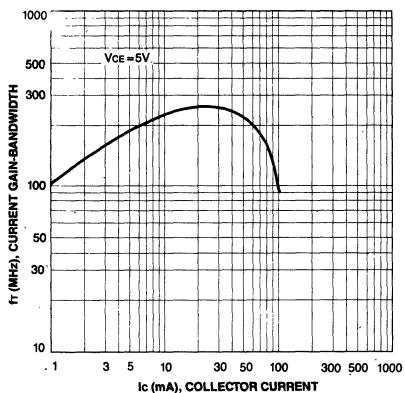
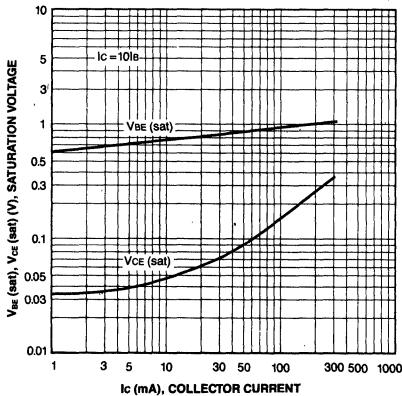
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	60			V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	6			V
Collector Cut-off Current	I_{CEO}	$V_{CE} = 60V, I_B = 0$		100	nA	
Collector Cut-off Current	I_{CBO}	$V_{CB} = 60V, I_E = 0$		100	nA	
Emitter Cut-off Current	I_{EBO}	$V_{EB} = 6V, I_C = 0$		100	nA	
*DC Current Gain	h_{FE}	$I_C = 1\text{mA}, V_{CE} = 5V$ $I_C = 10\text{mA}, V_{CE} = 5V$ $I_C = 100\text{mA}, V_{CE} = 5V$	100 100 75	300		
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100\text{mA}, I_B = 5\text{mA}$ $I_C = 100\text{mA}, I_B = 10\text{mA}$		0.4 0.3	V	
Output Capacitance	C_{ob}	$V_{CB} = 5V, I_E = 0$ $f = 1\text{MHz}$		6	pF	
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 5V$ $f = 100\text{MHz}$	150			MHz
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 1\text{mA}, V_{CE} = 5V$	0.5	0.7	V	

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

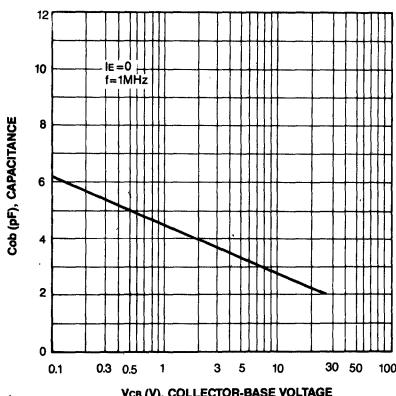
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE



AMPLIFIER TRANSISTOR

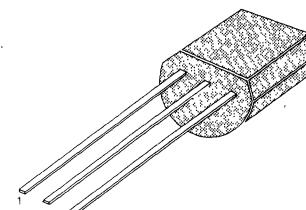
- Collector-Emitter Voltage: $V_{CEO} = 80V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	80	V
Collector-Emitter Voltage	V_{CEO}	80	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

- Refer to MPS8098 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10\text{mA}, I_B = 0$	80			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	80			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	6			V
Collector Cut-off Current	I_{CEO}	$V_{CE} = 60V, I_B = 0$		100	100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 80V, I_E = 0$		100	100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 6V, I_C = 0$		100	100	nA
*DC Current Gain	h_{FE}	$I_C = 1\text{mA}, V_{CE} = 5V$ $I_C = 10\text{mA}, V_{CE} = 5V$ $I_C = 100\text{mA}, V_{CE} = 5V$	100 100 75	300		
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100\text{mA}, I_B = 5\text{mA}$ $I_C = 100\text{mA}, I_B = 10\text{mA}$		0.4	0.4	V
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 10\text{mA}, V_{CE} = 5V$	0.6	0.3	0.8	V
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 5V$ $f = 100\text{MHz}$	150			MHz
Output Capacitance	C_{OB}	$V_{CB} = 5V, I_E = 0$ $f = 1\text{MHz}$		6	6	pF

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

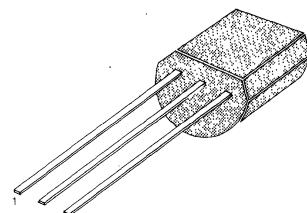
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO}=60V$
- Collector Dissipation: P_c (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ C$

TO-92

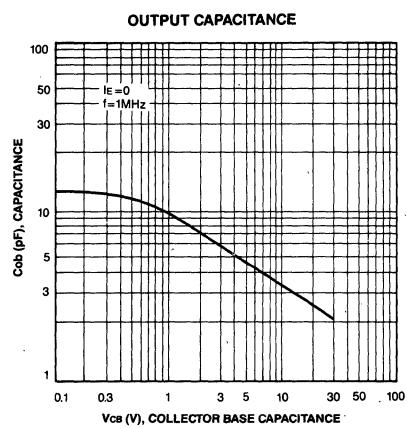
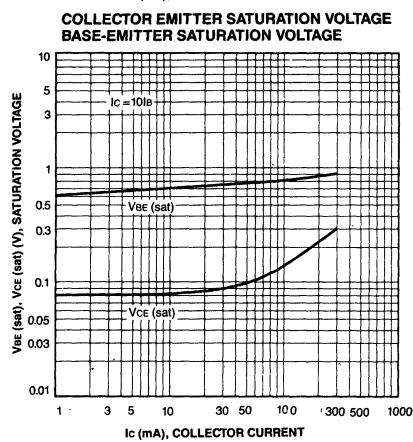
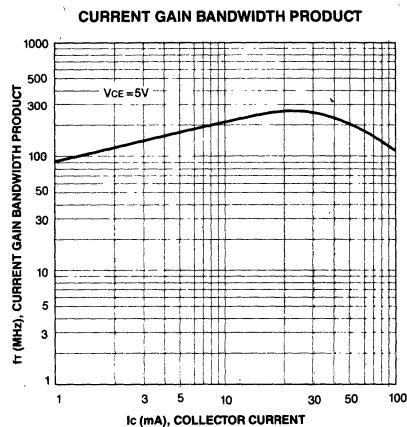
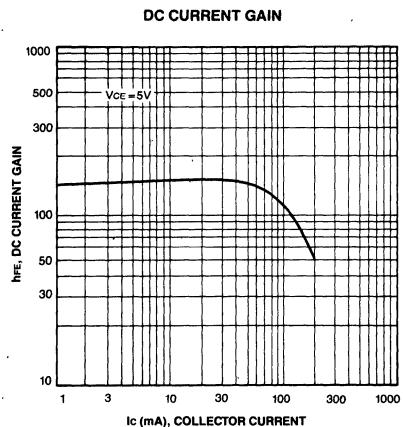


1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=10mA, I_B=0$	60			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu A, I_C=0$	5			V
Collector Cut-off Current	I_{CEO}	$V_{CE}=60V, I_B=0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB}=60V, I_E=0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE}=4V, I_C=0$			100	nA
* DC Current Gain	h_{FE}	$I_C=1mA, V_{CE}=5V$ $I_C=10mA, V_{CE}=5V$ $I_C=100mA, V_{CE}=5V$	100 100 75		300	
* Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=100mA, I_B=5mA$ $I_C=100mA, I_B=10mA$			0.4 0.3	V
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C=1mA, V_{CE}=5V$	0.5		0.7	V
Current Gain Bandwidth Product	f_T	$I_C=10mA, V_{CE}=5V$ $f=100MHz$	150			MHz
Output Capacitance	C_{ob}	$V_{CB}=5V, I_E=0$ $f=1MHz$			8	pF

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$ 



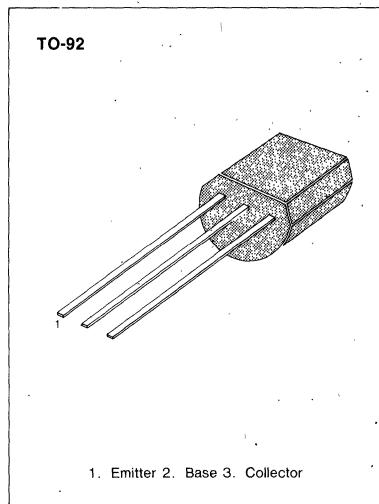
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 80V$
- Collector Dissipation: P_C (max) = 625mW

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	80	V
Collector-Emitter Voltage	V_{CEO}	80	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$

- Refer to MPS8598 for graphs

**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)**

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 10mA, I_B = 0$	80			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	80			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CEO}	$V_{CE} = 60V, I_B = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 80V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 4V, I_C = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 1mA, V_{CE} = 5V$ $I_C = 10mA, V_{CE} = 5V$ $I_C = 100mA, V_{CE} = 5V$	100 100 75		300	
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100mA, I_B = 5mA$ $I_C = 100mA, I_B = 10mA$			0.4 0.3	V
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 10mA, V_{CE} = 5V$	0.6		0.8	V
Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 5V$ $f = 100MHz$	150			MHz
Output Capacitance	C_{OB}	$V_{CB} = 5V, I_E = 0$ $f = 1MHz$			8	pF

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

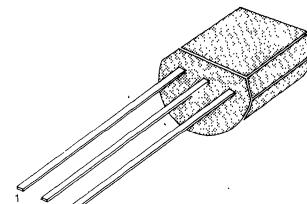
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 60V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



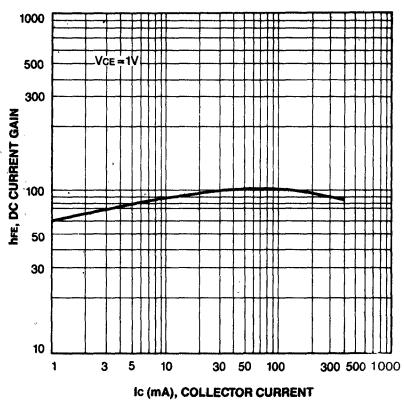
1 Emitter 2 Base 3 Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

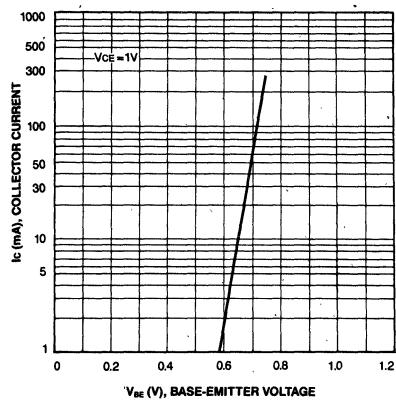
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 1\text{mA}, I_b = 0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_e = 100\mu\text{A}, I_c = 0$	4			V
Collector Cut-off Current	I_{CEO}	$V_{CE} = 60\text{V}, I_b = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 60\text{V}, I_e = 0$			100	nA
DC Current Gain	h_{FE}	$I_c = 10\text{mA}, V_{CE} = 1\text{V}$	50			
		$I_c = 100\text{mA}, V_{CE} = 1\text{V}$	50			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_c = 100\text{mA}, I_b = 10\text{mA}$			0.25	V
Current Gain Bandwidth Product	f_T	$I_c = 10\text{mA}, V_{CE} = 2\text{V}$	100			MHz
		$f = 100\text{MHz}$				
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_c = 100\text{mA}, V_{CE} = 1\text{V}$			1.2	V

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

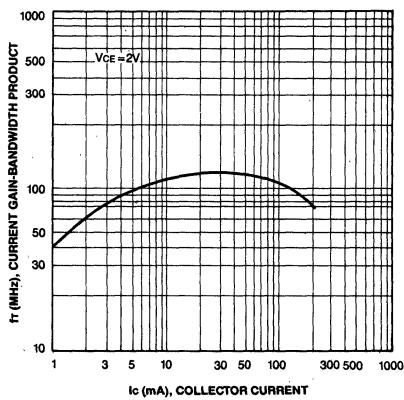
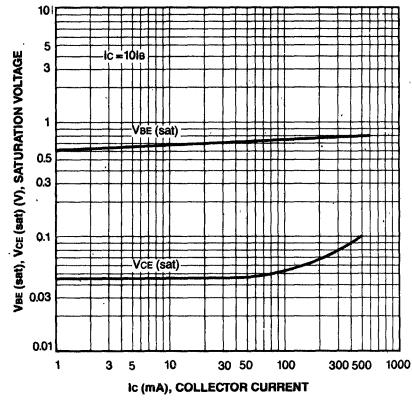
DC CURRENT GAIN



BASE-EMITTER ON VOLTAGE



CURRENT GAIN-BANDWIDTH PRODUCT

COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE

AMPLIFIER TRANSISTOR

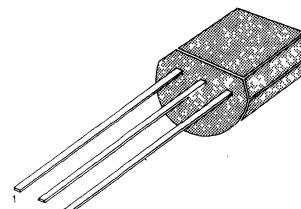
- Collector-Emitter Voltage: $V_{CEO} = 80V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	80	V
Collector-Emitter Voltage	V_{CEO}	80	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

* Refer to MPSA05 for graphs

TO-92



1 Emitter 2 Base 3 Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	80			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CEO}	$V_{CE} = 60V, I_B = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 80V, I_E = 0$			100	nA
DC Current Gain	h_{FE}	$I_C = 10\text{mA}, V_{CE} = 1V$ $I_C = 100\text{mA}, V_{CE} = 1V$	50			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100\text{mA}, I_B = 10\text{mA}$	50		0.25	V
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 2V$ $f = 100\text{MHz}$	100			MHz
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100\text{mA}, V_{CE} = 1V$			1.2	V

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



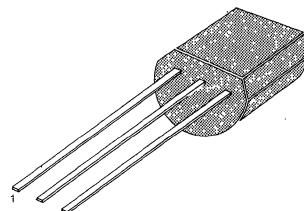
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO}=40V$
- Collector Dissipation: P_c (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$

TO-92



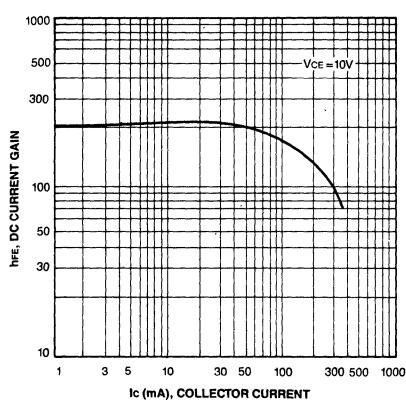
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

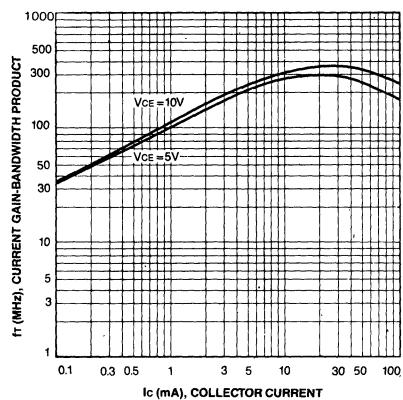
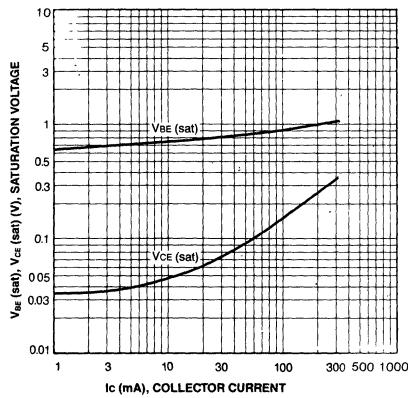
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1mA, I_B=0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu A, I_C=0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=30V, I_E=0$			100	nA
DC Current Gain	h_{FE}	$I_C=5mA, V_{CE}=10V$	40		400	
Current Gain Bandwidth Product	f_T	$I_C=5mA, V_{CE}=10V$ $f=100MHz$	125			MHz
Output Capacitance	C_{OB}	$V_{CB}=10V, I_E=0$ $f=100KHz$			4	pF



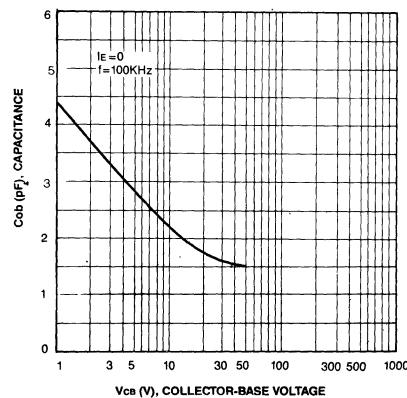
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH

COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE



DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CES} = 20V$
- Collector Dissipation: P_c (max) = 625mW

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

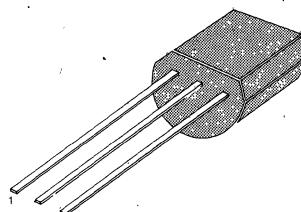
Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	20	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

- Refer to 2N6427 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu A, I_B = 0$	20		100	V
Collector Cut-off Current	I_{CEO}	$V_{CB} = 15V, I_E = 0$			100	nA
Collector Cut-off Current	I_{CES}	$V_{CE} = 15V, I_B = 0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
DC Current Gain	h_{FE}	$I_C = 10mA, V_{CE} = 5V$	20K		1	V
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10mA, I_B = 0.01mA$			1.4	V
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 10mA, V_{CE} = 5V$				

TO-92



1. Emitter 2. Base 3. Collector



SAMSUNG SEMICONDUCTOR

DARLINGTON TRANSISTOR

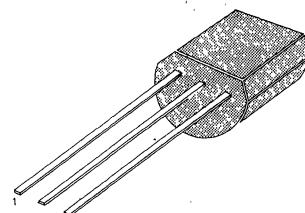
- Collector-Emitter Voltage: $V_{CES} = 30V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CES}	30	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N6427 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu\text{A}, I_E = 0$	30			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
*DC Current Gain	$\cdot h_{FE}$	$I_C = 10\text{mA}, V_{CE} = 5V$ $I_C = 100\text{mA}, V_{CE} = 5V$	5K			
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 100\text{mA}, I_E = 0.1\text{mA}$	10K			
Current Gain-Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 5V$ $f = 100\text{MHz}$	125		1.5	MHz
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C = 100\text{mA}, V_{CE} = 5V$			2	V

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



DARLINGTON TRANSISTOR

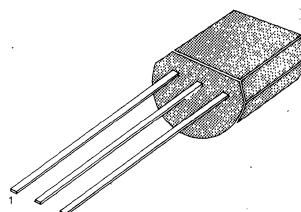
- Collector-Emitter Voltage: $V_{CES} = 30V$
- Collector Dissipation: P_C (max) = 625mW

ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CES}	30	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{Stg}	-55 ~ 150	°C

* Refer to 2N6427 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu A, I_B = 0$	30		100	V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 10mA, V_{CE} = 5V$ $I_C = 100mA, V_{CE} = 5V$	10K			
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100mA, I_B = 0.1mA$	20K		1.5	V
Current Gain Bandwidth Product	f_T	$I_C = 10mA, V_{CE} = 5V$ $f = 100MHz$	125			MHz
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100mA, V_{CE} = 5V$			2	V

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



AMPLIFIER TRANSISTOR

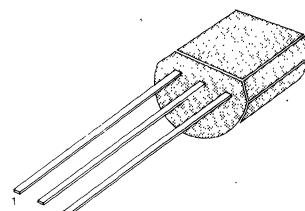
- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

- Refer to MPSA10 for graphs

TO-92



1 Emitter 2 Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_E = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 5\text{mA}, V_{CE} = 10V$	40		400	
*Current Gain Bandwidth Product	f_T	$I_C = 5\text{mA}, V_{CE} = 10V$ $f = 100\text{MHz}$	125			MHz
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 10\text{mA}, I_E = 1\text{mA}$			0.25	V
Output Capacitance	C_{OB}	$V_{CE} = 10V, I_E = 0$ $f = 100\text{KHz}$			4	pF

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



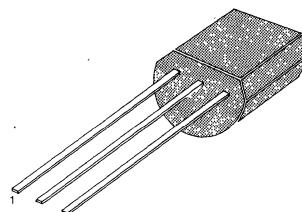
DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CES} = 40V$
- Collector Dissipation: $P_c (\max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	40	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

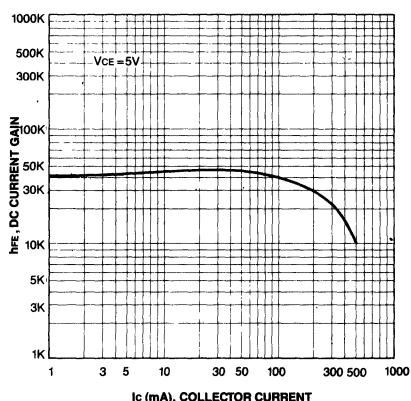
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu A, V_{BE} = 0$	40			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	40			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
Collector Cut-off Current	I_{CES}	$V_{CE} = 30V, V_{BE} = 0$			500	nA
*DC Current Gain	h_{FE}	$I_C = 10mA, V_{CE} = 5V$	10K			
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100mA, V_{CE} = 5V$			1.5	V
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100mA, I_B = 0.1mA$	10K		2	V
		$I_C = 100mA, V_{CE} = 5V$				

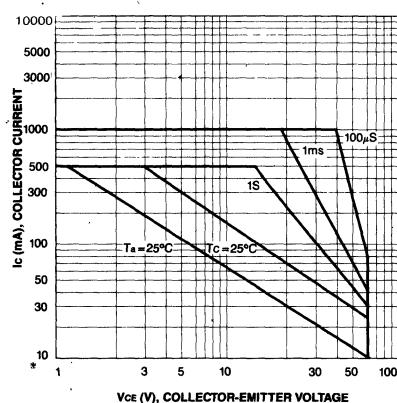
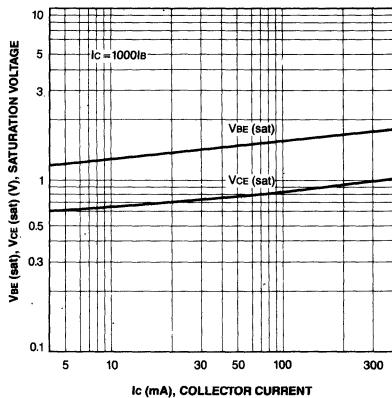
*Pulse Test: Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$ 

SAMSUNG SEMICONDUCTOR

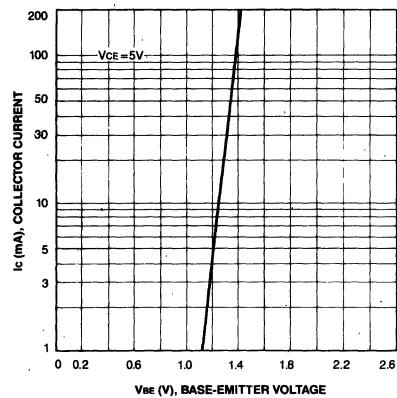
DC CURRENT GAIN



SAFE OPERATING AREA

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

BASE-EMITTER ON VOLTAGE



DARLINGTON TRANSISTOR

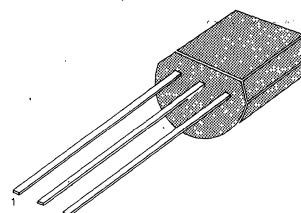
- Collector-Emitter Voltage: $V_{CES} = 50V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* Refer to MPSA25 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu\text{A}, V_{BE} = 0$	50			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
Collector Cut-off Current	I_{CES}	$V_{CE} = 40V, V_{BE} = 0$			500	nA
*DC Current Gain	h_{FE}	$I_C = 10\text{mA}, V_{CE} = 5V$				
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100\text{mA}, V_{CE} = 5V$	10K			
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100\text{mA}, I_E = 0.1\text{mA}$	10K			
		$I_C = 100\text{mA}, V_{CE} = 5V$			1.5	V
					2	V

* Pulse Test: Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.



DARLINGTON TRANSISTOR

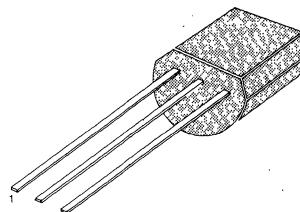
- Collector-Emitter Voltage: $V_{CES} = 60V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	60	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

* Refer to MPSA25 for graphs

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu\text{A}, V_{BE} = 0$	60			V
Collector-Base Breakdown Voltage	BV_{CEO}	$I_C = 100\mu\text{A}, I_E = 0$	60			V
Collector Cut-off Current	I_{CEO}	$V_{CB} = 50V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
Collector Cut-off Current	I_{CES}	$V_{CE} = 50V, V_{BE} = 0$			500	nA
*DC Current Gain	h_{FE}	$I_C = 10\text{mA}, V_{CE} = 5V$ $I_C = 100\text{mA}, V_{CE} = 5V$	10K			
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100\text{mA}, I_B = 0.1\text{mA}$			1.5	V
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100\text{mA}, V_{CE} = 5V$			2	V

* Pulse Test: Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

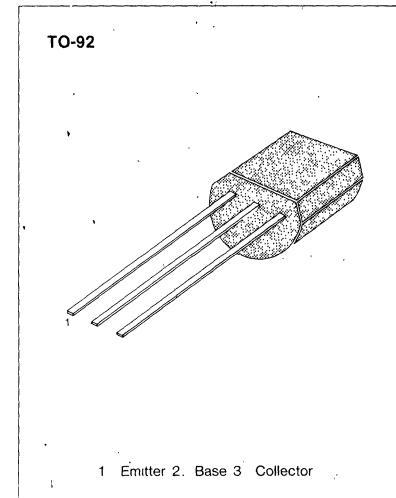


HIGH VOLTAGE TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 300V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	300	V
Collector-Emitter Voltage	V_{CEO}	300	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ\text{C}$

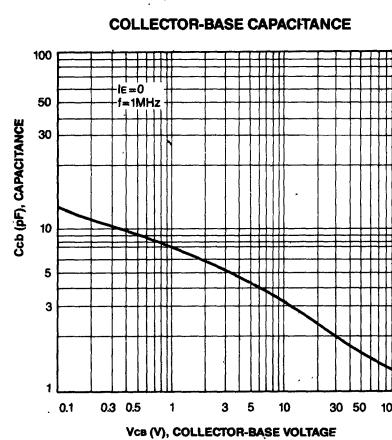
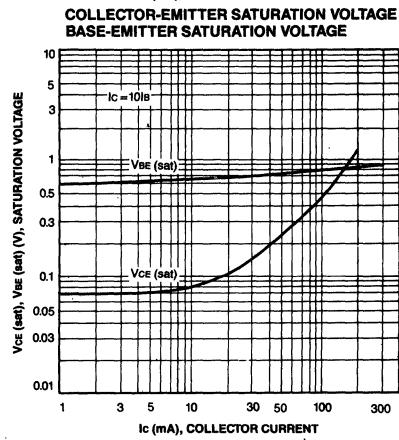
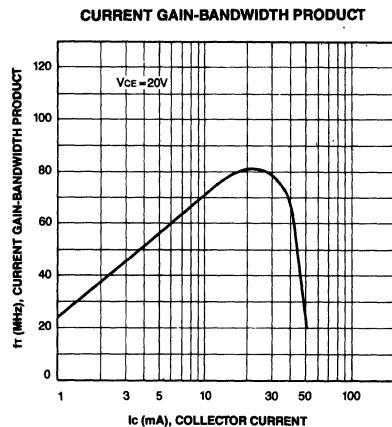
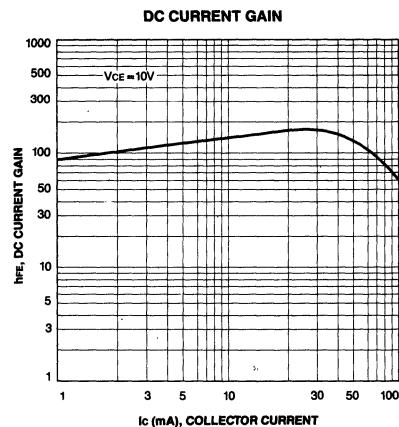
**ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)**

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	300			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	300			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	6			V
Collector Cut-off Current	I_{CEO}	$V_{CB} = 200\text{V}, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 6\text{V}, I_C = 0$		100		nA
*DC Current Gain	h_{FE}	$I_C = 1\text{mA}, V_{CE} = 10\text{V}$ $I_C = 10\text{mA}, V_{CE} = 10\text{V}$ $I_C = 30\text{mA}, V_{CE} = 10\text{V}$	25 40 40			
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 20\text{mA}, I_B = 2\text{mA}$			0.5	V
*Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 20\text{mA}, I_B = 2\text{mA}$			0.9	V
Current Gain Bandwidth Product	f_T	$I_C = 10\text{mA}, V_{CE} = 20\text{V}$ $f = 100\text{MHz}$	50			MHz
Collector-Base Capacitance	C_{cb}	$V_{CB} = 20\text{V}, I_E = 0$ $f = 1\text{MHz}$			3	pF

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



SAMSUNG SEMICONDUCTOR



HIGH VOLTAGE TRANSISTOR

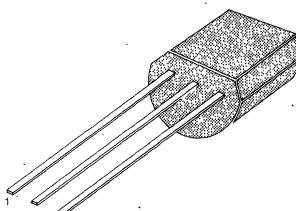
- Collector-Emitter Voltage: $V_{CEO}=200V$
- Collector Dissipation: P_c (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^{\circ}\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	200	V
Collector-Emitter Voltage	V_{CEO}	200	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^{\circ}\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^{\circ}\text{C}$

• Refer to MPSA42 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^{\circ}\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	200			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	200			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_C=0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=160\text{V}, I_E=0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE}=4\text{V}, I_C=0$			100	nA
*DC Current Gain	h_{FE}	$I_C=1\text{mA}, V_{CE}=10\text{V}$ $I_C=10\text{mA}, V_{CE}=10\text{V}$ $I_C=30\text{mA}, V_{CE}=10\text{V}$	25 40 40			
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=20\text{mA}, I_B=2\text{mA}$			0.5	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=20\text{mA}, I_B=2\text{mA}$			0.9	V
Collector-Base Capacitance	C_{Cb}	$V_{CB}=20\text{V}, I_E=0$ $f=1\text{MHz}$			4	pF
Current Gain Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=20\text{V}$ $f=100\text{MHz}$	50			MHz

*Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



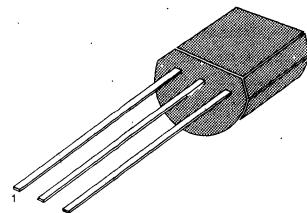
SAMSUNG SEMICONDUCTOR

HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	500	V
Collector-Emitter Voltage	V_{CEO}	400	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	300	mA
Collector Dissipation ($T_a=25^\circ\text{C}$)	P_C	625	mW
Collector Dissipation ($T_c=25^\circ\text{C}$)	P_C	1.5	W
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55~150	$^\circ\text{C}$

TO-92



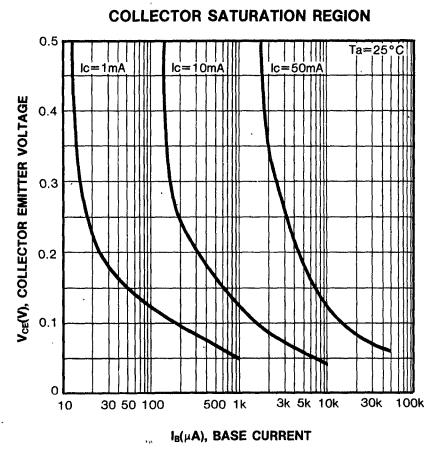
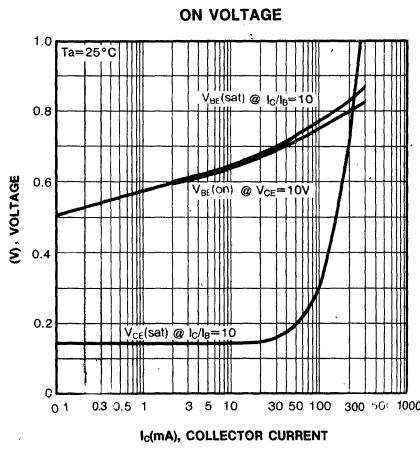
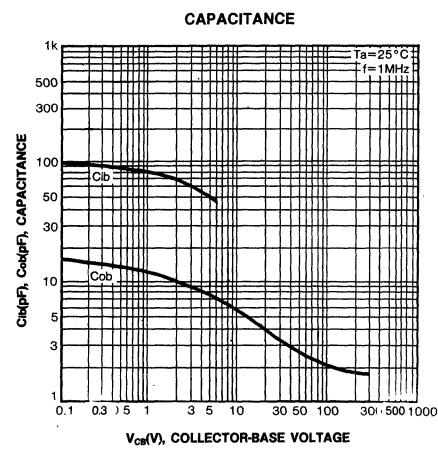
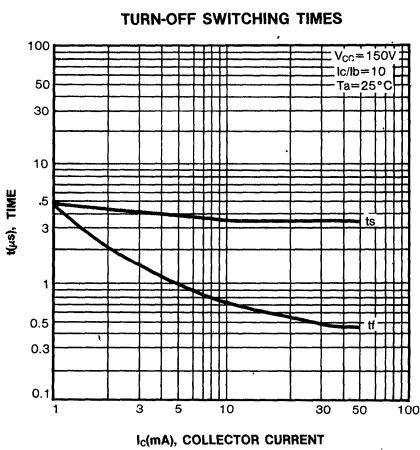
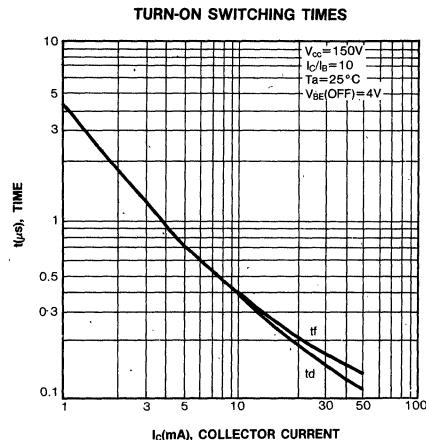
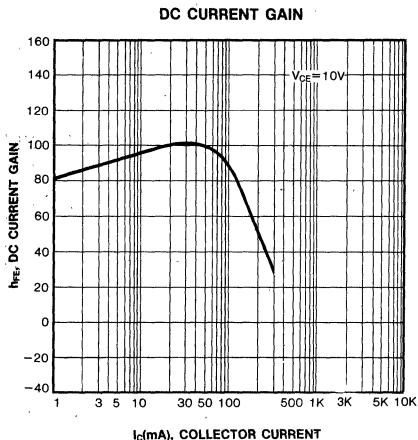
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

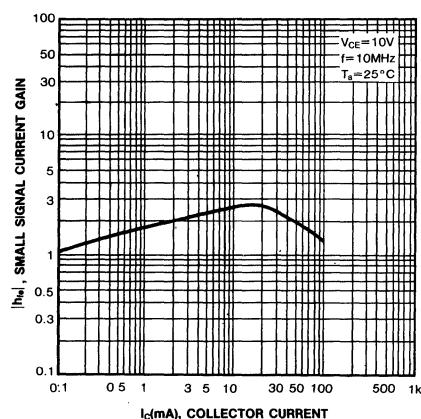
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Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	500		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_E=0$	400		V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C=100\mu\text{A}, V_{BE}=0$	500		V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	6		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=400\text{V}, I_E=0$		0.1	μA
Collector Cutoff Current	I_{CES}	$V_{CE}=400\text{V}, V_{BE}=0$		500	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=4\text{V}, I_C=0$		0.1	μA
*DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=1\text{mA}$ $V_{CE}=10\text{V}, I_C=10\text{mA}$ $V_{CE}=10\text{V}, I_C=50\text{mA}$ $V_{CE}=10\text{V}, I_C=100\text{mA}$	40 50 45 40	200	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=1\text{mA}, I_E=0.1\text{mA}$ $I_C=10\text{mA}, I_E=1\text{mA}$ $I_C=50\text{mA}, I_E=5\text{mA}$		0.4 0.5 0.75	V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C=10\text{mA}, I_E=1\text{mA}$		0.75	V
Output Capacitance	C_{ob}	$V_{CB}=20\text{V}, I_E=0, f=1\text{MHz}$		7	pF

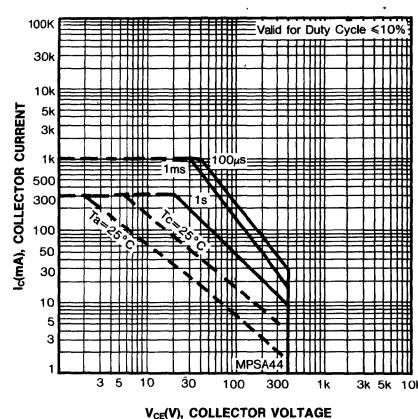
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HIGH FREQUENCY CURRENT GAIN



SAFE OPERATING AREA



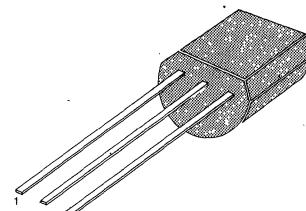
HIGH VOLTAGE TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 350V$
- Collector Dissipation: $P_C (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	400	V
Collector-Emitter Voltage	V_{CEO}	350	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	300	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ\text{C}$

TO-92



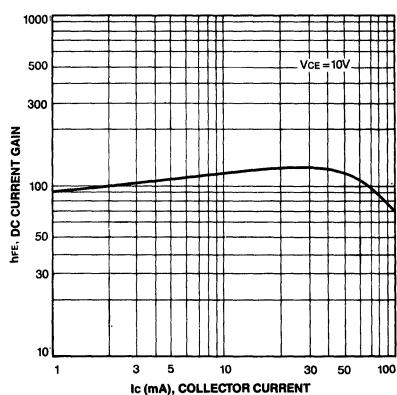
1 Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

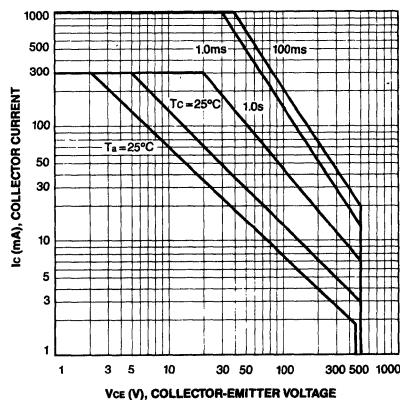
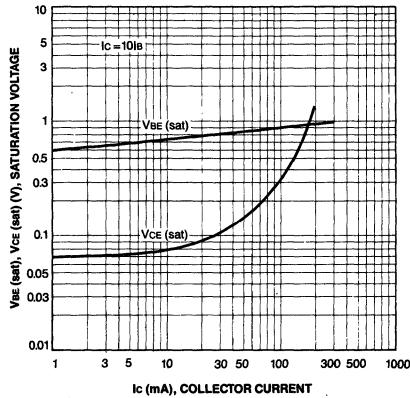
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	350			V
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu\text{A}, V_{BE} = 0$	400			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	400			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu\text{A}, I_C = 0$	6			V
Collector Cut-off Current	I_{CBO}	$V_{CE} = 320V, I_E = 0$		100		nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 4V, I_C = 0$		100		nA
Collector Cutoff Current	I_{CES}	$V_{CE} = 320V, V_{BE} = 0$		500		nA
*DC Current Gain	h_{FE}	$I_C = 1\text{mA}, V_{CE} = 10V$	40			
		$I_C = 10\text{mA}, V_{CE} = 10V$	50		200	
		$I_C = 50\text{mA}, V_{CE} = 10V$	45			
		$I_C = 100\text{mA}, V_{CE} = 10V$	40			
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 1\text{mA}, I_B = 0.1\text{mA}$		0.4		V
		$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.5		V
		$I_C = 50\text{mA}, I_B = 5\text{mA}$		0.75		V
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.75		V
Output Capacitance	C_{OB}	$V_{CB} = 20V, I_E = 0$ $f = 1\text{MHz}$		7		pF

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

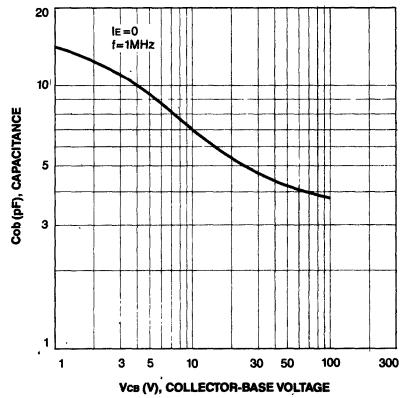
DC CURRENT GAIN



SAFE OPERATING AREA

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



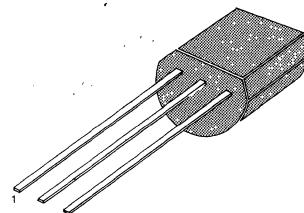
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO}=60V$
- Collector Dissipation: P_c (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	60	V
Collector-Emitter Voltage	V_{CEO}	60	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

TO-92



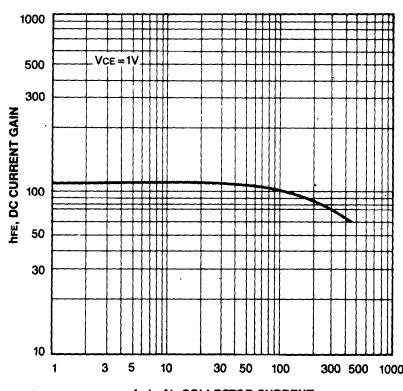
1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

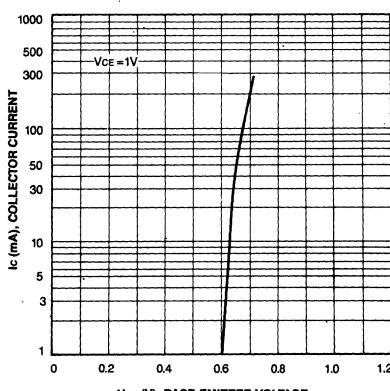
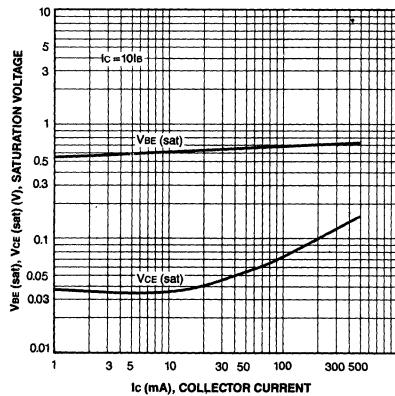
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c = 1mA, I_b = 0$	60			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_e = 100\mu A, I_c = 0$	4			V
Collector Cut-off Current	I_{CEO}	$V_{CE} = 60V, I_b = 0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB} = 60V, I_e = 0$			100	nA
DC Current Gain	h_{FE}	$I_c = 10mA, V_{CE} = 1V$	50			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_c = 100mA, V_{CE} = 1V$	50		0.25	V
Current Gain Bandwidth Product	f_T	$I_c = 100mA, I_b = 10mA$				MHz
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_c = 100mA, V_{CE} = 1V$	50		1.2	V
* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$						

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$ 

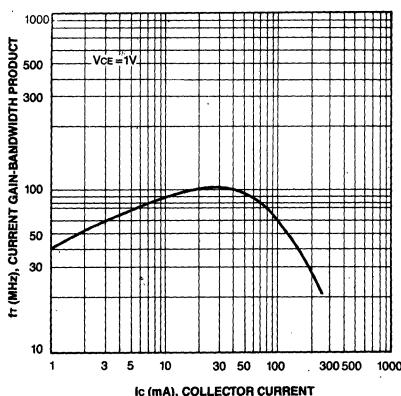
DC CURRENT GAIN



BASE-EMITTER ON VOLTAGE

COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT



AMPLIFIER TRANSISTOR

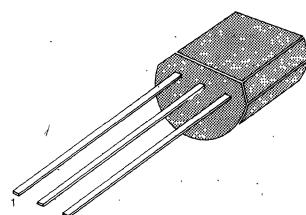
- Collector-Emitter Voltage: $V_{CEO}=80V$
- Collector Dissipation: P_c (max)=625mW

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	80	V
Collector-Emitter Voltage	V_{CEO}	80	V
Emitter-Base Voltage	I_{CEO}	4	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C

* Refer to MPSA55 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=1mA, I_b=0$	80			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_e=100\mu A, I_c=0$	4			V
Collector Cut-off Current	I_{CEO}	$V_{CE}=60V, I_b=0$			100	nA
Collector Cut-off Current	I_{CBO}	$V_{CB}=80V, I_e=0$			100	nA
DC Current Gain	h_{FE}	$I_c=10mA, V_{CE}=1V$ $I_c=100mA, V_{CE}=1V$	50			
Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=100mA, I_b=10mA$	50			
Current Gain Bandwidth Product	f_T	$I_c=100mA, V_{CE}=1V$ $f=100MHz$			0.25	V MHz
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_c=100mA, V_{CE}=1V$			1.2	V

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



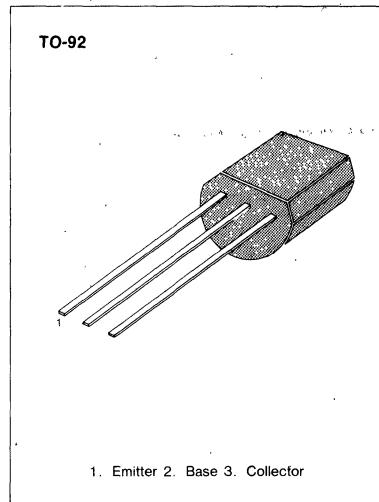
SAMSUNG SEMICONDUCTOR

DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CES} = 20V$
- Collector Dissipation: $P_c (\max) = 625mW$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	20	V
Collector-Base Voltage	V_{CBO}	20	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ C$



3

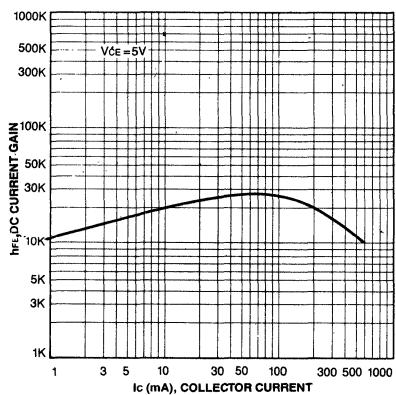
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu A, V_{BE} = 0$	20			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 15V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 10mA, V_{CE} = 5V$	20K			
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10mA, I_B = 0.01mA$			1.0	V
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 10mA, V_{CE} = 5V$			1.4	V

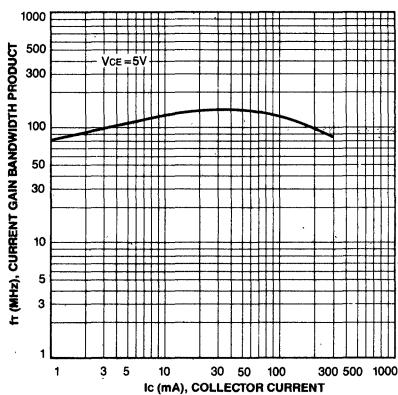
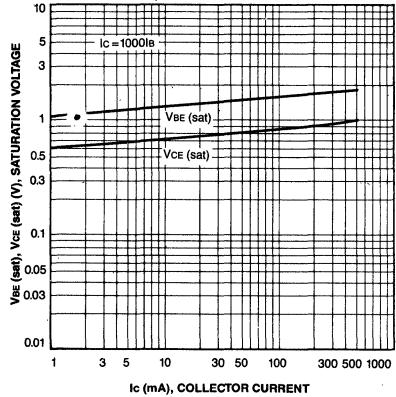
* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$



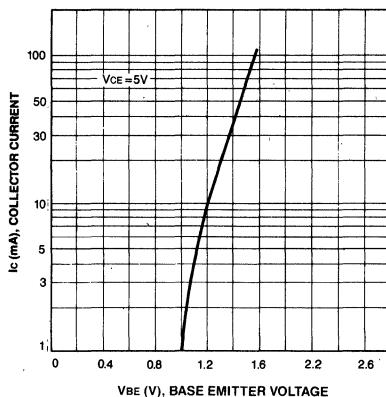
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

BASE Emitter ON VOLTAGE



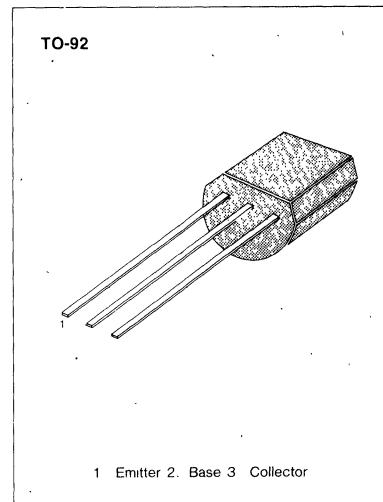
DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CES} = 30V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	30	V
Collector-Base Voltage	V_{CBO}	30	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_C	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to MPSA62 for graphs



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu\text{A}, V_{BE} = 0$	30			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 10\text{mA}, V_{CE} = 5V$ $I_C = 100\text{mA}, V_{CE} = 5V$ $I_C = 1000\text{mA}, I_B = 0.1\text{mA}$	5K		1.5	V
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C = 100\text{mA}, V_{CE} = 5V$	10K		2	V
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$I_C = 100\text{mA}, V_{CE} = 5V$				V
Current Gain Bandwidth Product	f_T	$I_C = 100\text{mA}, V_{CE} = 5V$ $f = 100\text{MHz}$	125			MHz

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



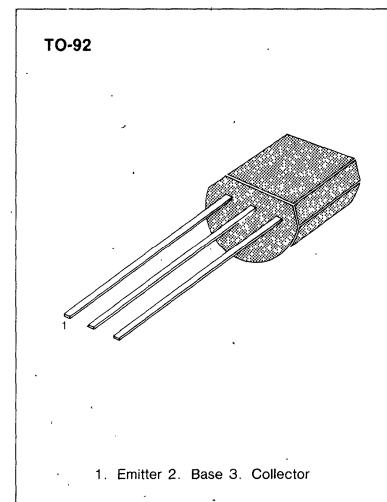
DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CES} = 30V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	30	V
Collector-Base Voltage	V_{CBO}	30	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

* Refer to MPSA62 for graphs

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu\text{A}, V_{BE} = 0$	30			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
*DC Current Gain	h_{FE}	$I_C = 10\text{mA}, V_{CE} = 5V$ $I_C = 100\text{mA}, V_{CE} = 5V$	10K			
*Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100\text{mA}, I_B = 0.1\text{mA}$	20K			
*Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100\text{mA}, V_{CE} = 5V$			1.5	V
Current Gain Bandwidth Product	f_T	$I_C = 100\text{mA}, V_{CE} = 5V$ $f = 100\text{MHz}$	125		2	V MHz

* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



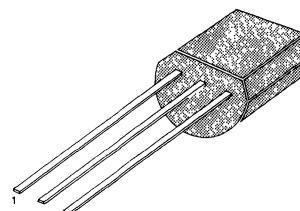
AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 40V$
- Collector Dissipation: P_C (max) = 625mW

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-55 ~ 150	$^\circ C$

TO-92

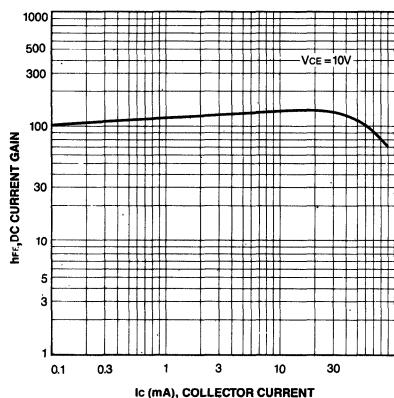


1. Emitter 2. Base 3. Collector

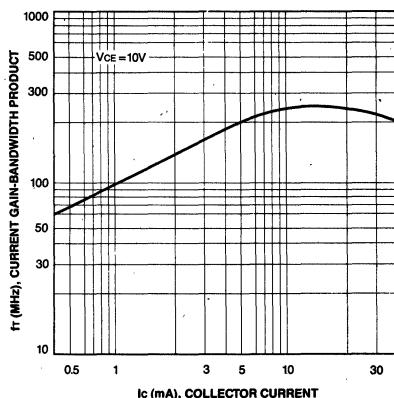
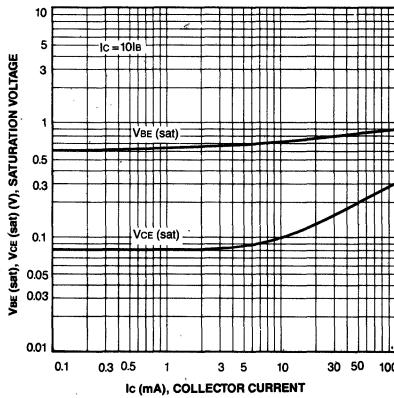
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_B = 0$	40			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu A, I_C = 0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
DC Current Gain	h_{FE}	$I_C = 5mA, V_{CE} = 10V$	40		400	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$			0.25	V
Current Gain Bandwidth Product	f_T	$I_C = 5mA, V_{CE} = 10V$ $f = 100MHz$	125			MHz
Output Capacitance	C_{OB}	$V_{CB} = 10V, I_E = 0$ $f = 100KHz$			4	pF

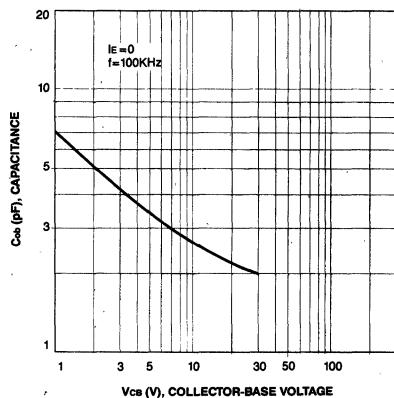
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE



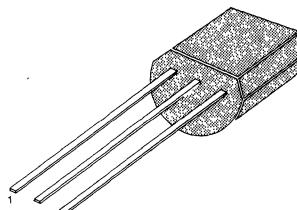
DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CES} = 40V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	40	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

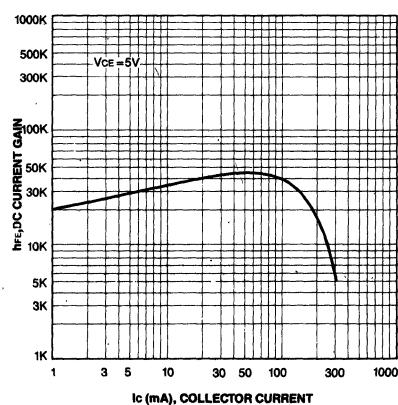
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_c = 100\mu\text{A}, V_{BE} = 0$	40			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu\text{A}, I_E = 0$	40			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 30V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_c = 0$			100	nA
Collector Cut-off Current	I_{CES}	$V_{CE} = 30V, V_{BE} = 0$			500	nA
DC Current Gain	h_{FE}	$I_c = 10\text{mA}, V_{CE} = 5V$	10K			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_c = 100\text{mA}, V_{CE} = 5V$			1.5	V
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_c = 100\text{mA}, I_B = 0.1\text{mA}$	10K		2	V



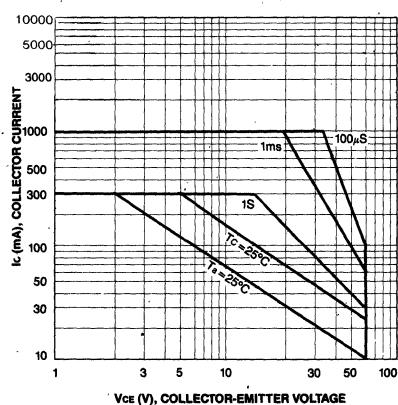
MPSA75

**PNP EPITAXIAL
SILICON DARLINGTON TRANSISTOR**

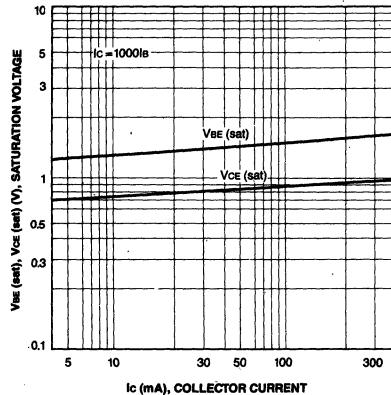
DC CURRENT GAIN



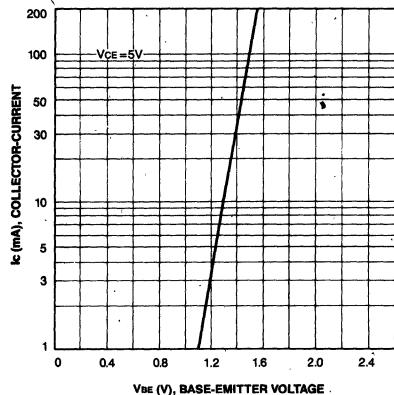
SAFE OPERATING AREA



**BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE**



BASE-EMITTER ON VOLTAGE



SAMSUNG SEMICONDUCTOR

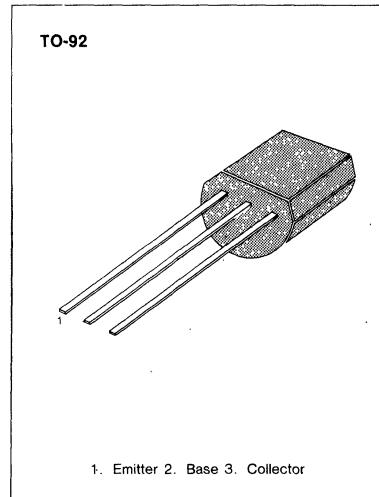
DARLINGTON TRANSISTOR

- Collector-Emitter Voltage: $V_{CES} = 50V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	50	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to MPSA75 for graphs



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_C = 100\mu\text{A}, V_{BE} = 0$	50			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$ $V_{CB} = 40V, I_E = 0$	50			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 40V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
Collector Cut-off Current	I_{CES}	$V_{CE} = 40V, V_{BE} = 0$			500	nA
DC Current Gain	h_{FE}	$I_C = 10\text{mA}, V_{CE} = 5V$ $I_C = 100\text{mA}, V_{CE} = 5V$	10K			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 100\text{mA}, I_B = 0.1\text{mA}$			1.5	V
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_C = 100\text{mA}, V_{CE} = 5V$	10K		2	V

DARLINGTON TRANSISTOR

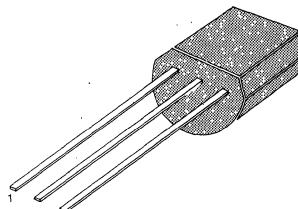
- Collector-Emitter Voltage: $V_{CES} = 60V$
- Collector Dissipation: $P_c (\text{max}) = 625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CES}	60	V
Emitter-Base Voltage	V_{EBO}	10	V
Collector Current	I_c	500	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to MPSA75 for graphs

TO-92



1 Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Emitter Breakdown Voltage	BV_{CES}	$I_c = 100\mu\text{A}, V_{BE} = 0$	60			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c = 100\mu\text{A}, I_E = 0$	60			V
Collector Cut-off Current	I_{CEO}	$V_{CB} = 50V, I_E = 0$			100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 10V, I_C = 0$			100	nA
Collector Cut-off Current	I_{CES}	$V_{CE} = 50V, V_{BE} = 0$			500	nA
DC Current Gain	h_{FE}	$I_c = 10\text{mA}, V_{CE} = 5V$	10K			
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_c = 100\text{mA}, V_{CE} = 5V$	10K			
Base-Emitter On Voltage	$V_{BE} (\text{on})$	$I_c = 100\text{mA}, I_B = 0.1\text{mA}$			1.5	V
		$I_c = 100\text{mA}, V_{CE} = 5V$			2	V

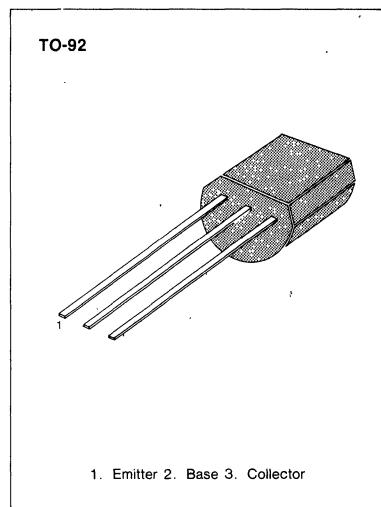


SAMSUNG SEMICONDUCTOR

HIGH VOLTAGE TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

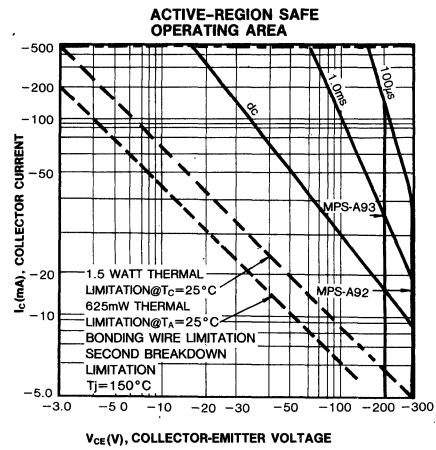
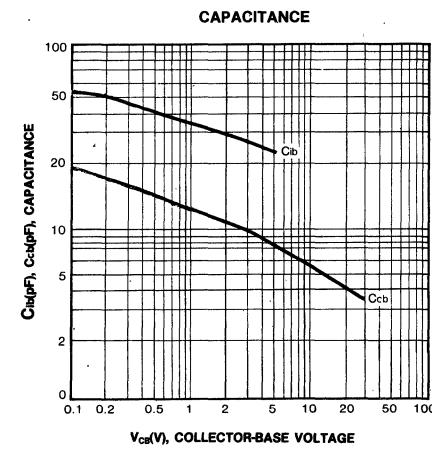
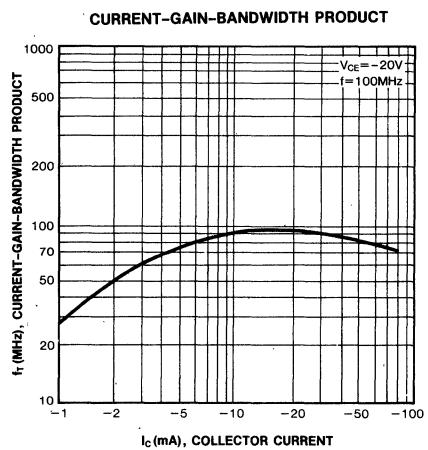
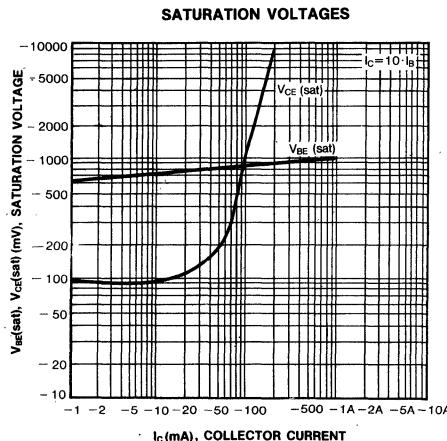
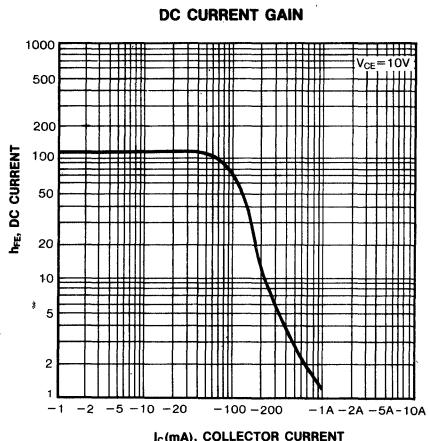
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : MPSA92	V_{CBO}	-300	V
: MPSA93		-200	V
Collector-Emitter Voltage: MPSA92	V_{CEO}	-300	V
: MPSA93		-200	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_c	-500	mA
Collector Dissipation ($T_a=25^\circ\text{C}$)	P_c	625	mW
Derate above 25°C		5	$\text{mW}/^\circ\text{C}$
Collector Dissipation ($T_c=25^\circ\text{C}$)	P_c	1.5	W
Derate above 25°C		12	$\text{mW}/^\circ\text{C}$
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Base Breakdown Voltage : MPSA92	BV_{CBO}	$I_c=-100\mu\text{A}, I_e=0$	-300		V
: MPSA93			-200		V
*Collector Emitter Breakdown Voltage : MPSA92	BV_{CEO}	$I_c=-1\text{mA}, I_b=0$	-300		V
: MPSA93			-200		V
Emitter Base Breakdown Voltage	BV_{EBO}	$I_e=-100\mu\text{A}, I_c=0$	-5		V
Collector Cutoff Current : MPSA92	I_{CBO}	$V_{CB}=-200\text{V}, I_e=0$		-0.25	μA
: MPSA93		$V_{CB}=-160\text{V}, I_e=0$		-0.25	μA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-3\text{V}, I_c=0$		-0.10	μA
* DC Current Gain	h_{FE}	$V_{CE}=-10\text{V}, I_c=-1\text{mA}$ $V_{CE}=-10\text{V}, I_c=-10\text{mA}$ $V_{CE}=-10\text{V}, I_c=-30\text{mA}$	25 40 25		
		$I_c=-20\text{mA}, I_b=-2\text{mA}$ $I_c=-20\text{mA}, I_b=-2\text{mA}$		-0.50 -0.90	V
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$V_{CE}=-20\text{V}, I_c=-10\text{mA}$	50		MHz
*Base-Emitter Saturation Voltage	$V_{BE}(\text{sat})$				
Current Gain Bandwidth Product	f_T	$f=100\text{MHz}$			
Collector Base Capacitance : MPSA92	C_{cb}	$V_{CB}=-20\text{V}, I_e=0$		6	pF
: MPSA93		$f=1\text{MHz}$		8	pF

* Pulse Test: PW≤300μs, Duty Cycle≤2%

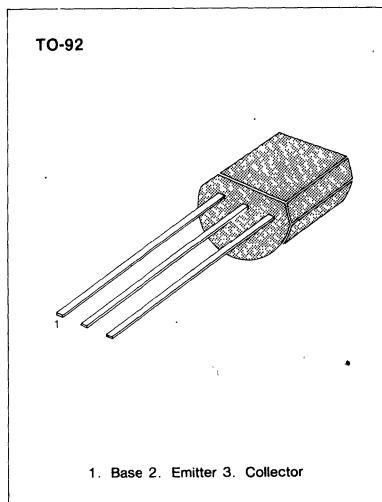




VHF/UHF TRANSISTOR

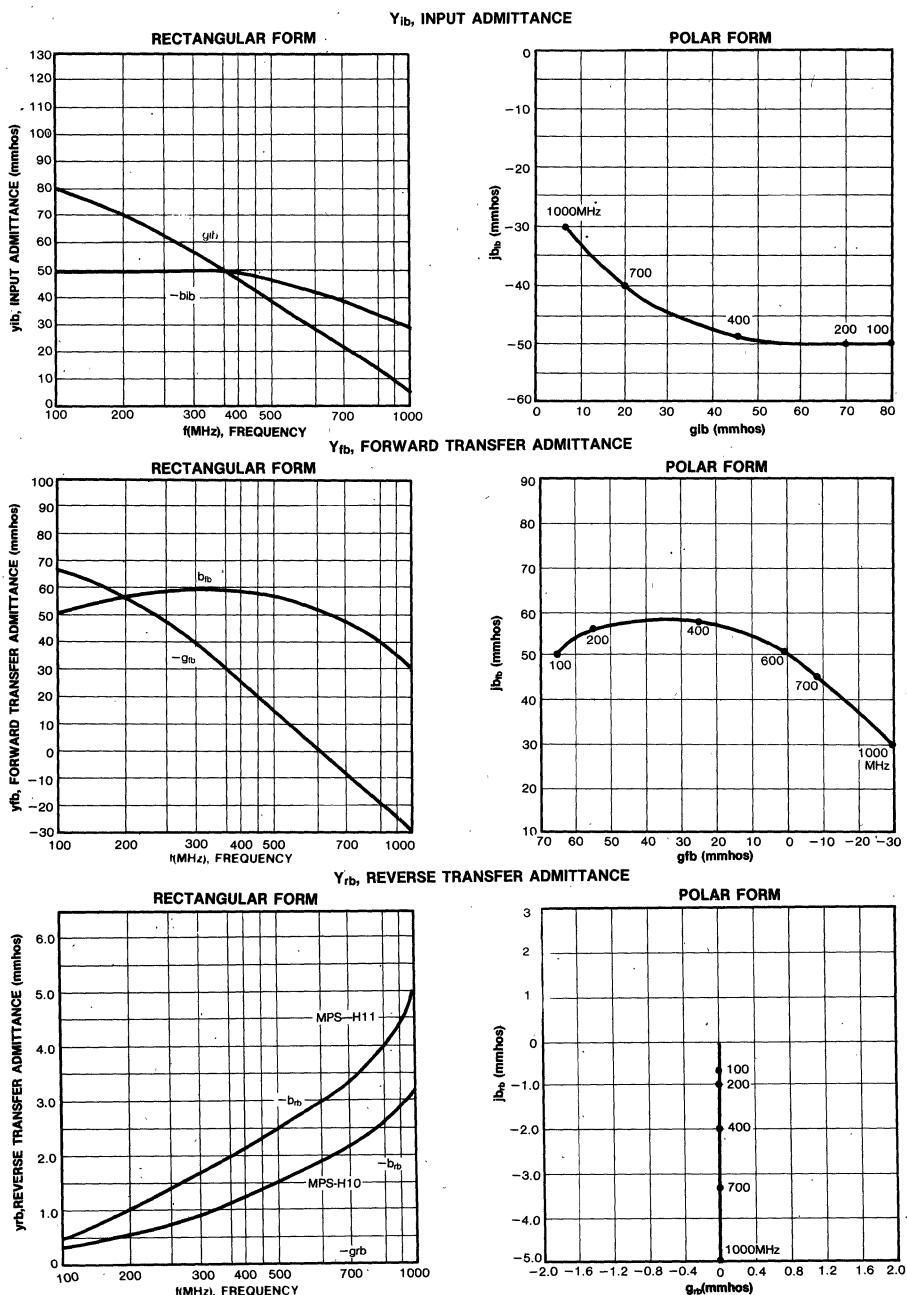
ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

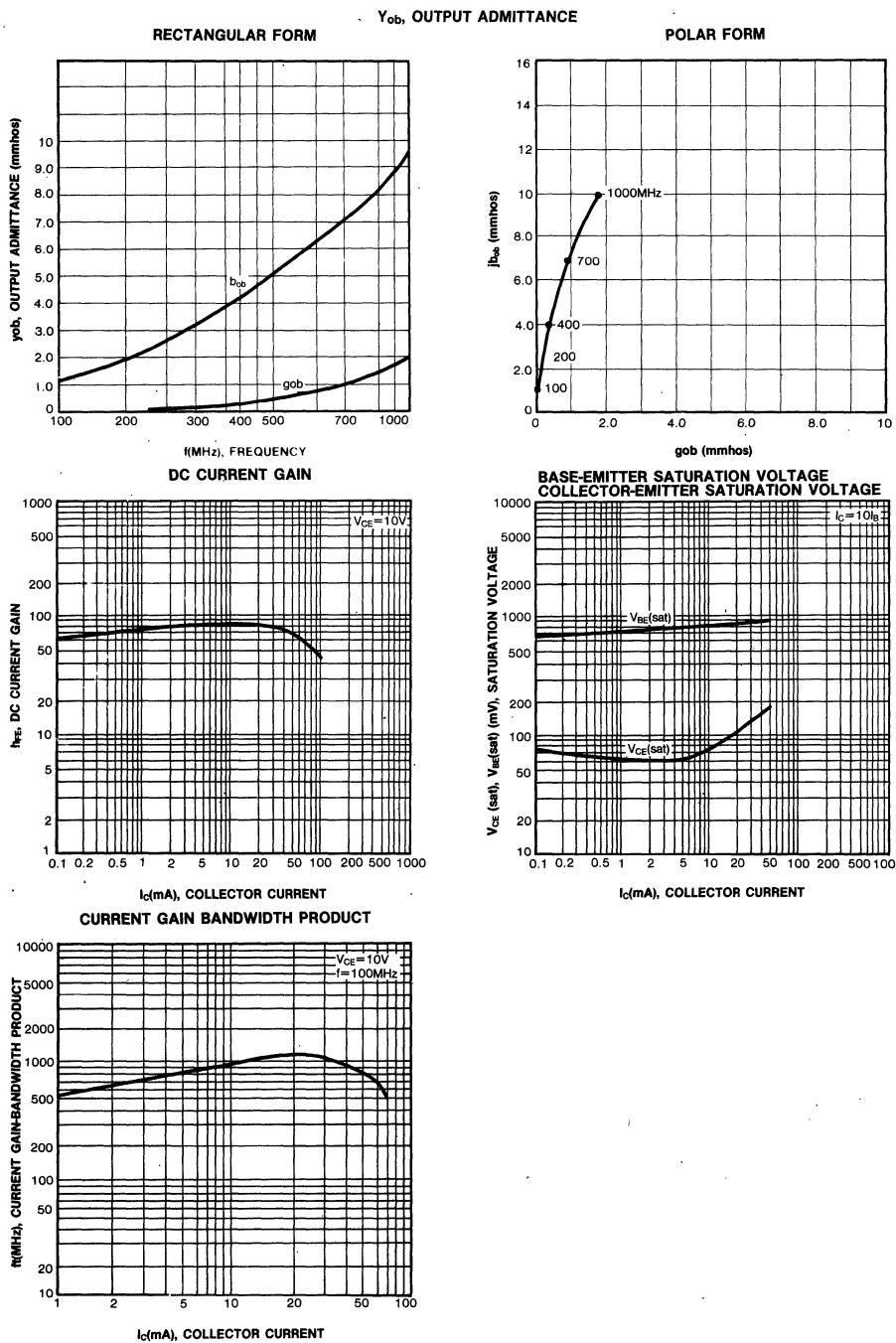
Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	3.0	V
Collector Dissipation ($T_a=25^\circ\text{C}$)	P_C	350	mW
Derate above 25°C		2.8	mW/ $^\circ\text{C}$
Collector Dissipation ($T_c=25^\circ\text{C}$)	P_C	1.0	W
Derate above 25°C		8.0	mW/ $^\circ\text{C}$
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$
Thermal Resistance, Junction to Case	$R_{th(j-c)}$	125	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C}/\text{W}$

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_c=100\mu\text{A}, I_E=0$	30		V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_c=1\text{mA}, I_B=0$	25		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_c=0$	3.0		V
Collector Cutoff Current	I_{CBO}	$V_{CB}=25\text{V}, I_E=0$		100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=2\text{V}, I_c=0$		100	nA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_c=4\text{mA}$	60		
Collector Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_c=4\text{mA}, I_B=0.4\text{mA}$		0.5	V
Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=10\text{V}, I_c=4\text{mA}$		0.95	V
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_c=4\text{mA}, f=100\text{MHz}$	650		MHz
Collector Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$		0.7	pF
Collector Base Feedback Capacitance	C_{rb}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$			
MPSH10			0.35	0.65	pF
MPSH11			0.6	0.9	pF
Collector Base Time Constant	$C_c \cdot r_{bb'}$	$V_{CB}=10\text{V}, I_c=4\text{mA}, f=31.8\text{MHz}$		9.0	ps

COMMON-BASE y PARAMETERS vs FREQUENCY
 $(V_{CB} = 10V, I_C = 4mA, T_a = 25^\circ C)$



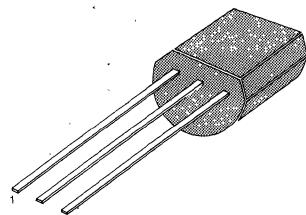


CATV TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	20	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	3.0	V
Collector Dissipation ($T_a=25^\circ\text{C}$) Derate above 25°C	P_C	625 5.0	mW mW/ $^\circ\text{C}$
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$
Thermal Resistance, Junction to Ambient	$R_{th(j-a)}$	200	$^\circ\text{C}/\text{W}$

TO-92

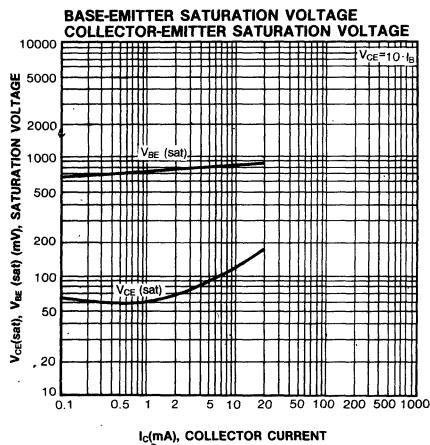
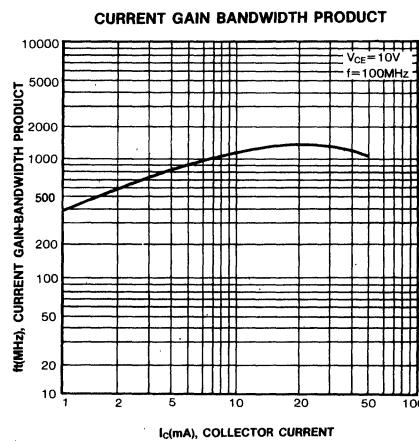
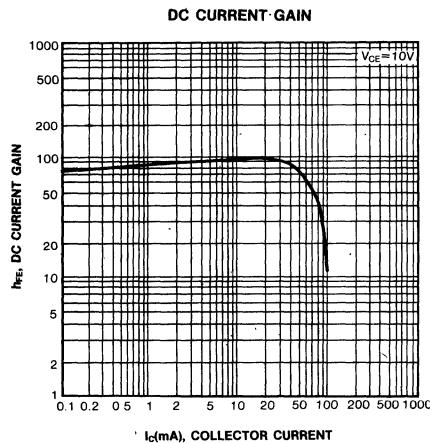


1. Base 2. Emitter 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	20			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	15			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	3.0			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}, I_E=0$			100	nA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=5\text{mA}$	25		250	
Collector Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=10\text{mA}, I_B=1\text{mA}$			0.5	V
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=5\text{mA}$ $f=100\text{MHz}$	800			MHz
Collector-Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$	0.3		0.9	pF
Small Signal Current Gain	h_{fe}	$V_{CE}=10\text{V}, I_C=5\text{mA}$ $f=1\text{kHz}$	30			
Noise Figure	NF	$V_{CC}=12\text{V}, I_C=5\text{mA}$ $R_S=50\Omega, f=200\text{MHz}$			6.0	dB
Amplifier Power Gain	G_{pe}	$V_{CC}=12\text{V}, I_C=5\text{mA}$ $R_S=50\Omega, f=200\text{MHz}$		24		dB



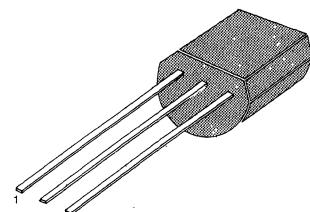


VHF TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4.0	V
Collector Current	I_C	100	mA
Collector Dissipation ($T_a=25^\circ\text{C}$) Derate above 25°C	P_C	350 2.81	mW mW/ $^\circ\text{C}$
Collector Dissipation ($T_c=25^\circ\text{C}$) Derate above 25°C	P_c	1.0 8.0	W mW/ $^\circ\text{C}$
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$
Thermal Resistance, Junction to Case	$R_{th(j-c)}$	83.3	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C}/\text{W}$

TO-92

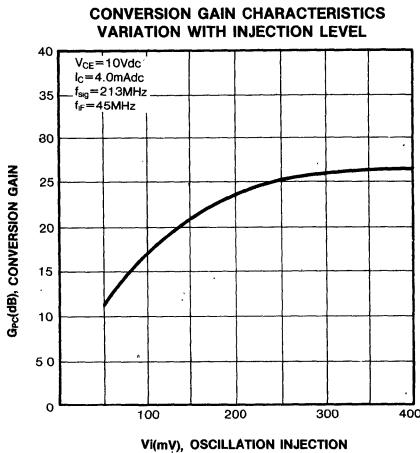
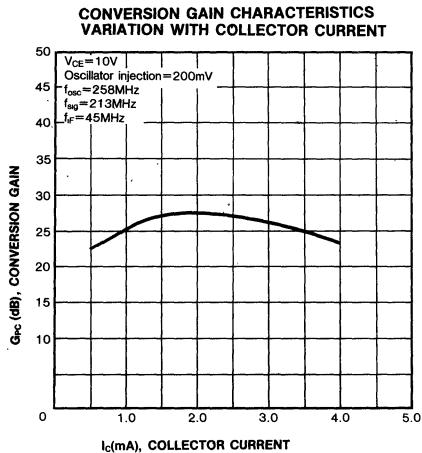
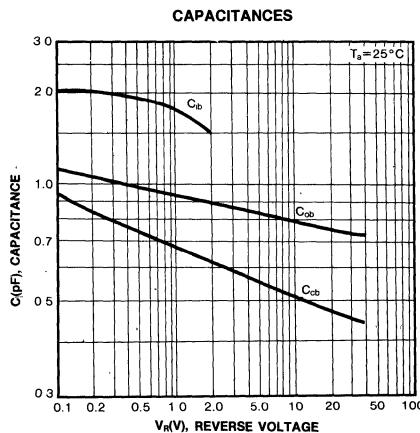
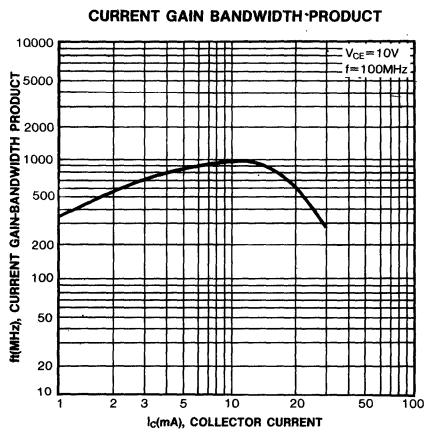
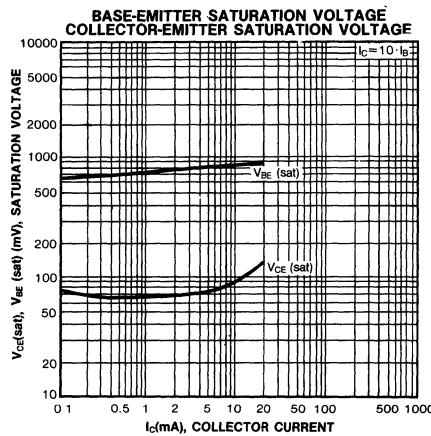
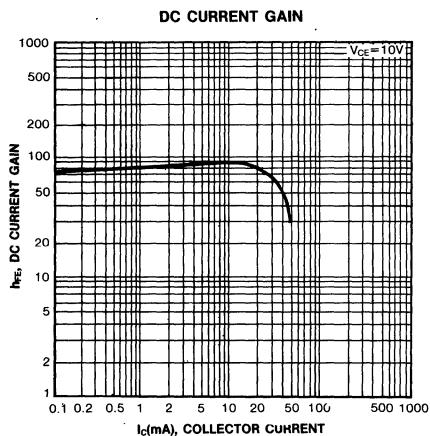


1. Base 2. Emitter 3. Collector

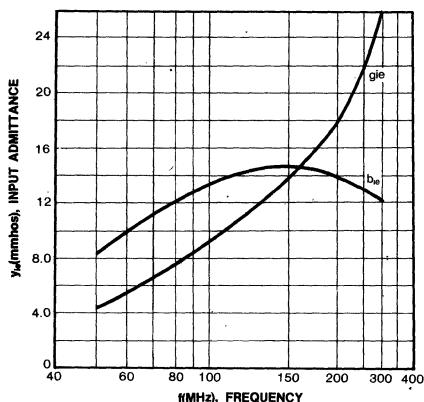
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	4.0			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}, I_E=0$			50	nA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=4\text{mA}$	25			
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=4\text{mA}$ $f=100\text{MHz}$	400	620		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$			0.65	pF
Collector Base Time Constant	$C_{cr-rrb'}$	$V_{CB}=10\text{V}, I_E=4\text{mA}$ $f=31.8\text{MHz}$		10		ps
Conversion Gain (213 to 45 MHz)	G_{CE}	$V_{CE}=10\text{V}, I_C=4\text{mA}$ Oscillator injection = 200mV	18	23		dB

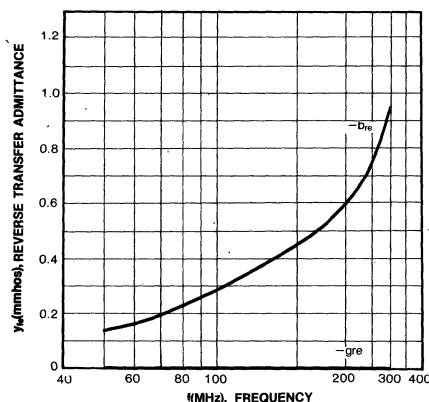




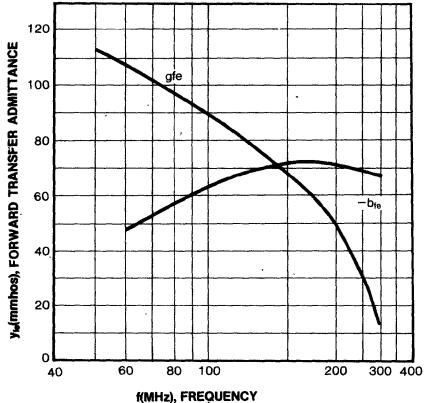
COMMON-EMITTER y PARAMETERS
($I_C = 4.0\text{mA}$, $V_{CE} = 10\text{V}$, $T_a = 25^\circ\text{C}$)
INPUT ADMITTANCE



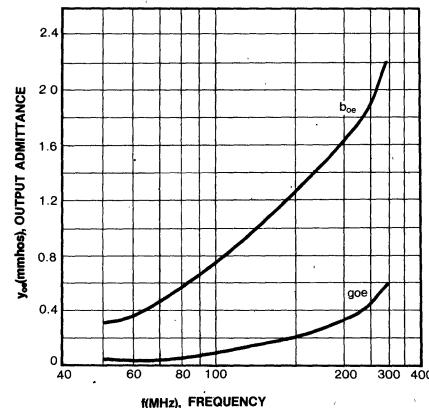
COMMON-EMITTER y PARAMETERS
($I_C = 4.0\text{mA}$, $V_{CE} = 10\text{V}$, $T_a = 25^\circ\text{C}$)
REVERSE TRANSFER ADMITTANCE



COMMON-EMITTER y PARAMETERS
($I_C = 4.0\text{mA}$, $V_{CE} = 10\text{V}$, $T_a = 25^\circ\text{C}$)
FORWARD TRANSFER ADMITTANCE



COMMON-EMITTER y PARAMETERS
($I_C = 4.0\text{mA}$, $V_{VE} = 10\text{V}$, $T_a = 25^\circ\text{C}$)
OUTPUT ADMITTANCE

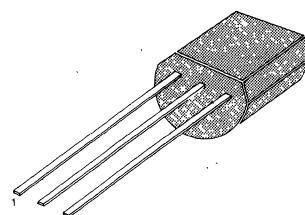


VHF TRANSISTOR

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	4.0	V
Collector Current	I_C	100	mA
Collector Dissipation ($T_a=25^\circ\text{C}$) Derate above 25°C	P_C	350 2.8	mW $\text{mW}/^\circ\text{C}$
Junction Temperature	T_J	135	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 ~ 135	$^\circ\text{C}$
Thermal Resistance, Junction to Ambient	$R_{th(j-a)}$	357	$^\circ\text{C}/\text{W}$

TO-92



1. Base 2. Emitter 3. Collector

3

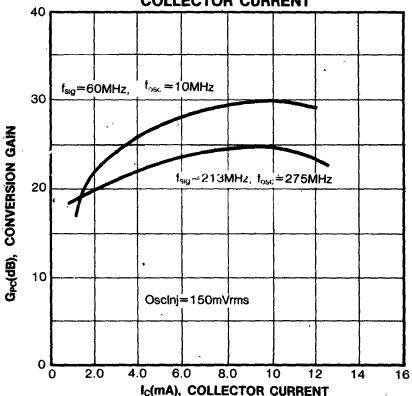
ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	4.0			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=15\text{V}, I_E=0$			50	nA
DC Current Gain	h_{FE}	$V_{CE}=10\text{V}, I_C=8\text{mA}$	30			
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=8\text{mA}$ $f=100\text{MHz}$	400	620		MHz
Collector-Base Capacitance	C_{cb}	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$				pF
Conversion Gain (213 to 45 MHz)	G_{CE}	$V_{CC}=20\text{V}, I_C=8\text{mA}$ Oscillator injection = 150mV	19	0.25	0.36	dB
Conversion Gain (60 to 45 MHz)	G_{CE}	$V_{CC}=20\text{V}, I_C=8\text{mA}$ Oscillator injection = 150mV	24	29		dB

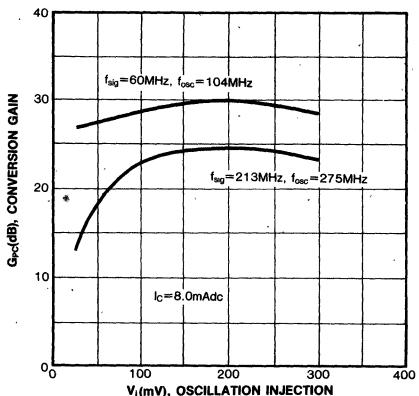


CONVERSION GAIN CHARACTERISTICS
 $(V_{CC} = 20V, R_s = R_L = 50\Omega, f_{IF} = 44MHz, B.W = 6MHz)$

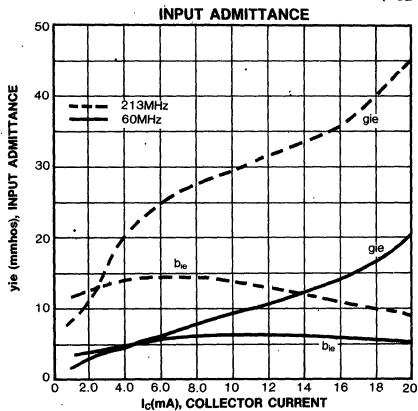
**CONVERSION GAIN versus
COLLECTOR CURRENT**



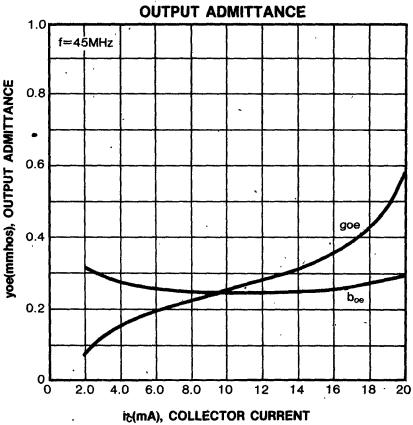
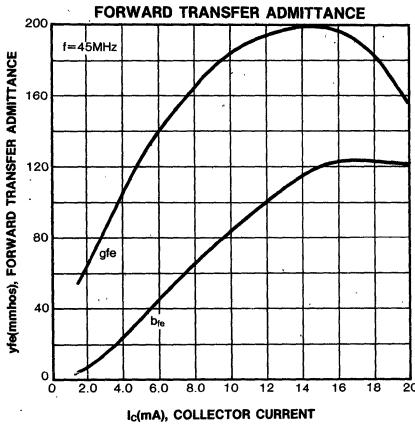
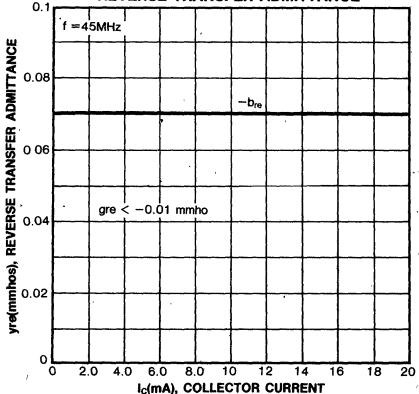
CONVERSION GAIN versus INJECTION LEVEL

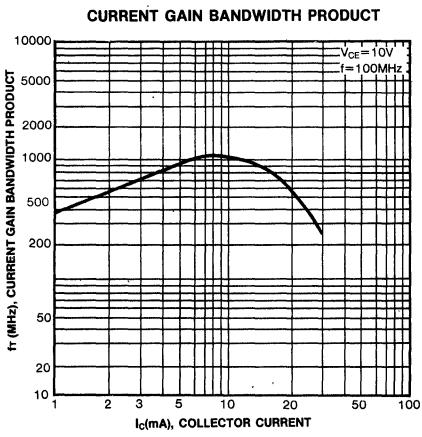
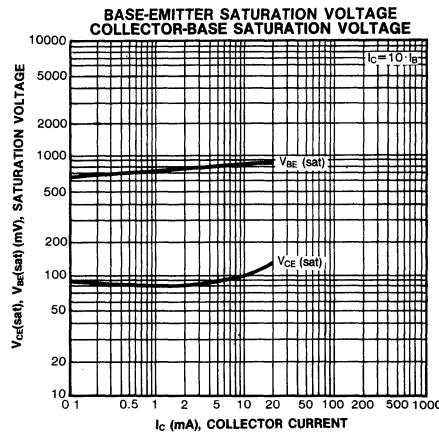
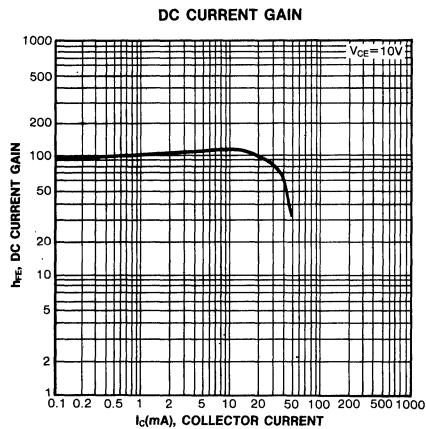


COMMON-BASE γ PARAMETERS
 $(V_{CE} = 15V, T_a = 25^\circ C)$



REVERSE TRANSFER ADMITTANCE



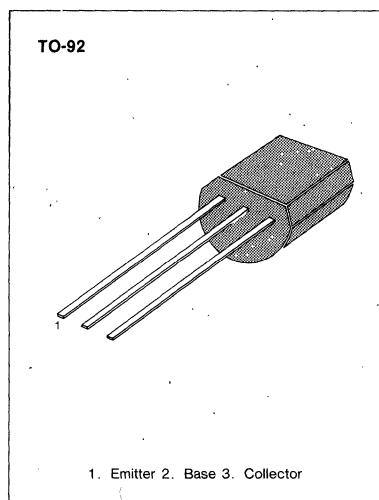


AMPLIFIER TRANSISTOR

- Collector-Emitter Voltage: $V_{CEO} = 120V$
- Collector Dissipation: P_c (max) = 625mW

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	140	V
Collector-Emitter Voltage	V_{CEO}	120	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	150	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	°C
Storage Temperature	T_{stg}	-55 ~ 150	°C



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

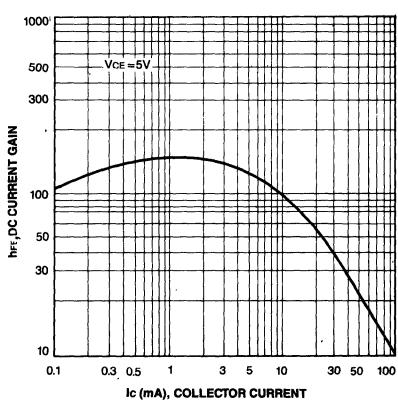
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1mA, I_E = 0$	120			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu A, I_E = 0$	140			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 10\mu A, I_C = 0$	5			V
Collector Cut-off Current	I_{CBO}	$V_{CB} = 75V, I_E = 0$			1	μA
Emitter Cut-off Current	I_{EBO}	$V_{BE} = 4V, I_C = 0$		100		nA
*DC Current Gain	h_{FE}	$I_C = 10mA, V_{CE} = 5V$	50		300	
Collector-Emitter Saturation Voltage	$V_{CE} (\text{sat})$	$I_C = 10mA, I_B = 1mA$			0.2	V
Base-Emitter Saturation Voltage	$V_{BE} (\text{sat})$	$I_C = 50mA, I_B = 5mA$			0.3	V
Collector-Base Capacitance	C_{cb}	$I_C = 10mA, I_B = 1mA$			1.2	V
*Current Gain Bandwidth Product	f_T	$I_C = 50mA, I_B = 5mA$			1.4	V
		$V_{CB} = 10V, I_E = 0$ $f = 1MHz$	60		8	pF
		$I_C = 10mA, V_{CE} = 10V$ $f = 100MHz$				MHz

* Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

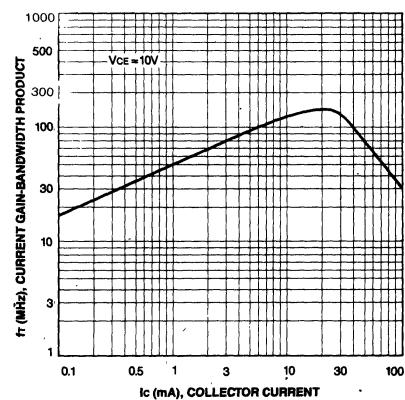
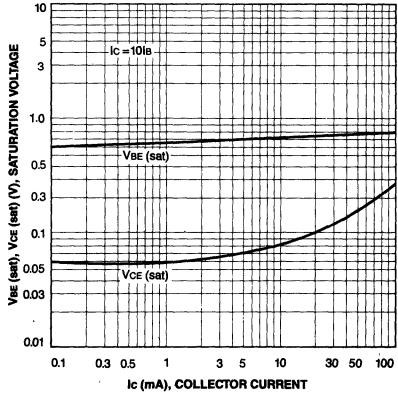


SAMSUNG SEMICONDUCTOR

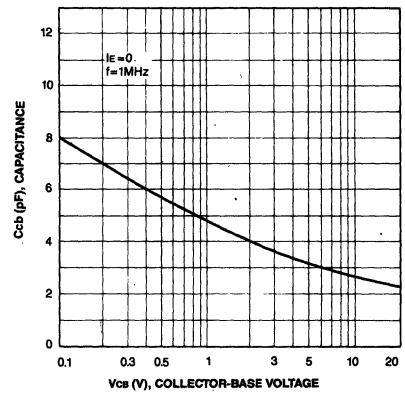
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR-BASE CAPACITANCE



AMPLIFIER TRANSISTOR

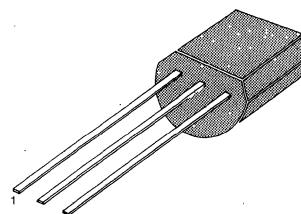
- Collector-Emitter Voltage: $V_{CEO}=100V$
- Collector Dissipation: $P_c \text{ (max)}=625\text{mW}$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	100	V
Collector-Emitter Voltage	V_{CEO}	100	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	600	mA
Collector Dissipation	P_c	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{Stg}	-55 ~ 150	$^\circ\text{C}$

- Refer to 2N5401 for graphs

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	100			V
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	100			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=10\mu\text{A}, I_C=0$	4			V
Collector Cut-off Current	I_{CBO}	$V_{CB}=50\text{V}, I_E=0$			1	μA
Emitter Cut-off Current	I_{EBO}	$V_{EB}=3\text{V}, I_C=0$			100	nA
*DC Current Gain	h_{FE}	$I_C=50\text{mA}, V_{CE}=5\text{V}$		40	250	
*Collector-Emitter Saturation Voltage	$V_{CE \text{ (sat)}}$	$I_O=10\text{mA}, I_E=1\text{mA}$			0.25	V
		$I_C=50\text{mA}, I_B=5\text{mA}$			0.3	V
*Base-Emitter Saturation Voltage	$V_{BE \text{ (sat)}}$	$I_C=10\text{mA}, I_E=1\text{mA}$			1.2	V
		$I_C=50\text{mA}, I_B=5\text{mA}$			1.2	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$			8	pF
		$f=1\text{MHz}$				
Current Gain Bandwidth Product	f_T	$I_C=10\text{mA}, V_{CE}=10\text{V}$	60			MHz
		$f=100\text{MHz}$				

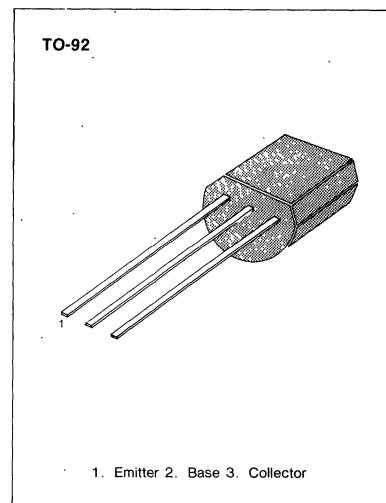
* Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$ 

**2W OUTPUT AMPLIFIER OF PORTABLE
RADIOS IN CLASS
B PUSH-PULL OPERATION.**

- Complimentary to SS8550
- Collector Current $I_C = 1.5A$
- Collector Dissipation $P_C = 2W$ ($T_C = 25^\circ C$)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	25	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	1.5	A
Collector Dissipation	P_C	1	W
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-65~150	$^\circ C$



3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

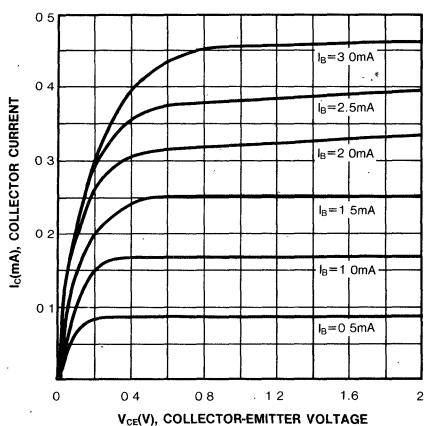
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=2mA, I_B=0$	25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu A, I_C=0$	6			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=35V, I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=6V, I_C=0$			100	nA
DC Current Gain	h_{FE1}	$V_{CE}=1V, I_C=5mA$	45	135		
	h_{FE2}	$V_{CE}=1V, I_C=100mA$	85	160	300	
	h_{FE3}	$V_{CE}=1V, I_C=800mA$	40	110		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=800mA, I_B=80mA$		0.28	0.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=800mA, I_B=80mA$		0.98	1.2	V
Base-Emitter Voltage	V_{BE}	$V_{CE}=1V, I_C=10mA$		0.66	1	V
Output Capacitance	C_{OB}	$V_{CB}=10V, I_E=0$		9.0		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=10V, I_C=50mA$	100	190		MHz

h_{FE} (2) CLASSIFICATION

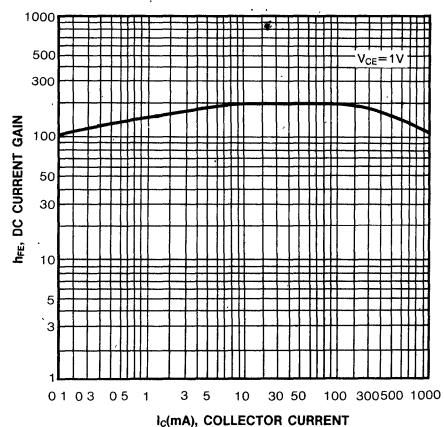
Classification	B	C	D
h_{FE} (2)	85-160	120-200	160-300



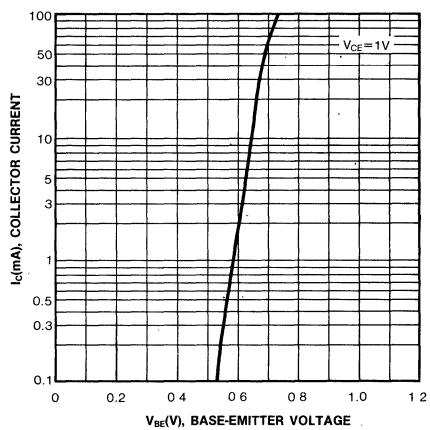
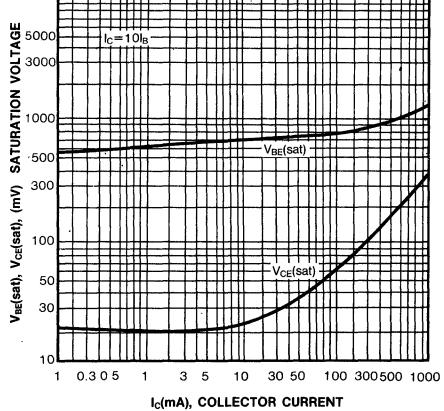
STATIC CHARACTERISTIC



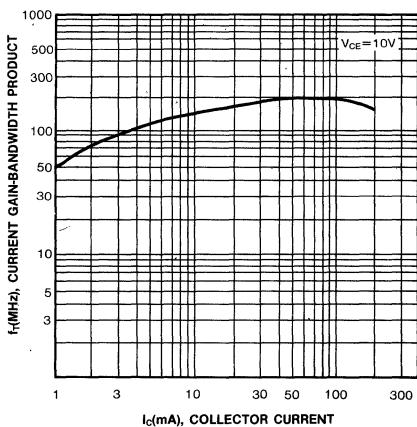
DC CURRENT GAIN



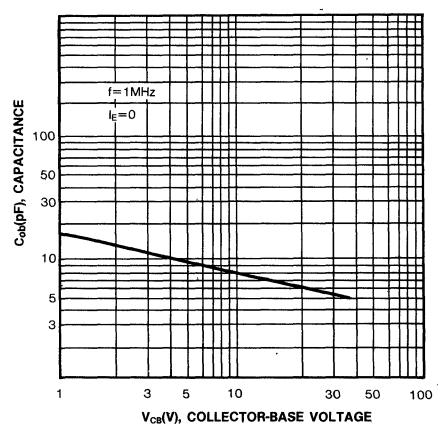
BASE-EMITTER ON VOLTAGE

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR OUTPUT CAPACITANCE



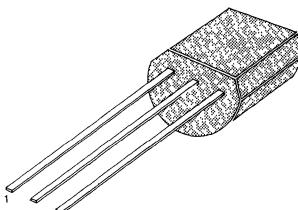
**2W OUTPUT AMPLIFIER OF PORTABLE
RADIOS IN CLASS
B PUSH-PULL OPERATION.**

- Complimentary to SS8050
- Collector Current $I_C = -1.5A$
- Collector Dissipation $P_C = 2W$ ($T_C = 25^\circ C$)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ C$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-25	V
Emitter-Base Voltage	V_{EBO}	-6	V
Collector Current	I_C	-1.5	A
Collector Dissipation	P_C	1	W
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature	T_{STG}	-65~150	$^\circ C$

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ C$)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu A, I_E = 0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -2mA, I_E = 0$	-25			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu A, I_C = 0$	-6			V
Collector Cutoff Current	I_{CBO}	$V_{CE} = -35V, I_F = 0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -6V, I_C = 0$			-100	nA
DC Current Gain	h_{FE1}	$V_{CE} = -1V, I_C = -5mA$	45	170		
	h_{FE2}	$V_{CE} = -1V, I_C = -100mA$	85	160	300	
	h_{FE3}	$V_{CE} = -1V, I_C = -800mA$	40	80		
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = -800mA, I_B = -80mA$		-0.28	-0.5	V
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C = -800mA, I_B = -80mA$		-0.98	-1.2	V
Base Emitter Voltage	V_{BE}	$V_{CF} = -1V, I_C = -10mA$		-0.66	-1.0	V
Output Capacitance	C_{OB}	$V_{CB} = -10V, I_E = 0$ $f = 1MHz$		15		pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -10V, I_C = -50mA$	100	200		MHz

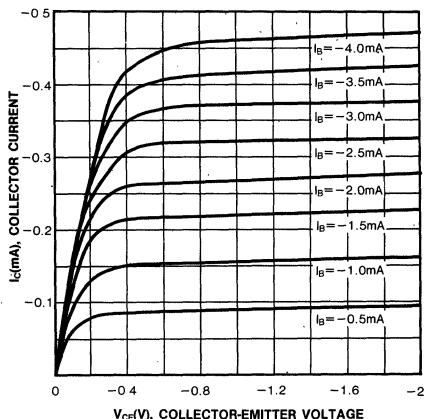
$h_{FE}(2)$ CLASSIFICATION

Classification	B	C	D
$h_{FE}(2)$	85-160	120-200	160-300

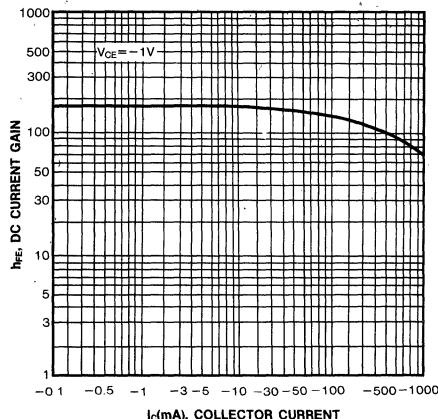


SAMSUNG SEMICONDUCTOR

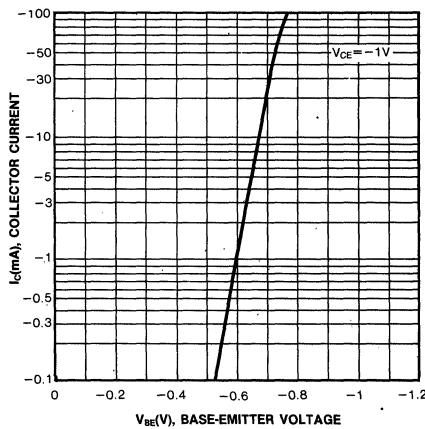
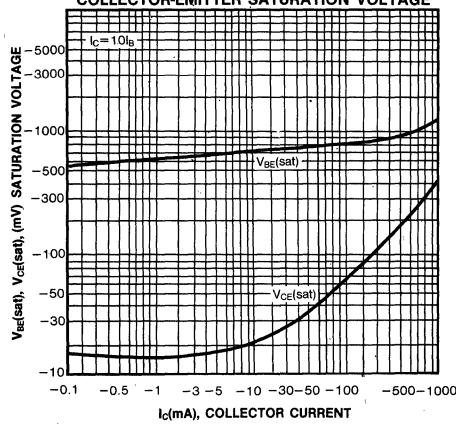
STATIC CHARACTERISTIC



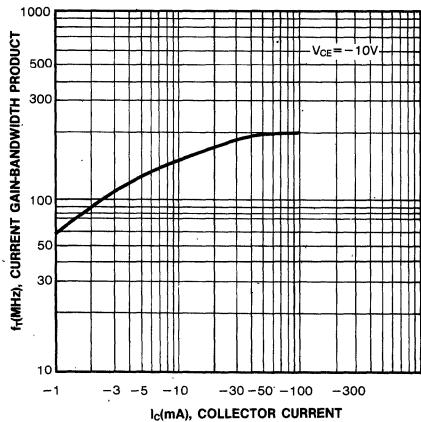
DC CURRENT GAIN



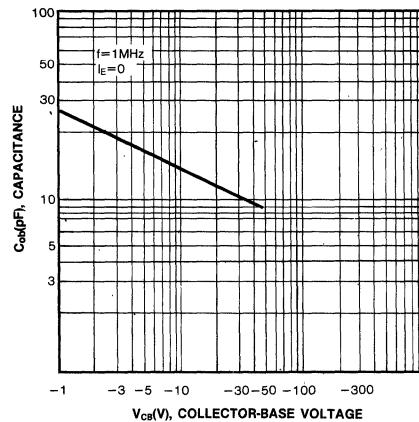
BASE-EMITTER ON VOLTAGE

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT



COLLECTOR OUTPUT CAPACITANCE

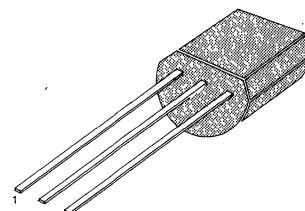


**AM CONVERTER, AM/FM IF AMPLIFIER
GENERAL PURPOSE TRANSISTOR**

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	30	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	30	mA
Collector Dissipation	P_C	400	mW
Junction Temperature	T_j	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

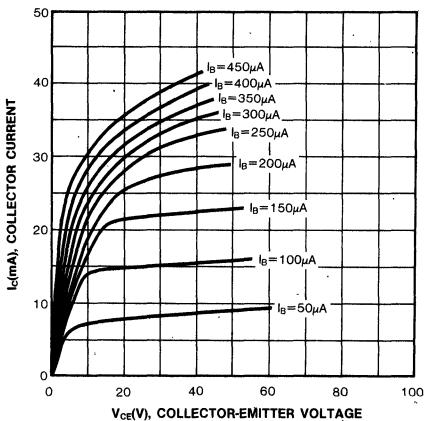
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_E=0$	30			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_C=0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=50\text{V}, I_E=0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}, I_C=0$			100	nA
DC Current Gain	β_{FE}	$V_{CF}=5\text{V}, I_C=1\text{mA}$	28	90	198	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=10\text{mA}, I_B=1\text{mA}$		0.08	0.3	V
Base-Emitter Voltage	V_{BE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	0.65	0.7	0.75	V
Output Capacitance	C_{ob}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		1.5		pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{V}, I_C=1\text{mA}$	150	370		MHz
Noise Figure	NF	$V_{CE}=5\text{V}, I_C=1.0\text{mA}$ $f=1\text{MHz}, R_s=500\Omega$		2.0	4.0	dB

β_{FE} CLASSIFICATION

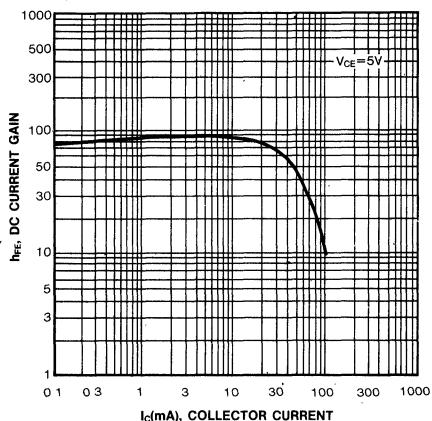
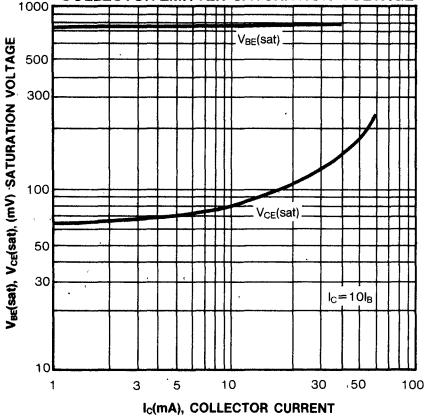
Classification	D	E	F	G	H	I
β_{FE}	28-45	39-60	54-80	72-108	97-146	132-198



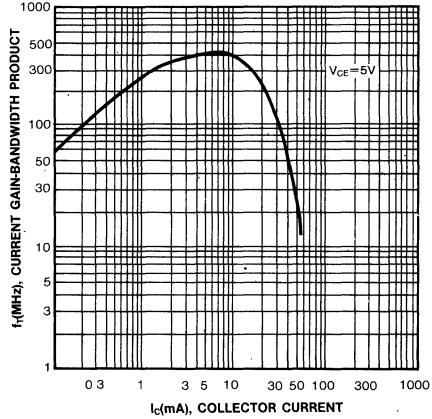
STATIC CHARACTERISTIC



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT

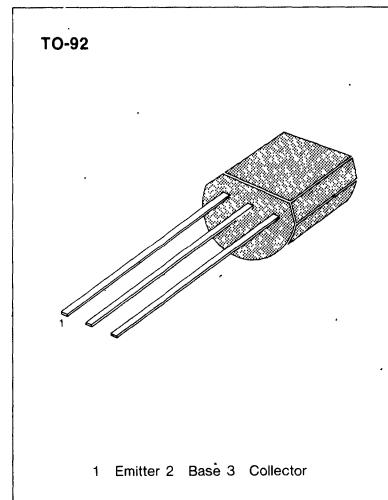


**1W OUTPUT AMPLIFIER OF POTABLE
RADIOS IN CLASS
B PUSH-PULL OPERATION.**

- High total power dissipation. ($PT=625\text{mW}$)
- High Collector Current. ($I_C = -500\text{mA}$)
- Complementary to SS9013
- Excellent h_{FE} linearity.

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-40	V
Collector-Emitter Voltage	V_{CEO}	-20	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-55~150	$^\circ\text{C}$



3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

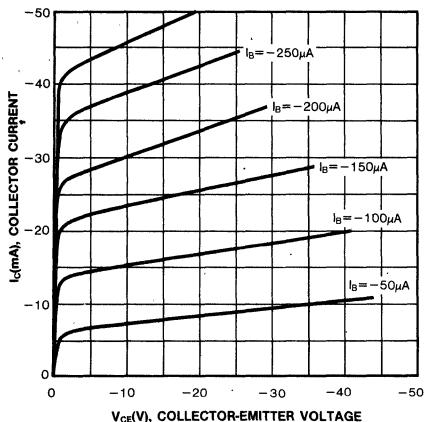
Characteristic	Symbol	Test Condition	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=-100\mu\text{A}, I_E=0$	-40			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=-1\text{mA}, I_B=0$	-20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=-100\mu\text{A}, I_C=0$	-5			V
Collector Cutoff Current	I_{CBO}	$V_{CB}=-25\text{V}, I_E=0$			-100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=-3\text{V}, I_C=0$			-100	nA
DC Current Gain	h_{FE}					
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$V_{CE}=-1\text{V}, I_C=-50\text{mA}$	64	120	202	nA
	$V_{BE(sat)}$	$V_{CE}=-1\text{V}, I_C=-500\text{mA}$	40	90		
Base-Emitter On Voltage	$V_{BE(on)}$	$I_C=-500\text{mA}, I_B=-50\text{mA}$				
		$I_C=-500\text{mA}, I_B=-50\text{mA}$	-0.18	-0.6		V
		$I_C=-500\text{mA}, I_B=-50\text{mA}$	-0.95	-1.2		V
		$V_{CE}=-1\text{V}, I_C=-10\text{mA}$	-0.6	-0.67	-0.7	V

h_{FE} (1) CLASSIFICATION

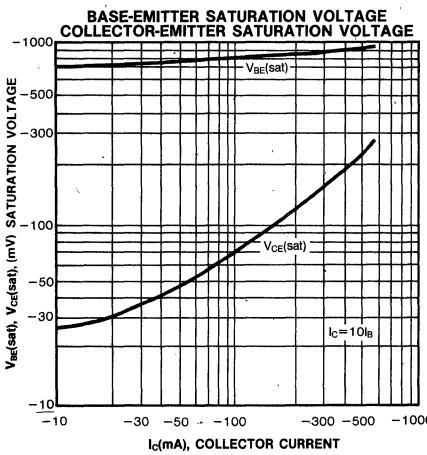
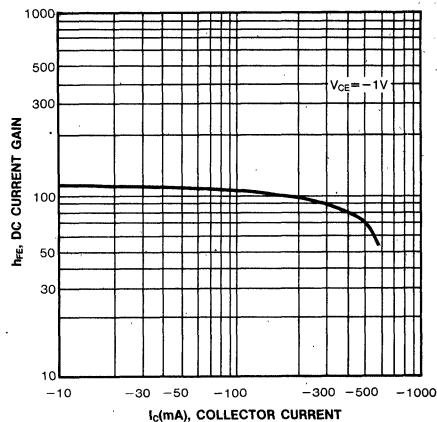
Classification	D	E	F	G	H
h_{FE} (1)	64-91	78-112	96-135	112-166	144-202



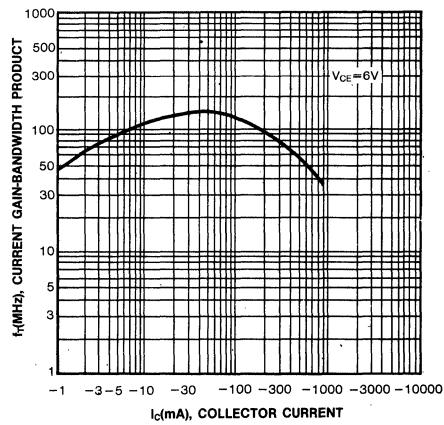
STATIC CHARACTERISTIC



DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT



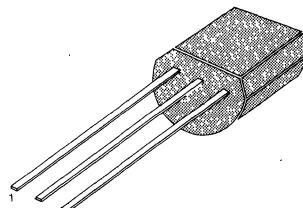
**1W OUTPUT AMPLIFIER OF POTABLE
RADIOS IN CLASS
B PUSH-PULL OPERATION.**

- High total power dissipation. ($PT=625\text{mW}$)
- High Collector Current. ($I_C=500\text{mA}$)
- Complementary to SS9012
- Excellent h_{FE} linearity.

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	40	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

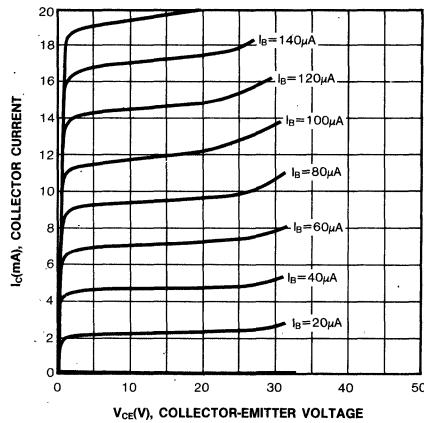
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit	
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	40			V	
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	20			V	
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_C=0$	5			V	
Collector Cutoff Current	I_{CBO}	$V_{CB}=25\text{V}, I_E=0$			100	nA	
Emitter Cutoff Current	I_{EBO}	$V_{EB}=3\text{V}, I_C=0$			100	nA	
DC Current Gain	h_{FE1}	$V_{CE}=1\text{V}, I_C=50\text{mA}$	64	120	202	nA	
	h_{FE2}	$V_{CE}=1\text{V}, I_C=500\text{mA}$	40	120			
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=500\text{mA}, I_B=50\text{mA}$		0.16	0.6	V	
Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=500\text{mA}, I_B=50\text{mA}$			0.91	1.2	V
Base-Emitter On Voltage	$V_{BE(on)}$	$V_{CE}=1\text{V}, I_C=10\text{mA}$	0.6	0.67	0.7	V	

h_{FE} (1) CLASSIFICATION

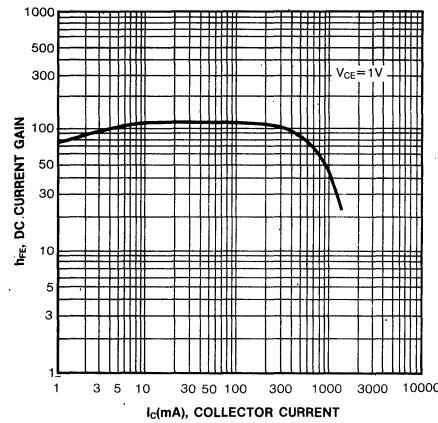
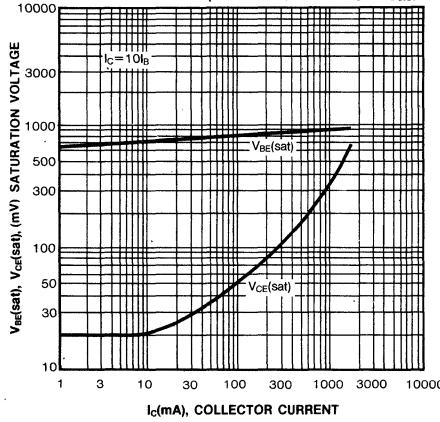
Classification	D	E	F	G	H
h_{FE} (1)	64-91	78-112	96-135	112-166	144-202



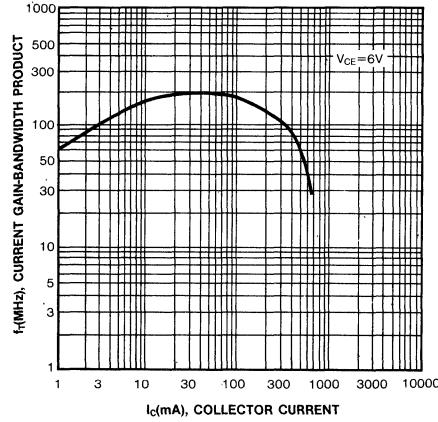
STATIC CHARACTERISTIC



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT



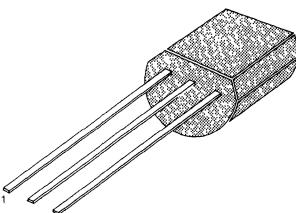
PRE-AMPLIFIER, LOW LEVEL & LOW NOISE

- High total power dissipation. ($P_T=450\text{mW}$)
- High h_{FE} and good linearity
- Complementary to SS9015

ABSOLUTE MAXIMUM RATINGS ($T_a=25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	50	V
Collector-Emitter Voltage	V_{CEO}	45	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	100	mA
Collector Dissipation	P_C	450	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a=25^\circ\text{C}$)

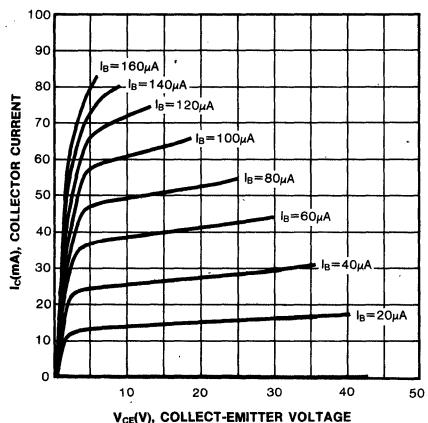
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu\text{A}, I_E=0$	50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1\text{mA}, I_B=0$	45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu\text{A}, I_C=0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CE}=50\text{V}, I_E=0$			50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB}=5\text{V}, I_C=0$			50	nA
DC Current Gain	h_{FE}	$V_{CE}=5\text{V}, I_C=1\text{mA}$	60	280	1000	
Collector-Base Saturation Voltage	$V_{CE(\text{sat})}$	$I_C=100\text{mA}, I_R=5\text{mA}$		0.14	0.3	V
Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C=100\text{mA}, I_S=5\text{mA}$		0.84	1.0	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$V_{CE}=5\text{V}, I_C=2\text{mA}$	0.58	0.63	0.7	V
Output Capacitance	C_{OB}	$V_{CB}=10\text{V}, I_E=0$ $f=1\text{MHz}$		2.2	3.5	pF
Current Gain-Bandwidth Product	f_T	$V_{CE}=5\text{V}, I_C=10\text{mA}$	150	270		MHz
Noise Figure	NF	$V_{CE}=5\text{V}, I_C=0.2\text{mA}$ $f=1\text{KHz}, R_s=2\text{k}\Omega$		0.9	10	dB

 h_{FE} CLASSIFICATION

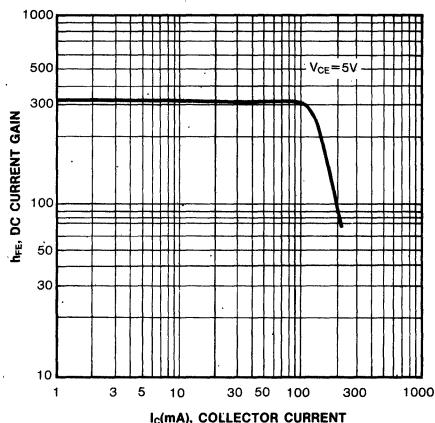
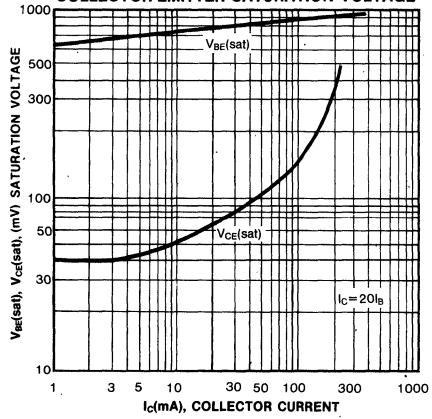
Classification	A	B	C	D
h_{FE}	60-150	100-300	200-600	400-1000



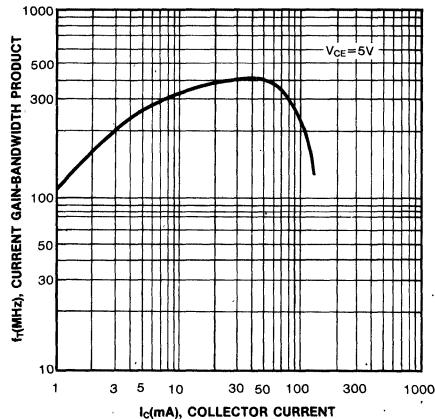
STATIC CHARACTERISTIC



DC CURRENT GAIN

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

CURRENT GAIN-BANDWIDTH PRODUCT



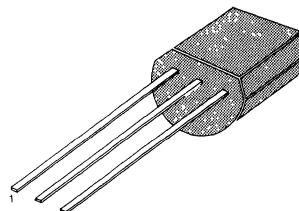
LOW FREQUENCY, LOW NOISE AMPLIFIER

- Complement to SS9014

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-45	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-100	mA
Collector Dissipation	P_C	450	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

TO-92



1. Emitter 2. Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

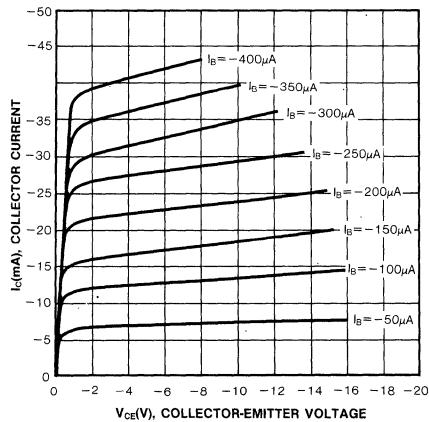
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = -100\mu\text{A}, I_E = 0$	-50			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = -1\text{mA}, I_B = 0$	-45			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = -100\mu\text{A}, I_C = 0$	-5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = -50\text{V}, I_E = 0$			-50	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = -5\text{V}, I_C = 0$			-50	nA
DC Current Gain	h_{FE}	$V_{CE} = -5\text{V}, I_C = -1\text{mA}$	60	200	600	
Collector-Base Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = -100\text{mA}, I_B = -5\text{mA}$		-0.2	-0.7	V
Base-Emitter Saturation Voltage	$V_{BE(\text{sat})}$	$I_C = -100\text{mA}, I_B = -5\text{mA}$		-0.82	-1.0	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$V_{CE} = -5\text{V}, I_C = -2\text{mA}$	-0.6	-0.65	-0.75	V
Output Capacitance	C_{OB}	$V_{CB} = -10\text{V}, I_E = 0$ $f = 1\text{MHz}$		4.5	7.0	pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = -5\text{V}, I_C = -10\text{mA}$	100	190		MHz
Noise Figure	NF	$V_{CE} = -5\text{V}, I_C = -0.2\text{mA}$ $f = 1\text{KHz}, R_s = 1\text{k}\Omega$		0.7	10	dB

 h_{FE} CLASSIFICATION

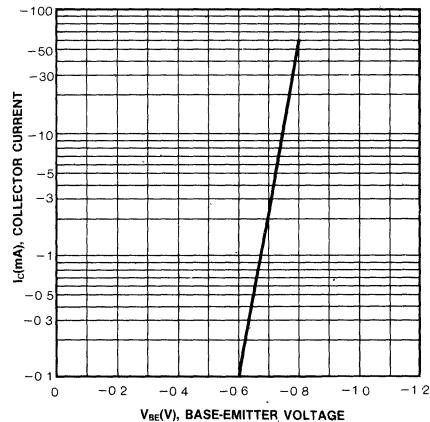
Classification	A	B	C
h_{FE}	60-150	100-300	200-600



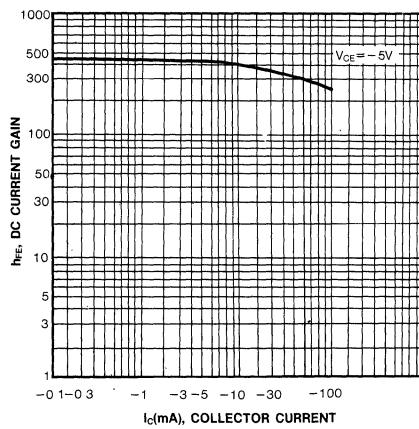
STATIC CHARACTERISTIC



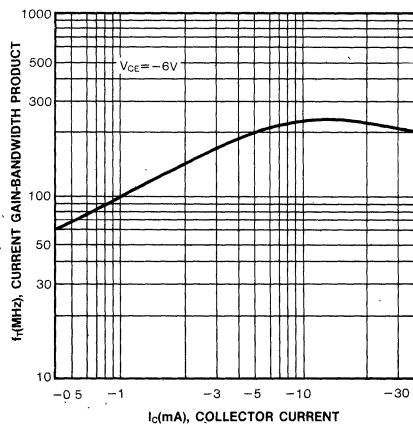
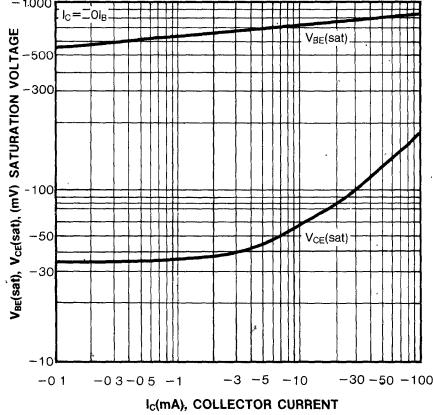
BASE-EMITTER ON VOLTAGE



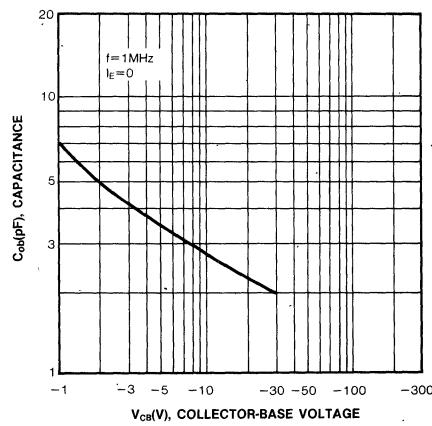
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



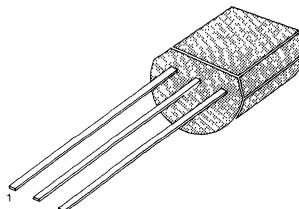
**AM CONVERTER, FM/RF AMPLIFIER OF
LOW NOISE.**

- High total power dissipation. (PT=400mW)

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	20	V
Emitter-Base Voltage	V_{EBO}	4	V
Collector Current	I_C	25	mA
Collector Dissipation	P_C	400	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

TO-92



1 Emitter 2 Base 3. Collector

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

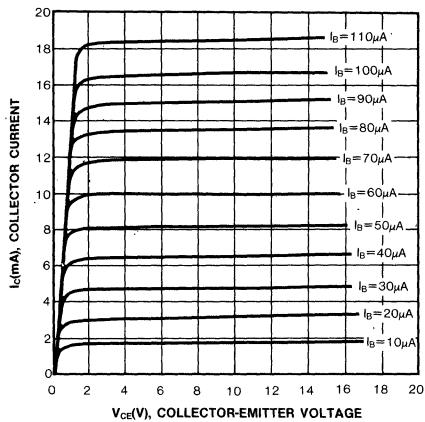
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1\text{mA}, I_B = 0$	20			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	4			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 30\text{V}, I_E = 0$			100	nA
Emitter Cutoff Current	I_{EBO}	$V_{EB} = 3\text{V}, I_C = 0$			100	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 1\text{mA}$	28	90	198	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$		0.1	0.3	V
Base-Emitter On Voltage	$V_{BE(\text{on})}$	$V_{CE} = 5\text{V}, I_C = 1\text{mA}$		0.72		V
Output Capacitance	C_{OB}	$V_{CB} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		1.2	1.6	pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{V}, I_C = 1\text{mA}$	400	620		MHz
Noise Figure	NF	$V_{CE} = 5\text{V}, I_C = 1.0\text{mA}$ $f = 100\text{MHz}, R_S = 50\Omega$		3.0	5.0	dB

 h_{FE} CLASSIFICATION

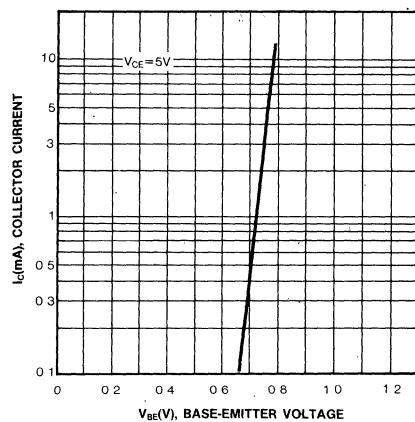
Classification	D	E	F	G	H	I
h_{FE}	28-45	39-60	54-80	72-108	97-146	132-198



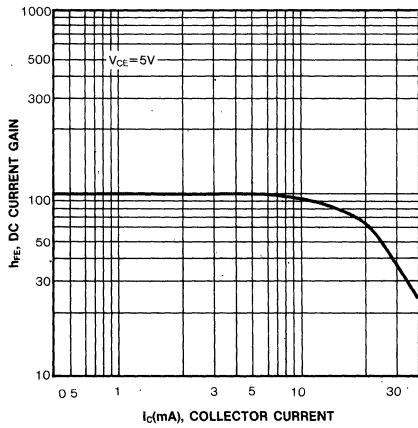
STATIC CHARACTERISTIC



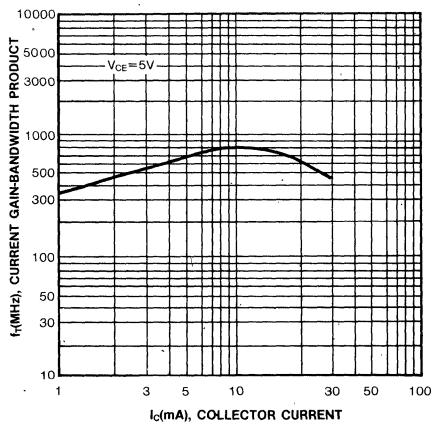
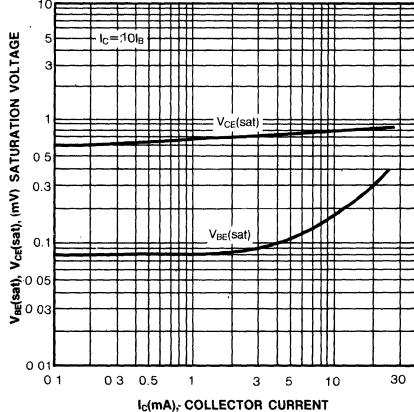
BASE-EMITTER ON VOLTAGE



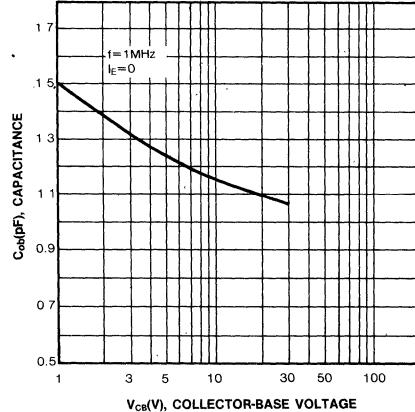
DC CURRENT GAIN



CURRENT GAIN-BANDWIDTH PRODUCT

BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

COLLECTOR OUTPUT CAPACITANCE



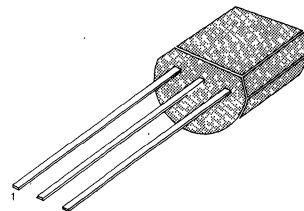
**AM/FM IF AMPLIFIER, LOCAL OSCILLATOR
OF FM/VHF TUNER**

- High Current Gain Bandwidth Product $f_T = 1,100 \text{ MHz} (\text{Typ})$

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V_{CEO}	15	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current	I_C	50	mA
Collector Dissipation	P_C	400	mW
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55~150	$^\circ\text{C}$

TO-92



1 Emitter 2 Base 3. Collector

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

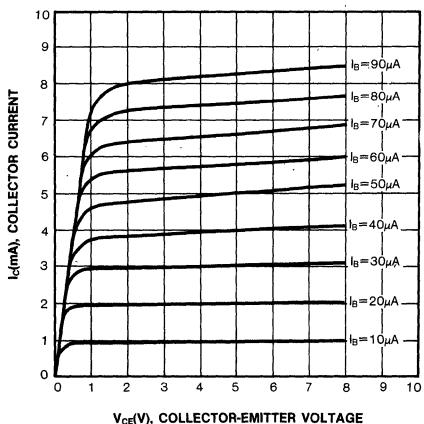
Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C = 100\mu\text{A}, I_E = 0$	30			V
Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C = 1.0\text{mA}, I_B = 0$	15			V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E = 100\mu\text{A}, I_C = 0$	5			V
Collector Cutoff Current	I_{CBO}	$V_{CB} = 12\text{V}, I_E = 0$			50	nA
DC Current Gain	h_{FE}	$V_{CE} = 5\text{V}, I_C = 1.0\text{mA}$	28	100	198	
Collector-Emitter Saturation Voltage	$V_{CE(\text{sat})}$	$I_C = 10\text{mA}, I_B = 1\text{mA}$			0.5	V
Output Capacitance	C_{ob}	$V_{CE} = 10\text{V}, I_E = 0$ $f = 1\text{MHz}$		1.3	1.7	pF
Current Gain-Bandwidth Product	f_T	$V_{CE} = 5\text{V}, I_C = 5\text{mA}$	700	1100		MHz

 h_{FE} CLASSIFICATION

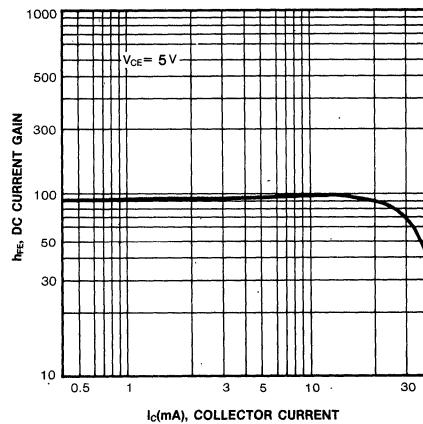
Classification	D	E	F	G	H	I
h_{FE}	28-45	39-60	54-80	72-108	97-146	132-198



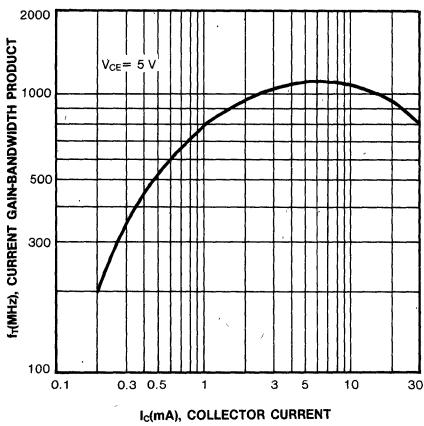
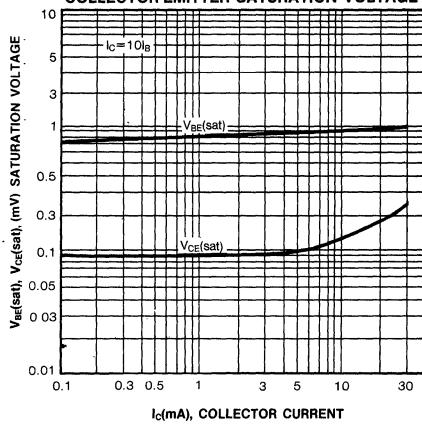
STATIC CHARACTERISTIC



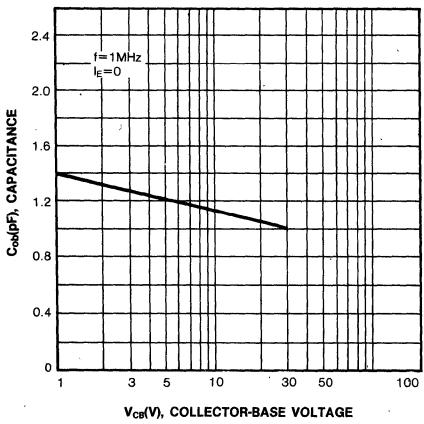
DC CURRENT GAIN



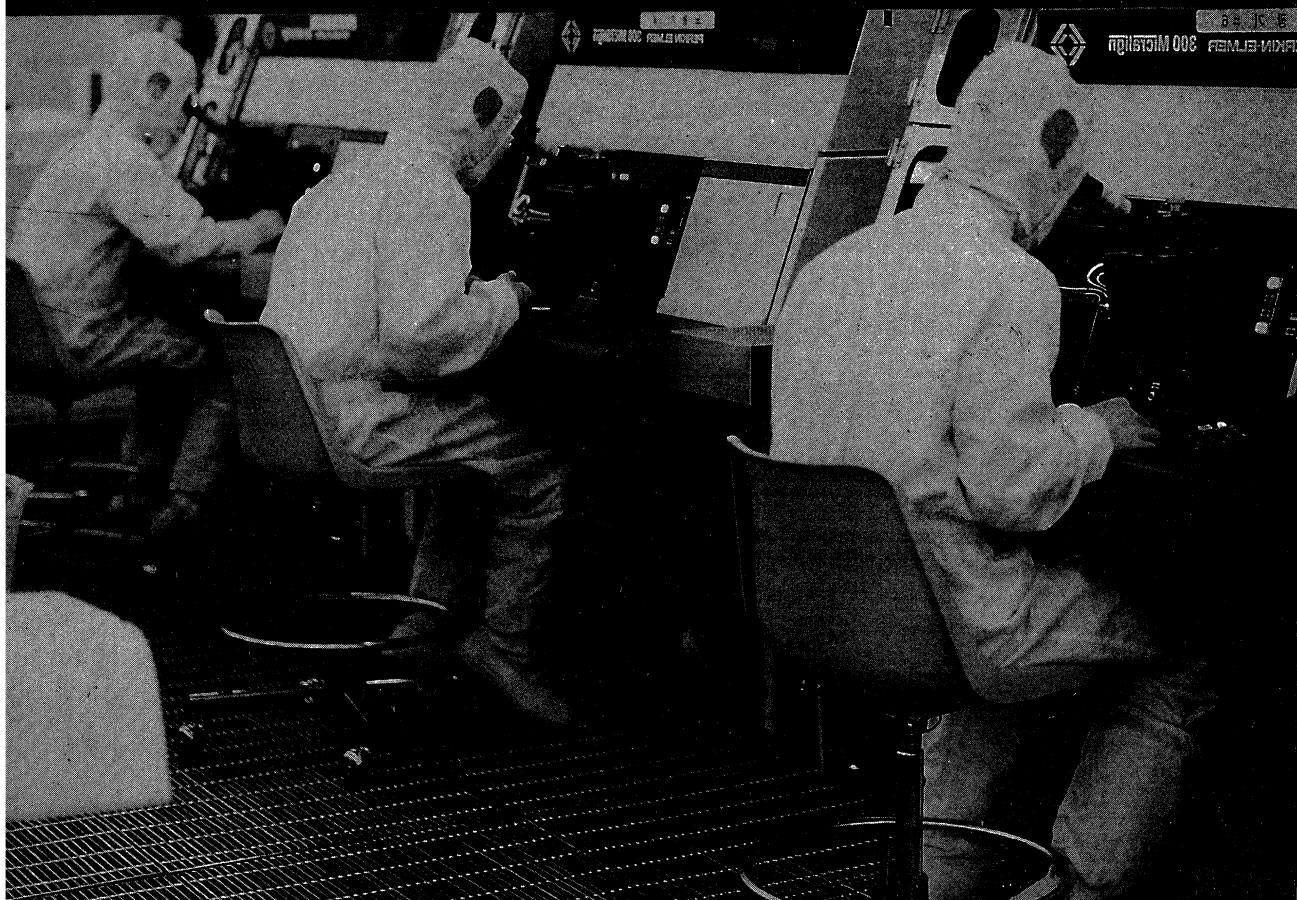
CURRENT GAIN-BANDWIDTH PRODUCT

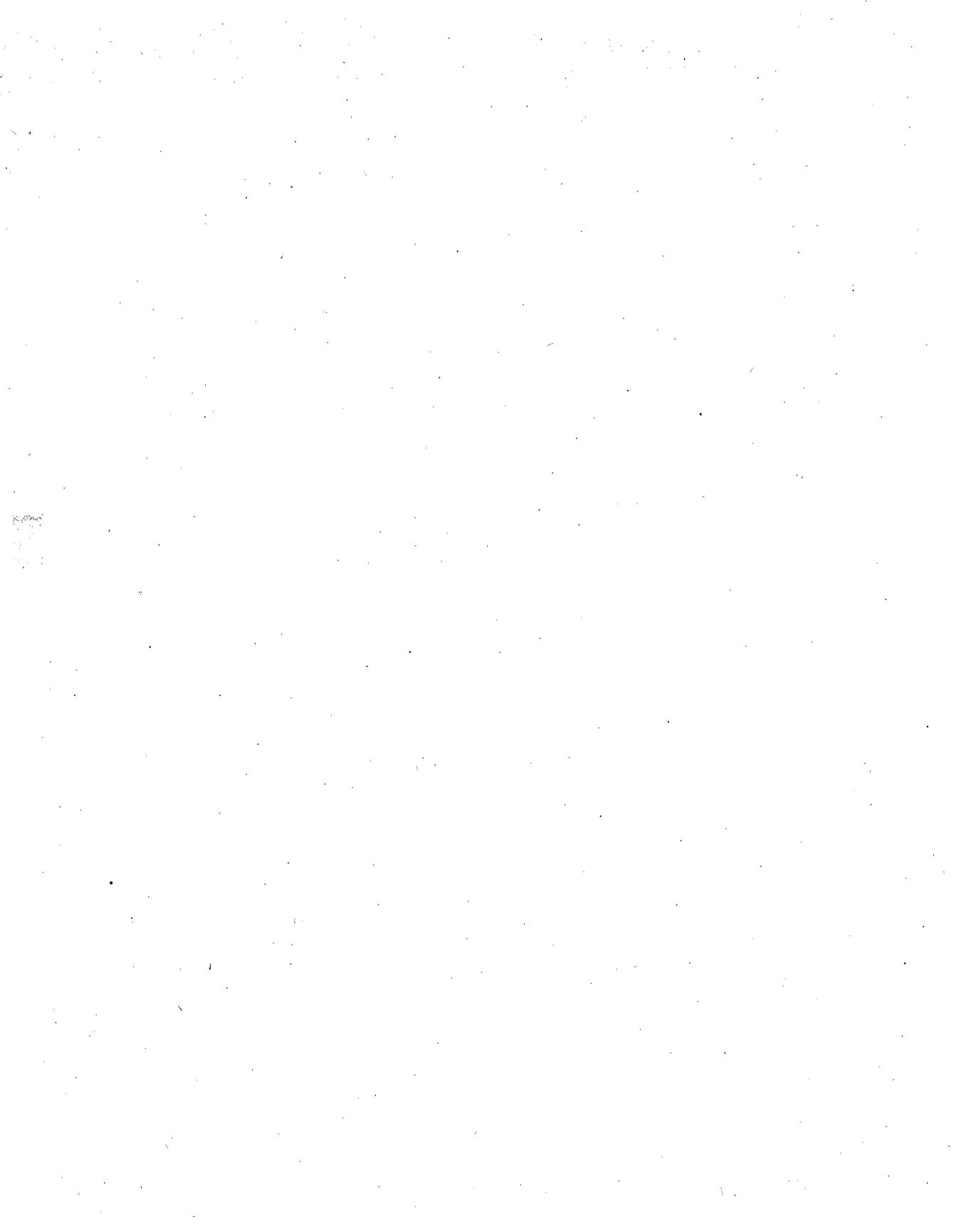
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE

OUTPUT CAPACITANCE



PACKAGE DIMENSIONS 4

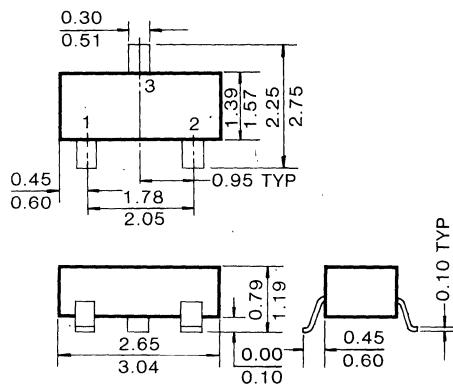




PACKAGE DIMENSIONS

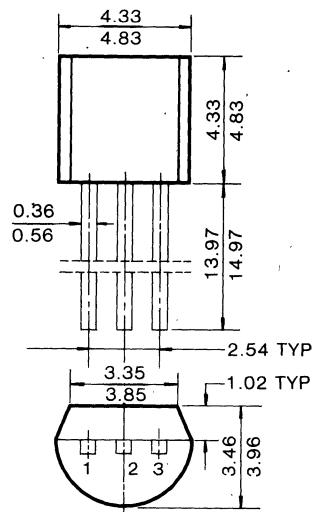
SOT-23

Unit: mm



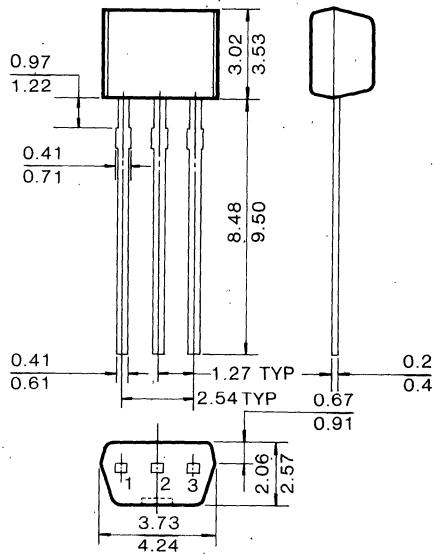
TO-92

Unit: mm



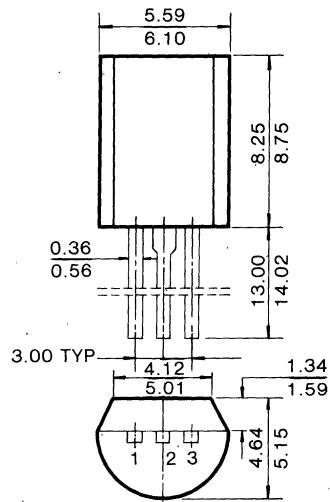
TO-92S

Unit: mm



TO-92L

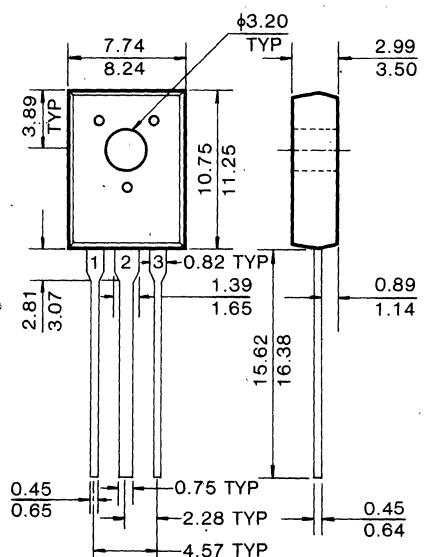
Unit: mm



PACKAGE DIMENSIONS

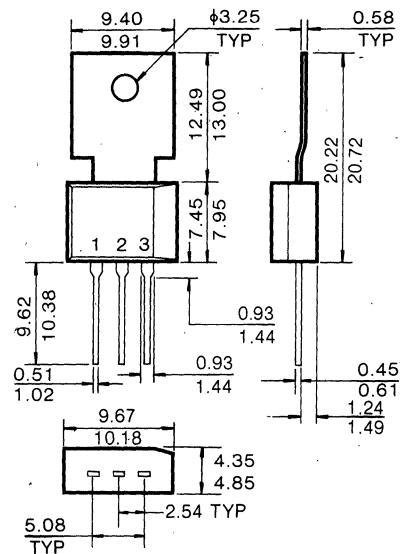
TO-126

Unit: mm



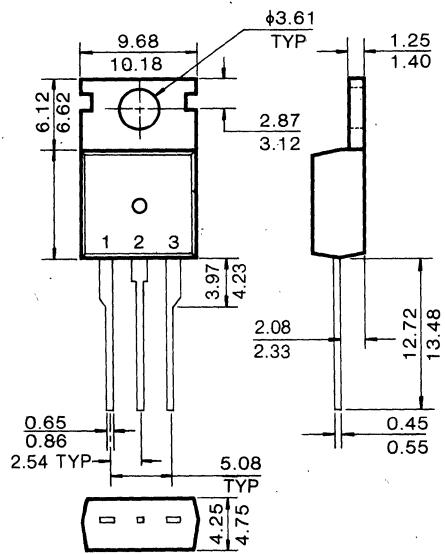
TO-202

Unit: mm



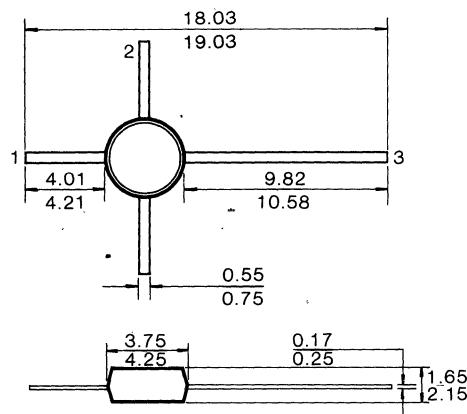
TO-220

Unit: mm



DISK TR

Unit: mm

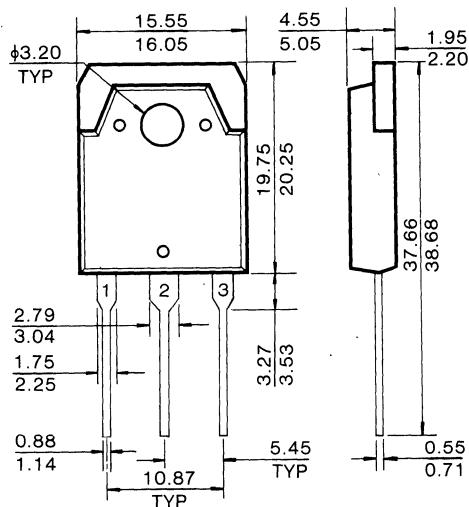


SAMSUNG SEMICONDUCTOR

PACKAGE DIMENSIONS

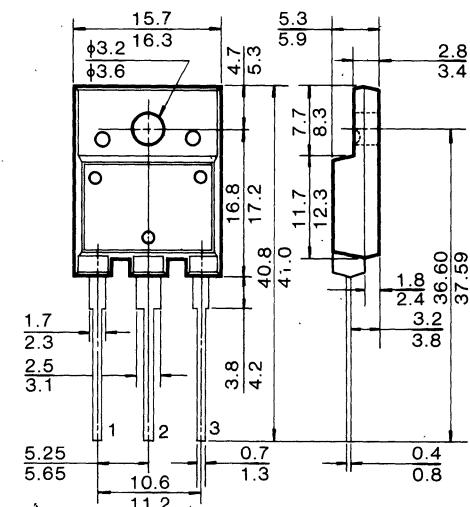
TO-3P

Unit: mm



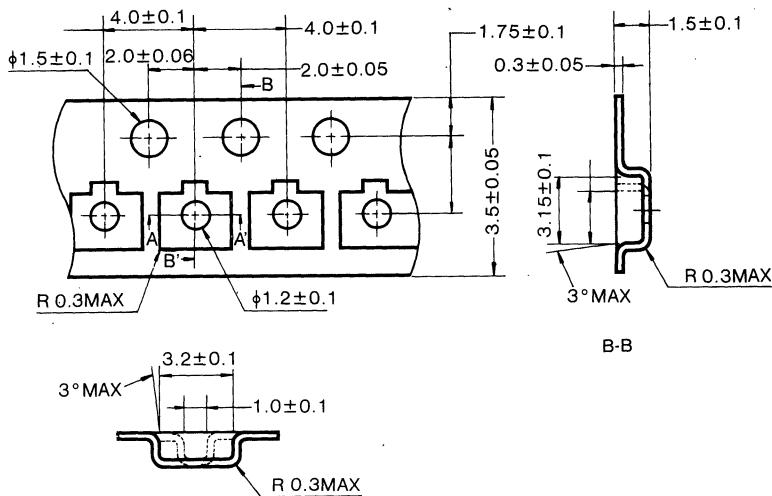
Unit: mm

TO-3P(F)



EMBOSSED CARRIER Specification for SOT-23

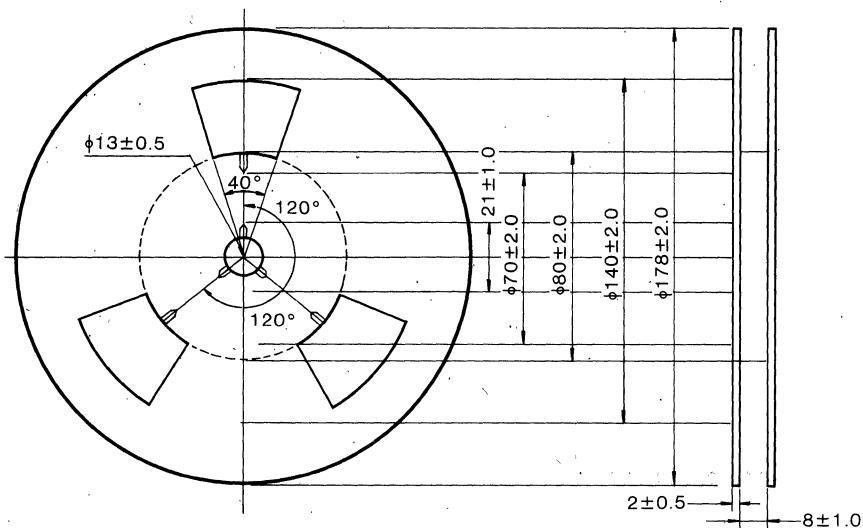
Unit: mm



PACKAGE DIMENSIONS

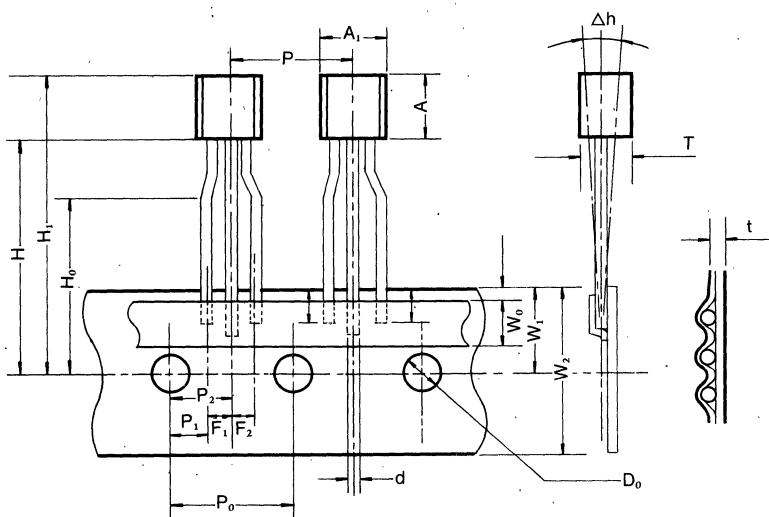
CARRIER TAPE REELS

Unit: mm



TO-92 TAPING SPECIFICATION

Unit: mm



P	12.7 ± 0.5
P_0	12.7 ± 0.2
P_1	3.85 ± 0.5
P_2	6.35 ± 0.5
W	$18^{+0.5}_{-0.5}$
W_0	6 ± 0.5
W_1	9 ± 0.5
W_2	Max. 0.5
H	Max. 21
H_1	Max. 27
H_0	16 ± 0.5
F	$5^{+0.8}_{-0.2}$
F_1-F_2	± 0.3
D_0	4 \pm 0.2
t	0.65 ± 0.2
Δh	$C \pm 1$
d	0.46
T	3.56
L_1	Min. 2.5

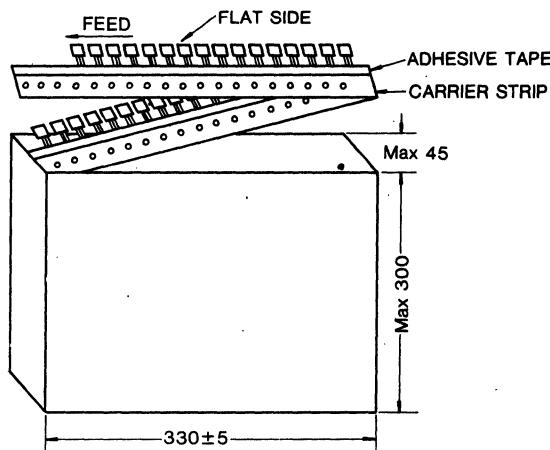


SAMSUNG SEMICONDUCTOR

PACKAGE DIMENSIONS

TO-92 AMMO PACK

Unit: mm



FLAT SIDE OF TRANSISTOR and ADHESIVE TAPE VISIBLE

SAMSUNG's AMMO PACK is equivalent to styles A,B,C,D of reel pack depending on which box-flat is opened and which end of the box the devices are fed from.

1 AMMO PACK contains 2000 pcs Transistors.

4



SAMSUNG SEMICONDUCTOR

NOTES

**SAMSUNG SALES OFFICES &
MANUFACTURER'S REPRESENTATIVES**

5



SAMSUNG SEMICONDUCTOR DISTRIBUTORS

ALABAMA

HAMMOND (205) 830-4764
4411-B Evangel Circle, N.W.
Huntsville, AL 35816

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ADDED VALUE (714) 259-8258
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